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Test Report

Concerning : Lot acceptance test on square flange receptacle tab contact SMA R125612140X for ASTRA Microwave Products.

Test sample identification : Square flange receptacle tab contact SMA R125612140X Batch 05-34A quantity 94 Batch 05-40A quantity 68	**Addressee :** Poizat S. Blanchard A.
Applicant : Poizat S. **Department :** Space connectors	**Started** : 10/01/2006 **Finished** : 22/23/2006
Written by : Bouvier D. **Verified by** : Bouvier D. **Approved by** : Blanchard A.	**Date :** 22/03/2006
Tests : - Dielectric withstanding voltage. - Insulation resistance. - Contact resistance. - RF Insertion loss. - VSWR. - Thermal shocks. - Temperature operational. - Force to engage / disengage. - Mating characteristics. - Centre contact retention. - Connector durability. - Steady state humidity. - Microsectioning. - Solderability.	**Purpose :** Lot acceptance test level 1 on square flange receptacle tab contact SMA R125612140X according to ASTRA Microwave Products order N°4520001573.

Conclusion :

All the samples fulfilled the test requirements of lot acceptance test level 1 on square flange receptacle tab contact SMA R125612140X according to ASTRA Microwave Products order N°4520001573, except :
- On sample N°138, the tab contact was broken due to a wrong handling by the operator during the installation of the steady state humidity test.

Quality manager decision :

Lot acceptance test results acceptable.

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All the samples fulfilled the test requirements of lot acceptance test level 1 on square flange receptacle tab contact SMA R125612140X according to ASTRA Microwave Products order N°4520001573, except :
- On sample N°138, the tab contact was broken due to a wrong handling by the operator during the installation of the steady state humidity test.

Quality manager decision :

Lot acceptance test results acceptable.

Group I		
Tests / Samples	**Batch 05-34A**	**Batch 05-40A**
Dielectric withstanding voltage	N°1 to 94	N°95 to 162
Insulation resistance	N°1 to 94	N°95 to 162
Contact resistance	N°1 to 94	N°95 to 162
RF Insertion loss	N°1 to 35	N°95 to 119
VSWR	N°1 to 35	N°95 to 119
Thermal shocks	N°1 to 94	N°95 to 162
Dielectric withstanding voltage after thermal shocks	N°1 to 94	N°95 to 162
Insulation resistance after thermal shocks	N°1 to 94	N°95 to 162
Contact resistance after thermal shocks	N°36 to 94	N°120 to 162
RF Insertion loss after thermal shocks	N°1 to 35	N°95 to 119
VSWR after thermal shocks	N°1 to 35	N°95 to 119
Group II		
Subgroup A		
Tests / Samples	**Batch 05-34A**	**Batch 05-40A**
Temperature operational	N°1 to 35	N°95 to 119
Force to engage / disengage	N°1 to 35	N°95 to 119
Mating characteristics	N°1 to 35	N°95 to 119
Centre contact retention	N°1 to 35	N°95 to 119
Connector durability	N°1 to 35	N°95 to 119
Subgroup B		
Steady state humidity	N°36 to 70	N°120 to 144
Dielectric withstanding voltage after Steady state humidity	N°36 to 70	N°120 to 144
Insulation resistance after Steady state humidity	N°36 to 70	N°120 to 144
Contact resistance after Steady state humidity	N°36 to 70	N°120 to 144
Group III		
Tests / Samples	**Batch 05-34A**	**Batch 05-40A**
Microsectioning	N°71 to 87	N°145 to 157
Group IV		
Tests / Samples	**Batch 05-34A**	**Batch 05-40A**
Solderability	N°88 to 94	N°158 to 162

The batch N°05-34A is composed by samples N°1 to 94.

The batch N°05-40A is composed by samples N°95 to 162.

To perform the tests of groups III and IV, the samples shall remain entire, so to perform the RF insertion loss and VSWR measurements in group I, the samples shall cut and put back to back. Consequently the samples of groups III and IV will not to be measured in RF insertion loss and VSWR measurements.

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Group I : Dielectric withstanding voltage.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Test method standard MIL-STD-202 G

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°1 to 94.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°95 to 162.

Equipment :

Dielectrimeter SEFELEC MPC316 n°8064 007 1091

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 10/01/2006

Test description:

The voltage withstanding test was performed according to standard MIL-STD-202 G method 301 with the following conditions :
- Voltage : 1000 Vrms.
- Duration : 1 minute minimum.
- The test voltage was applied on uncabled connectors between centre contact and shell.

Requirement : 1000V with no leakage current ≥ 2 mA. Pass or fail.

Results :

Pass for all samples.

Tests / Samples	Batch 05-34A / N°1 to 94	Batch 05-40A / N°95 to 162
Dielectric withstanding voltage (1000 Vrms)	Pass	Pass

Conclusion :

Pass.

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Group I : Insulation resistance.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Test method standard MIL-STD-202 G

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°1 to 94.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°95 to 162.

Equipment :

Dielectrimeter SEFELEC MPC316 n°8064 007 1091

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 10/01/2006

Test description:

The insulation resistance test was performed according to standard MIL-STD-202 G method 302 condition B with the following conditions :
- Voltage : 500 V dc.
- Duration before measurement : 1 minute minimum.
- The test voltage was applied on uncabled connectors between centre contact and shell.

Requirement : > 5000 MΩ. Pass or fail.

Results :

Pass for all samples.

Tests / Samples	Batch 05-34A / N°1 to 94	Batch 05-40A / N°95 to 162
Insulation resistance (> 5000 MΩ.)	Pass	Pass

Conclusion :

Pass.

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Group I : Contact resistance.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Test method standard MIL-PRF-39012
Standard RAD DET CONN 003

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°1 to 94.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°95 to 162.

Equipment :

Microhmmeter SEFELEC MGR10 n° 80630040106

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 12/01/2006

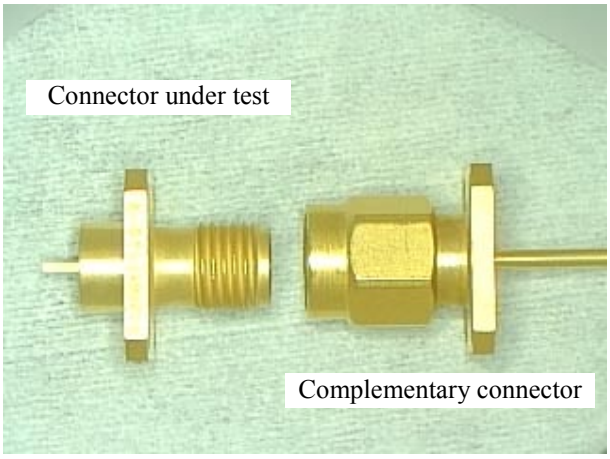
Test description:

The contact resistance test was performed according to standard MIL-PRF-39012 paragraph 4.7.13 method B with following conditions :
- Measurement current : 50mA
- Nominal DC potential on open circuit : 5 V
- Measurement was performed with complementary connector.

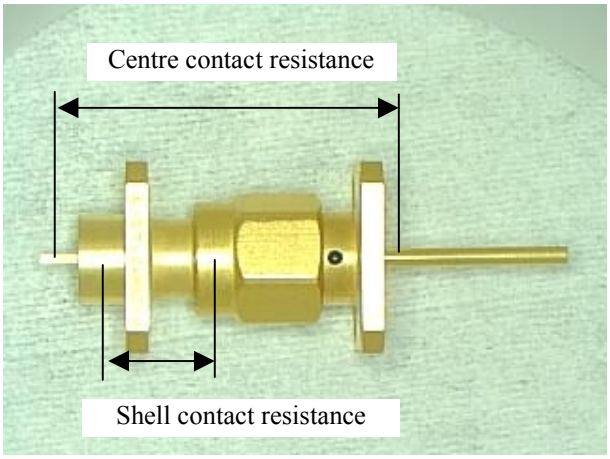
Requirement :
- Centre contact ≤ 3.0 mΩ
- Shell contact ≤ 2.0 mΩ

Points of measurements

Before assembling



During measurement



Results :

Contact resistance on batch 05-34A (mΩ)

Sample	Centre contact	Shell contact	Sample	Centre contact	Shell contact
Requirement	≤ 3.0 mΩ	≤ 2.0 mΩ	Requirement	≤ 3.0 mΩ	≤ 2.0 mΩ
N°1	2.40	0.47	N°48	1.98	0.55
N°2	2.44	0.57	N°49	1.90	0.47
N°3	2.10	0.53	N°50	2.09	0.51
N°4	2.36	0.56	N°51	2.26	0.50
N°5	2.51	0.51	N°52	2.43	0.50
N°6	2.45	0.52	N°53	2.15	0.51
N°7	2.21	0.51	N°54	2.27	0.46
N°8	2.30	0.50	N°55	2.12	0.47
N°9	2.60	0.51	N°56	2.16	0.44
N°10	2.37	0.52	N°57	2.13	0.46
N°11	2.68	0.51	N°58	2.40	0.42
N°12	2.54	0.50	N°59	2.13	0.39
N°13	2.43	0.55	N°60	2.00	0.46
N°14	2.11	0.51	N°61	2.35	0.42
N°15	2.17	0.58	N°62	2.41	0.48
N°16	2.10	0.50	N°63	2.38	0.46
N°17	2.25	0.53	N°64	2.32	0.46
N°18	2.20	0.54	N°65	2.40	0.43
N°19	2.10	0.54	N°66	2.33	0.45
N°20	2.32	0.51	N°67	2.30	0.46
N°21	2.34	0.52	N°68	2.42	0.48
N°22	1.92	0.51	N°69	2.30	0.50
N°23	2.28	0.56	N°70	2.40	0.53
N°24	2.10	0.58	N°71	2.50	0.47
N°25	2.01	0.55	N°72	2.33	0.40
N°26	2.10	0.53	N°73	2.47	0.46
N°27	2.15	0.60	N°74	2.14	0.48
N°28	2.24	0.49	N°75	2.42	0.51
N°29	2.16	0.57	N°76	2.05	0.45
N°30	2.05	0.46	N°77	2.10	0.43
N°31	2.14	0.48	N°78	2.55	0.43
N°32	1.98	0.40	N°79	2.41	0.41
N°33	2.20	0.45	N°80	2.23	0.43
N°34	2.18	0.54	N°81	2.33	0.44
N°35	2.28	0.56	N°82	2.17	0.44
N°36	2.22	0.50	N°83	2.51	0.40
N°37	2.18	0.47	N°84	2.42	0.48
N°38	2.21	0.51	N°85	2.31	0.50
N°39	2.34	0.57	N°86	2.37	0.38
N°40	2.11	0.53	N°87	2.42	0.50
N°41	2.11	0.54	N°88	2.32	0.43
N°42	2.01	0.53	N°89	2.38	0.45
N°43	2.40	0.54	N°90	2.38	0.45
N°44	2.17	0.41	N°91	2.43	0.44
N°45	2.27	0.46	N°92	2.42	0.51
N°46	2.00	0.52	N°93	2.52	0.46
N°47	1.92	0.53	N°94	2.31	0.45

Contact resistance on batch 05-40A (mΩ)

Sample	Centre contact	Shell contact	Sample	Centre contact	Shell contact
Requirement	≤ 3.0 mΩ	≤ 2.0 mΩ	Requirement	≤ 3.0 mΩ	≤ 2.0 mΩ
N°95	2.41	0.40	N°129	2.14	0.46
N°96	2.20	0.44	N°130	2.41	0.49
N°97	2.10	0.48	N°131	2.40	0.38
N°98	2.29	0.44	N°132	2.42	0.48
N°99	2.45	0.46	N°133	2.31	0.53
N°100	2.30	0.46	N°134	2.22	0.43
N°101	2.36	0.47	N°135	2.25	0.46
N°102	2.34	0.46	N°136	2.34	0.48
N°103	2.35	0.45	N°137	2.30	0.46
N°104	2.38	0.40	N°138	2.11	0.39
N°105	2.16	0.44	N°139	2.44	0.39
N°106	2.42	0.46	N°140	2.54	0.49
N°107	2.50	0.39	N°141	2.47	0.47
N°108	2.32	0.51	N°142	2.42	0.42
N°109	2.28	0.40	N°143	2.28	0.49
N°110	2.47	0.39	N°144	2.54	0.38
N°111	2.34	0.42	N°145	2.42	0.45
N°112	2.37	0.45	N°146	2.37	0.41
N°113	2.29	0.38	N°147	2.33	0.43
N°114	2.18	0.45	N°148	2.31	0.50
N°115	2.41	0.50	N°149	2.44	0.38
N°116	2.35	0.43	N°150	2.37	0.53
N°117	2.39	0.40	N°151	2.42	0.45
N°118	2.47	0.42	N°152	2.31	0.40
N°119	2.30	0.43	N°153	2.46	0.40
N°120	2.30	0.48	N°154	2.44	0.46
N°121	2.41	0.42	N°155	2.36	0.46
N°122	2.19	0.47	N°156	2.31	0.45
N°123	2.30	0.40	N°157	2.00	0.39
N°124	2.38	0.46	N°158	2.08	0.38
N°125	2.25	0.47	N°159	2.28	0.50
N°126	2.13	0.51	N°160	2.14	0.42
N°127	2.35	0.48	N°161	2.21	0.45
N°128	2.27	0.48	N°162	2.22	0.42

Conclusion :

Pass.

Group I : RF Insertion loss.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Standard RAD GEN CONN 001
FIPA 024906S

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°1 to 35.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°95 to 119.

Equipment :

Vector Network Analyser WILLTRON 37269A n°8025 007 0995
Calibration Kit K WILTRON 3652 n°8039 111 0905

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 24/01/2006

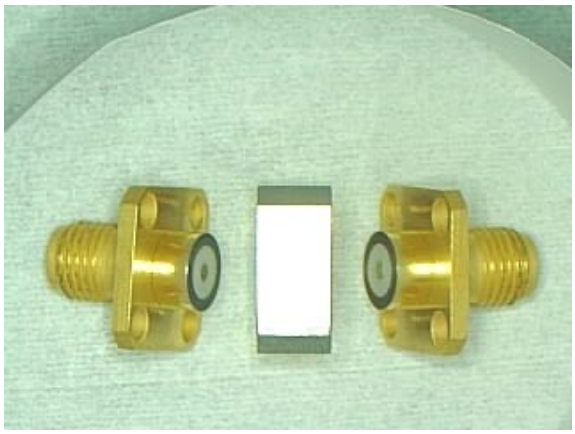
Test description:

Insertion loss measurements were performed on Vector Network Analyser according to test procedures FIPA 024906S, Radiall generic specification RAD GEN CONN 001 § 9.19 and the following conditions.
- Temperature : room temperature
- Frequency range : 0 to 18 GHz
- Number of points : 401
- Calibration : full two ports

Requirements : $0.03*\sqrt{Frequency(GHz)}$ dB max. from 0 to 5GHz (0.067dB at 5 GHz).
: $0.05*\sqrt{Frequency(GHz)}$ dB max. from 5 to 18GHz (0.212dB at 18 GHz).

To perform the RF measurements, the connectors were put back to back thanks to a centring tool. The back face of each connector was mechanically reworked to coincide between them. A drop of conductive glue was added to ensure a good continuity on the centre contact. In this configuration, the results of insertion loss measurements were the sum of two connectors and the requirement on the graphs was multiplied by two.

Initial state of connector	After mechanical rework of the back face
	

Before assembling	Couple of connector back to back
	

Results :

Insertion loss at frequency point on batch 05-34A and 05-40A(dB)

Couple	5.0 GHz	18.0 GHz	Couple	5.0 GHz	18.0 GHz
Requirement	≤ 0.134 dB *	≤ 0.424 dB *	Requirement	≤ 0.134 dB *	≤ 0.424 dB *
1-2	0.105	0.174	31-32	0.096	0.209
3-4	0.085	0.184	33-34	0.081	0.176
5-6	0.082	0.165	35-95	0.104	0.239
7-8	0.085	0.174	96-97	0.090	0.205
9-10	0.092	0.189	98-99	0.078	0.160
11-12	0.080	0.164	100-101	0.090	0.176
13-14	0.083	0.166	102-103	0.090	0.187
15-16	0.098	0.193	104-105	0.096	0.180
17-18	0.085	0.181	106-107	0.110	0.223
19-20	0.087	0.182	108-109	0.099	0.199
21-22	0.103	0.219	110-111	0.087	0.174
23-24	0.085	0.189	112-113	0.098	0.184
25-26	0.087	0.182	114-115	0.103	0.188
27-28	0.089	0.179	116-117	0.107	0.194
29-30	0.101	0.232	118-119	0.106	0.201

* Couple of connector (requirement × 2).

See insertion loss graphs in appendix 1 page 1.2 to 1.16.

Conclusion :

Group I : VSWR.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Standard RAD GEN CONN 001
FIPA 024906S

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°1 to 35.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°95 to 119.

Equipment :

Vector Network Analyser WILLTRON 37269A n°8025 007 0995
Calibration Kit K WILTRON 3652 n°8039 111 0905

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 24/01/2006

Test description:

VSWR measurements were performed on Vector Network Analyser according to test procedures FIPA 024906S, Radiall generic specification RAD GEN CONN 001 § 9.16 and the following conditions.
- Temperature : room temperature
- Frequency range : 0 to 18 GHz
- Number of points : 401
- Calibration : full two ports

Requirements : 1.05 + 0.005 * Frequency (GHz) max. from 0 to 5 GHz (1.075 at 5GHz).
: 1.10 + 0.010 * Frequency (GHz) max. from 5 to 18 GHz (1.280 at 18.0 GHz).

To perform the VSWR measurements, the connectors were put back to back thanks to a centring tool as described for insertion loss.

Results :

See VSWR graphs in appendix 2 page 2.2 to 2.31.

See VSWR chart on next page.

Results :

VSWR max in frequency range on batch 05-34A (dB)

Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz	Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz
1	1.035	1.087	19	1.020	1.074
2	1.023	1.051	20	1.031	1.073
3	1.028	1.108	21	1.025	1.066
4	1.018	1.078	22	1.034	1.065
5	1.029	1.090	23	1.028	1.078
6	1.021	1.085	24	1.036	1.066
7	1.024	1.102	25	1.034	1.090
8	1.029	1.100	26	1.023	1.059
9	1.053	1.083	27	1.030	1.083
10	1.057	1.085	28	1.023	1.083
11	1.033	1.063	29	1.035	1.088
12	1.038	1.055	30	1.040	1.090
13	1.031	1.115	31	1.032	1.106
14	1.019	1.107	32	1.028	1.087
15	1.024	1.078	33	1.026	1.078
16	1.032	1.080	34	1.034	1.071
17	1.037	1.097	35	1.024	1.125
18	1.037	1.077			

VSWR max in frequency range on batch 05-40A (dB)

Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz	Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz
95	1.026	1.124	108	1.022	1.120
96	1.028	1.156	109	1.027	1.112
97	1.022	1.155	110	1.031	1.120
98	1.023	1.109	111	1.023	1.113
99	1.028	1.096	112	1.022	1.064
100	1.027	1.085	113	1.026	1.054
101	1.026	1.075	114	1.034	1.110
102	1.024	1.097	115	1.025	1.097
103	1.024	1.084	116	1.033	1.070
104	1.037	1.091	117	1.026	1.057
105	1.028	1.086	118	1.035	1.087
106	1.033	1.096	119	1.027	1.088
107	1.022	1.080			

Conclusion :

Pass.

Group I : Thermal shocks.

Specification :

MIL-STD 202 G method 107

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°1 to 94.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°95 to 162.

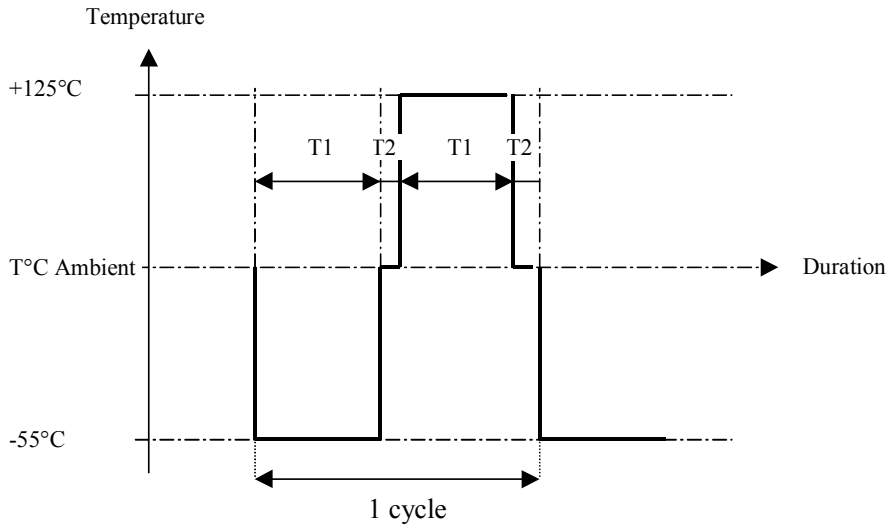
Equipment :

Climatic chamber VÖTSCH VT7012 S2 LCE n°0230

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Decembre J.	**Department :** LCE laboratory	**Date of test :** 26 to 27/01/20069

Test description :

The thermal shocks test was performed according to standard MIL-STD 202 G method 107 condition B and following conditions :
- Maximum temperature: +105°C.
- Minimum temperature: -55°C.
- Duration transfer : < 1 minute
- Stage duration: 15 minutes.
- Number of cycles: 50.



T1 : Duration exposure 15 minutes
T2 : Duration transfer < 1 minute

Results :

See LCE report in appendix 3 page 3.1 to 3.8.
On sample N°138, the tab contact was broken due to a wrong handling by the operator during the installation of the test.
See notice of anomaly N°1 in appendix 4 page 4.2.

Conclusion :

Pass.

Group I : Dielectric withstanding voltage after thermal shocks.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Test method standard MIL-STD-202 G

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°1 to 94.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°95 to 162.

Equipment :

Dielectrimeter SEFELEC MPC316 n°8064 007 1091

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 30/01/2006

Test description:

The voltage withstanding test was performed according to standard MIL-STD-202 G method 301 with the following conditions :
- Voltage : 1000 Vrms.
- Duration : 1 minute minimum.
- The test voltage was applied on uncabled connectors between centre contact and shell.

Requirement : 1000V with no leakage current ≥ 2 mA. Pass or fail.

Results :

Pass for all samples.

Tests / Samples	Batch 05-34A / N°1 to 94	Batch 05-40A / N°95 to 162
Dielectric withstanding voltage (1000 Vrms)	Pass	Pass

Conclusion :

Pass.

Group I : Insulation resistance after thermal shocks.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Test method standard MIL-STD-202 G

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°1 to 94.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°95 to 162.

Equipment :

Dielectrimeter SEFELEC MPC316 n°8064 007 1091

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 30/01/2006

Test description:

The insulation resistance test was performed according to standard MIL-STD-202 G method 302 condition B with the following conditions :
- Voltage : 500 V dc.
- Duration before measurement : 1 minute minimum.
- The test voltage was applied on uncabled connectors between centre contact and shell.

Requirement : > 5000 MΩ. Pass or fail.

Results :

Pass for all samples.

Tests / Samples	Batch 05-34A / N°1 to 94	Batch 05-40A / N°95 to 162
Insulation resistance (> 5000 MΩ.)	Pass	Pass

Conclusion :

Pass.

Group I : Contact resistance after thermal shocks.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Test method standard MIL-PRF-39012
Standard RAD DET CONN 003

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°36 to 94.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°120 to 162. (except N°138).

Equipment :

Microhmmeter SEFELEC MGR10 n° 80630040106

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 31/01/2006

Test description:

The contact resistance test was performed according to standard MIL-PRF-39012 paragraph 4.7.13 method B with the conditions described page 7.

Results :

Contact resistance on batch 05-40A (mΩ)

Sample	Centre contact	Shell contact	Sample	Centre contact	Shell contact
Requirement	≤ 3.0 mΩ	≤ 2.0 mΩ	Requirement	≤ 3.0 mΩ	≤ 2.0 mΩ
N°120	2.36	0.70	N°142	2.37	0.77
N°121	2.50	0.69	N°143	2.35	0.82
N°122	2.39	0.70	N°144	2.28	0.68
N°123	2.39	0.63	N°145	2.41	0.73
N°124	2.30	0.72	N°146	2.53	0.70
N°125	2.49	0.70	N°147	2.32	0.75
N°126	2.17	0.73	N°148	2.41	0.80
N°127	2.27	0.69	N°149	2.39	0.77
N°128	2.42	0.72	N°150	2.30	0.81
N°129	2.30	0.69	N°151	2.51	0.78
N°130	2.50	0.82	N°152	2.41	0.72
N°131	2.40	0.75	N°153	2.42	0.79
N°132	2.35	0.83	N°154	2.39	0.87
N°133	2.34	0.80	N°155	2.40	0.90
N°134	2.30	0.68	N°156	2.33	0.89
N°135	2.57	0.75	N°157	2.42	0.79
N°136	2.30	0.80	N°158	2.45	0.85
N°137	2.20	0.75	N°159	2.40	0.87
N°138	N.A.	N.A.	N°160	2.29	0.82
N°139	2.23	0.80	N°161	2.30	0.77
N°140	2.40	0.77	N°162	2.57	0.71
N°141	2.32	0.74			

Group I : Contact resistance after thermal shocks.

Contact resistance on batch 05-34A (mΩ)

Sample	Centre contact	Shell contact	Sample	Centre contact	Shell contact
Requirement	≤ 3.0 mΩ	≤ 2.0 mΩ	Requirement	≤ 3.0 mΩ	≤ 2.0 mΩ
N°36	2.24	0.57	N°66	2.43	0.50
N°37	2.22	0.58	N°67	2.36	0.59
N°38	2.18	0.47	N°68	2.35	0.58
N°39	2.31	0.51	N°69	2.39	0.59
N°40	2.15	0.54	N°70	2.40	0.63
N°41	2.09	0.46	N°71	2.46	0.57
N°42	2.02	0.49	N°72	2.38	0.49
N°43	2.38	0.50	N°73	2.45	0.56
N°44	2.20	0.47	N°74	2.12	0.58
N°45	2.29	0.47	N°75	2.40	0.55
N°46	2.06	0.53	N°76	2.12	0.59
N°47	2.01	0.52	N°77	2.15	0.52
N°48	2.01	0.54	N°78	2.57	0.55
N°49	1.96	0.51	N°79	2.52	0.59
N°50	2.10	0.46	N°80	2.30	0.57
N°51	2.32	0.47	N°81	2.35	0.52
N°52	2.41	0.54	N°82	2.18	0.64
N°53	2.15	0.54	N°83	2.16	0.66
N°54	2.32	0.45	N°84	2.40	0.70
N°55	2.15	0.52	N°85	2.36	0.62
N°56	2.14	0.48	N°86	2.43	0.63
N°57	2.16	0.54	N°87	2.39	0.60
N°58	2.44	0.50	N°88	2.40	0.65
N°59	2.15	0.49	N°89	2.30	0.65
N°60	2.05	0.62	N°90	2.40	0.65
N°61	2.30	0.47	N°91	2.45	0.66
N°62	2.42	0.54	N°92	2.47	0.70
N°63	2.49	0.57	N°93	2.54	0.68
N°64	2.33	0.59	N°94	2.40	0.71
N°65	2.38	0.47			

Conclusion :

Pass.

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Group I : RF Insertion loss after thermal shocks.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Standard RAD GEN CONN 001
FIPA 024906S

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°1 to 35.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°95 to 119.

Equipment :

Vector Network Analyser WILLTRON 37269A n°8025 007 0995
Calibration Kit K WILTRON 3652 n°8039 111 0905

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 07/02/2006

Test description:

Insertion loss measurements were performed on Vector Network Analyser as described page 10 and11.

Requirements : $0.03*\sqrt{Frequency(GHz)}$ dB max. from 0 to 5GHz (0.067dB at 5 GHz).

: $0.05*\sqrt{Frequency(GHz)}$ dB max. from 5 to 18GHz (0.212dB at 18 GHz).

Results :

Insertion loss at frequency point on batch 05-34A and 05-40A(dB)

Couple	5.0 GHz	18.0 GHz	Couple	5.0 GHz	18.0 GHz
Requirement	≤ 0.134 dB *	≤ 0.424 dB *	Requirement	≤ 0.134 dB *	≤ 0.424 dB *
1-2	0.077	0.163	**31-32**	0.070	0.162
3-4	0.080	0.218	**33-34**	0.087	0.179
5-6	0.082	0.183	**35-95**	0.070	0.156
7-8	0.066	0.156	**96-97**	0.088	0.176
9-10	0.072	0.161	**98-99**	0.067	0.151
11-12	0.077	0.167	**100-101**	0.078	0.164
13-14	0.080	0.166	**102-103**	0.071	0.167
15-16	0.075	0.165	**104-105**	0.066	0.160
17-18	0.071	0.165	**106-107**	0.072	0.160
19-20	0.078	0.174	**108-109**	0.067	0.148
21-22	0.078	0.172	**110-111**	0.072	0.160
23-24	0.090	0.186	**112-113**	0.076	0.169
25-26	0.082	0.173	**114-115**	0.099	0.177
27-28	0.069	0.160	**116-117**	0.087	0.178
29-30	0.071	0.164	**118-119**	0.081	0.180

* Couple of connector (requirement × 2). See insertion loss graphs in appendix 1 page 1.17 to 1.31.

Conclusion :

Pass.

Group I : VSWR after thermal shocks.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Standard RAD GEN CONN 001
FIPA 024906S

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°1 to 35.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°95 to 119.

Equipment :

Vector Network Analyser WILLTRON 37269A n°8025 007 0995
Calibration Kit K WILTRON 3652 n°8039 111 0905

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 07/02/2006

Test description:

VSWR measurements were performed on Vector Network as described page 12.

Requirements : 1.05 + 0.005 * Frequency (GHz) max. from 0 to 5 GHz (1.075 at 5GHz).
: 1.10 + 0.010 * Frequency (GHz) max. from 5 to 18 GHz (1.280 at 18.0 GHz).

Results :

VSWR max in frequency range on batch 05-34A (dB)

Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz	Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz
1	1.030	1.080	**19**	1.025	1.066
2	1.024	1.052	**20**	1.025	1.060
3	1.034	1.118	**21**	1.023	1.057
4	1.027	1.103	**22**	1.027	1.088
5	1.033	1.085	**23**	1.027	1.067
6	1.023	1.088	**24**	1.028	1.094
7	1.023	1.102	**25**	1.037	1.090
8	1.025	1.097	**26**	1.024	1.066
9	1.052	1.079	**27**	1.031	1.087
10	1.056	1.075	**28**	1.023	1.089
11	1.027	1.059	**29**	1.024	1.091
12	1.034	1.054	**30**	1.021	1.095
13	1.036	1.114	**31**	1.032	1.093
14	1.024	1.101	**32**	1.032	1.067
15	1.022	1.071	**33**	1.019	1.072
16	1.026	1.069	**34**	1.028	1.088
17	1.035	1.094	**35**	1.024	1.096
18	1.027	1.071			

Group I : VSWR after thermal shocks.

VSWR max in frequency range on batch 05-40A (dB)

Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz	Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz
95	1.019	1.090	**108**	1.024	1.103
96	1.038	1.074	**109**	1.024	1.091
97	1.030	1.073	**110**	1.034	1.114
98	1.024	1.087	**111**	1.025	1.109
99	1.028	1.089	**112**	1.023	1.058
100	1.031	1.078	**113**	1.026	1.086
101	1.021	1.070	**114**	1.037	1.113
102	1.026	1.078	**115**	1.027	1.104
103	1.020	1.106	**116**	1.034	1.064
104	1.038	1.092	**117**	1.026	1.060
105	1.028	1.091	**118**	1.035	1.093
106	1.033	1.091	**119**	1.027	1.096
107	1.022	1.074			

See VSWR graphs in appendix 2 page 2.31 to 2.61.

Conclusion :

Pass.

Group II subgroup A : Temperature operational.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Standard RAD GEN CONN 001
FIPA 024906S

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°1 to 35.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°95 to 119.

Equipment :

Vector Network Analyser WILLTRON 37269A n°8025 007 0995
Calibration Kit K WILTRON 3652 n°8039 111 0905

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 08 to 09/02/2006

Test description:

The RF measurements at high and low temperature were performed with the same conditions as ambient temperature. The sample were put in a climatic chamber at least 2 hours of stabilisation before to be measured.

Insertion loss measurements were performed on Vector Network Analyser according to test procedures FIPA 024906S, Radiall generic specification RAD GEN CONN 001 § 9.19 and the following conditions.
- Temperature : - 40 and + 100°C
- Frequency range : 0 to 18 GHz
- Number of points : 401
- Calibration : full two ports

Requirements : $0.03*\sqrt{Frequency(GHz)}$ dB max. from 0 to 5GHz (0.067dB at 5 GHz).
: $0.05*\sqrt{Frequency(GHz)}$ dB max. from 5 to 18GHz (0.212dB at 18 GHz).

VSWR measurements were performed on Vector Network Analyser according to test procedures FIPA 024906S, Radiall generic specification RAD GEN CONN 001 § 9.16 and the following conditions.
- Temperature : - 40 and + 100°C
- Frequency range : 0 to 18 GHz
- Number of points : 401
- Calibration : full two ports

Requirements : 1.05 + 0.005 * Frequency (GHz) max. from 0 to 5 GHz (1.075 at 5GHz).
: 1.10 + 0.010 * Frequency (GHz) max. from 5 to 18 GHz (1.280 at 18.0 GHz).

Results :

- Results of RF measurements at **low temperature : -40°C**

Insertion loss at frequency point on batch 05-34A and 05-40A(dB)

Couple	5.0 GHz	18.0 GHz	Couple	5.0 GHz	18.0 GHz
Requirement	≤ 0.134 dB *	≤ 0.424 dB *	Requirement	≤ 0.134 dB *	≤ 0.424 dB *
1-2	0.065	0.148	**31-32**	0.061	0.144
3-4	0.064	0.164	**33-34**	0.073	0.161
5-6	0.086	0.184	**35-95**	0.063	0.145
7-8	0.066	0.151	**96-97**	0.084	0.170
9-10	0.066	0.156	**98-99**	0.067	0.157
11-12	0.074	0.160	**100-101**	0.075	0.153
13-14	0.079	0.171	**102-103**	0.065	0.158
15-16	0.078	0.167	**104-105**	0.061	0.149
17-18	0.071	0.156	**106-107**	0.065	0.146
19-20	0.077	0.172	**108-109**	0.060	0.130
21-22	0.073	0.165	**110-111**	0.061	0.134
23-24	0.081	0.176	**112-113**	0.067	0.152
25-26	0.075	0.165	**114-115**	0.088	0.152
27-28	0.065	0.154	**116-117**	0.078	0.156
29-30	0.066	0.163	**118-119**	0.073	0.160

* Couple of connector (requirement × 2).

VSWR max in frequency range on batch 05-34A (dB)

Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz	Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz
1	1.030	1.077	**19**	1.022	1.076
2	1.027	1.097	**20**	1.026	1.094
3	1.030	1.109	**21**	1.022	1.106
4	1.024	1.142	**22**	1.028	1.136
5	1.032	1.075	**23**	1.031	1.123
6	1.022	1.071	**24**	1.033	1.151
7	1.021	1.081	**25**	1.035	1.088
8	1.025	1.098	**26**	1.024	1.108
9	1.052	1.084	**27**	1.028	1.063
10	1.056	1.110	**28**	1.020	1.091
11	1.027	1.058	**29**	1.025	1.113
12	1.034	1.083	**30**	1.021	1.144
13	1.035	1.097	**31**	1.032	1.090
14	1.024	1.085	**32**	1.032	1.113
15	1.021	1.101	**33**	1.020	1.124
16	1.026	1.127	**34**	1.030	1.140
17	1.033	1.094	**35**	1.023	1.076
18	1.027	1.073			

VSWR max in frequency range on batch 05-40A (dB)

Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz	Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz
95	1.022	1.085	**108**	1.023	1.085
96	1.035	1.066	**109**	1.023	1.096
97	1.027	1.086	**110**	1.031	1.092
98	1.024	1.107	**111**	1.022	1.109
99	1.029	1.139	**112**	1.022	1.117
100	1.028	1.095	**113**	1.026	1.146
101	1.020	1.119	**114**	1.035	1.100
102	1.024	1.129	**115**	1.026	1.081
103	1.019	1.157	**116**	1.031	1.061
104	1.035	1.078	**117**	1.024	1.079
105	1.026	1.098	**118**	1.033	1.071
106	1.031	1.090	**119**	1.025	1.076
107	1.025	1.114			

- Results of RF measurements at **high temperature : +100°C**

Insertion loss at frequency point on batch 05-34A and 05-40A(dB)

Couple	5.0 GHz	18.0 GHz	Couple	5.0 GHz	18.0 GHz
Requirement	≤ 0.134 dB *	≤ 0.424 dB *	Requirement	≤ 0.134 dB *	≤ 0.424 dB *
1-2	0.093	0.206	**31-32**	0.089	0.216
3-4	0.096	0.212	**33-34**	0.111	0.233
5-6	0.080	0.201	**35-95**	0.087	0.215
7-8	0.088	0.209	**96-97**	0.080	0.189
9-10	0.093	0.212	**98-99**	0.085	0.194
11-12	0.105	0.227	**100-101**	0.081	0.180
13-14	0.113	0.230	**102-103**	0.087	0.203
15-16	0.101	0.238	**104-105**	0.087	0.212
17-18	0.088	0.214	**106-107**	0.094	0.208
19-20	0.097	0.226	**108-109**	0.083	0.190
21-22	0.092	0.213	**110-111**	0.082	0.185
23-24	0.086	0.212	**112-113**	0.093	0.202
25-26	0.091	0.203	**114-115**	0.130	0.220
27-28	0.089	0.227	**116-117**	0.100	0.209
29-30	0.087	0.209	**118-119**	0.111	0.229

*Couple of connector (requirement × 2).

VSWR max in frequency range on batch 05-34A (dB)

Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz	Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz
1	1.030	1.084	**19**	1.034	1.062
2	1.021	1.049	**20**	1.039	1.061
3	1.032	1.096	**21**	1.035	1.059
4	1.030	1.058	**22**	1.039	1.043
5	1.028	1.111	**23**	1.026	1.094
6	1.020	1.098	**24**	1.025	1.094
7	1.029	1.092	**25**	1.036	1.086
8	1.032	1.088	**26**	1.029	1.048
9	1.052	1.075	**27**	1.031	1.087
10	1.055	1.075	**28**	1.029	1.073
11	1.036	1.059	**29**	1.032	1.090
12	1.043	1.047	**30**	1.035	1.059
13	1.037	1.106	**31**	1.029	1.092
14	1.027	1.093	**32**	1.041	1.065
15	1.029	1.068	**33**	1.029	1.058
16	1.036	1.070	**34**	1.038	1.053
17	1.046	1.093	**35**	1.024	1.092
18	1.046	1.070			

VSWR max in frequency range on batch 05-40A (dB)

Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz	Sample / Frequency	0 - 5.0 GHz	5.0- 18.0 GHz
95	1.019	1.086	**108**	1.021	1.099
96	1.033	1.077	**109**	1.022	1.087
97	1.027	1.074	**110**	1.034	1.103
98	1.032	1.086	**111**	1.025	1.097
99	1.036	1.062	**112**	1.026	1.054
100	1.026	1.101	**113**	1.031	1.038
101	1.025	1.088	**114**	1.040	1.113
102	1.027	1.065	**115**	1.029	1.101
103	1.023	1.042	**116**	1.035	1.072
104	1.037	1.082	**117**	1.026	1.055
105	1.029	1.077	**118**	1.038	1.091
106	1.033	1.090	**119**	1.029	1.080
107	1.022	1.069			

Conclusion :

Pass.

Group II subgroup A : Force to engage / disengage.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Standard RAD GEN CONN 001
Standard RAD DET CONN 003
Standard MIL PRF 39012

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°1 to 35.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°95 to 119.

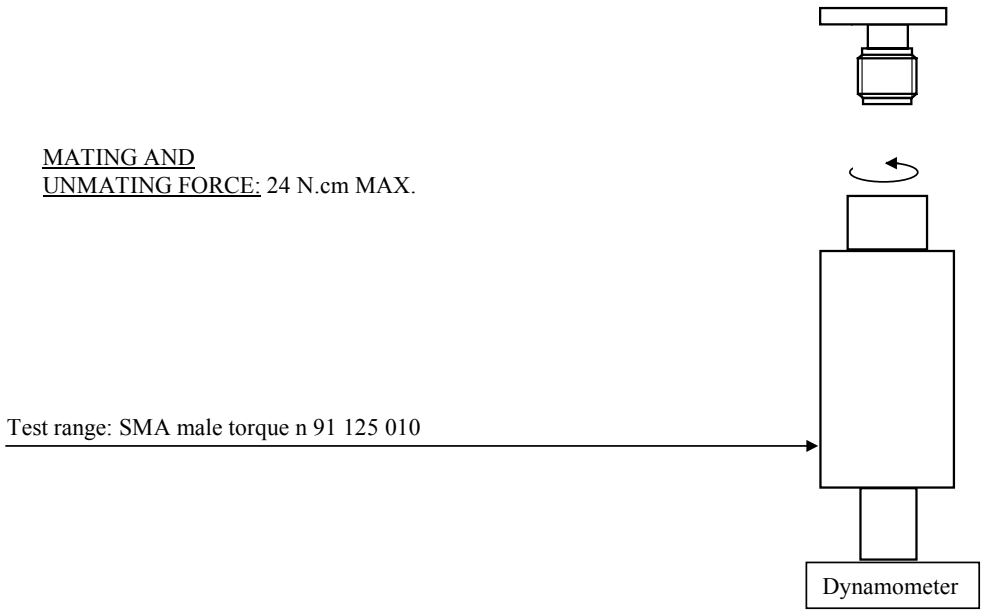
Equipment :

Dynamometer ADEMVA CM10 30141020787
Test range SMA male torque N°91125010

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 13/02/2006

Test description:

The engage and disengage force test was performed according to standard MIL PRF 39012 § 4.7.2.1 and standard RAD GEN CONN 001 with the following conditions :
During the entire mating or unmating cycle, the necessary torque was not exceed 24 N cm.
A screw-coupling connector is fully mated with its mating gauge when their reference planes coincide.



Results :

Force to engage and disengage on batch 05-34A (N.cm)

Sample	Mating	Unmating	Sample	Mating	Unmating
Requirement	< 24 N.cm		Requirement	< 24 N.cm	
1	< 2	< 2	**19**	< 2	< 2
2	< 2	< 2	**20**	< 3	< 2
3	< 2	< 2	**21**	< 2	< 2
4	< 2	< 2	**22**	< 2	< 3
5	< 3	< 2	**23**	< 2	< 2
6	< 2	< 2	**24**	< 2	< 2
7	< 2	< 2	**25**	< 2	< 2
8	< 3	< 2	**26**	< 2	< 2
9	< 2	< 2	**27**	< 2	< 2
10	< 3	< 2	**28**	< 2	< 2
11	< 2	< 2	**29**	< 2	< 3
12	< 2	< 2	**30**	< 2	< 2
13	< 2	< 3	**31**	< 2	< 2
14	< 3	< 2	**32**	< 2	< 2
15	< 2	< 2	**33**	< 2	< 3
16	< 2	< 2	**34**	< 2	< 2
17	< 2	< 2	**35**	< 2	< 3
18	< 2	< 2			

Force to engage and disengage on batch 05-40A (N.cm)

Sample	Mating	Unmating	Sample	Mating	Unmating
Requirement	< 24 N.cm		Requirement	< 24 N.cm	
95	< 2	< 2	**108**	< 2	< 2
96	< 4	< 3	**109**	< 2	< 2
97	< 2	< 2	**110**	< 2	< 2
98	< 3	< 2	**111**	< 2	< 2
99	< 3	< 2	**112**	< 3	< 2
100	< 2	< 2	**113**	< 2	< 2
101	< 2	< 2	**114**	< 2	< 2
102	< 2	< 2	**115**	< 3	< 2
103	< 2	< 2	**116**	< 3	< 2
104	< 2	< 2	**117**	< 3	< 2
105	< 2	< 3	**118**	< 3	< 2
106	< 2	< 2	**119**	< 2	< 3
107	< 2	< 2			

Conclusion :

Pass.

Group II subgroup A : Mating characteristics.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Standard RAD GEN CONN 001
Standard RAD DET CONN 003
Standard MIL PRF 39012

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°1 to 35.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°95 to 119.

Equipment :

Oversize test pin Radiall tool 3009 521 0793
Maximum diameter test pin Radiall tool 3009 524 0793
Minimum diameter test pin Radiall tool 3009 528 1194
Dynamometer CHATILLON force gauge DPP 1 kg n°3012 215 0190

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 14/02/2006

Test description:

The mating characteristics test was performed according to standard MIL PRF 39012 § 4.7.4 and standard RAD GEN CONN 001 § 4.3.8 with the following conditions :

- A Oversize pin :
  - Steel test pin diameter : 0.9525 / 0.955 mm
  - Insertion depth : 0.76 / 1.14 mm
  - Number of insertions : 3
- B Engagement force test (maximum diameter test pin) :
  - Steel test pin diameter : 0.940 / 0.942 mm
  - Engagement depth : 1.27 / 1.91 mm
  - Engagement force : 1360 g max.
- C Separation force test (minimum diameter test pin):
  - Steel test pin diameter : 0.902 / 0.904 mm
  - Separation depth : 1.27 / 1.91 mm
  - Separation force : 28.4 g min

Results :

- A Oversize pin : Nothing to report
- B Engagement force test : Pass for all sample (see table on next page).
- C Separation force test : Pass for all samples

Engagement force test on batch 05-34A (g)

Sample	Engagement	Sample	Engagement
Requirement	< 1360 g	Requirement	< 1360 g
1	470	**19**	530
2	450	**20**	400
3	640	**21**	460
4	430	**22**	580
5	450	**23**	560
6	430	**24**	510
7	570	**25**	470
8	580	**26**	440
9	430	**27**	410
10	610	**28**	430
11	540	**29**	510
12	500	**30**	600
13	570	**31**	590
14	420	**32**	490
15	540	**33**	520
16	530	**34**	630
17	440	**35**	540
18	400		

Engagement force test on batch 05-40A (g)

Sample	Engagement	Sample	Engagement
Requirement	< 1360 g	Requirement	< 1360 g
95	460	**108**	440
96	450	**109**	470
97	480	**110**	540
98	500	**111**	390
99	500	**112**	530
100	560	**113**	490
101	520	**114**	490
102	470	**115**	470
103	420	**116**	430
104	480	**117**	480
105	550	**118**	460
106	460	**119**	430
107	410		

Conclusion :

Pass.

Group II subgroup A : Centre contact retention.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Standard RAD GEN CONN 001
Standard RAD DET CONN 003
Standard MIL PRF 39012

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°1 to 35.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°95 to 119.

Equipment :

SMA socket calliper Type 532 n° VCOH 0201 019
Dynamometer CHATILLON force gauge DPP 1 kg n°3012 215 0190

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 14/02/2006

Test description:

The centre contact retention test was performed according to standard MIL PRF 39012 § 4.7.9 and standard RAD GEN CONN 001 § 9.6 with the following conditions :

- A axial (*) force of 27 N was applied on the centre contact in one direction. The inner contact was inspected and the interface dimensions were measured.

- A axial (*) force of 27 N was applied on the centre contact in the opposite direction. The inner contact was inspected and the interface dimensions were measured.

Requirement :
No displacement of the inner contact out of specified interface dimensions.
Interface dimensions shall be conform to the detail specification.
Centre contact 0 / -0.25 mm.

* Rotational forces test was not applicable on this type on connector.

Results :

Nothing to report.
See table on next page.

Results :

Interface dimensions of centre contact on batch 05-34A (mm)

Sample	One direction	Opposite direction	Sample	One direction	Opposite direction
Requirement	0 / -0.25 mm		Requirement	0 / -0.25 mm	
1	-0.09	-0.09	**19**	-0.11	-0.11
2	-0.11	-0.11	**20**	-0.09	-0.09
3	-0.10	-0.10	**21**	-0.11	-0.11
4	-0.12	-0.12	**22**	-0.11	-0.11
5	-0.11	-0.11	**23**	-0.10	-0.10
6	-0.16	-0.16	**24**	-0.09	-0.09
7	-0.11	-0.11	**25**	-0.10	-0.10
8	-0.13	-0.13	**26**	-0.11	-0.11
9	-0.11	-0.12	**27**	-0.09	-0.09
10	-0.11	-0.11	**28**	-0.13	-0.13
11	-0.10	-0.10	**29**	-0.08	-0.08
12	-0.09	-0.09	**30**	-0.12	-0.12
13	-0.12	-0.12	**31**	-0.09	-0.08
14	-0.12	-0.12	**32**	-0.11	-0.11
15	-0.10	-0.10	**33**	-0.14	-0.14
16	-0.11	-0.11	**34**	-0.08	-0.08
17	-0.10	-0.10	**35**	-0.13	-0.13
18	-0.10	-0.10			

Interface dimensions of centre contact on batch 05-40A (mm)

Sample	One direction	Opposite direction	Sample	One direction	Opposite direction
Requirement	0 / -0.25 mm		Requirement	0 / -0.25 mm	
95	-0.10	-0.10	**108**	-0.12	-0.12
96	-0.12	-0.12	**109**	-0.14	-0.14
97	-0.08	-0.08	**110**	-0.14	-0.14
98	-0.09	-0.09	**111**	-0.12	-0.12
99	-0.11	-0.11	**112**	-0.09	-0.09
100	-0.10	-0.10	**113**	-0.11	-0.11
101	-0.12	-0.12	**114**	-0.14	-0.14
102	-0.11	-0.11	**115**	-0.12	-0.12
103	-0.12	-0.11	**116**	-0.08	-0.08
104	-0.13	-0.12	**117**	-0.09	-0.09
105	-0.13	-0.13	**118**	-0.10	-0.10
106	-0.12	-0.12	**119**	-0.13	-0.13
107	-0.12	-0.12			

Conclusion :

Pass.

Group II subgroup A : Connector durability.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Standard RAD GEN CONN 001
Standard RAD DET CONN 003
Standard MIL PRF 39012

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°1 to 35.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°95 to 119.

Equipment :

Wrench SMA torque RADIALL 110 N*cm n° 1030 139 0204
Dynamometer ADEMVA CM10 3014 102 0787
Test range SMA male torque N°91125010

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 14/02 to 22/03/2006

Test description:

The connector durability test was performed according to standard MIL PRF 39012 § 4.7.12 and generic RAD-GEN-CONN-001 § 9.18. with the following conditions :
- Number of mating unmating cycles : 500.
- Rate : 12 cycles maximum/minute.
- Coupling torque : 100 N*cm .
- The connector and its mating part were completely mated and completely unmated during the cycle.
- Each connector under test was mated with a typical production mating connector.

Requirements :
- Visual inspection : After the test, the connectors shall be visually examined and, except for contact and thread wear, there shall be no evidence of damage.
- Mating / unmating force ≤ 24N.cm (as described page 26).

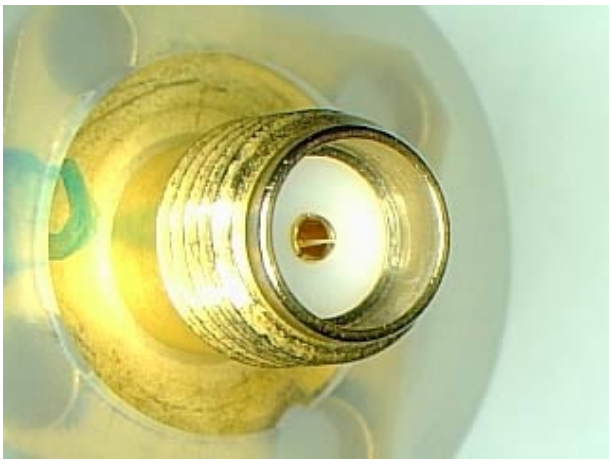
Results :

- Visual inspection after a complete cleaning : except for contact and thread wear, there was no evidence of damage on all samples.

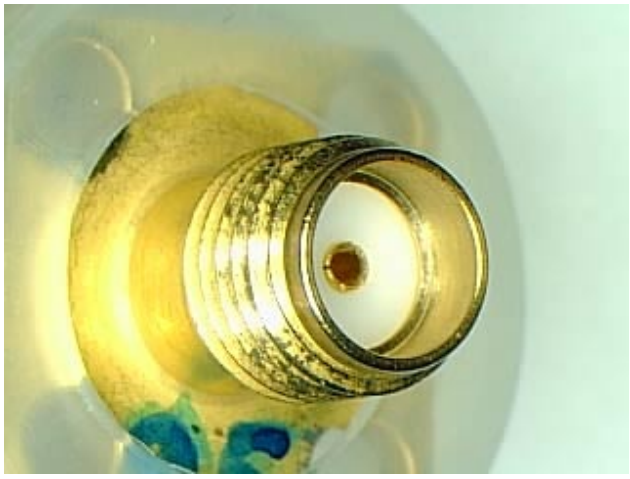
Some photos of samples after durability test

Sample N°1 batch 05-34A

Sample N°2 batch 05-34A



Visual inspection on some sample

Sample N°10 batch 05-34A	Sample N°20 batch 05-34A
	
Sample N°30 batch 05-34A	Sample N°95 batch 05-40A
	
Sample N°108 batch 05-40A	Sample N°119 batch 05-40A
	

- Mating / unmating force ≤ 24N.cm

Force to engage and disengage on batch 05-34A (N.cm)

Sample	Mating	Unmating	Sample	Mating	Unmating
Requirement	< 24 N.cm		Requirement	< 24 N.cm	
1	< 2	< 2	**19**	< 2	< 2
2	< 2	< 2	**20**	< 2	< 2
3	< 2	< 2	**21**	< 2	< 2
4	< 2	< 2	**22**	< 2	< 2
5	< 2	< 2	**23**	< 2	< 2
6	< 2	< 2	**24**	< 2	< 2
7	< 2	< 2	**25**	< 3	< 3
8	< 2	< 2	**26**	< 2	< 2
9	< 2	< 2	**27**	< 2	< 2
10	< 2	< 2	**28**	< 2	< 2
11	< 2	< 2	**29**	< 3	< 3
12	< 2	< 2	**30**	< 2	< 2
13	< 2	< 2	**31**	< 2	< 2
14	< 2	< 2	**32**	< 2	< 2
15	< 2	< 2	**33**	< 2	< 2
16	< 2	< 2	**34**	< 2	< 2
17	< 2	< 2	**35**	< 2	< 2
18	< 2	< 2			

Force to engage and disengage on batch 05-40A (N.cm)

Sample	Mating	Unmating	Sample	Mating	Unmating
Requirement	< 24 N.cm		Requirement	< 24 N.cm	
95	< 2	< 2	**108**	< 2	< 2
96	< 3	< 3	**109**	< 2	< 2
97	< 2	< 2	**110**	< 2	< 2
98	< 2	< 2	**111**	< 2	< 2
99	< 2	< 2	**112**	< 2	< 2
100	< 2	< 2	**113**	< 2	< 2
101	< 2	< 2	**114**	< 2	< 2
102	< 2	< 2	**115**	< 2	< 2
103	< 2	< 2	**116**	< 2	< 2
104	< 2	< 2	**117**	< 2	< 2
105	< 2	< 2	**118**	< 2	< 2
106	< 2	< 2	**119**	< 2	< 2
107	< 5	< 5			

Conclusion :

Pass.

Group II subgroup B : Steady state humidity.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Test method standard MIL-STD-202 G

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°36 to 70.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°120 to 144.

Equipment :

Climatic chamber MPC type FO n°3053 017 0583

Room temperature :	**Room humidity :**	**Room pressure :**
20 ± 10 °C	25 - 70 % HR	860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 08/02 to 15/02/2006

Test description:

The steady state humidity test was performed according to standard MIL-STD 202 G method 103 condition B and following conditions :
- Temperature : +40°C.
- Humidity : 90 to 95% R.H..
- Duration : 168 hours

Results :

Nothing to report.

Conclusion :

Pass.

Group II subgroup B : Dielectric withstanding voltage after steady state humidity.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Test method standard MIL-STD-202 G

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°36 to 70.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°120 to 144.

Equipment :

Dielectrimeter SEFELEC MPC316 n°8064 007 1091

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 16/02/2006

Test description:

The voltage withstanding test was performed according to standard MIL-STD-202 G method 301 with the following conditions :
- Voltage : 1000 Vrms.
- Duration : 1 minute minimum.
- The test voltage was applied on uncabled connectors between centre contact and shell.

Requirement : 1000V with no leakage current ≥ 2 mA. Pass or fail.

Results :

Pass for all samples.

Tests / Samples	Batch 05-34A / N°36 to 70	Batch 05-40A / N°120 to 144
Dielectric withstanding voltage (1000 Vrms)	Pass	Pass

Conclusion :

Pass.

Group II subgroup B : Insulation resistance after steady state humidity.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Test method standard MIL-STD-202 G

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°36 to 70.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°120 to 144.

Equipment :

Dielectrimeter SEFELEC MPC316 n°8064 007 1091

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 16/02/2006

Test description:

The insulation resistance test was performed according to standard MIL-STD-202 G method 302 condition B with the following conditions :
- Voltage : 500 V dc.
- Duration before measurement : 1 minute minimum.
- The test voltage was applied on uncabled connectors between centre contact and shell.

Requirement : > 5000 MΩ. Pass or fail.

Results :

Pass for all samples.

Tests / Samples	Batch 05-34A / N°36 to 70	Batch 05-40A / N°120 to 144
Insulation resistance (> 5000 MΩ.)	Pass	Pass

Conclusion :

Pass.

Group II subgroup B : Contact resistance after steady state humidity.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Test method standard MIL-PRF-39012
Standard RAD DET CONN 003

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°36 to 70.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°120 to 144.

Equipment :

Microhmmeter SEFELEC MGR10 n° 80630040106

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 17/02/2006

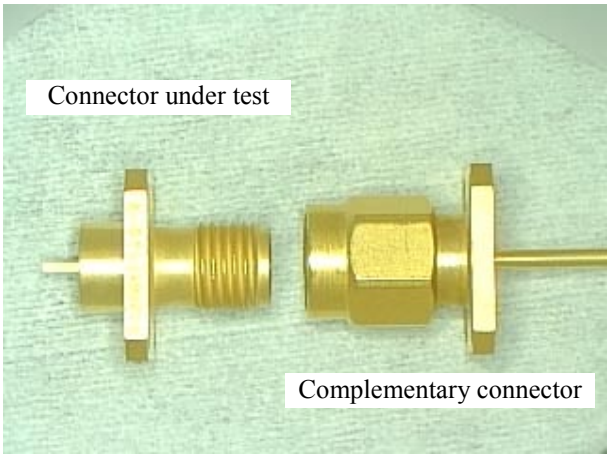
Test description:

The contact resistance test was performed according to standard MIL-PRF-39012 paragraph 4.7.13 method B with following conditions :
- Measurement current : 50mA
- Nominal DC potential on open circuit : 5 V
- Measurement was performed with complementary connector.

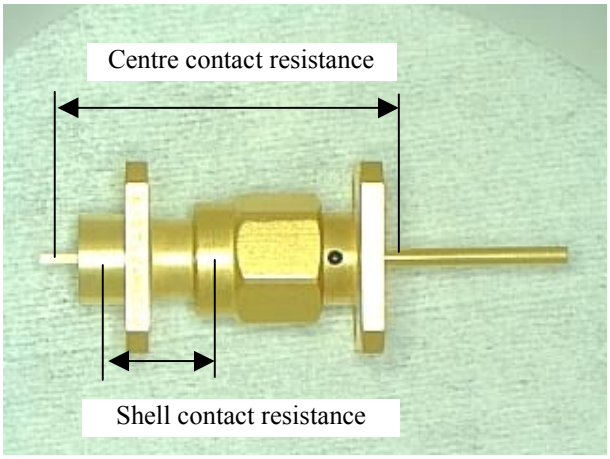
Requirement :
- Centre contact ≤ 3.0 mΩ
- Shell contact ≤ 2.0 mΩ

Points of measurements

Before assembling



During measurement



Group II subgroup B : Contact resistance after steady state humidity.

Results :

Contact resistance on batch 05-34A (mΩ)

Sample	Centre contact	Shell contact	Sample	Centre contact	Shell contact
Requirement	≤ 3.0 mΩ	≤ 2.0 mΩ	Requirement	≤ 3.0 mΩ	≤ 2.0 mΩ
N°36	2.55	0.57	N°54	2.69	0.72
N°37	2.54	0.53	N°55	2.50	0.59
N°38	2.51	0.73	N°56	2.55	0.55
N°39	2.54	0.69	N°57	2.57	0.57
N°40	2.60	0.71	N°58	2.54	0.66
N°41	2.59	0.63	N°59	2.46	0.67
N°42	2.47	0.67	N°60	2.45	0.83
N°43	2.45	0.70	N°61	2.70	0.73
N°44	2.70	0.53	N°62	2.61	0.67
N°45	2.59	0.65	N°63	2.51	0.58
N°46	2.38	0.50	N°64	2.62	0.55
N°47	2.41	0.57	N°65	2.47	0.53
N°48	2.44	0.53	N°66	2.70	0.52
N°49	2.60	0.39	N°67	2.50	0.58
N°50	2.27	0.58	N°68	2.59	0.53
N°51	2.55	0.56	N°69	2.58	0.57
N°52	2.69	0.70	N°70	2.50	0.70
N°53	2.68	0.77			

Contact resistance on batch 05-40A (mΩ)

Sample	Centre contact	Shell contact	Sample	Centre contact	Shell contact
Requirement	≤ 3.0 mΩ	≤ 2.0 mΩ	Requirement	≤ 3.0 mΩ	≤ 2.0 mΩ
N°120	2.66	0.75	N°133	2.50	0.75
N°121	2.62	0.65	N°134	2.34	0.62
N°122	2.70	0.72	N°135	2.40	0.57
N°123	2.60	0.64	N°136	2.60	0.59
N°124	2.52	0.63	N°137	2.42	0.57
N°125	2.61	0.74	N°138	N.A.	N.A.
N°126	2.56	0.73	N°139	2.68	0.52
N°127	2.66	0.70	N°140	2.49	0.70
N°128	2.47	0.69	N°141	2.72	0.63
N°129	2.51	0.67	N°142	2.61	0.71
N°130	2.69	0.57	N°143	2.65	0.80
N°131	2.58	0.82	N°144	2.60	0.72
N°132	2.78	0.80			

Conclusion :

Pass.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Standard RAD DET CONN 003
Radiall FIQ T 4 C 041

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°71 to 87.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°145 to 157.

Equipment :

Digital calliper MITUTOYO type ID-150M n°3002 116 0586
Digital calliper MITUTOYO 0-25mm n°3001 142 1190
Digital calliper MITUTOYO n°3000182 0699
Digital calliper MITUTOYO type NTD10P-15 n°3000 101 1194
Fischer scope 1600 X9AL N°020 7552

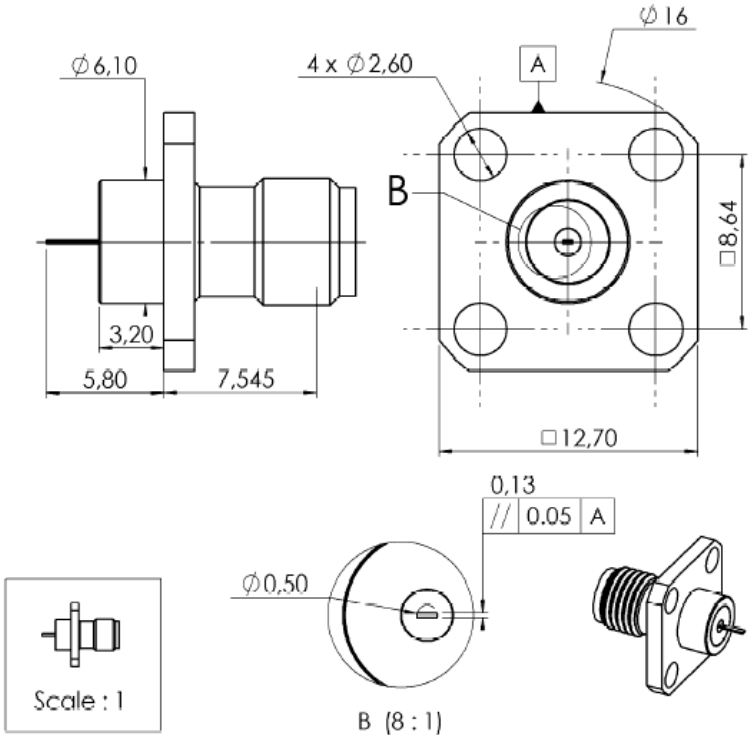
Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D. / Grandvallet V.	**Department :** IDA laboratory / Voreppe plant	**Date of test :** 03/03 to 09/03/2006

Test description:

In the group III called “microsectioning”, the requirement are the physical dimensions and the gold plating thickness :

- To perform the gold plating thickness test, we use the fluorescence X ray method according to quality instruction file FIQ T 4 C 041, but we must separate the tab contact from the SMA connector. With this method it was not necessary to practice microsectioning.

- Connector dimensions measurements were performed according to RADIALL technical data sheet R125612140X.



Results :

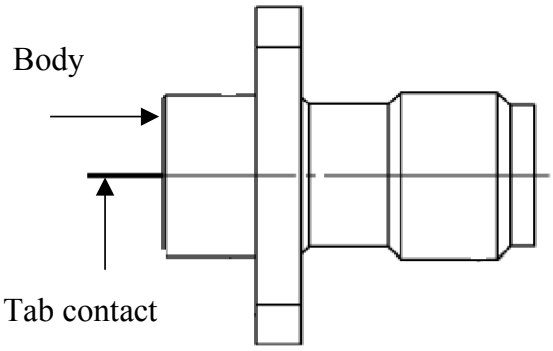
- Connector dimension

Dimensions (mm)

Dimensions	∅ 6.10	5.80	3.20	7.545	∅ 0.50	0.13	8.64	2.60	∅ 16.0
Min	6.00	5.70	3.10	7.70	0.45	0.11	8.59	2.70	15.90
Max	6.20	5.90	3.30	7.50	0.55	0.15	8.69	2.55	16.10
Samples	Batch 05-34A								
71	6.10	5.82	3.24	7.557	0.51	0.15	Pass	Pass	Pass
72	6.10	5.78	3.22	7.546	0.51	0.15	Pass	Pass	Pass
73	6.08	5.80	3.24	7.553	0.51	0.15	Pass	Pass	Pass
74	6.09	5.80	3.23	7.569	0.52	0.15	Pass	Pass	Pass
75	6.10	5.82	3.26	7.556	0.51	0.15	Pass	Pass	Pass
76	6.11	5.81	3.24	7.551	0.51	0.15	Pass	Pass	Pass
77	6.09	5.79	3.24	7.564	0.52	0.15	Pass	Pass	Pass
78	6.09	5.82	3.24	7.549	0.52	0.15	Pass	Pass	Pass
79	6.08	5.79	3.24	7.552	0.51	0.15	Pass	Pass	Pass
80	6.08	5.80	3.23	7.552	0.52	0.15	Pass	Pass	Pass
81	6.11	5.79	3.23	7.574	0.51	0.15	Pass	Pass	Pass
82	6.08	5.80	3.23	7.547	0.53	0.15	Pass	Pass	Pass
83	6.10	5.82	3.25	7.550	0.50	0.15	Pass	Pass	Pass
84	6.08	5.80	3.22	7.544	0.52	0.15	Pass	Pass	Pass
85	6.09	5.83	3.24	7.559	0.52	0.15	Pass	Pass	Pass
86	6.11	5.83	3.26	7.537	0.50	0.15	Pass	Pass	Pass
87	6.11	5.80	3.24	7.547	0.50	0.15	Pass	Pass	Pass
Samples	Batch 05-40A								
145	6.08	5.77	3.23	7.562	0.51	0.15	Pass	Pass	Pass
146	6.10	5.80	3.24	7.561	0.52	0.15	Pass	Pass	Pass
147	6.11	5.80	3.23	7.544	0.50	0.15	Pass	Pass	Pass
148	6.09	5.79	3.23	7.535	0.53	0.14	Pass	Pass	Pass
149	6.08	5.83	3.27	7.540	0.51	0.15	Pass	Pass	Pass
150	6.09	5.80	3.25	7.545	0.51	0.15	Pass	Pass	Pass
151	6.10	5.83	3.28	7.545	0.49	0.16	Pass	Pass	Pass
152	6.11	5.82	3.27	7.563	0.51	0.14	Pass	Pass	Pass
153	6.09	5.80	3.25	7.547	0.51	0.15	Pass	Pass	Pass
154	6.10	5.84	3.29	7.536	0.51	0.15	Pass	Pass	Pass
155	6.10	5.81	3.24	7.543	0.50	0.14	Pass	Pass	Pass
156	6.08	5.81	3.24	7.549	0.51	0.14	Pass	Pass	Pass
157	6.11	5.79	3.23	7.552	0.50	0.15	Pass	Pass	Pass

- Gold plating thickness measurement

Points of measurement on samples by fluorescence X ray (µm).



Batch 05-34A			Batch 05-40A		
Sample / point	body	tab contact	Sample N°	body	tab contact
Requirement	> 0.5 µm	> 1.3 µm	Requirement	> 0.5 µm	> 1.3 µm
71	0.76	1.55	145	0.71	1.42
72	0.83	1.51	146	0.74	1.51
73	0.80	1.57	147	0.76	1.45
74	0.78	1.63	148	0.85	1.50
75	0.77	1.48	149	0.81	1.39
76	0.82	1.80	150	0.80	1.36
77	0.81	1.71	151	0.83	1.55
78	0.75	1.41	152	0.70	1.58
79	0.69	1.46	153	0.71	1.34
80	0.76	1.40	154	0.76	1.47
81	0.75	1.55	155	0.73	1.45
82	0.72	1.76	156	0.80	1.40
83	0.83	1.58	157	0.75	1.43
84	0.75	1.57			
85	0.76	1.76			
86	0.75	1.43			
87	0.80	1.68			

Conclusion :

- Connector dimension : Pass.
- Gold plating thickness measurement : Pass.

Group IV : Solderability.

Specification :

ASTRA Microwave products order N°4520001573
Technical data sheet R125612140X
Standard RAD DET CONN 003
Test method standard MIL-STD-202 G method 208

Sampling :

Square flange receptacle tab contact SMA R125612140X Batch 05-34A N°88 to 94.
Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°158 to 162.

Equipment :

Thermostatic bath

Room temperature : 20 ± 10 °C	**Room humidity :** 25 - 70 % HR	**Room pressure :** 860 -1060 mbar
Operator : Bouvier D.	**Department :** IDA laboratory	**Date of test :** 02 and 03/03/2006

Test description:

The test was performed in accordance with MIL-STD-202 method 208 with the following conditions. The sample was subjected to an aging process ; it stayed in steam of distilled water for 8 hours, and then it dried at room temperature. Within 18 hours after this test, the solderability test was performed. Flux immersion ; the sample was dipped in flux (non activated flux) at room ambient temperature and drained for 5 to 20 seconds. The sample was dipped into a 63% tin 37 % lead soldering bath at 245°C for 5 seconds. The remaining flux was removed thanks to a isopropyl alcohol before final visual inspection.

Requirement : No visual damage and no any cracking.

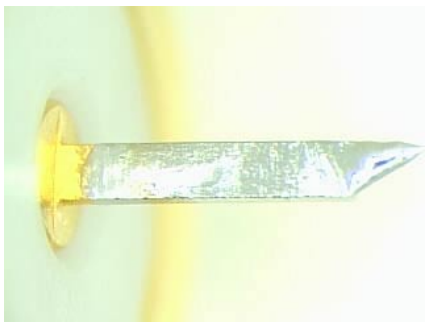
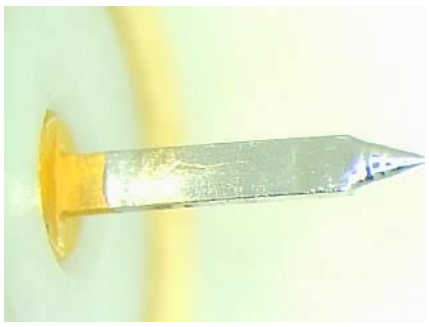
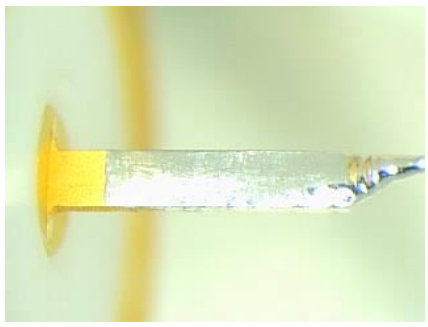
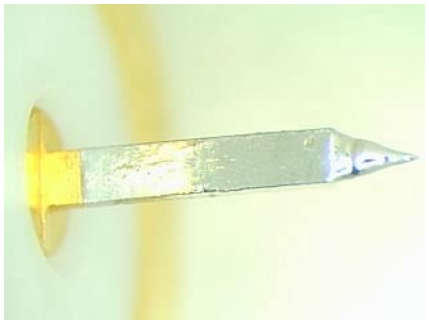
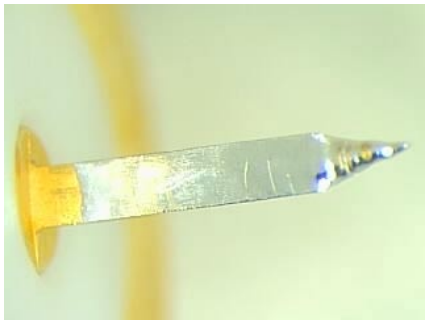
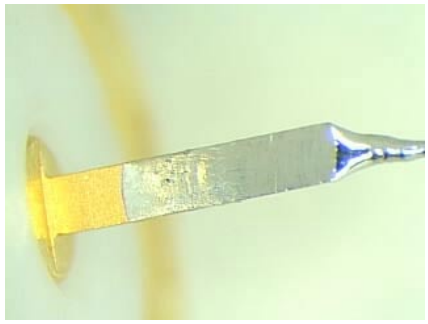
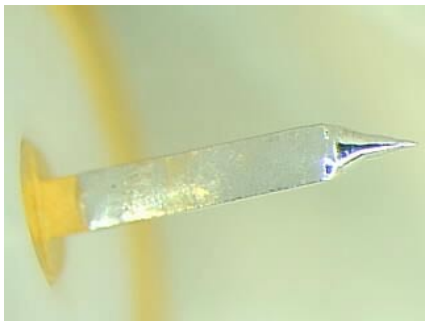
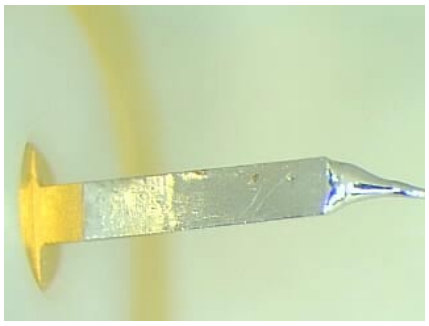
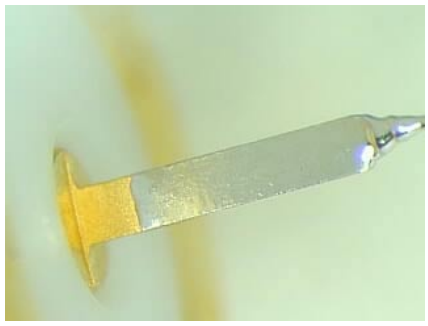
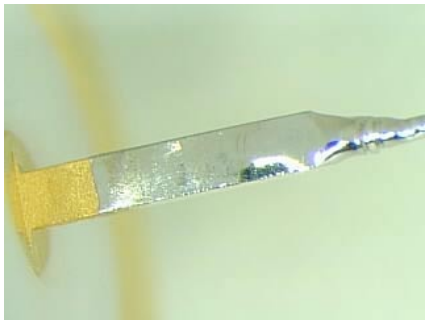
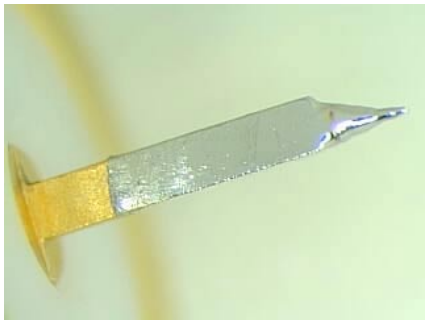
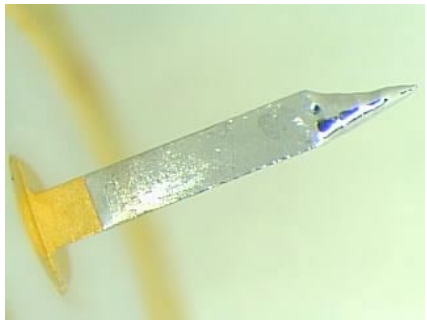
Results :

The samples did not show evidence of damage or cracking.
See photographs on next page.

Conclusion :

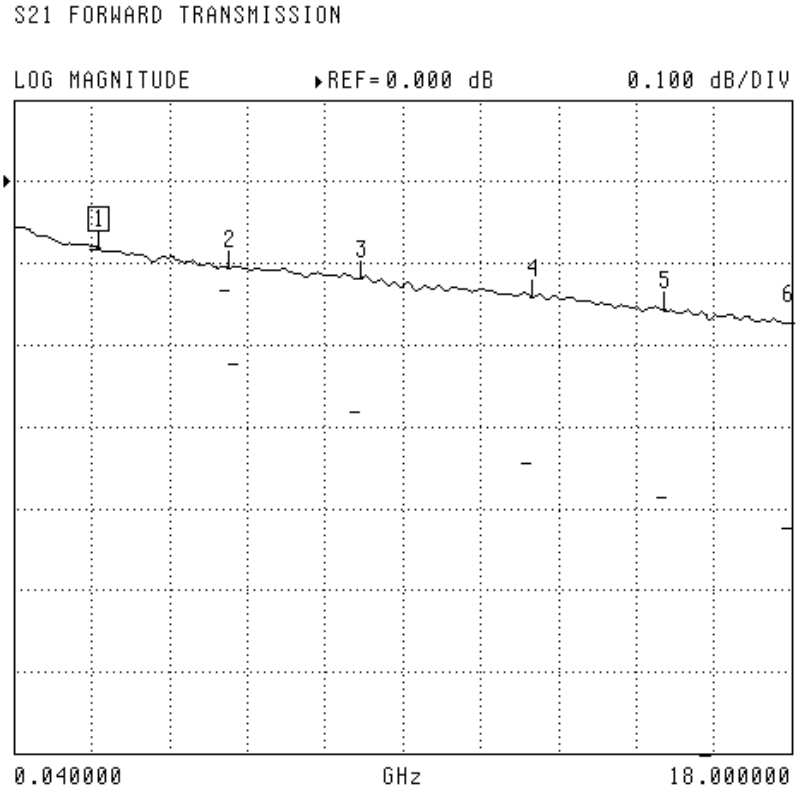
Pass.

Visual inspection on tabs after solderability test.

Sample N°**88** batch 05-34A	Sample N°**89** batch 05-34A	Sample N°**90** batch 05-34A
		
Sample N°**91** batch 05-34A	Sample N°**92** batch 05-34A	Sample N°**93** batch 05-34A
		
Sample N°**94** batch 05-34A	Sample N°**158** batch 05-40A	Sample N°**159** batch 05-40A
		
Sample N°**160** batch 05-40A	Sample N°**161** batch 05-40A	Sample N°**162** batch 05-40A
		

Insertion loss graphs.

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 1/2

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

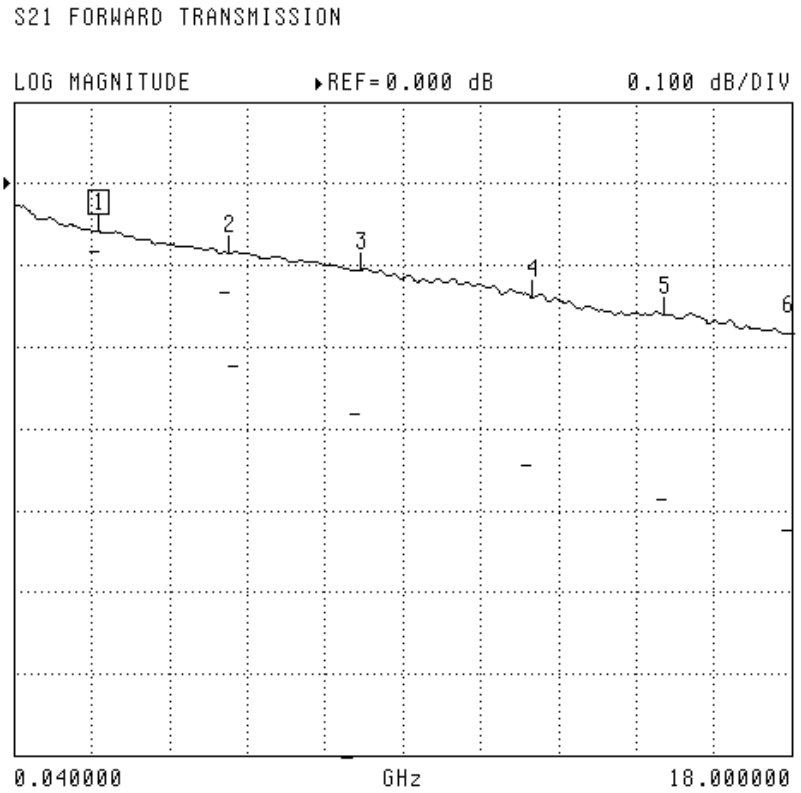
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 3/4

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

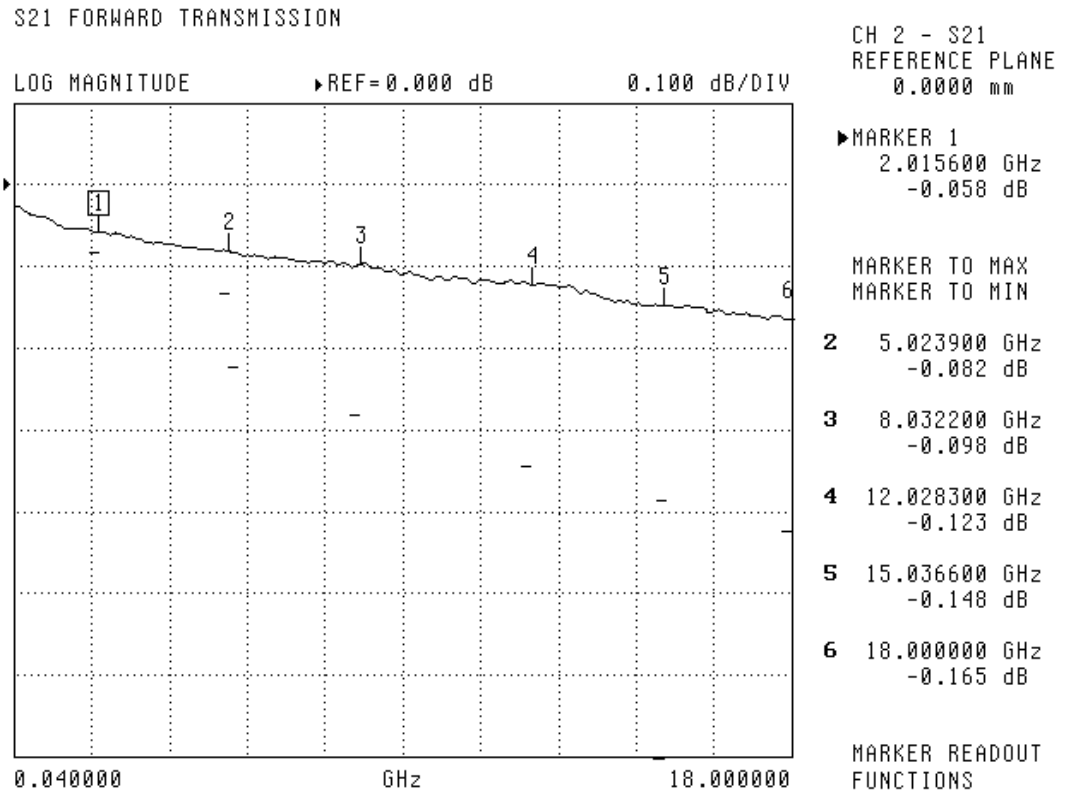
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 5/6

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

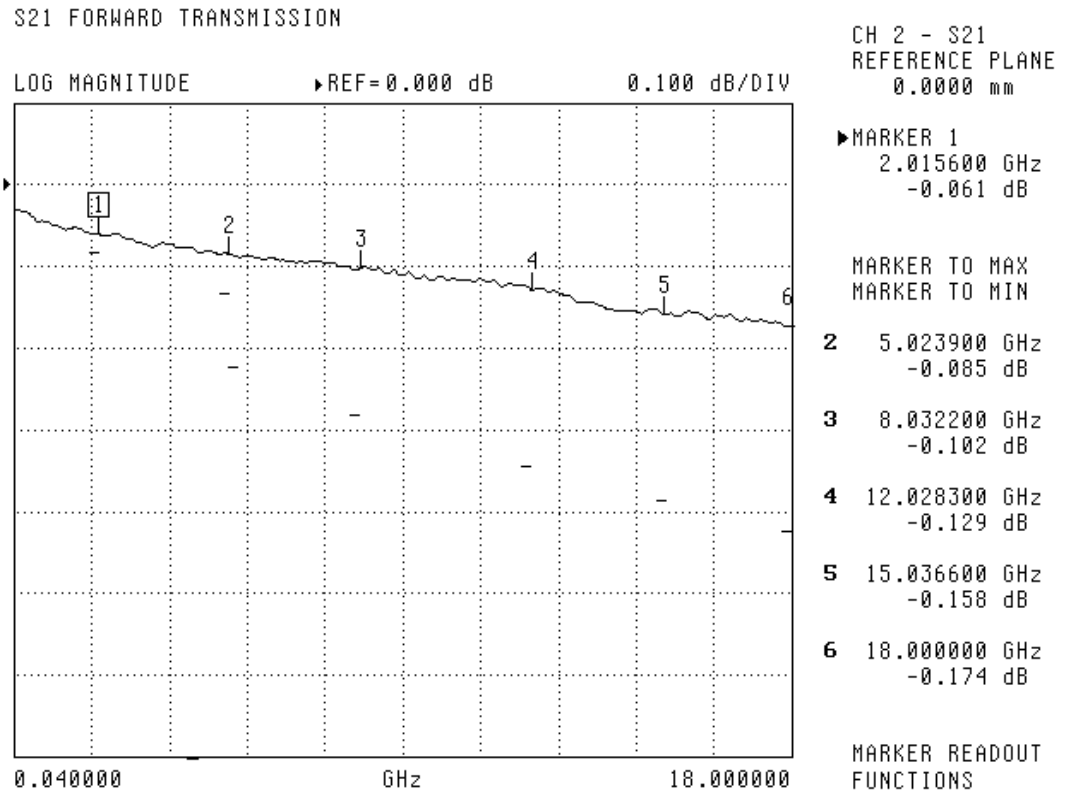
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 7/8

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

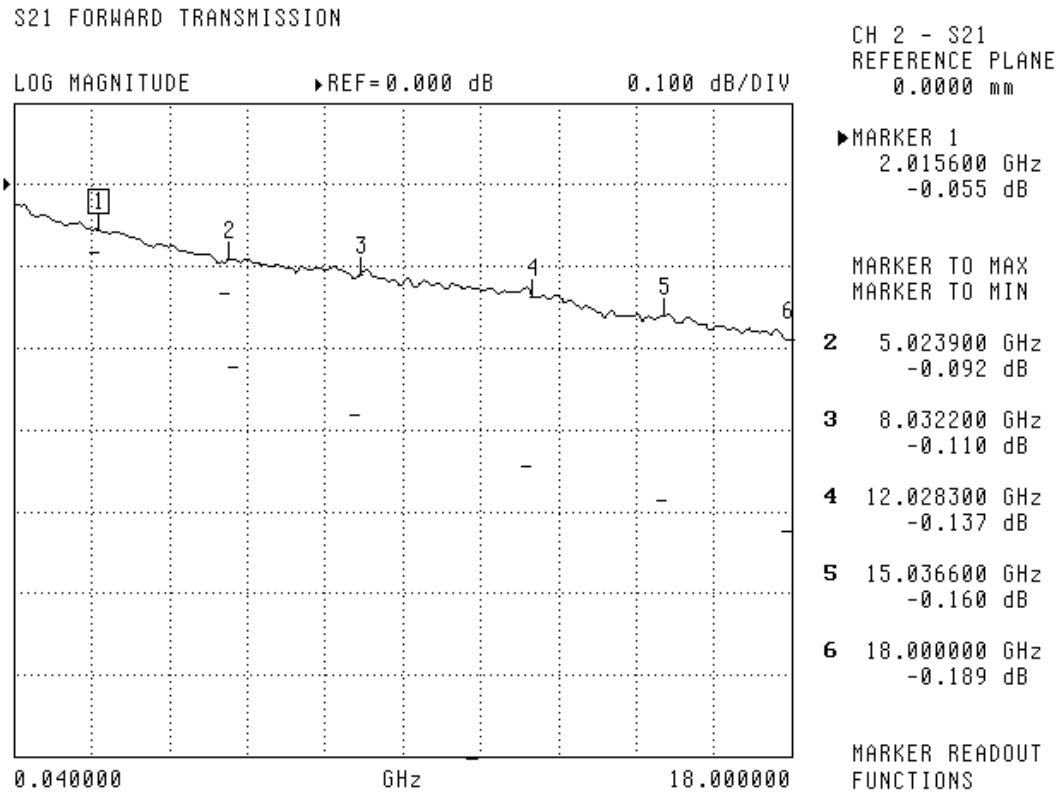
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 9/10

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

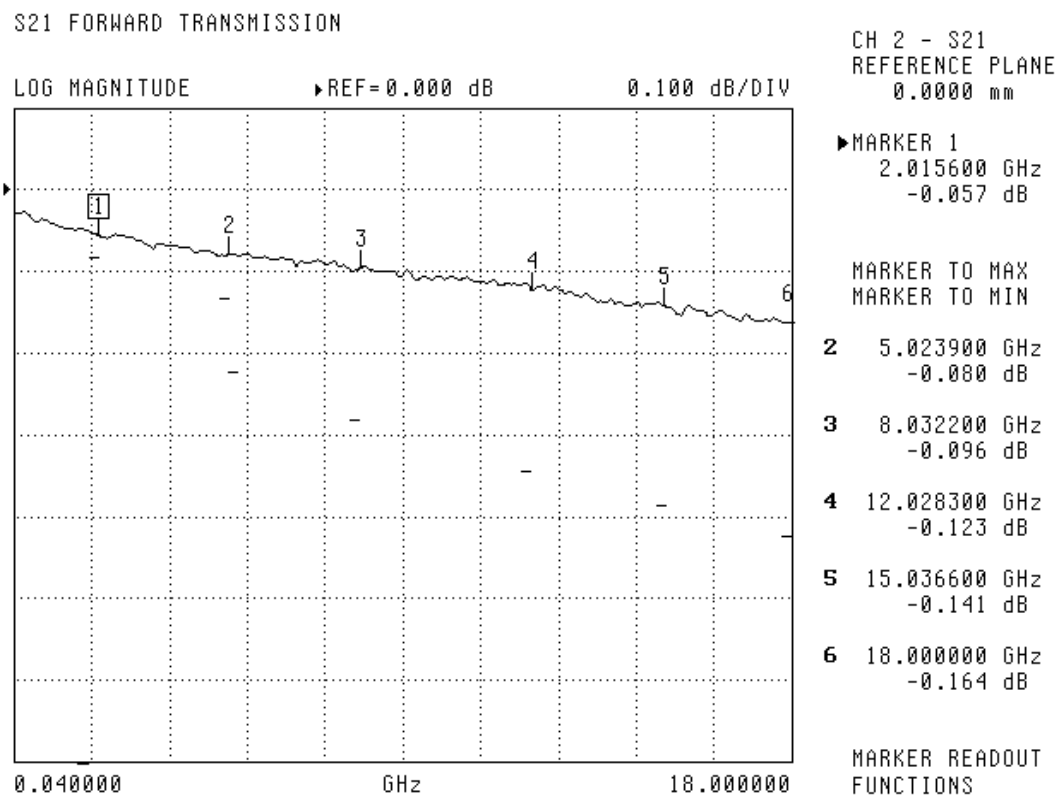
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 11/12

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

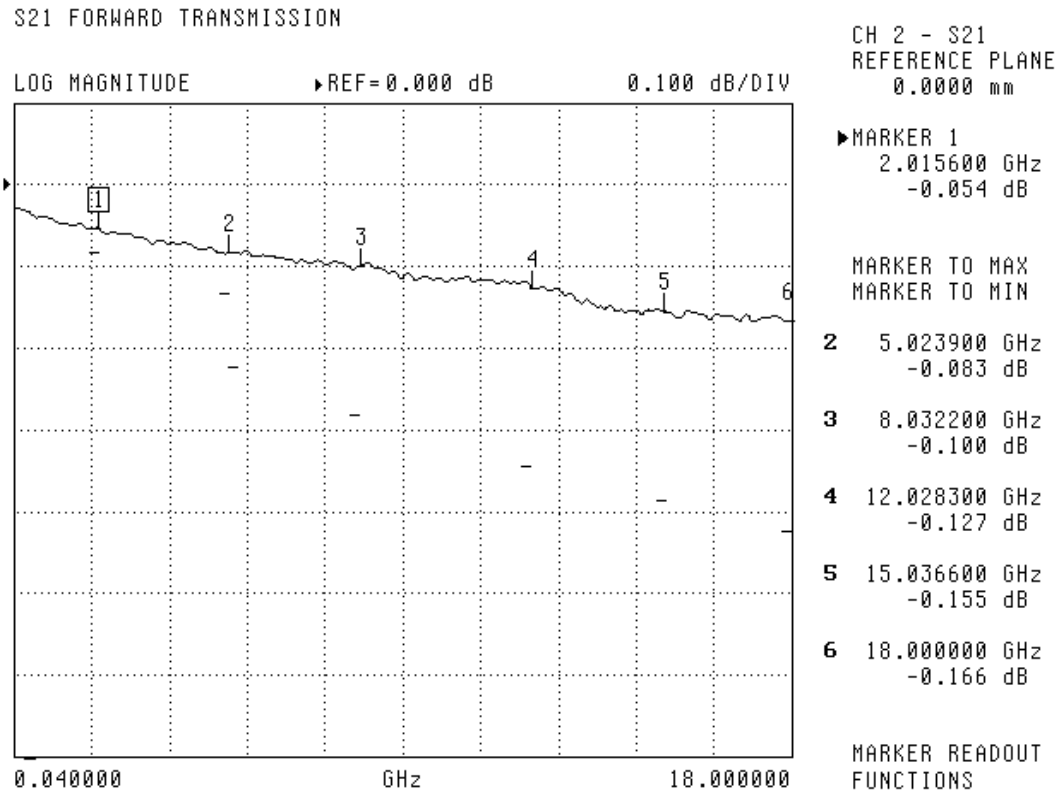
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 13/14

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

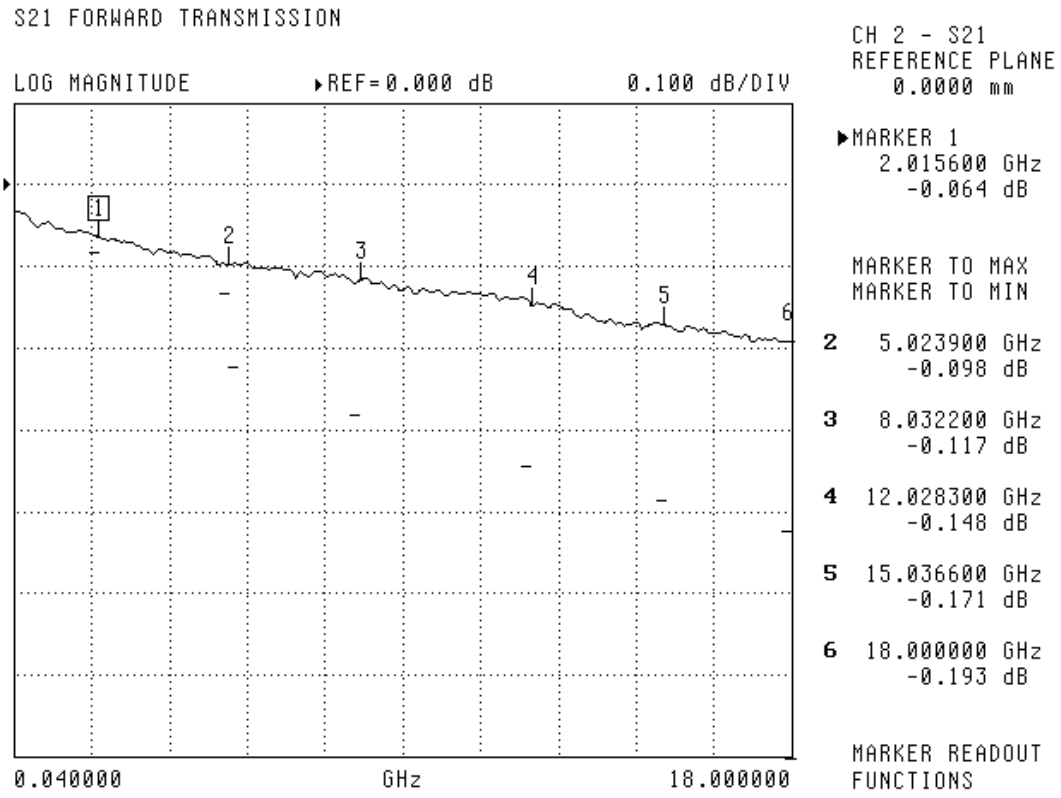
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 15/16

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

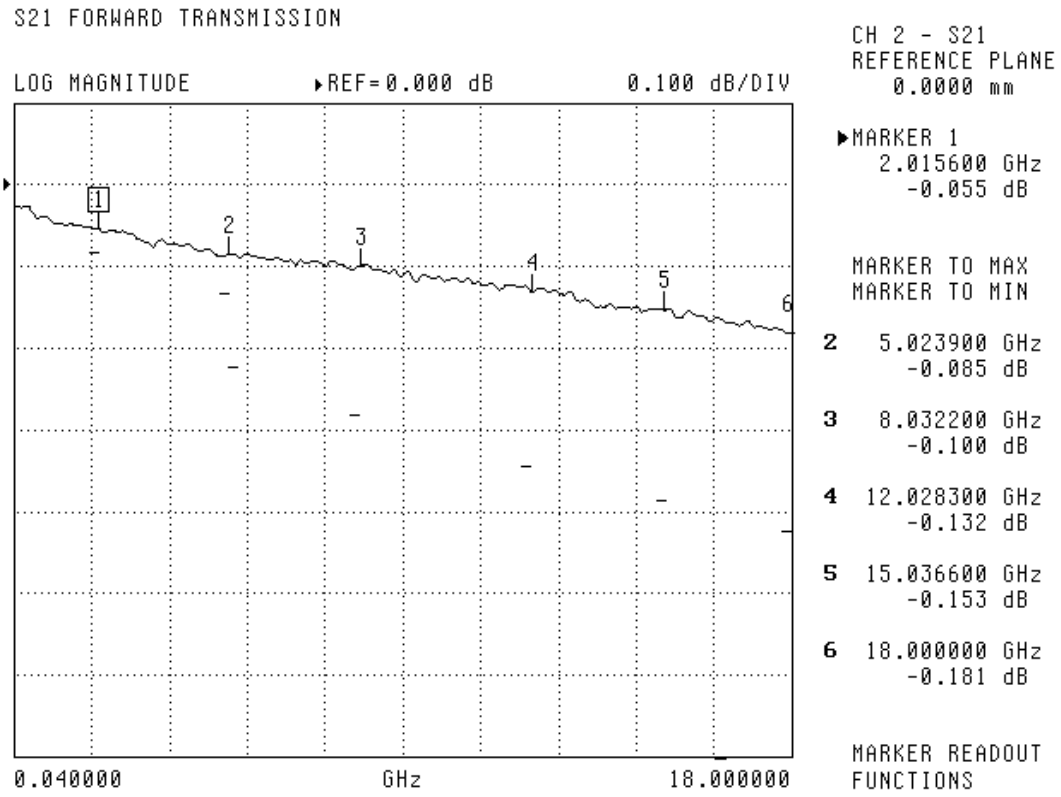
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 17/18

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

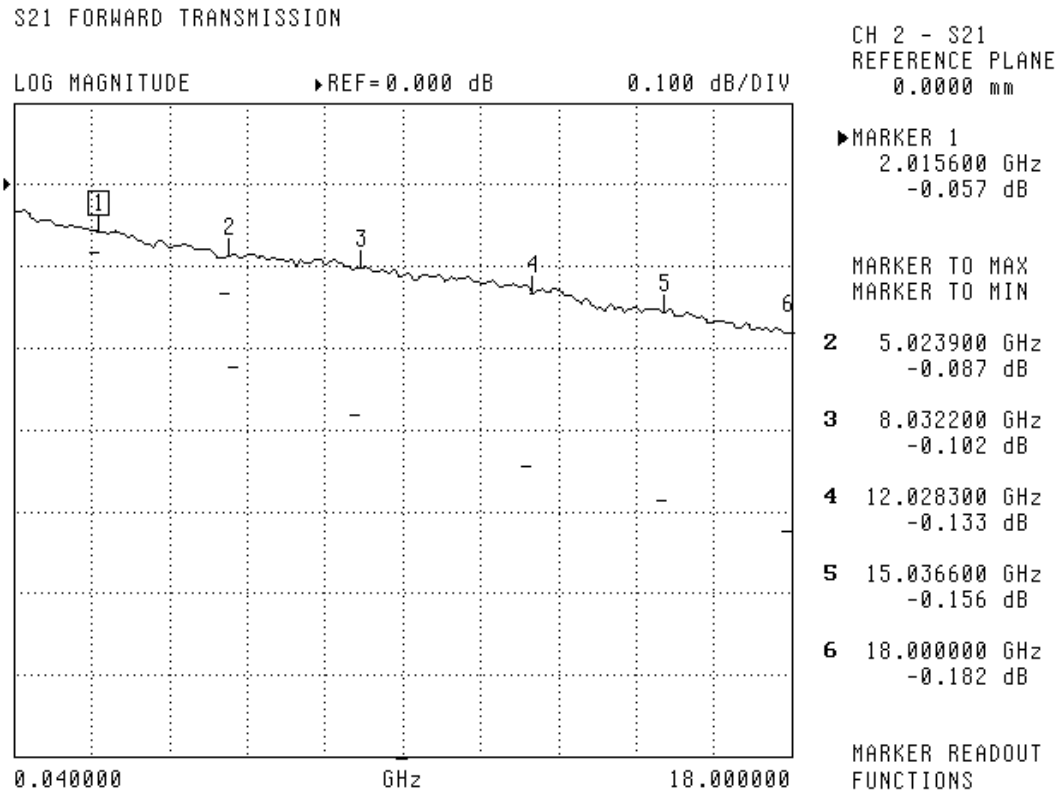
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 19/20

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

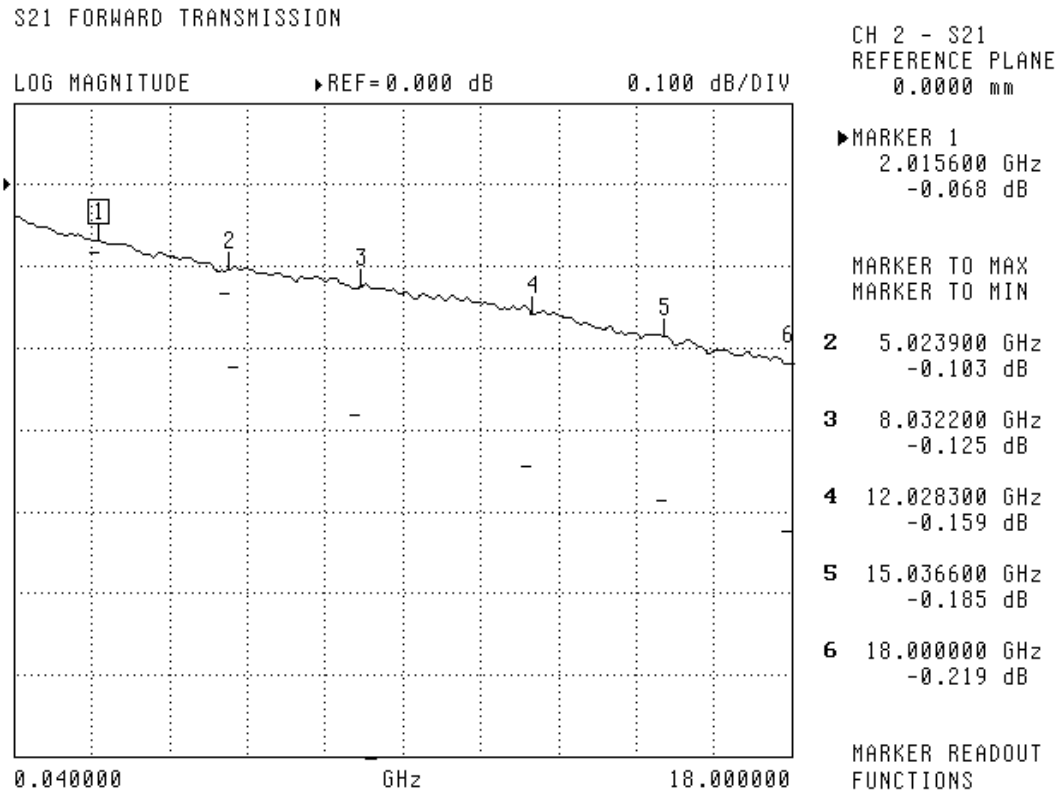
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 21/22

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

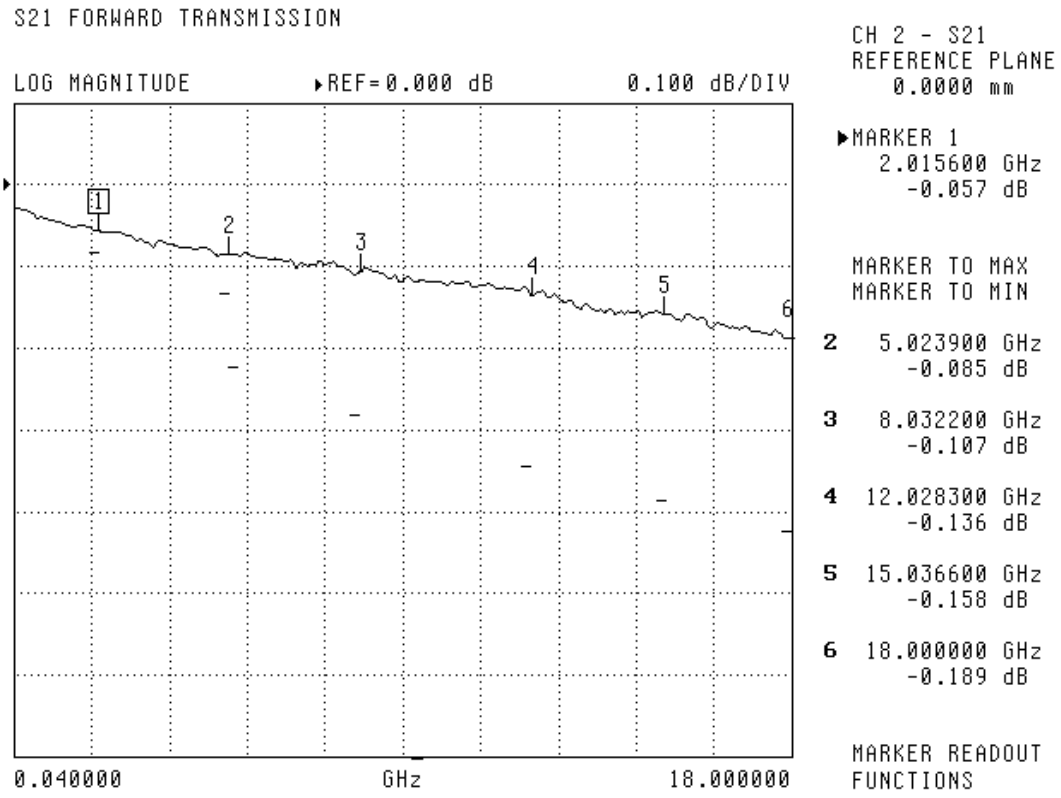
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 23/24

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

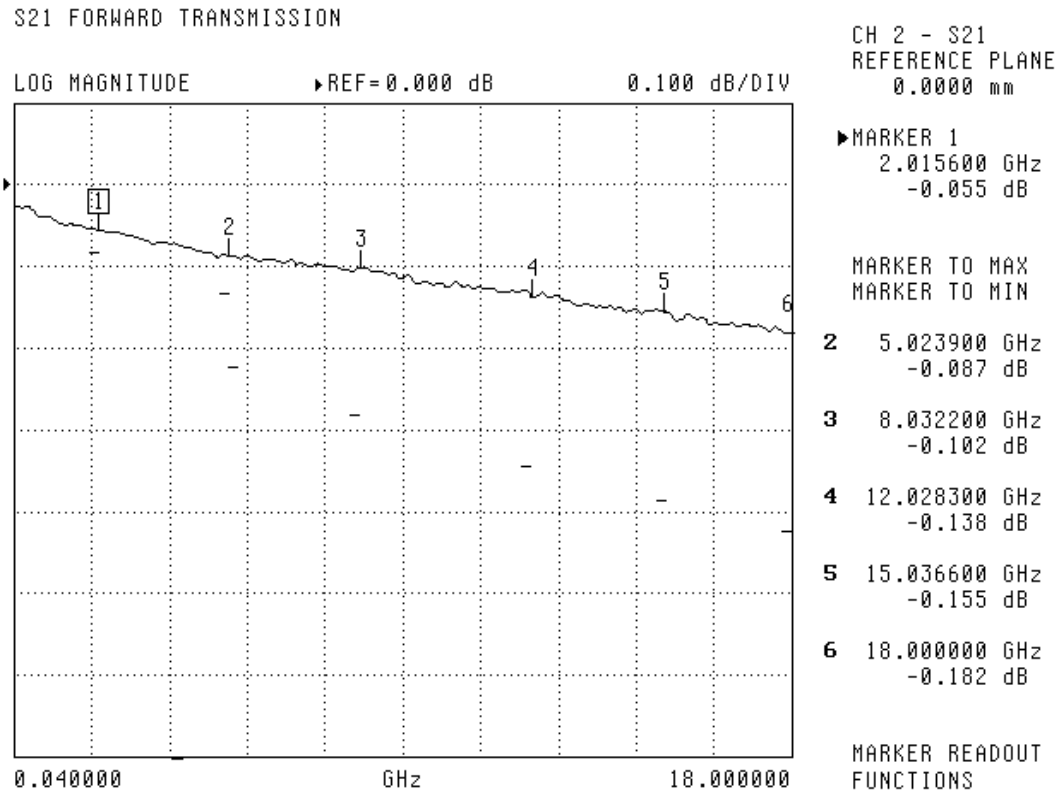
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 25/26

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

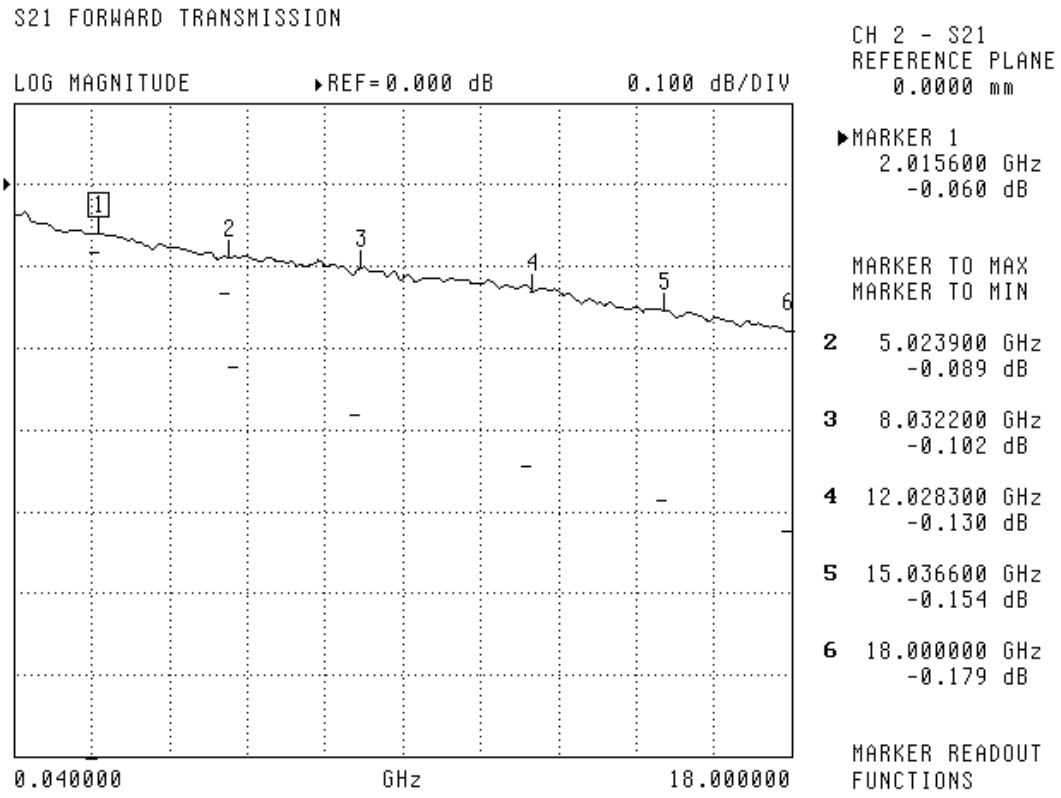
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 27/28

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

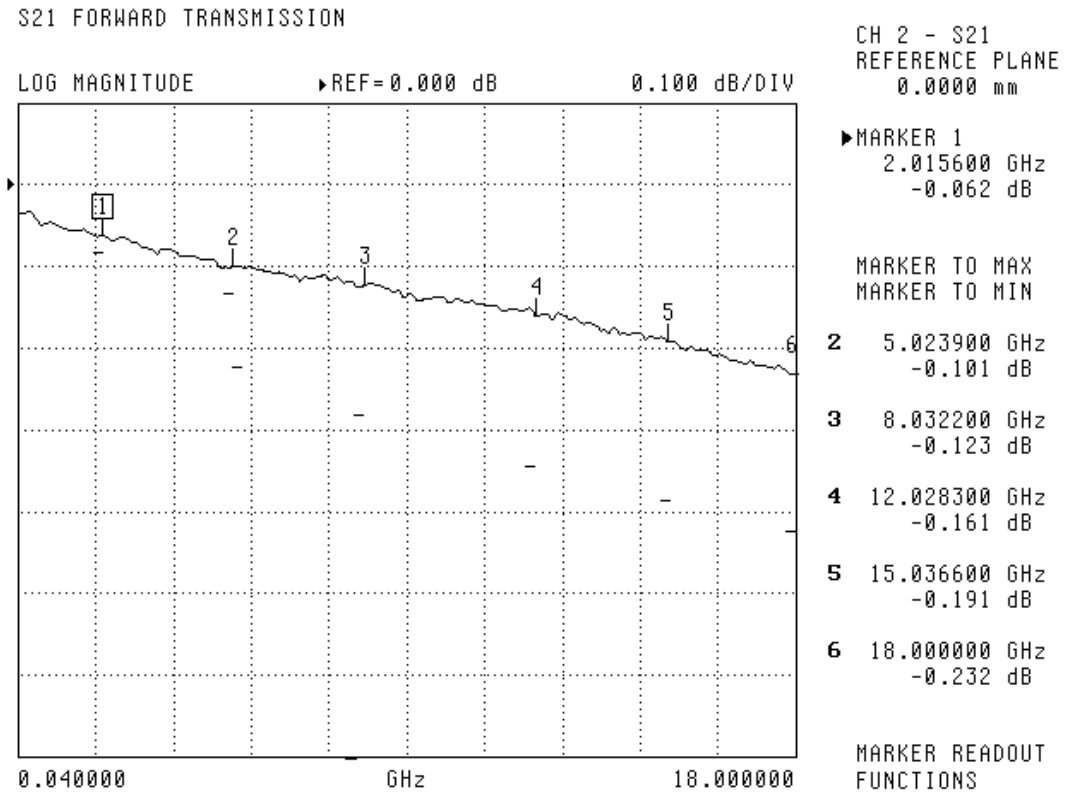
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 29/30

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

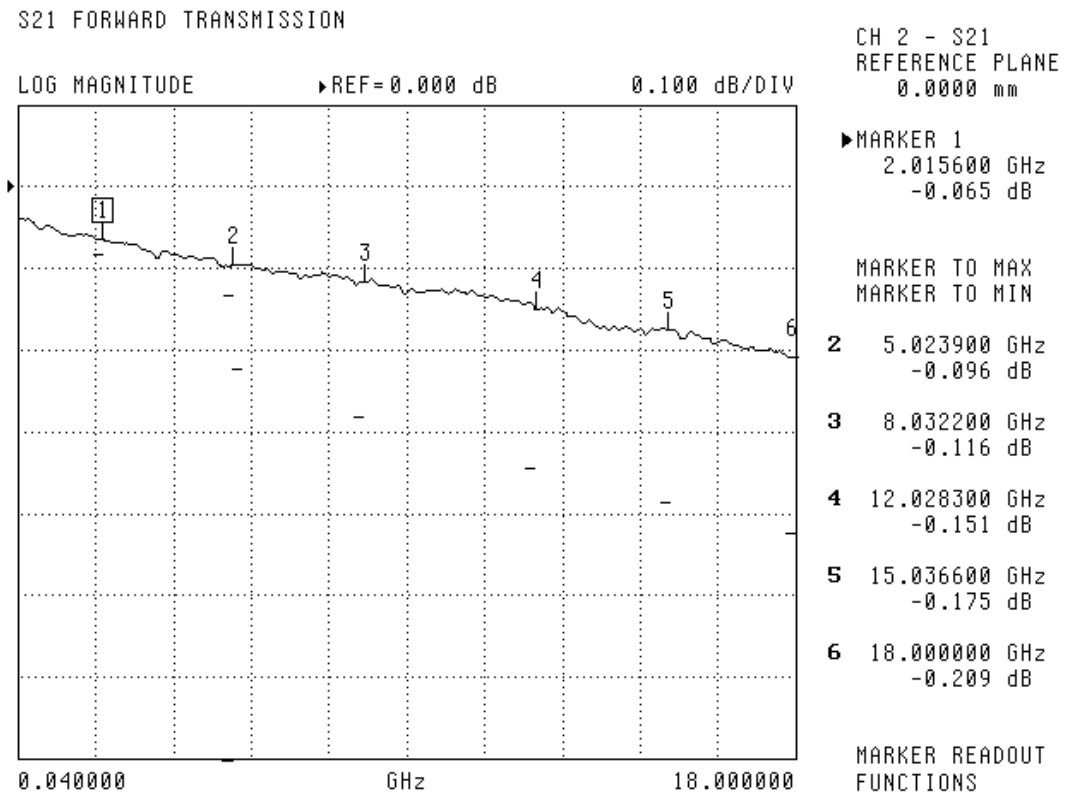
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 31/32

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

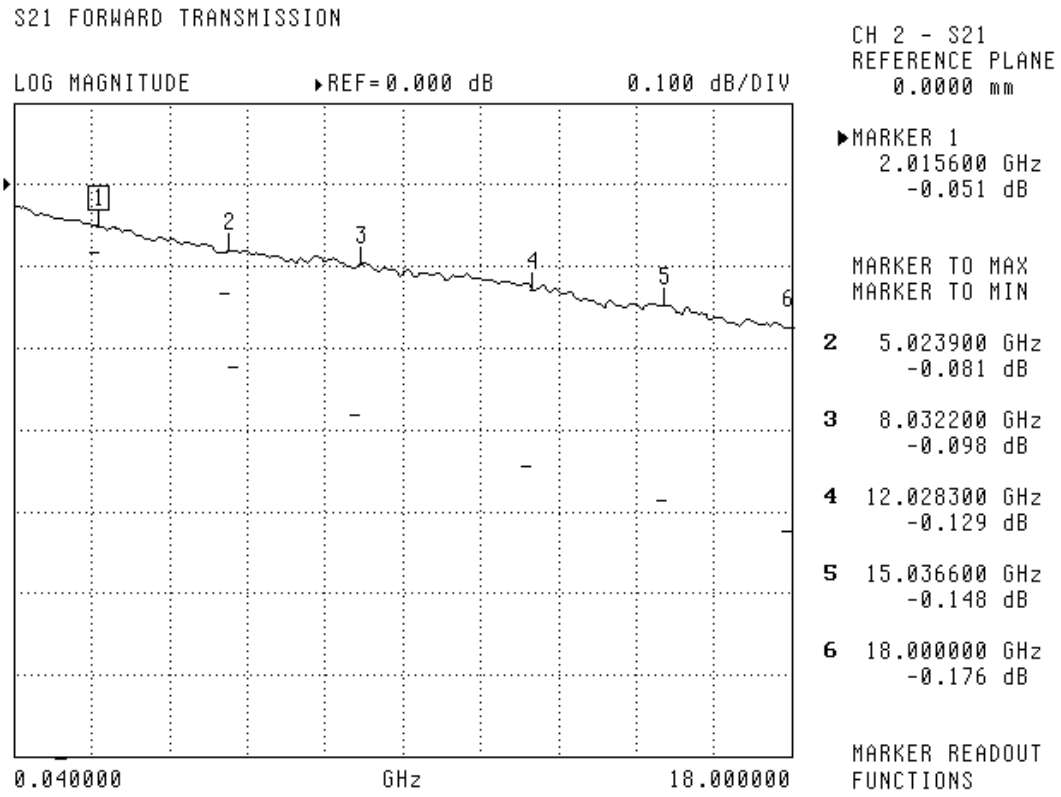
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 33/34

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

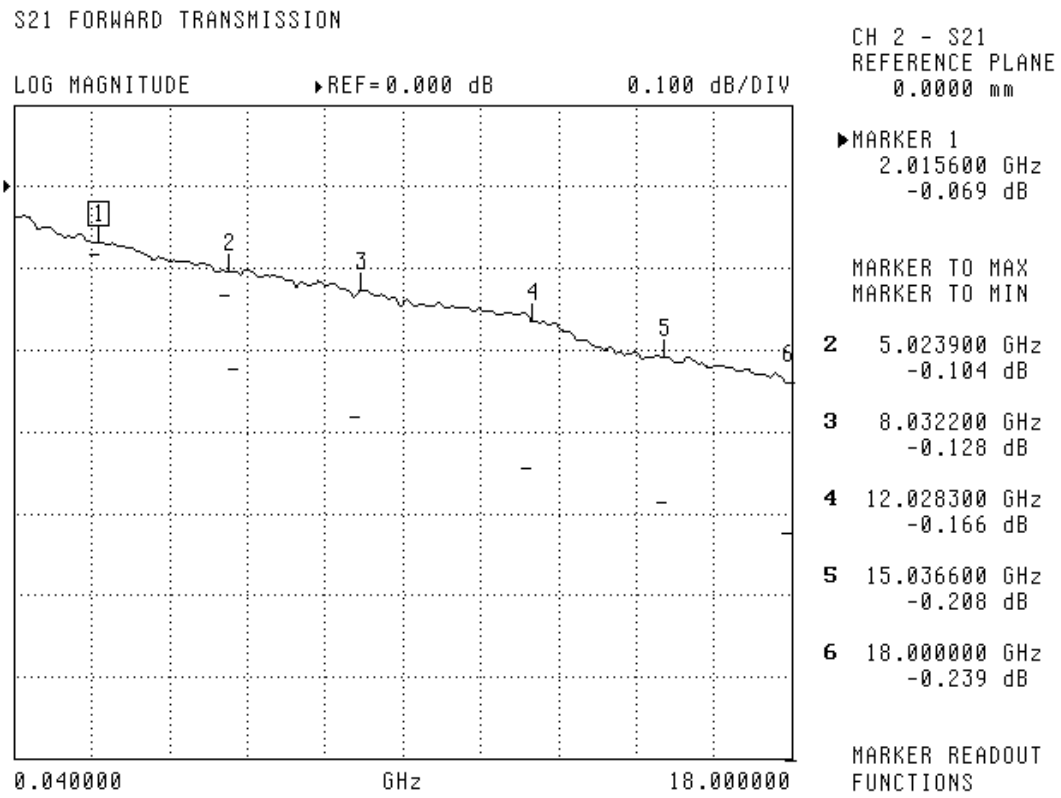
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 35/95

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

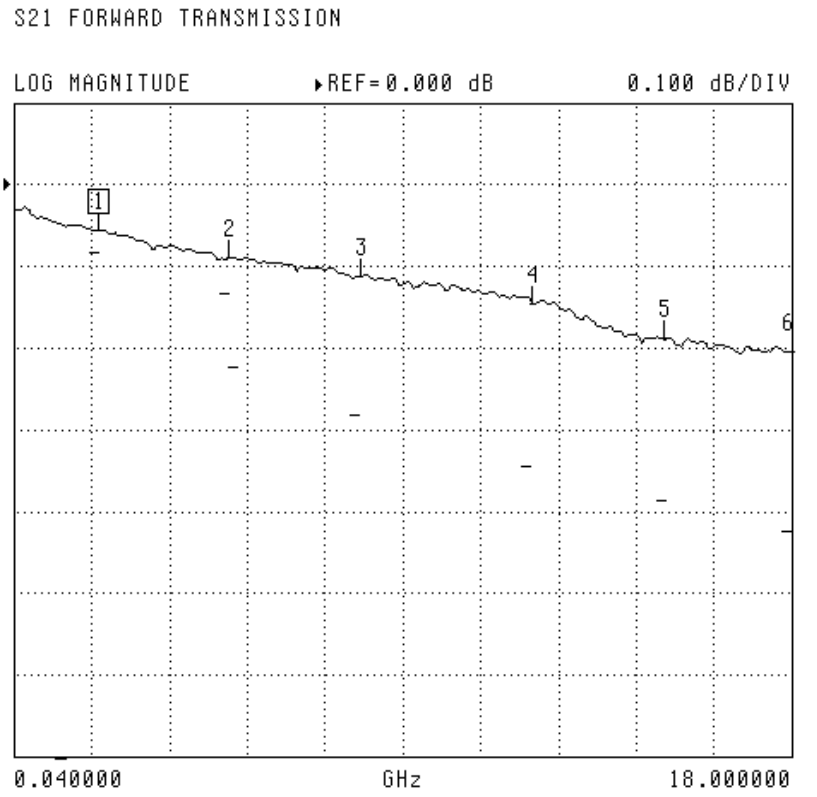
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.056 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.090 dB

3 8.032200 GHz
-0.112 dB

4 12.028300 GHz
-0.146 dB

5 15.036600 GHz
-0.188 dB

6 18.000000 GHz
-0.205 dB

MARKER READOUT
FUNCTIONS

Couple 96/97

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

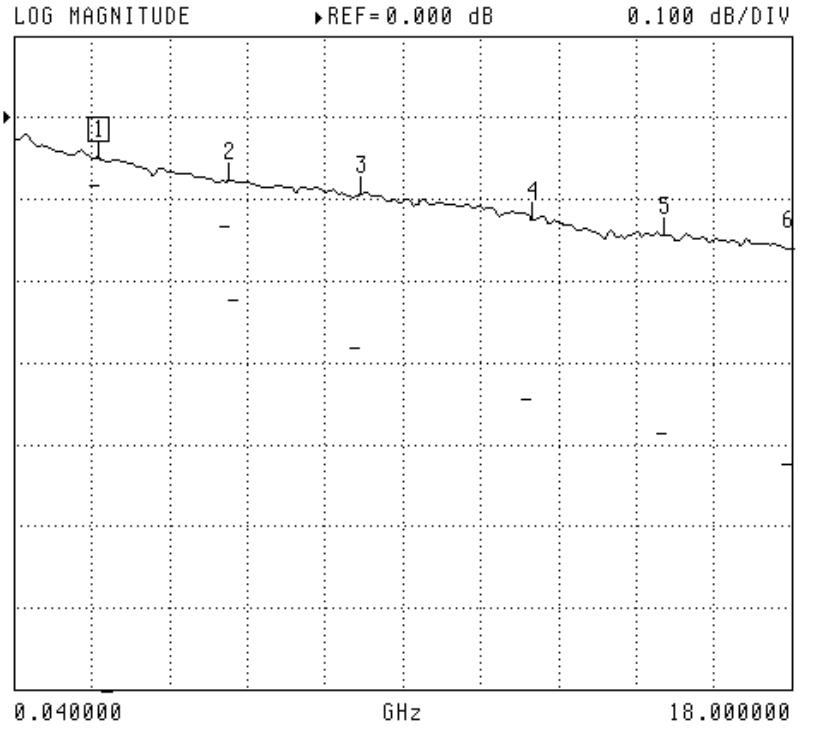
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.050 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.078 dB

3 8.032200 GHz
-0.095 dB

4 12.028300 GHz
-0.125 dB

5 15.036600 GHz
-0.144 dB

6 18.000000 GHz
-0.160 dB

MARKER READOUT
FUNCTIONS

Couple 98/99

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

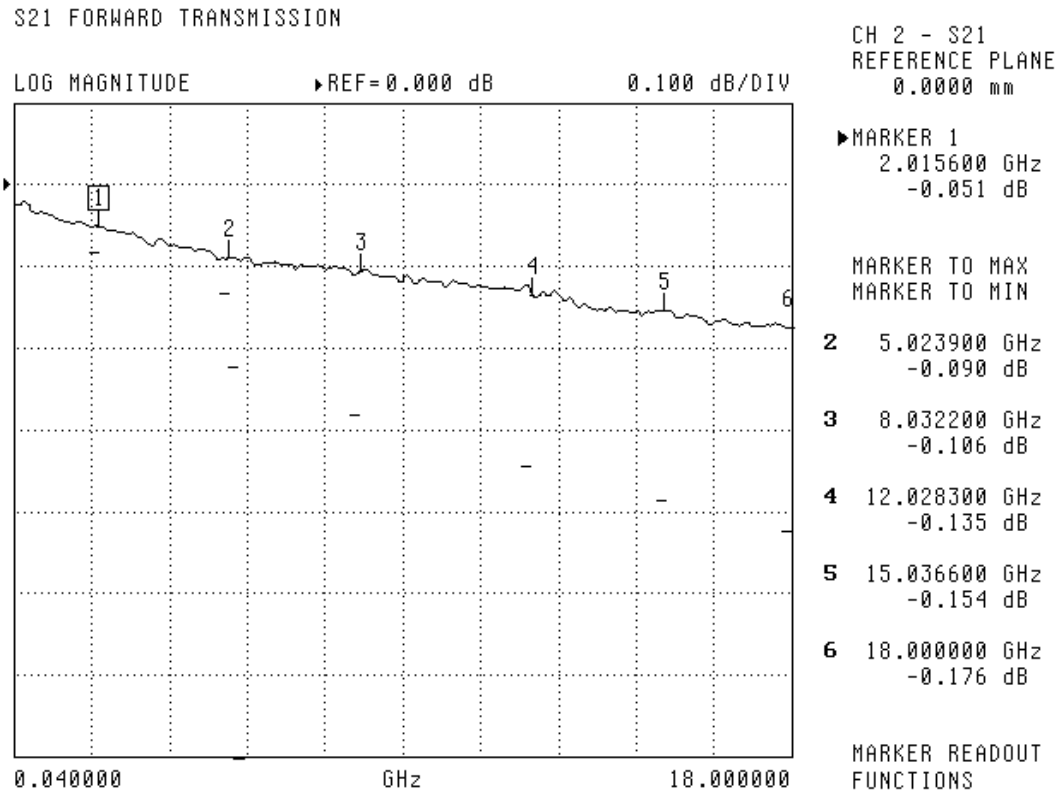
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 100/101

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

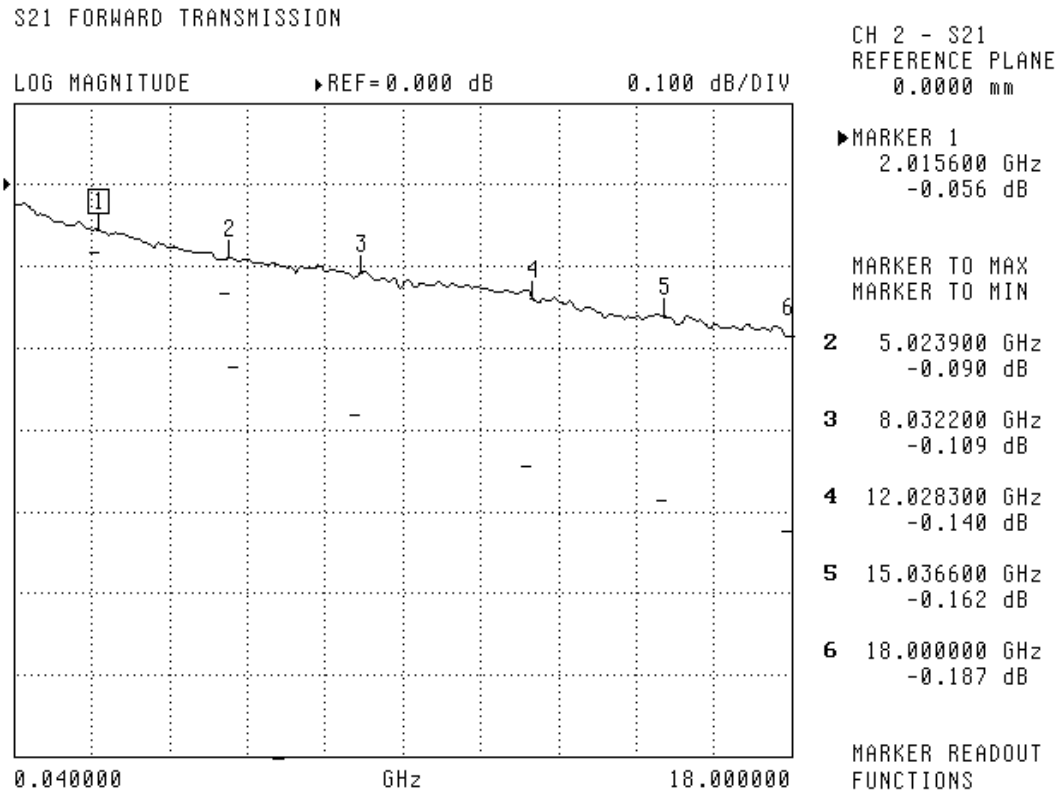
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 102/103

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

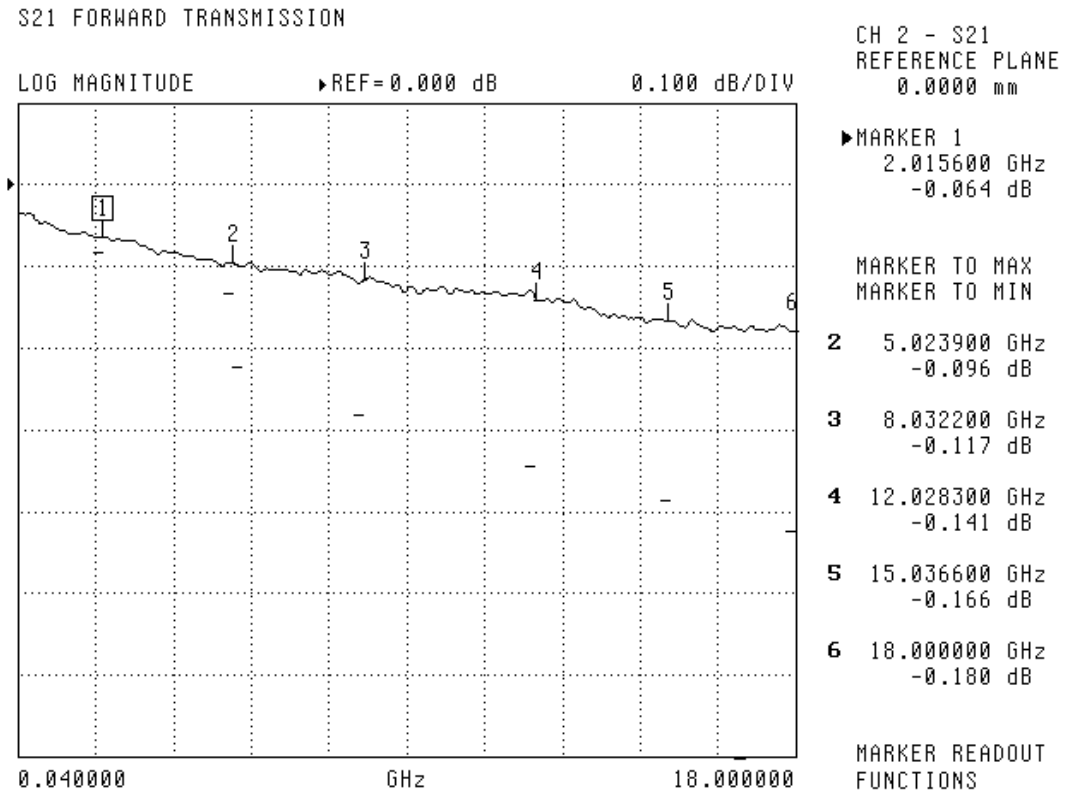
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 104/105

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

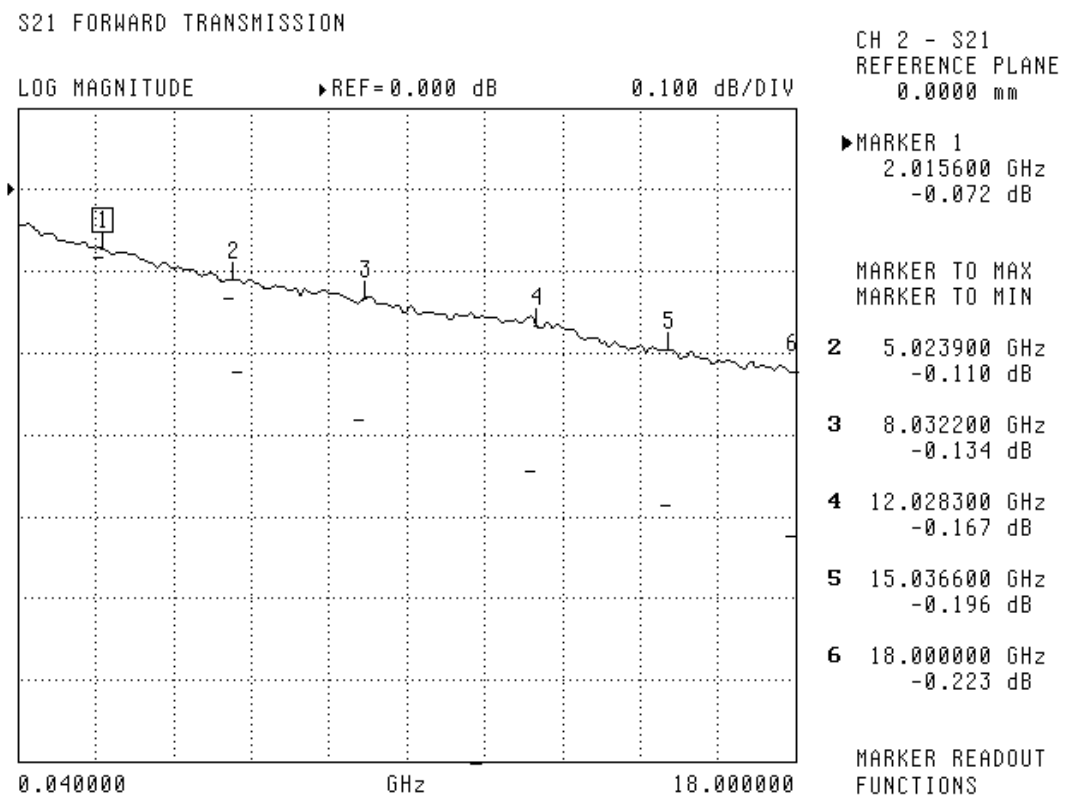
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 106/107

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

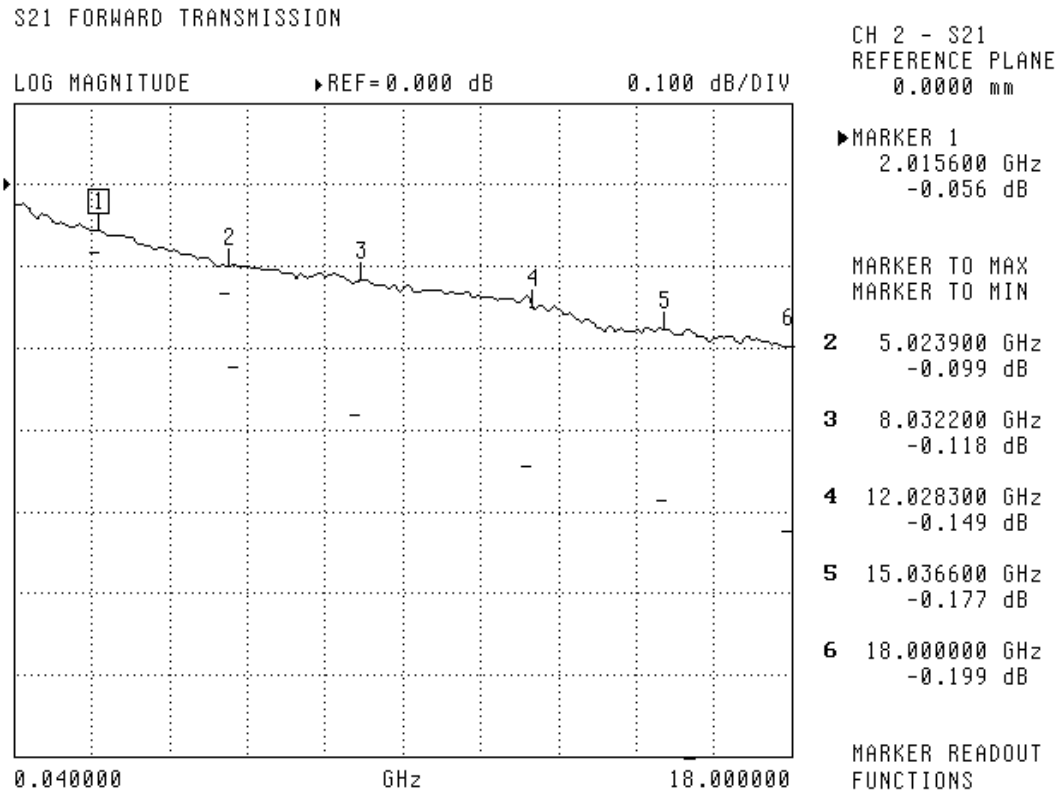
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 108/109

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

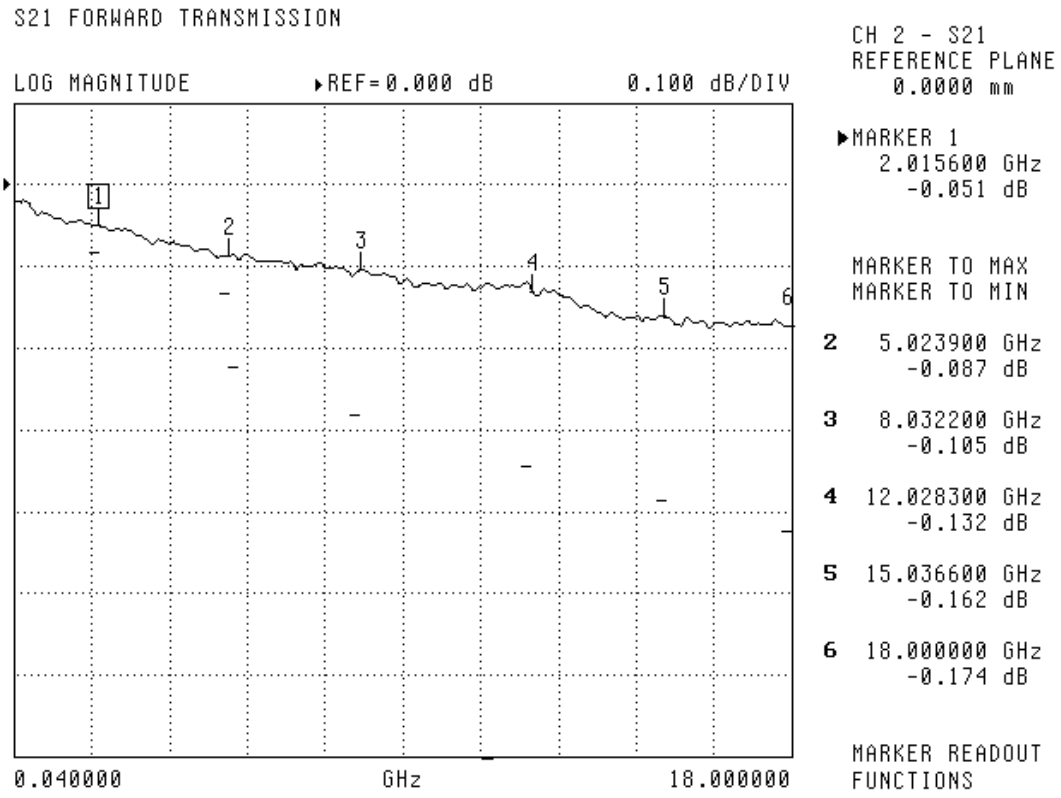
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 110/111

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

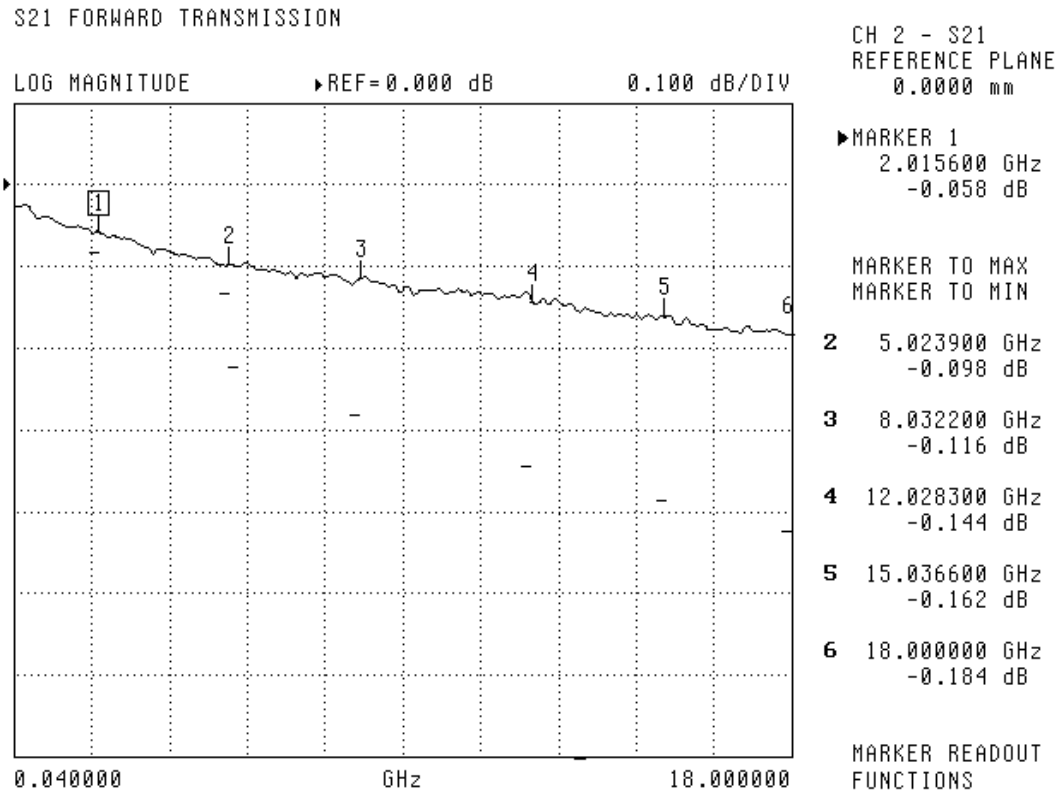
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 112/113

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

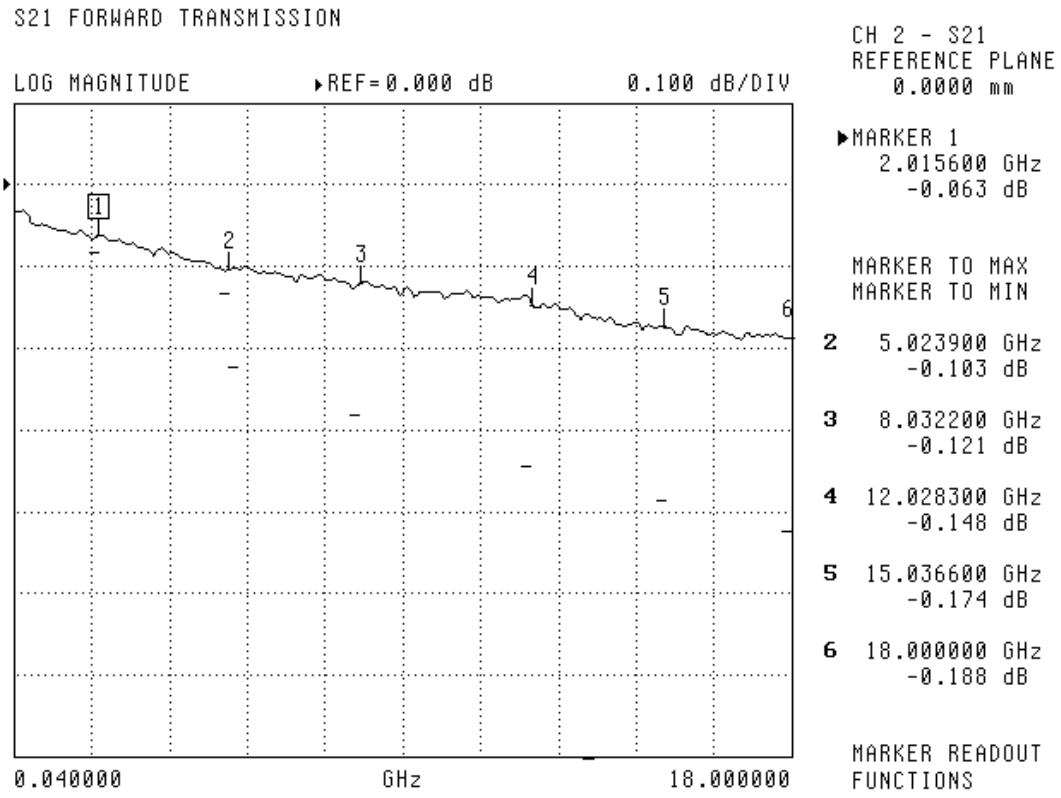
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 114/115

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

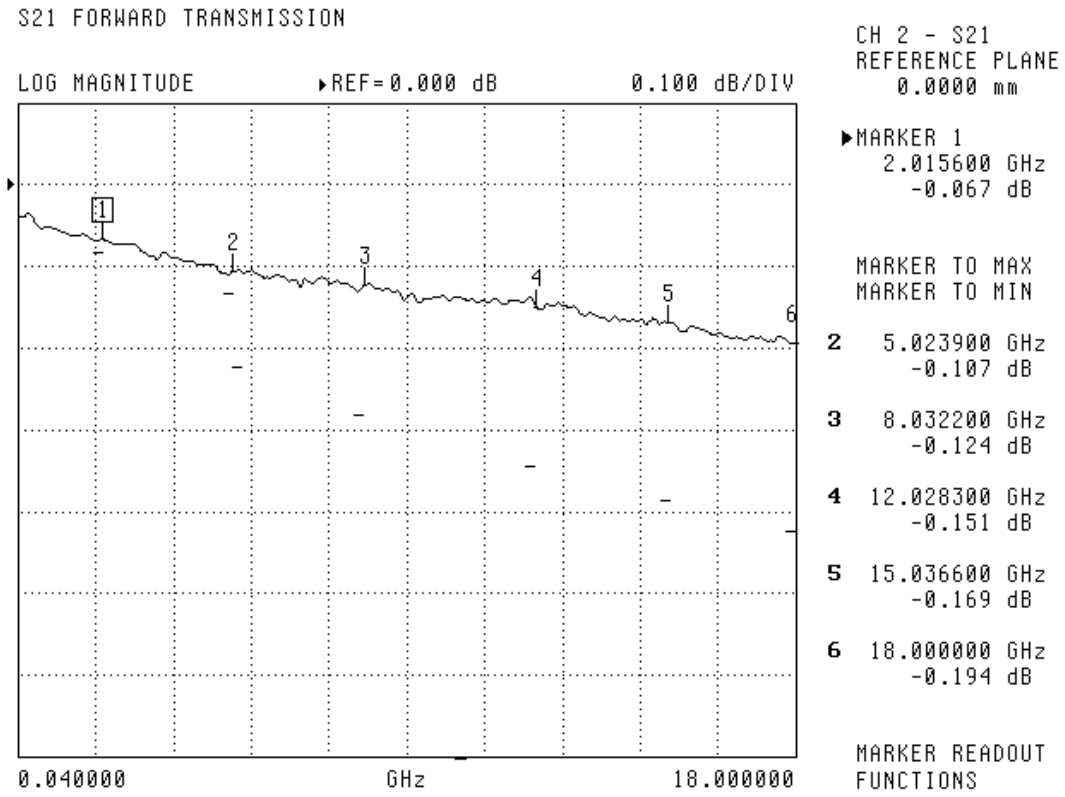
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 116/117

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

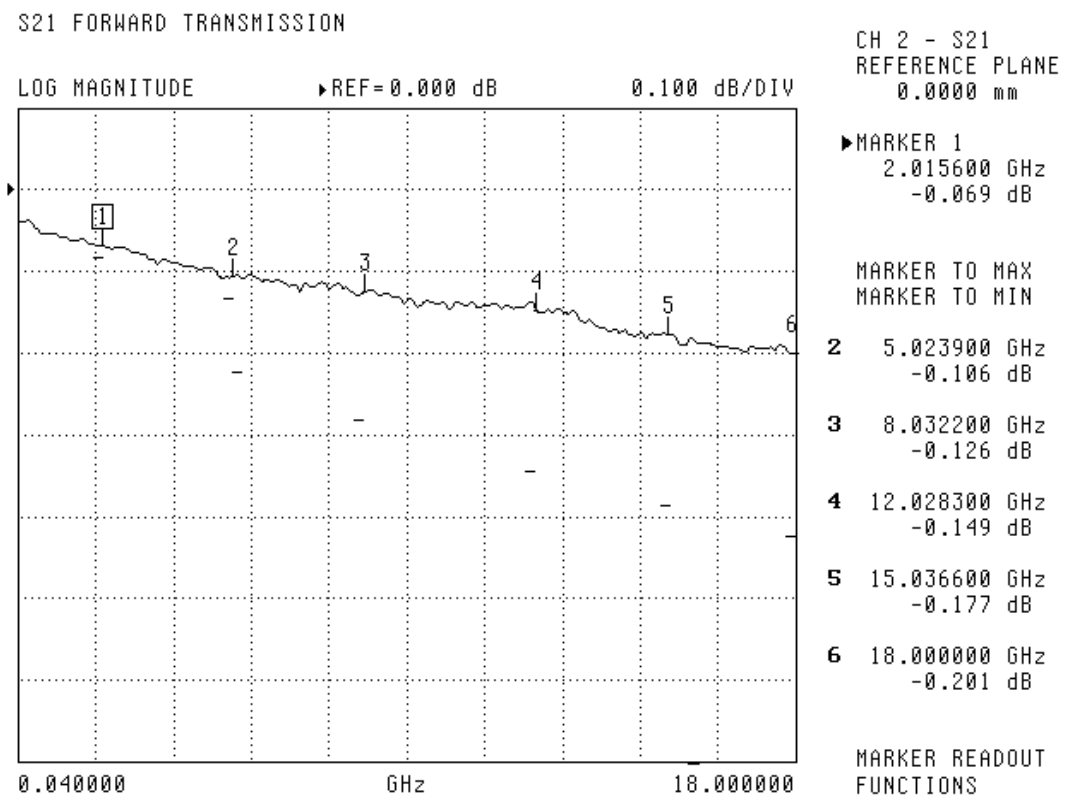
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Initial measurement 24/01/2006



Couple 118/119

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

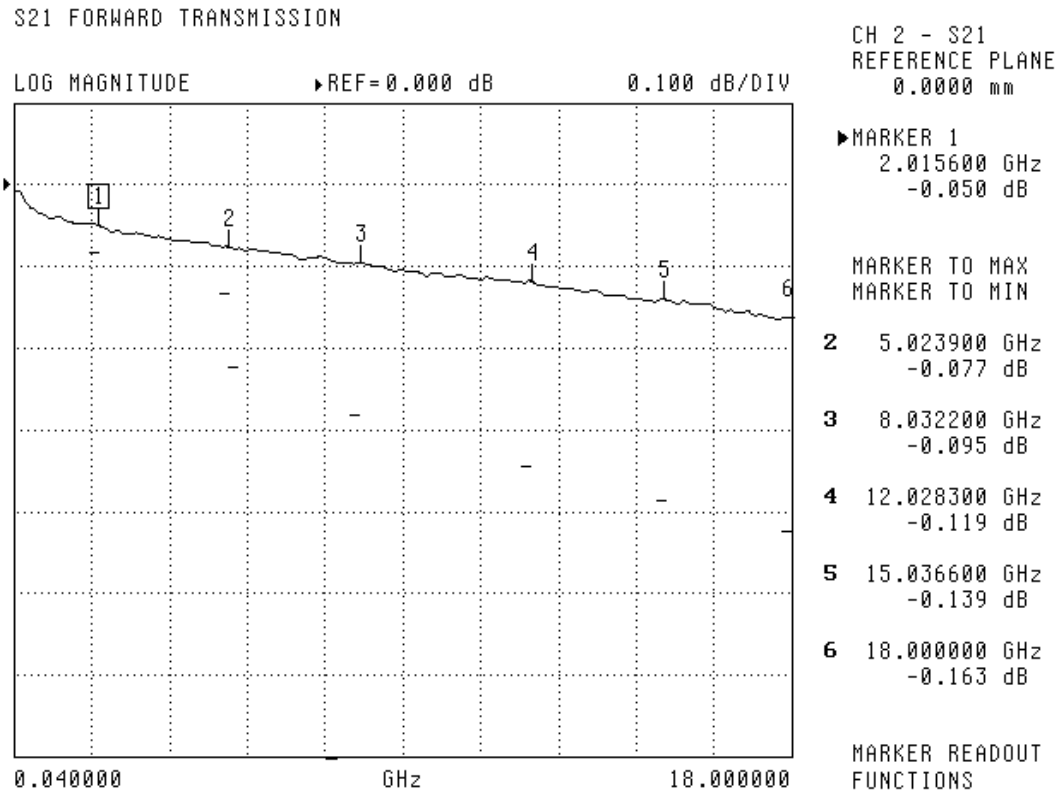
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 1/2

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

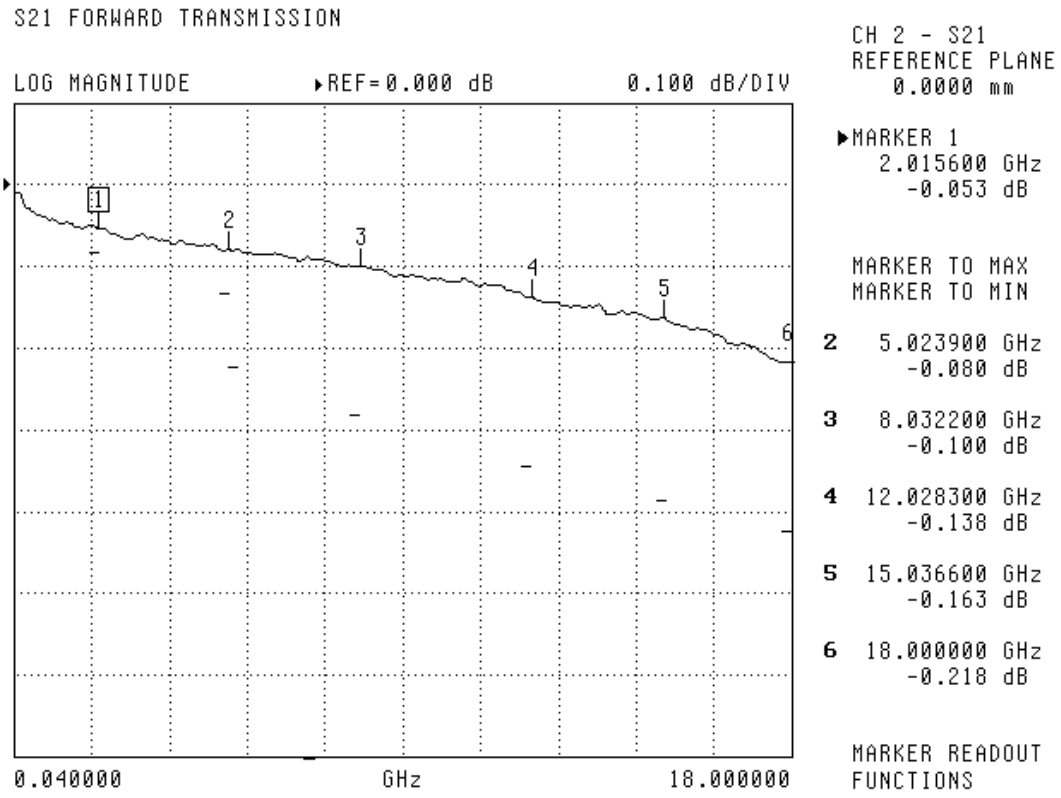
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 3/4

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

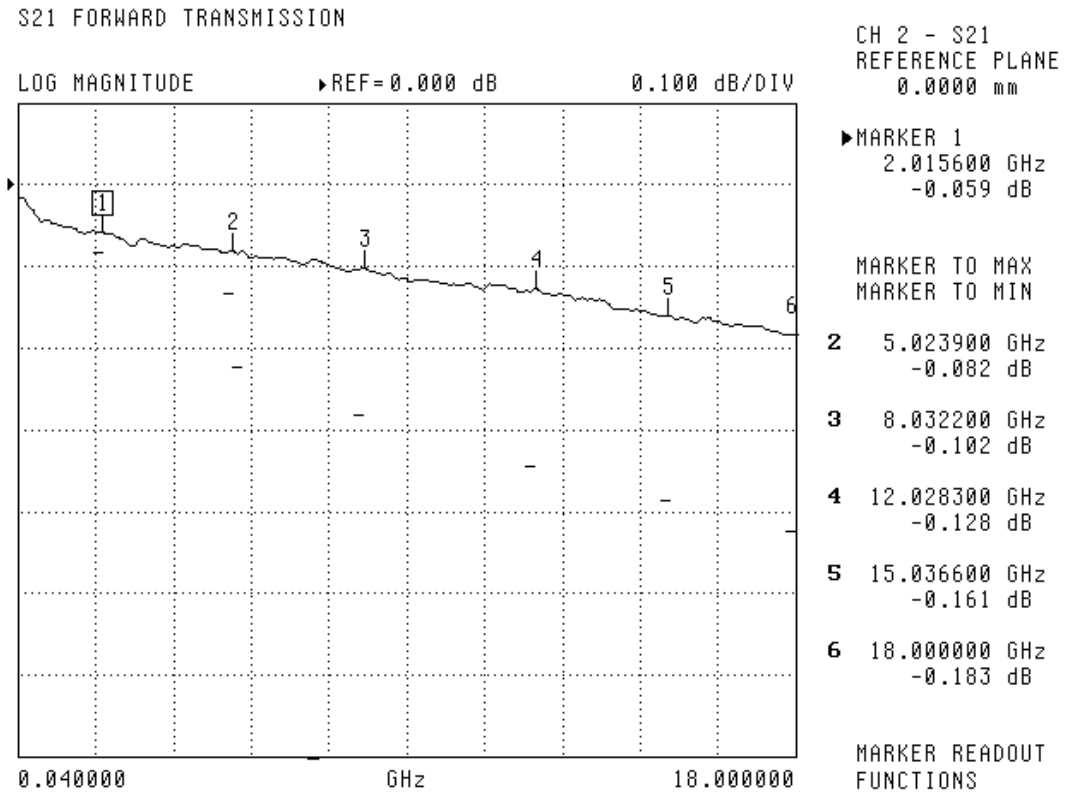
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 5/6

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

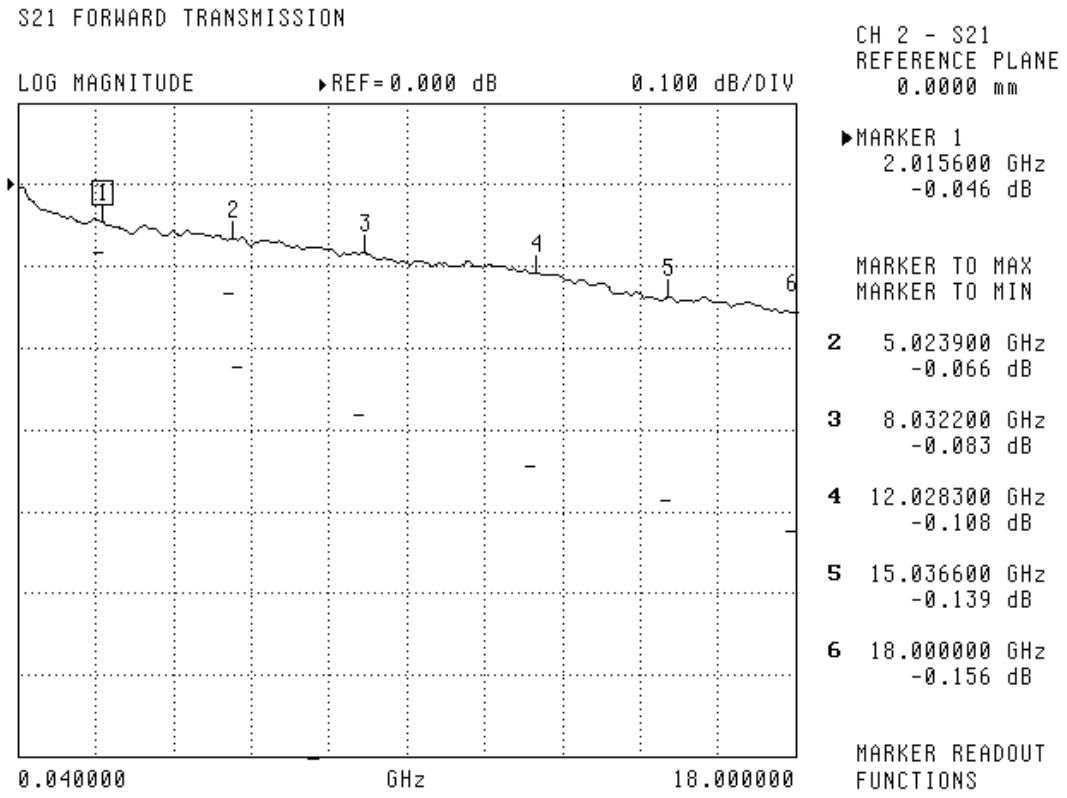
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 7/8

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

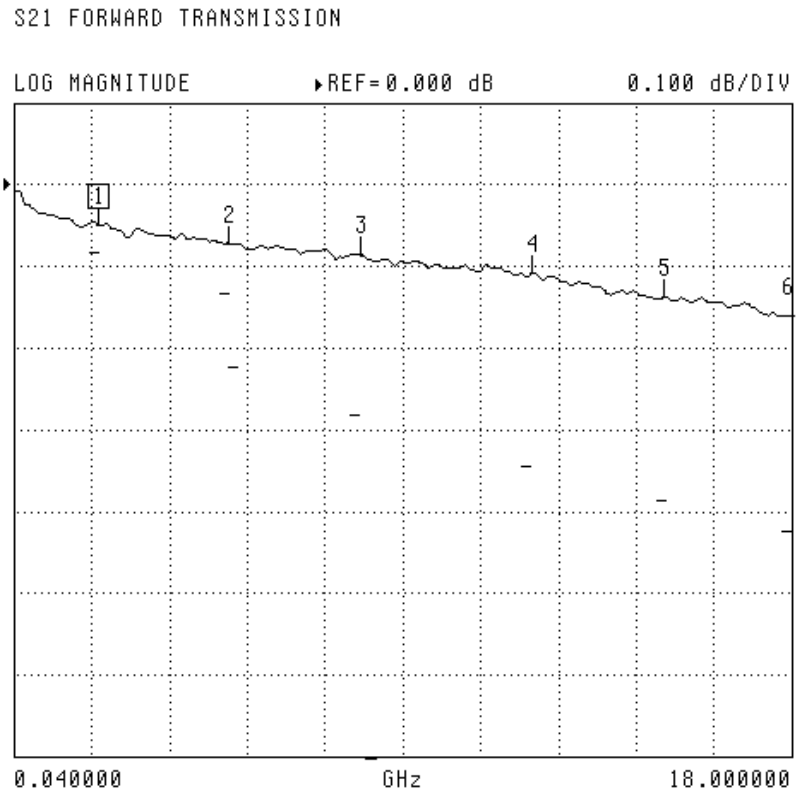
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.049 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.072 dB

3 8.032200 GHz
-0.086 dB

4 12.028300 GHz
-0.108 dB

5 15.036600 GHz
-0.138 dB

6 18.000000 GHz
-0.161 dB

MARKER READOUT
FUNCTIONS

Couple 9/10

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

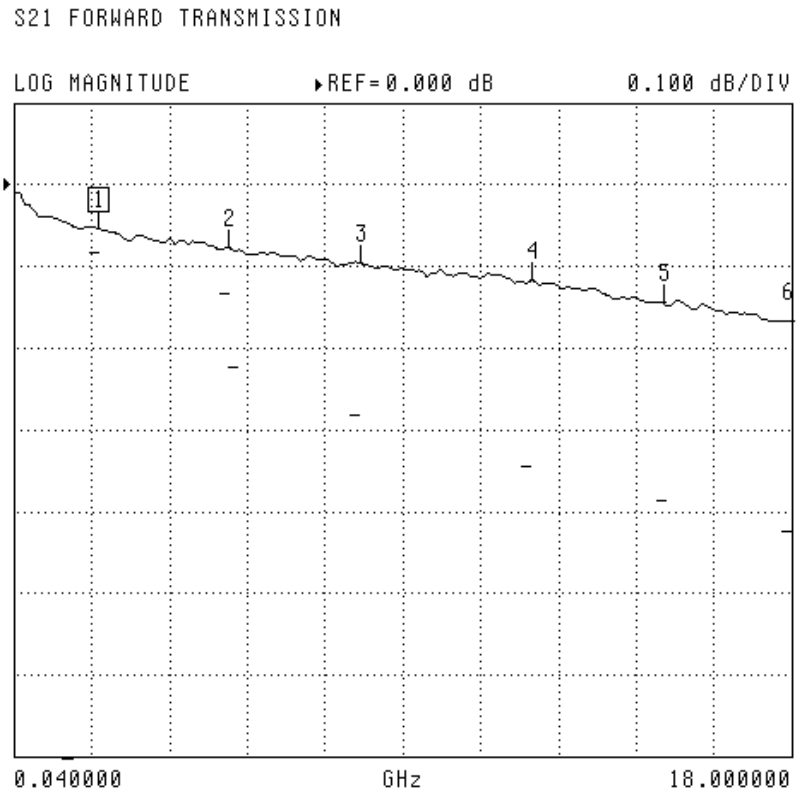
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.054 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.077 dB

3 8.032200 GHz
-0.096 dB

4 12.028300 GHz
-0.118 dB

5 15.036600 GHz
-0.145 dB

6 18.000000 GHz
-0.167 dB

MARKER READOUT
FUNCTIONS

Couple 11/12

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

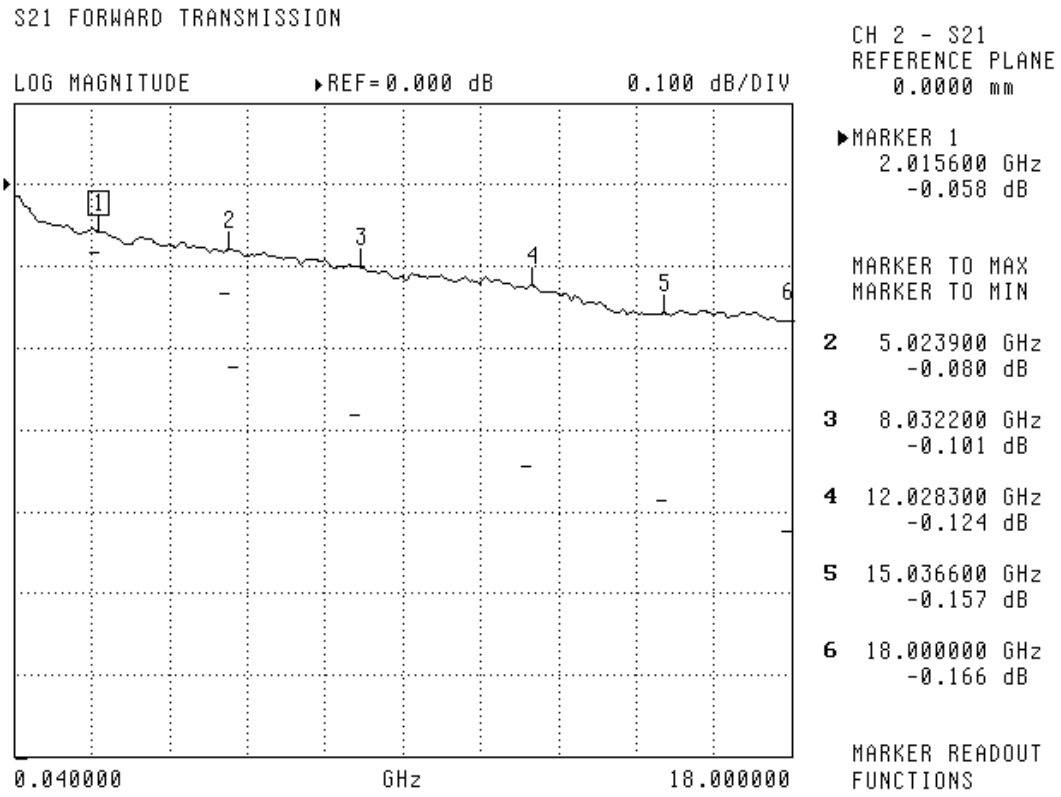
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 13/14

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

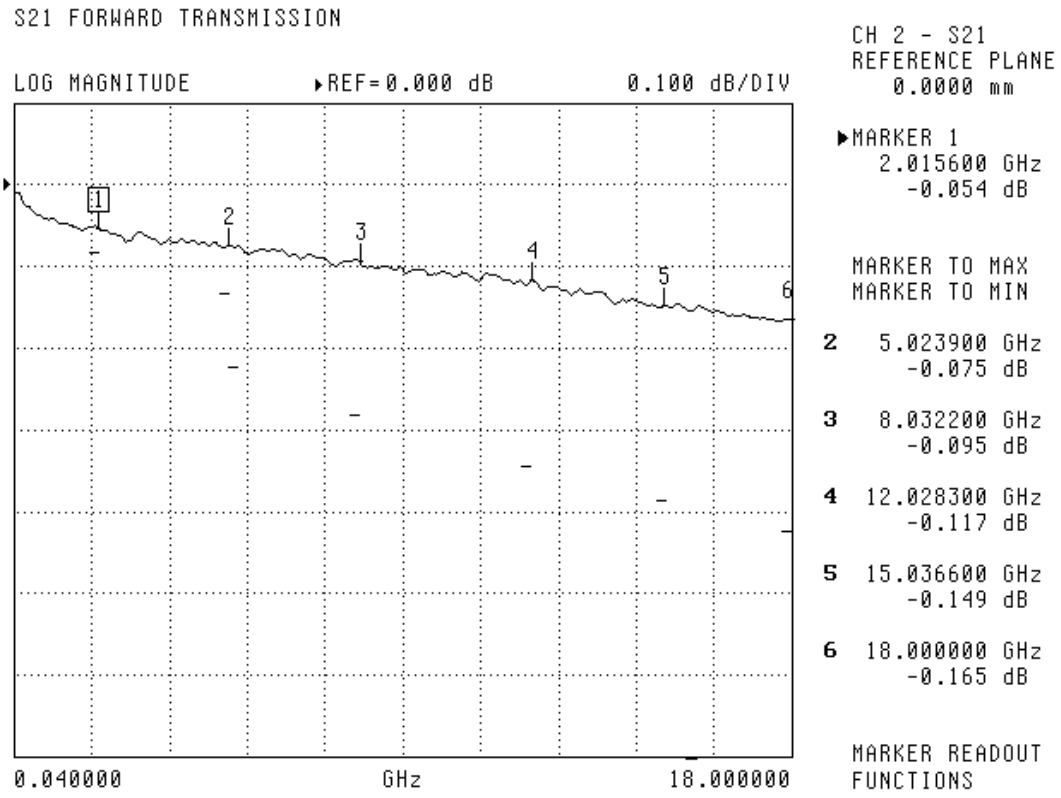
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 15/16

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

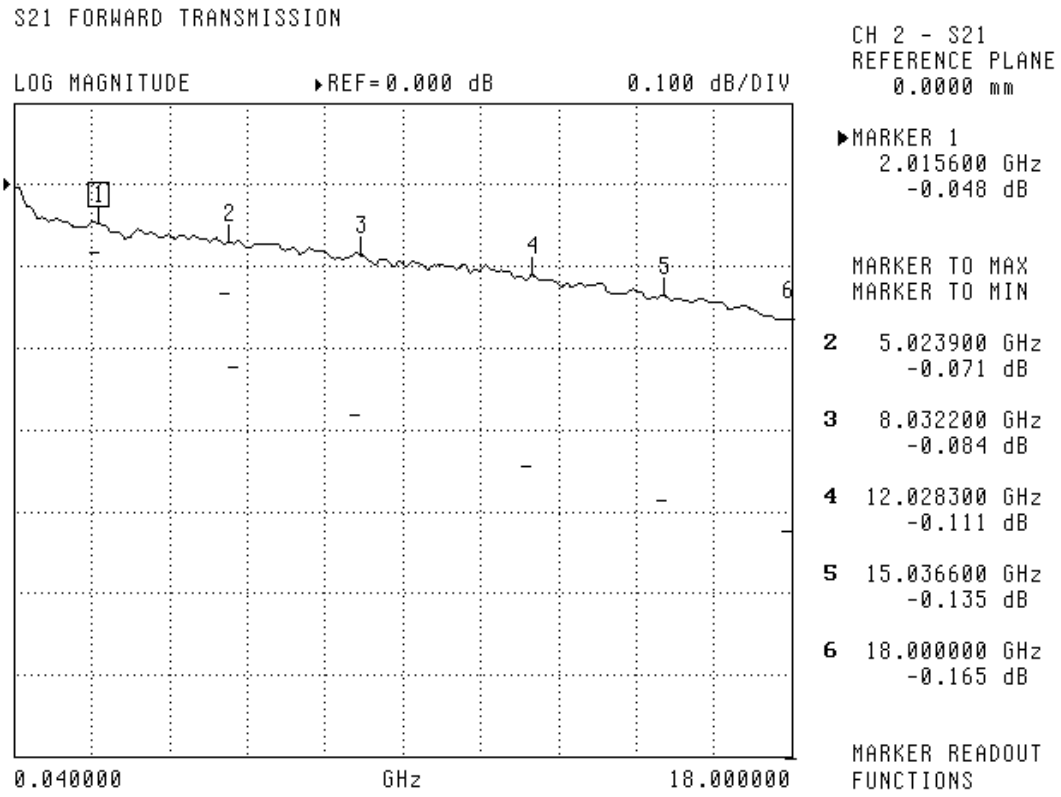
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 17/18

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

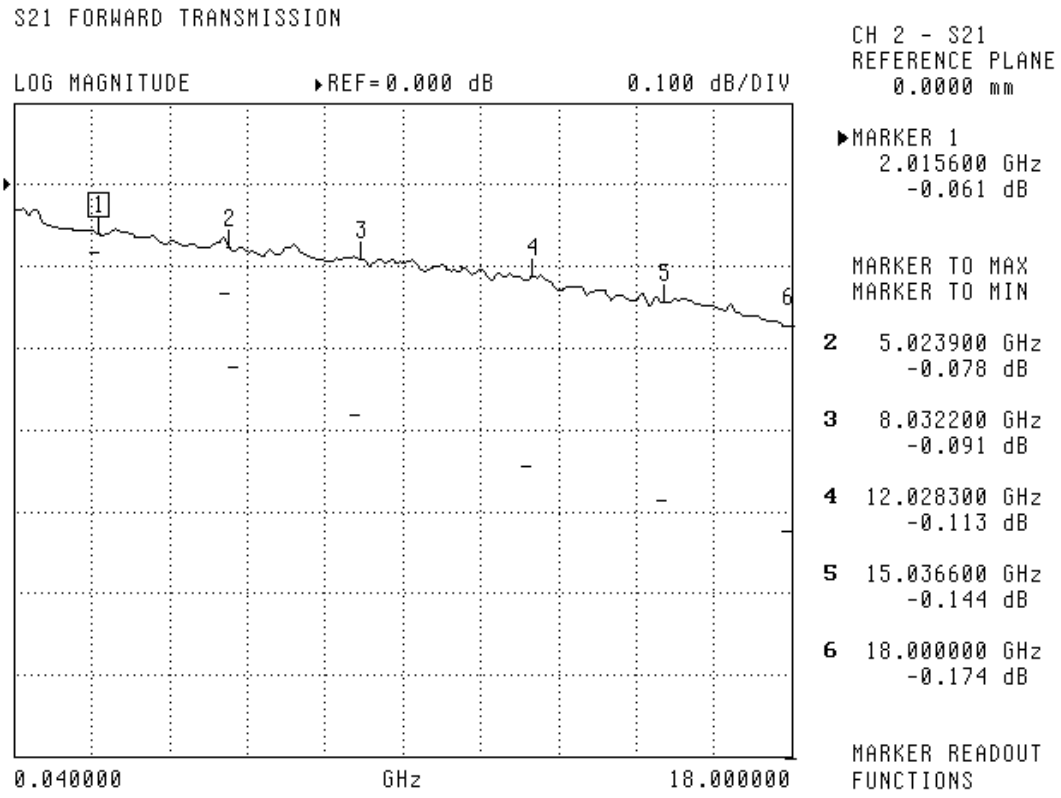
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 19/20

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

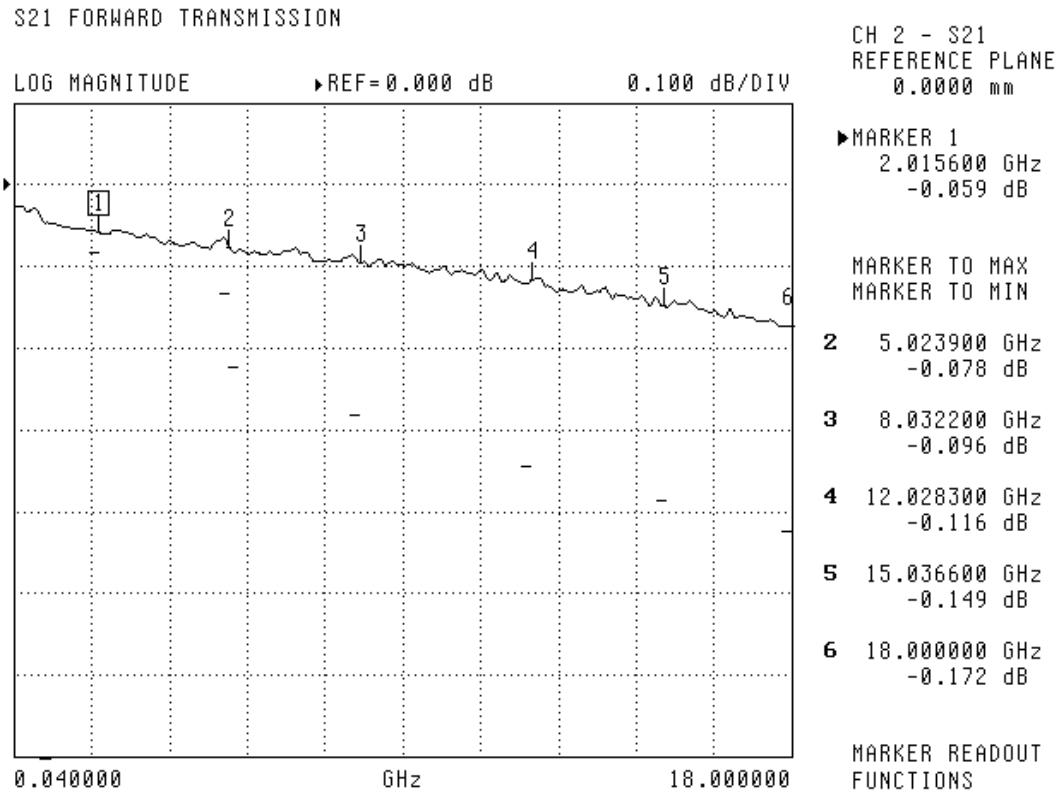
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 21/22

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

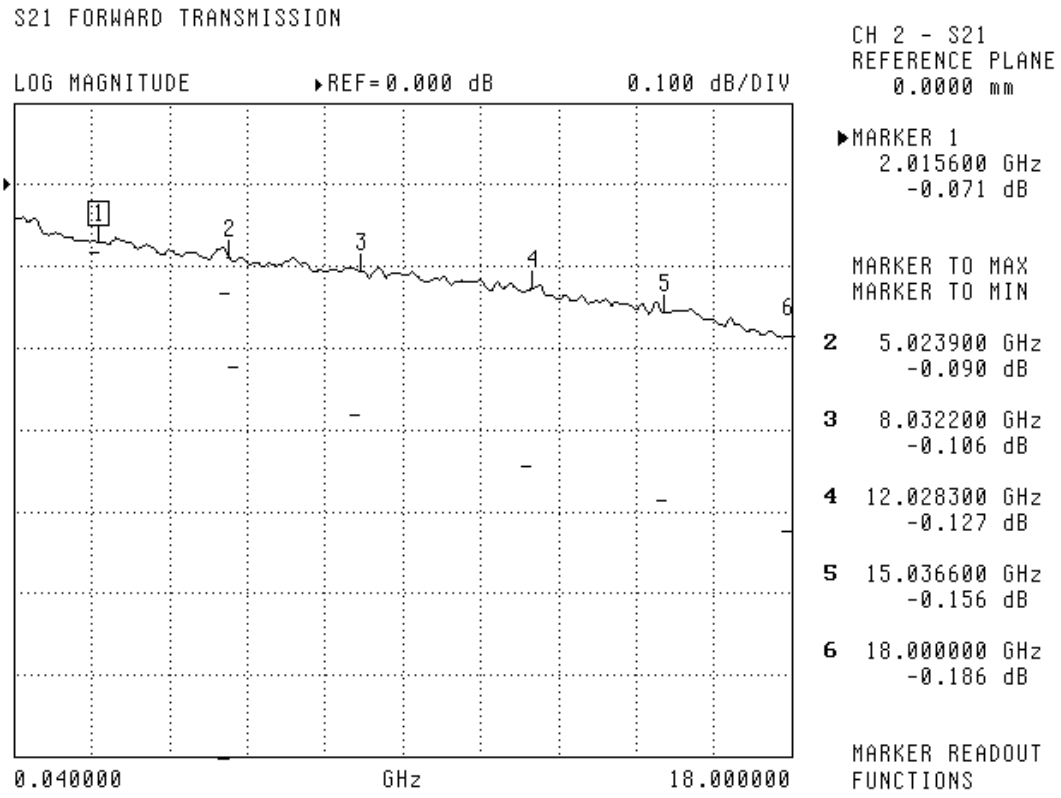
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 23/24

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

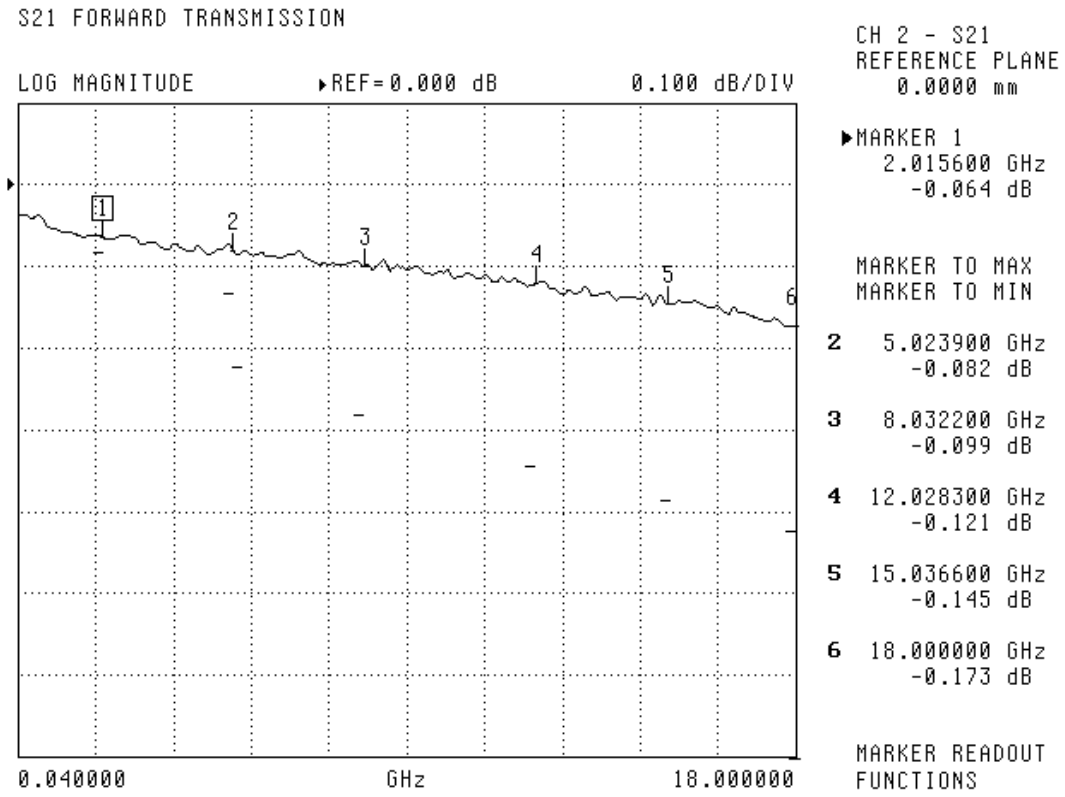
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 25/26

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

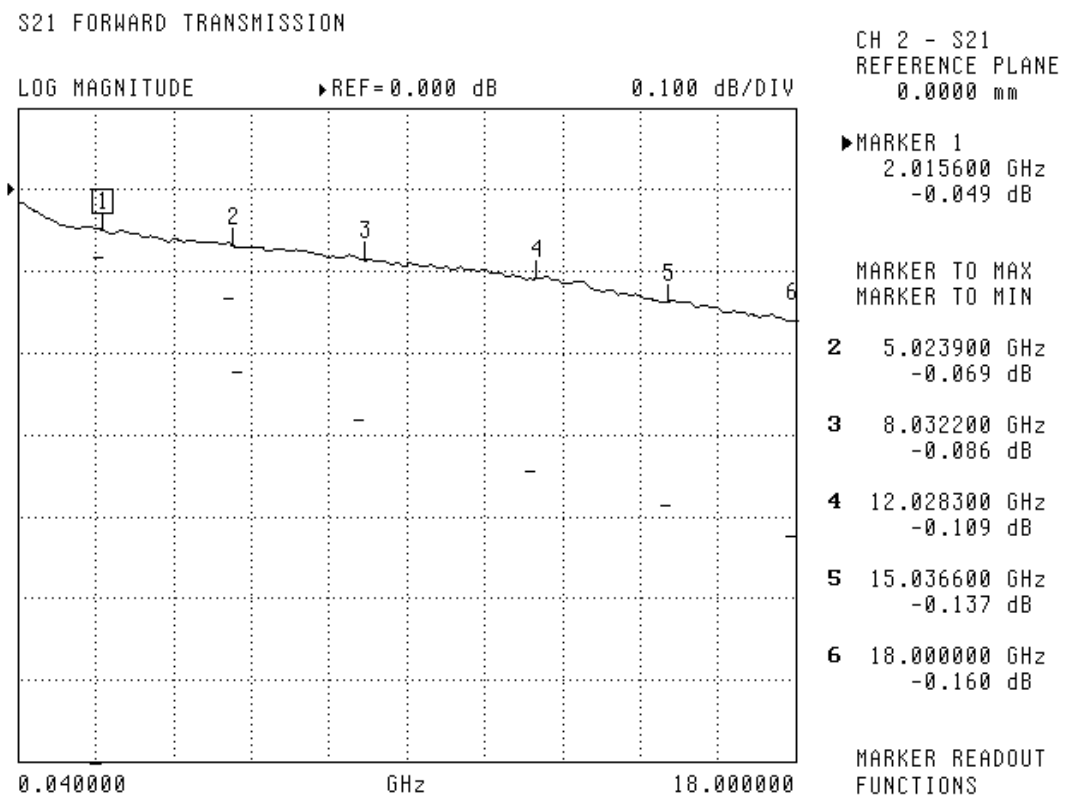
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 27/28

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

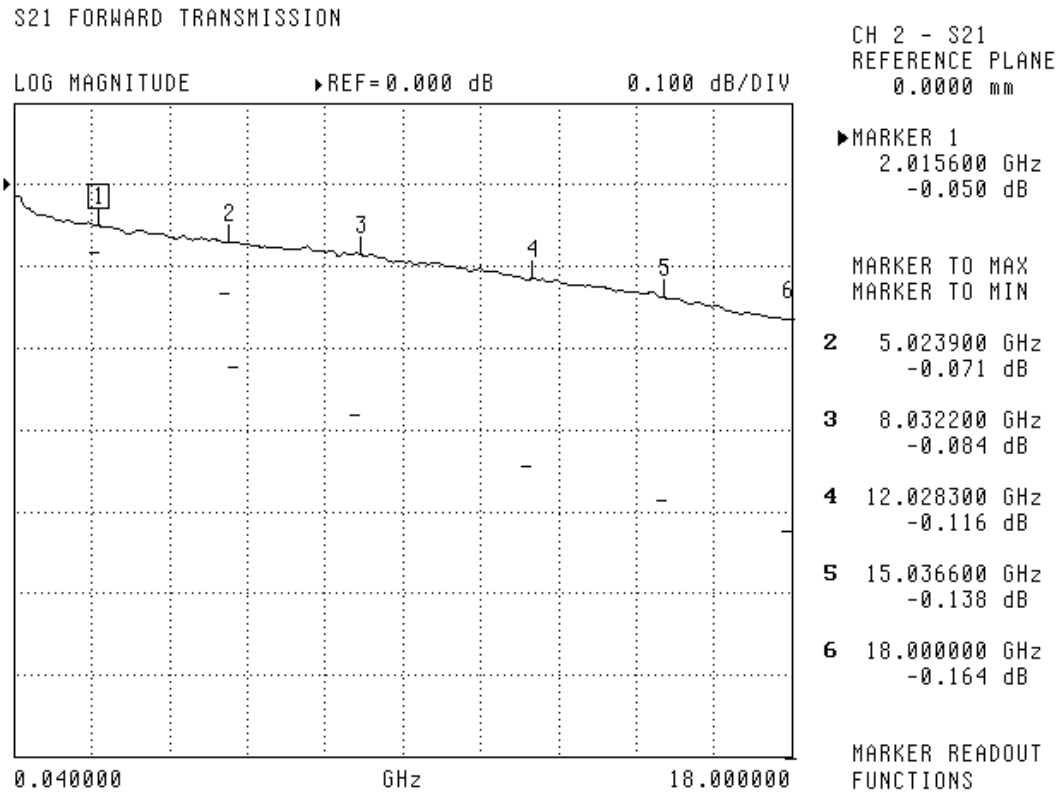
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 29/30

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

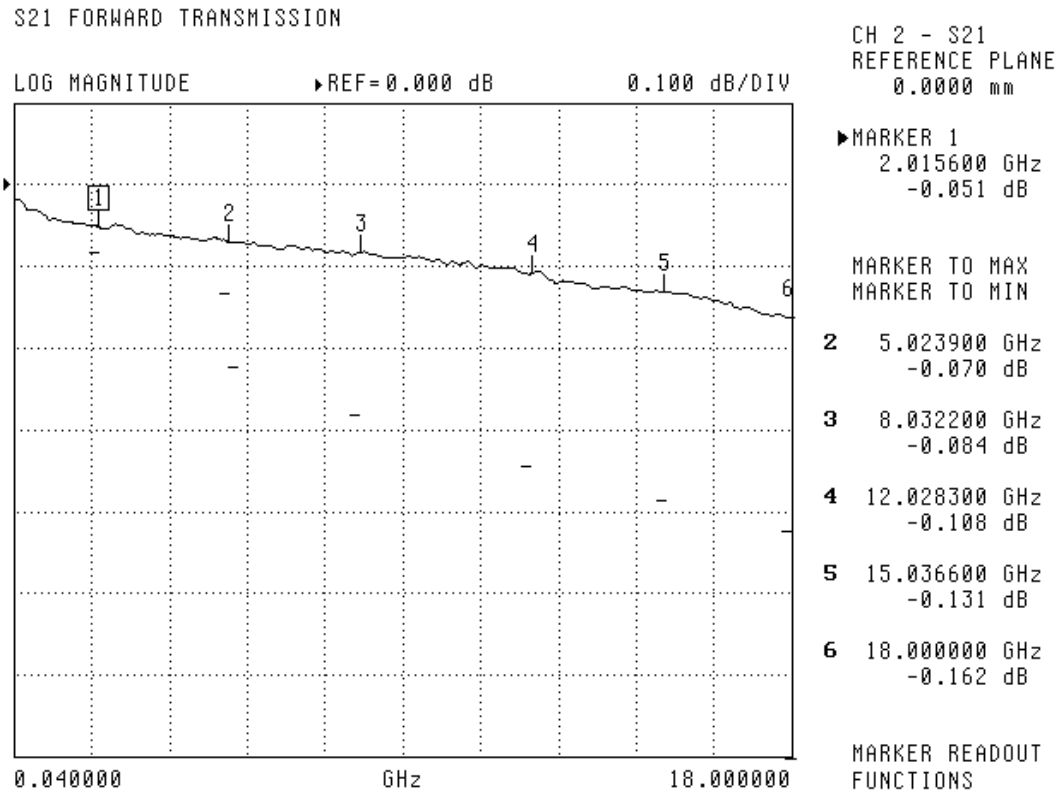
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 31/32

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

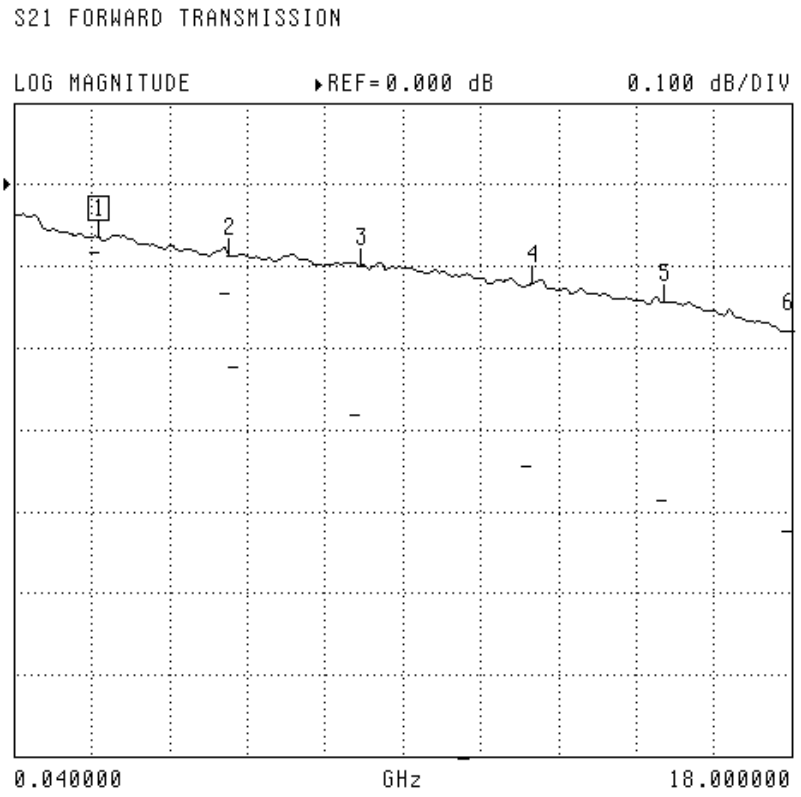
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.065 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.087 dB

3 8.032200 GHz
-0.100 dB

4 12.028300 GHz
-0.120 dB

5 15.036600 GHz
-0.145 dB

6 18.000000 GHz
-0.179 dB

MARKER READOUT
FUNCTIONS

Couple 33/34

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

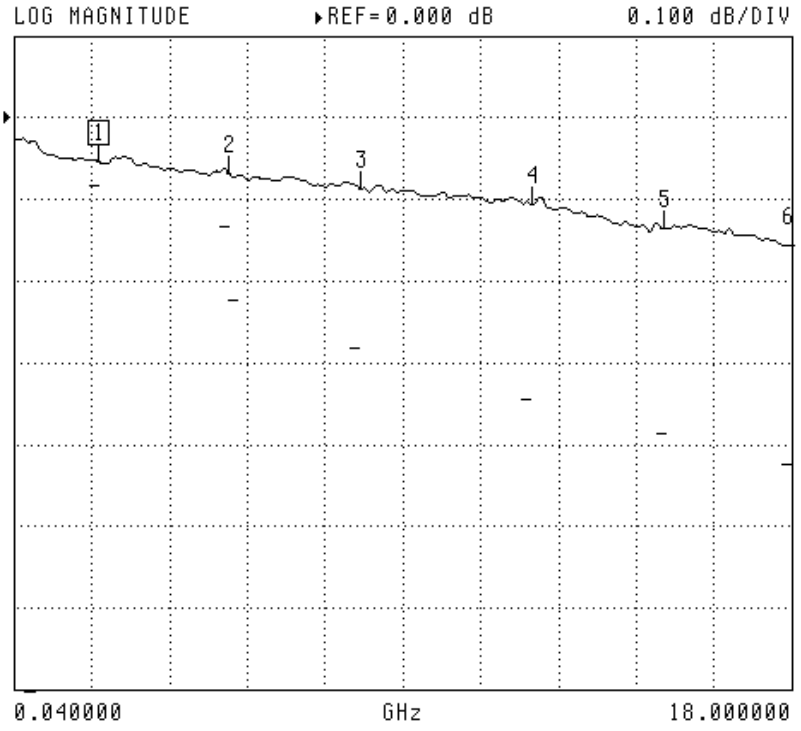
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.054 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.070 dB

3 8.032200 GHz
-0.087 dB

4 12.028300 GHz
-0.105 dB

5 15.036600 GHz
-0.136 dB

6 18.000000 GHz
-0.156 dB

MARKER READOUT
FUNCTIONS

Couple 35/95

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

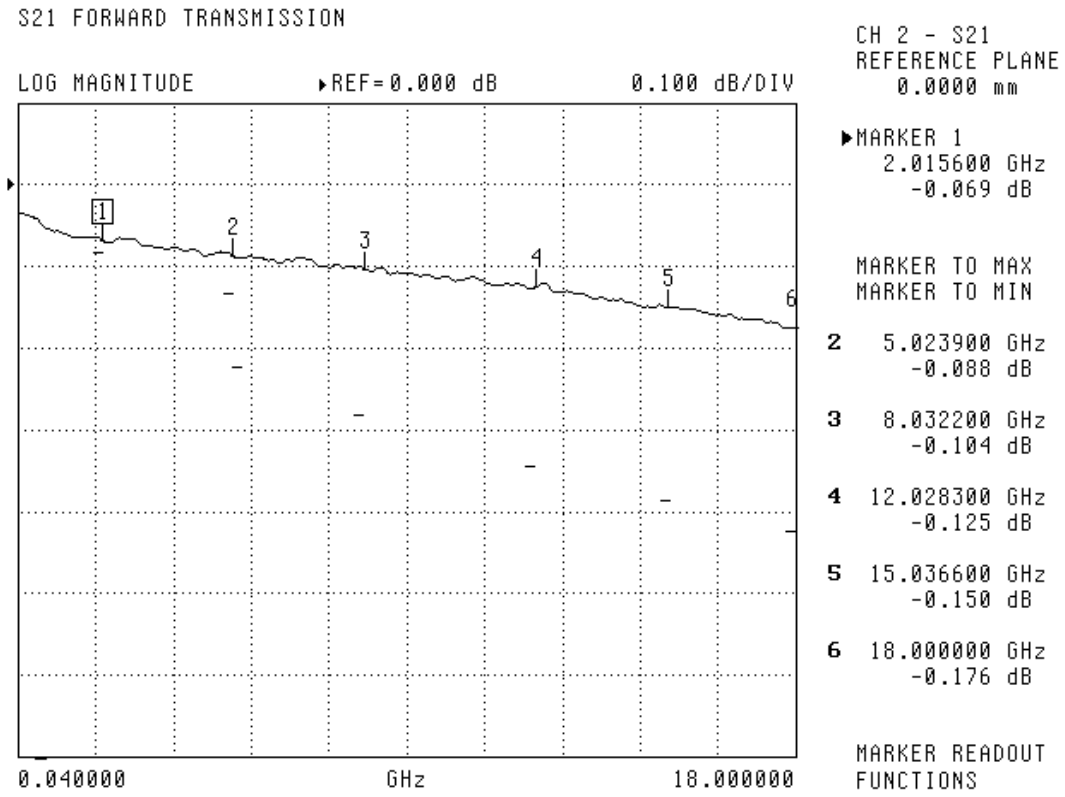
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 96/97

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

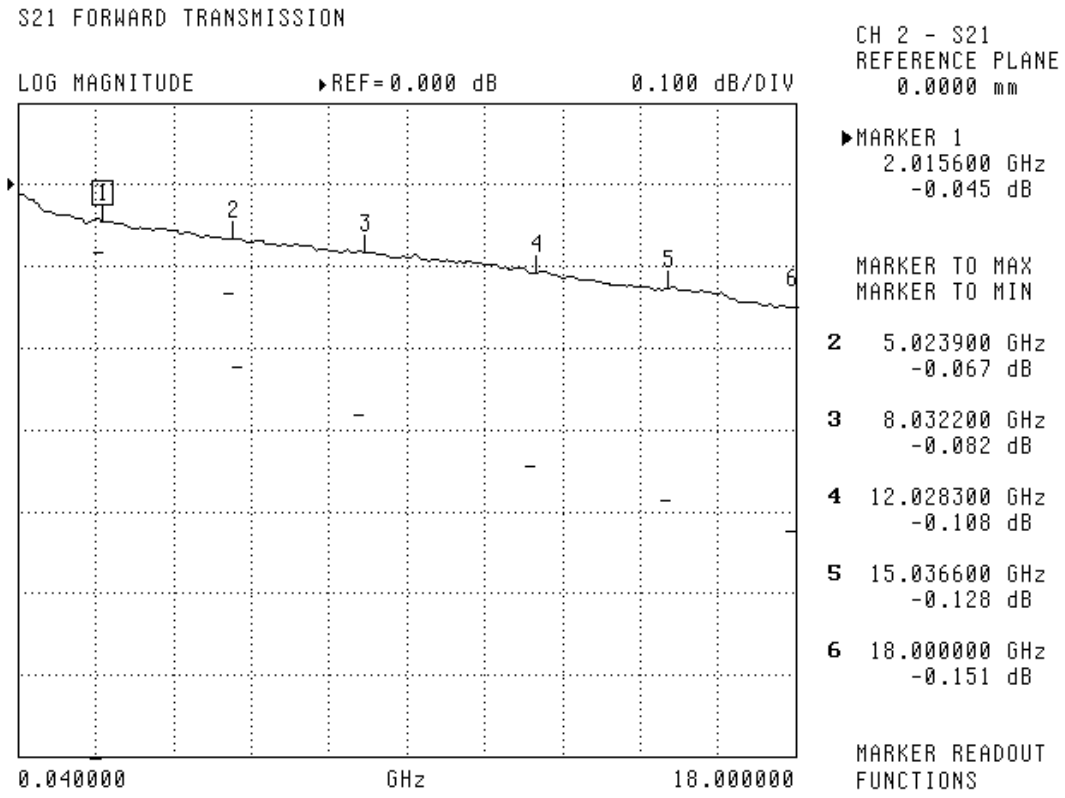
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 98/99

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

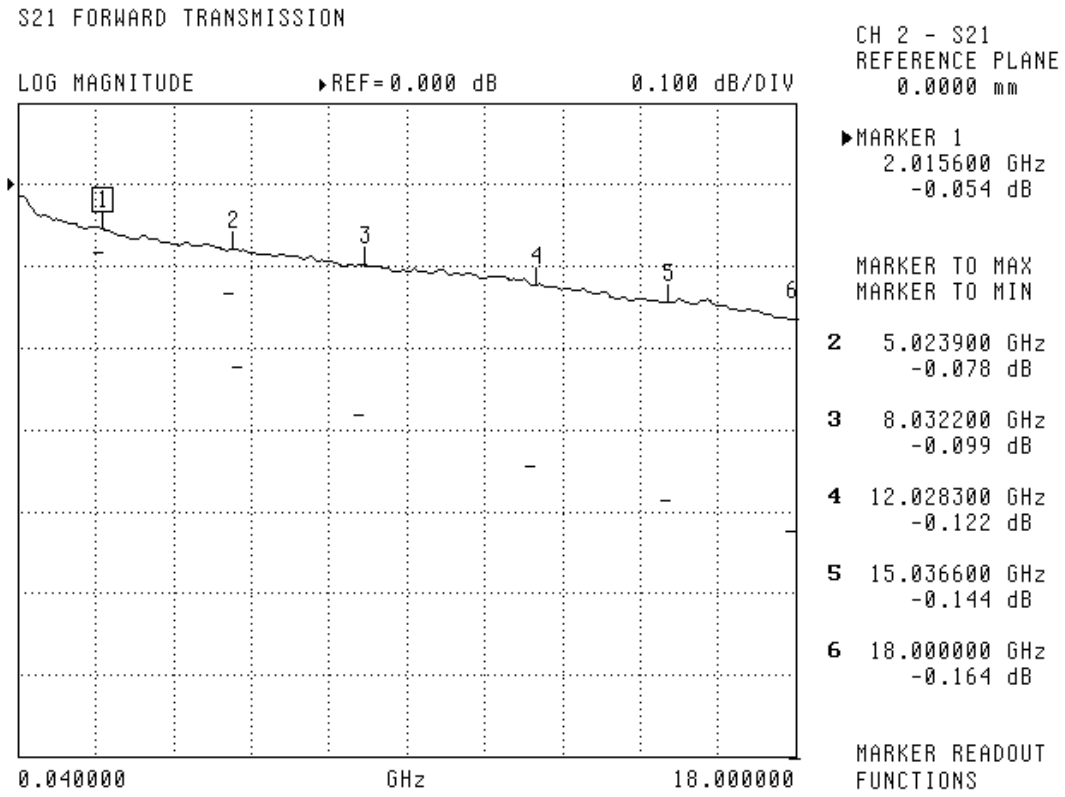
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 100/101

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

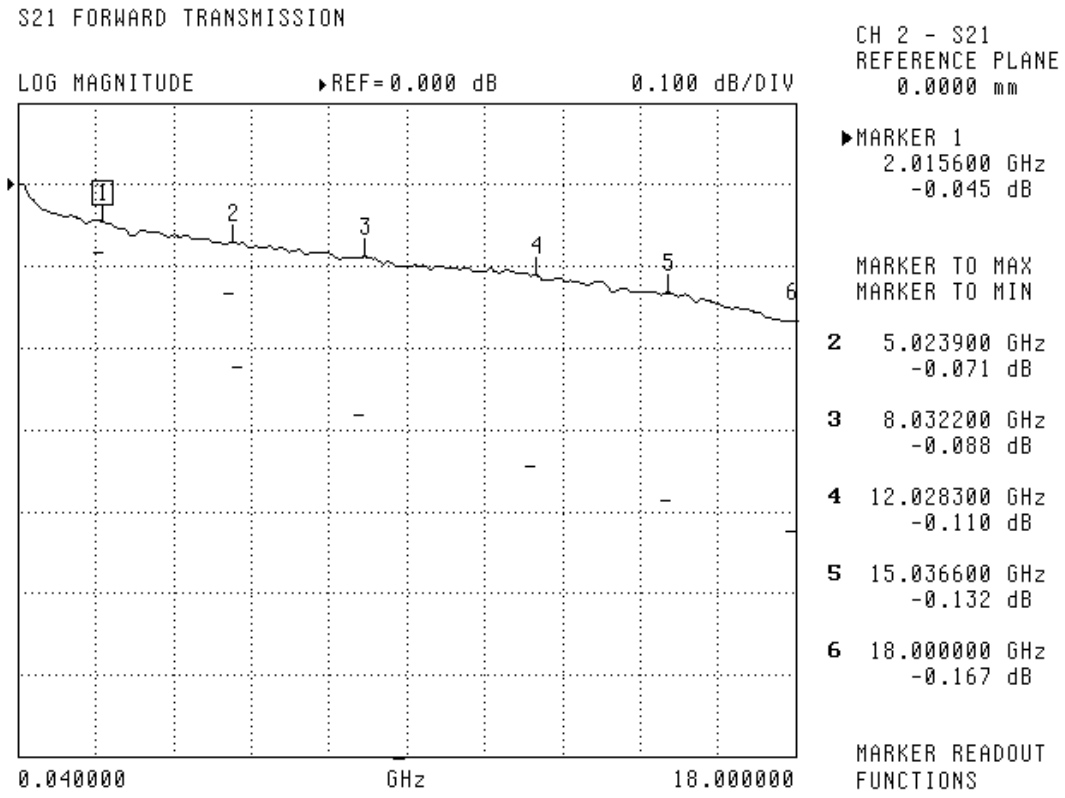
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 102/103

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

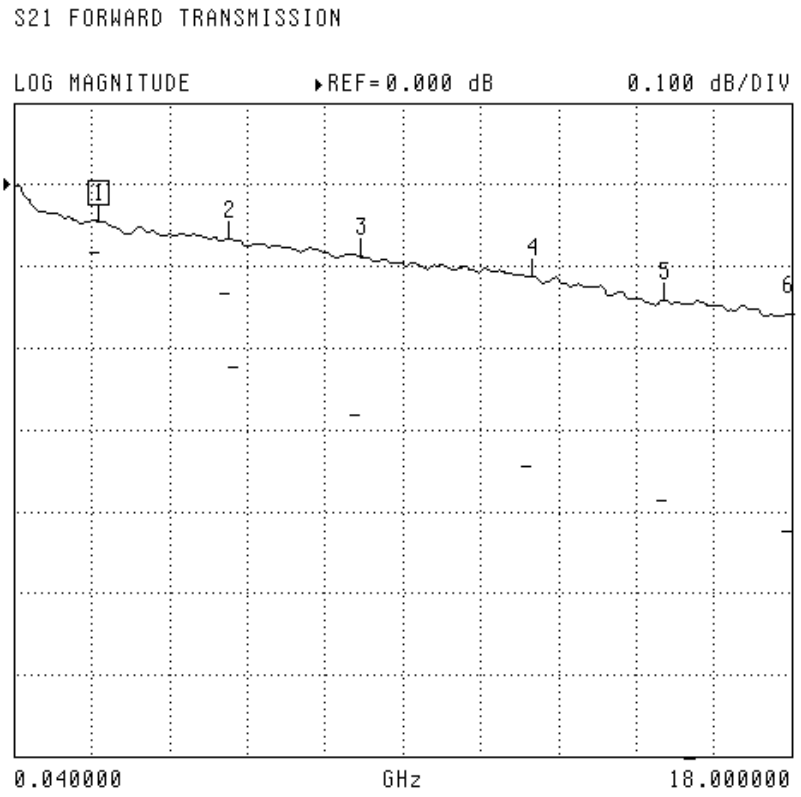
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 104/105

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

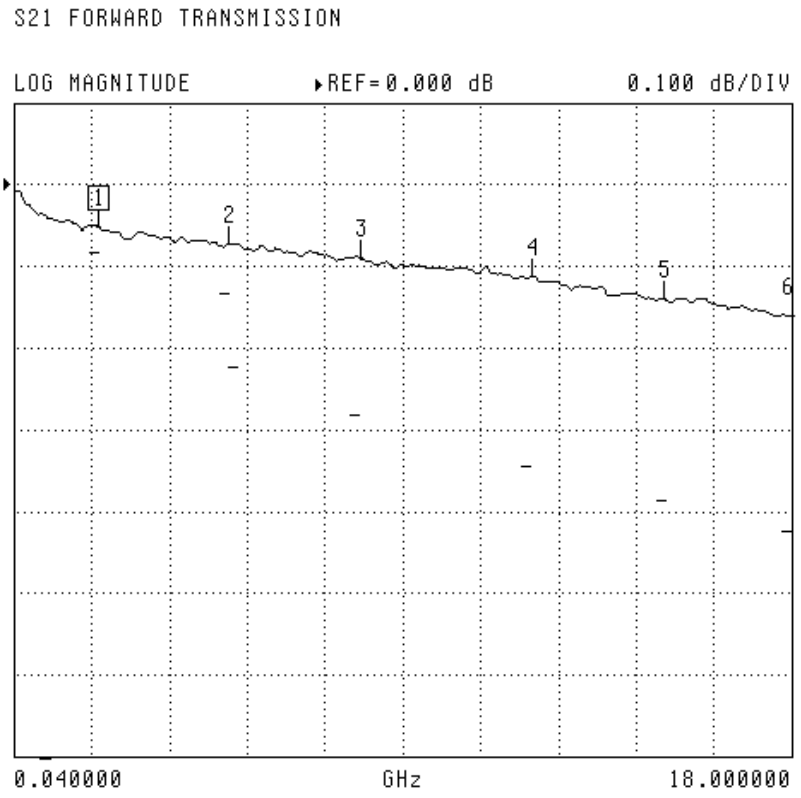
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 106/107

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

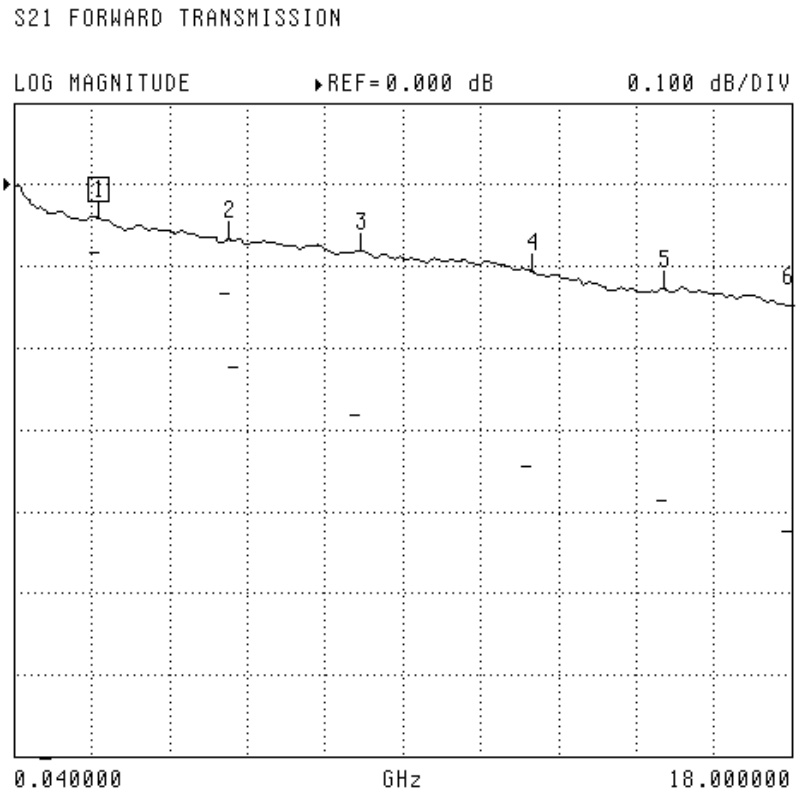
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 108/109

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

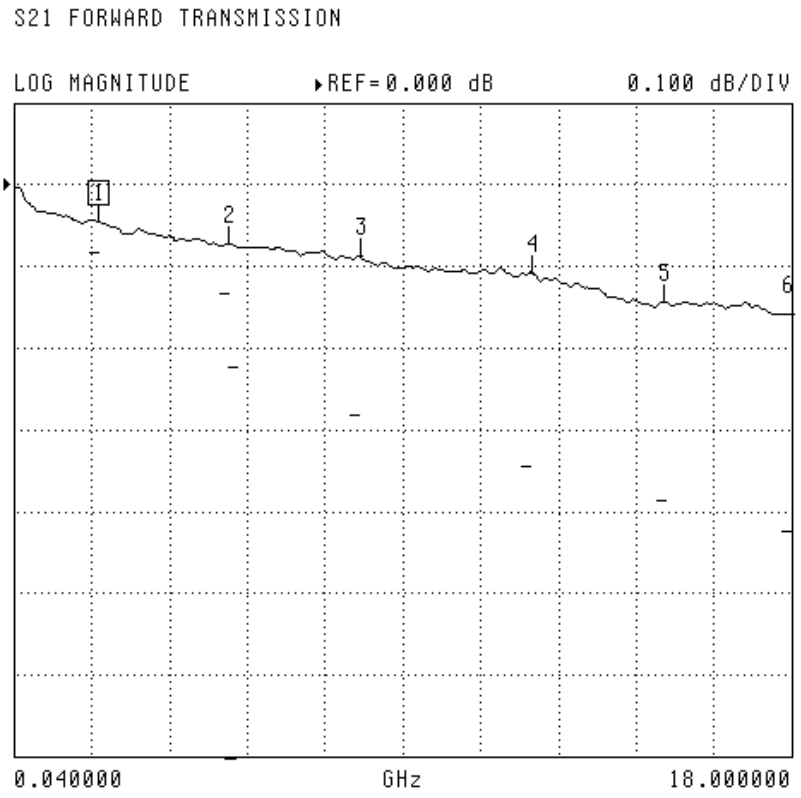
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 110/111

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

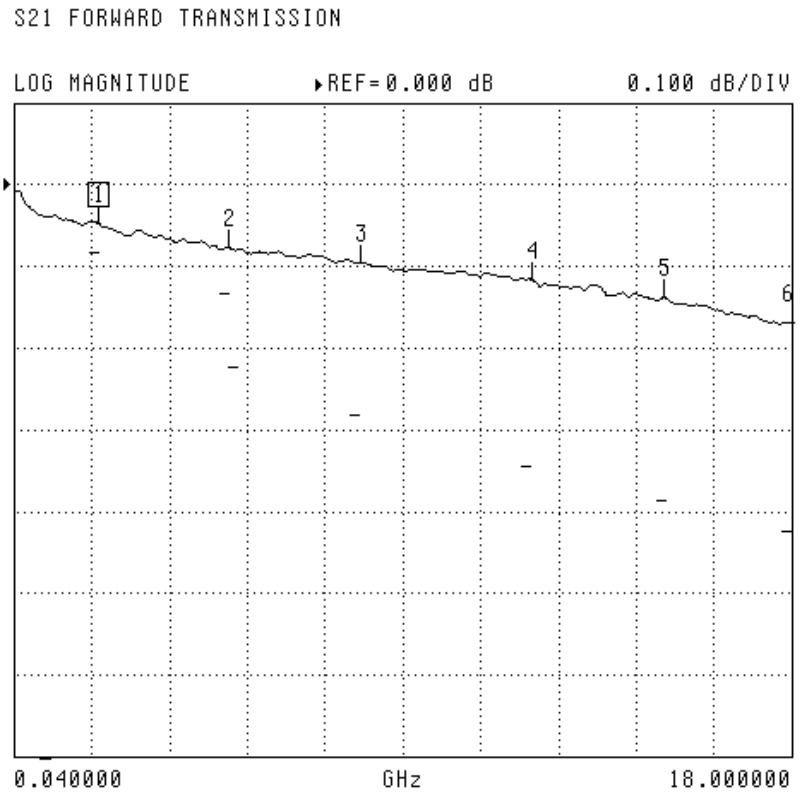
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 112/113

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

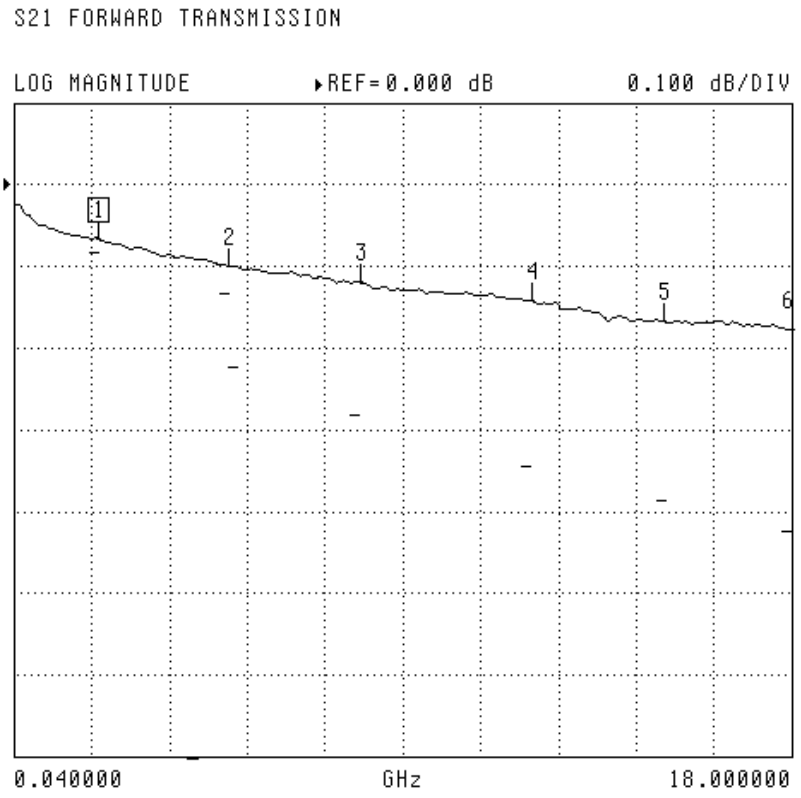
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 114/115

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

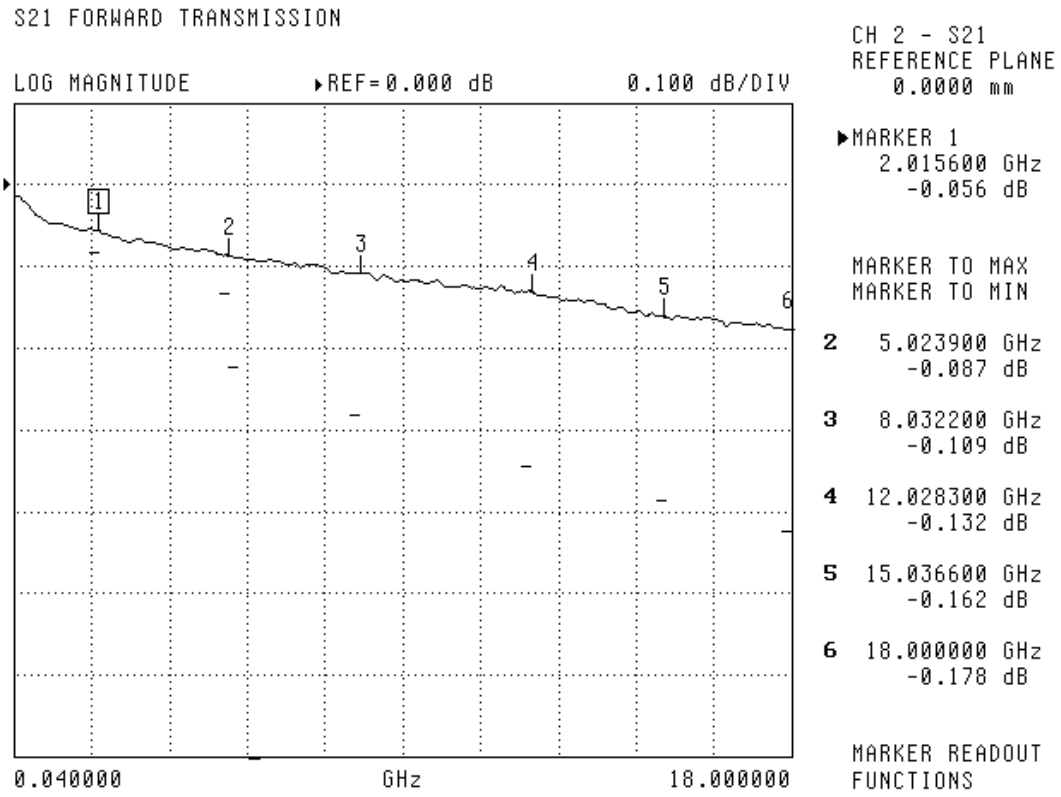
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 116/117

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

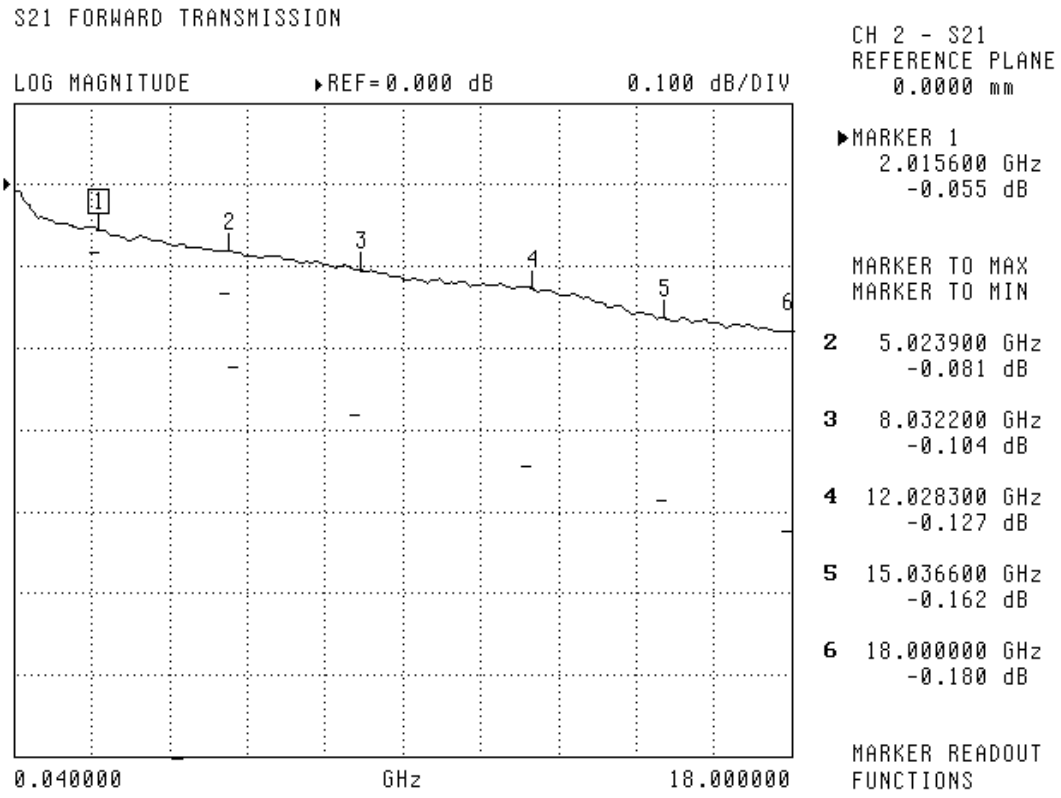
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / After thermal shocks 07/02/2006



Couple 118/119

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

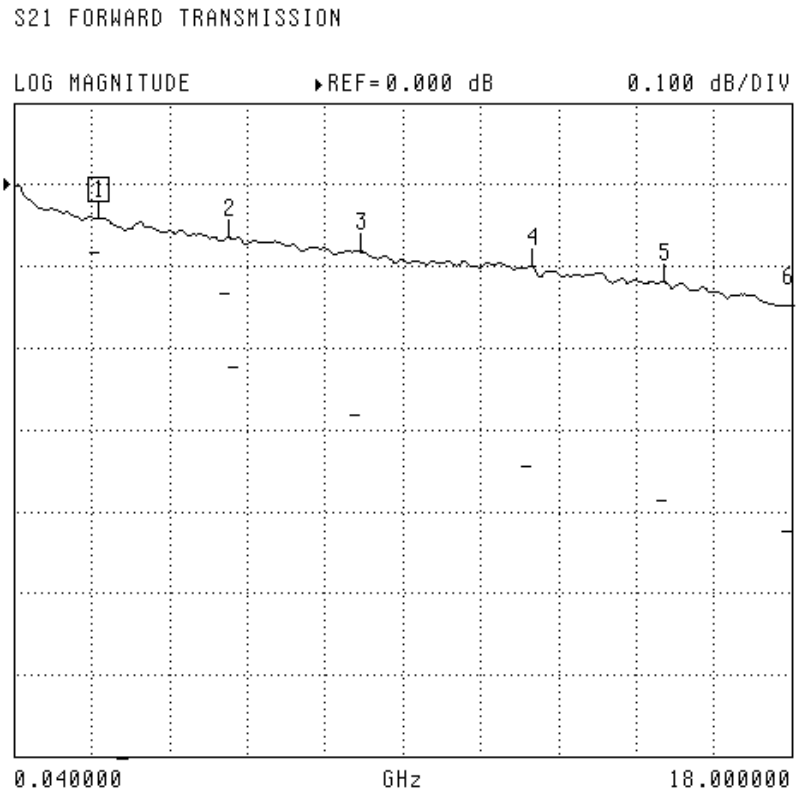
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.041 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.065 dB

3 8.032200 GHz
-0.082 dB

4 12.028300 GHz
-0.101 dB

5 15.036600 GHz
-0.119 dB

6 18.000000 GHz
-0.148 dB

MARKER READOUT
FUNCTIONS

Couple 1/2

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

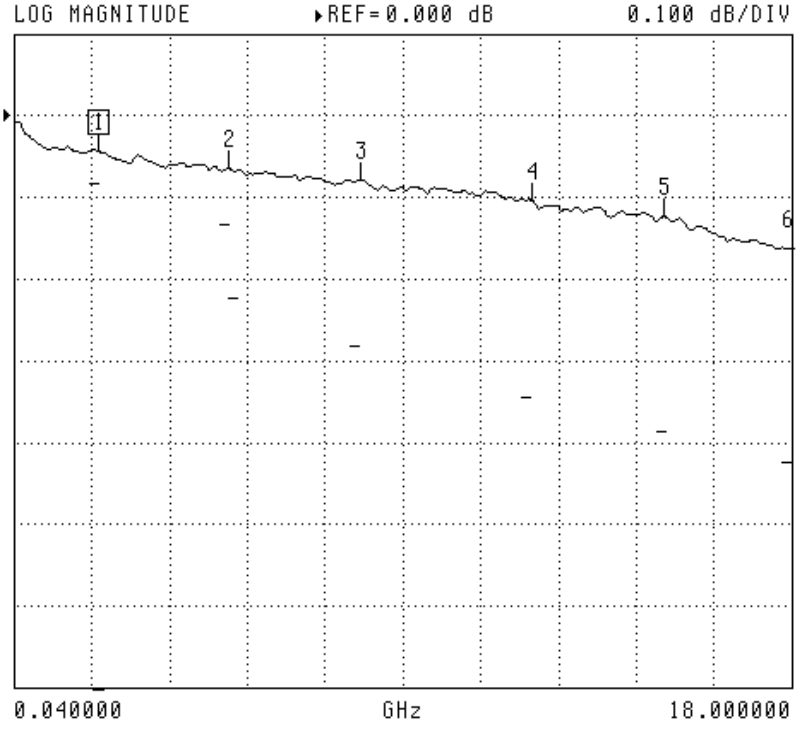
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.044 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.064 dB

3 8.032200 GHz
-0.079 dB

4 12.028300 GHz
-0.105 dB

5 15.036600 GHz
-0.124 dB

6 18.000000 GHz
-0.164 dB

MARKER READOUT
FUNCTIONS

Couple 3/4

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

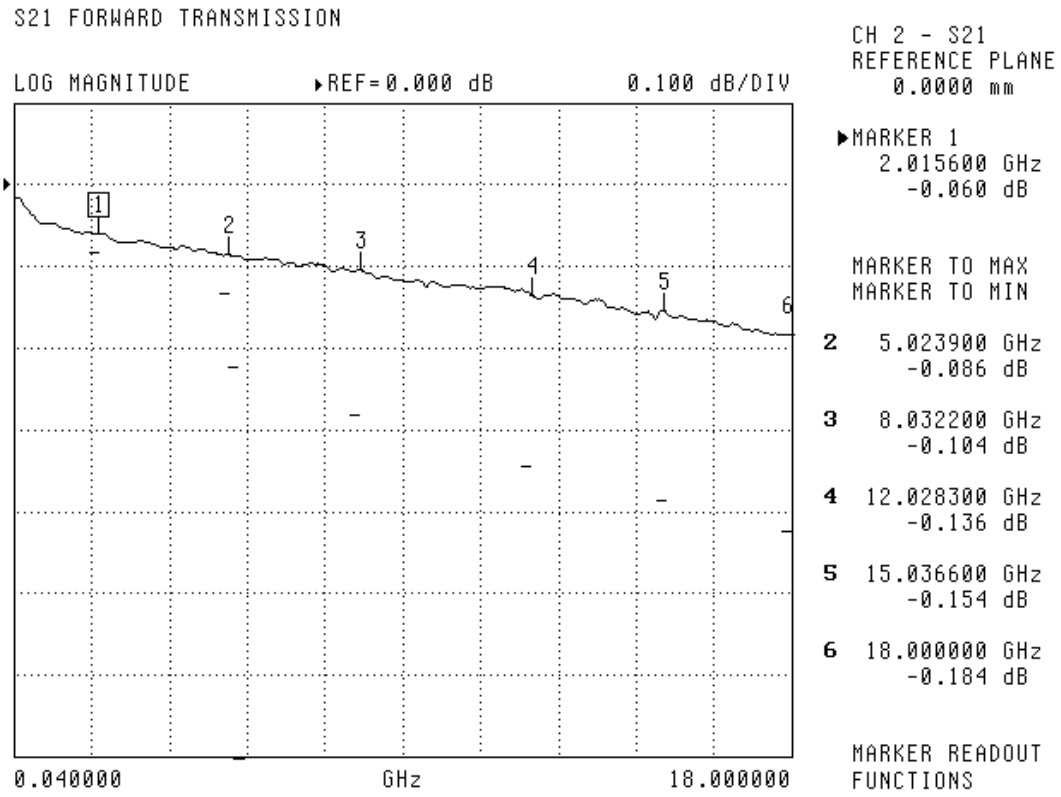
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 5/6

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

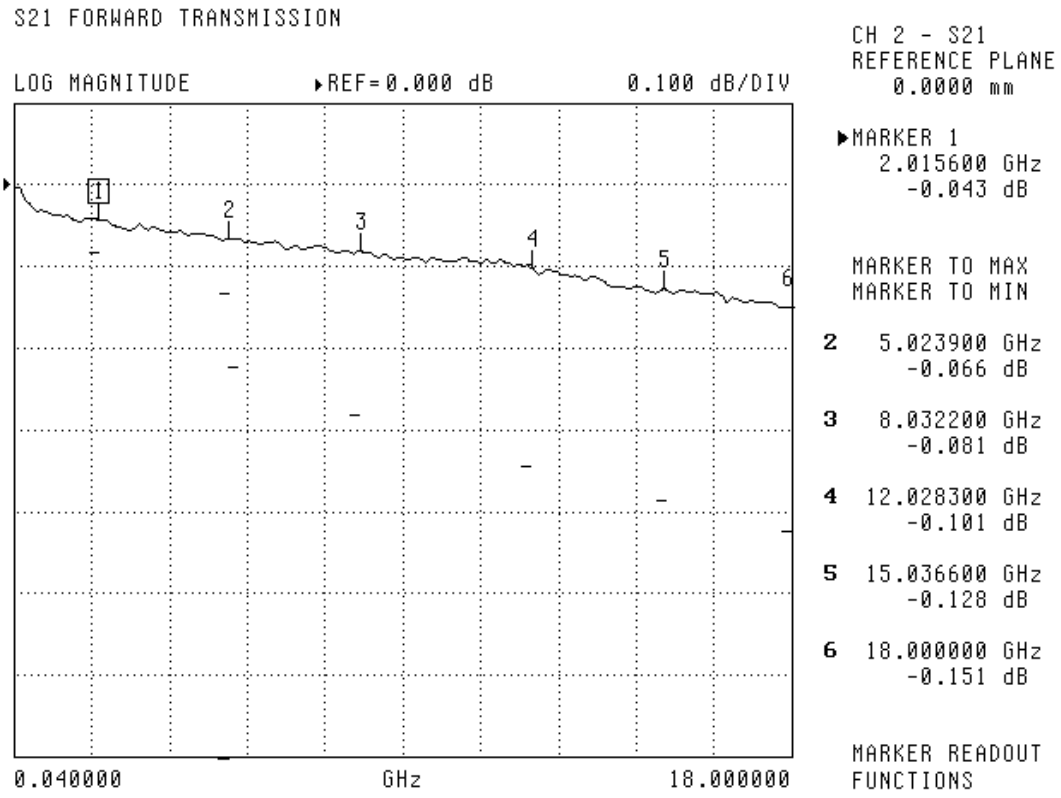
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 7/8

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

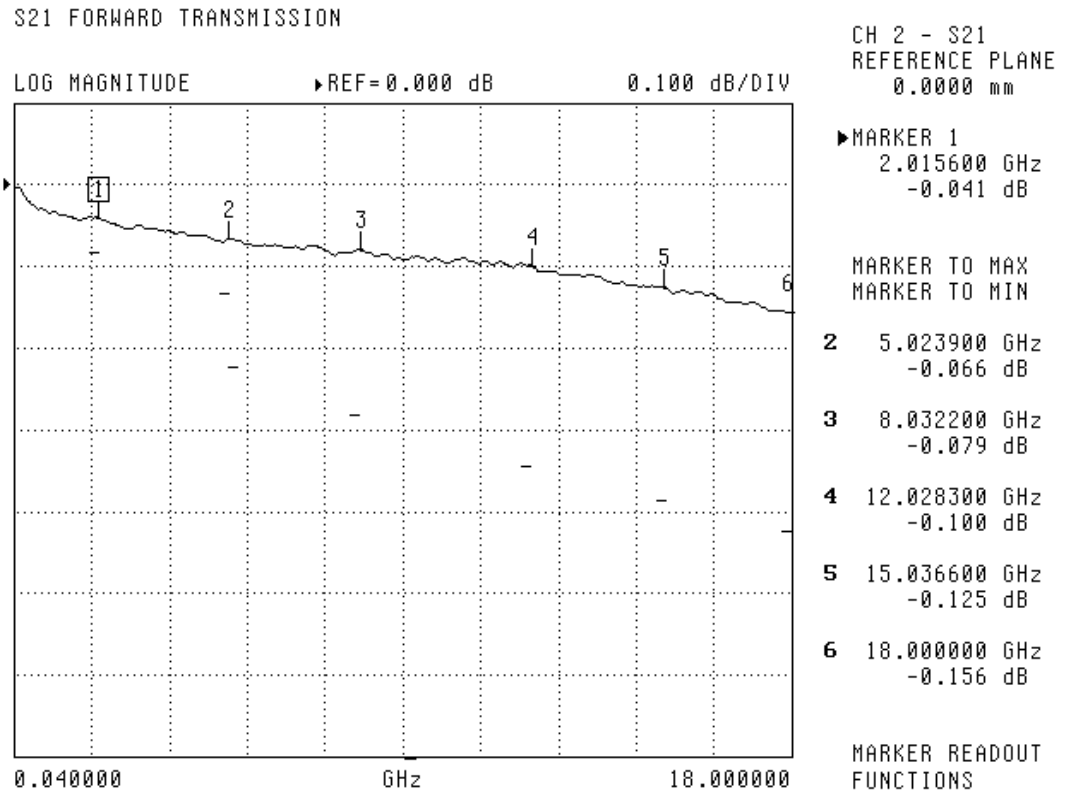
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 9/10

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

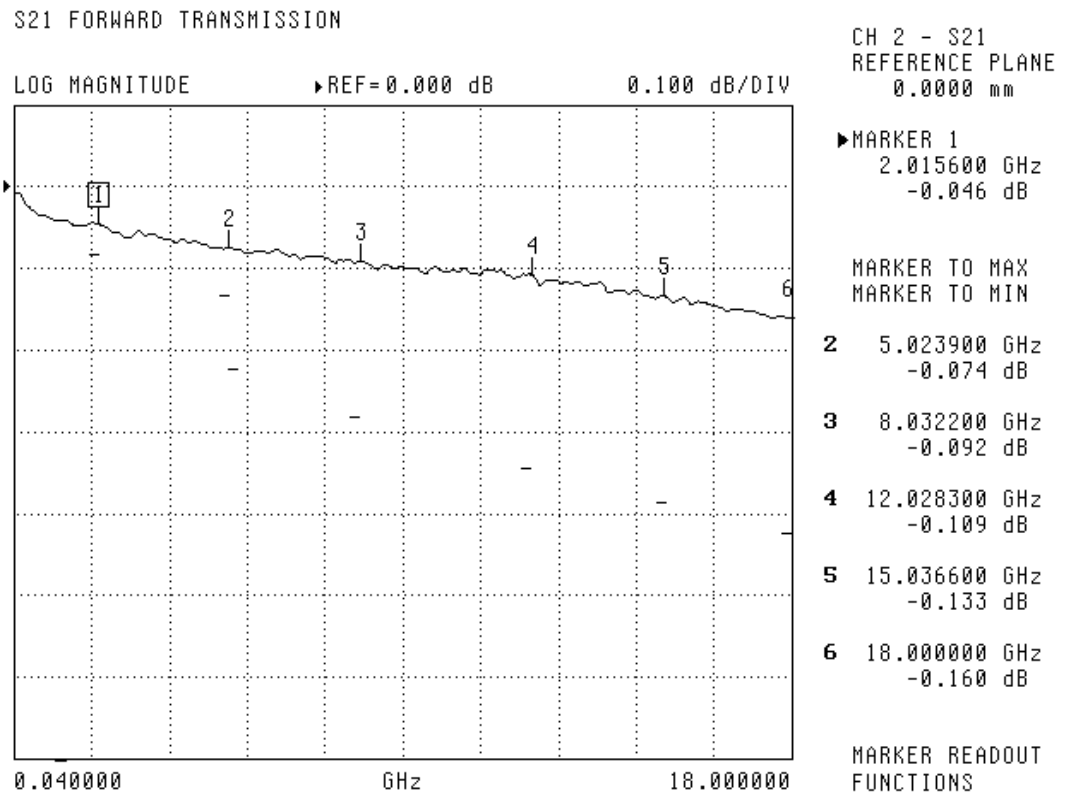
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 11/12

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

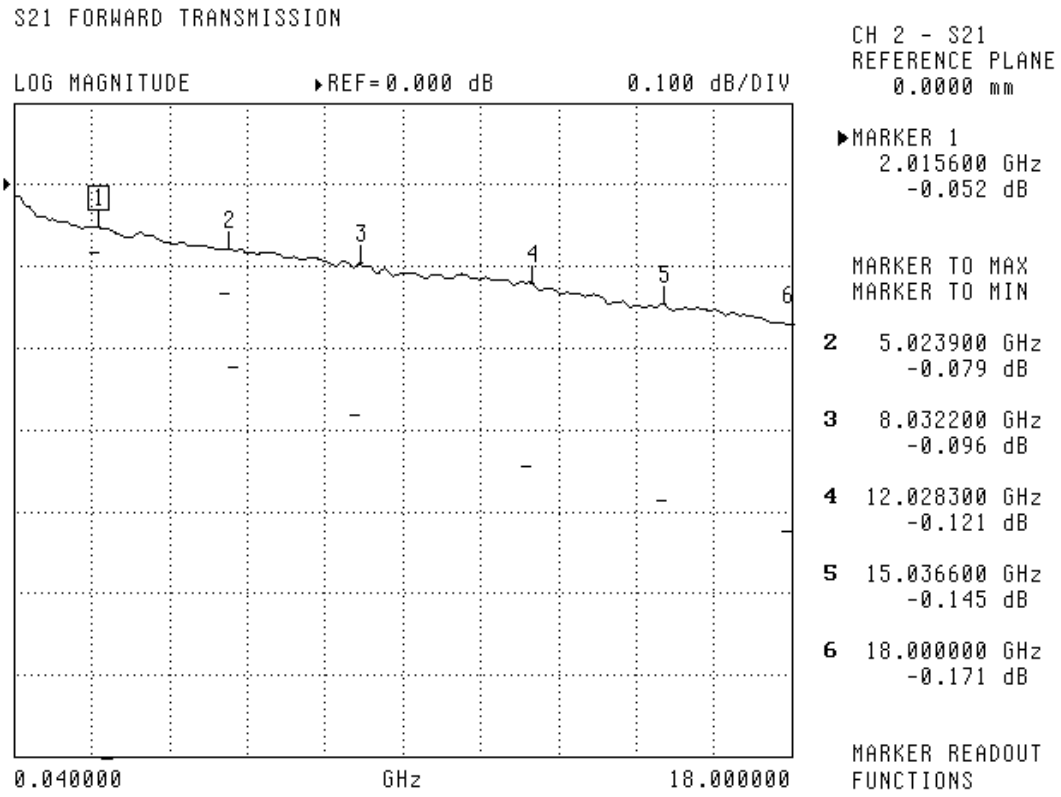
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 13/14

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

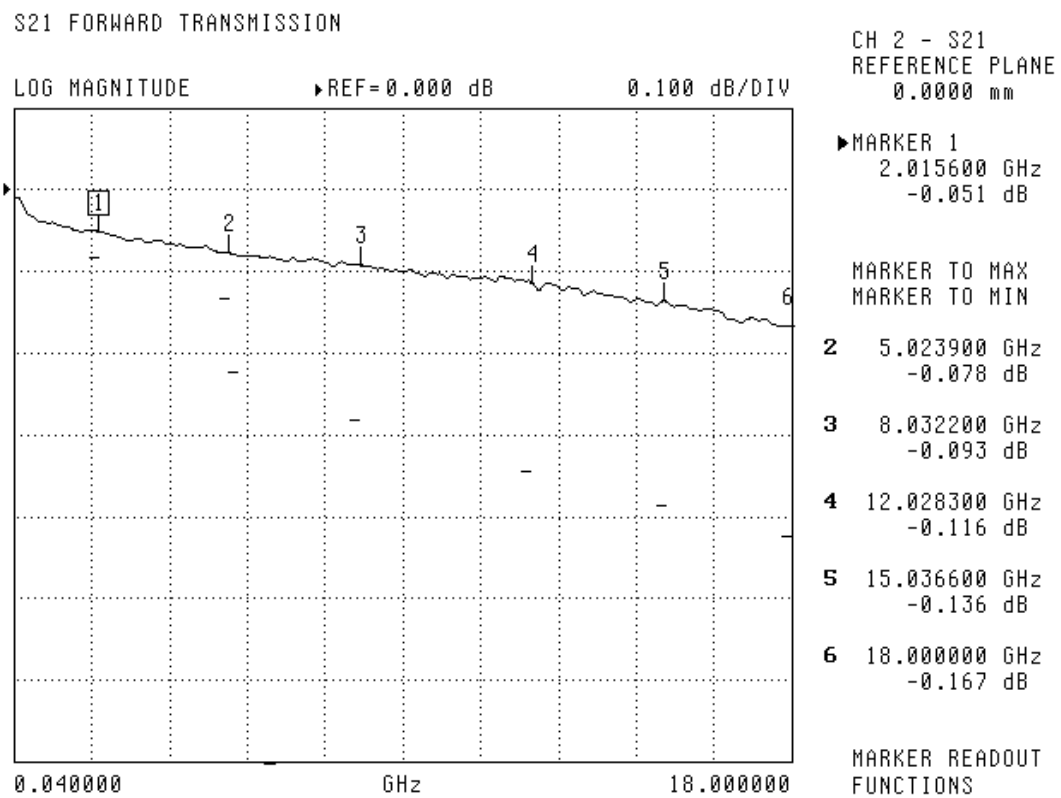
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 15/16

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

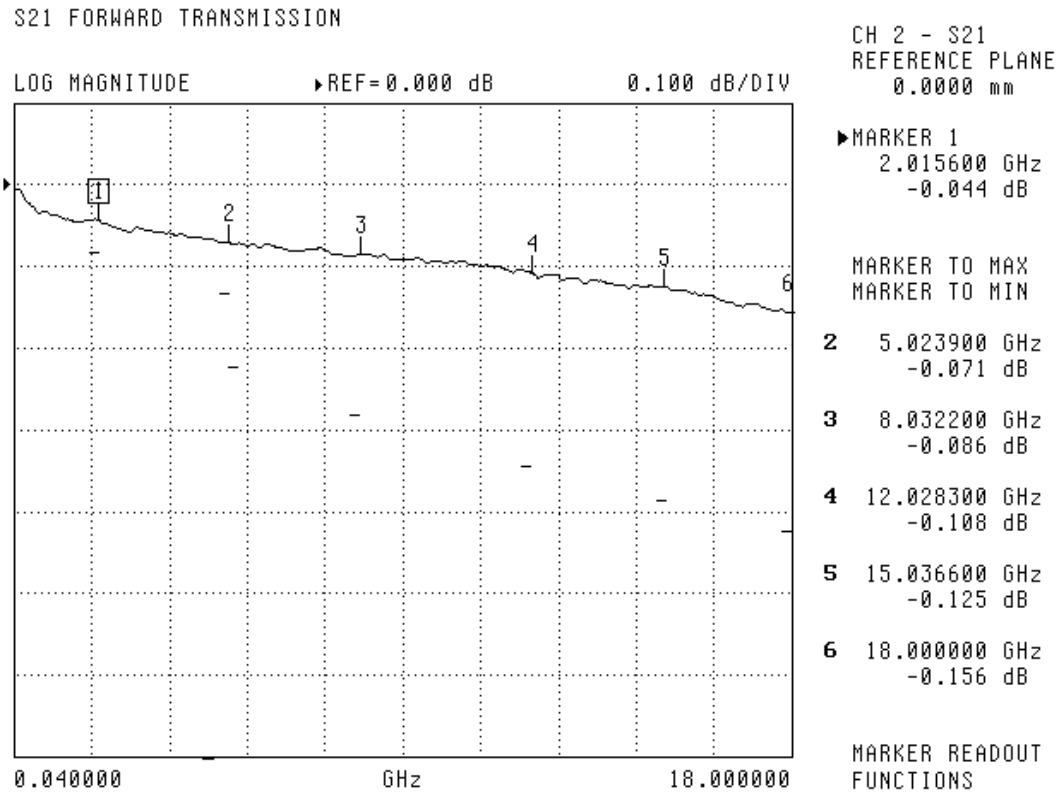
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 17/18

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

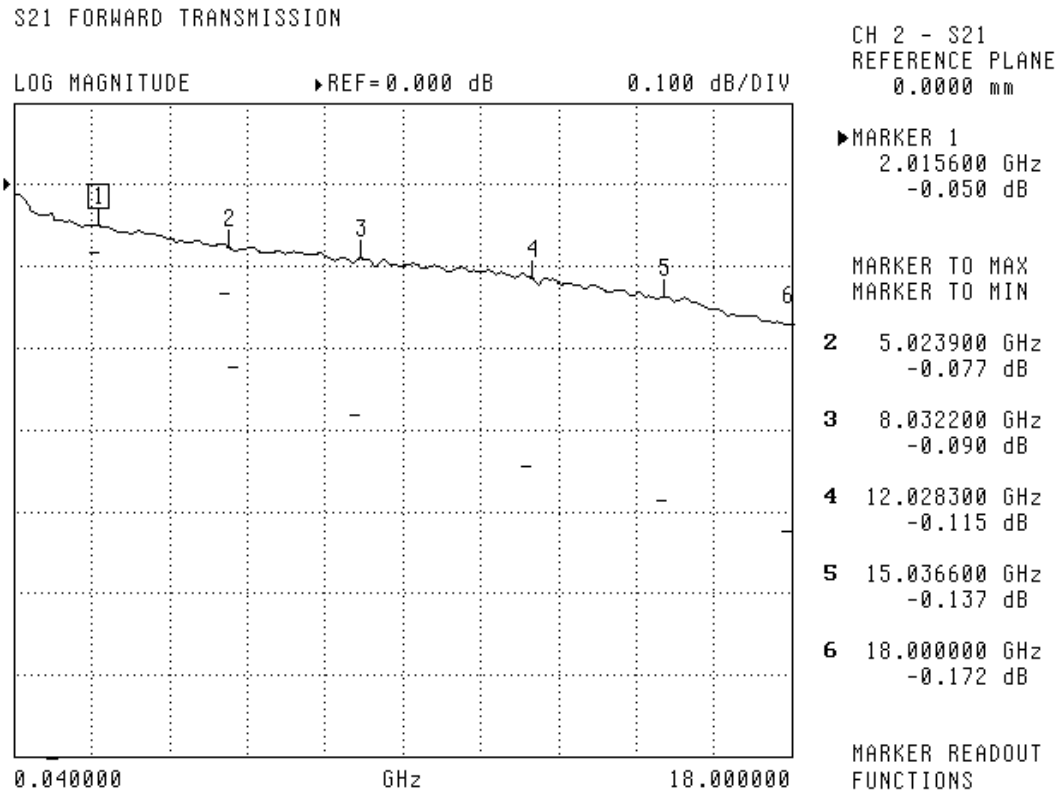
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 19/20

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

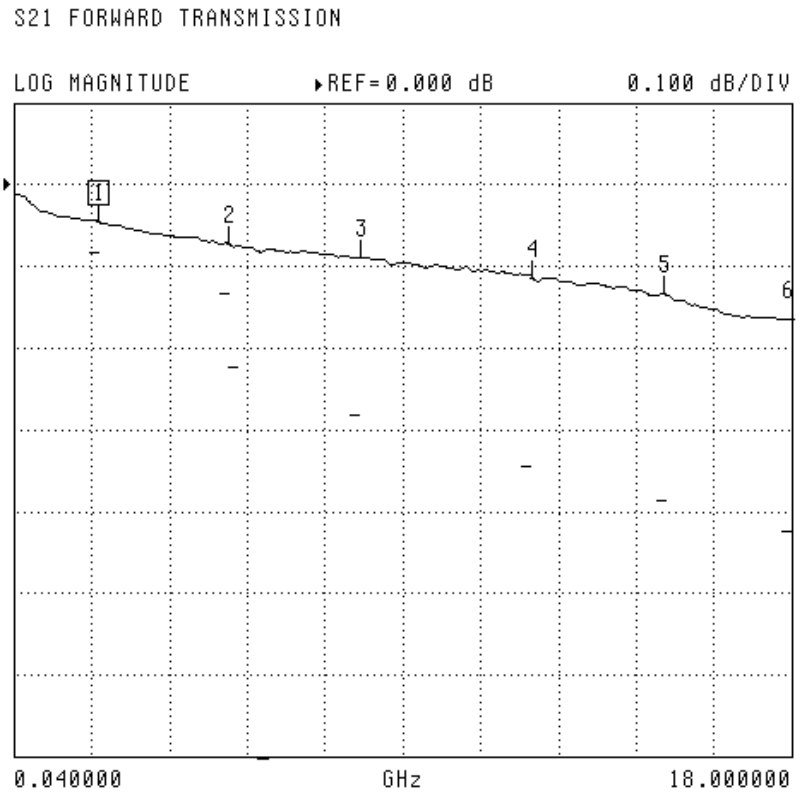
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.046 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.073 dB

3 8.032200 GHz
-0.089 dB

4 12.028300 GHz
-0.114 dB

5 15.036600 GHz
-0.134 dB

6 18.000000 GHz
-0.165 dB

MARKER READOUT
FUNCTIONS

Couple 21/22

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

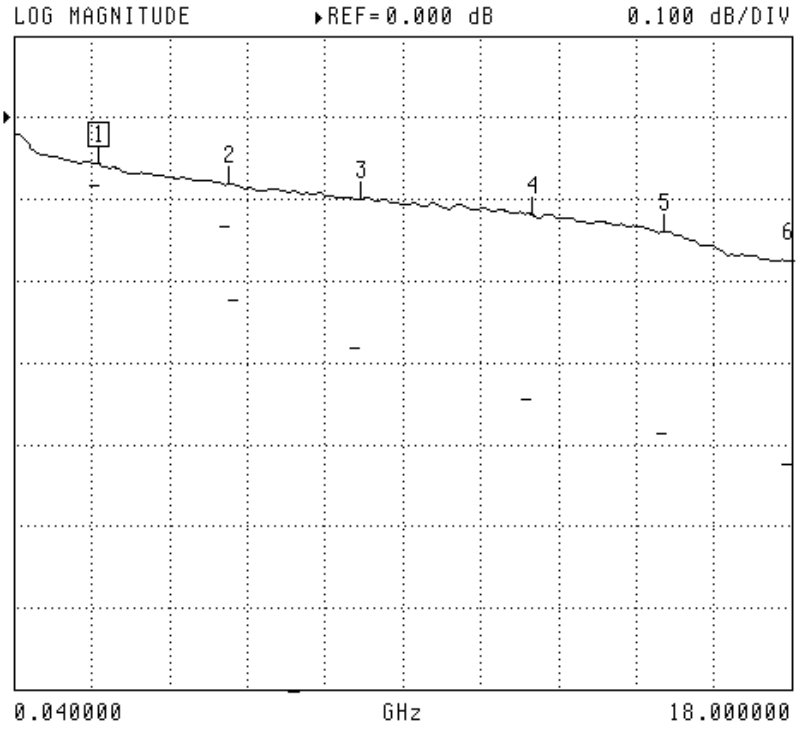
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.057 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.081 dB

3 8.032200 GHz
-0.100 dB

4 12.028300 GHz
-0.119 dB

5 15.036600 GHz
-0.139 dB

6 18.000000 GHz
-0.176 dB

MARKER READOUT
FUNCTIONS

Couple 23/24

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

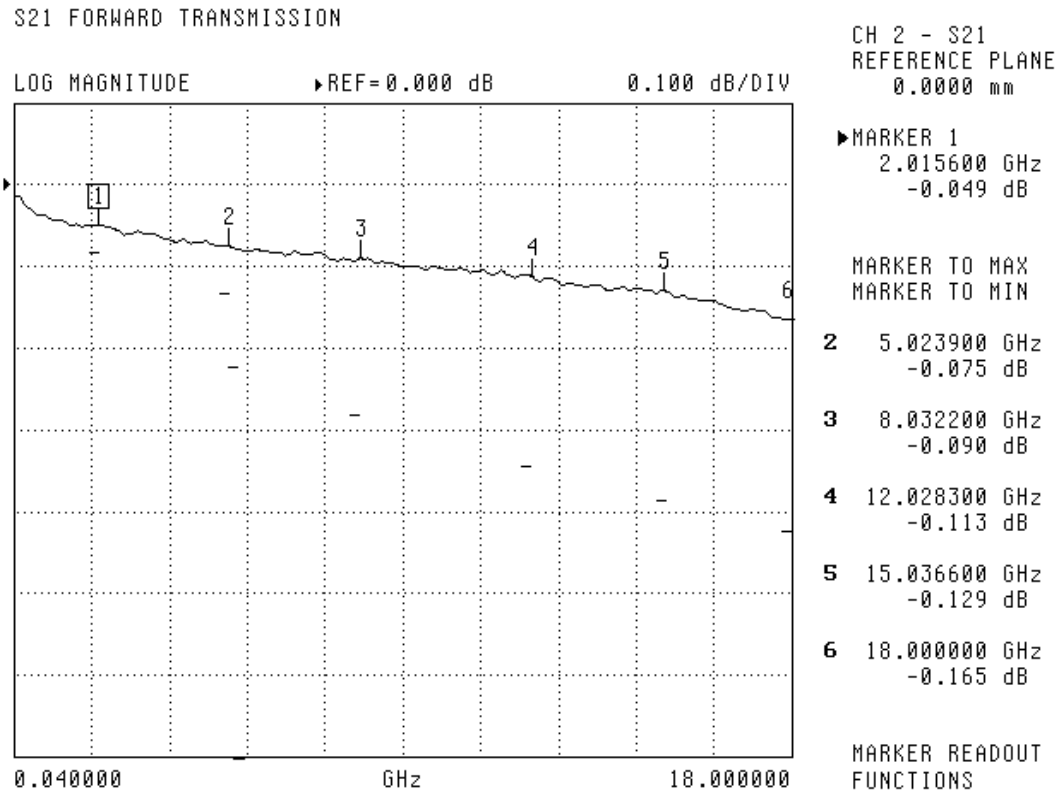
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 25/26

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

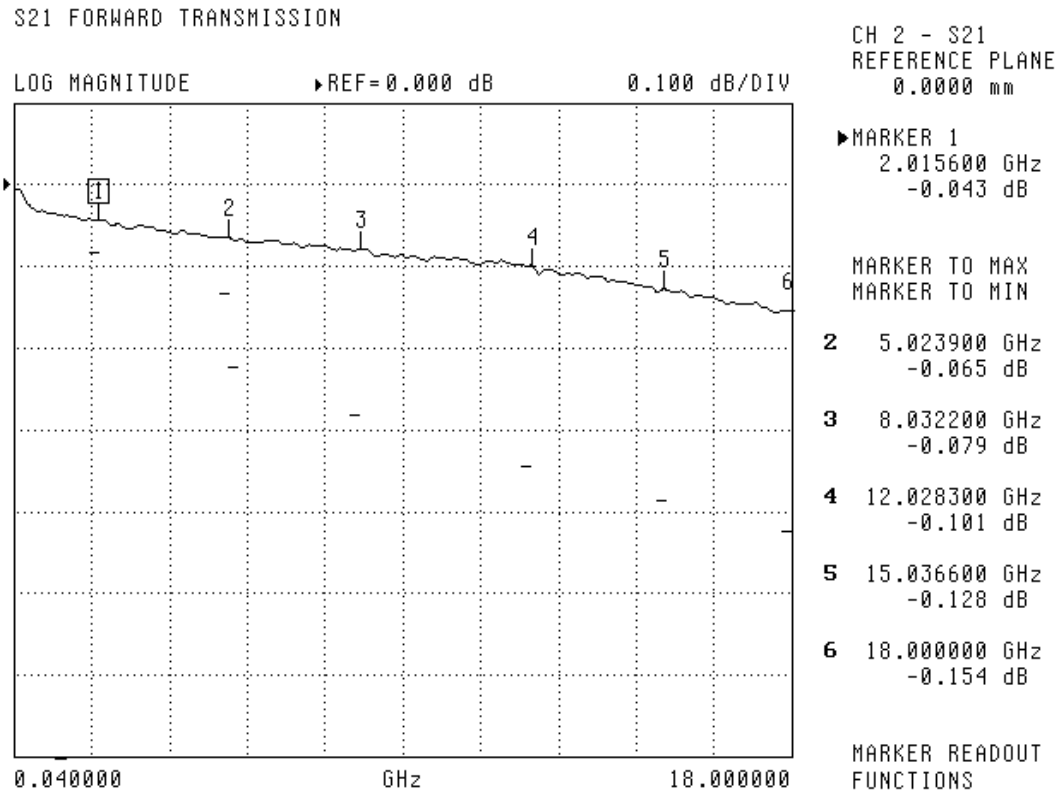
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 27/28

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

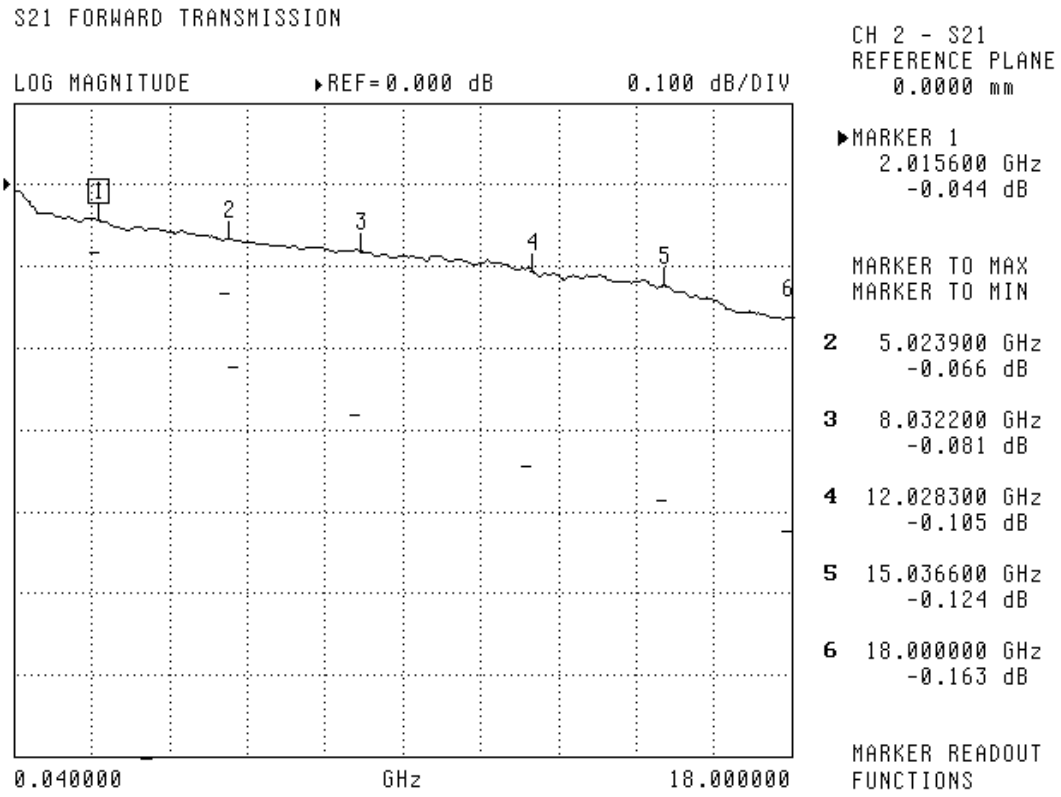
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 29/30

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

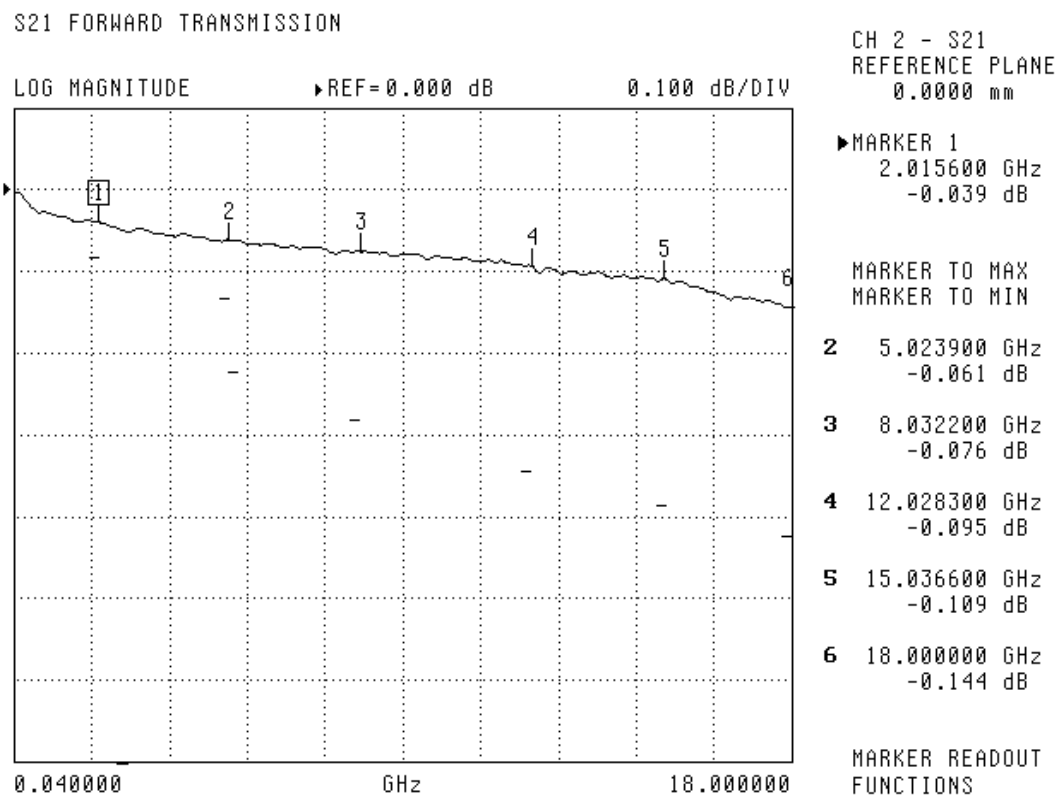
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 31/32

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

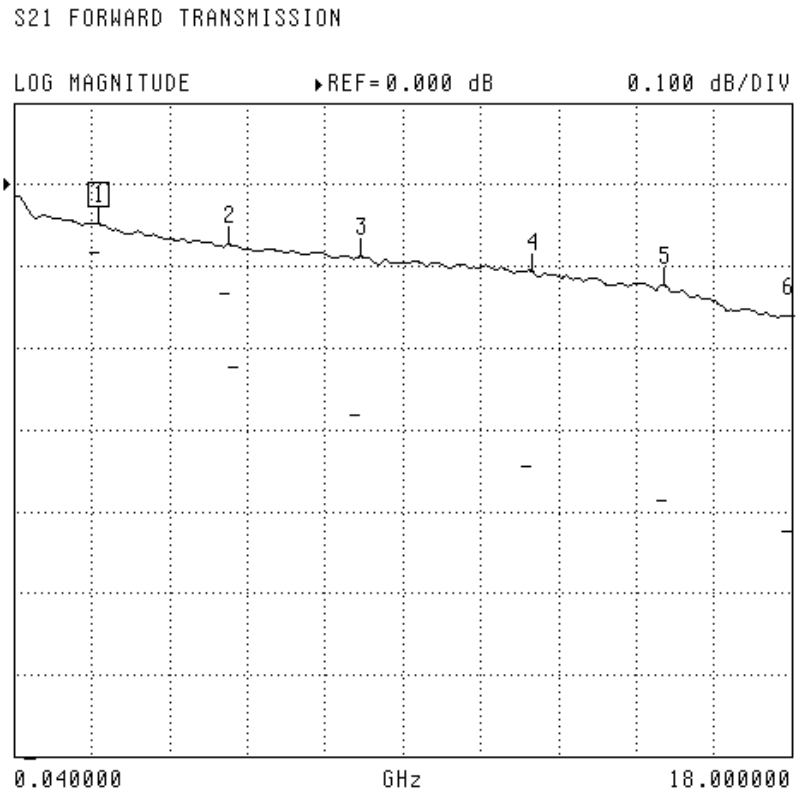
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 33/34

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

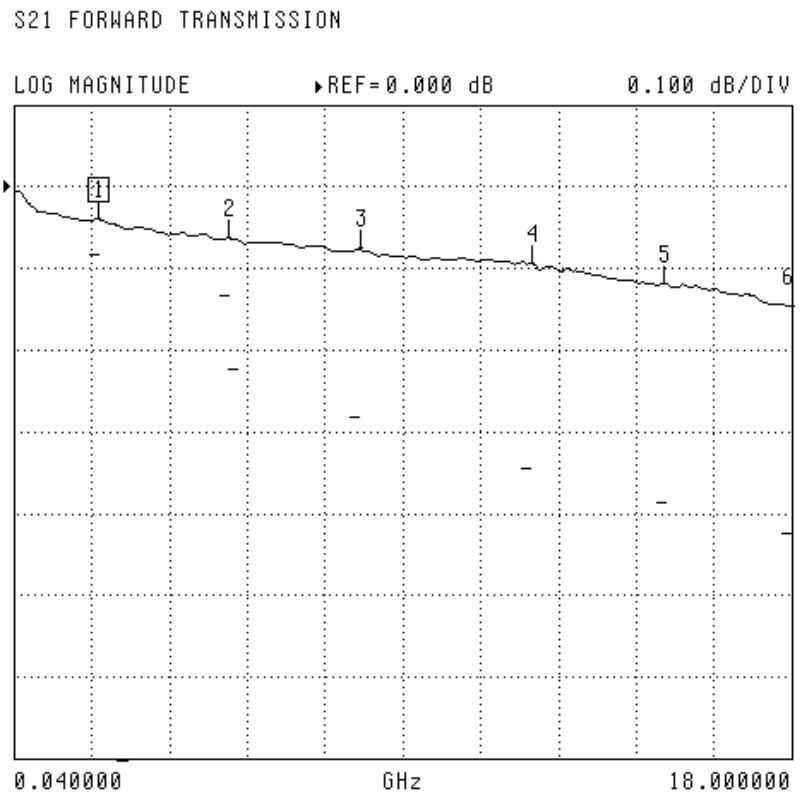
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 35/95

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

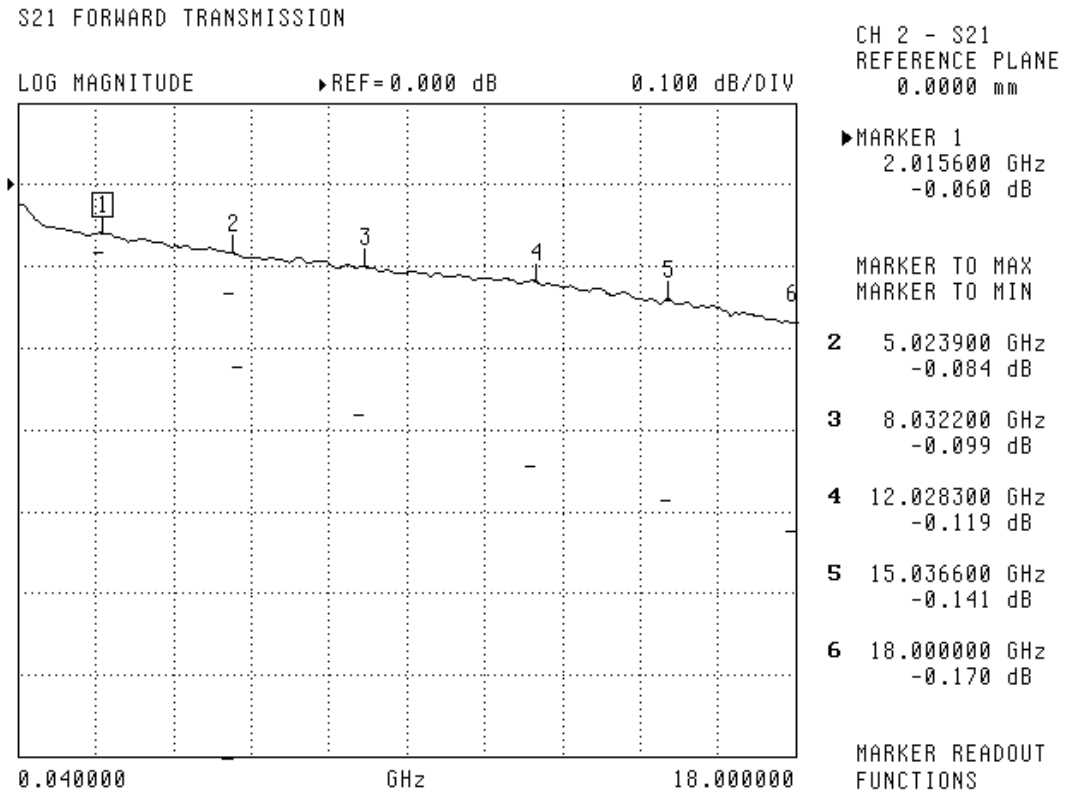
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 96/97

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

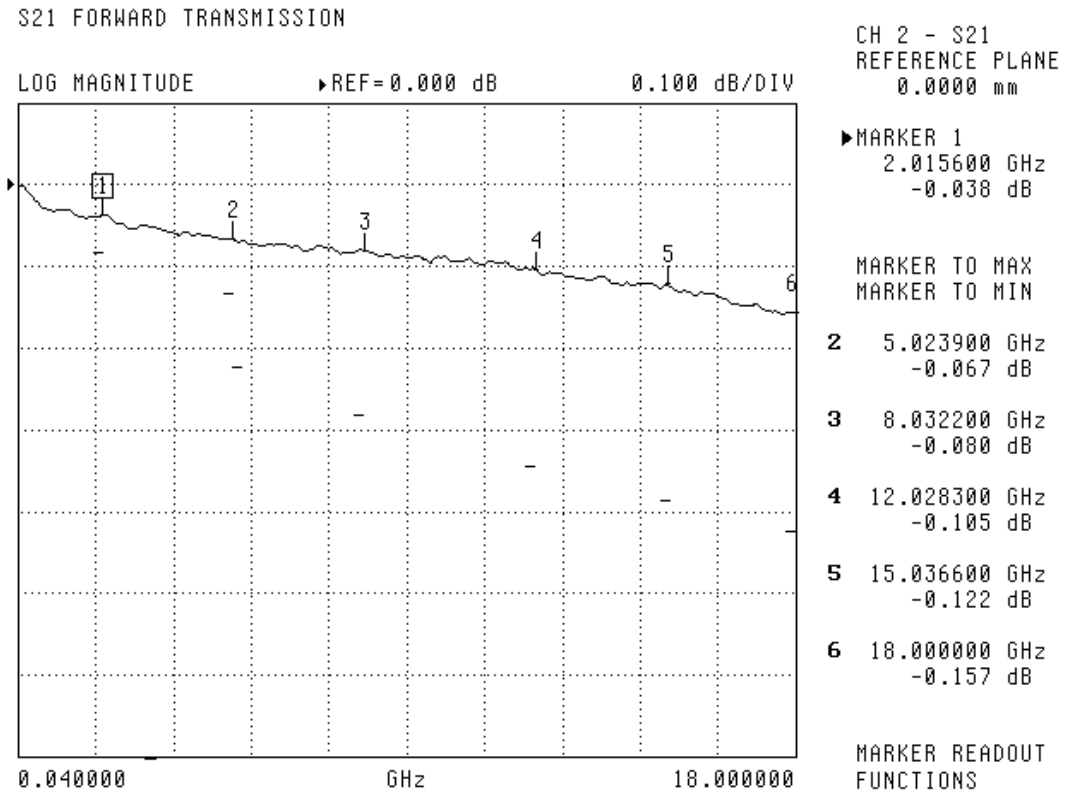
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 98/99

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

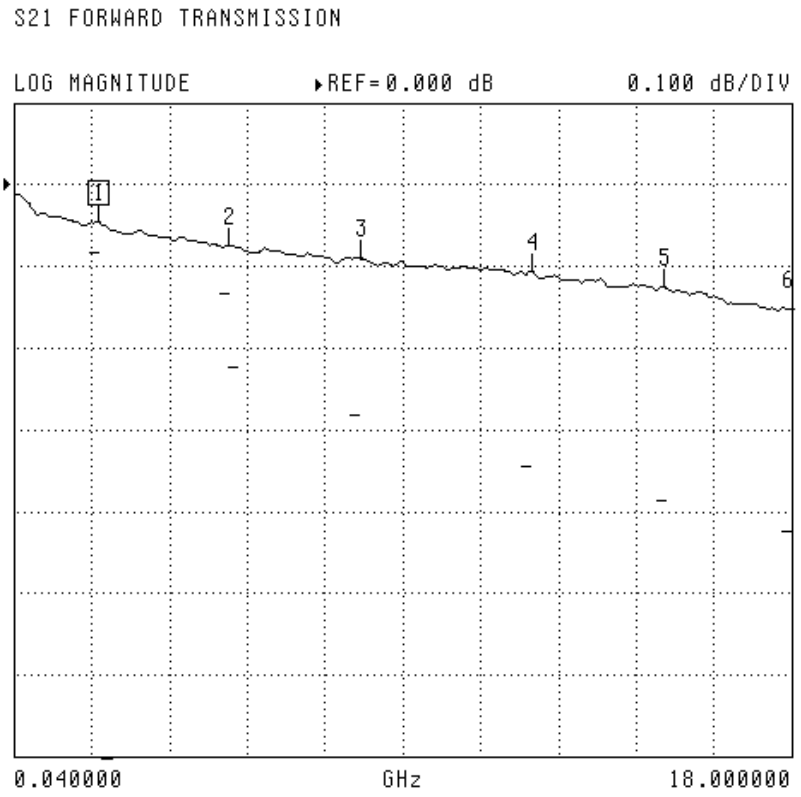
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.046 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.075 dB

3 8.032200 GHz
-0.089 dB

4 12.028300 GHz
-0.107 dB

5 15.036600 GHz
-0.124 dB

6 18.000000 GHz
-0.153 dB

MARKER READOUT
FUNCTIONS

Couple 100/101

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

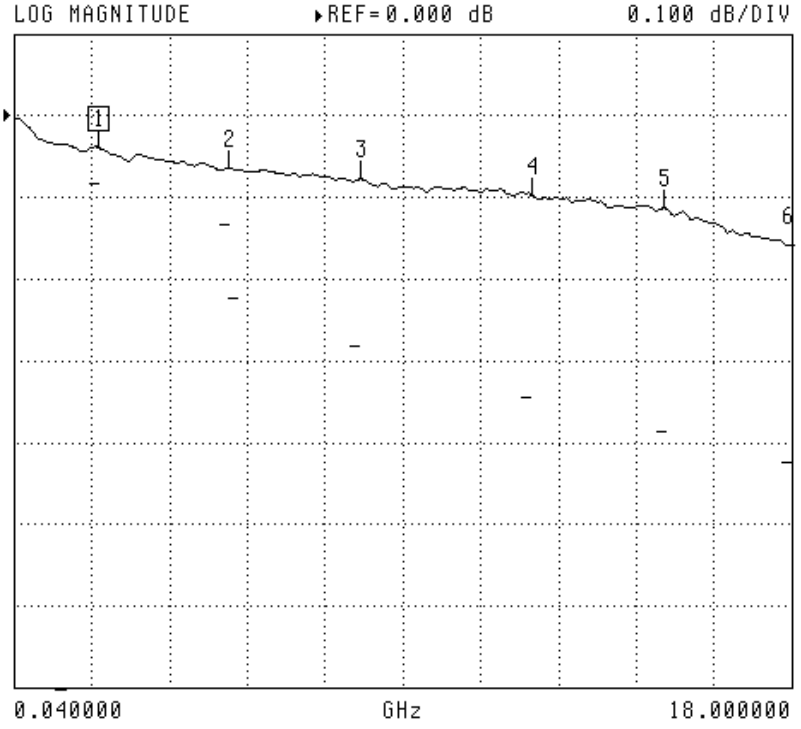
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.038 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.065 dB

3 8.032200 GHz
-0.077 dB

4 12.028300 GHz
-0.097 dB

5 15.036600 GHz
-0.113 dB

6 18.000000 GHz
-0.158 dB

MARKER READOUT
FUNCTIONS

Couple 102/103

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

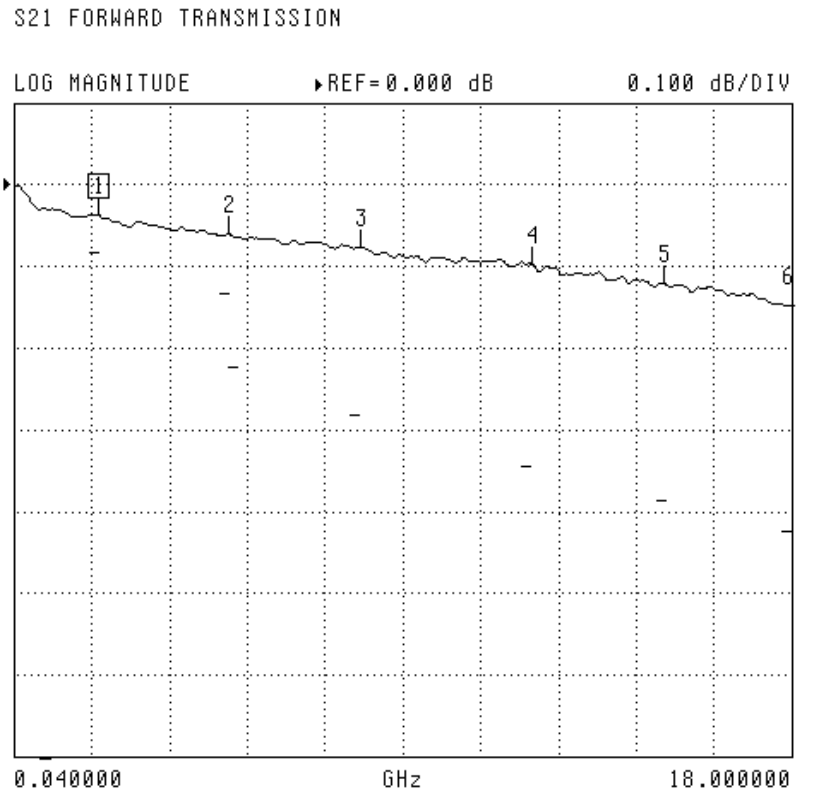
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 104/105

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

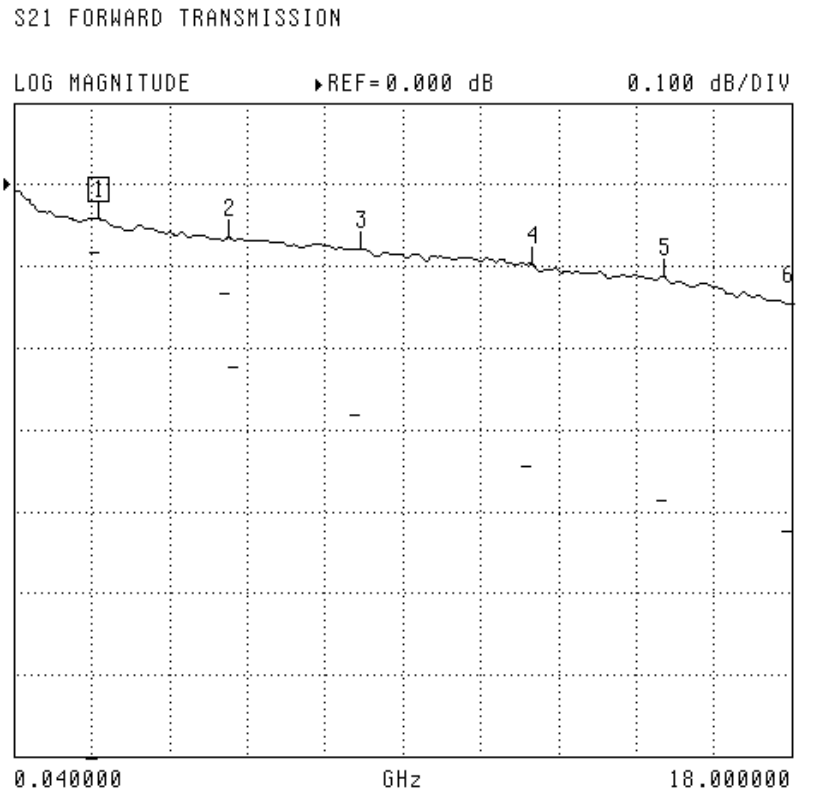
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 106/107

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

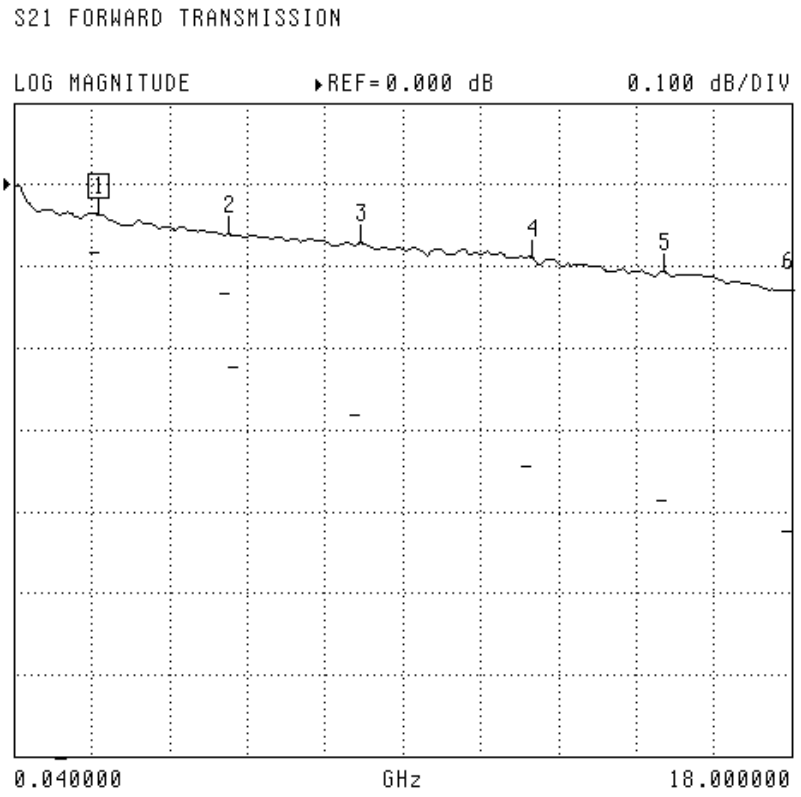
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.036 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.060 dB

3 8.032200 GHz
-0.071 dB

4 12.028300 GHz
-0.090 dB

5 15.036600 GHz
-0.106 dB

6 18.000000 GHz
-0.130 dB

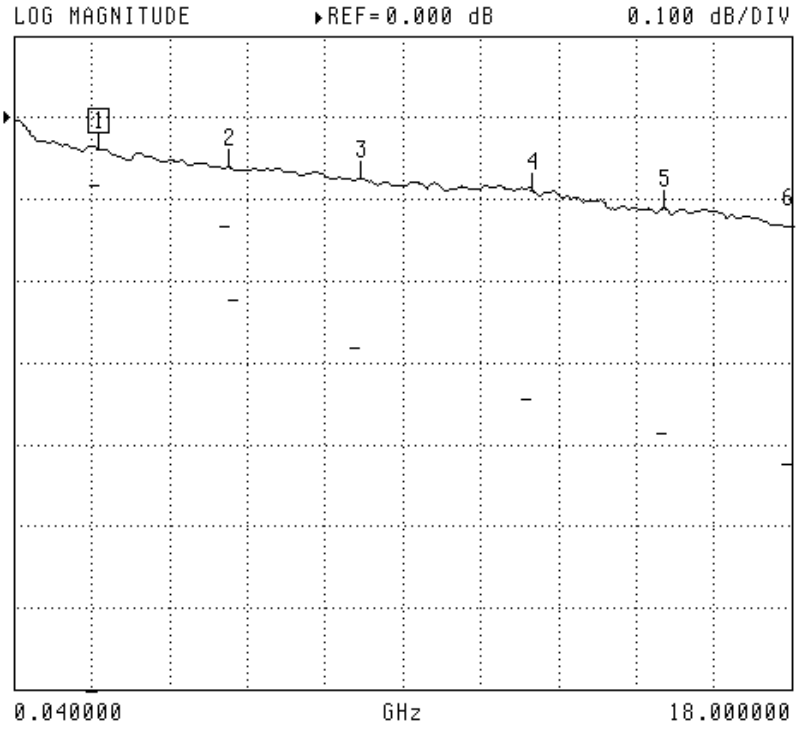
MARKER READOUT
FUNCTIONS

Couple 108/109

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.039 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.061 dB

3 8.032200 GHz
-0.075 dB

4 12.028300 GHz
-0.089 dB

5 15.036600 GHz
-0.111 dB

6 18.000000 GHz
-0.134 dB

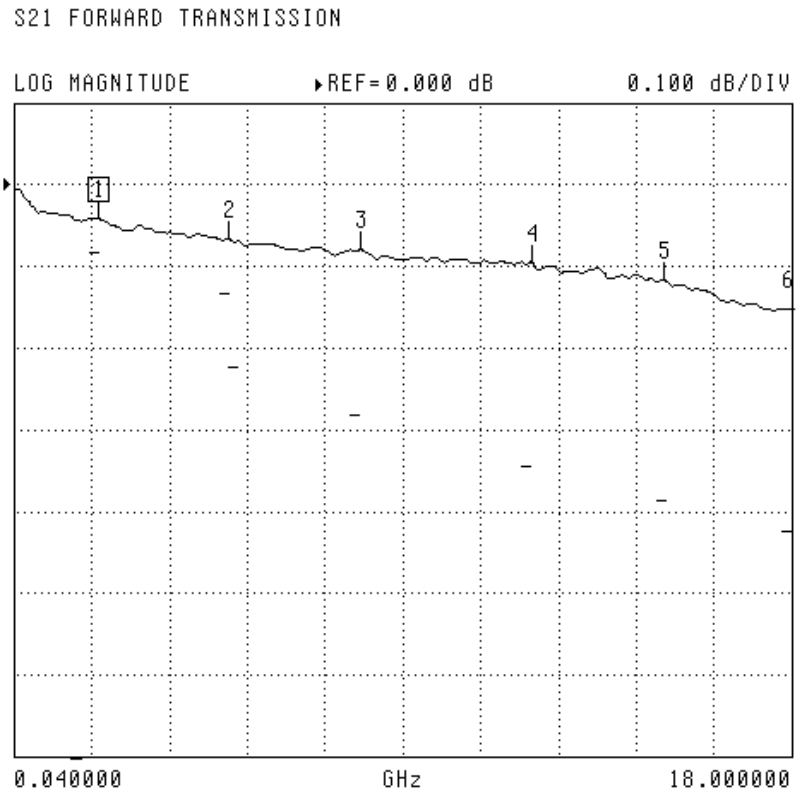
MARKER READOUT
FUNCTIONS

Couple 110/111

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.042 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.067 dB

3 8.032200 GHz
-0.080 dB

4 12.028300 GHz
-0.097 dB

5 15.036600 GHz
-0.116 dB

6 18.000000 GHz
-0.152 dB

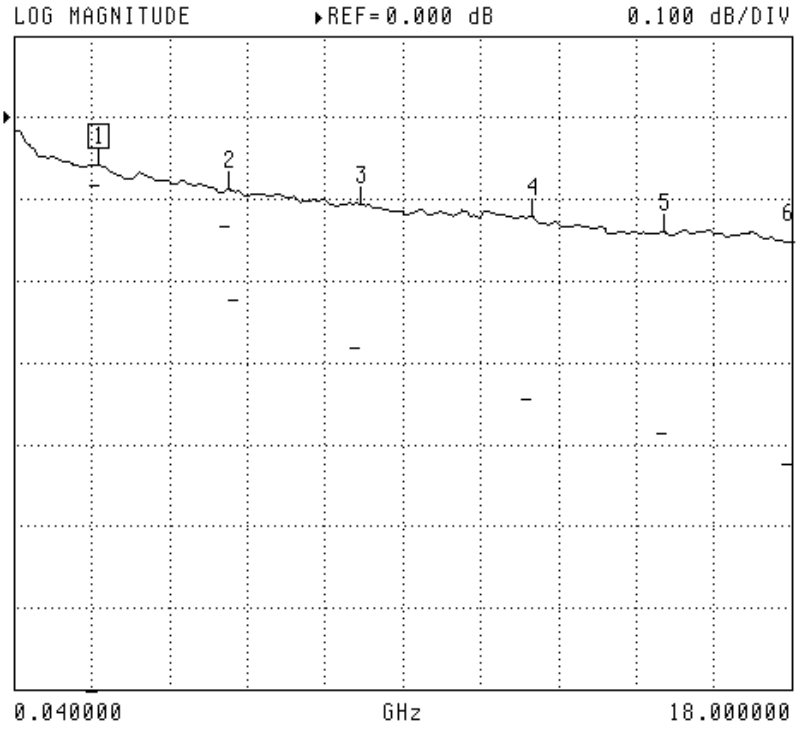
MARKER READOUT
FUNCTIONS

Couple 112/113

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.058 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.088 dB

3 8.032200 GHz
-0.106 dB

4 12.028300 GHz
-0.122 dB

5 15.036600 GHz
-0.140 dB

6 18.000000 GHz
-0.152 dB

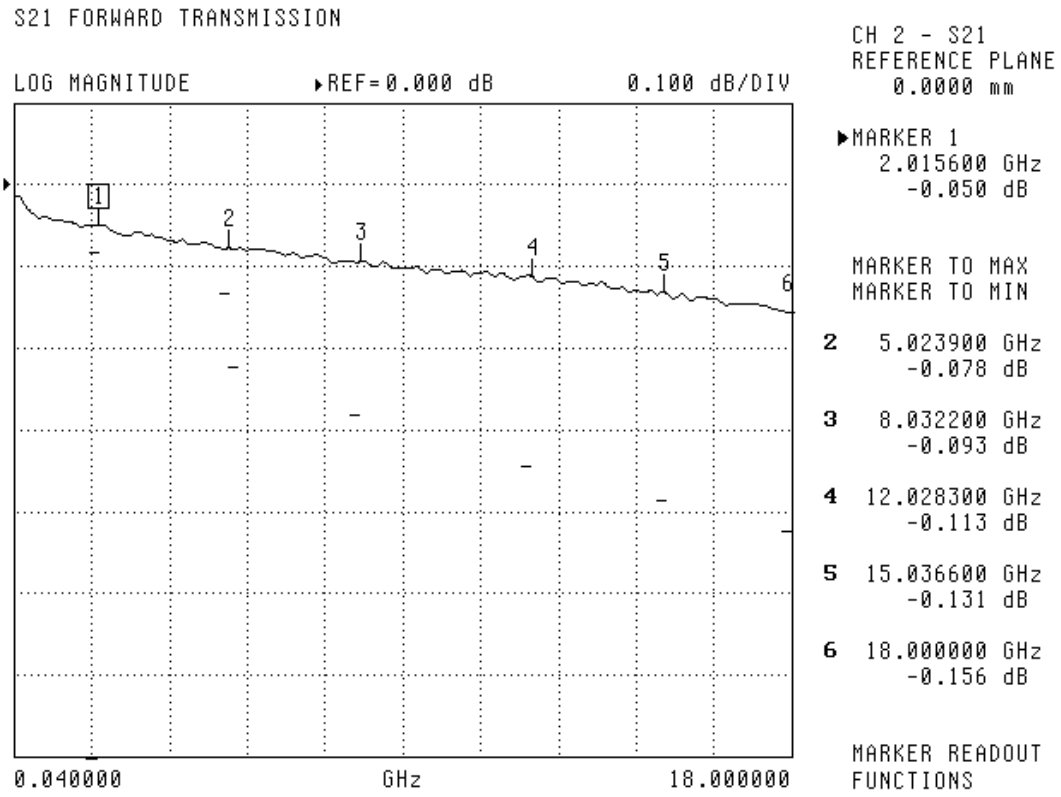
MARKER READOUT
FUNCTIONS

Couple 114/115

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 116/117

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

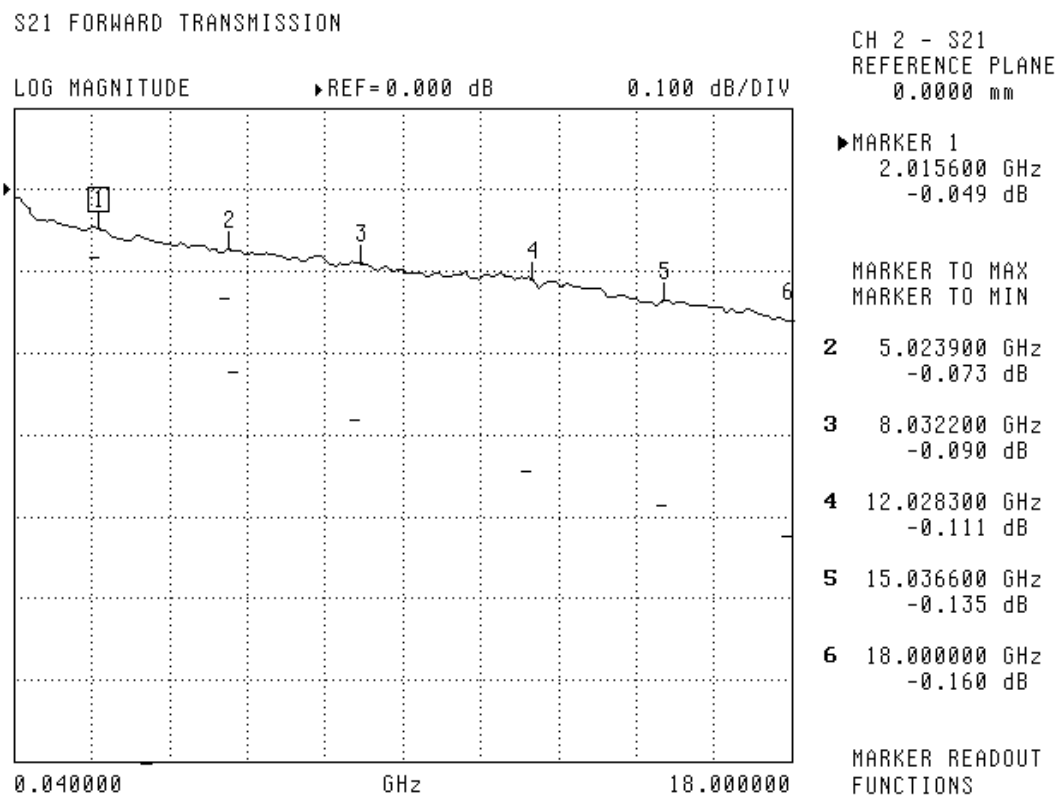
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / Low temperature –40°C 08/02/2006



Couple 118/119

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

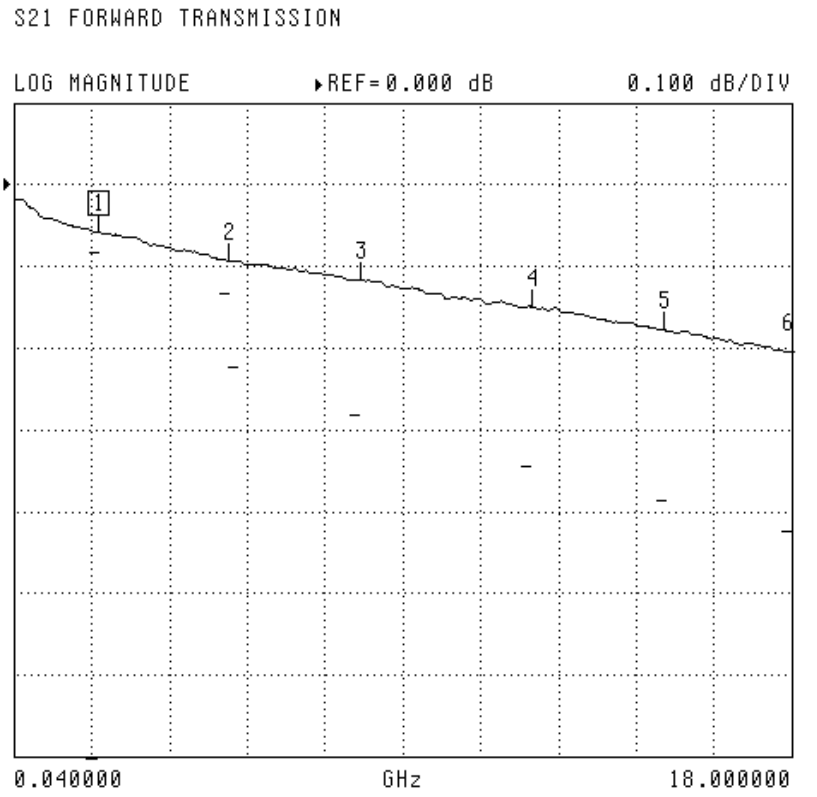
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 1/2

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

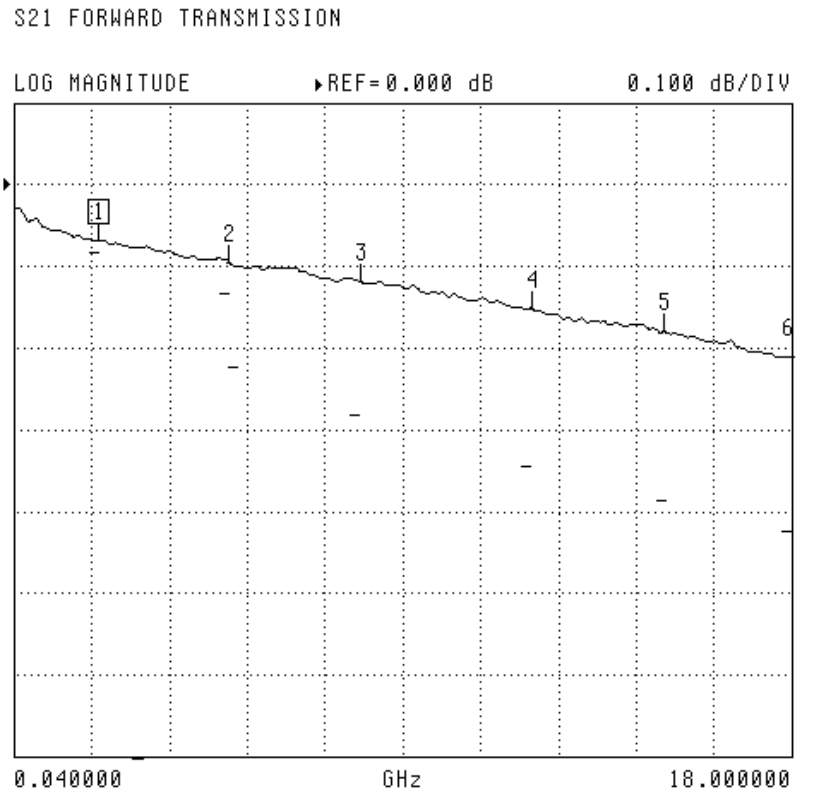
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 3/4

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

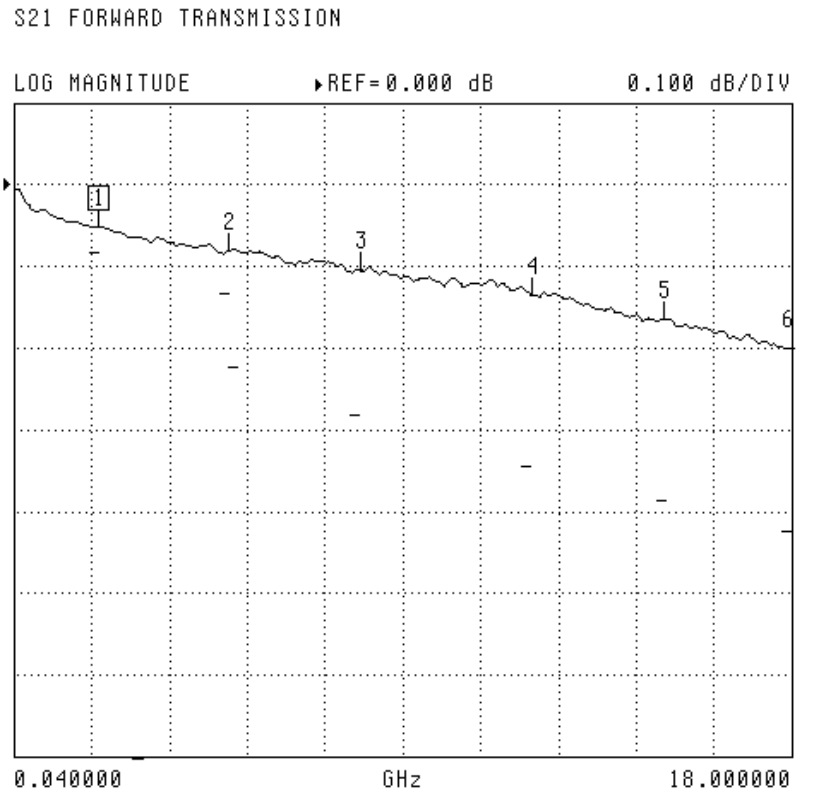
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 5/6

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

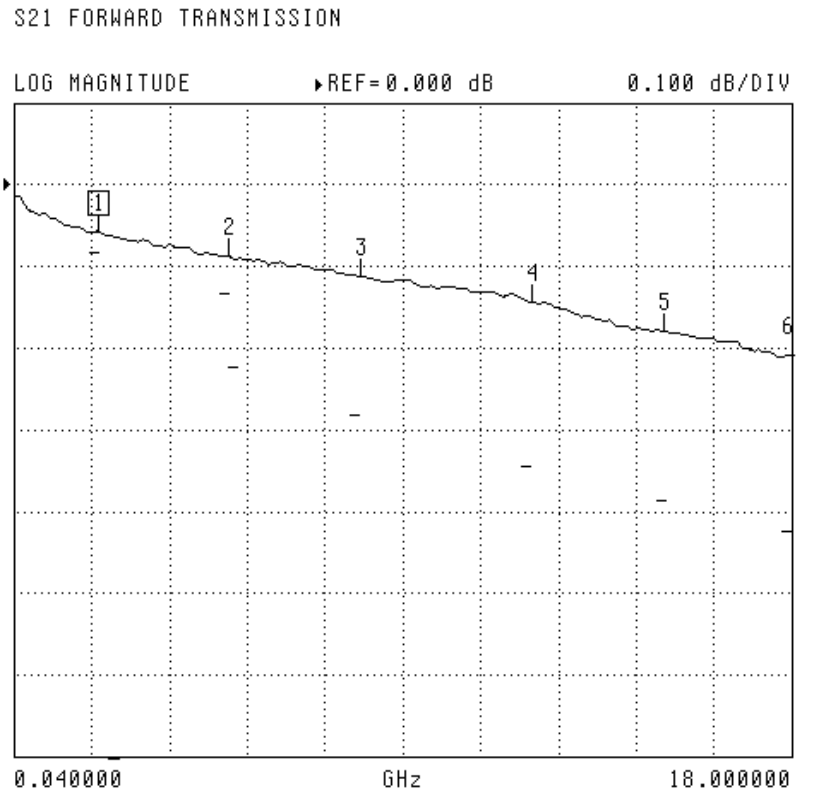
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 7/8

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

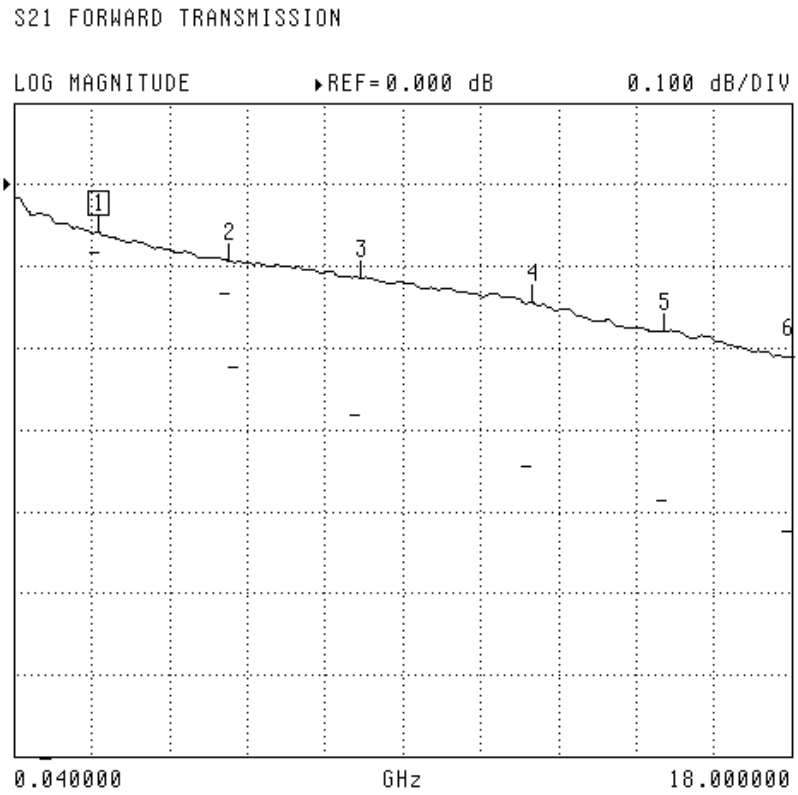
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 9/10

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

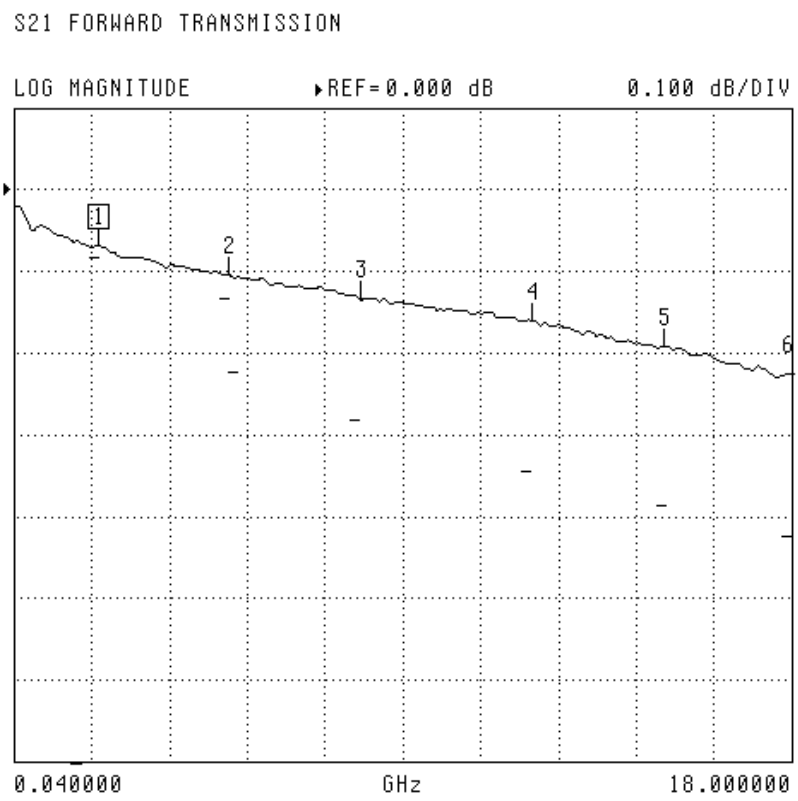
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 11/12

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

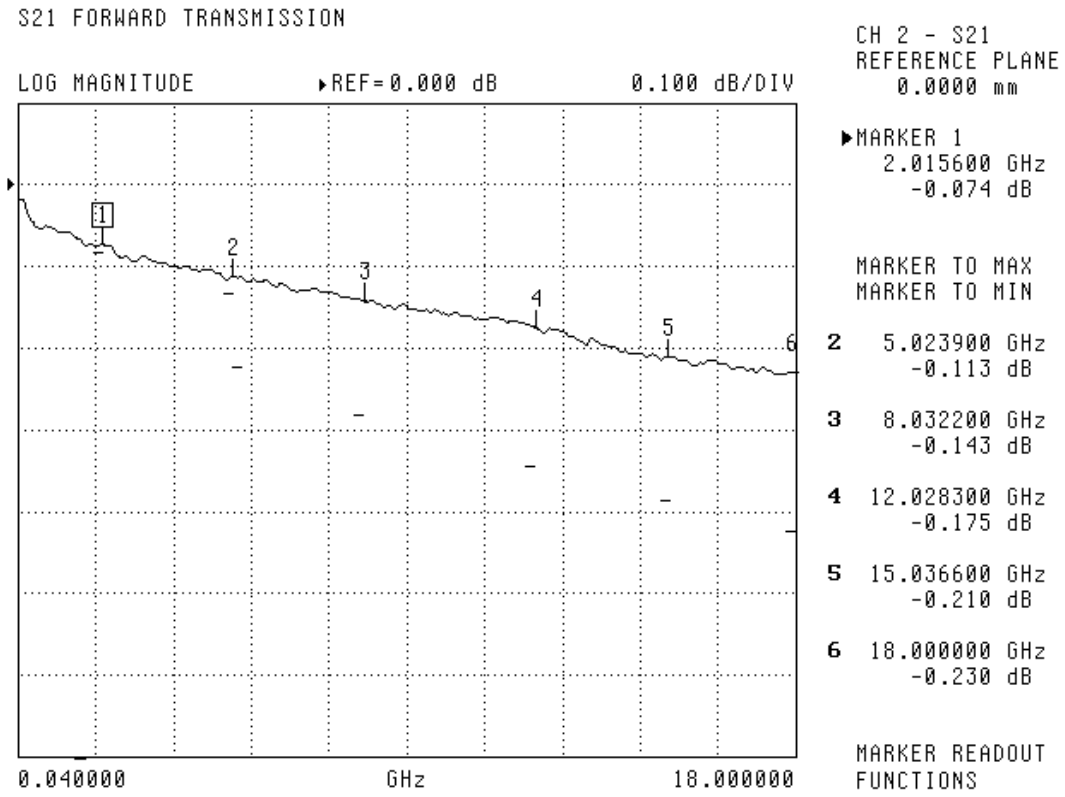
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 13/14

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

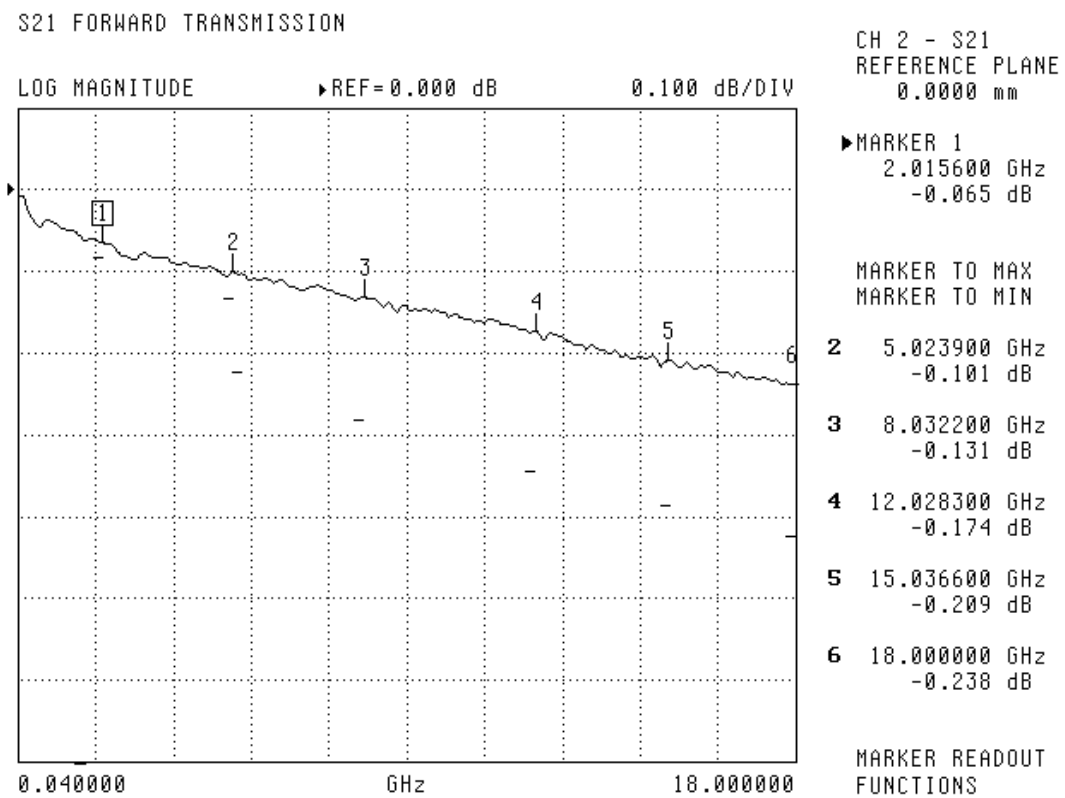
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 15/16

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

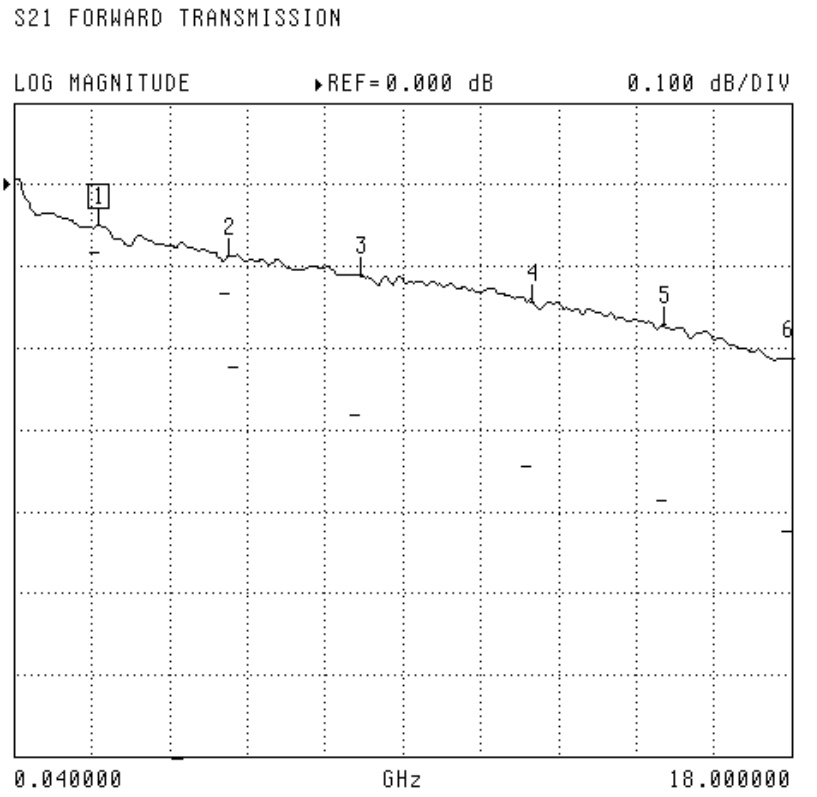
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 17/18

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

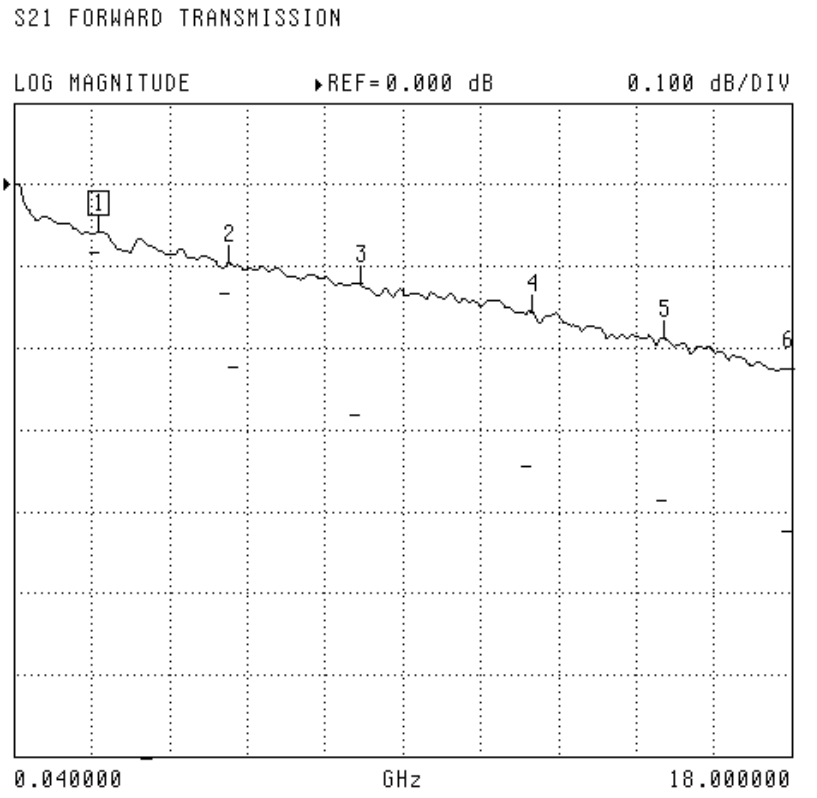
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 19/20

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

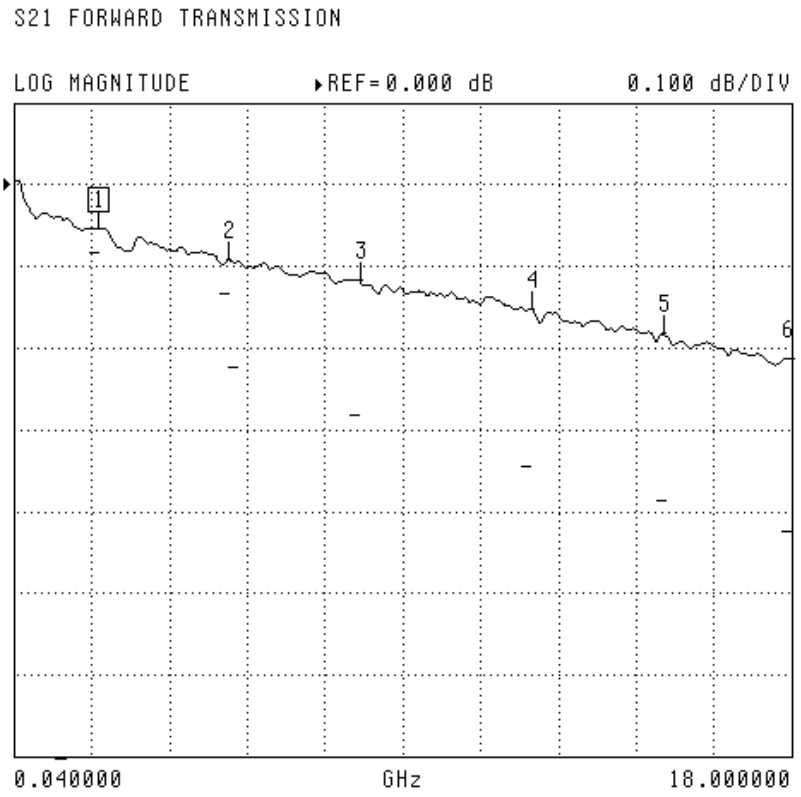
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.054 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.092 dB

3 8.032200 GHz
-0.117 dB

4 12.028300 GHz
-0.153 dB

5 15.036600 GHz
-0.183 dB

6 18.000000 GHz
-0.213 dB

MARKER READOUT
FUNCTIONS

Couple 21/22

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

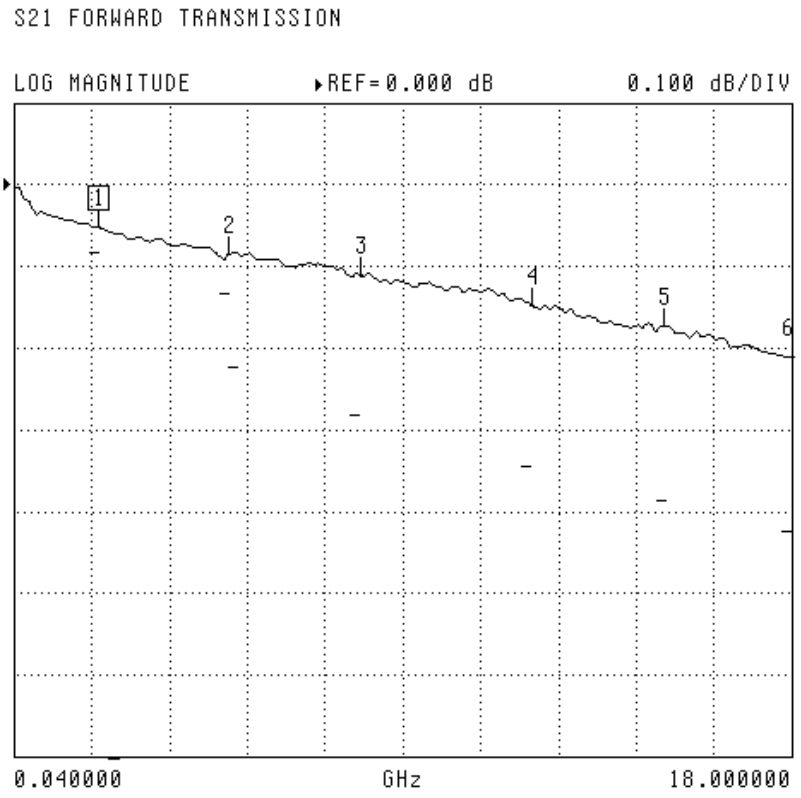
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.052 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.086 dB

3 8.032200 GHz
-0.111 dB

4 12.028300 GHz
-0.148 dB

5 15.036600 GHz
-0.173 dB

6 18.000000 GHz
-0.212 dB

MARKER READOUT
FUNCTIONS

Couple 23/24

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

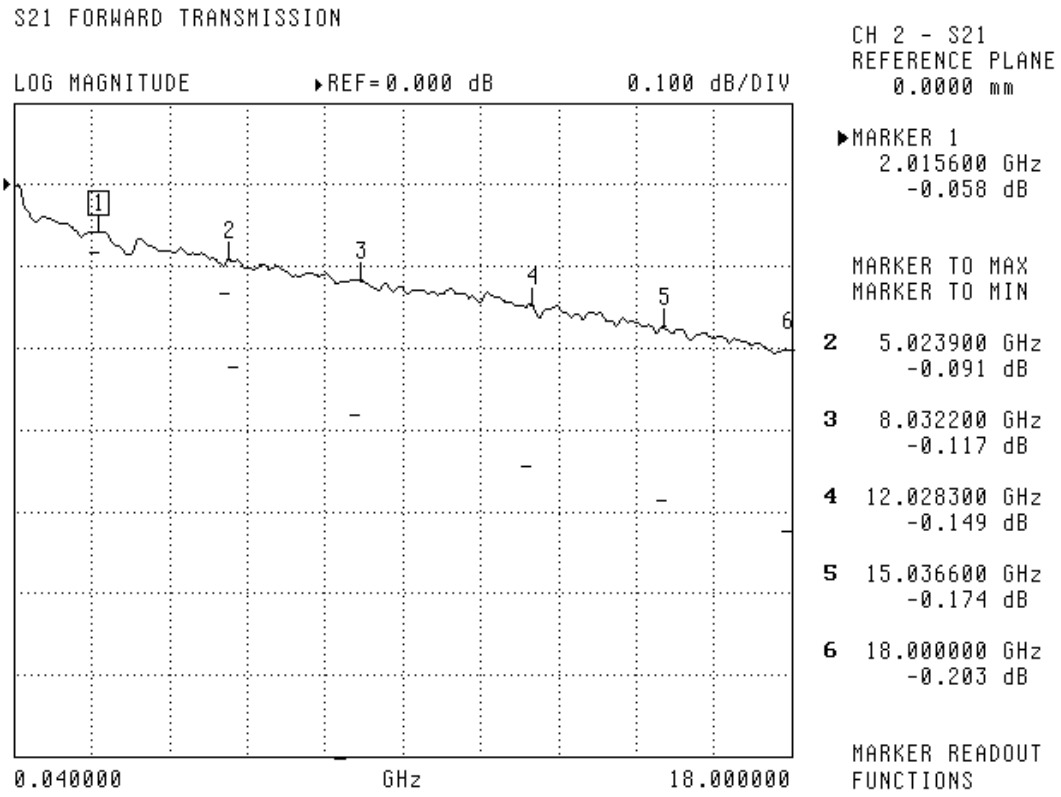
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 25/26

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

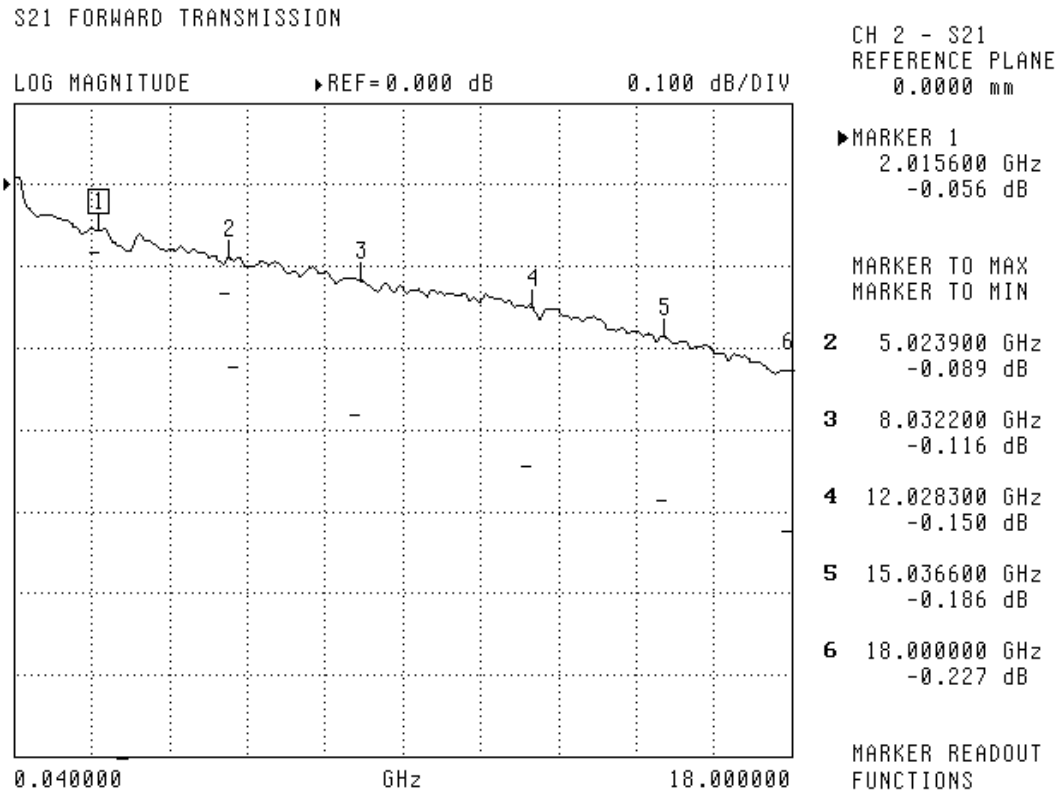
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 27/28

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

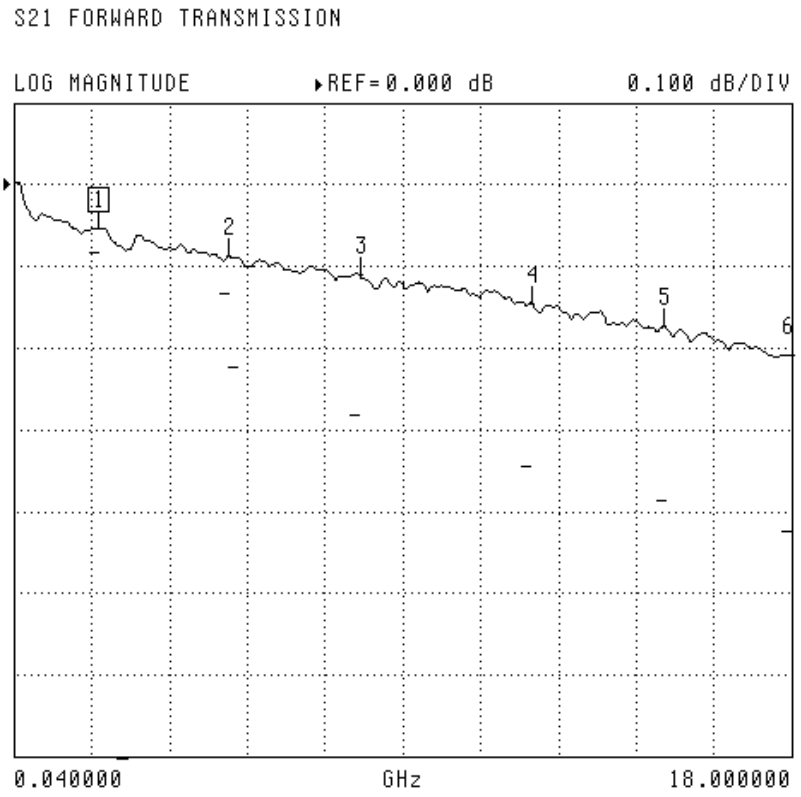
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 29/30

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

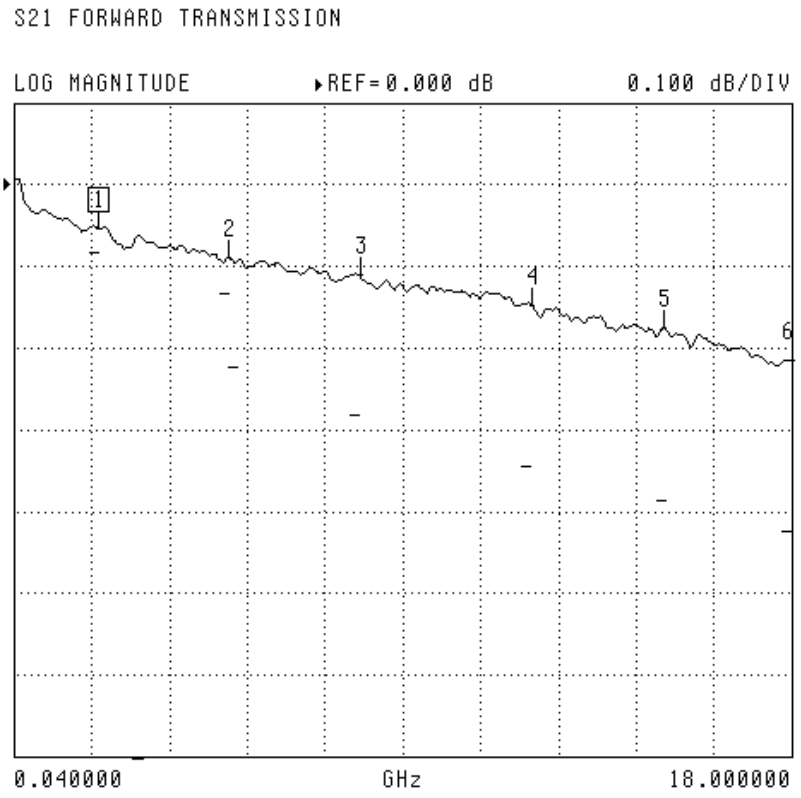
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 31/32

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

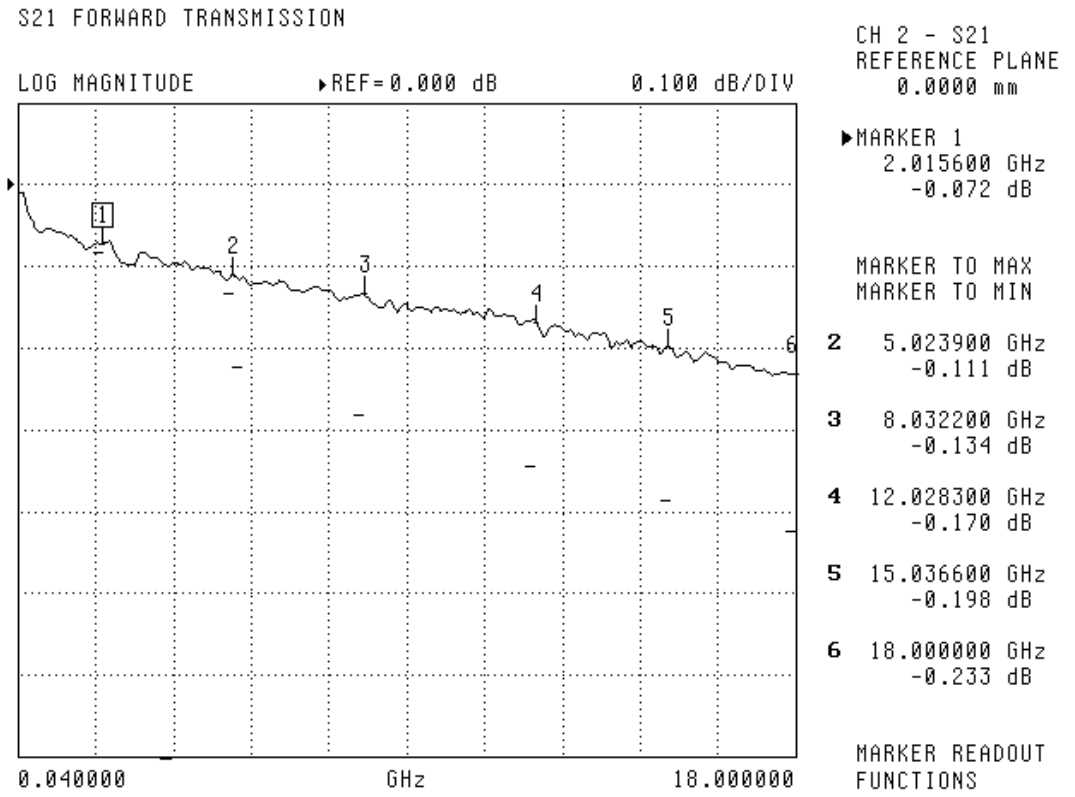
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 33/34

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

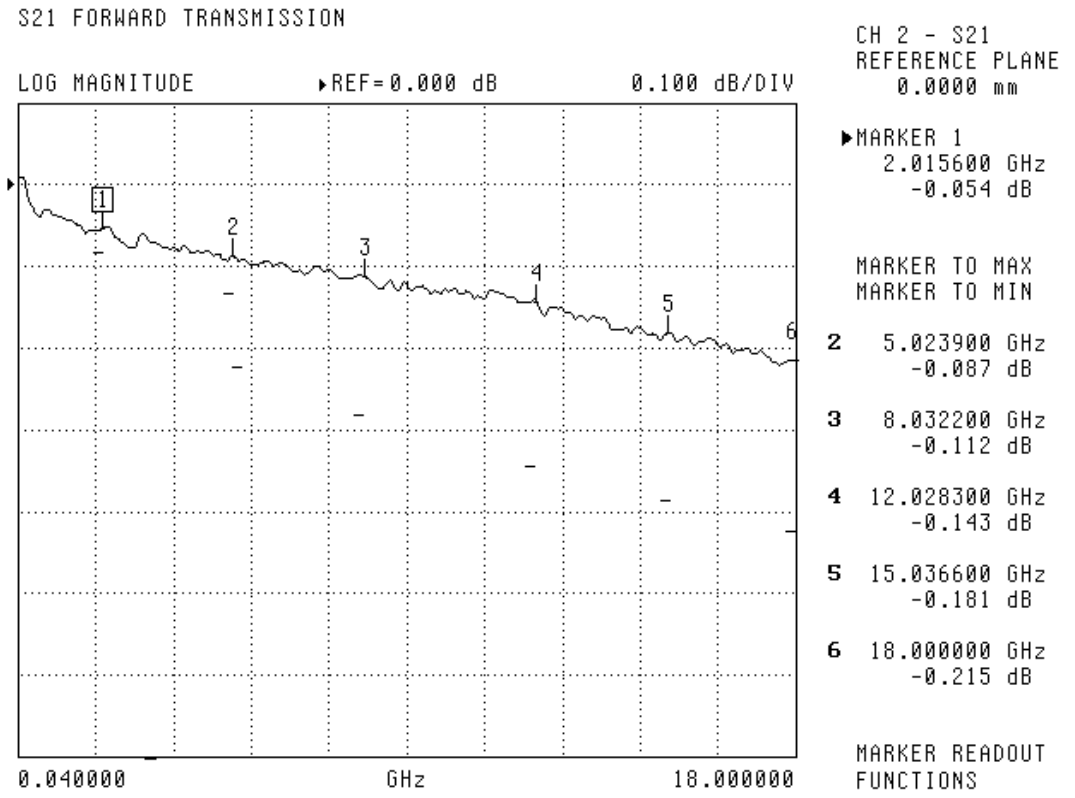
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 35/95

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

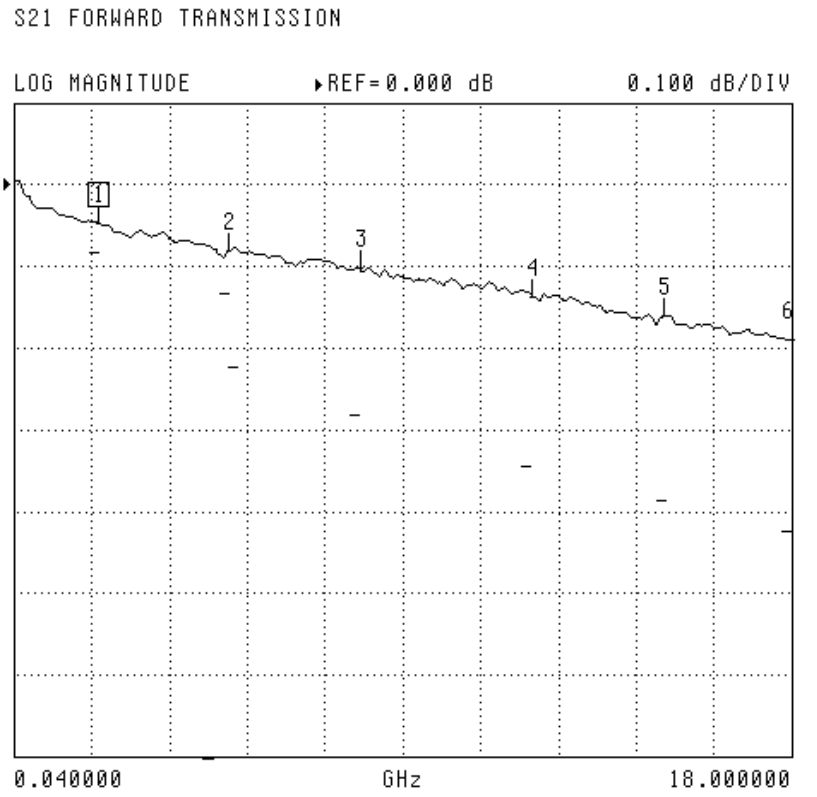
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 96/97

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

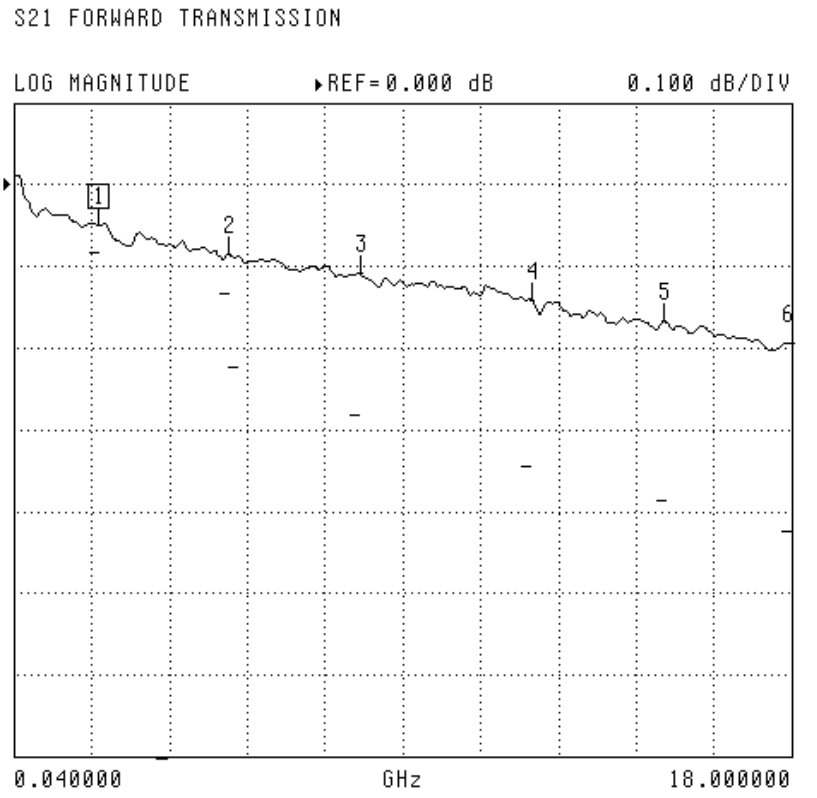
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 98/99

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

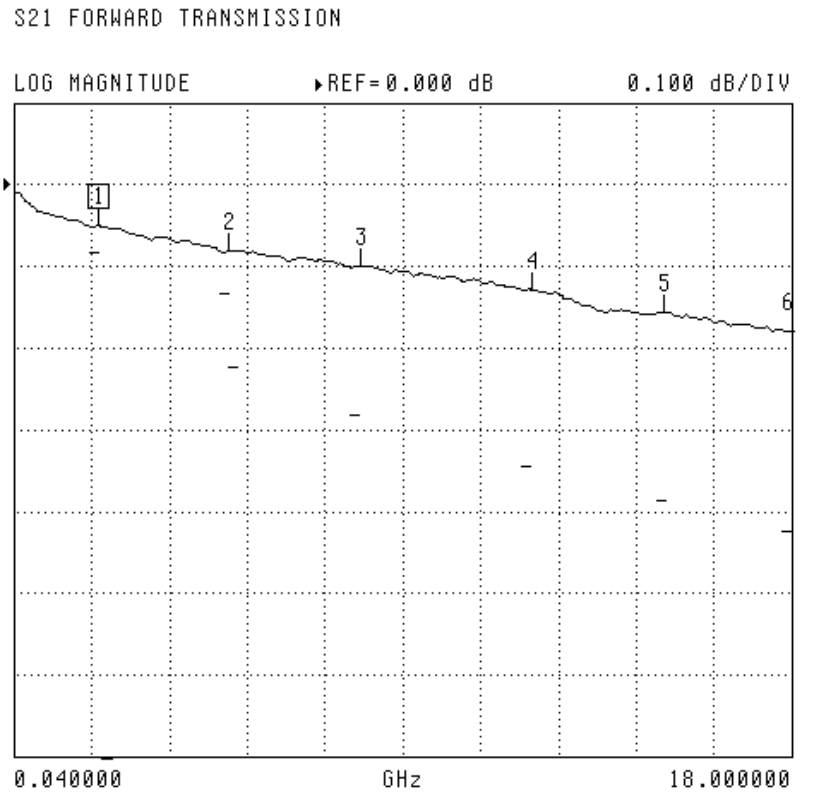
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 100/101

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

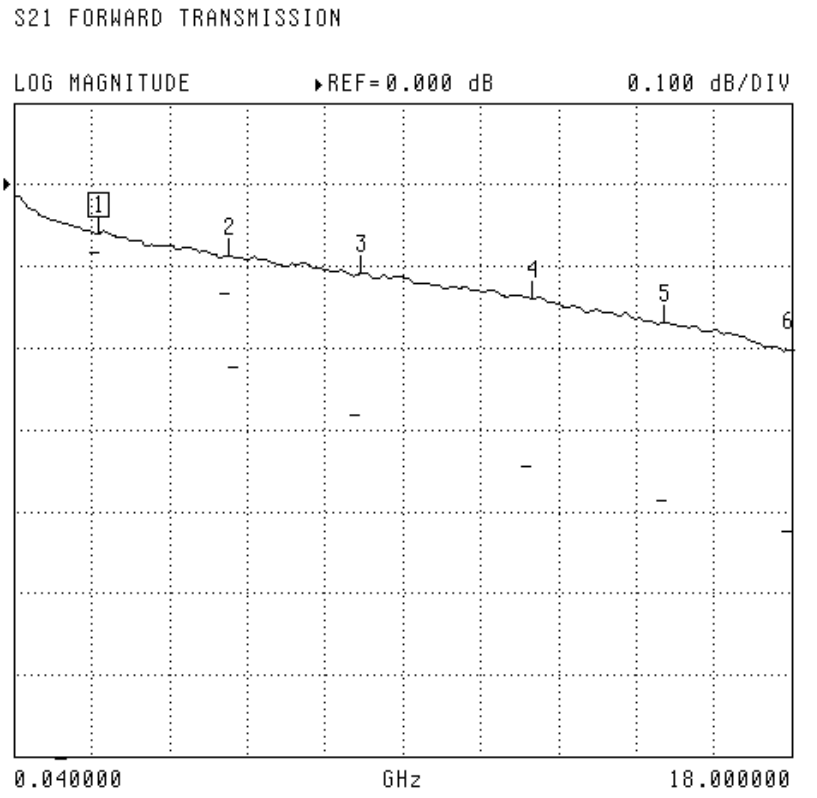
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 102/103

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

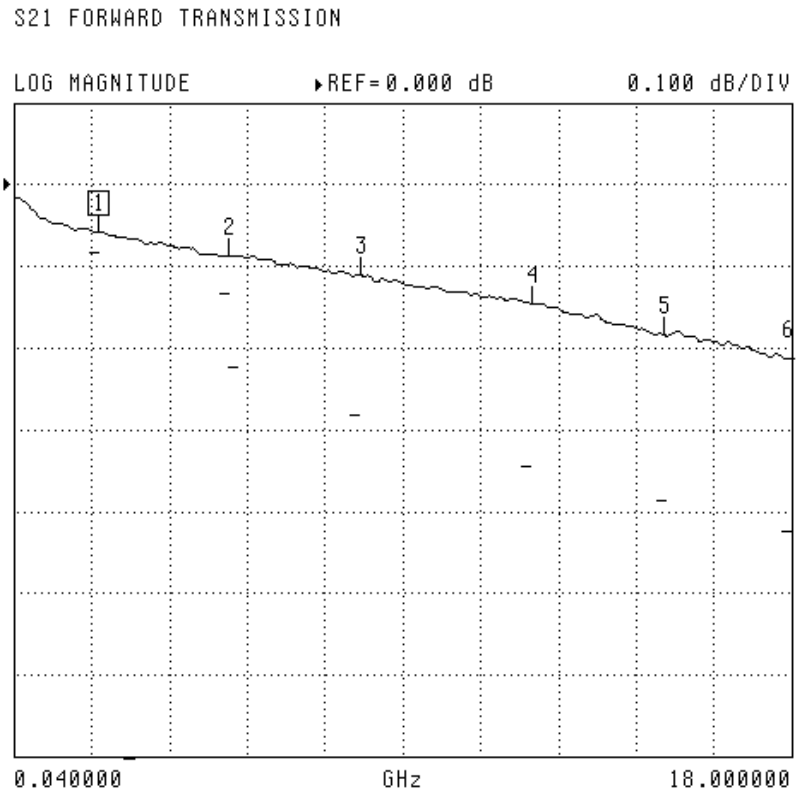
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.058 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.087 dB

3 8.032200 GHz
-0.110 dB

4 12.028300 GHz
-0.147 dB

5 15.036600 GHz
-0.183 dB

6 18.000000 GHz
-0.212 dB

MARKER READOUT
FUNCTIONS

Couple 104/105

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

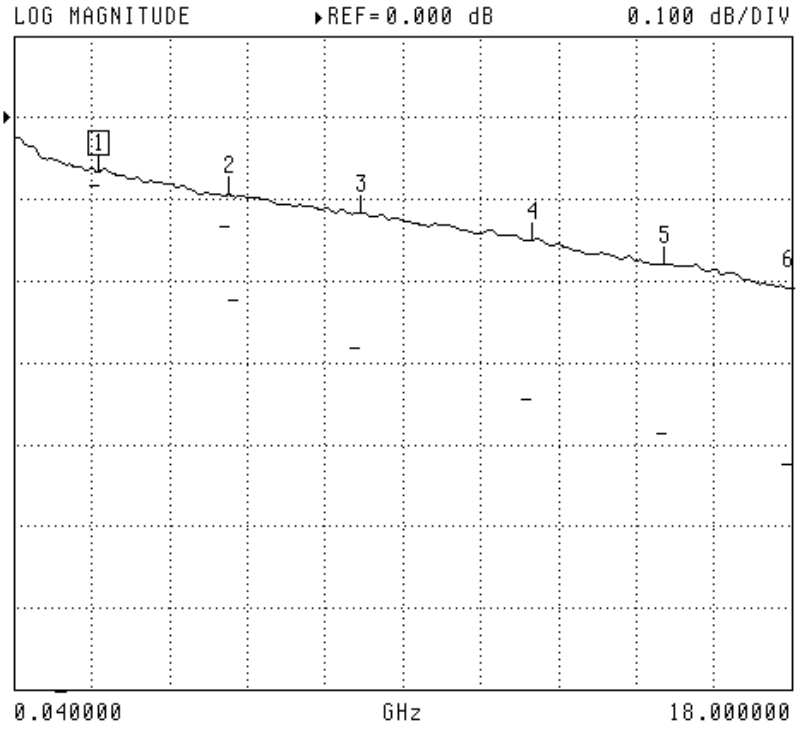
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



CH 2 - S21
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
-0.067 dB

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
-0.094 dB

3 8.032200 GHz
-0.116 dB

4 12.028300 GHz
-0.150 dB

5 15.036600 GHz
-0.179 dB

6 18.000000 GHz
-0.208 dB

MARKER READOUT
FUNCTIONS

Couple 106/107

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

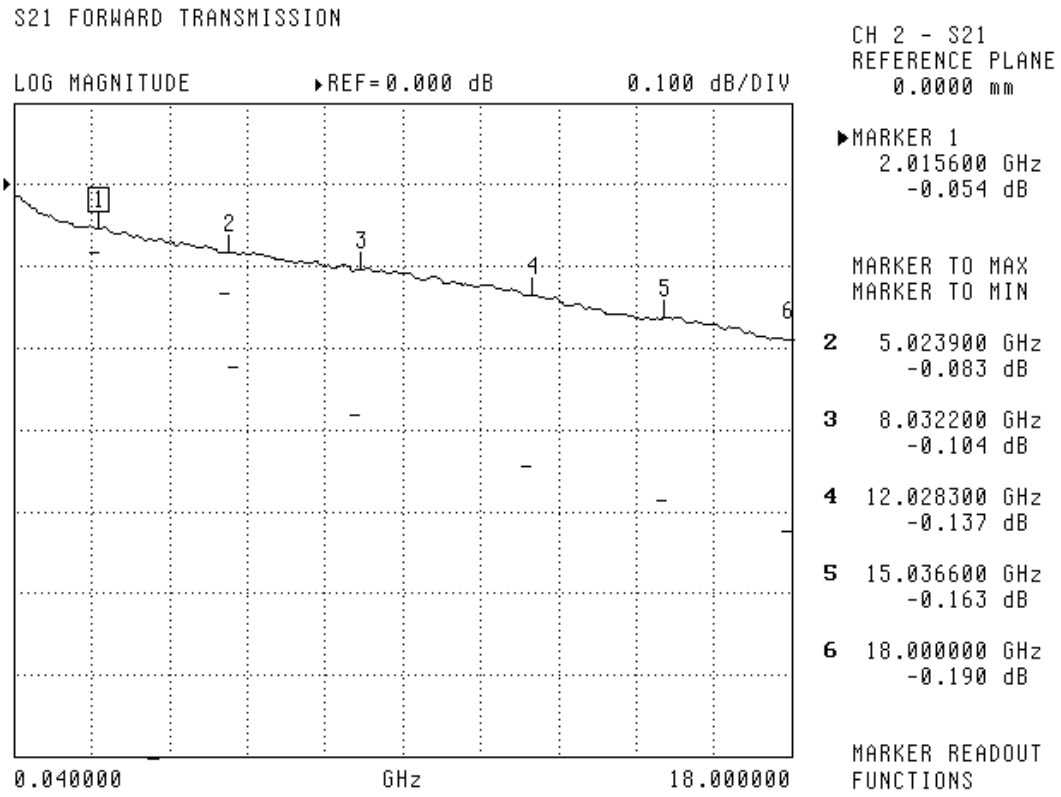
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 108/109

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

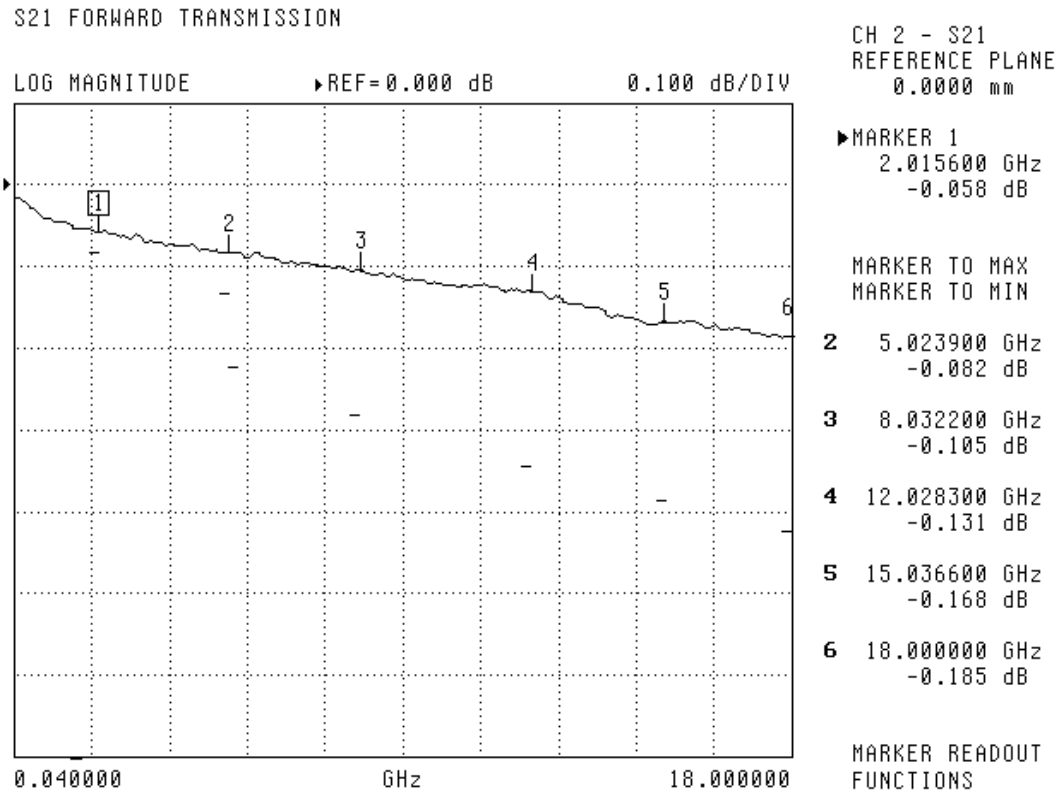
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 110/111

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

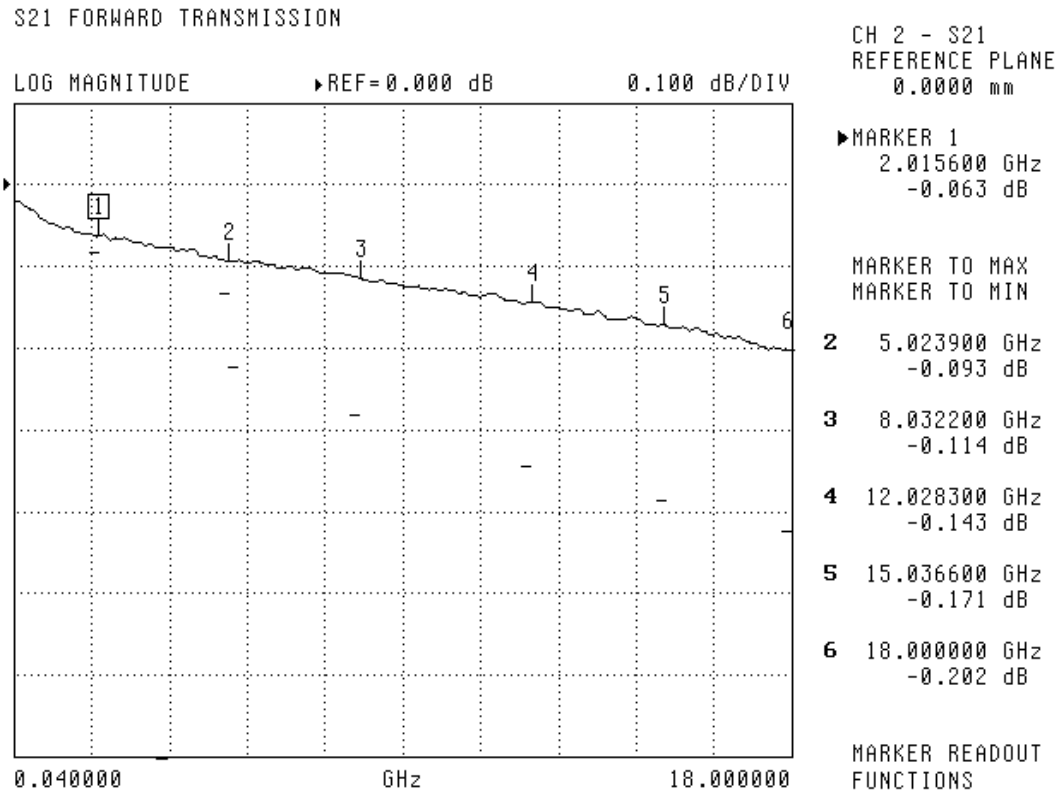
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 112/113

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

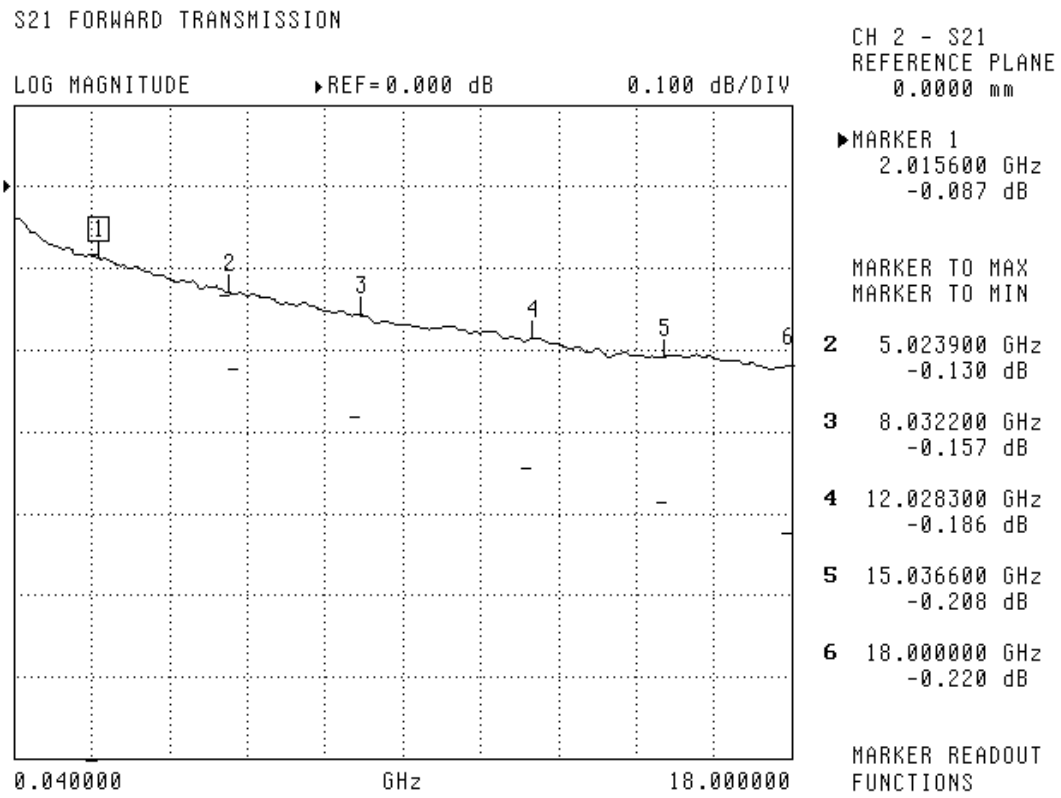
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 114/115

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

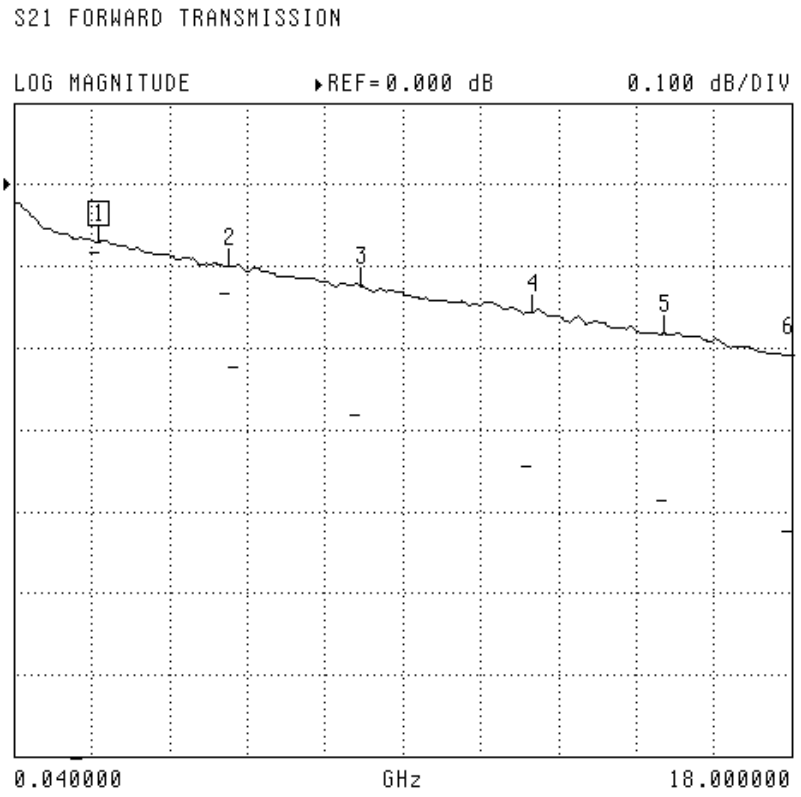
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 116/117

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

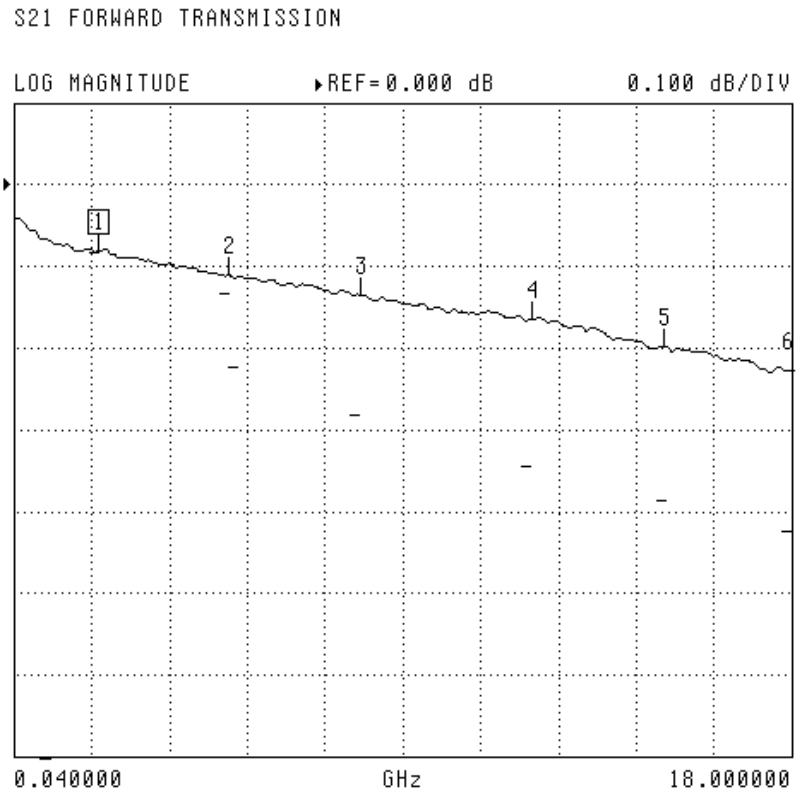
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / Insertion loss back to back / High temperature +100°C 09/02/2006



Couple 118/119

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

Reference plane : 0mm

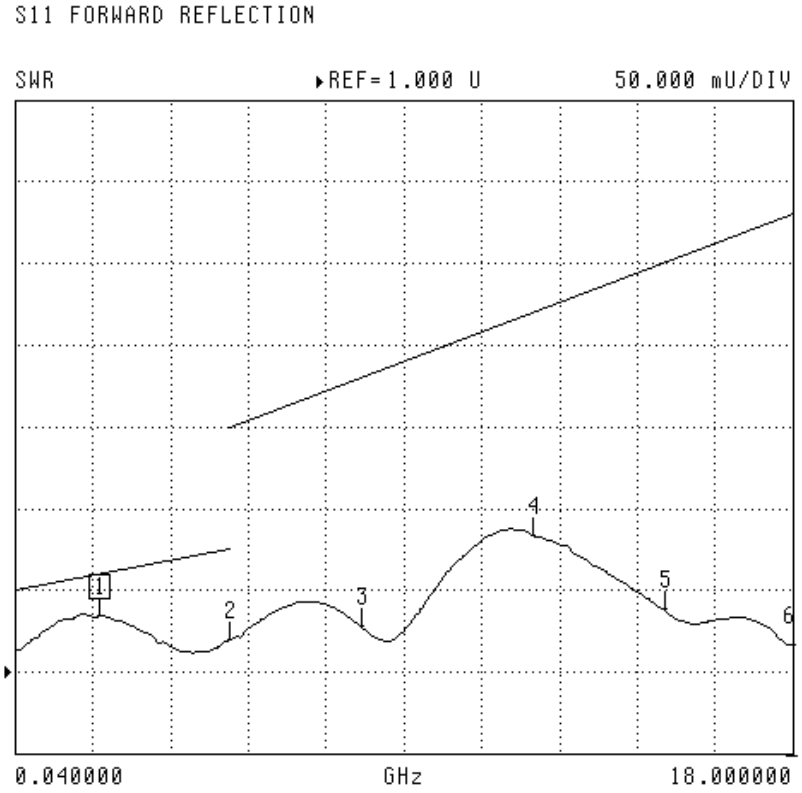
IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

V.S.W.R. graphs.

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006



Sample 1

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

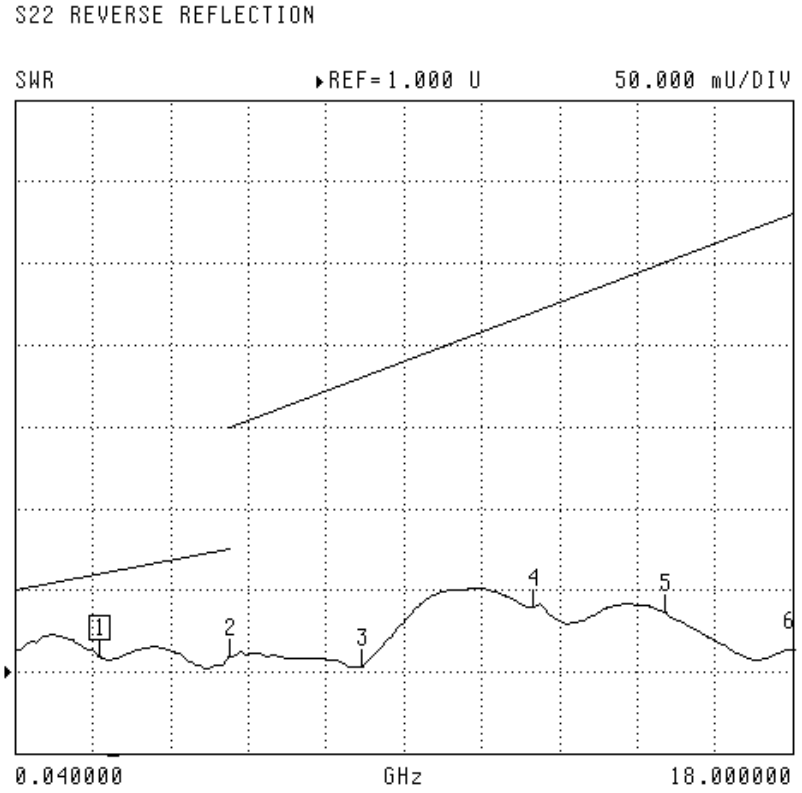
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006



Sample 2

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

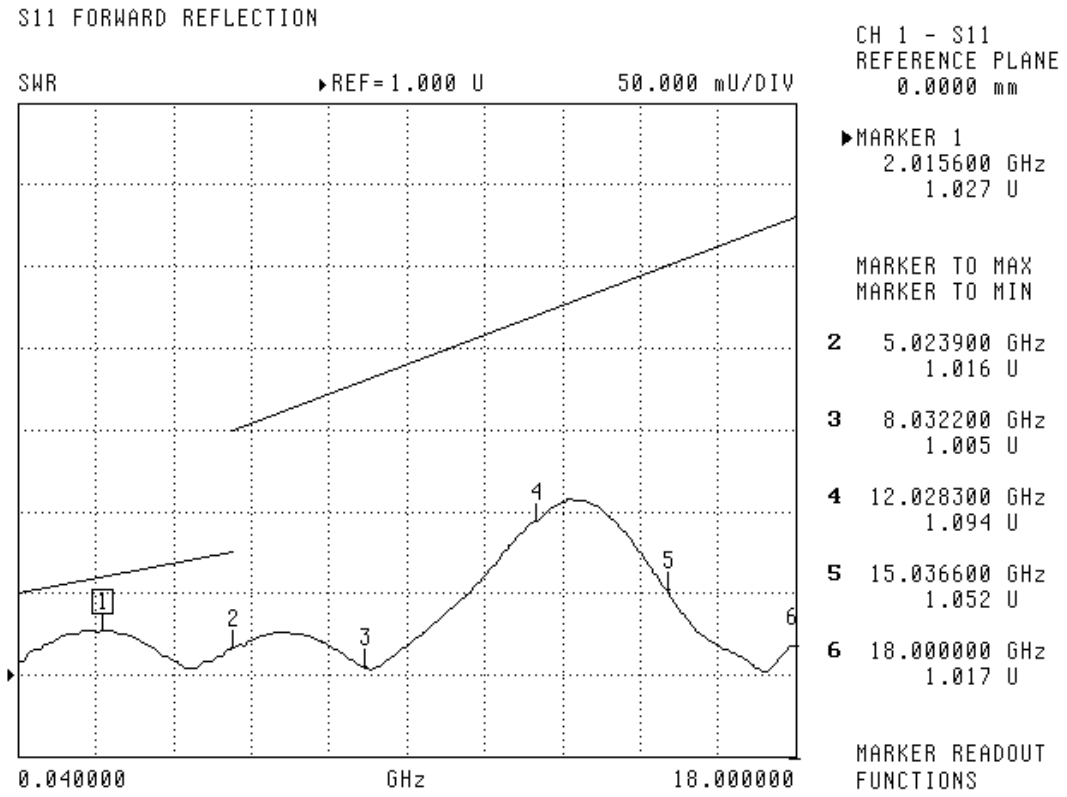
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006



Sample 3

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

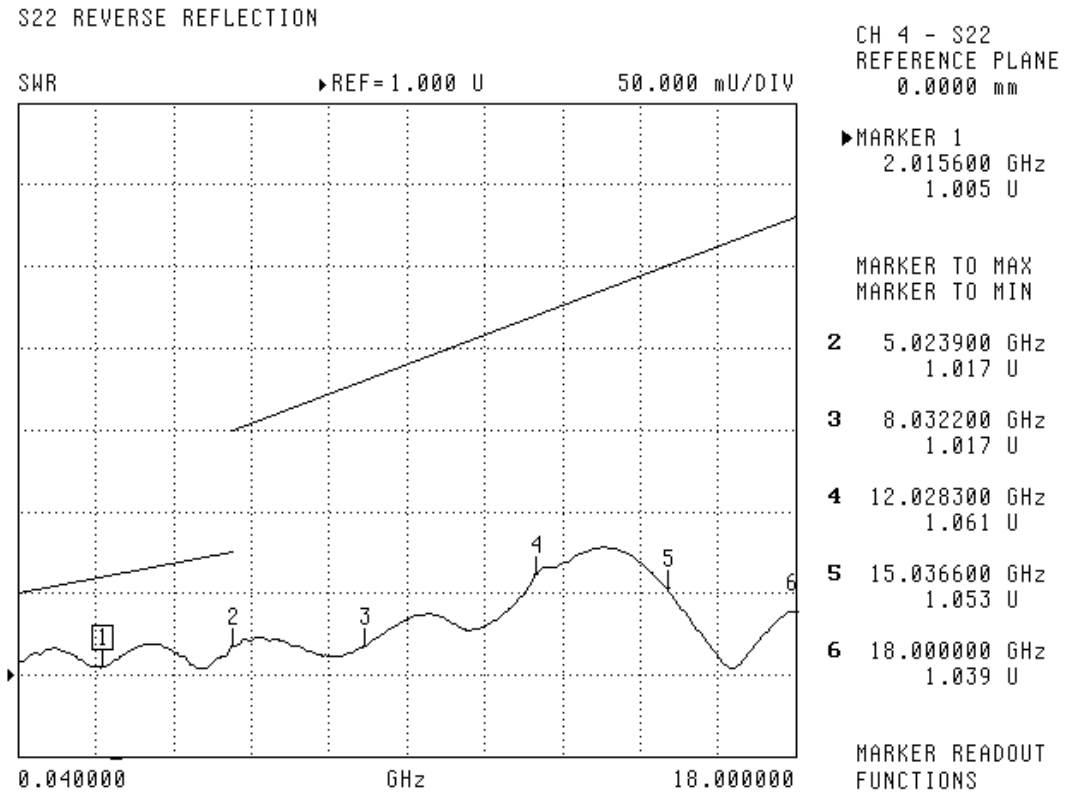
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006



Sample 4

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

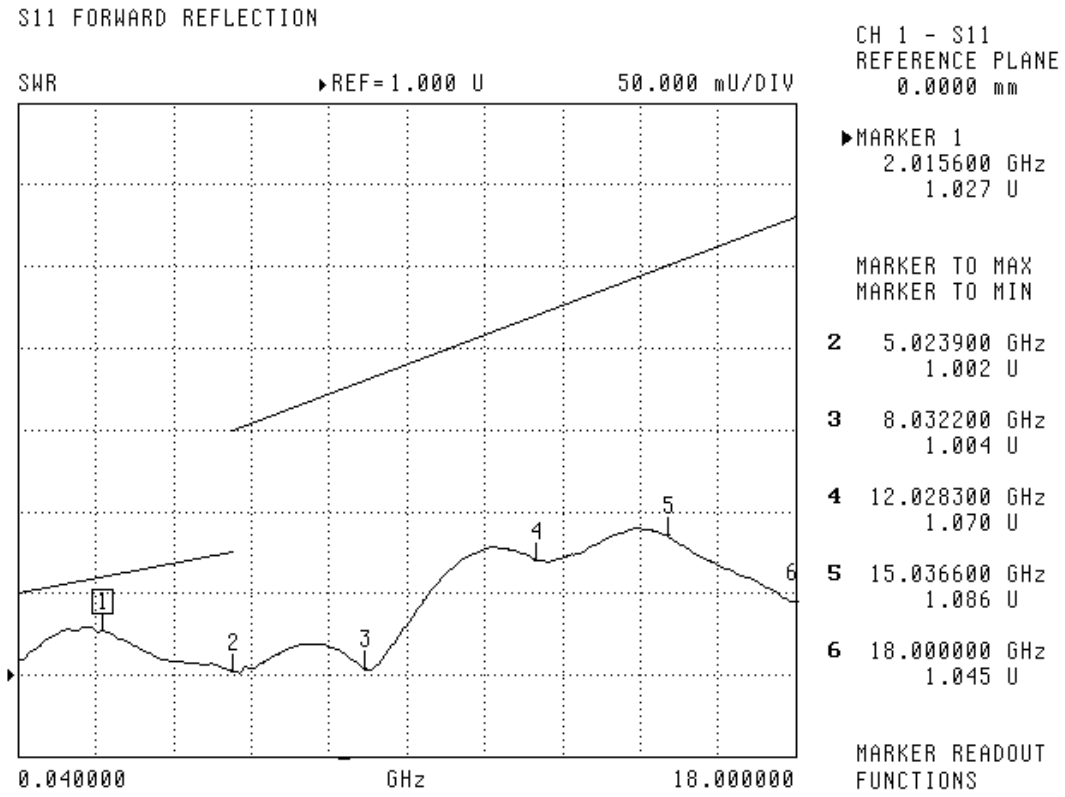
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006



Sample 5

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

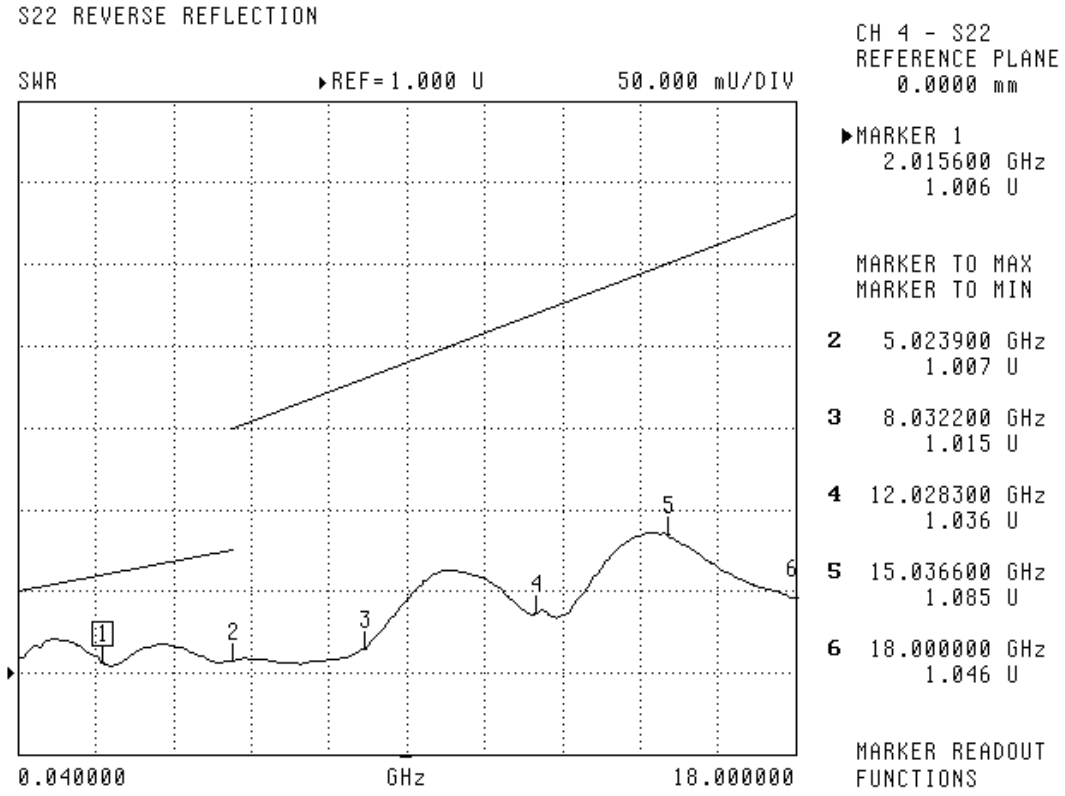
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006



Sample 6

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

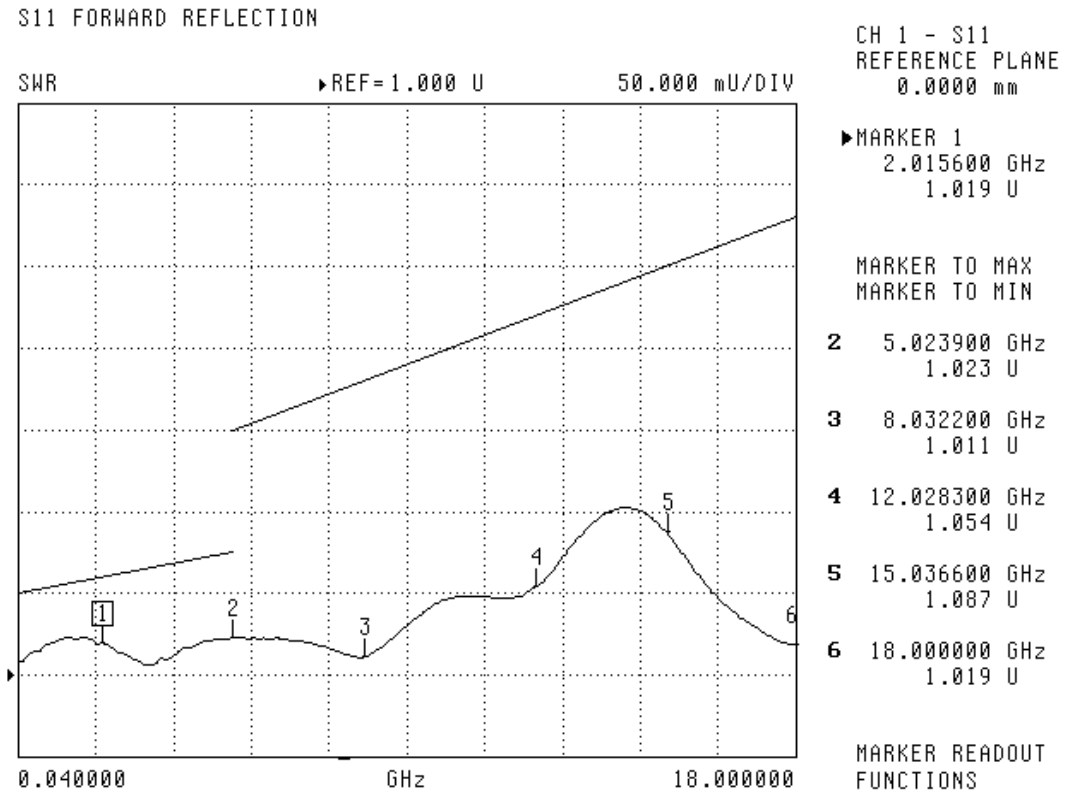
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006



Sample 7

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

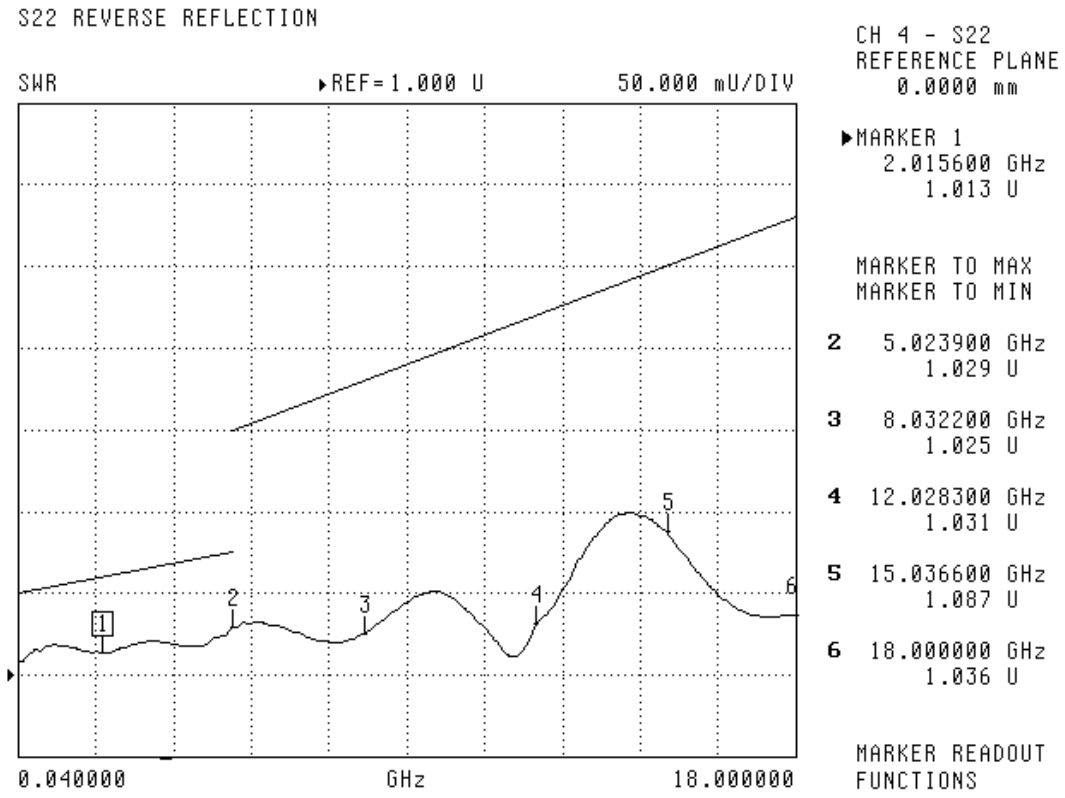
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006



Sample 8

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

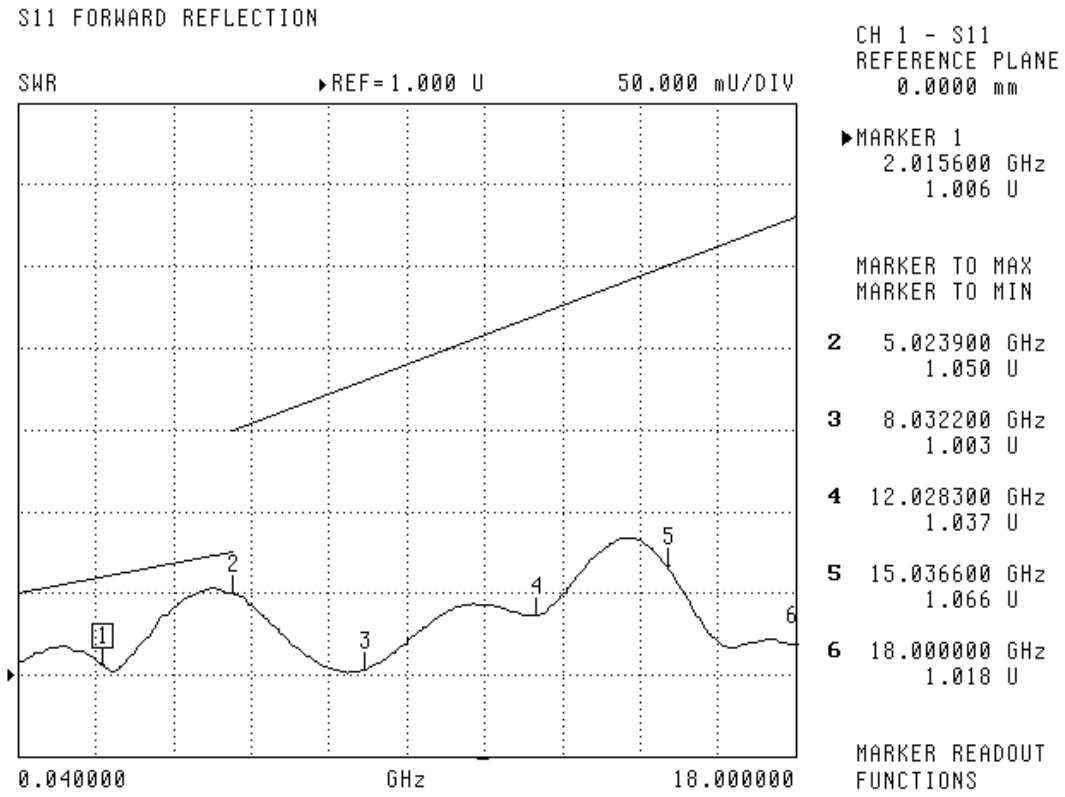
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

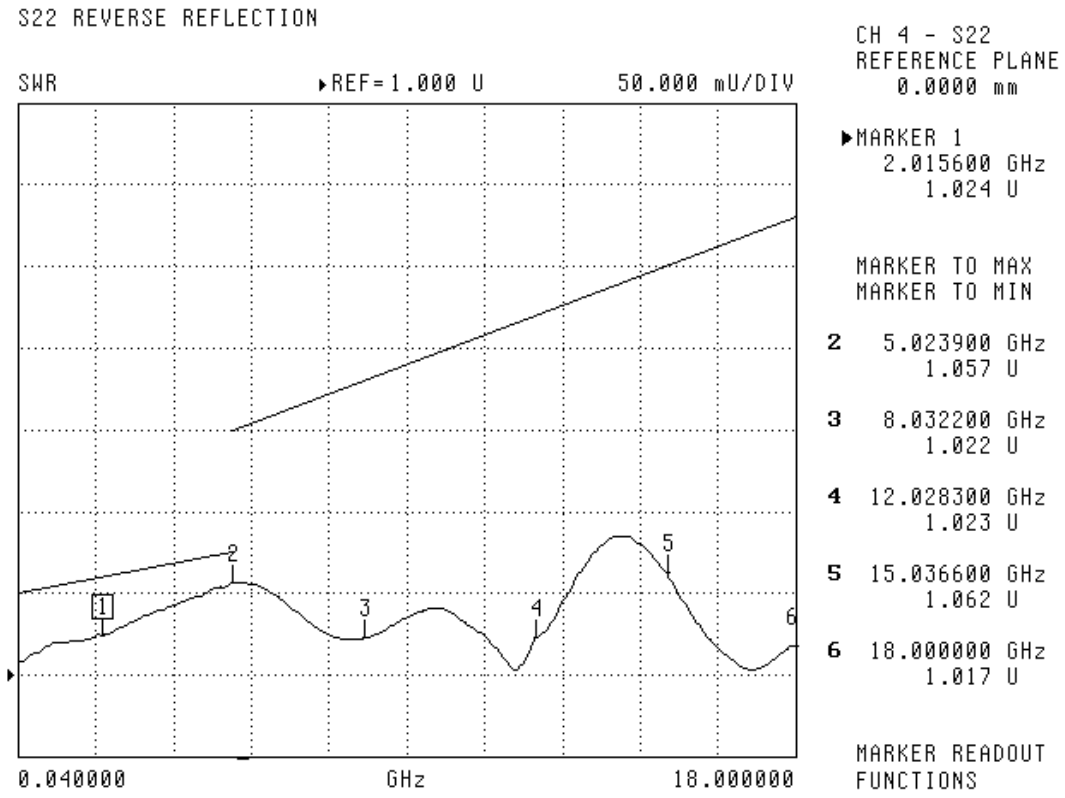


Sample 9

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

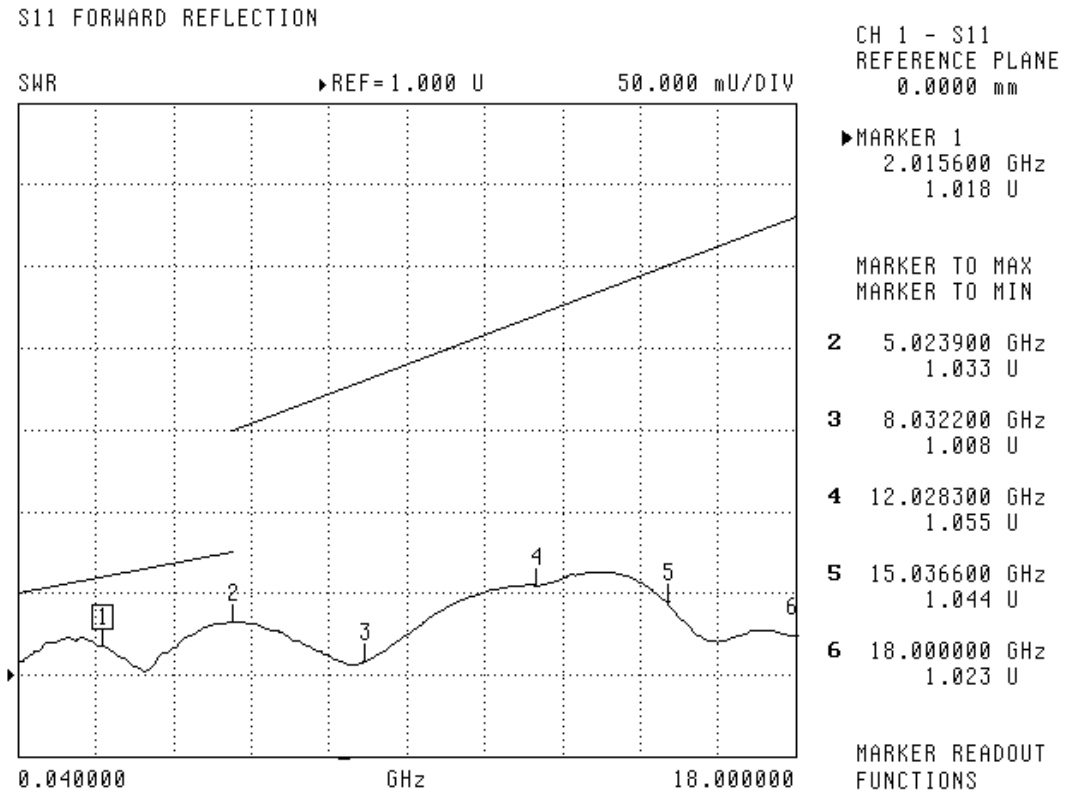


Sample 10

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

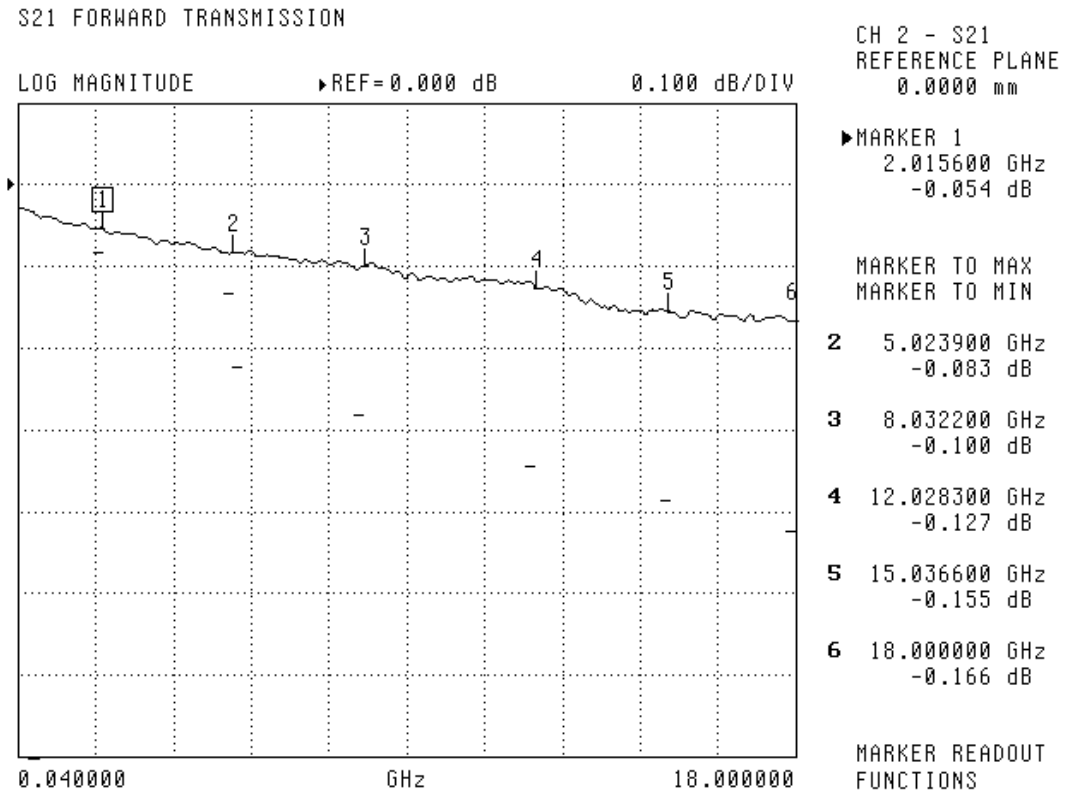


Sample 11

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

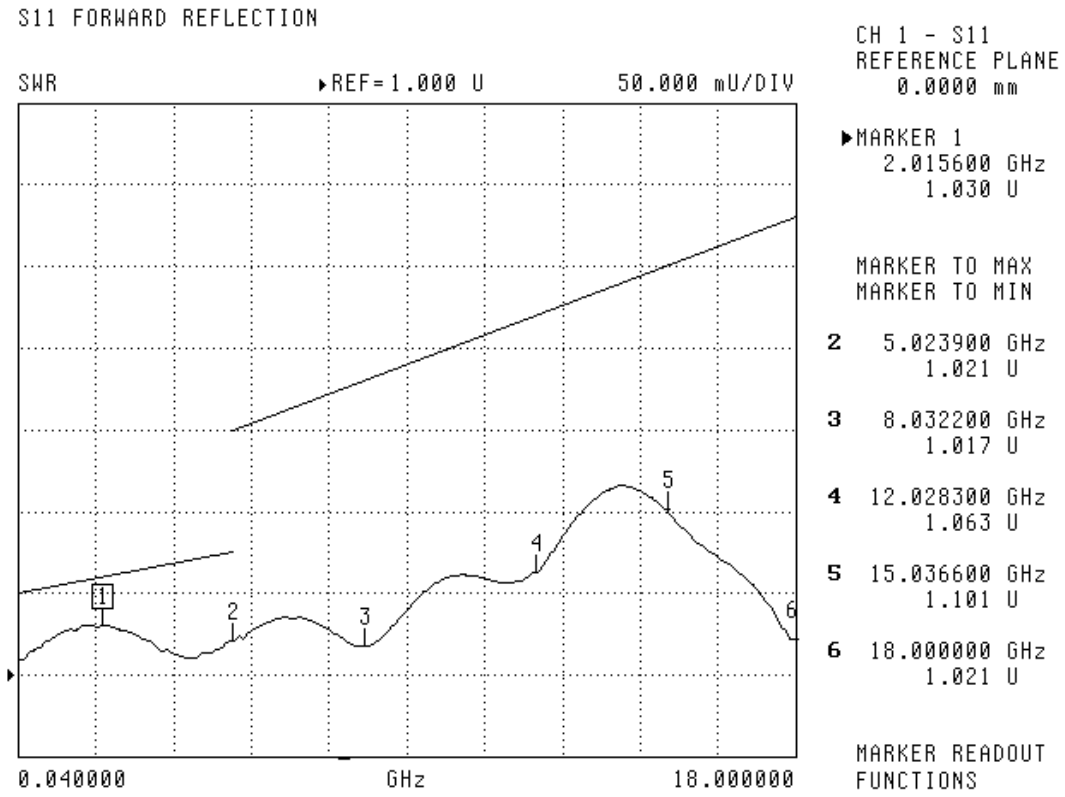


Sample 12

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

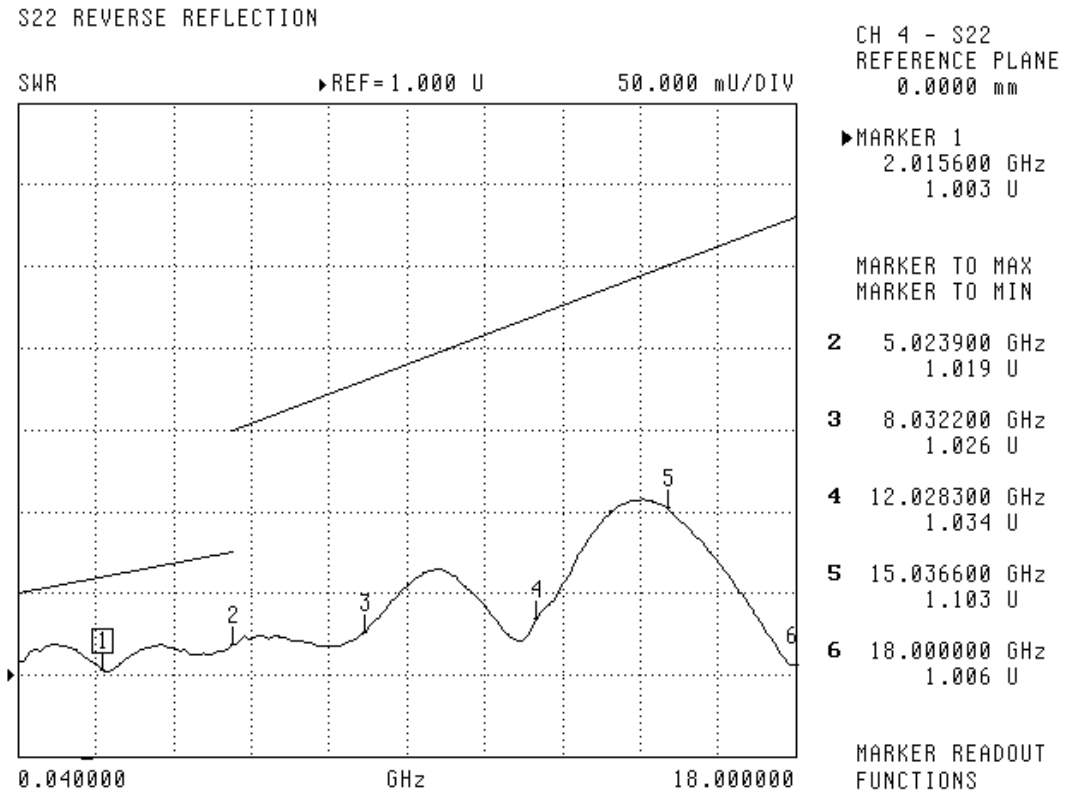


Sample 13

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

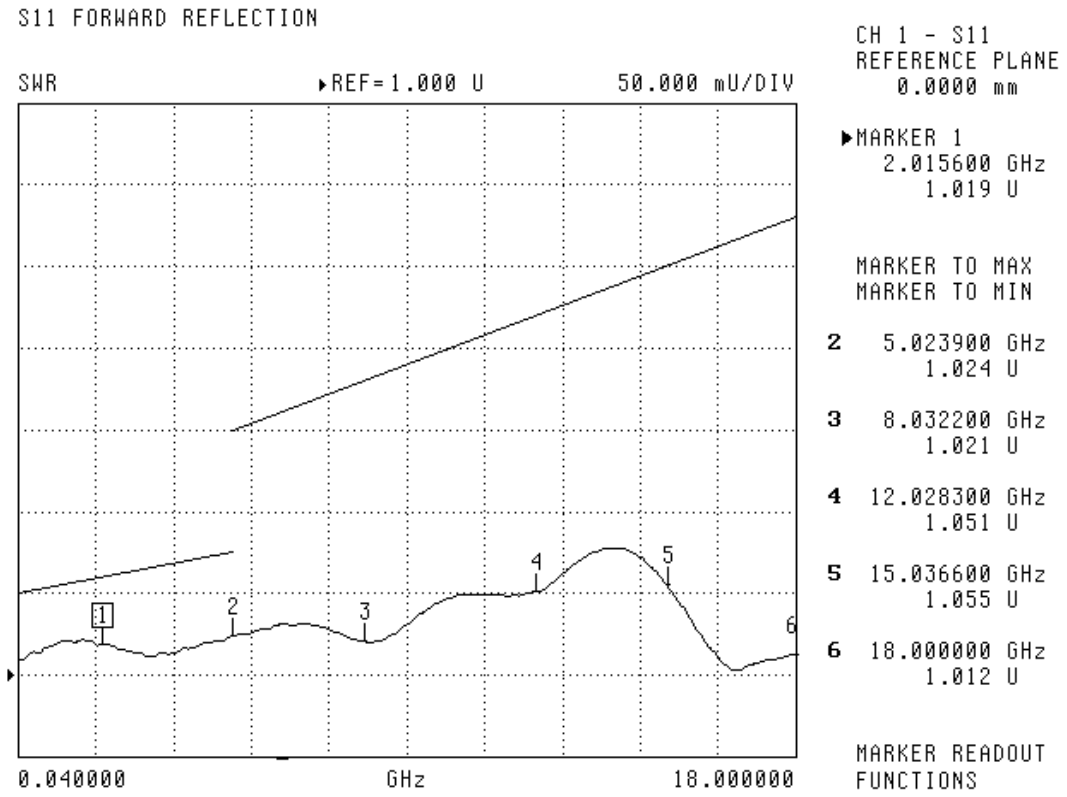


Sample 14

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006



Sample 15

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

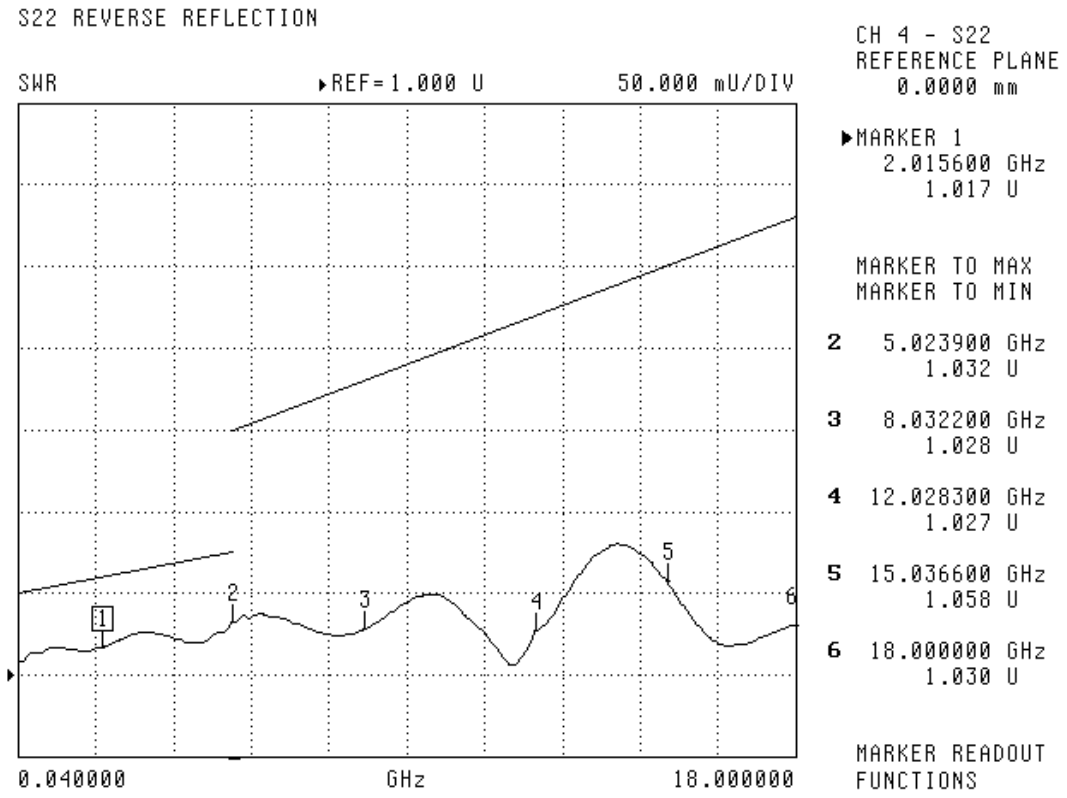
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006



Sample 16

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

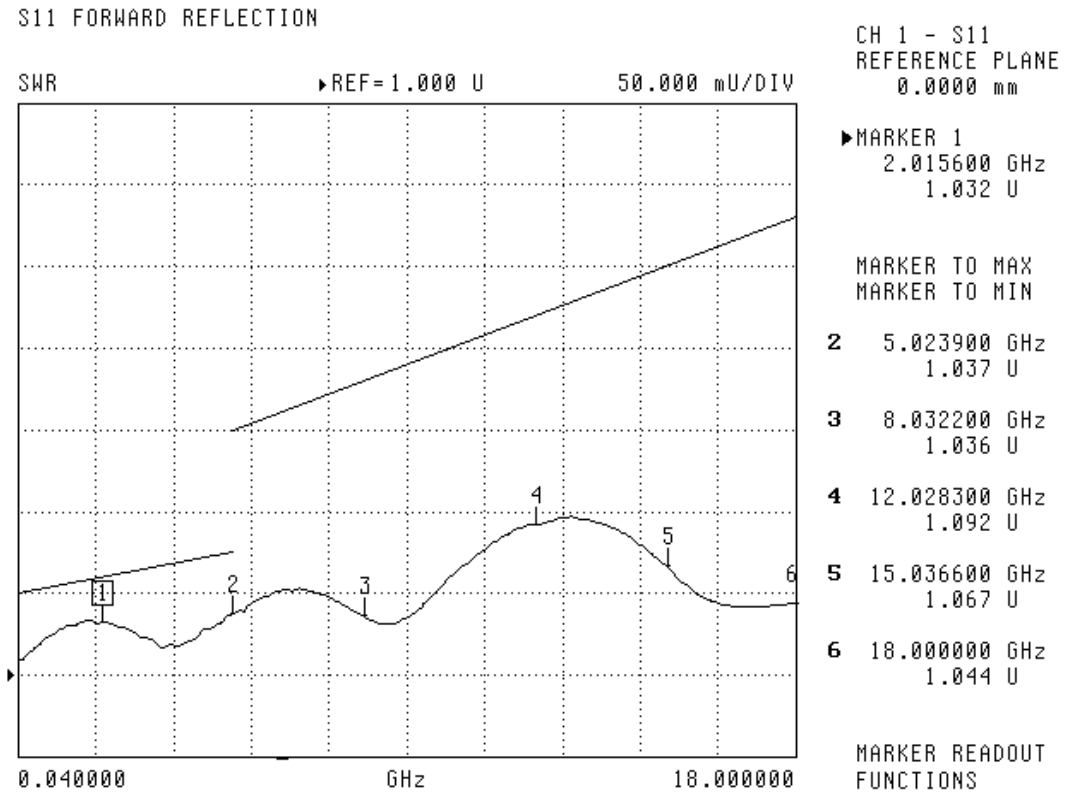
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

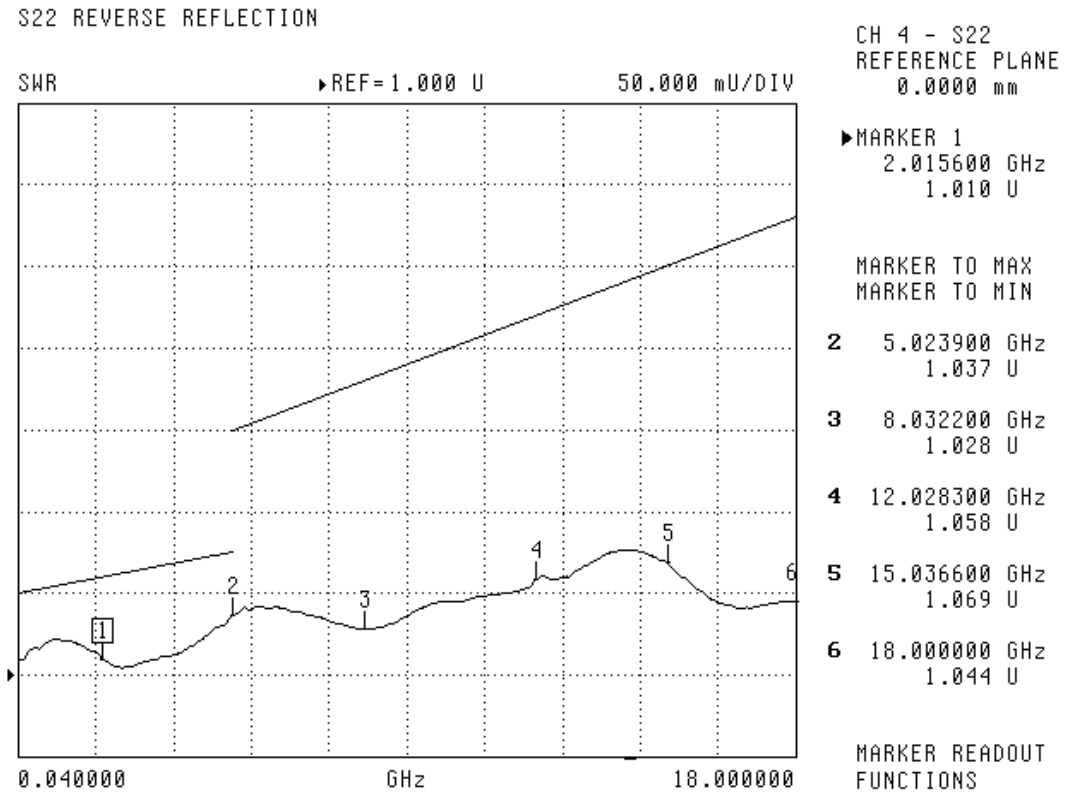


Sample 17

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

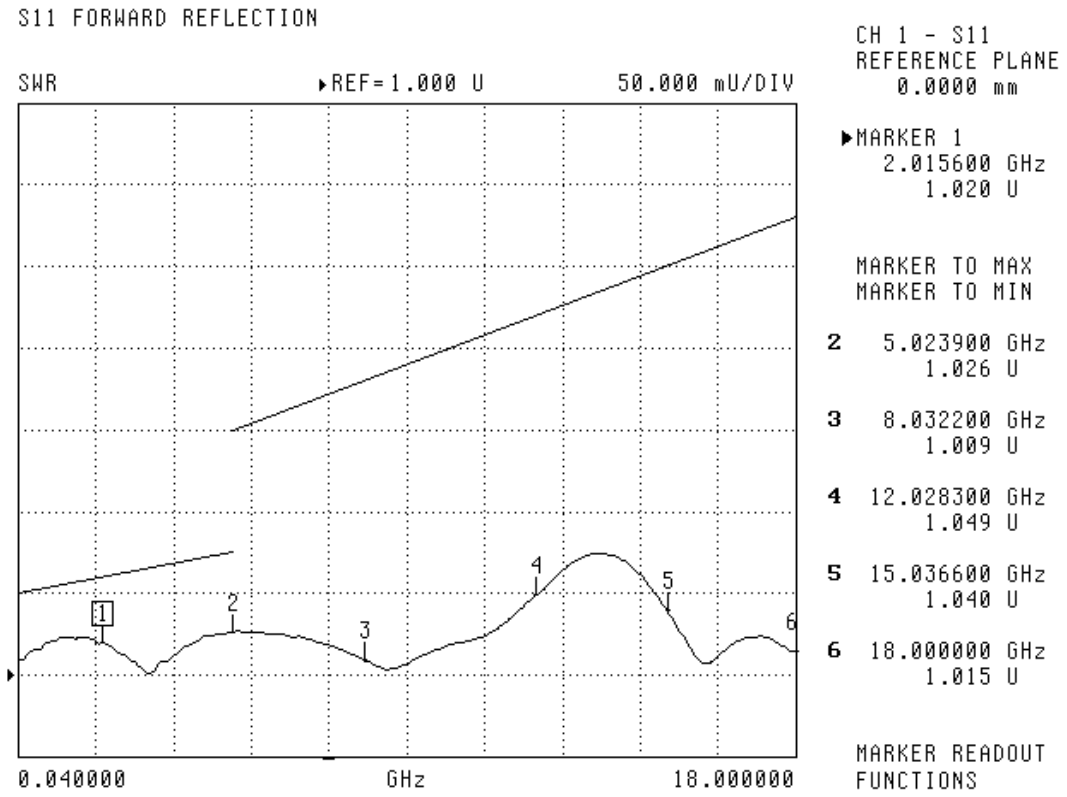


Sample 18

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

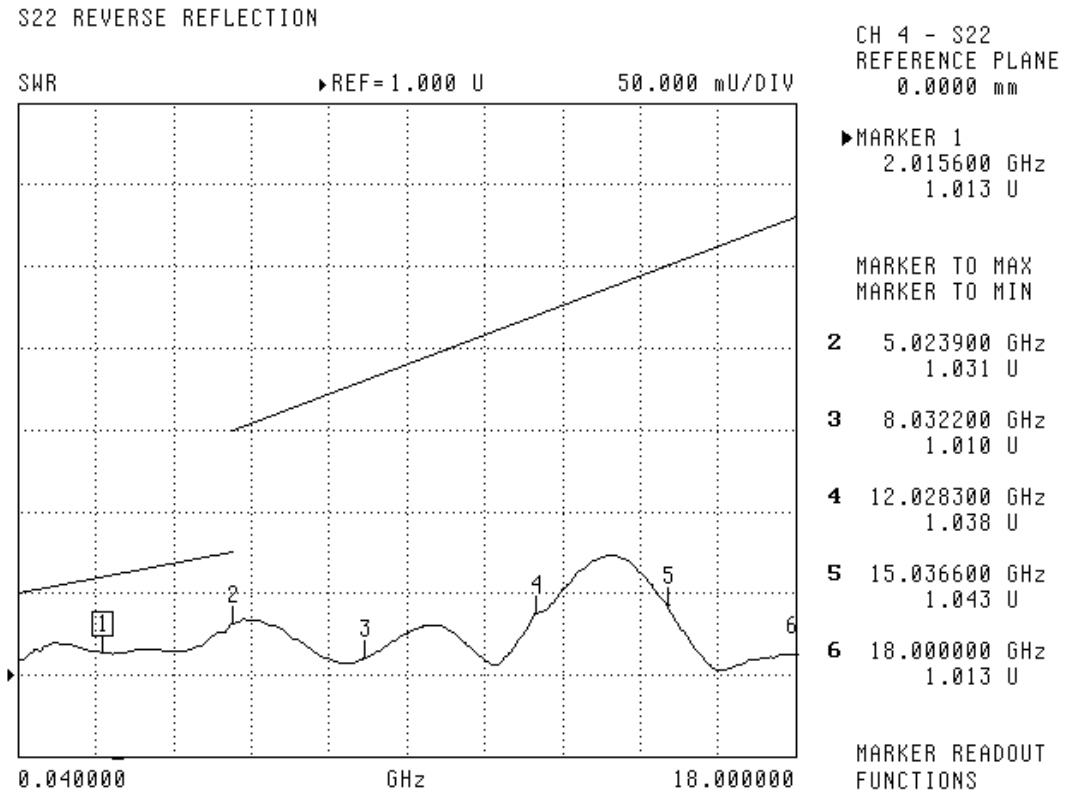


Sample 19

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

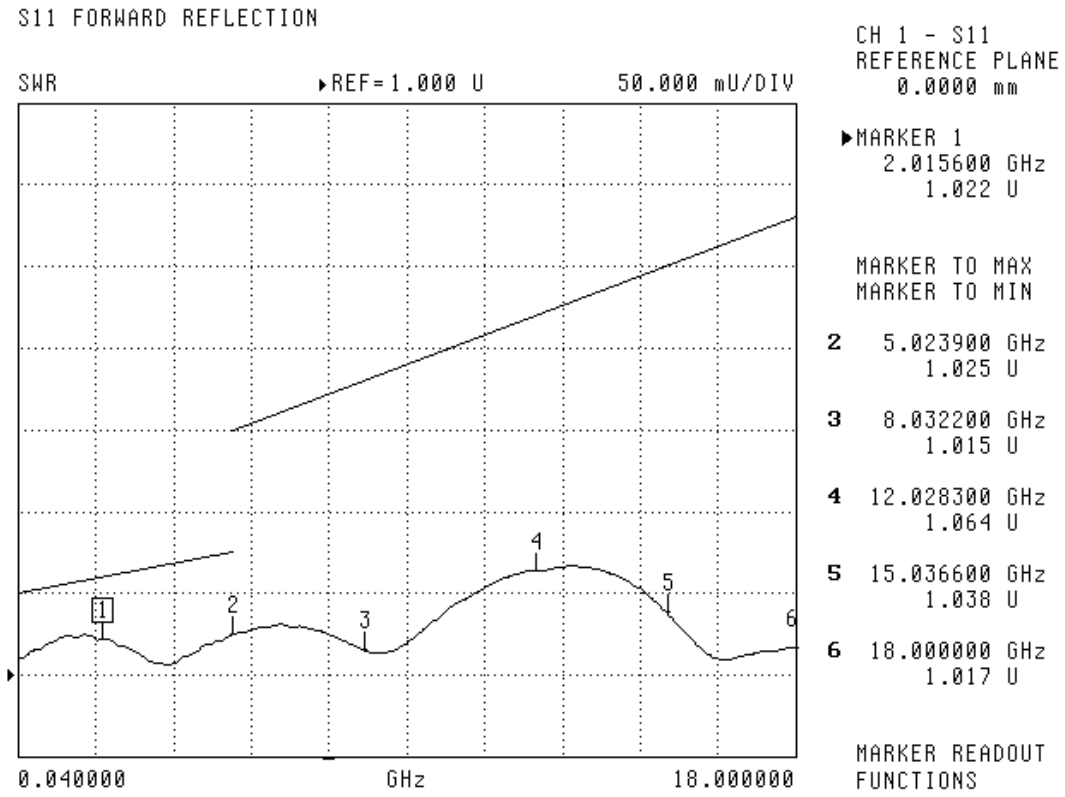


Sample 20

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

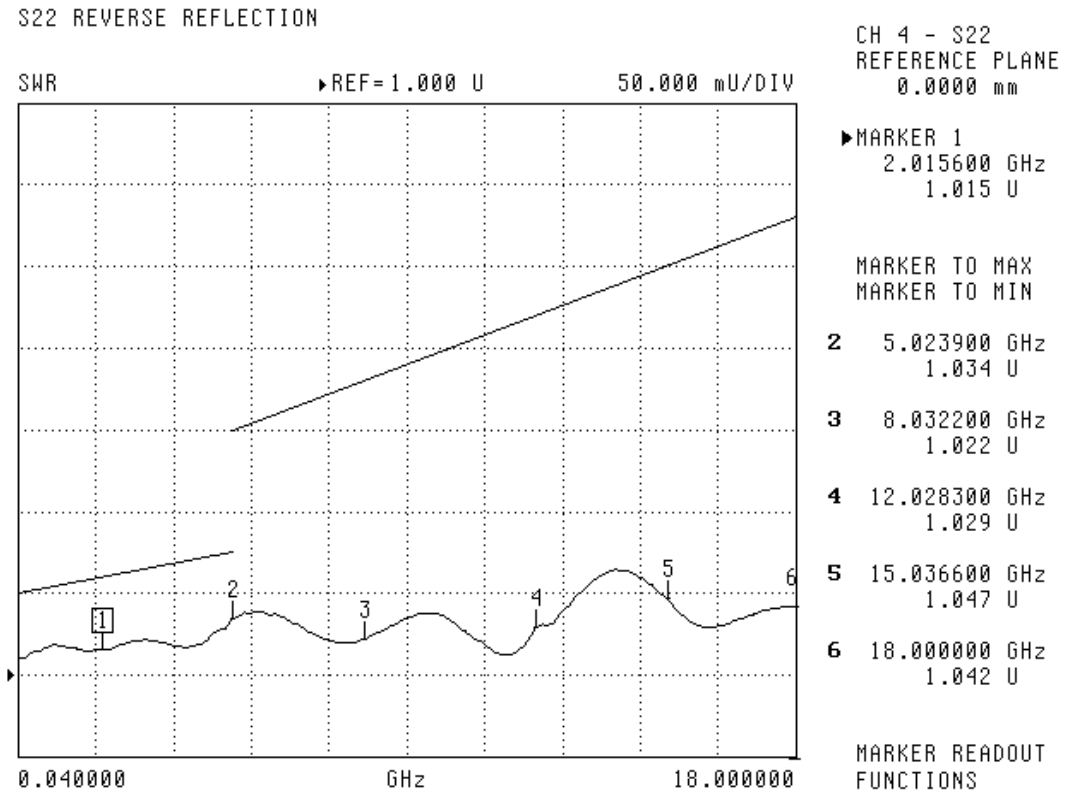


Sample 21

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

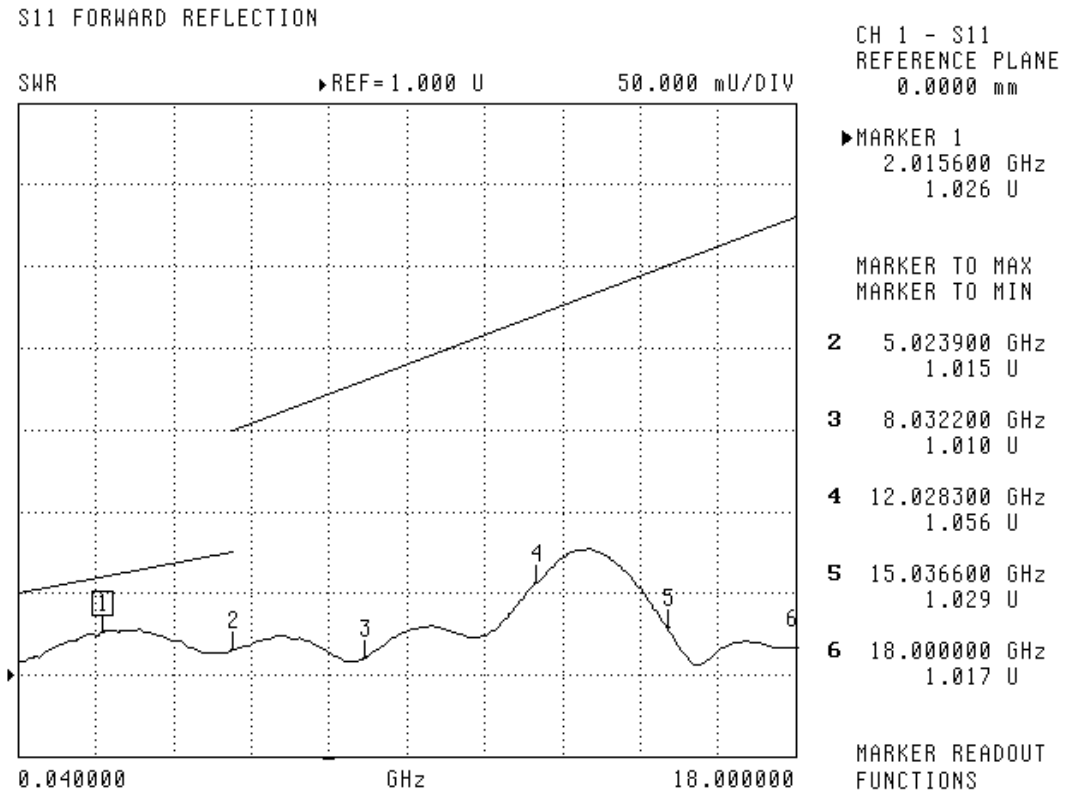


Sample 22

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

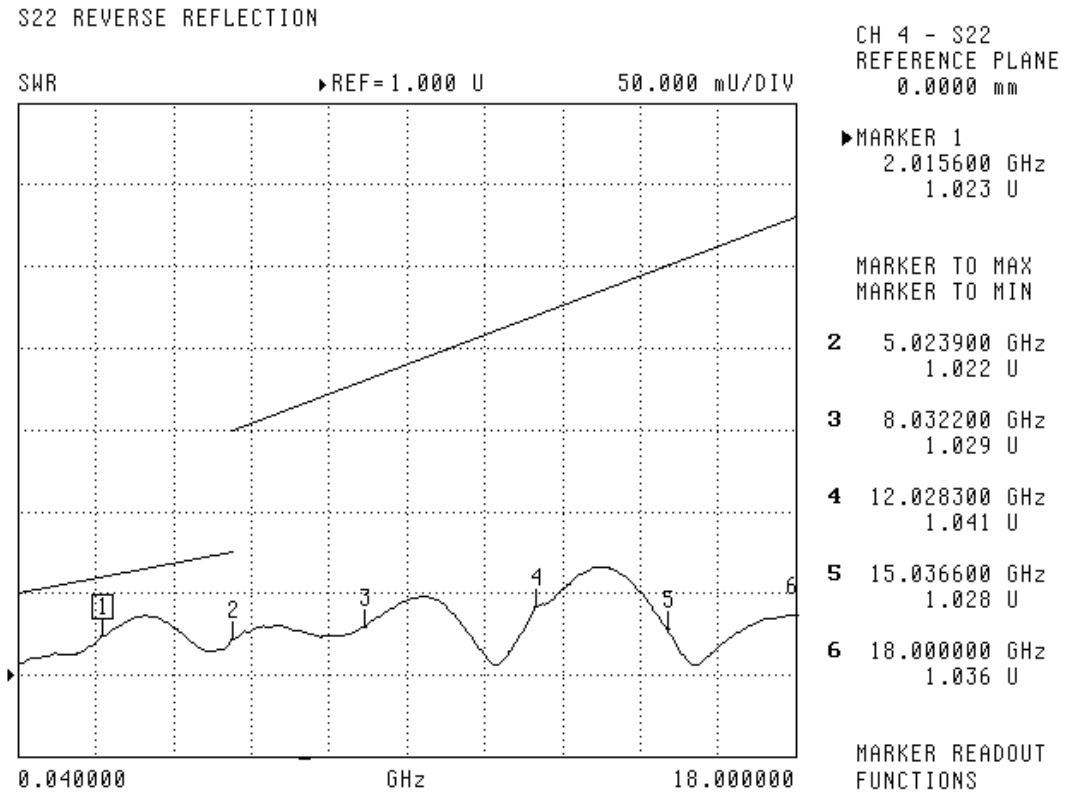


Sample 23

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

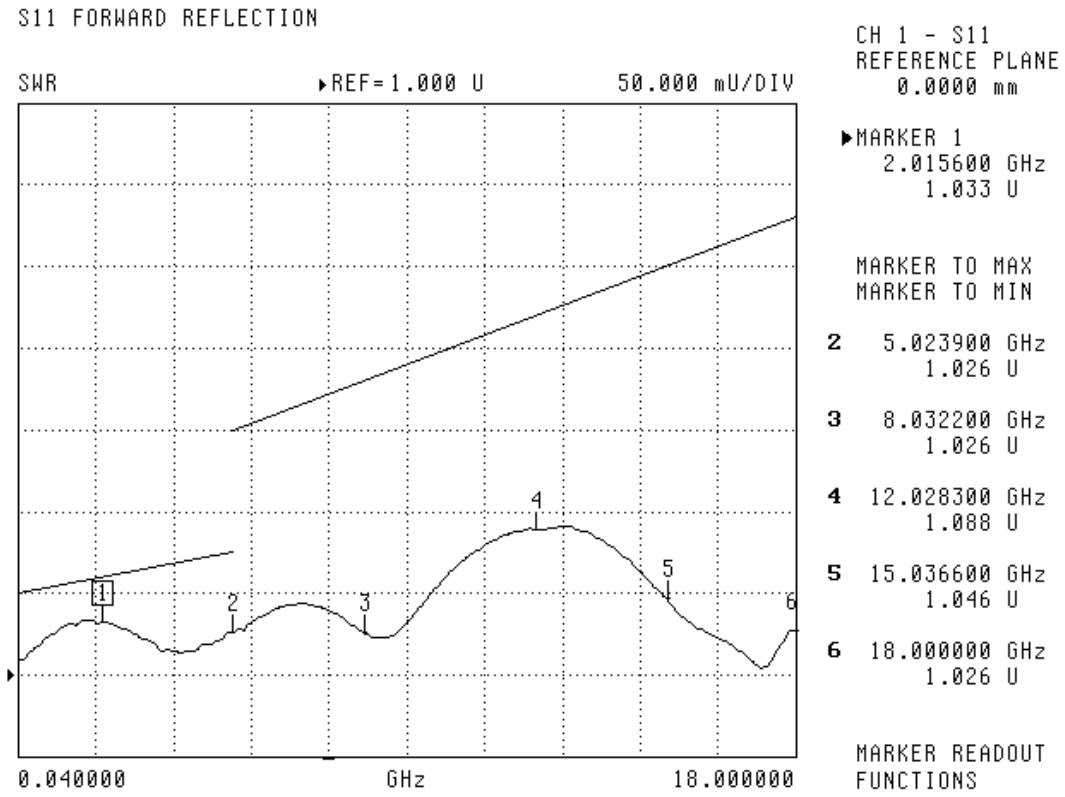


Sample 24

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

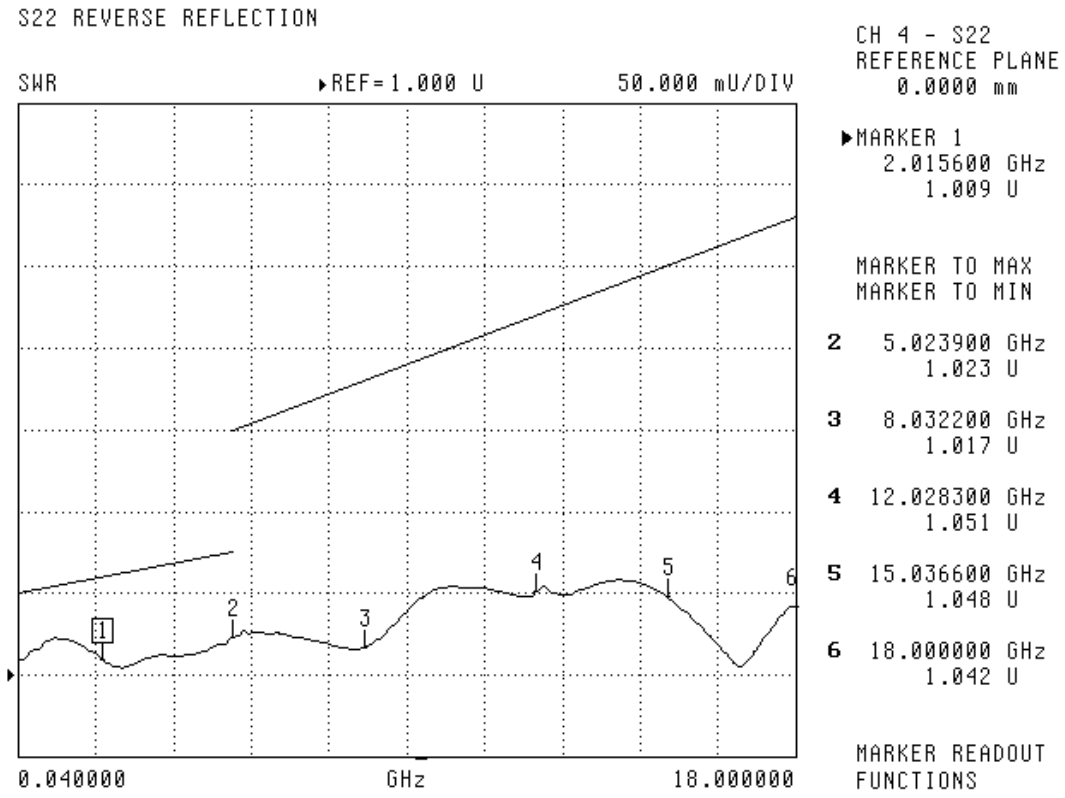


Sample 25

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

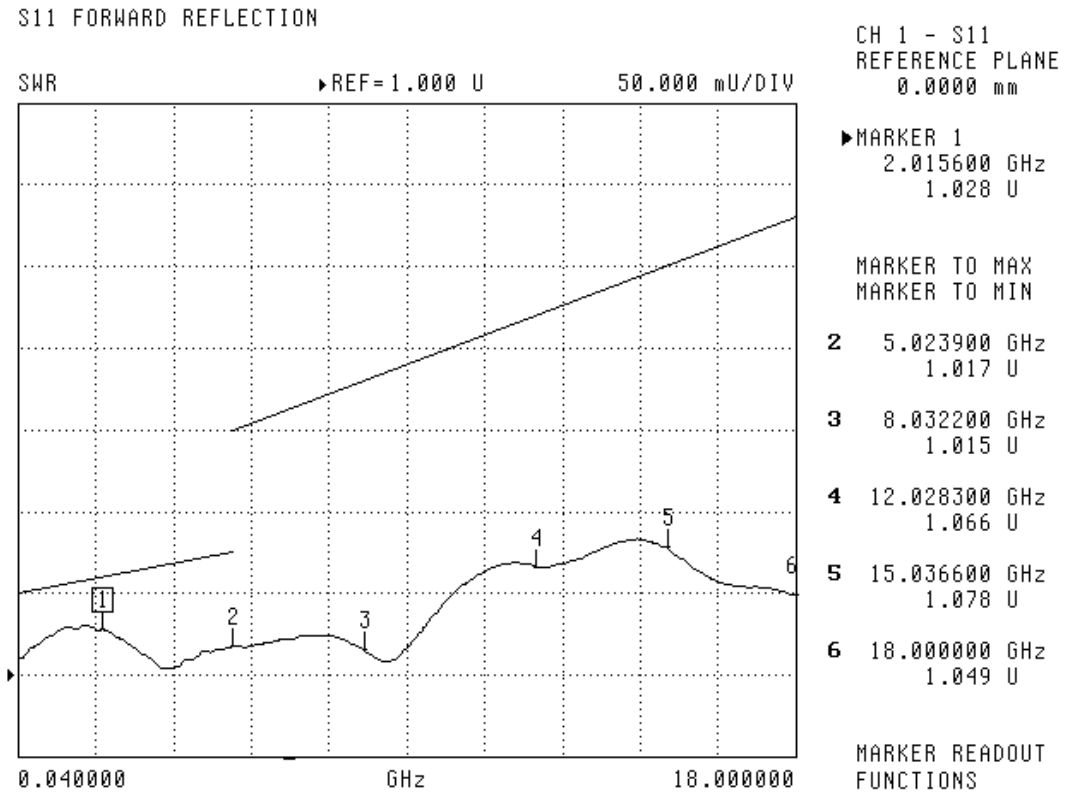


Sample 26

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

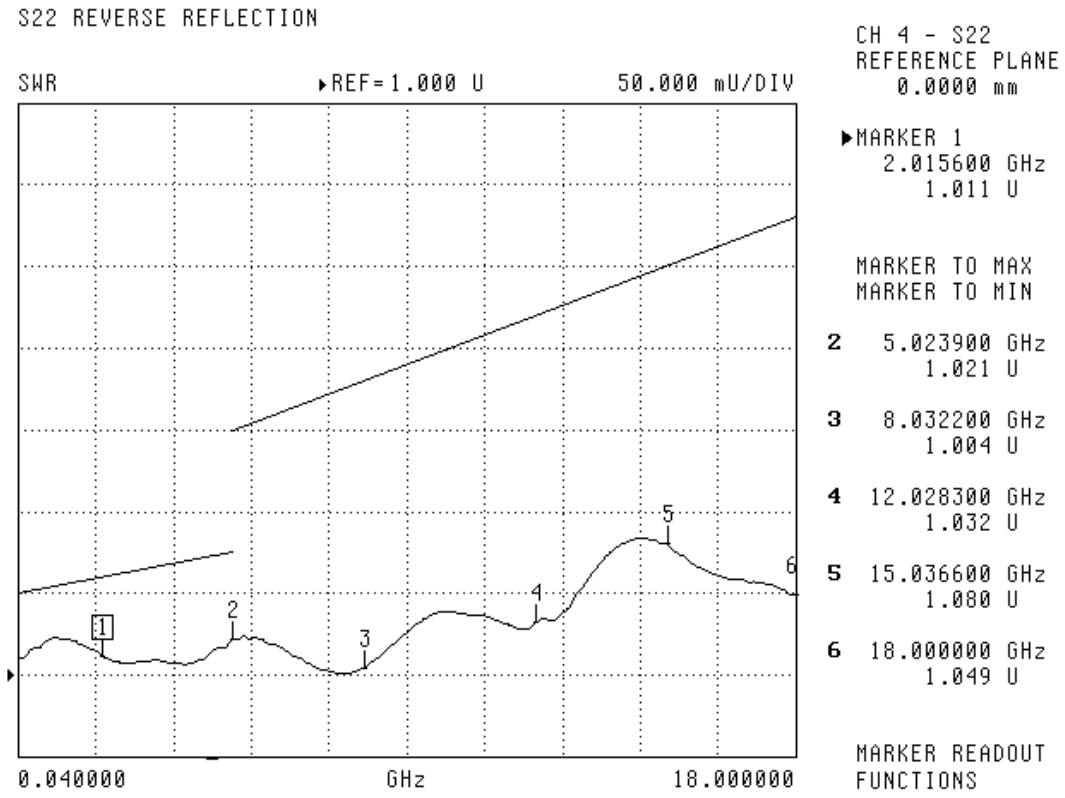


Sample 27

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

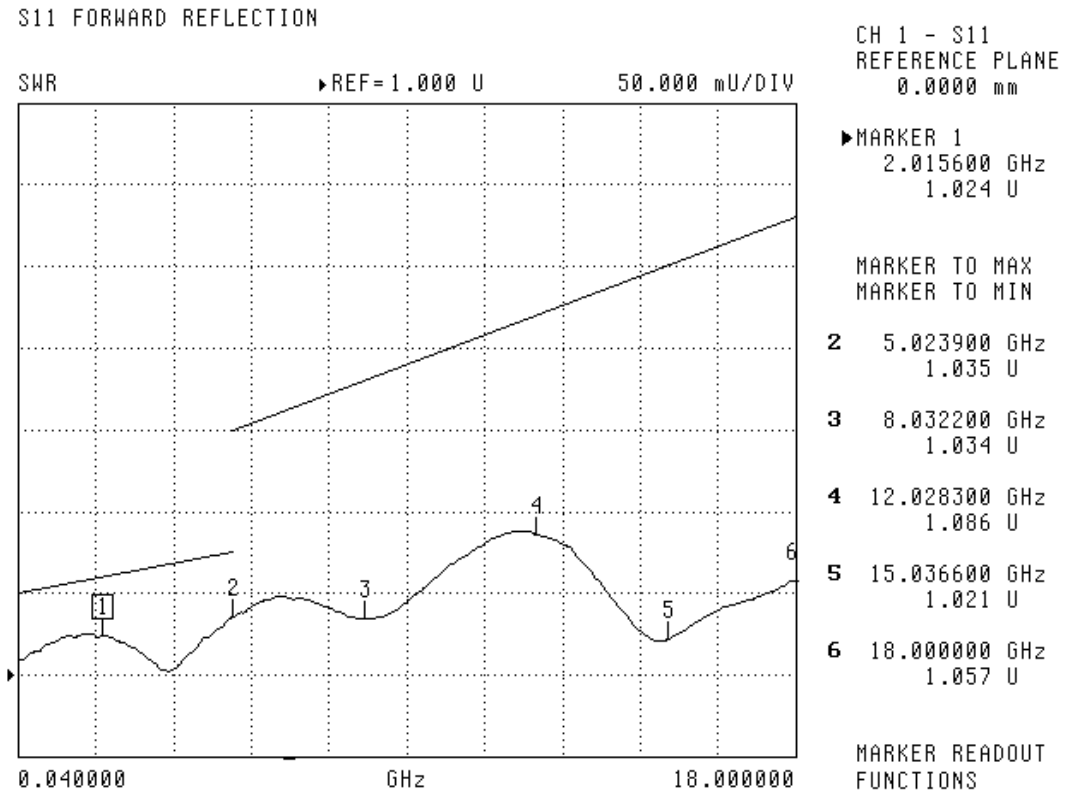


Sample 28

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

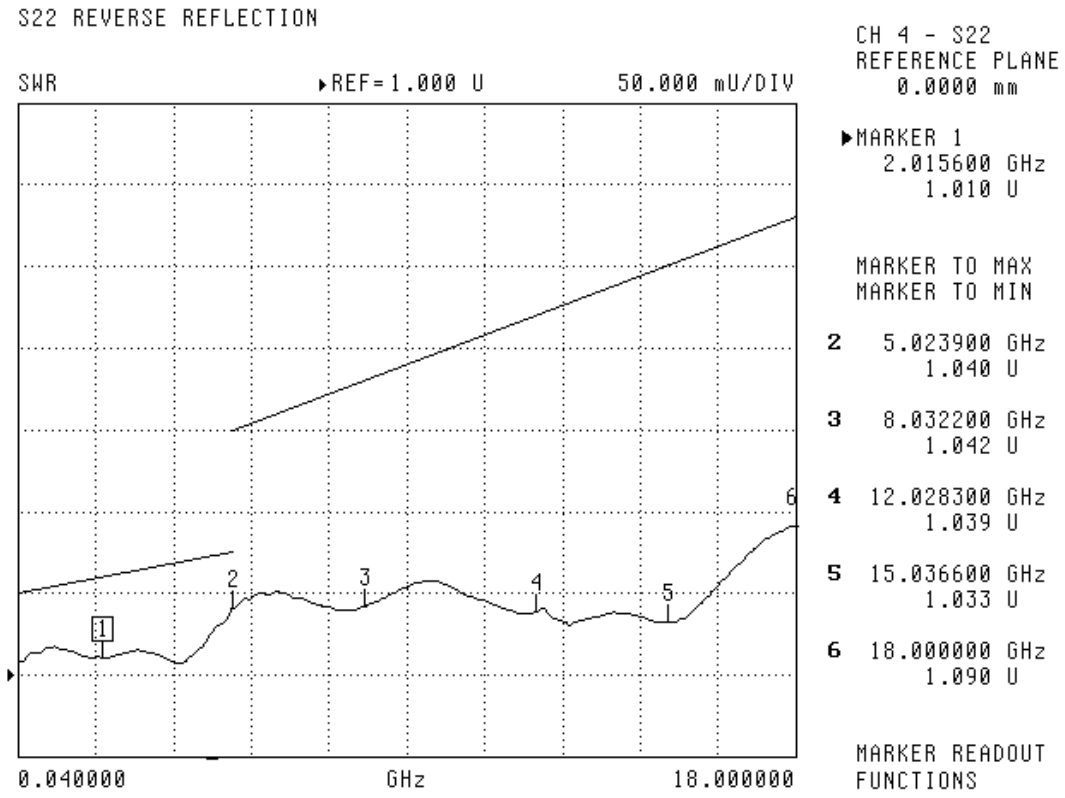


Sample 29

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

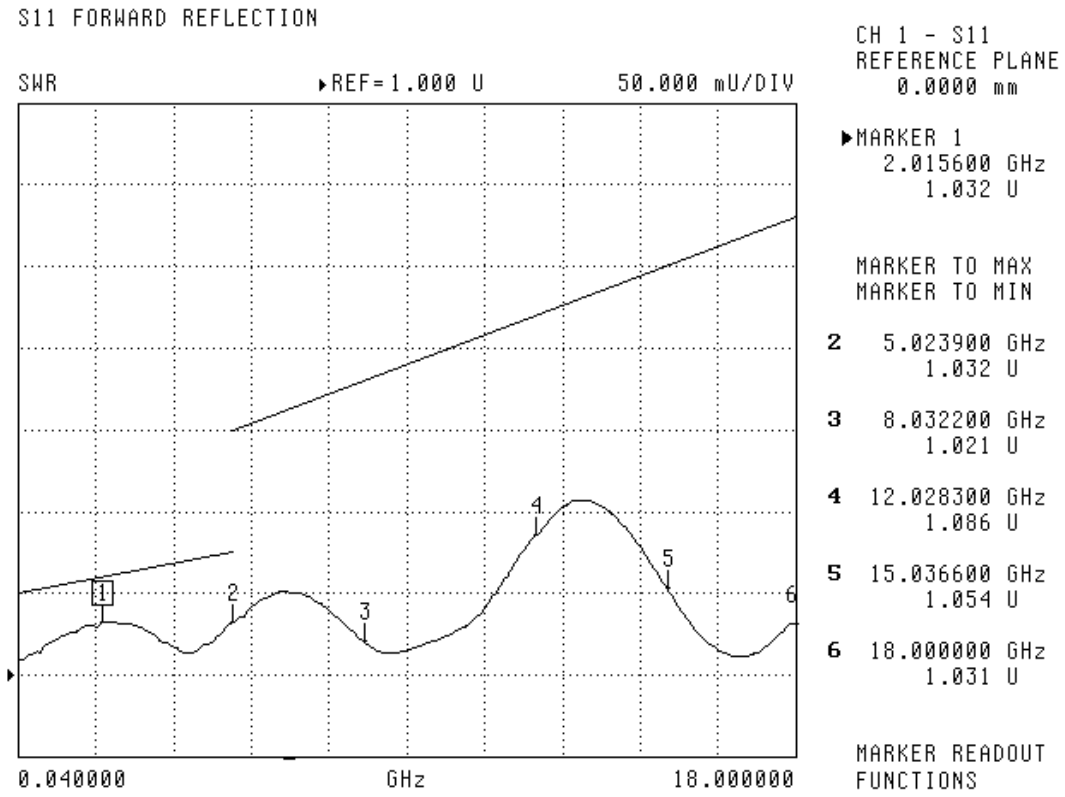


Sample 30

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

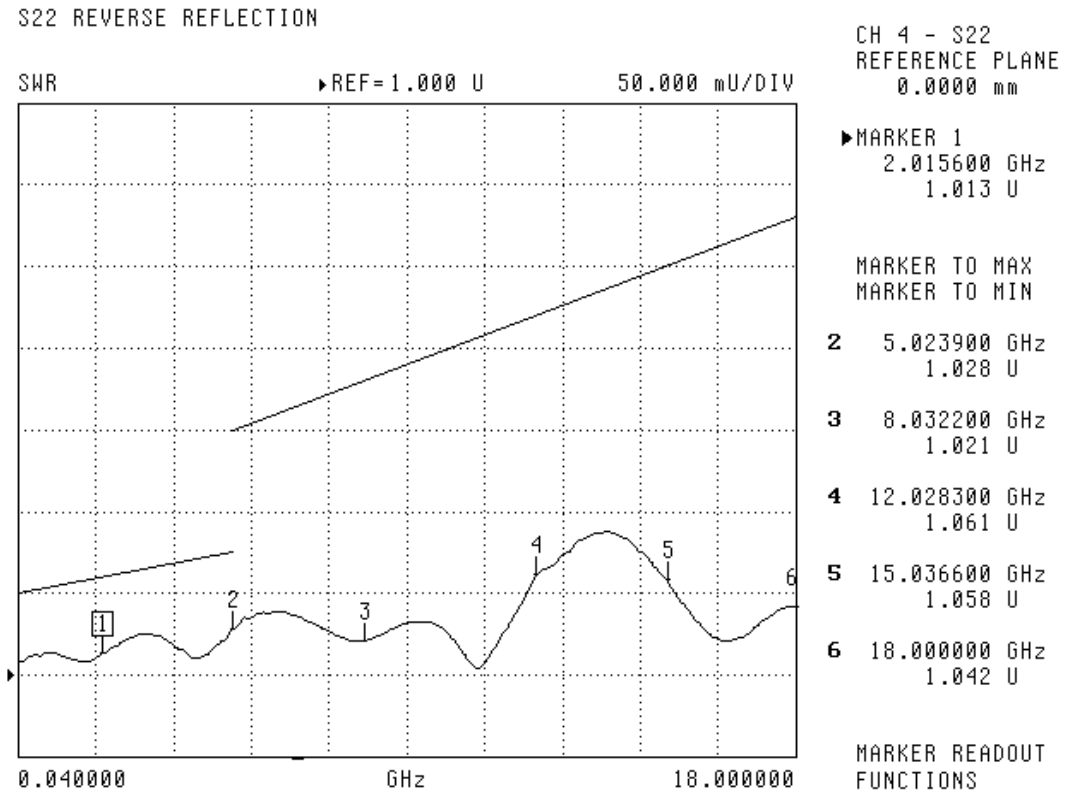


Sample 31

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

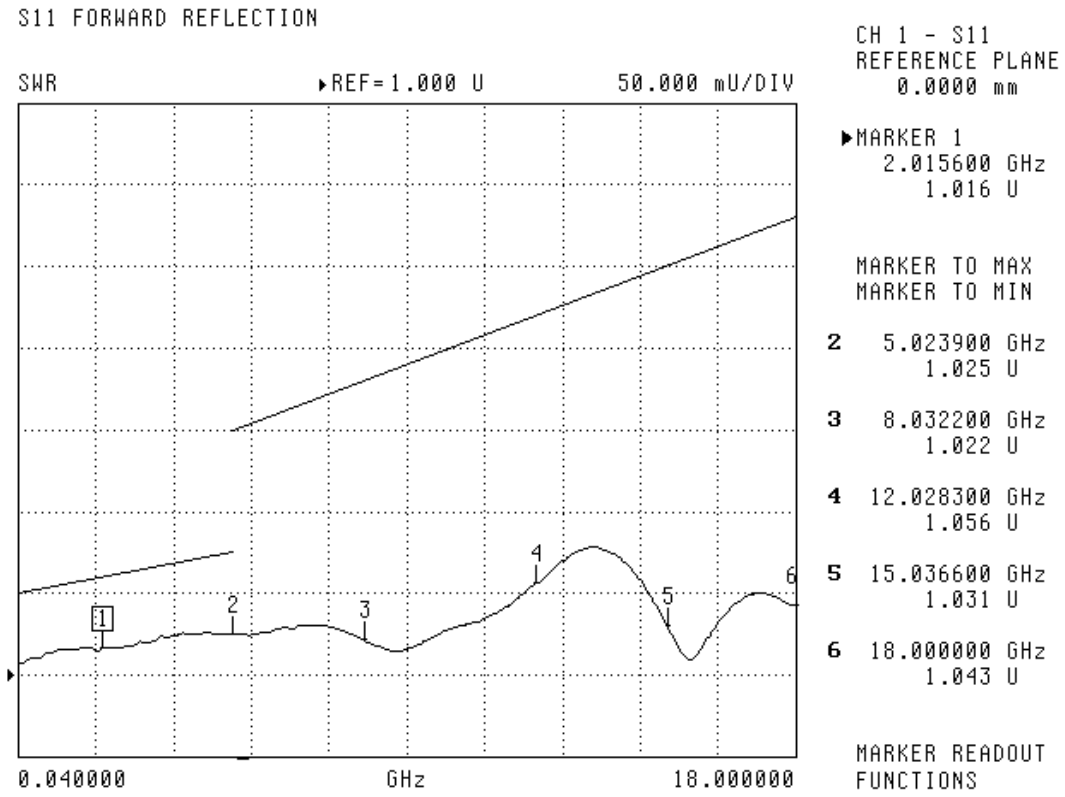


Sample 32

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

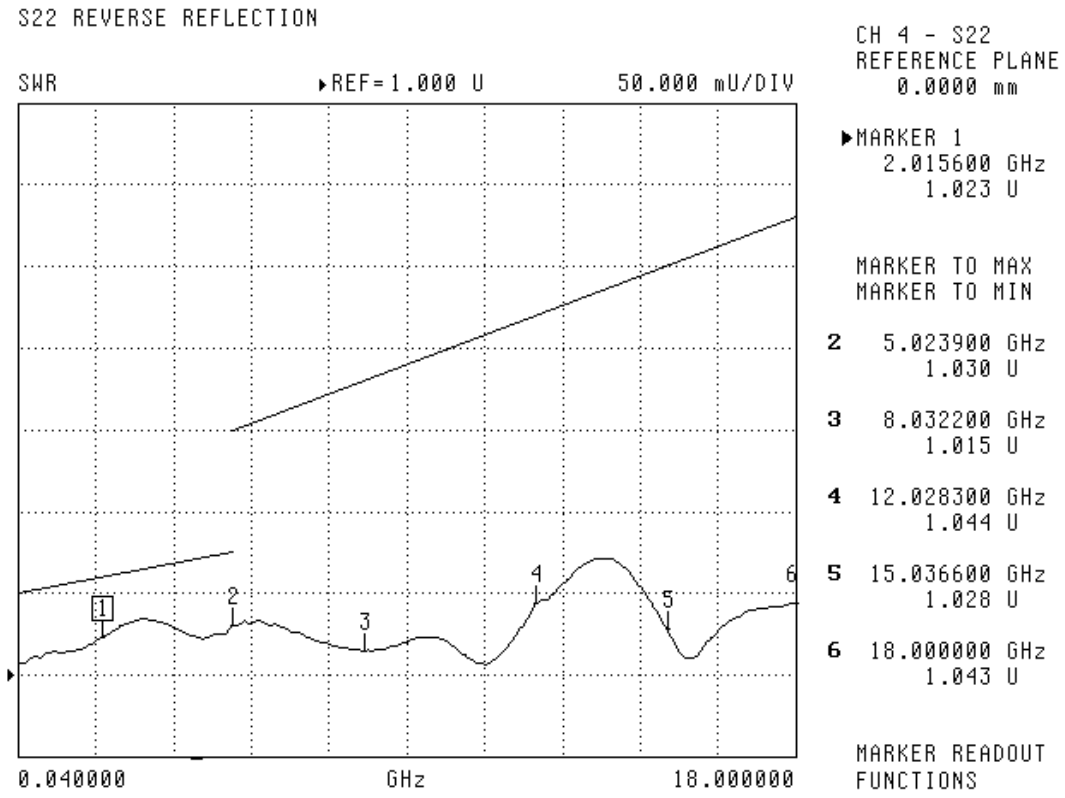


Sample 33

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

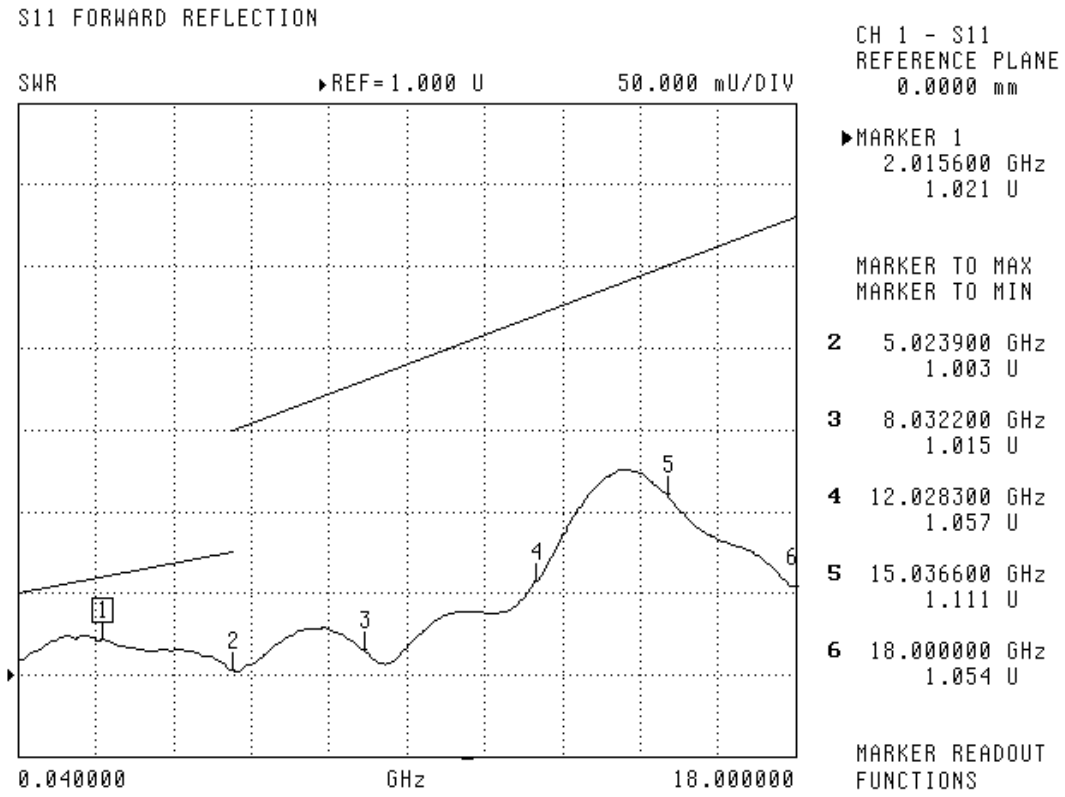


Sample 34

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

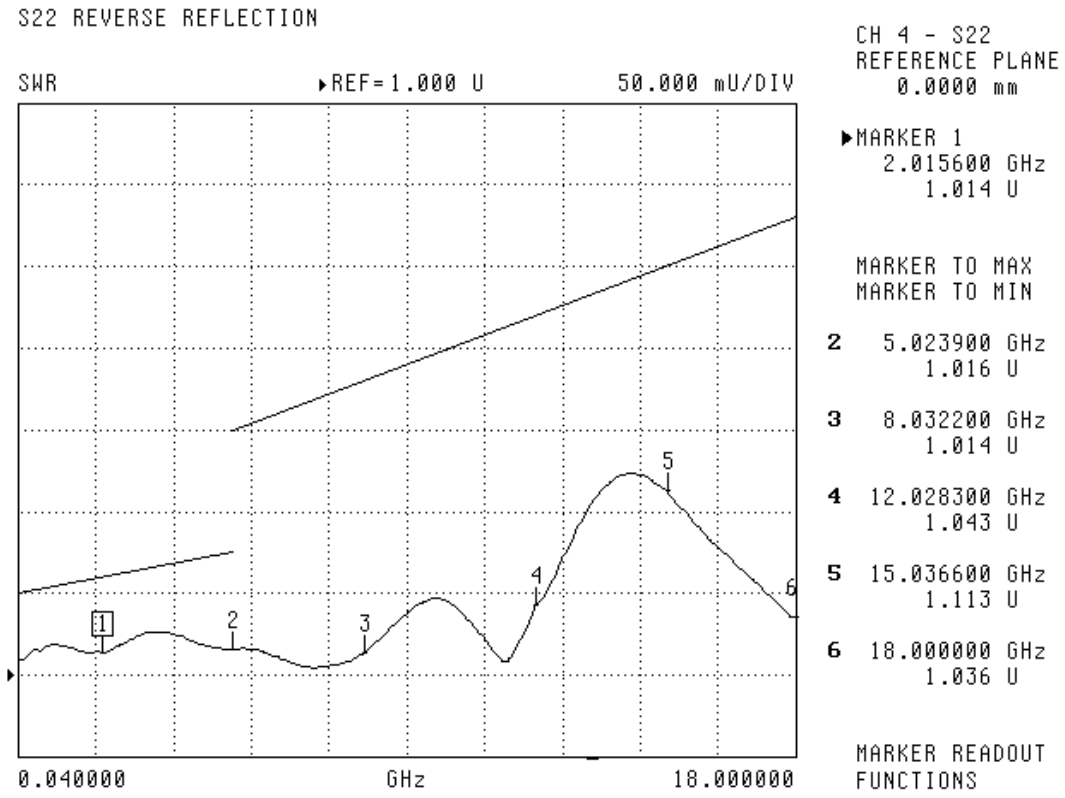


Sample 35

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

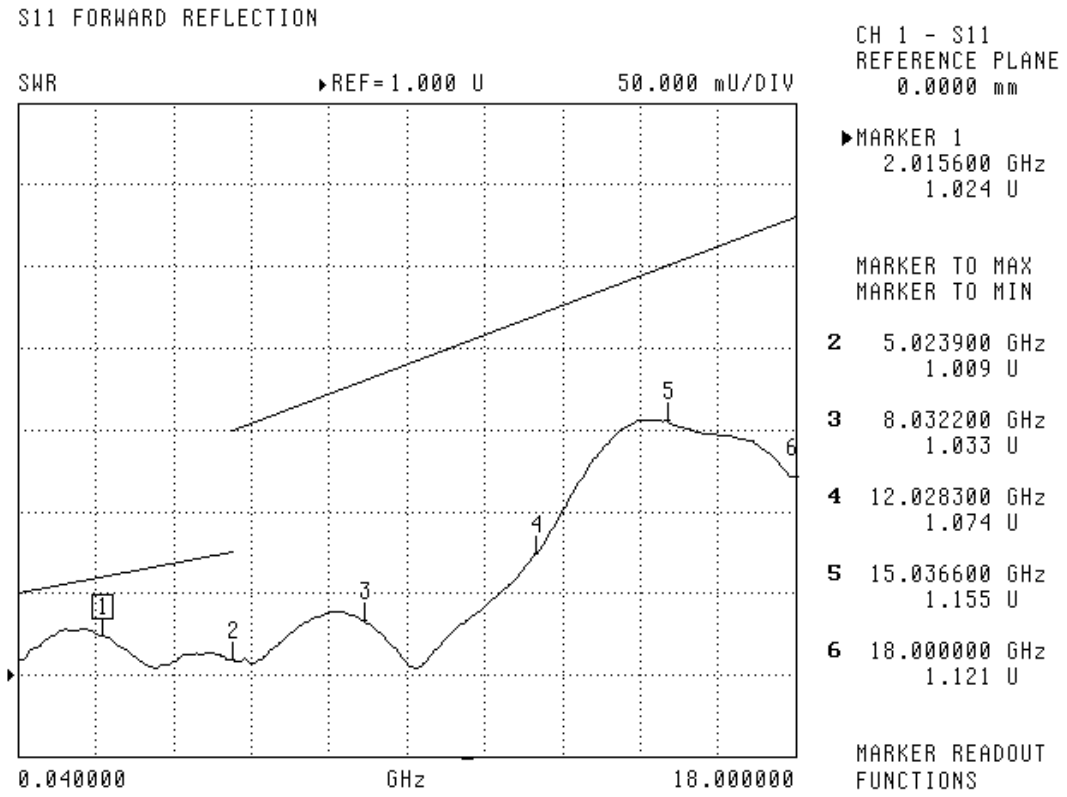


Sample 95

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

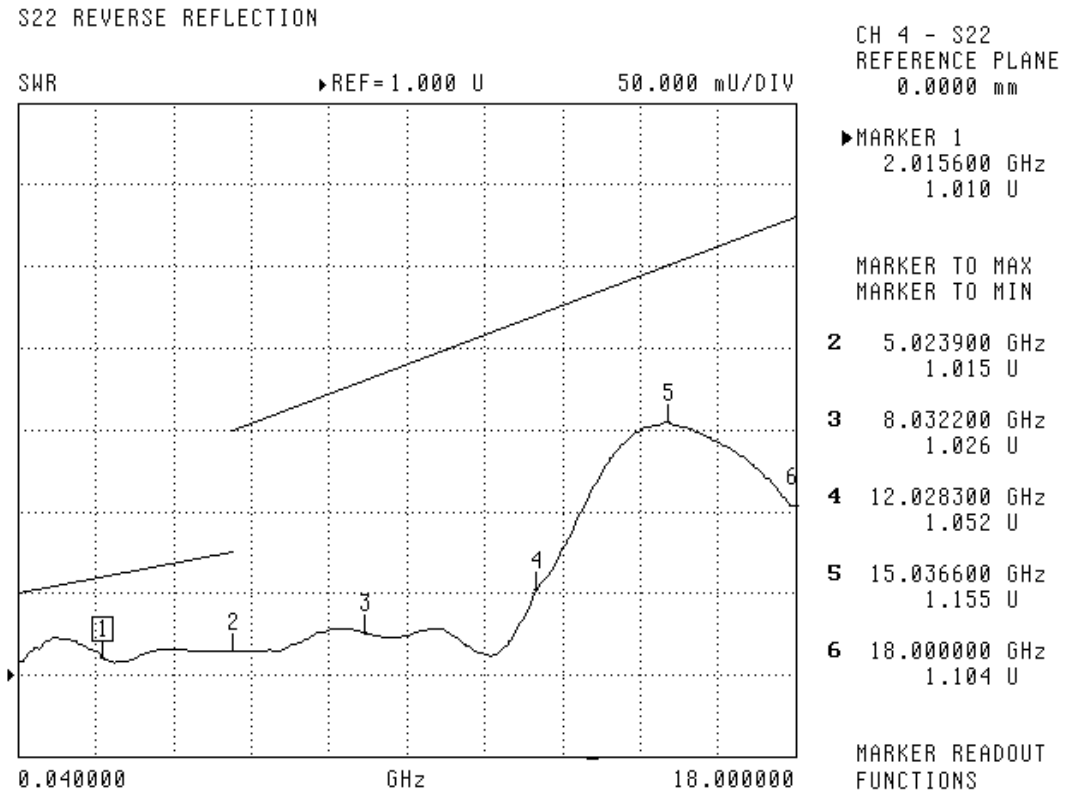


Sample 96

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

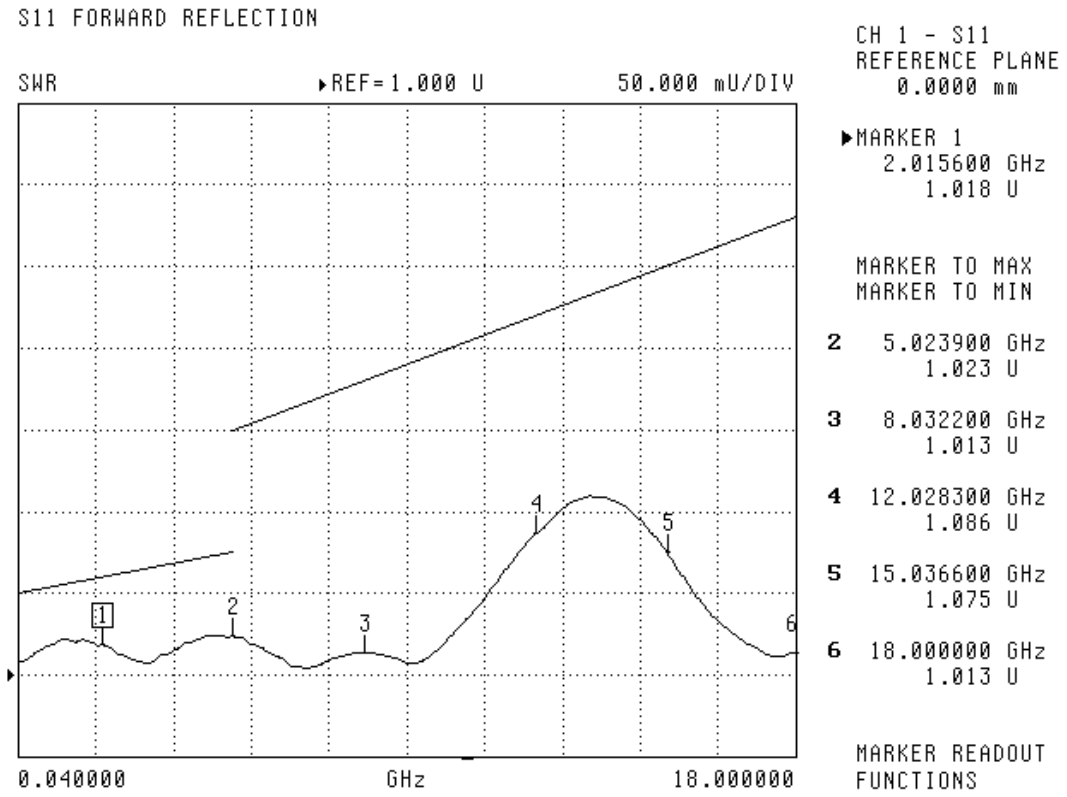


Sample 97

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

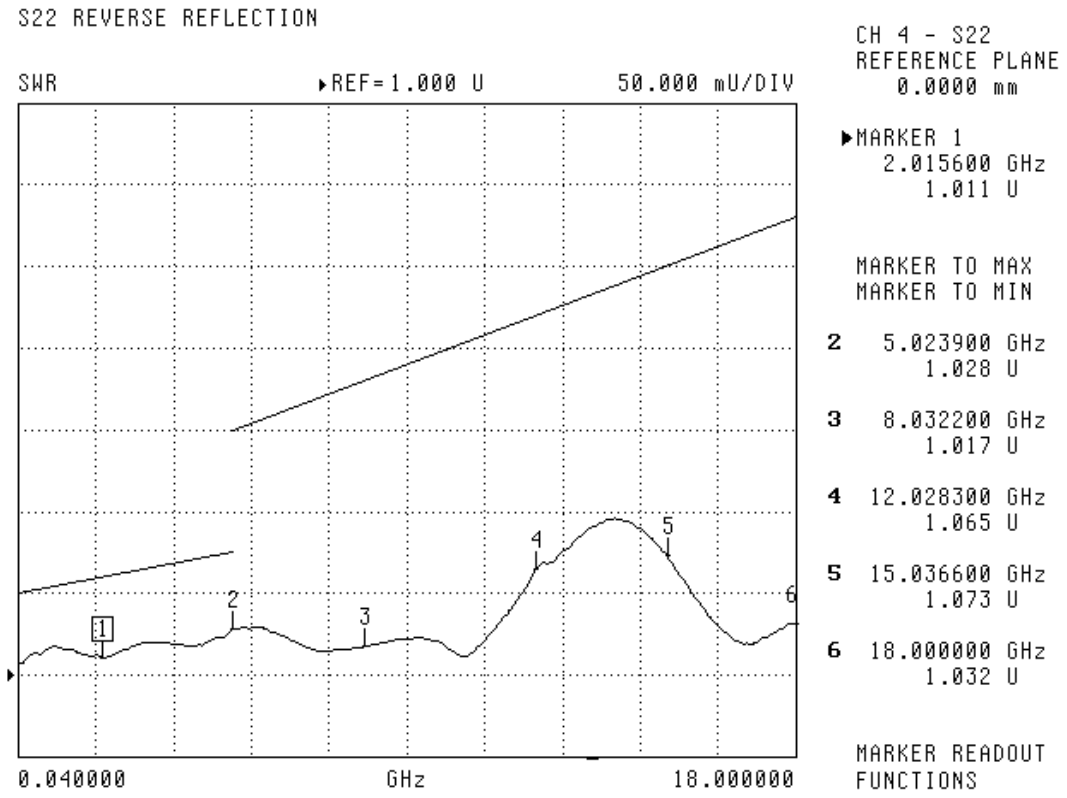


Sample 98

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

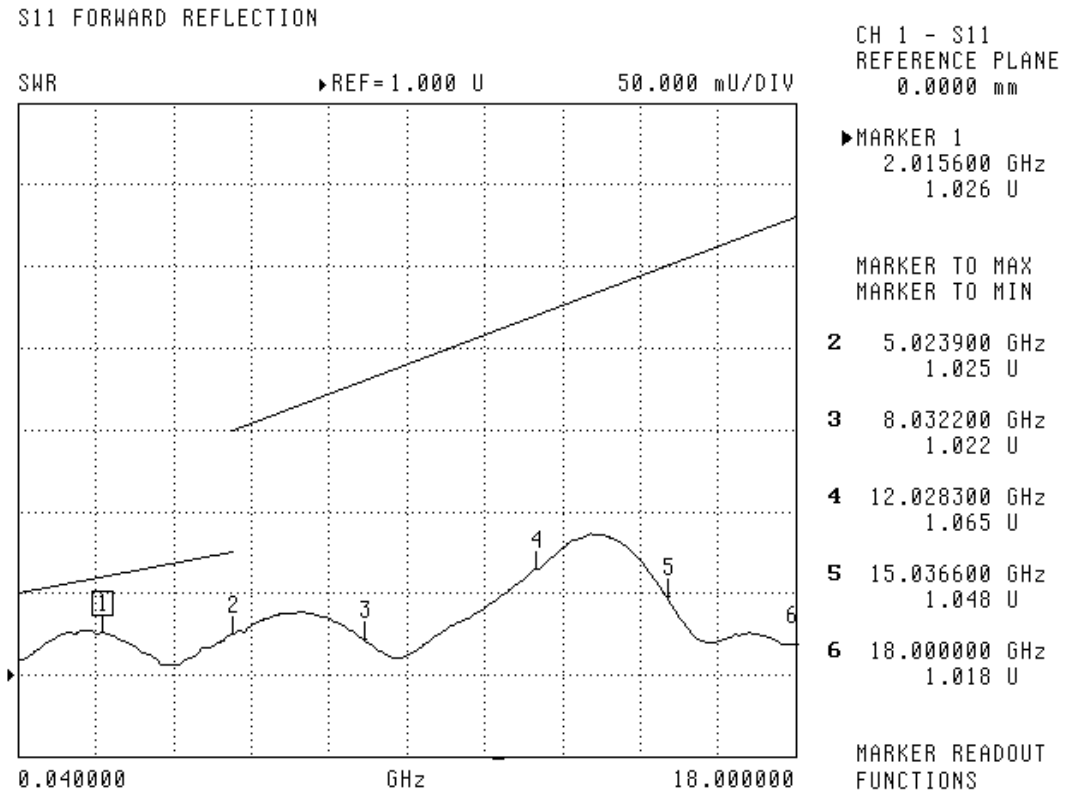


Sample 99

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

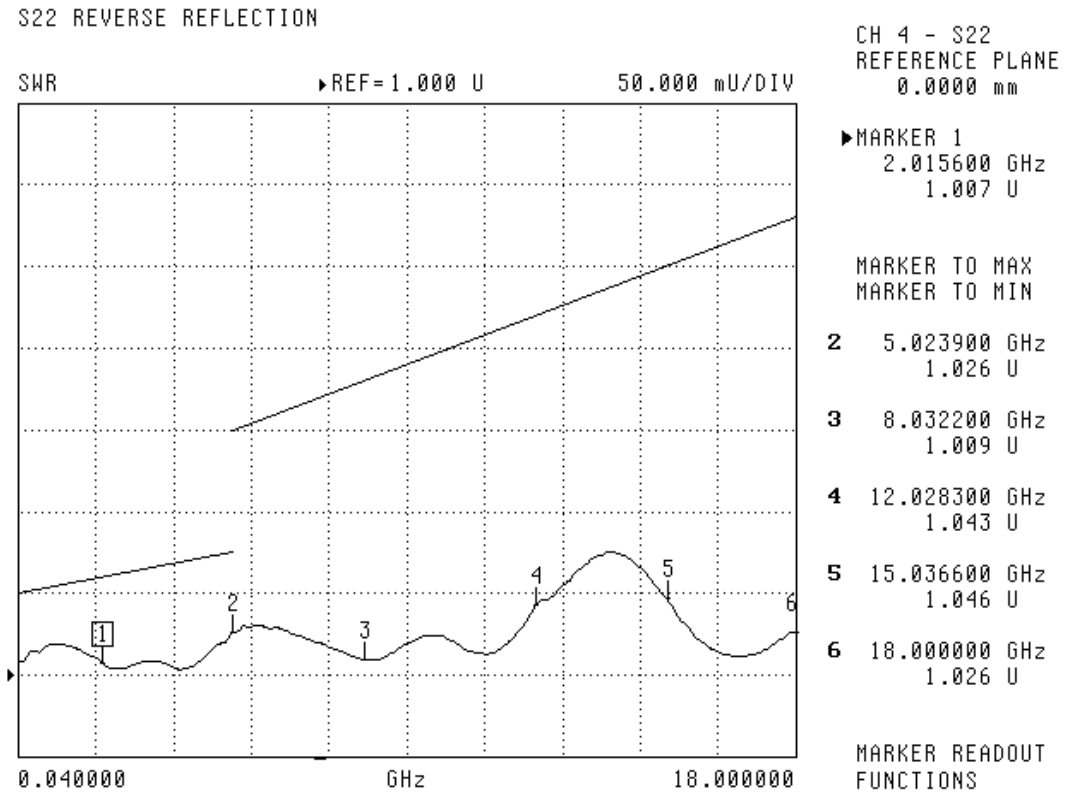


Sample 100

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

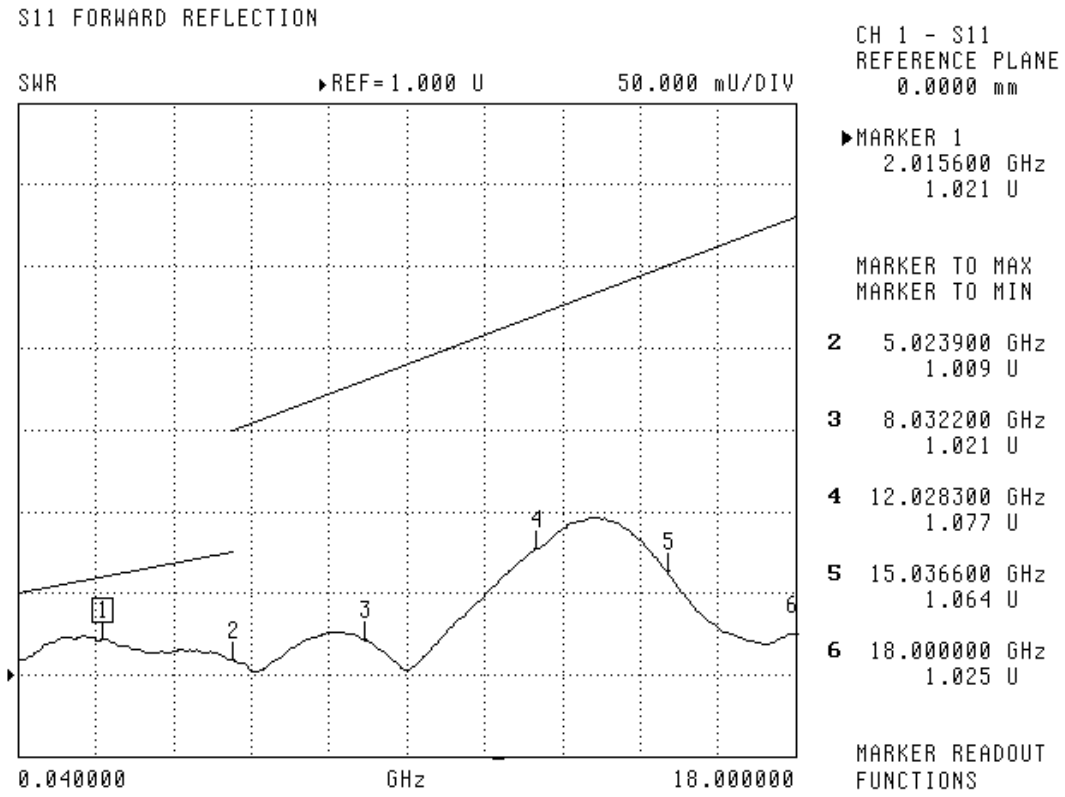


Sample 101

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

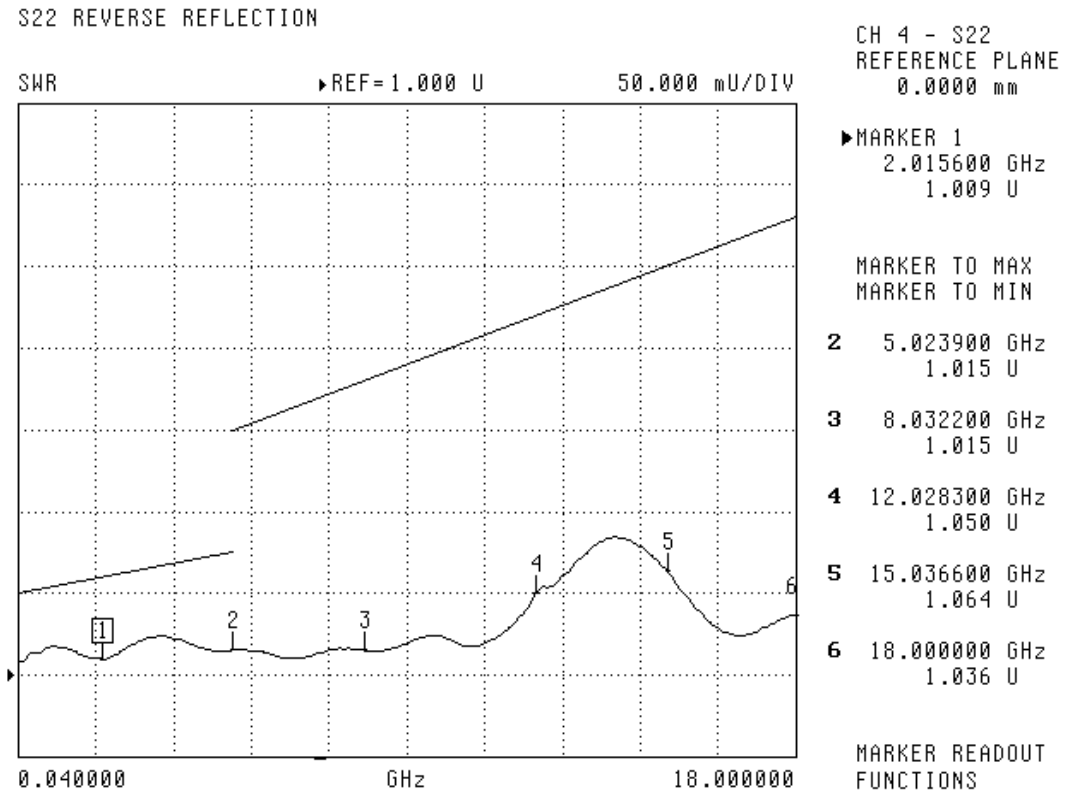


Sample 102

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

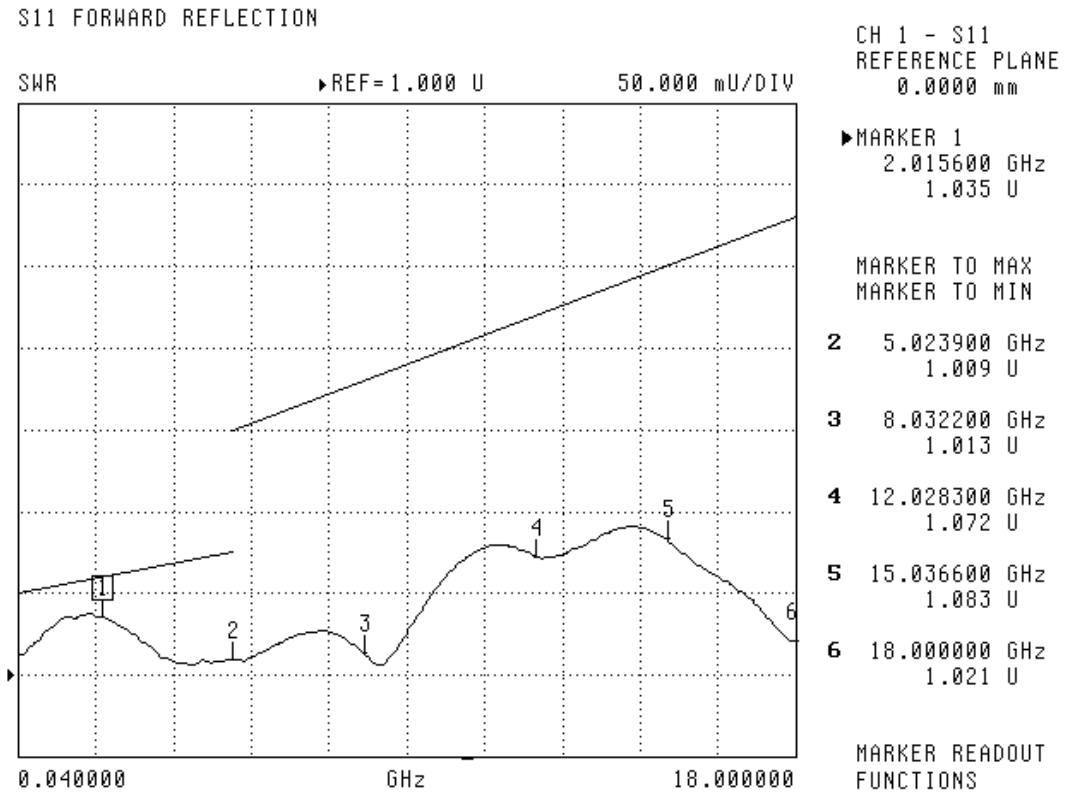


Sample 103

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

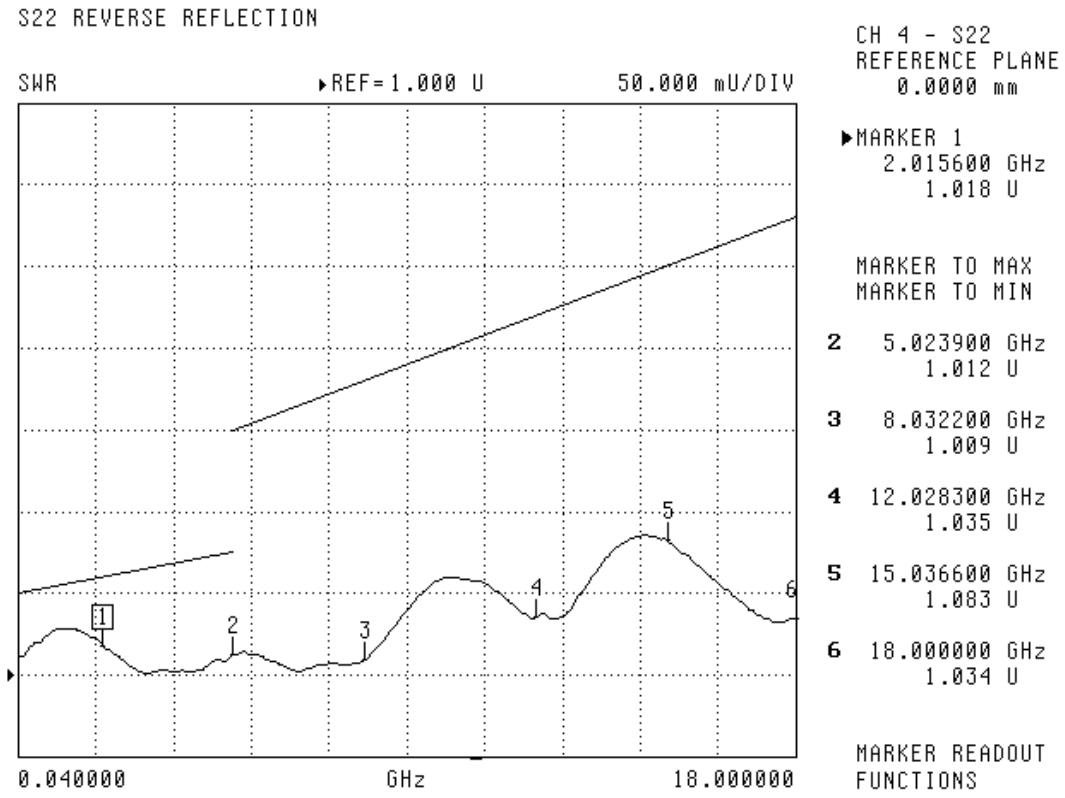


Sample 104

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

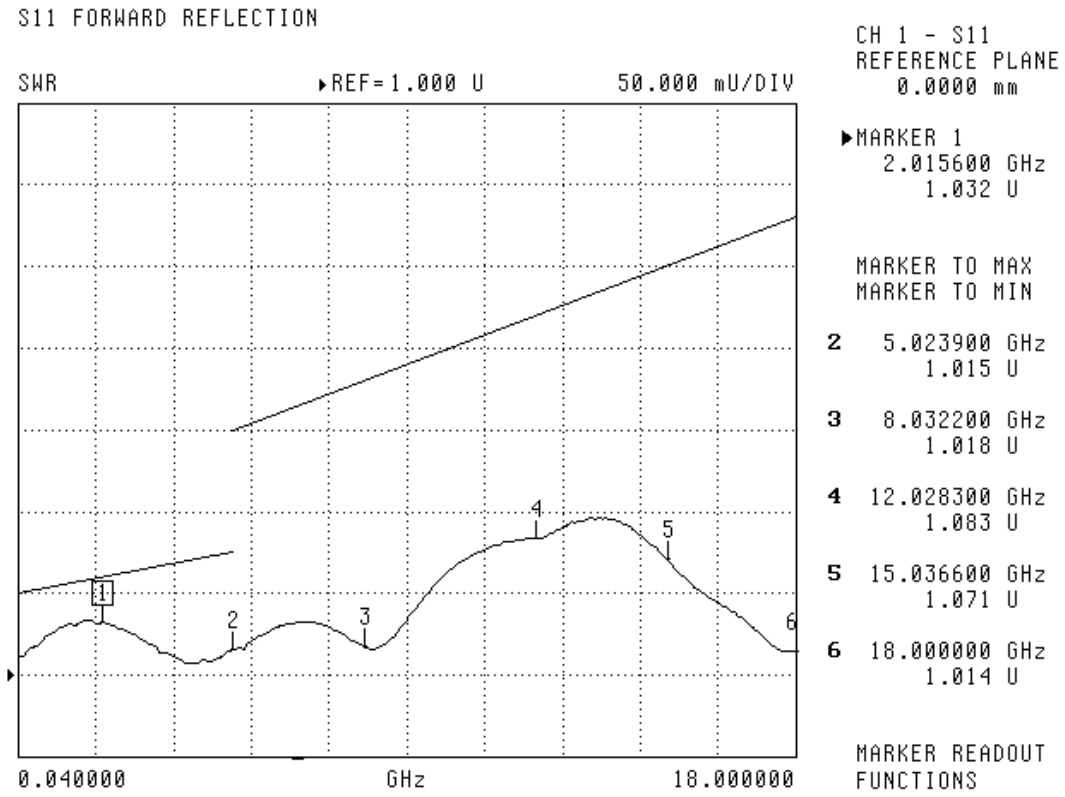


Sample 105

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

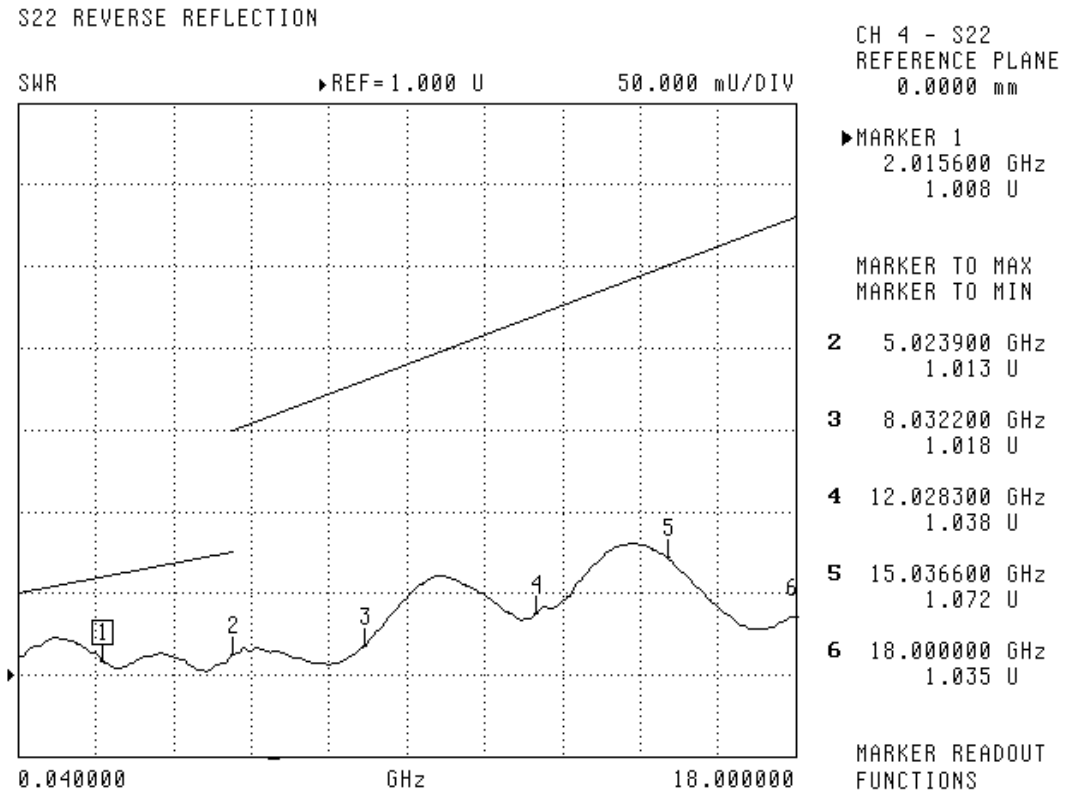


Sample 106

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

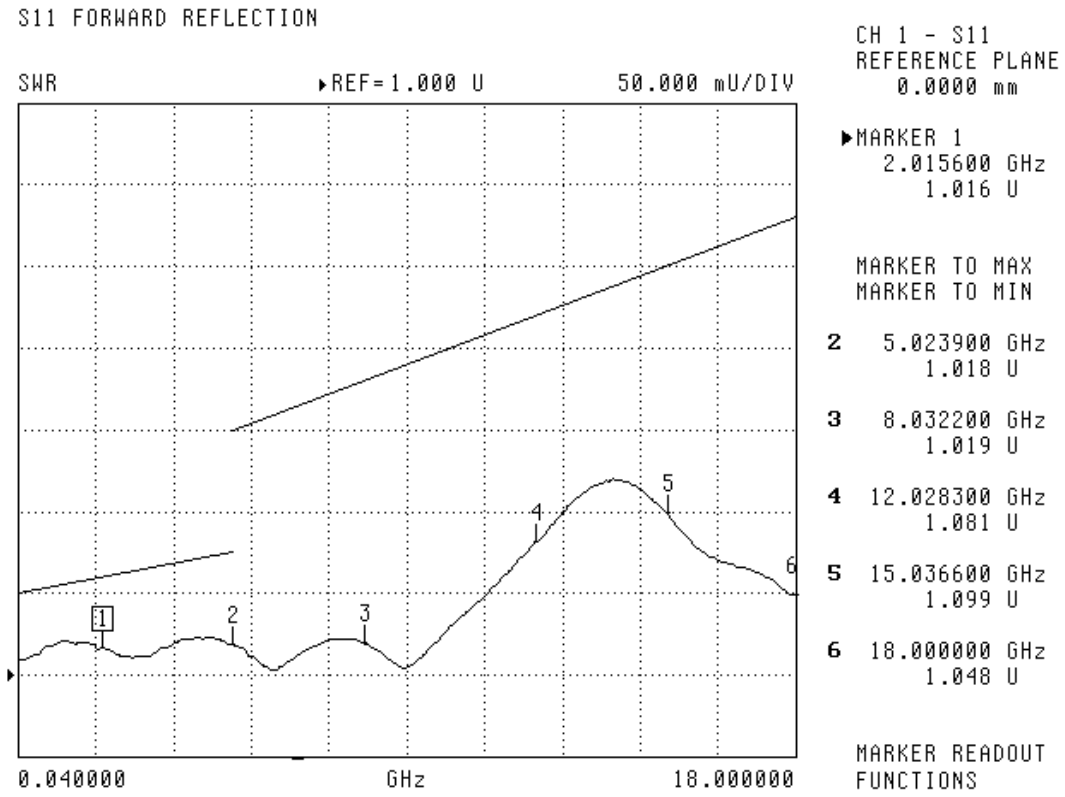


Sample 107

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

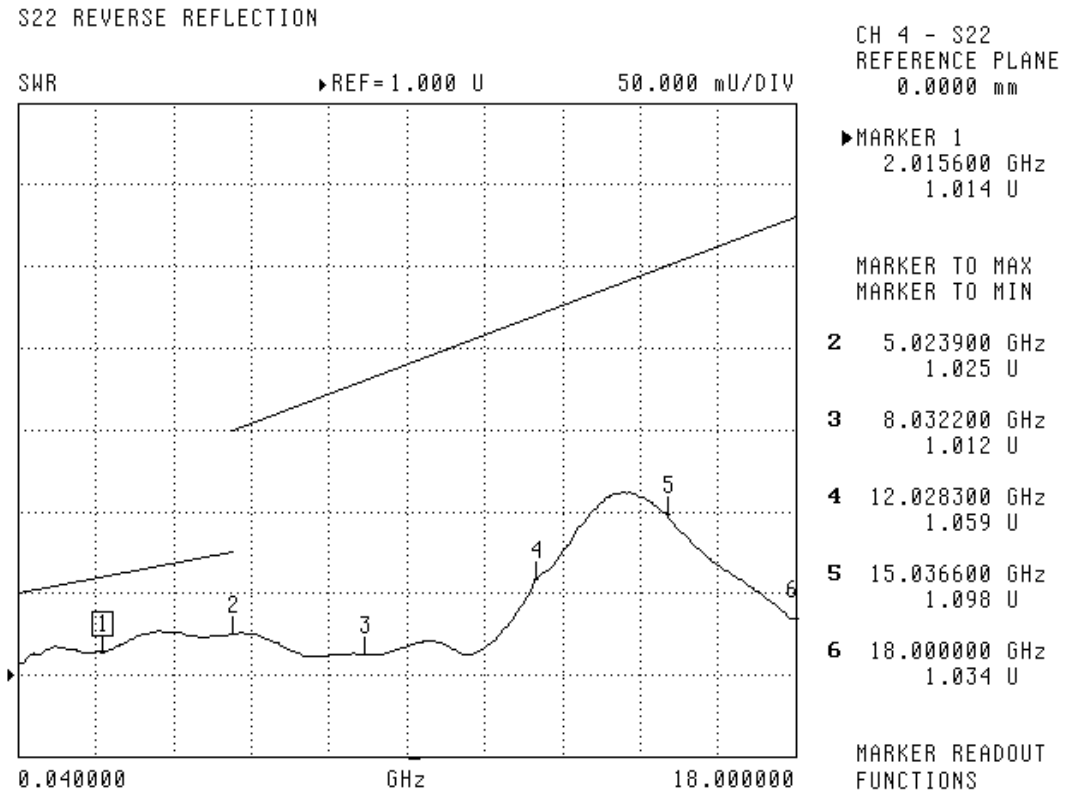


Sample 108

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

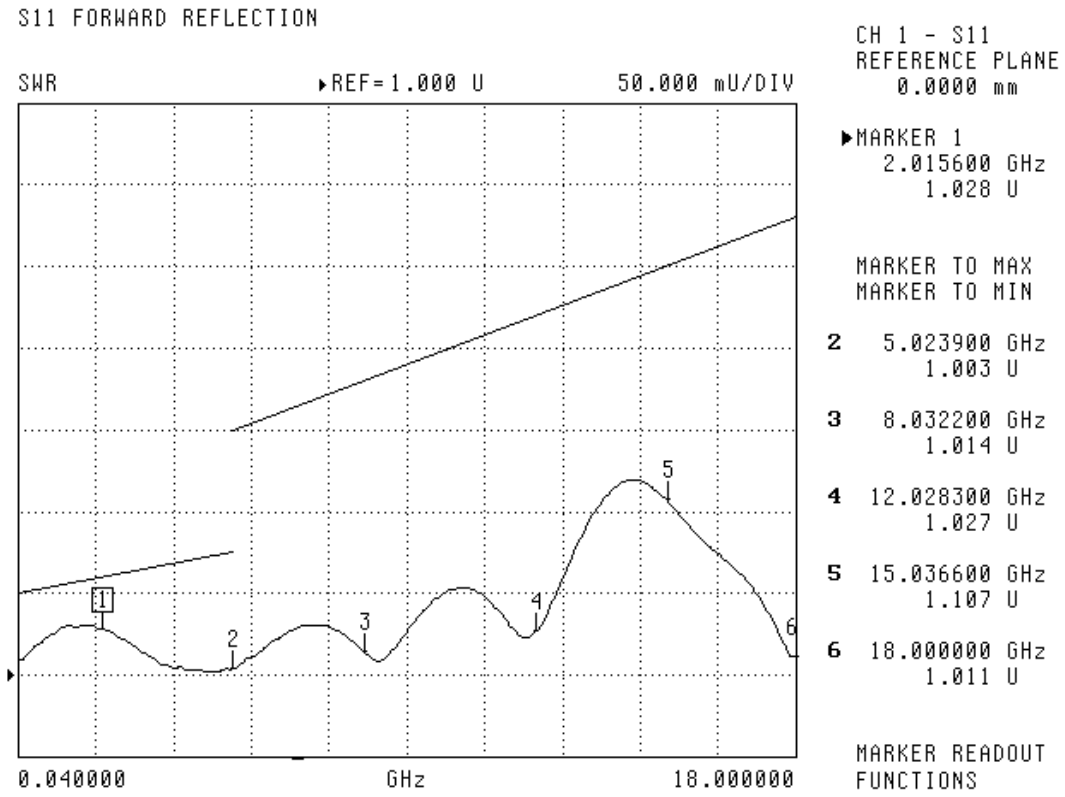


Sample 109

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

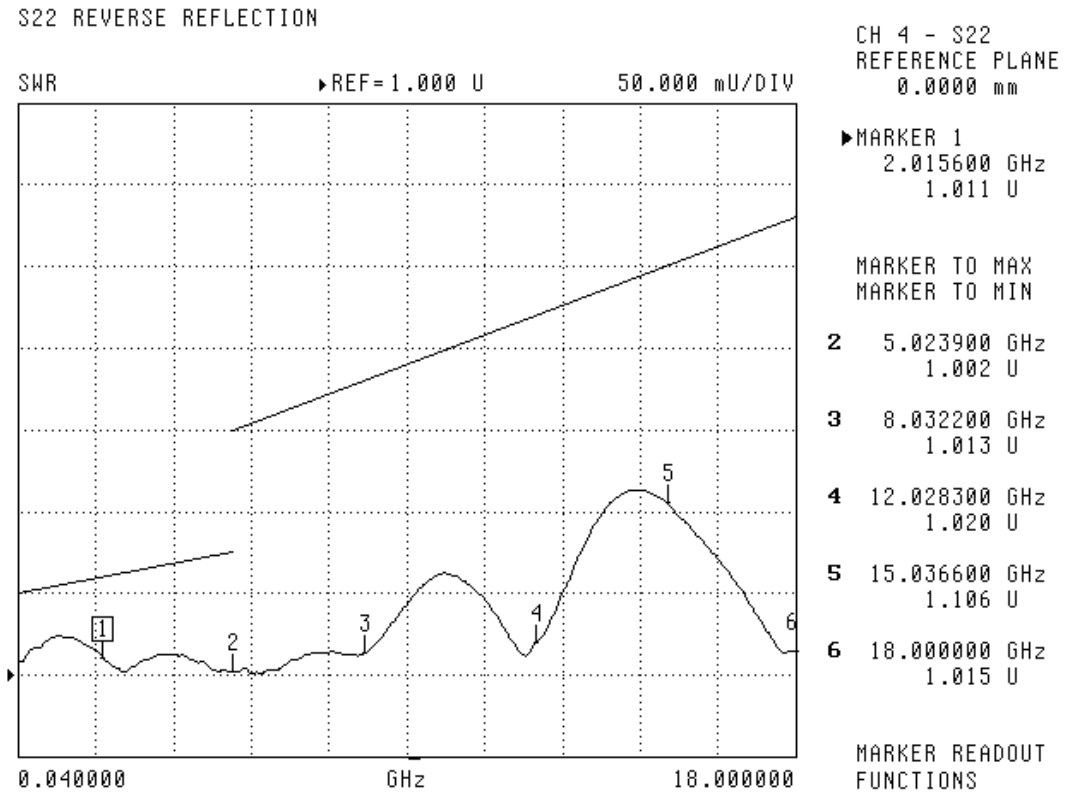


Sample 110

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

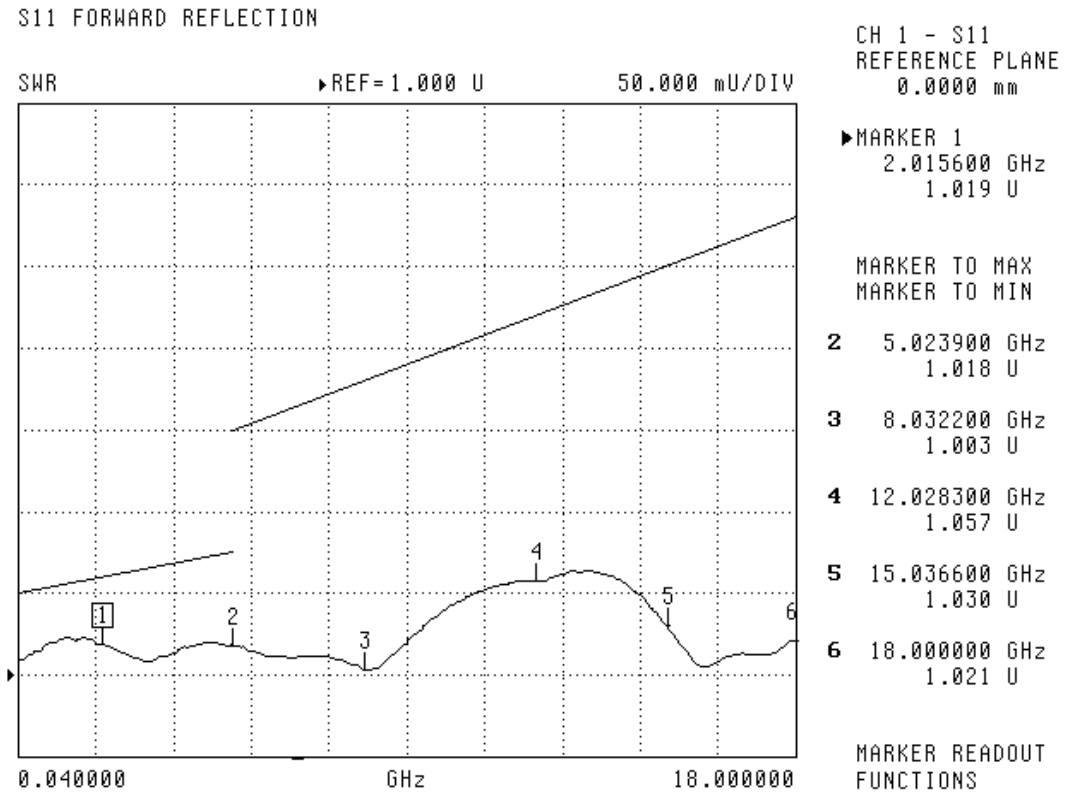


Sample 111

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

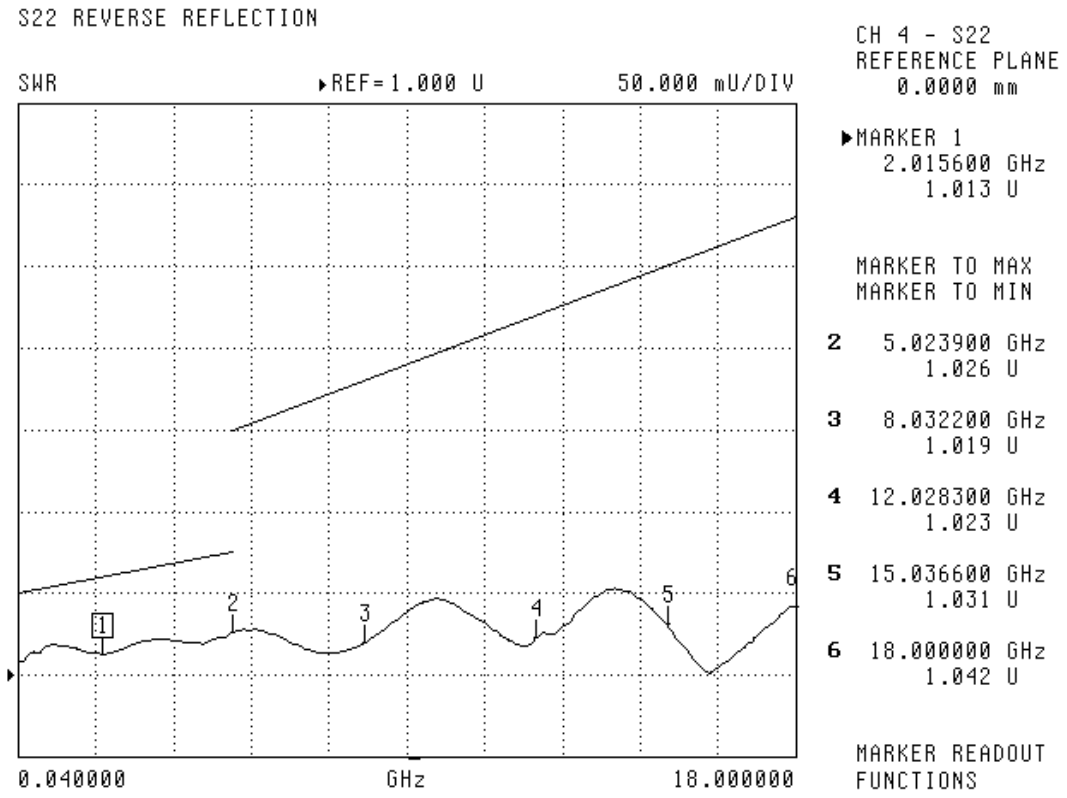


Sample 112

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

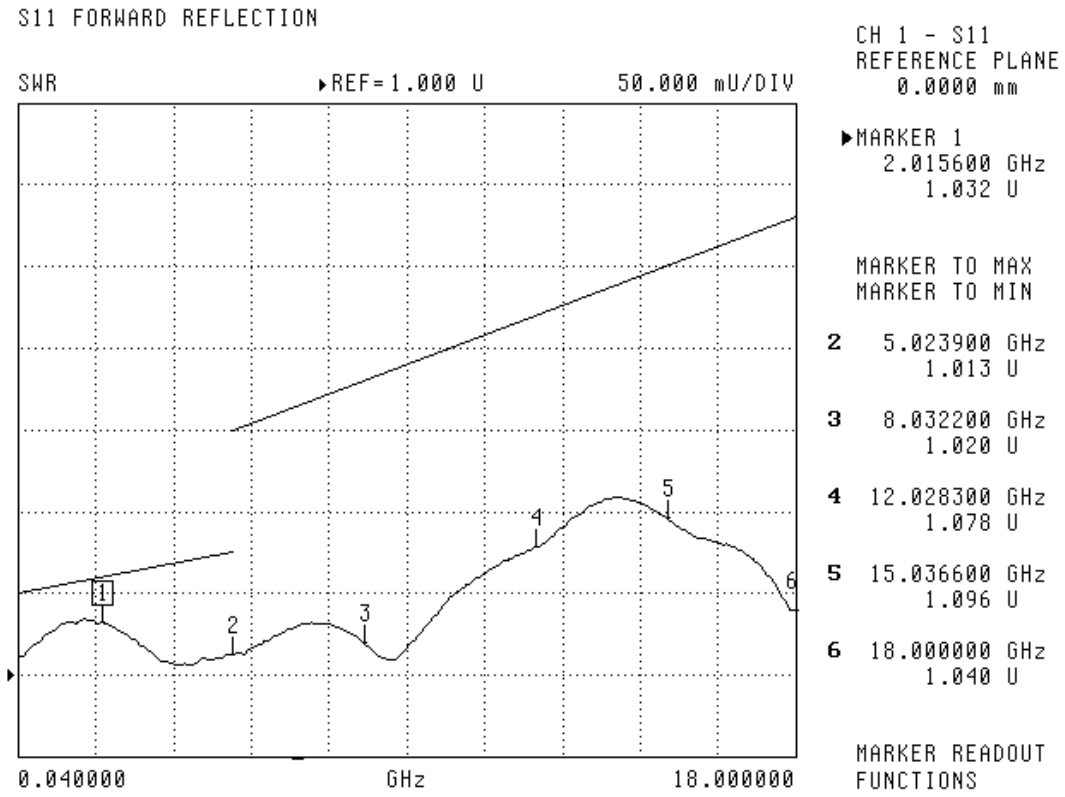


Sample 113

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

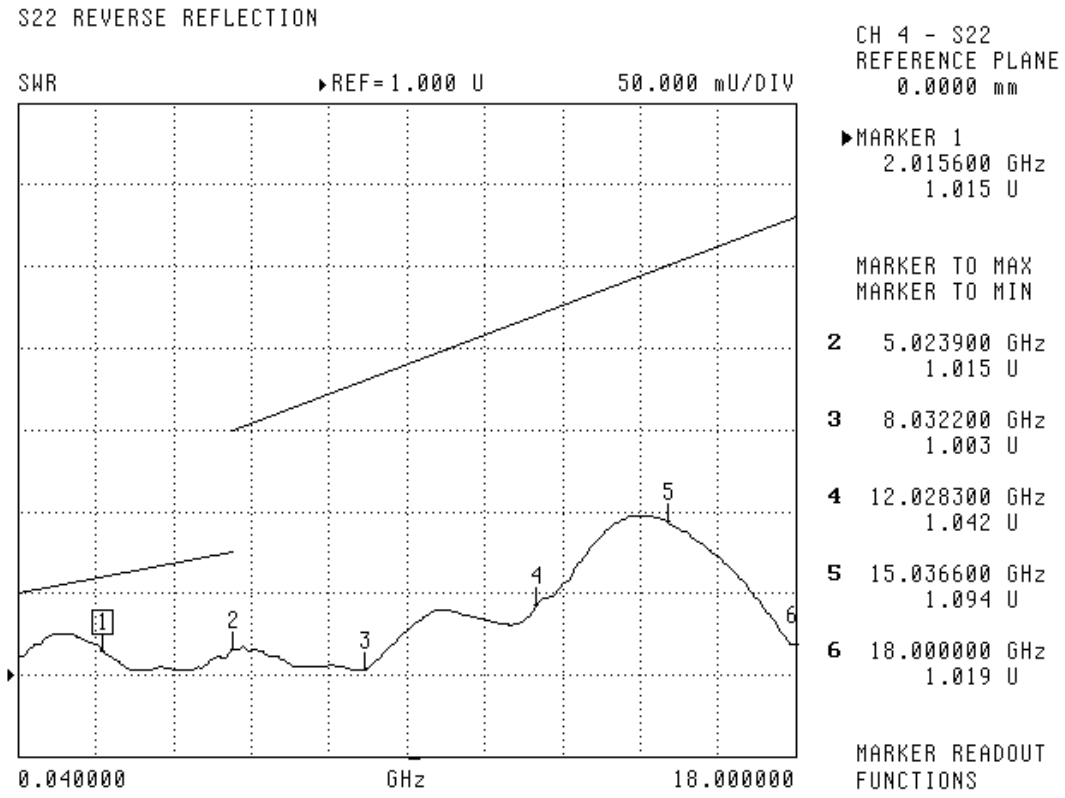


Sample 114

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

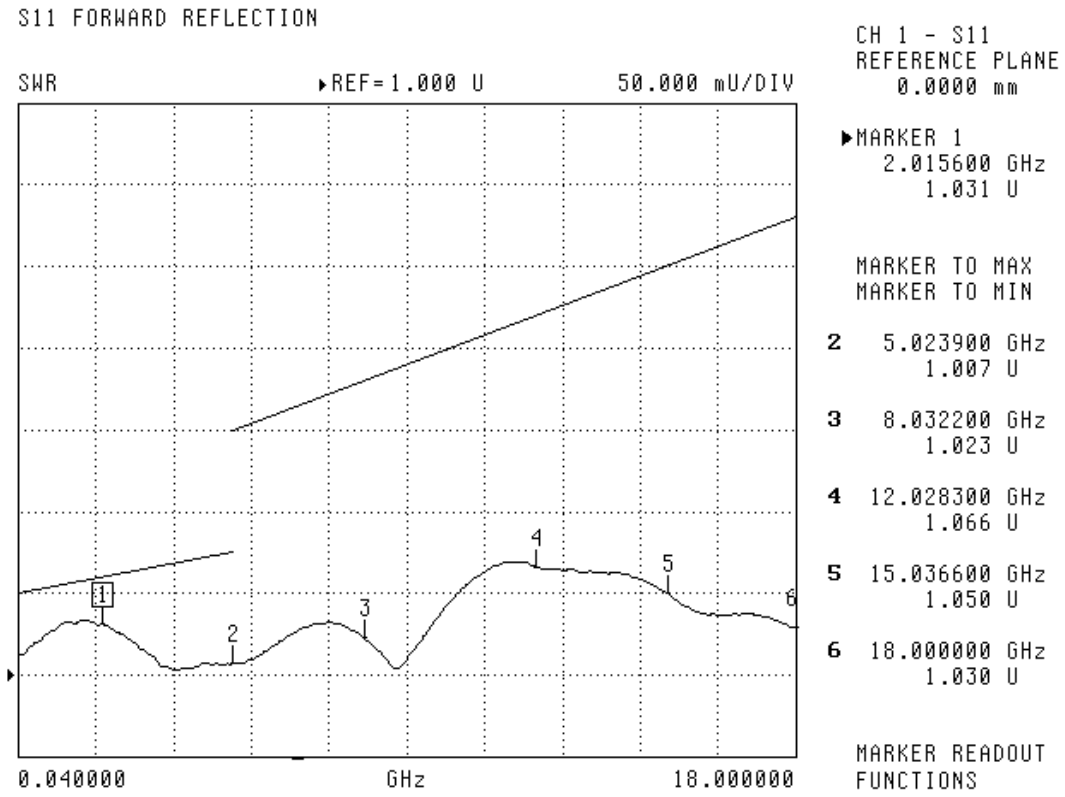


Sample 115

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

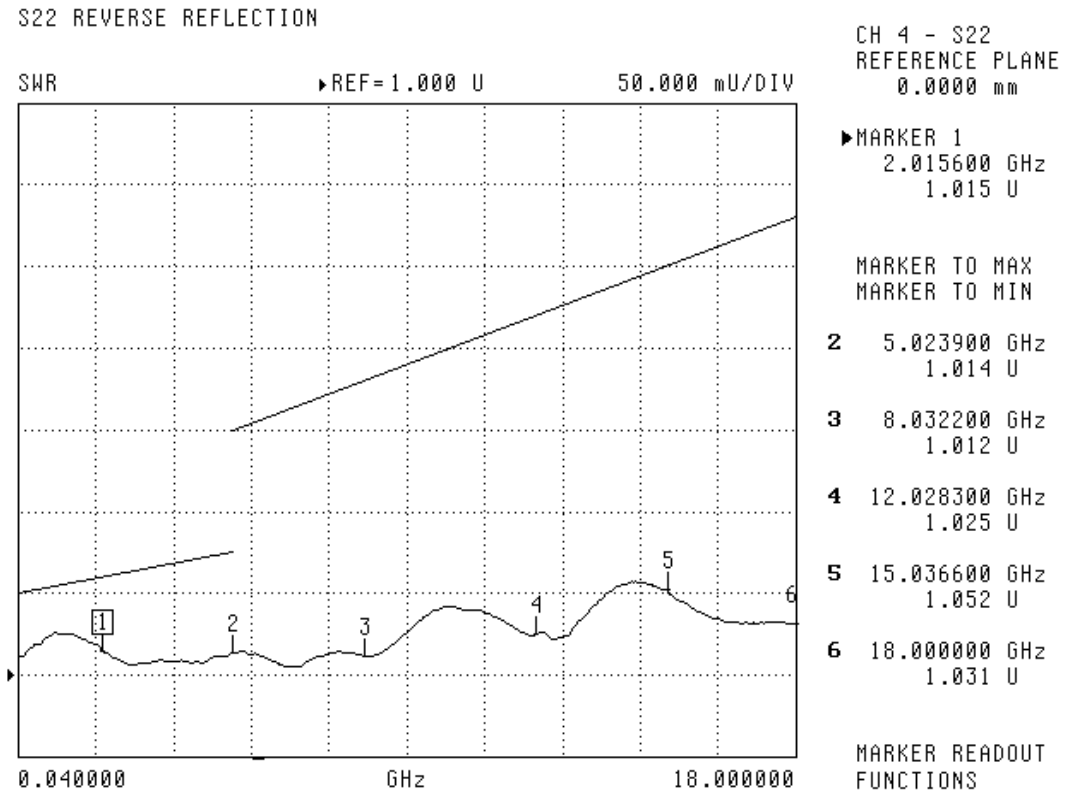


Sample 116

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

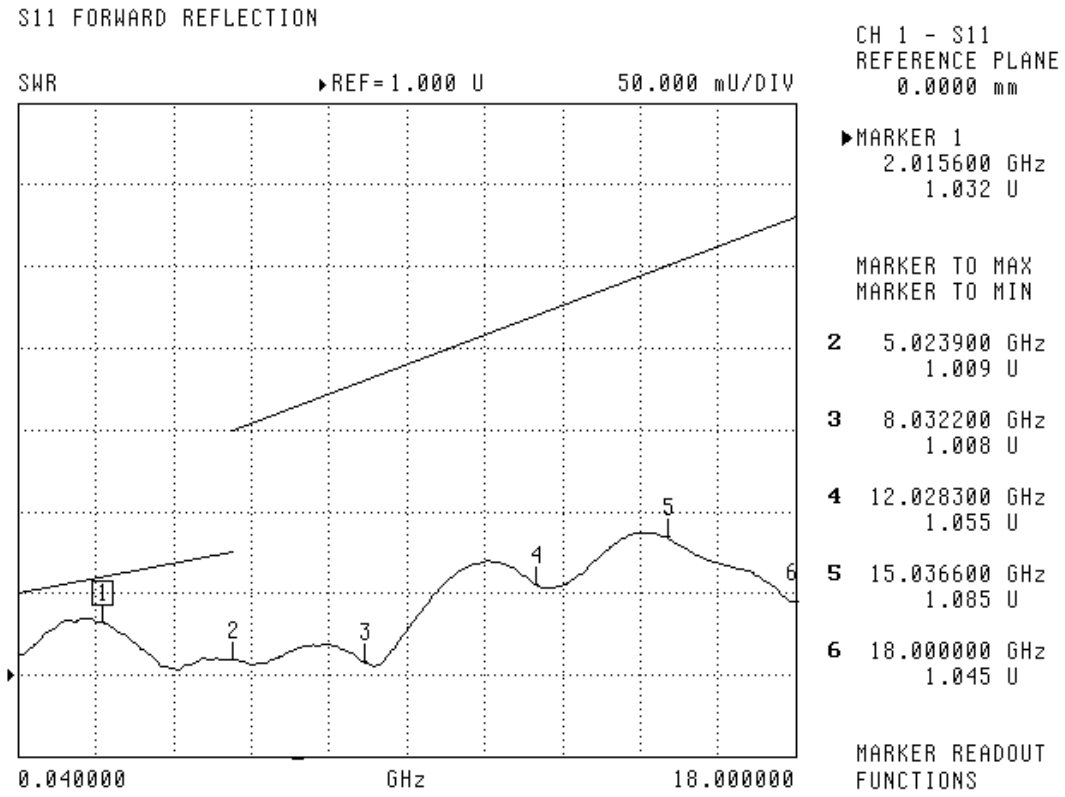


Sample 117

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

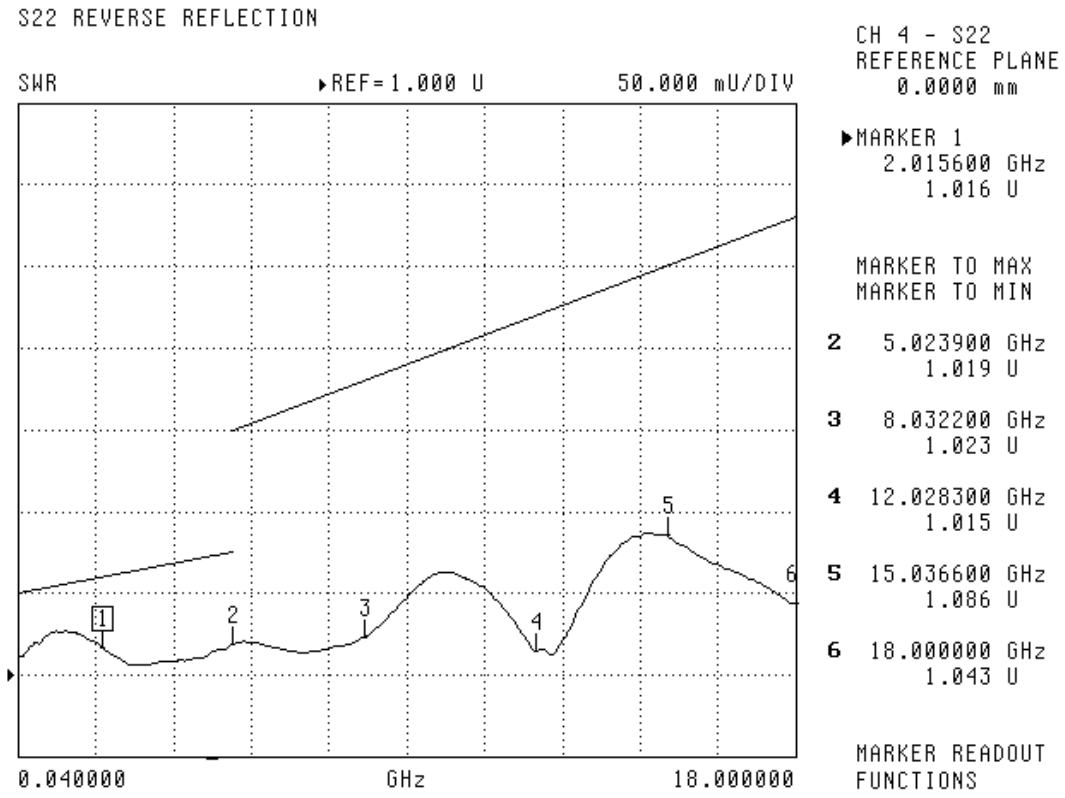


Sample 118

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / Initial measurement 24/01/2006

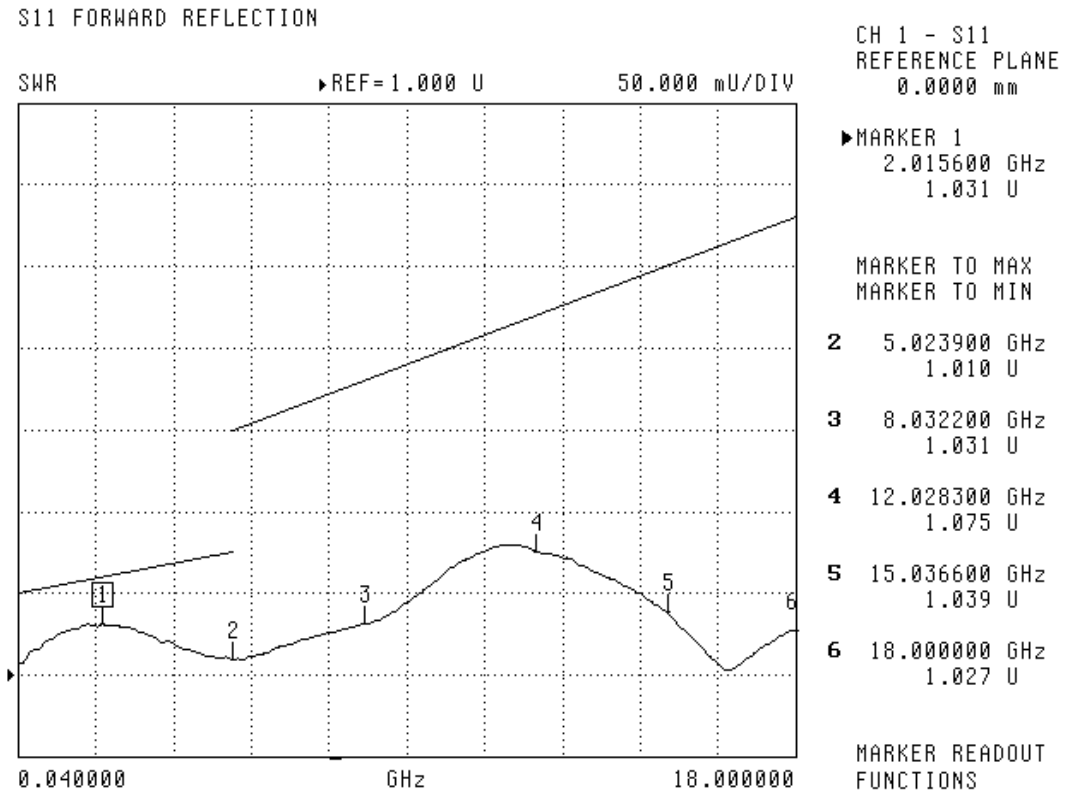


Sample 119

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

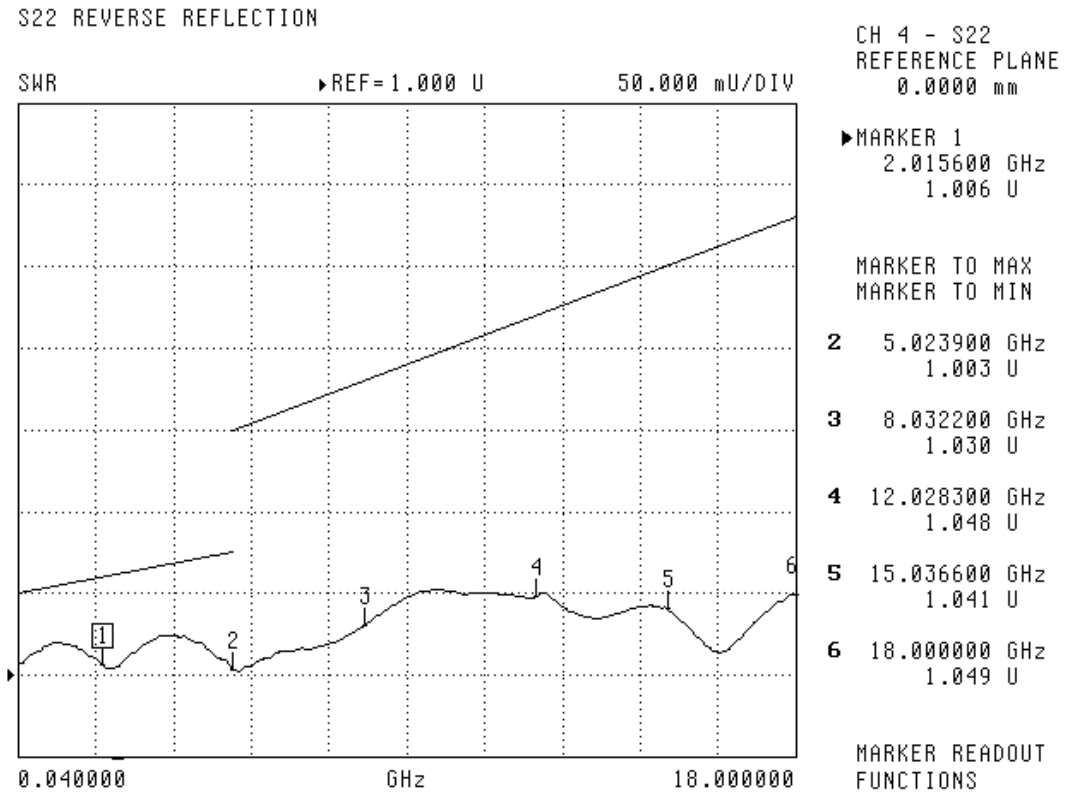


Sample 1

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

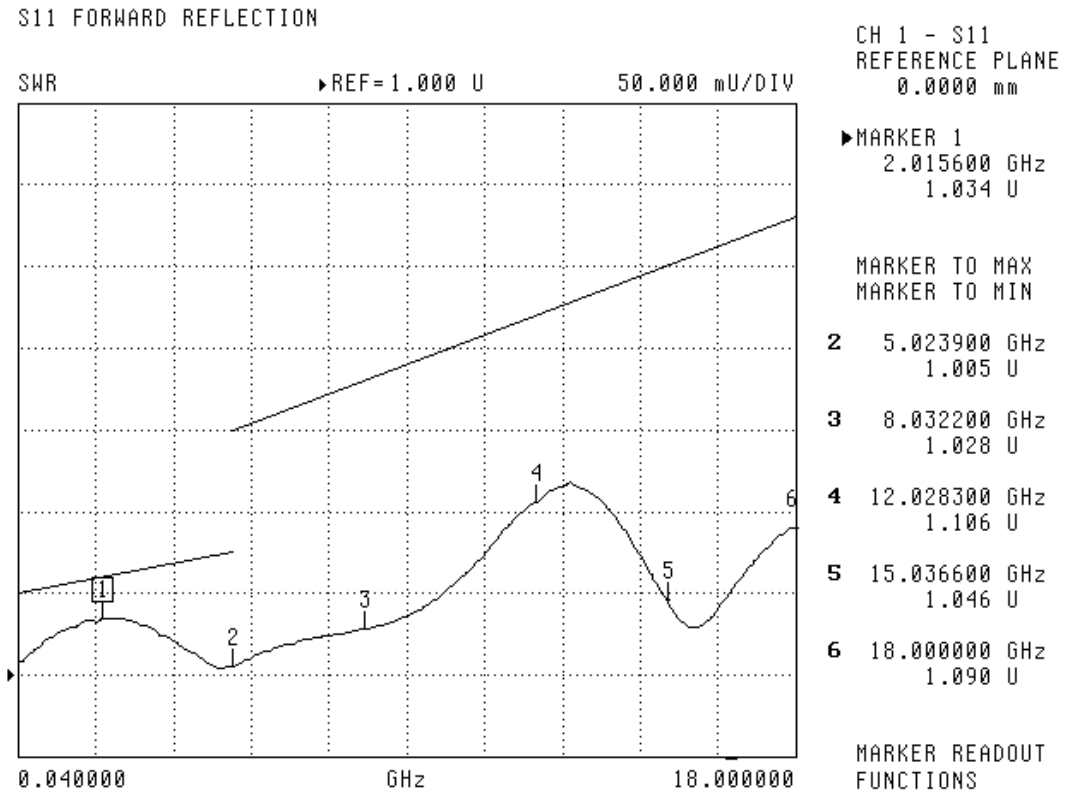


Sample 2

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

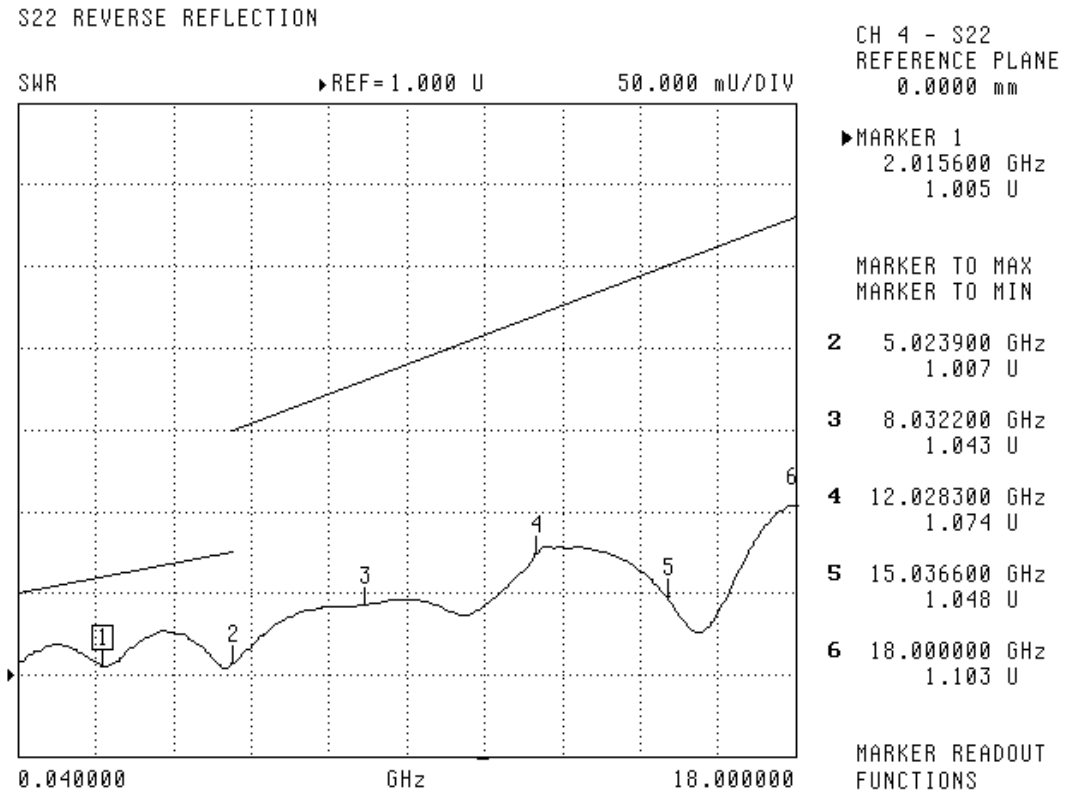


Sample 3

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

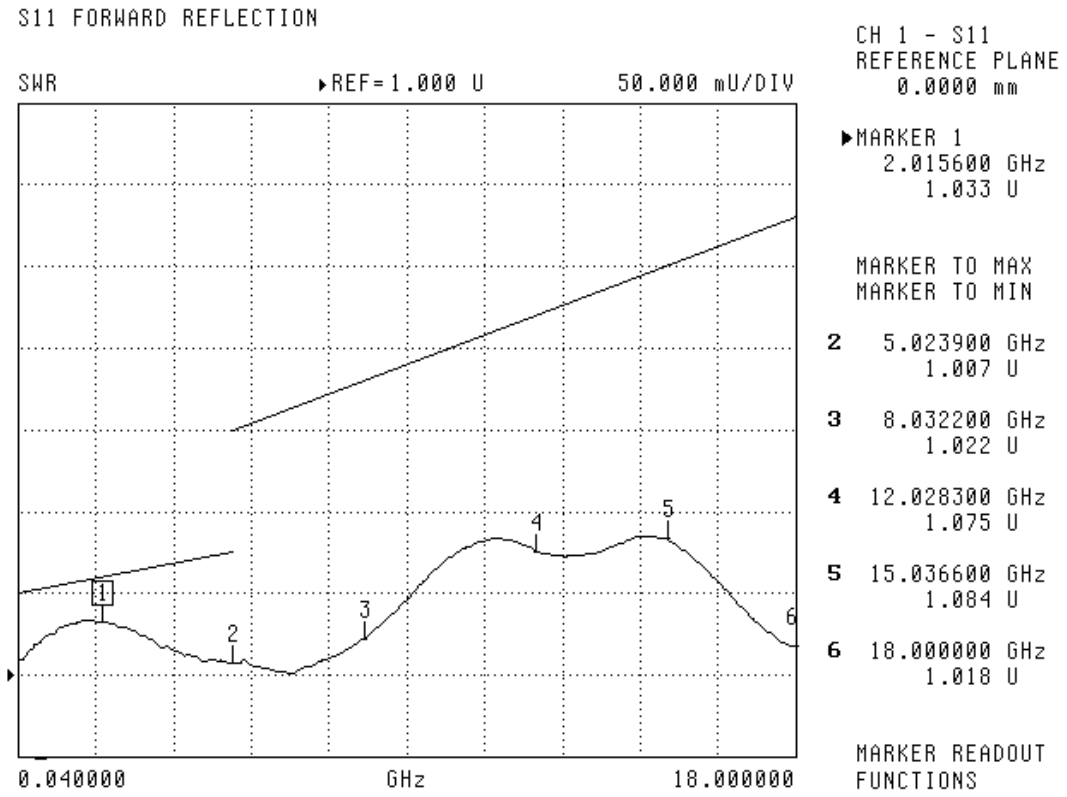


Sample 4

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

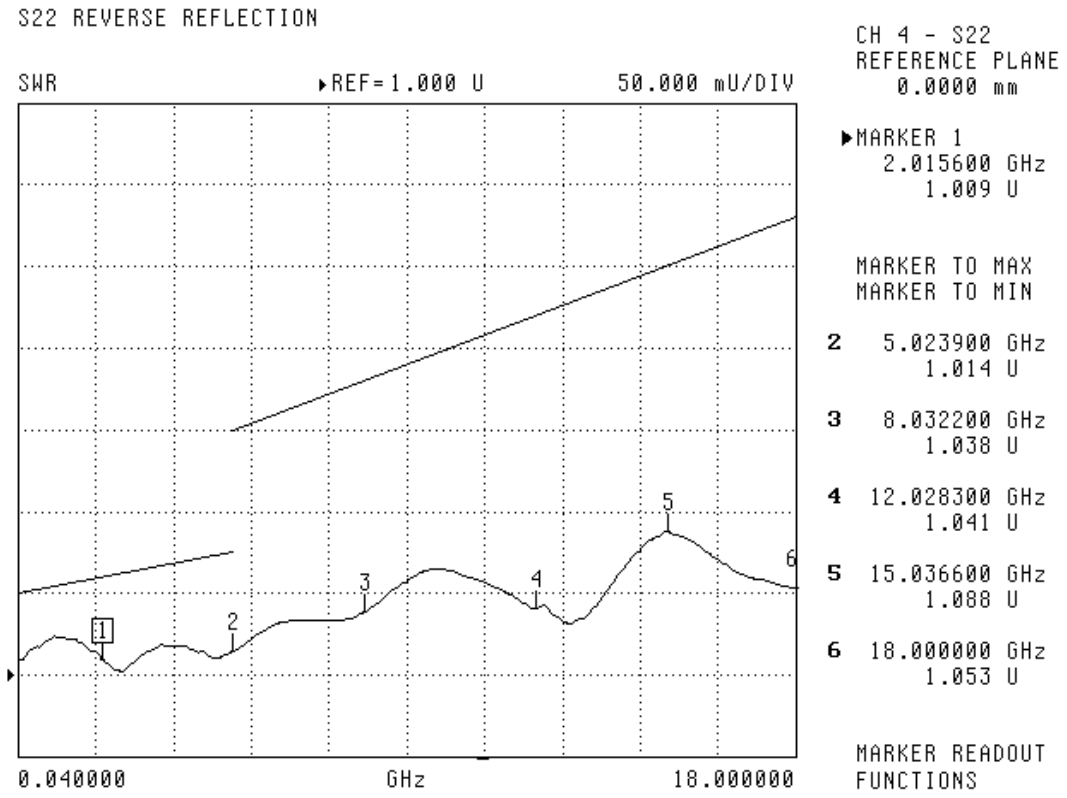


Sample 5

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

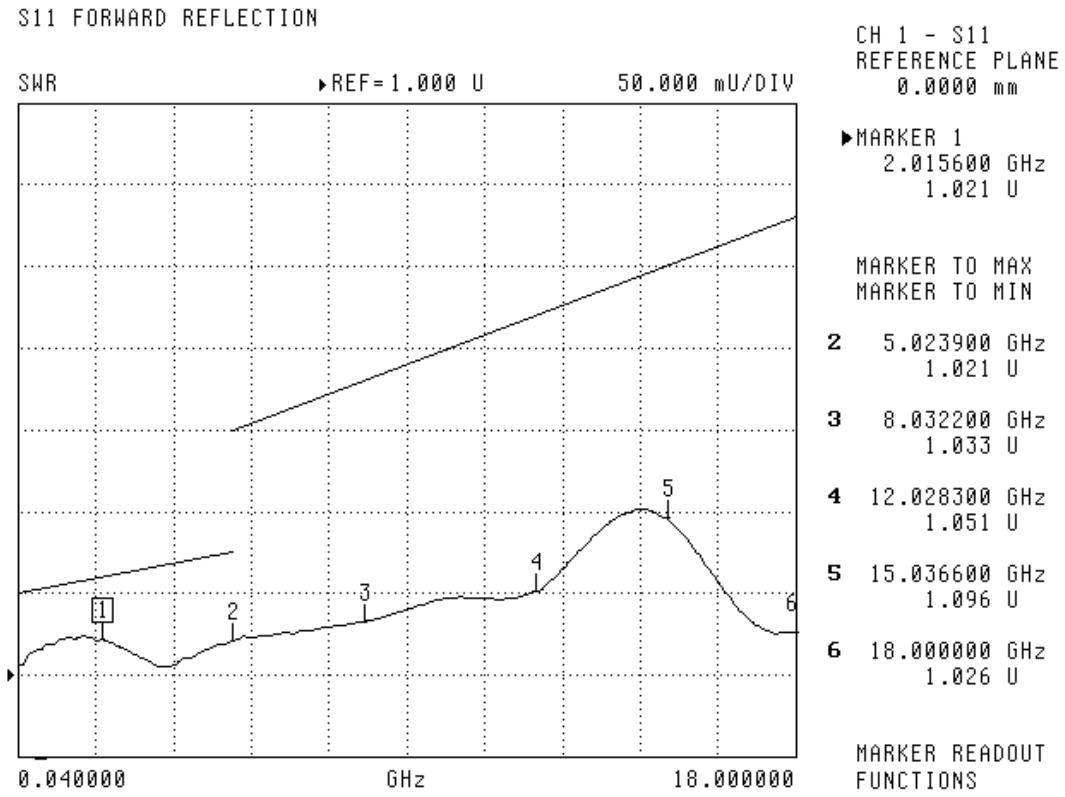


Sample 6

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

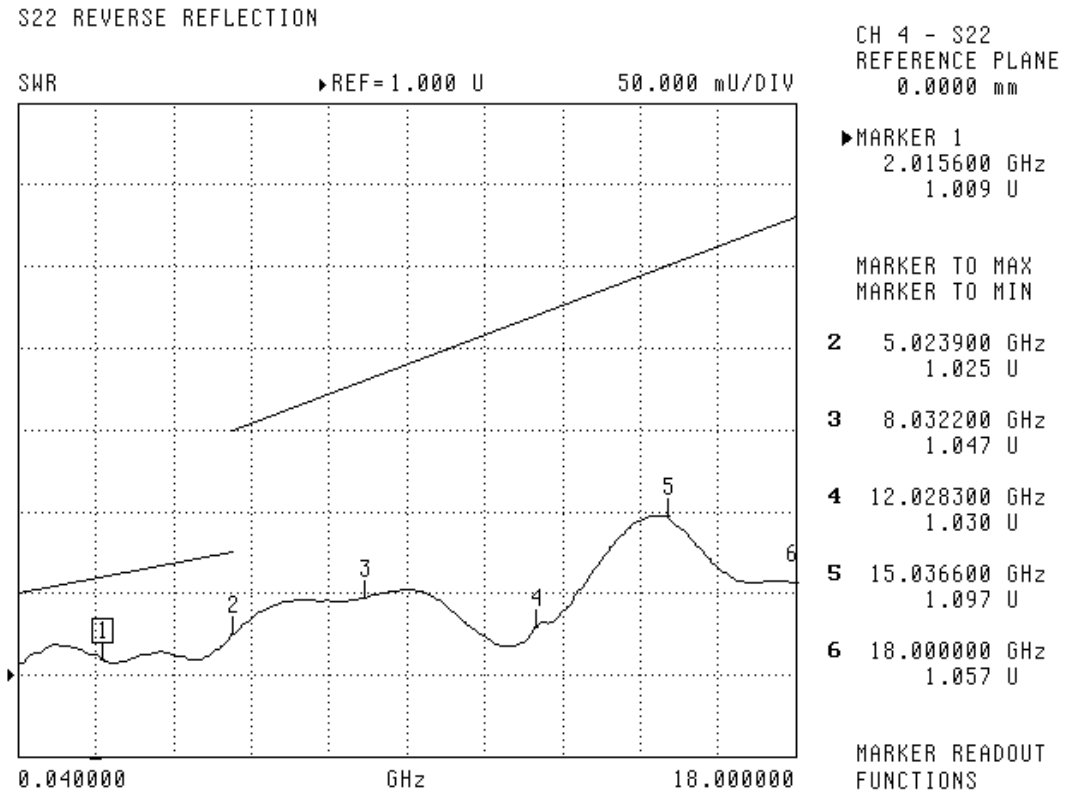


Sample 7

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

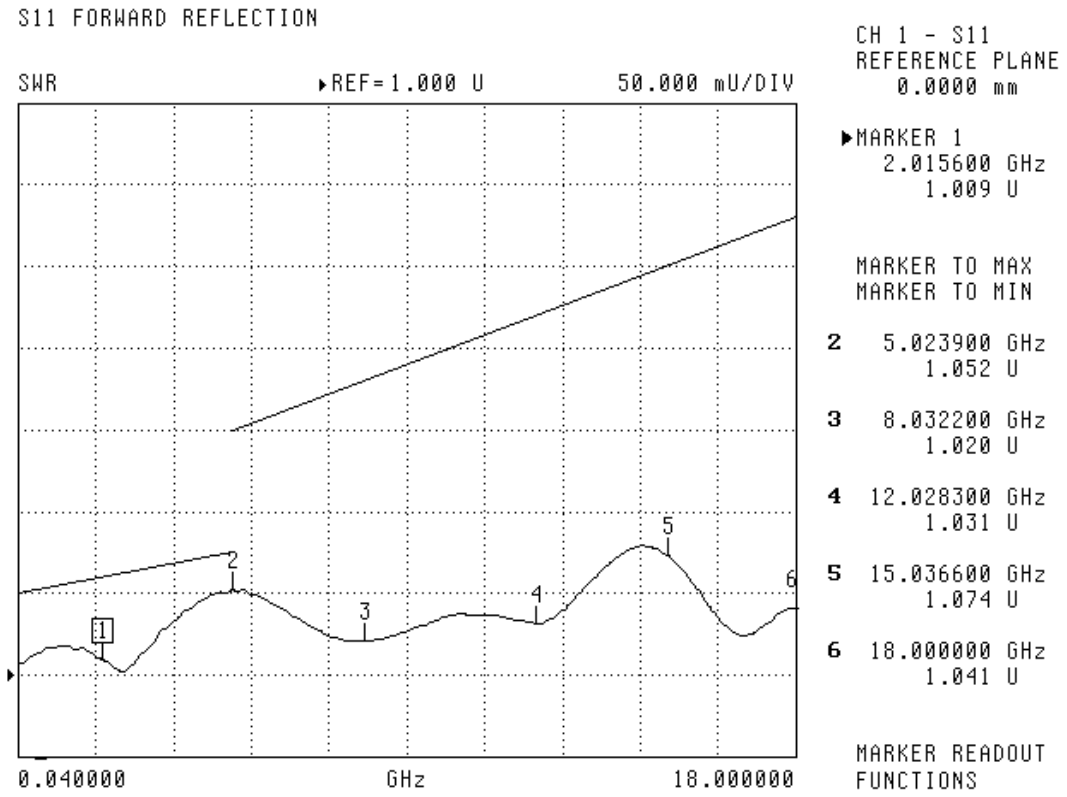


Sample 8

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

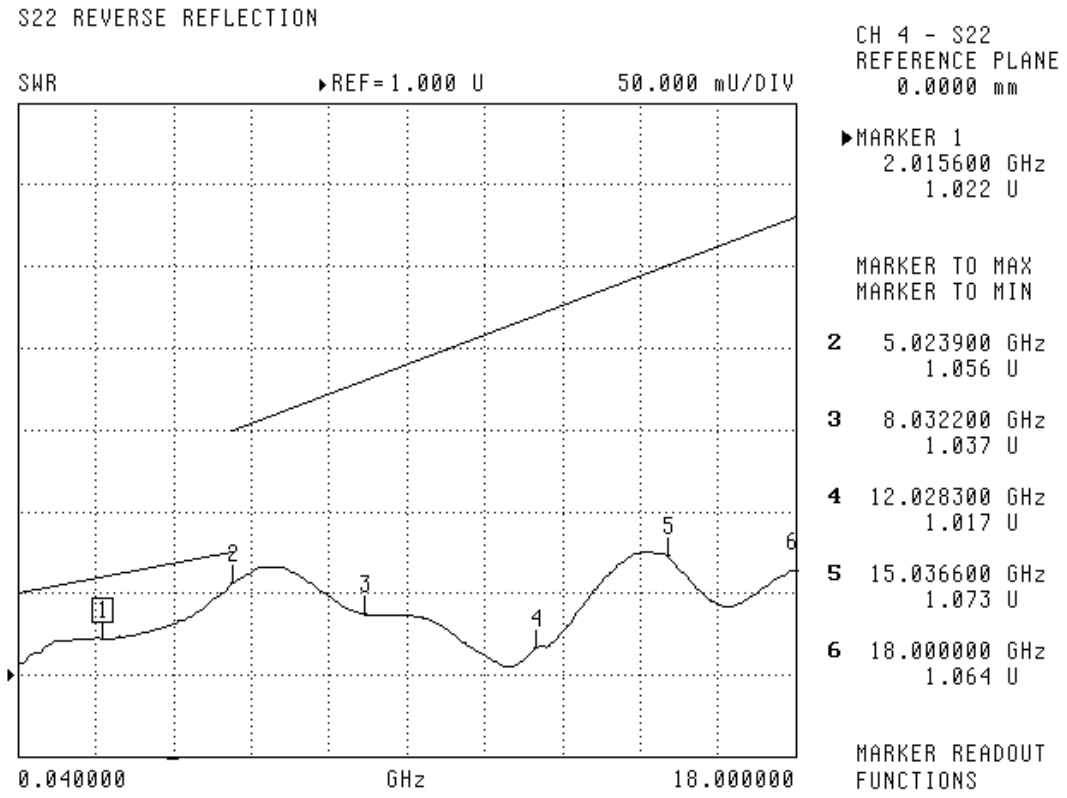


Sample 9

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

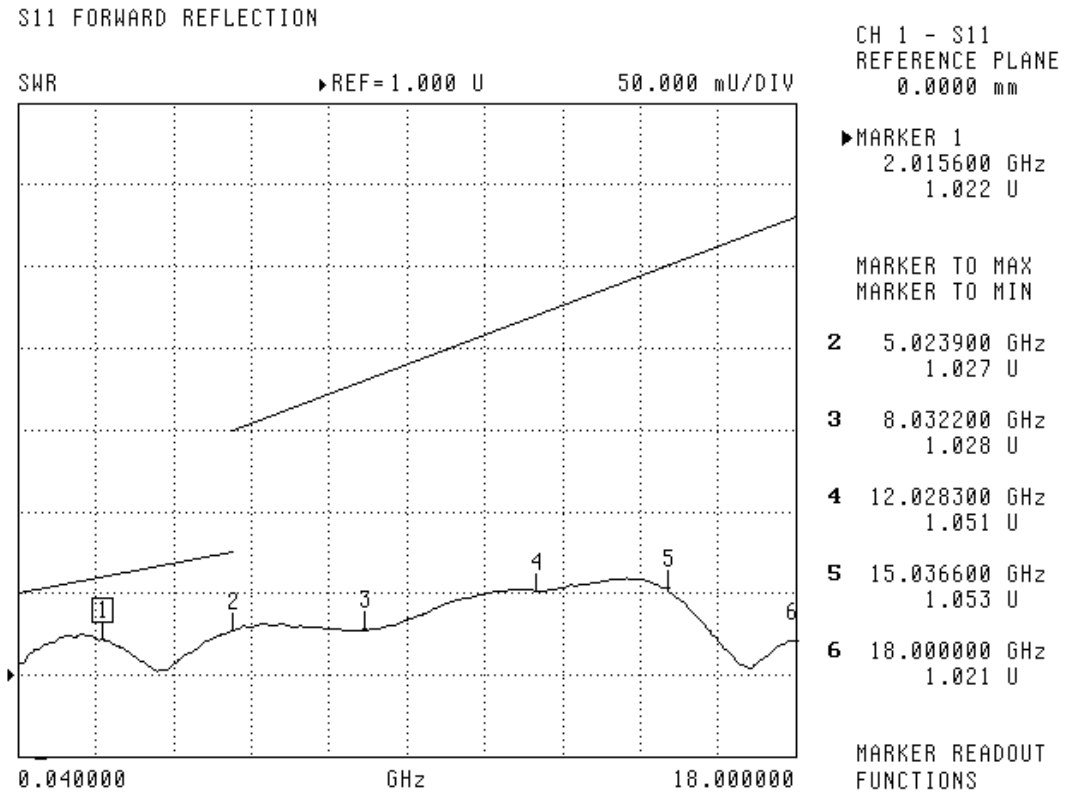


Sample 10

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

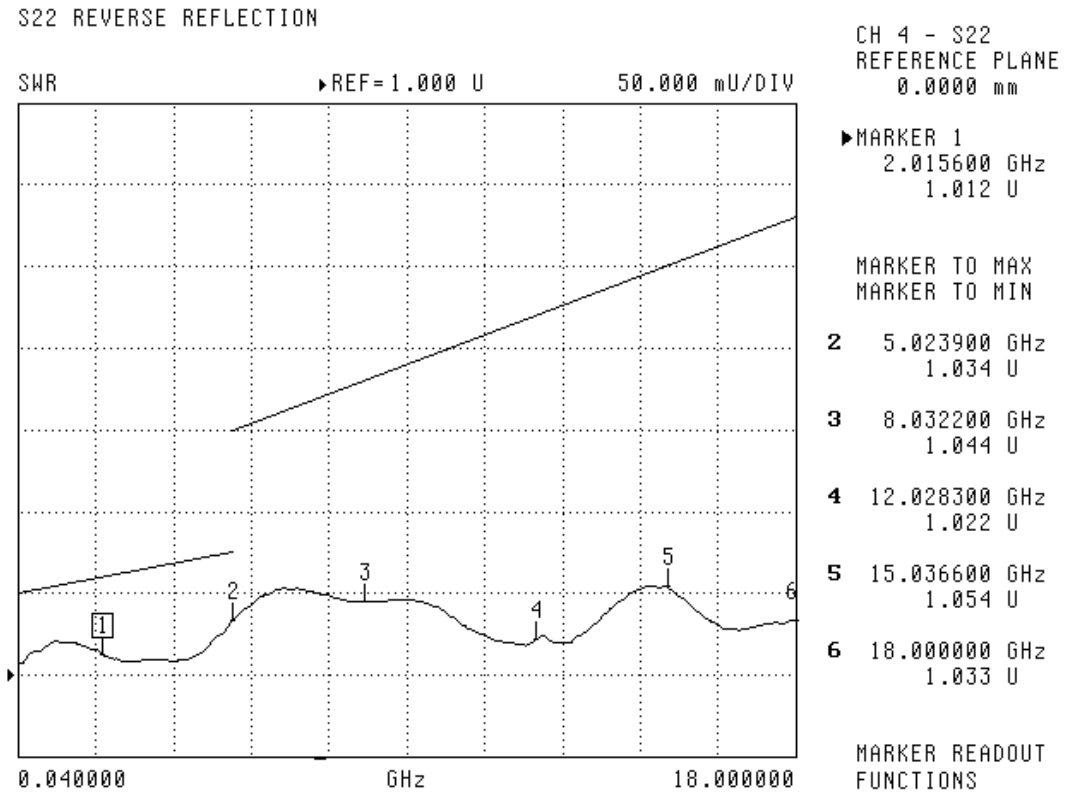


Sample 11

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

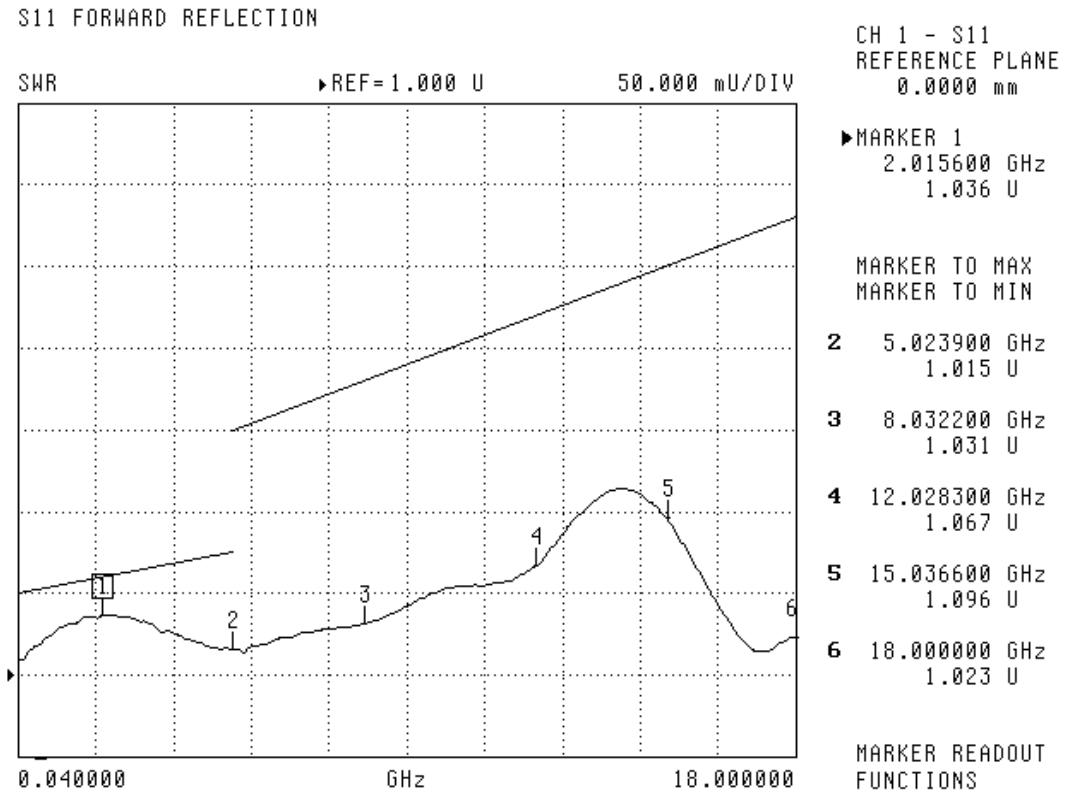


Sample 12

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

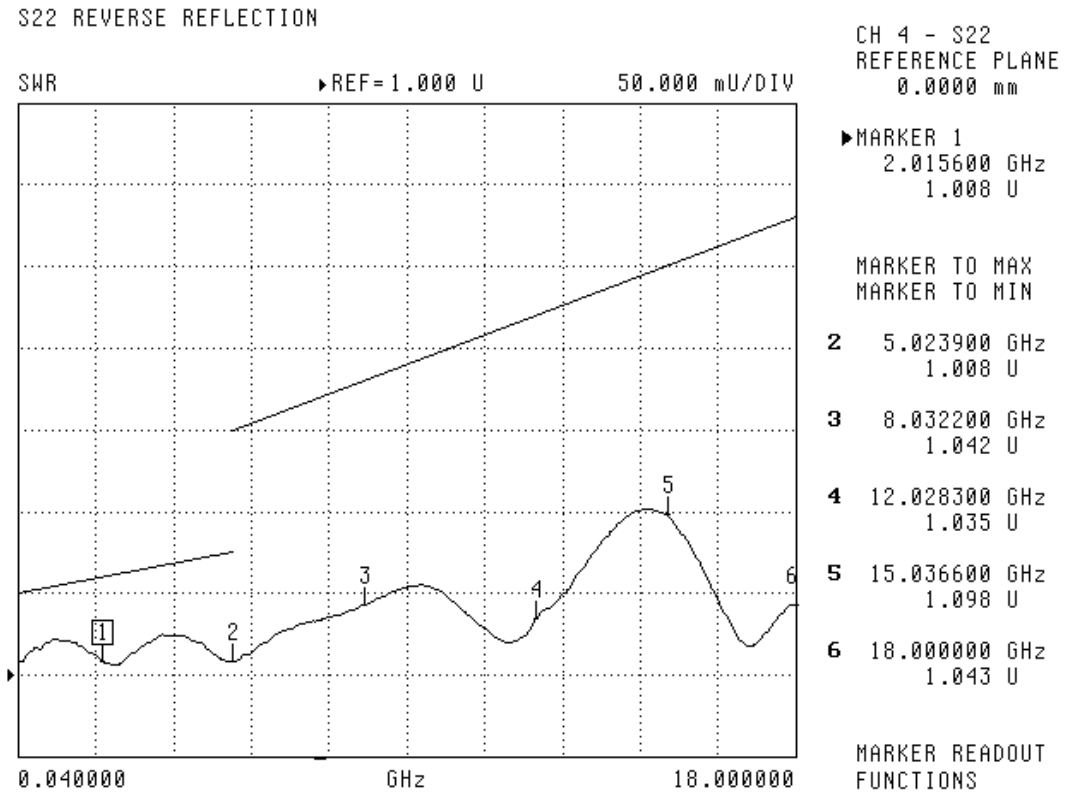


Sample 13

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

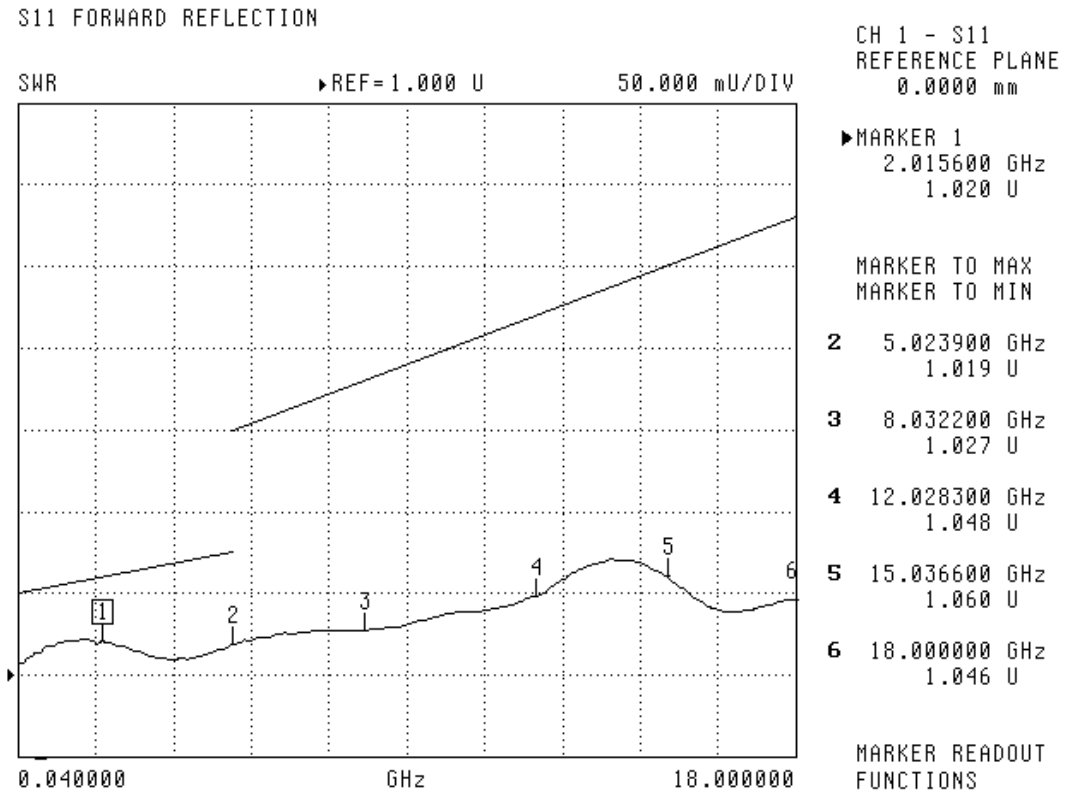


Sample 14

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

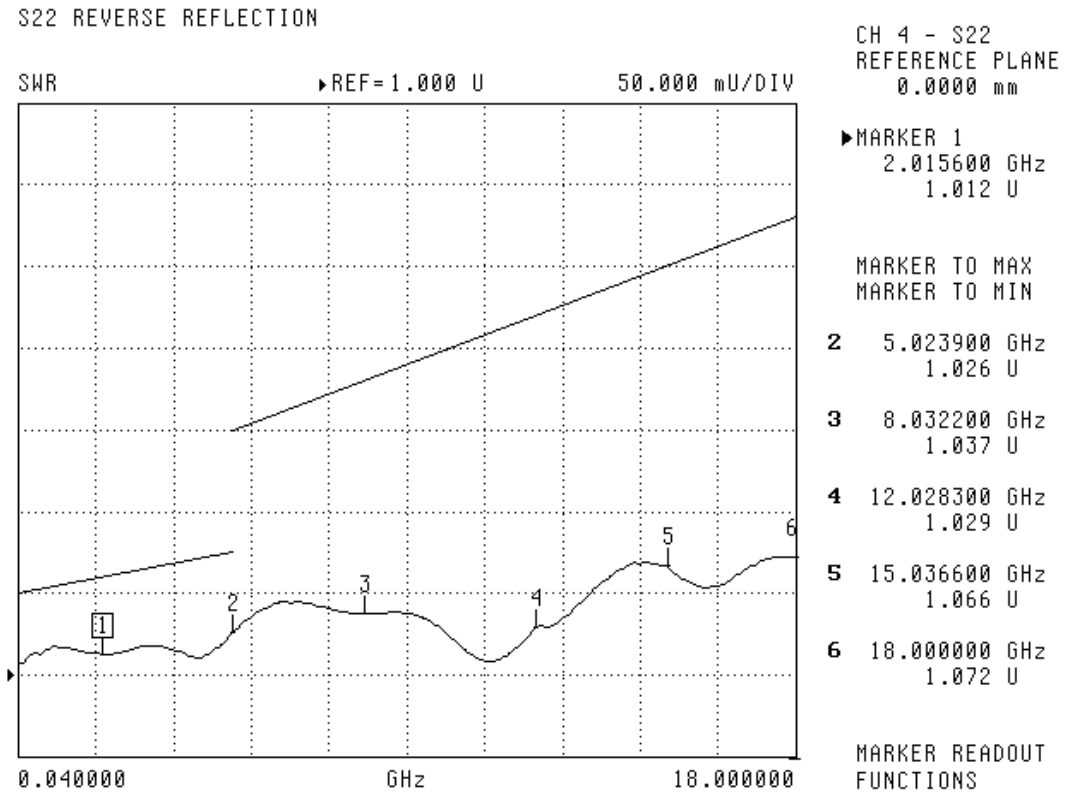


Sample 15

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

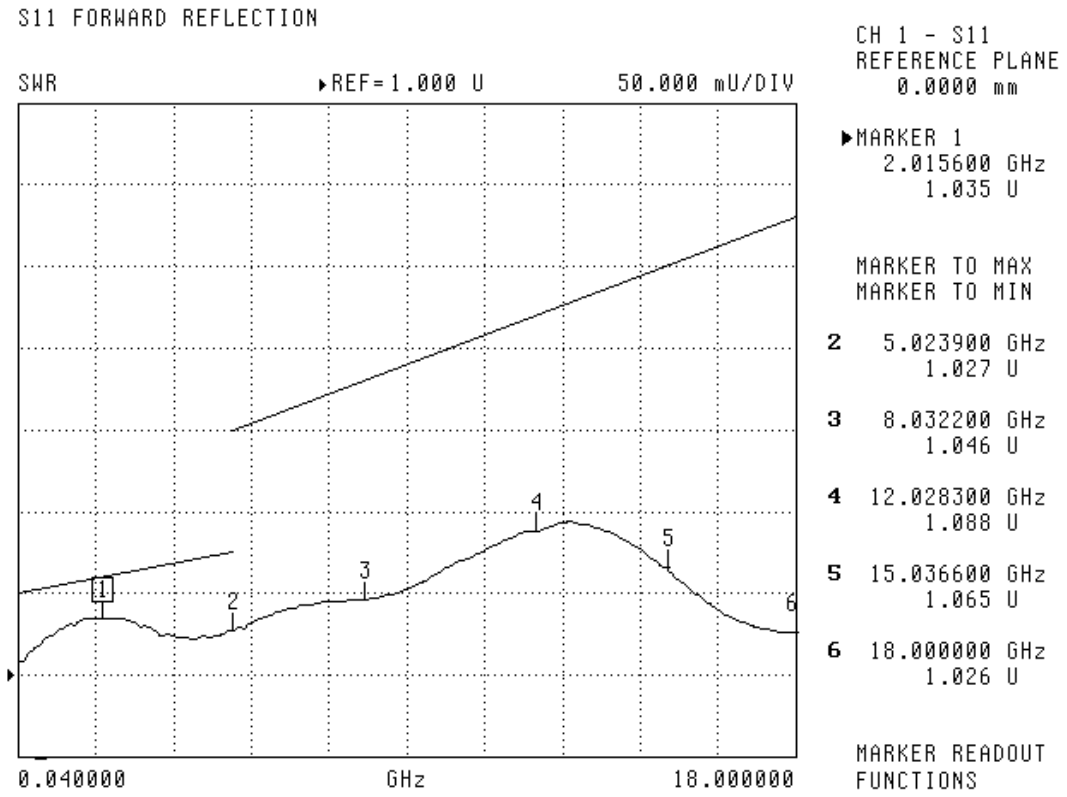


Sample 16

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

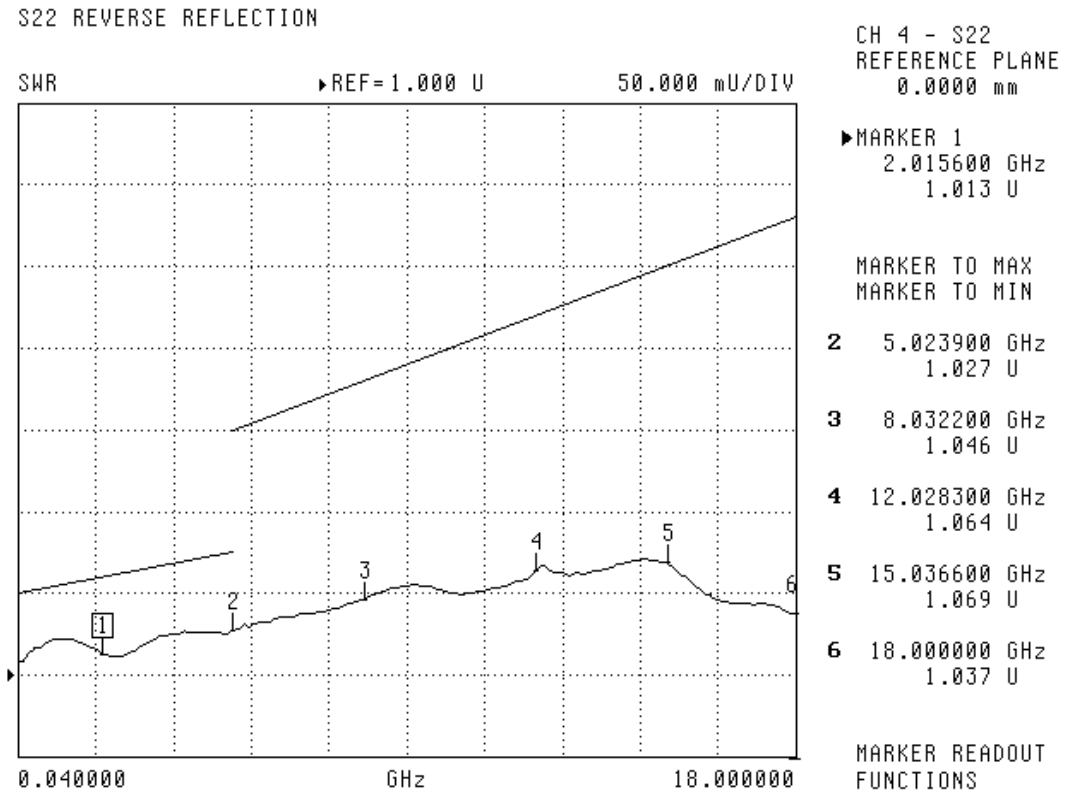


Sample 17

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

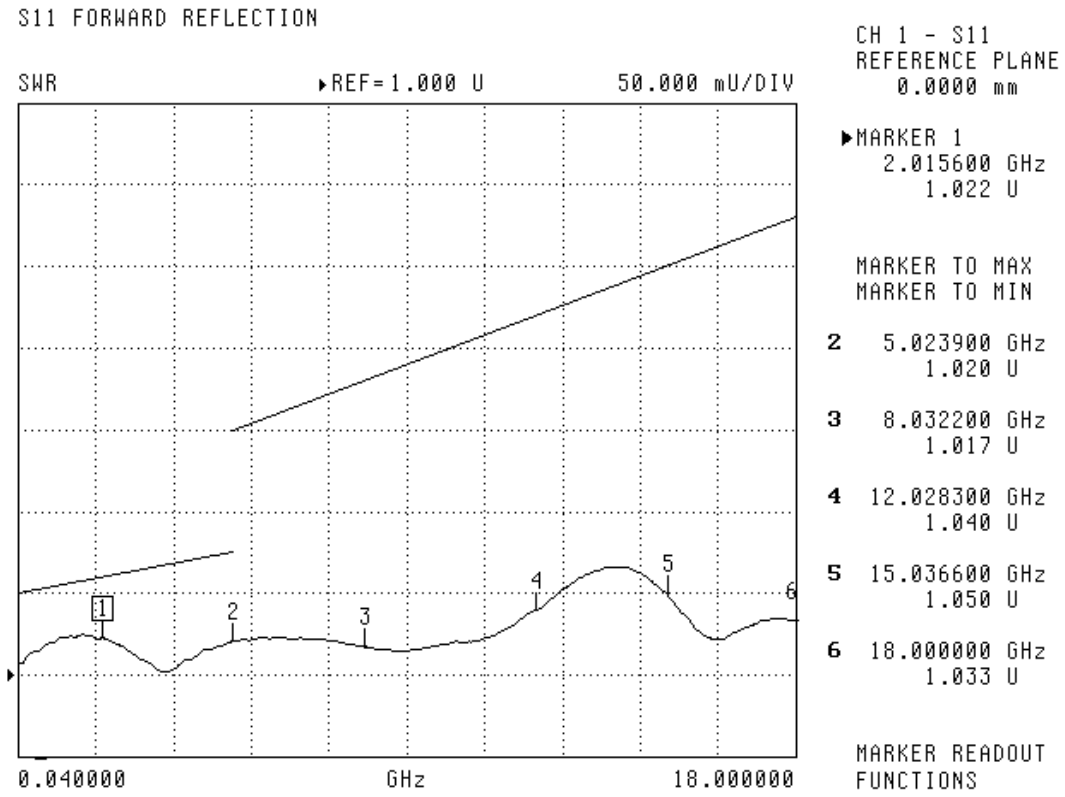


Sample 18

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

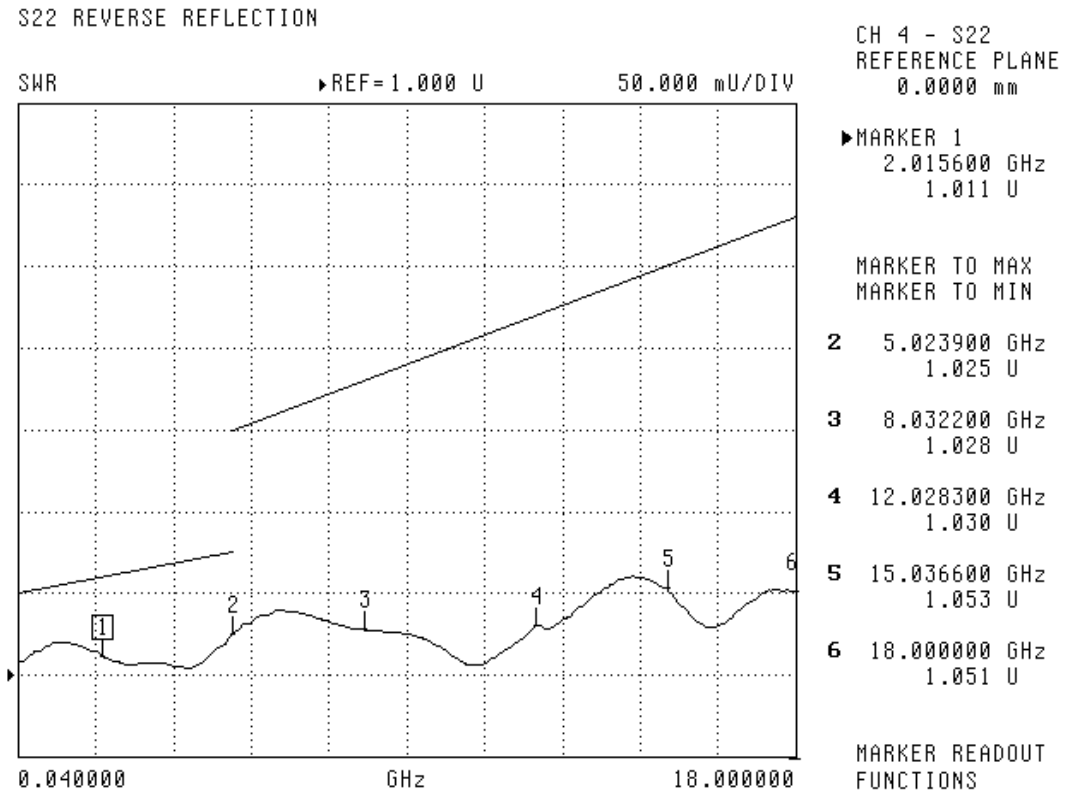


Sample 19

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

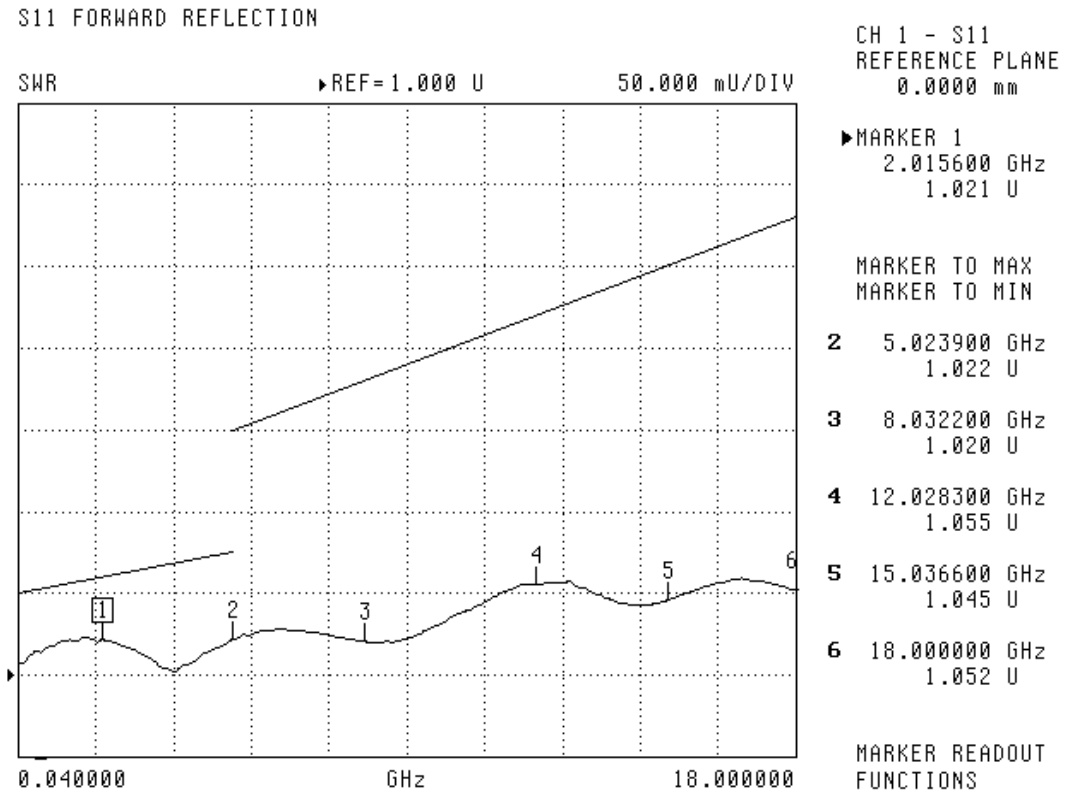


Sample 20

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

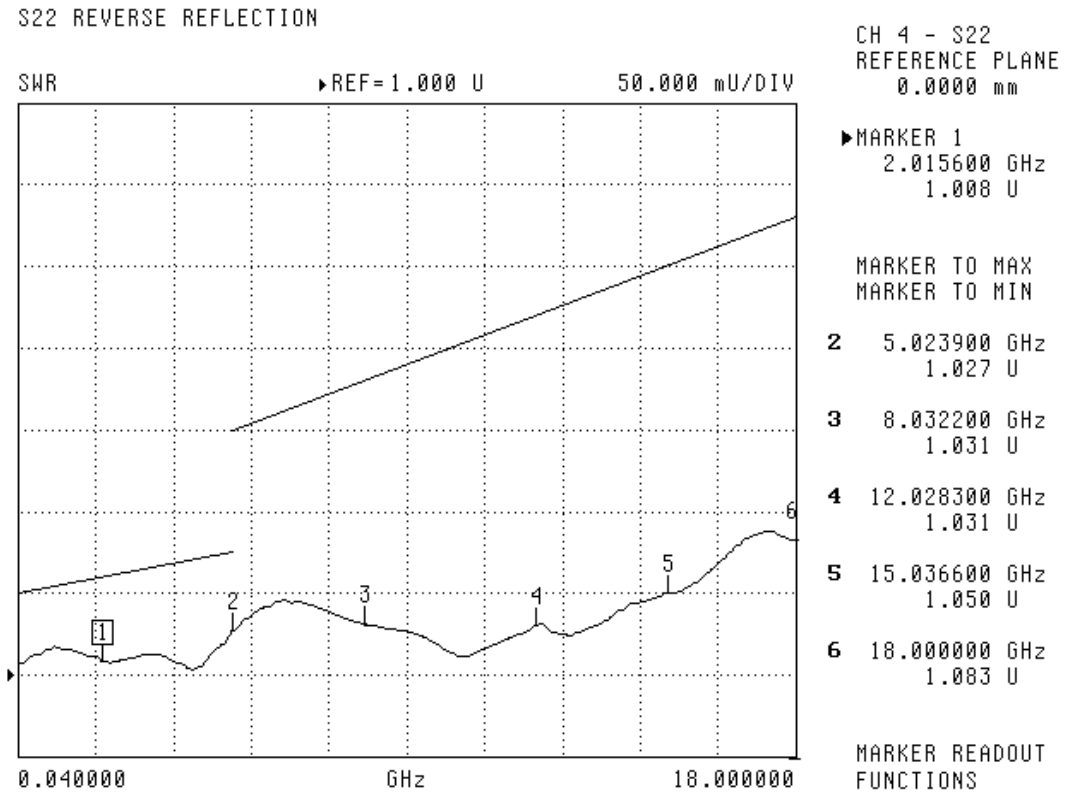


Sample 21

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

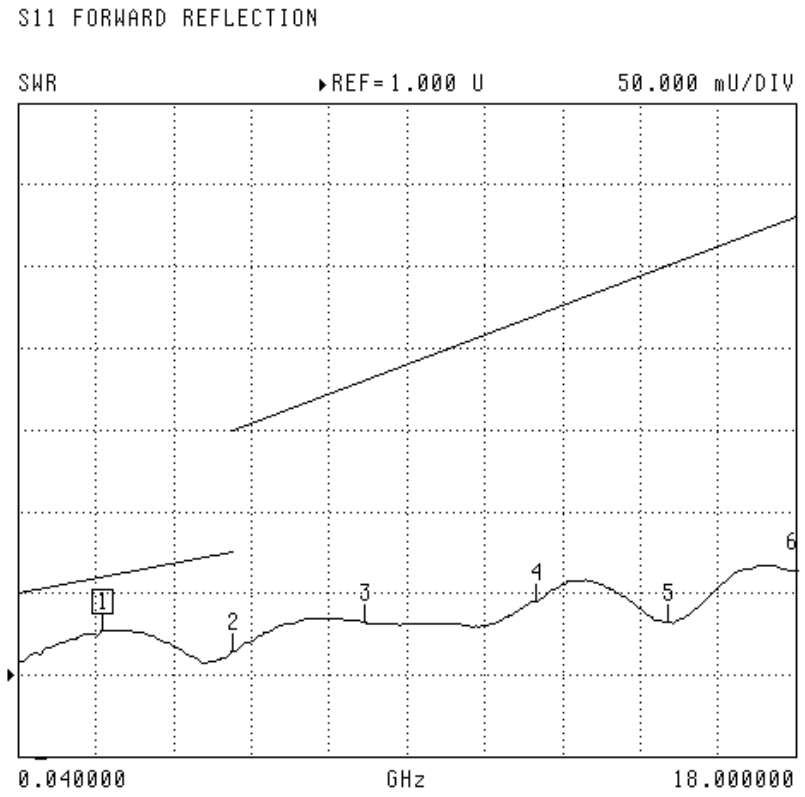


Sample 22

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006



CH 1 - S11
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
1.027 U

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
1.014 U

3 8.032200 GHz
1.032 U

4 12.028300 GHz
1.045 U

5 15.036600 GHz
1.032 U

6 18.000000 GHz
1.064 U

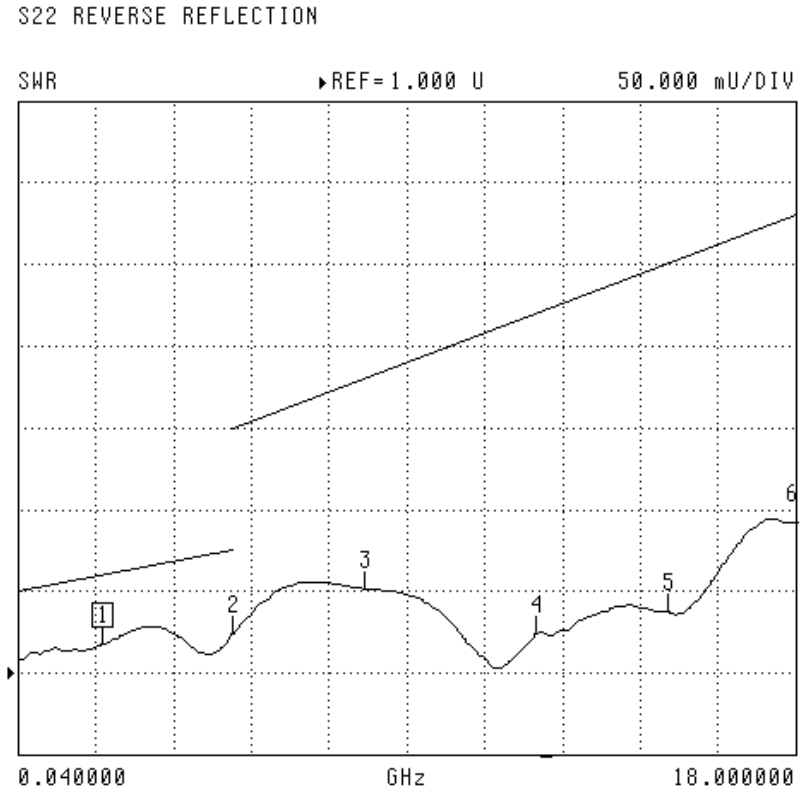
MARKER READOUT
FUNCTIONS

Sample 23

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006



CH 4 - S22
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
1.017 U

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
1.024 U

3 8.032200 GHz
1.051 U

4 12.028300 GHz
1.024 U

5 15.036600 GHz
1.038 U

6 18.000000 GHz
1.091 U

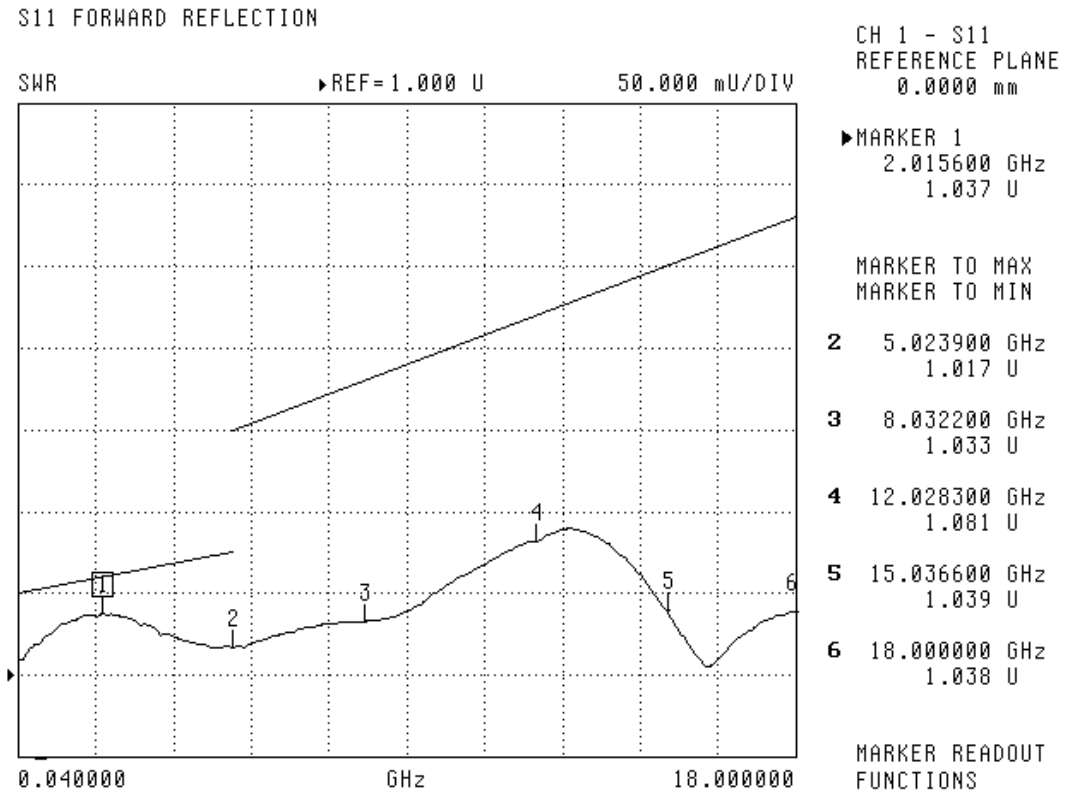
MARKER READOUT
FUNCTIONS

Sample 24

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

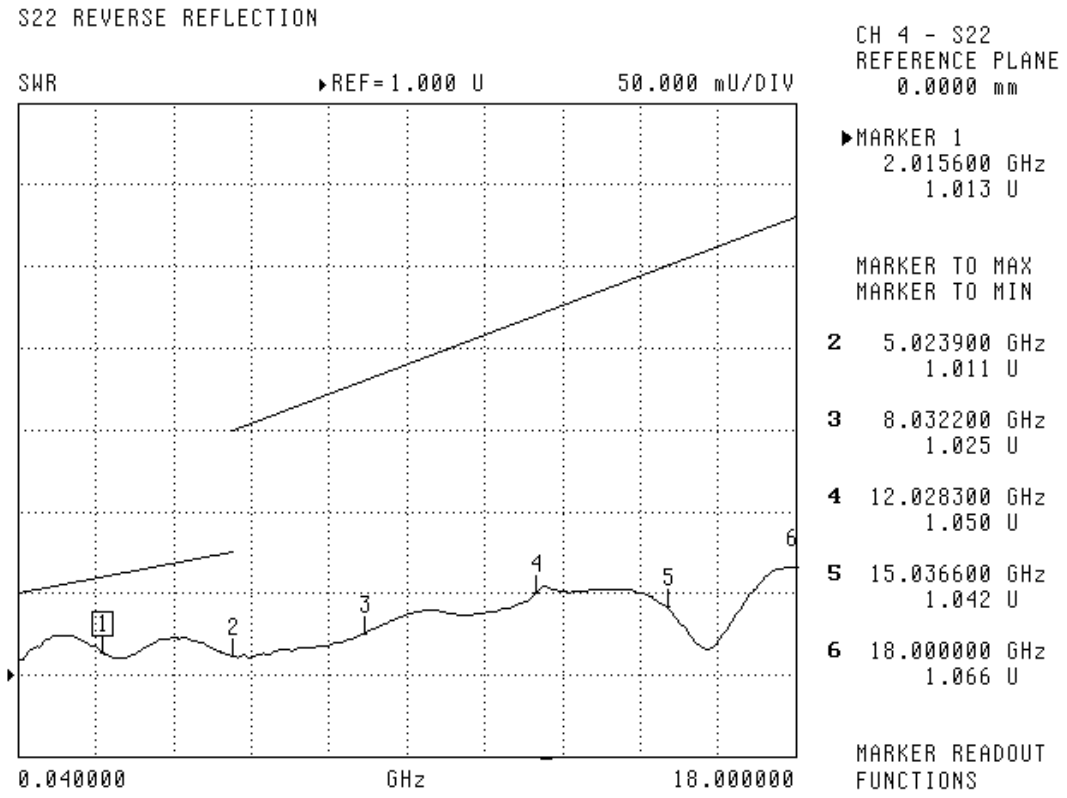


Sample 25

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

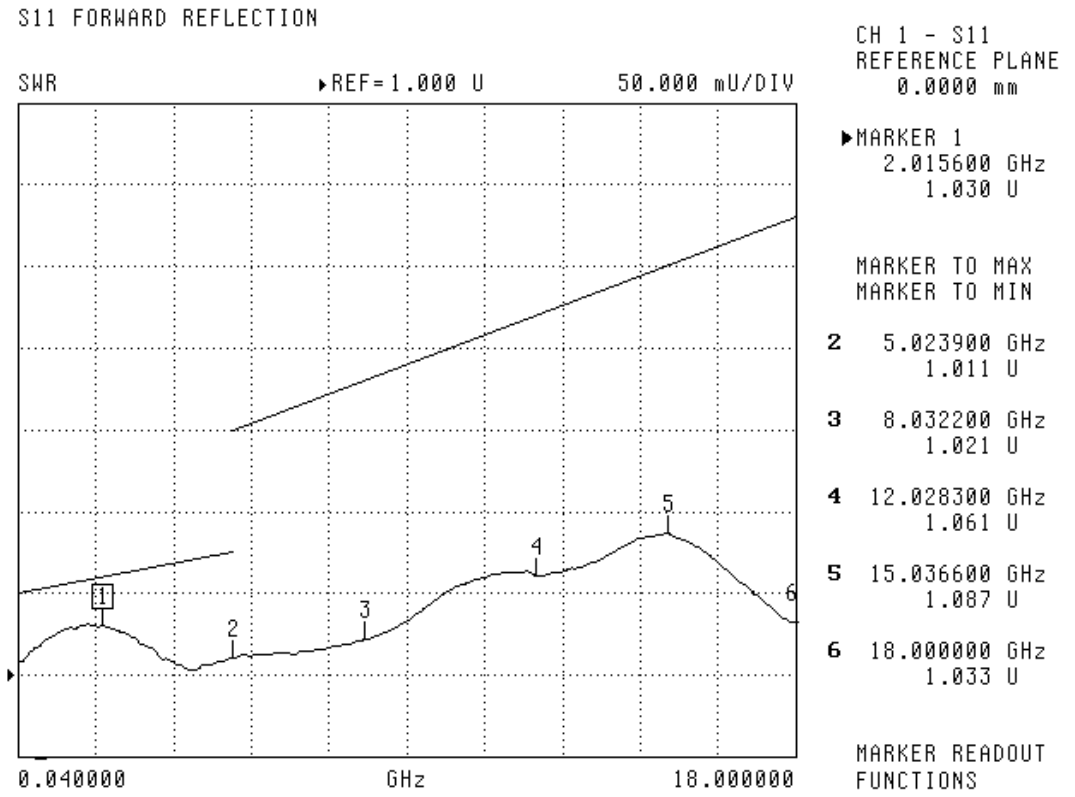


Sample 26

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

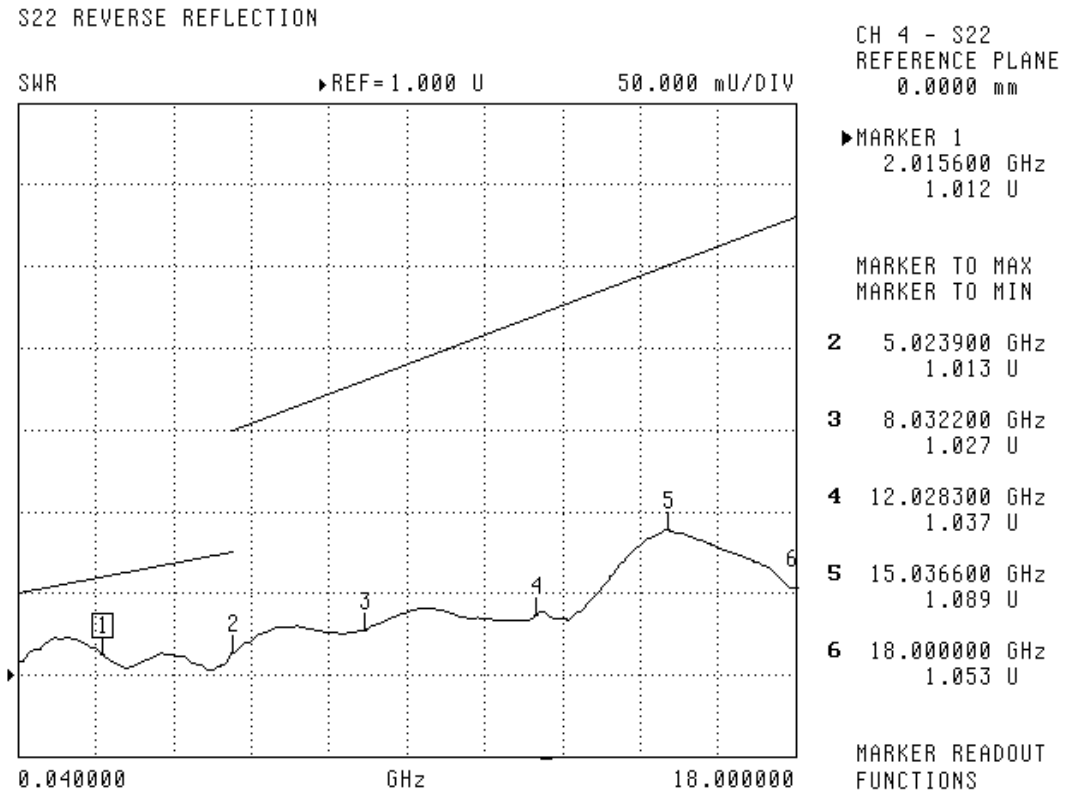


Sample 27

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

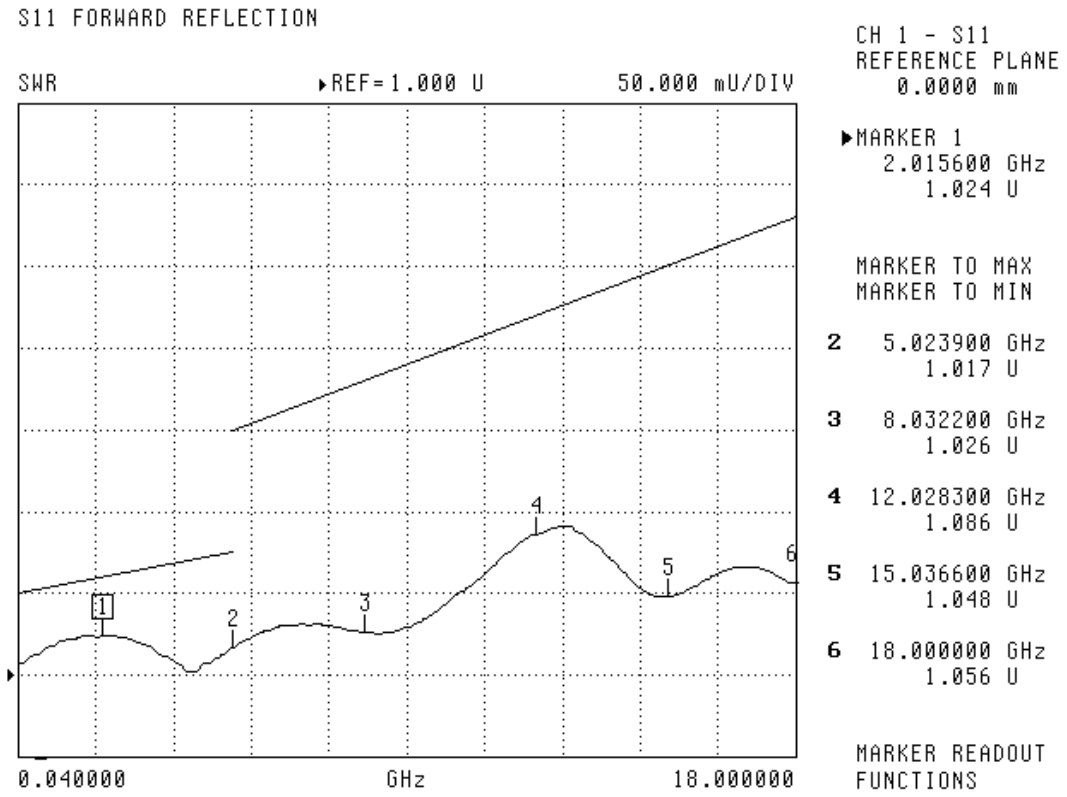


Sample 28

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

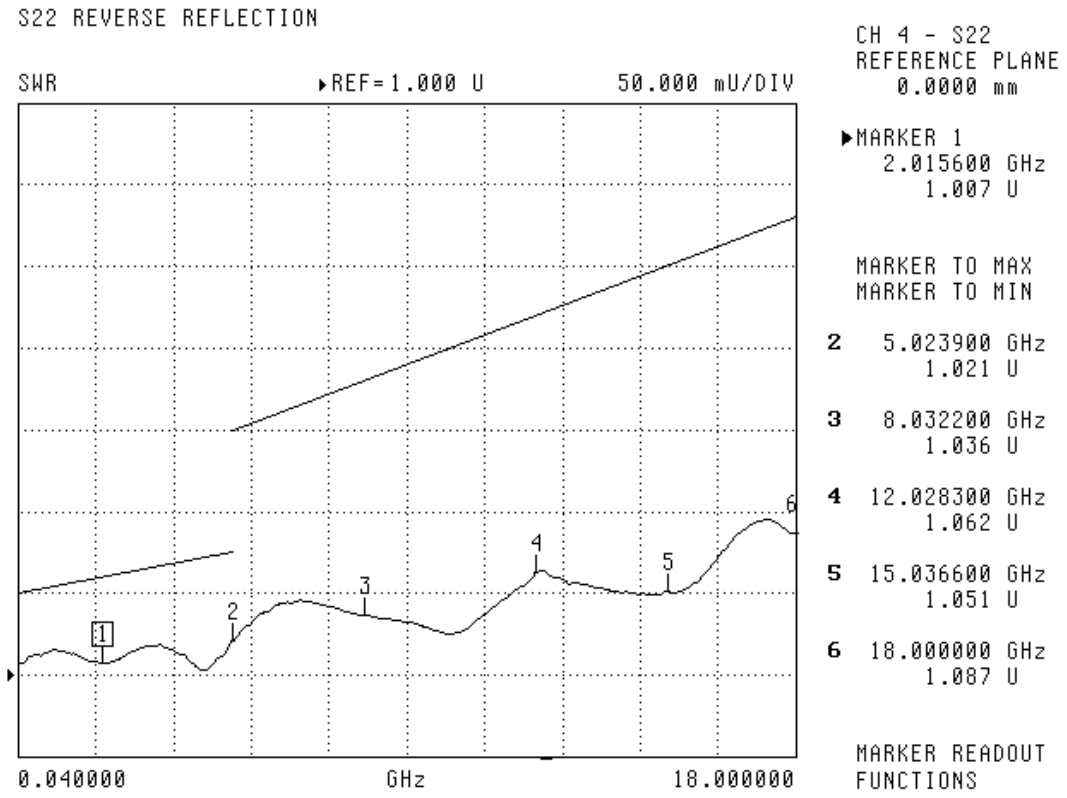


Sample 29

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

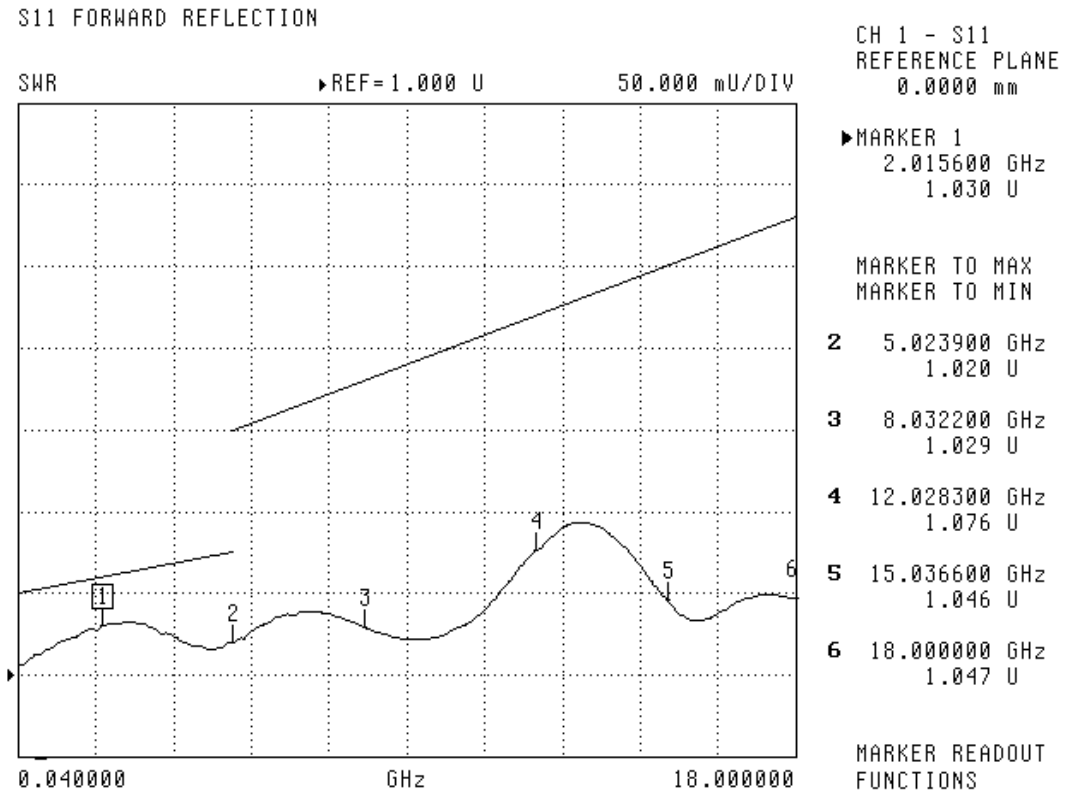


Sample 30

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

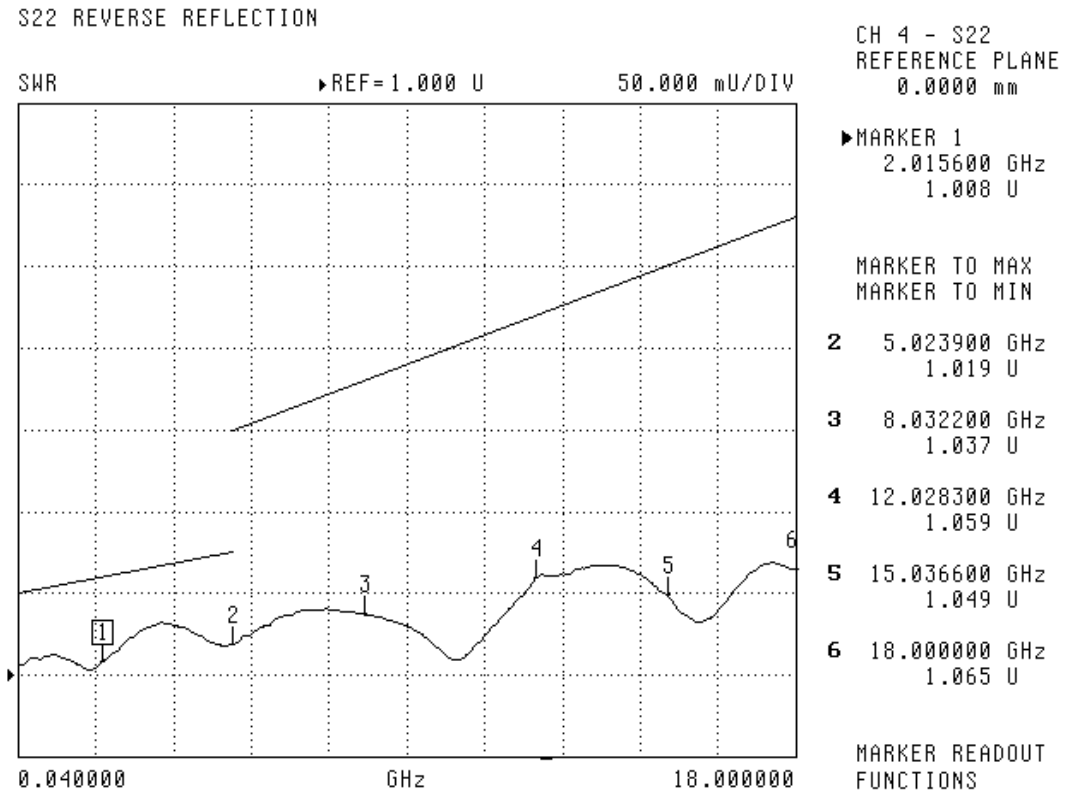


Sample 31

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

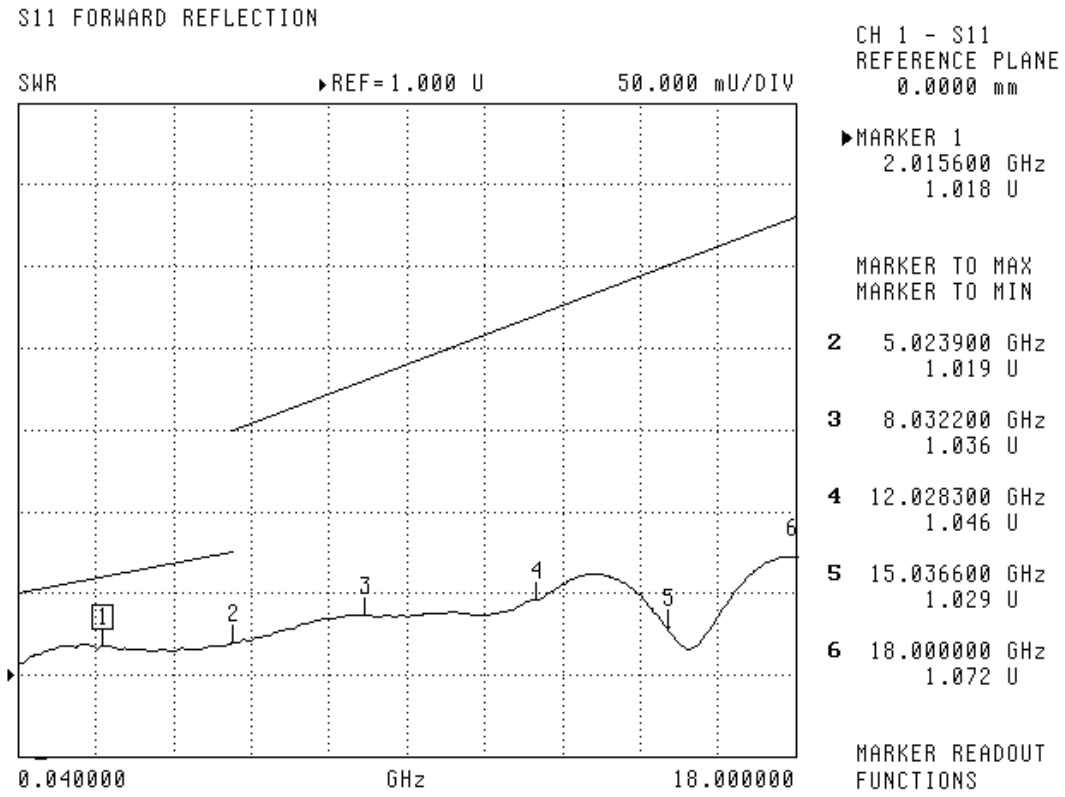


Sample 32

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

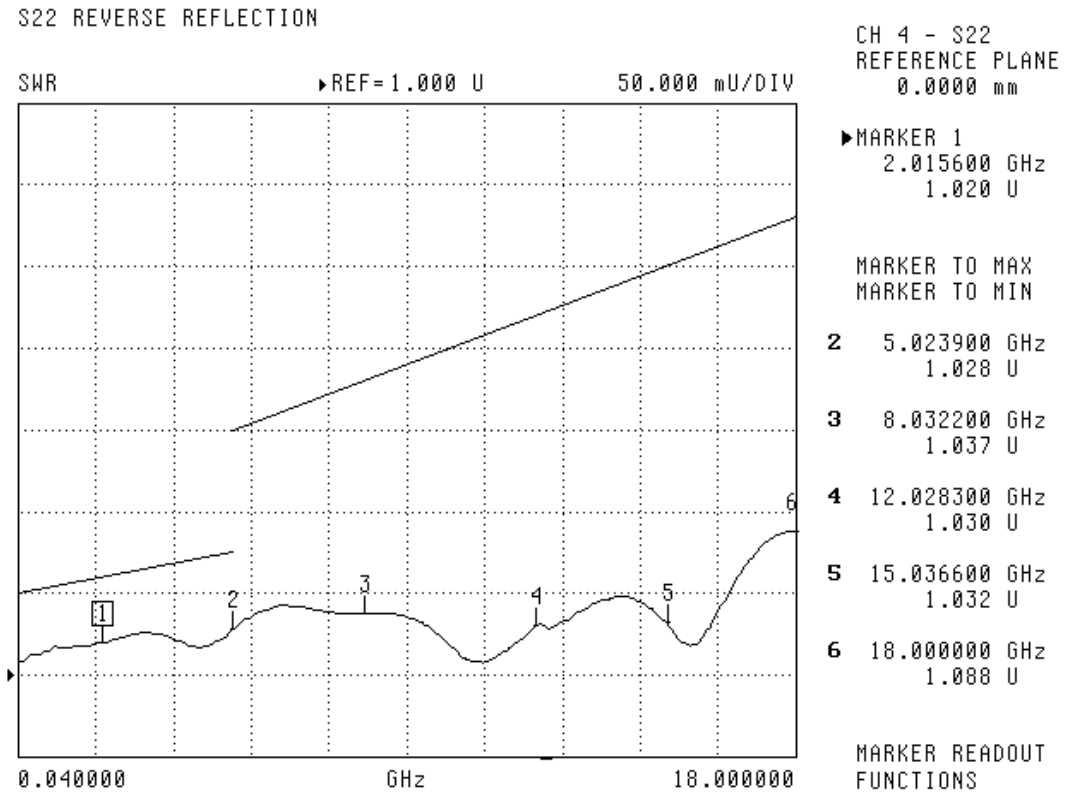


Sample 33

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

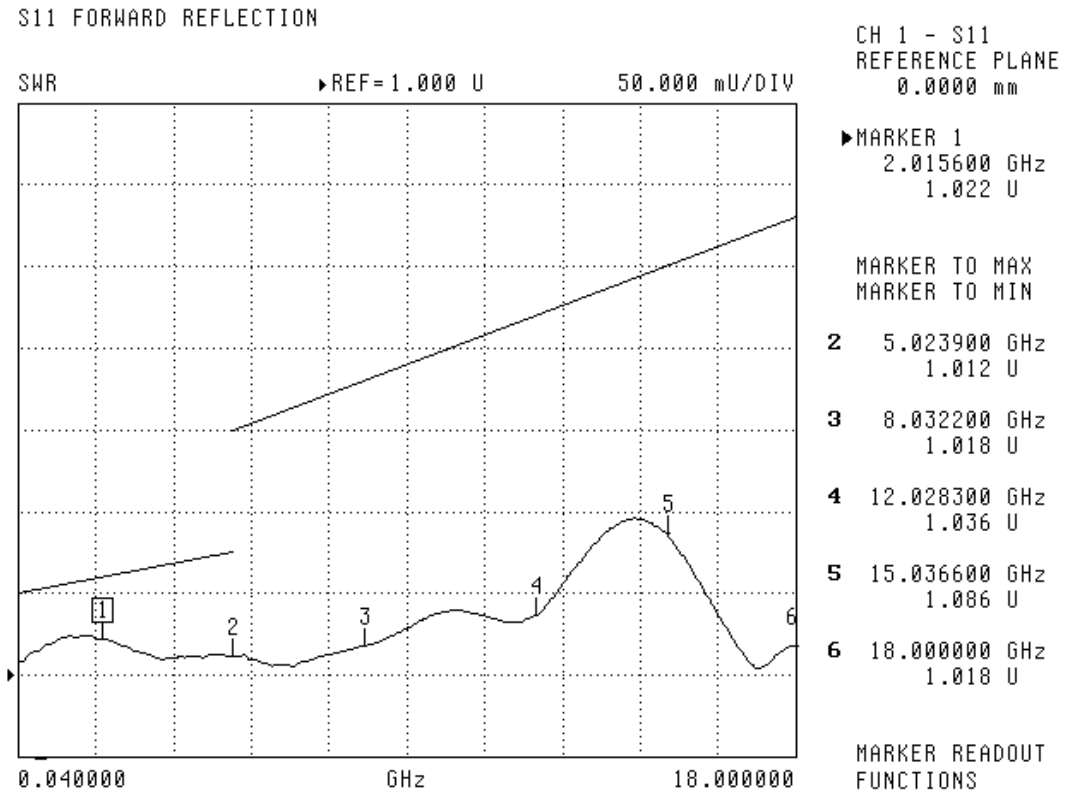


Sample 34

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

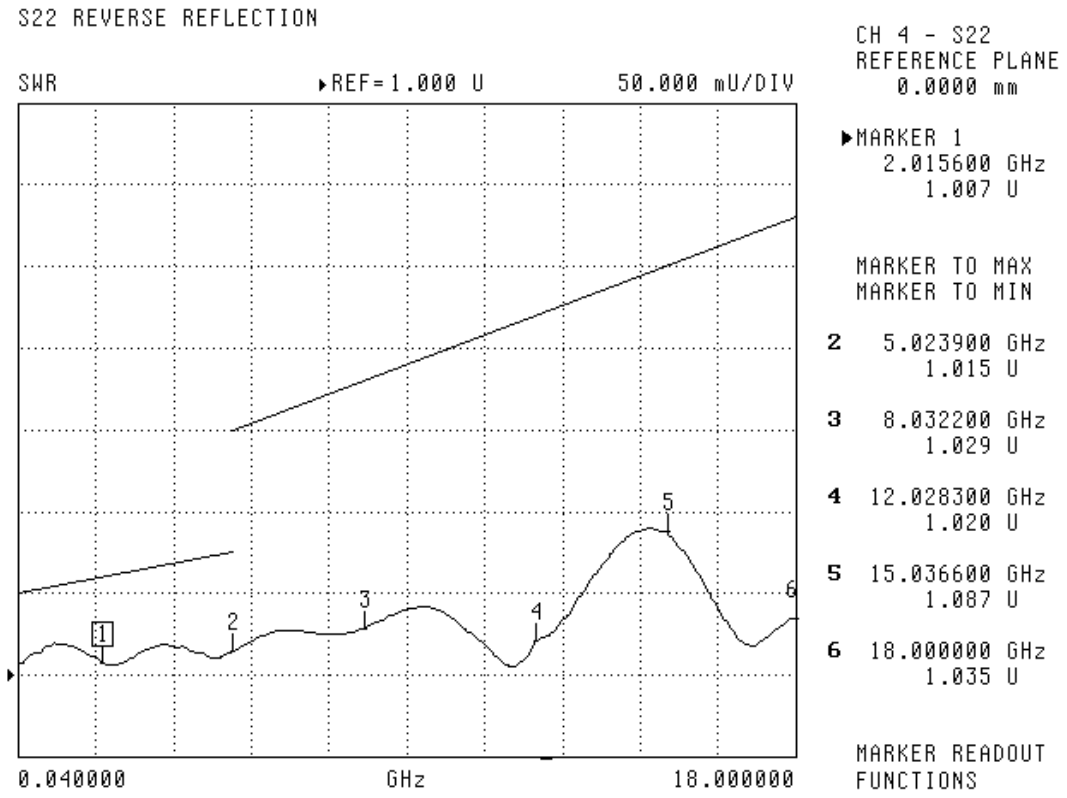


Sample 35

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

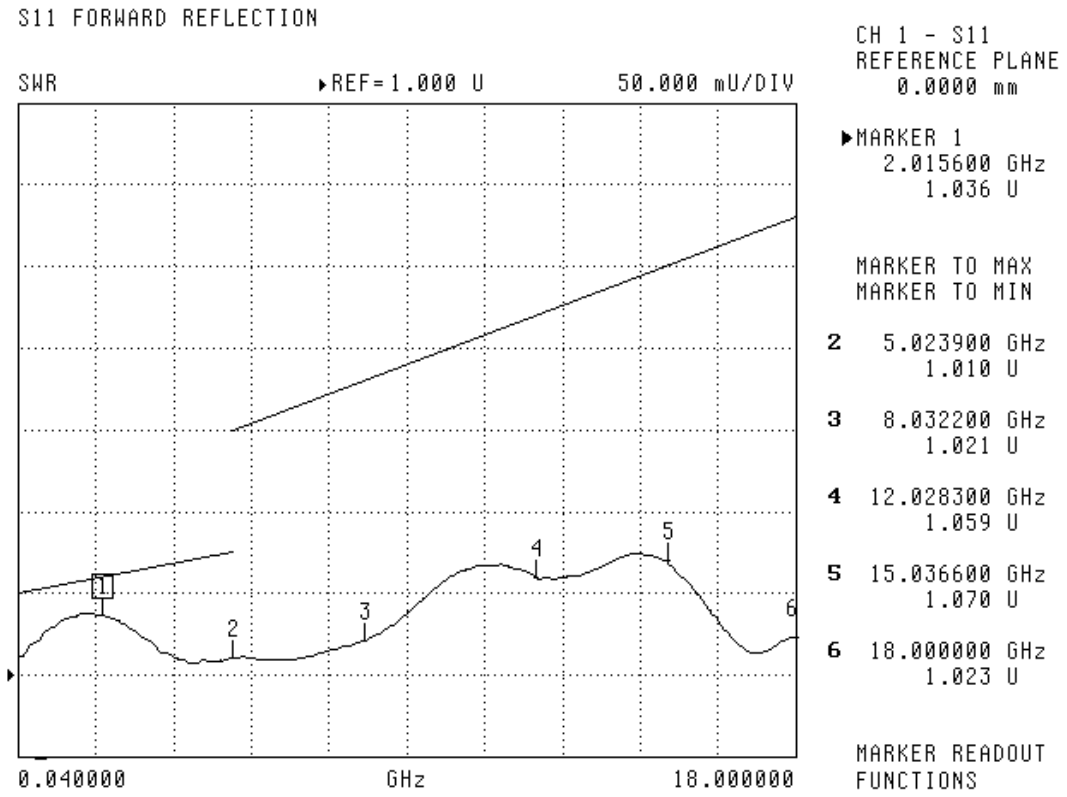


Sample 95

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

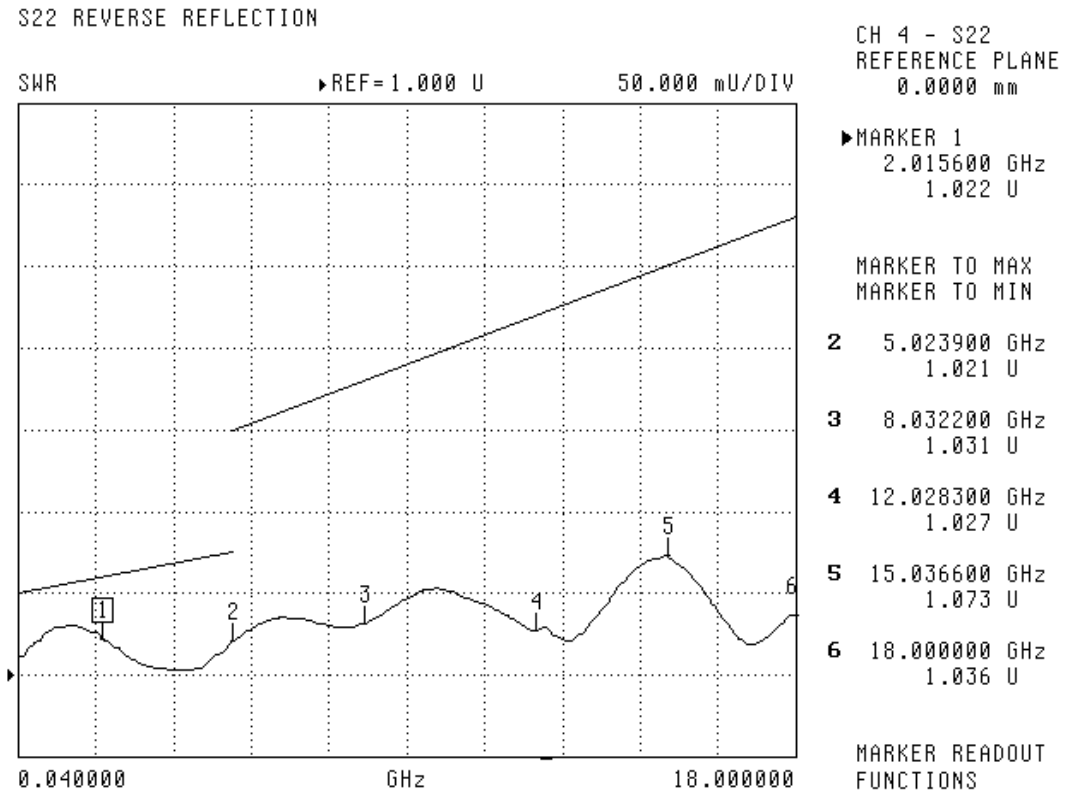


Sample 96

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

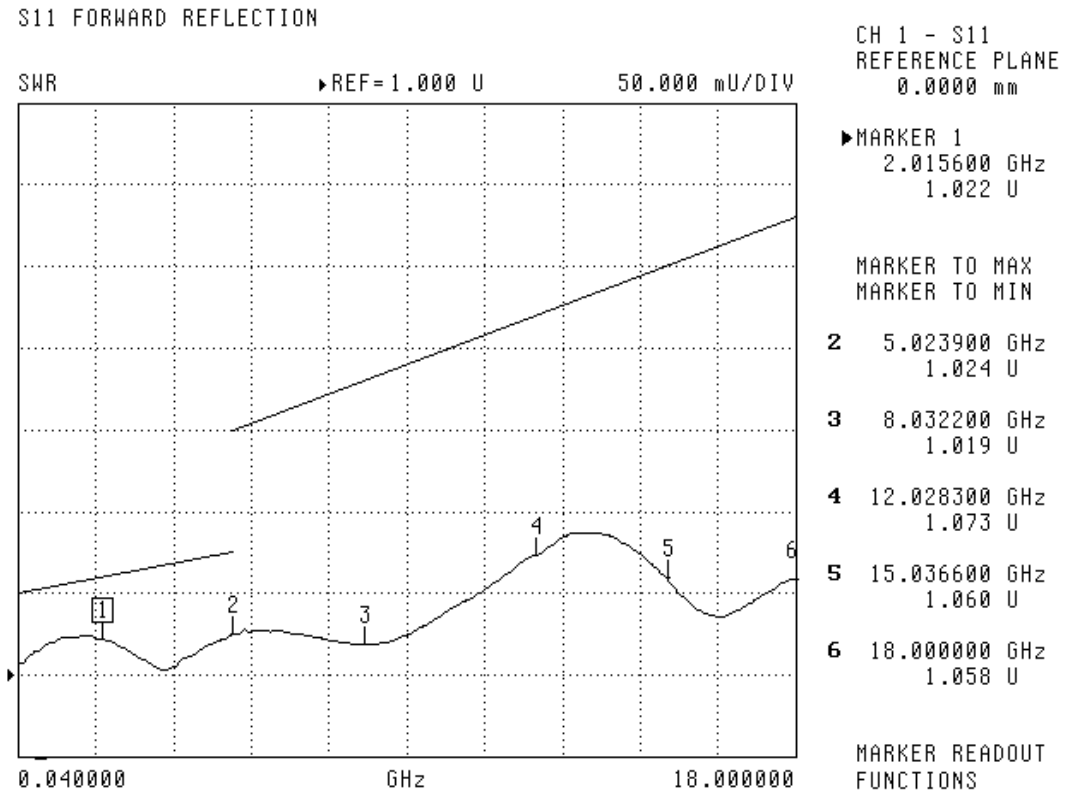


Sample 97

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

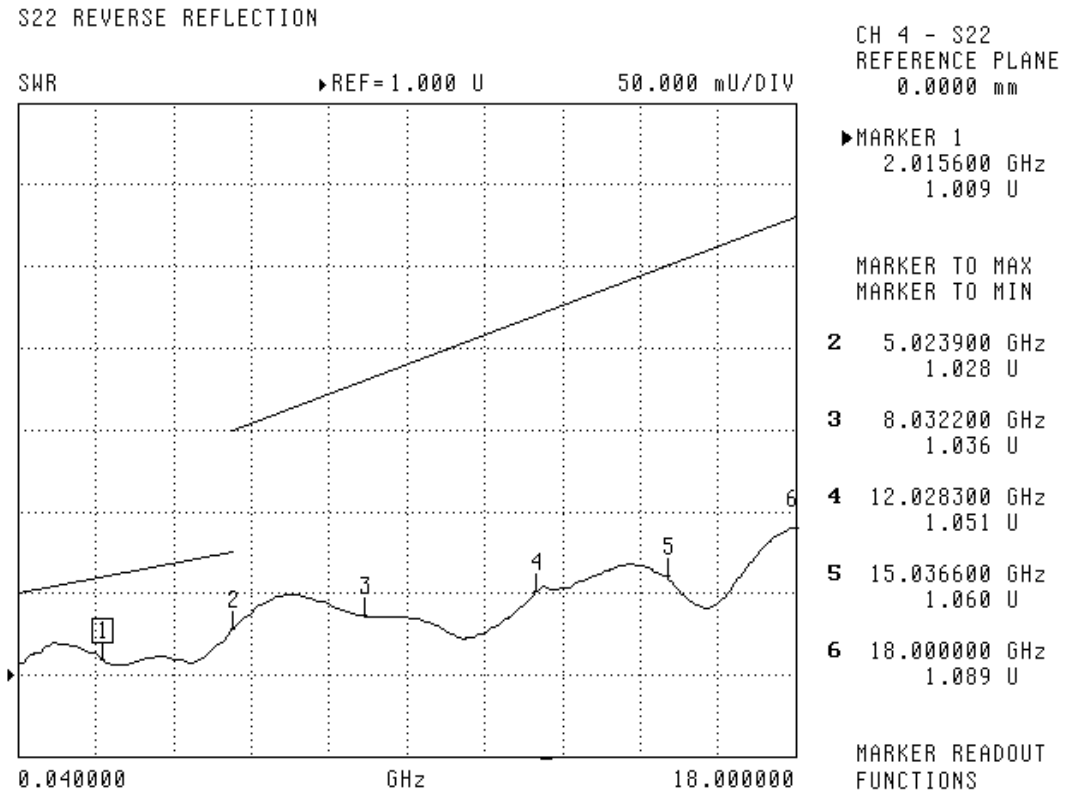


Sample 98

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

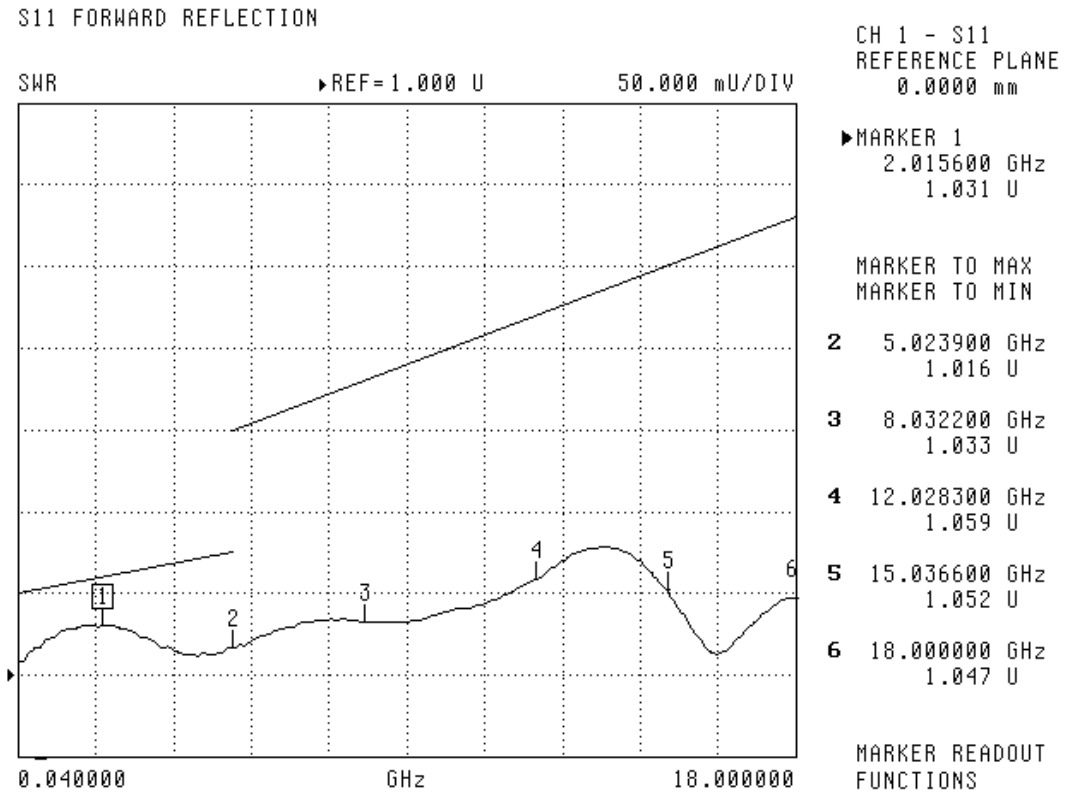


Sample 99

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

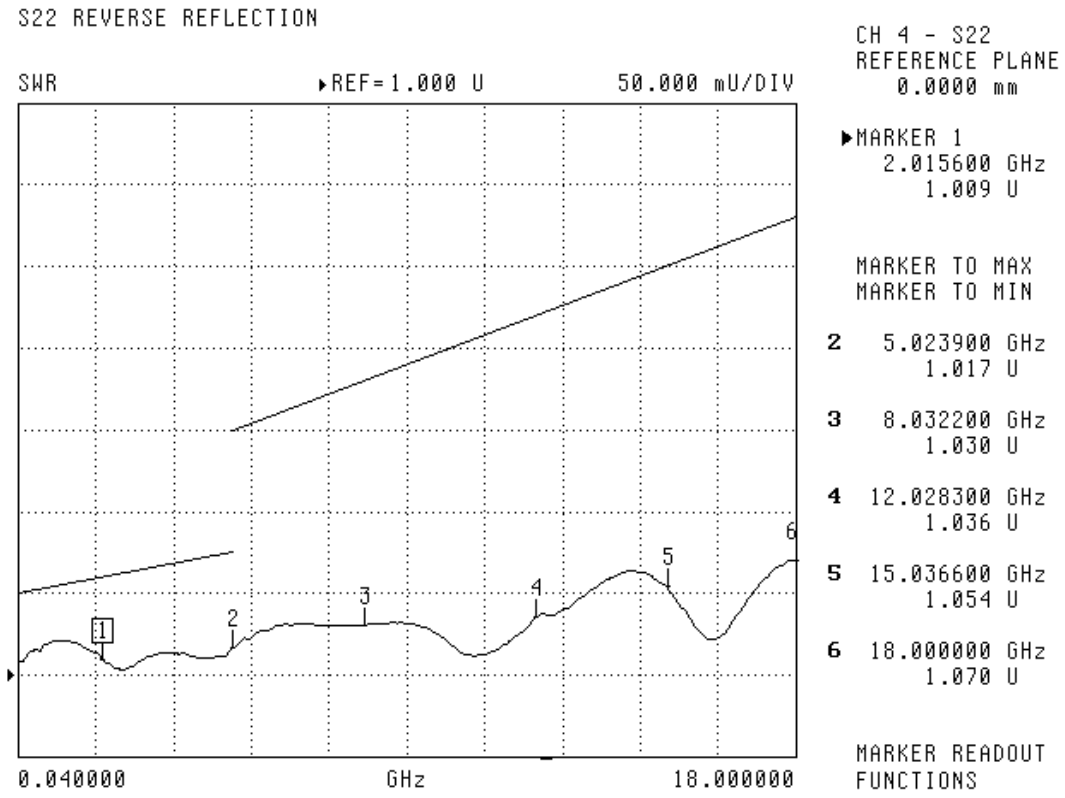


Sample 100

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

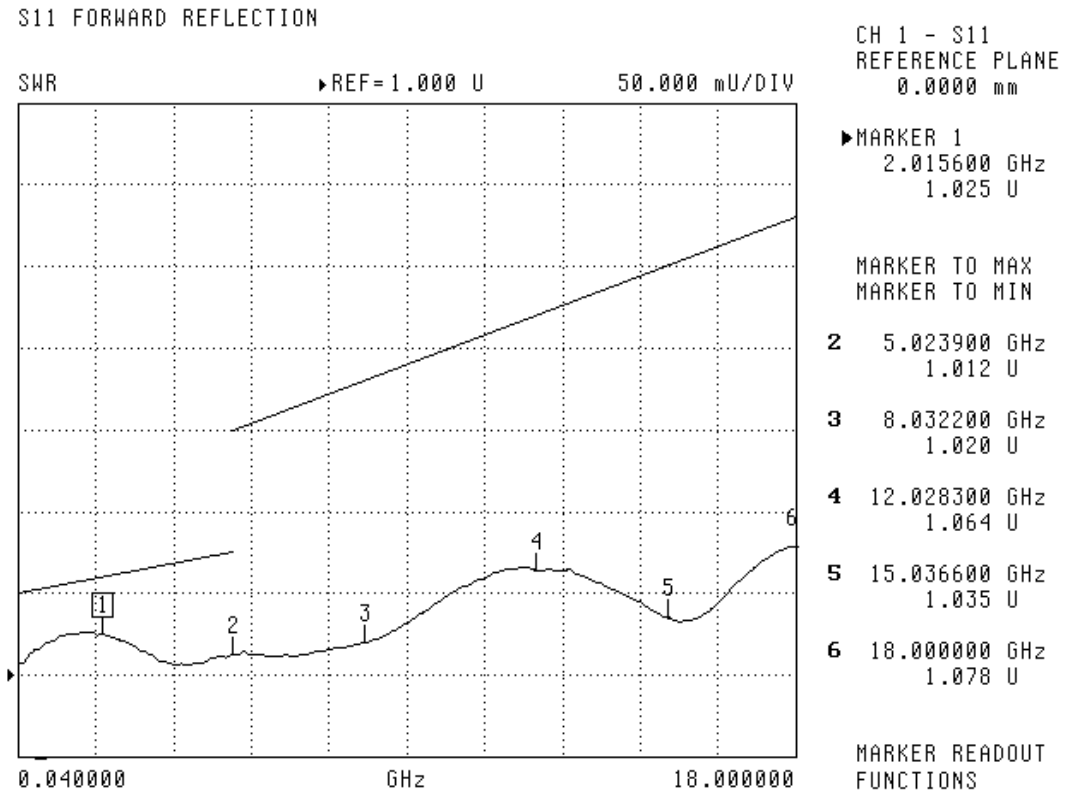


Sample 101

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

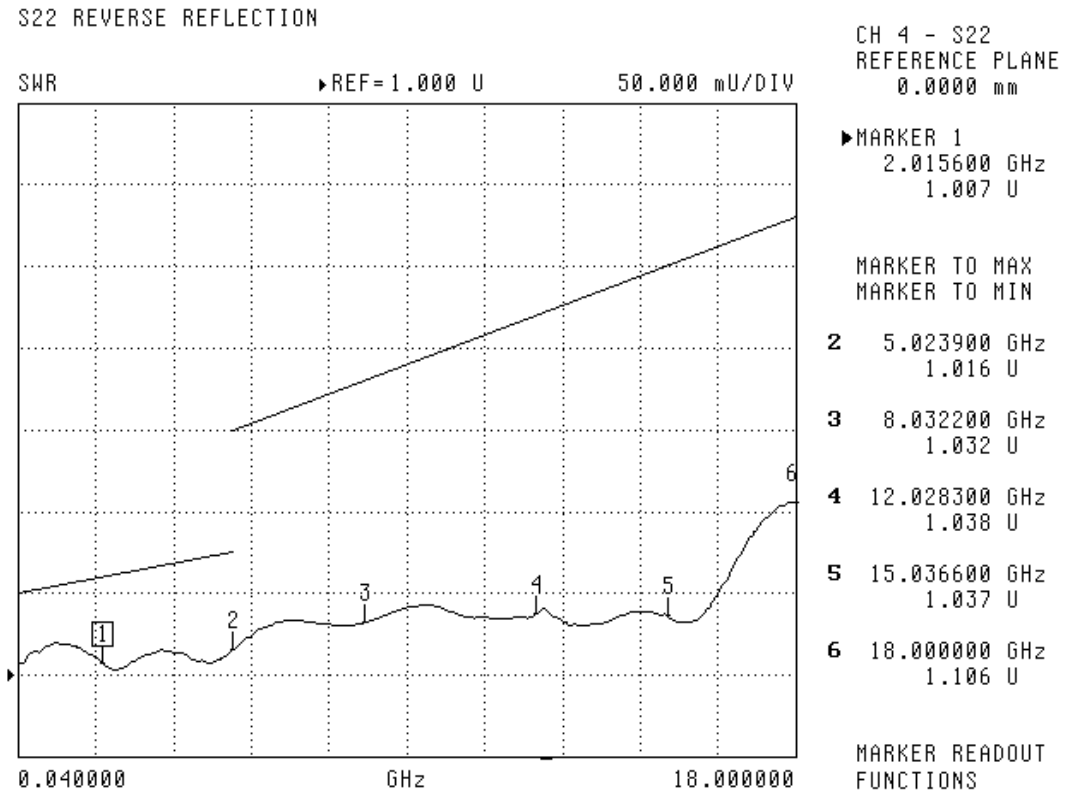


Sample 102

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

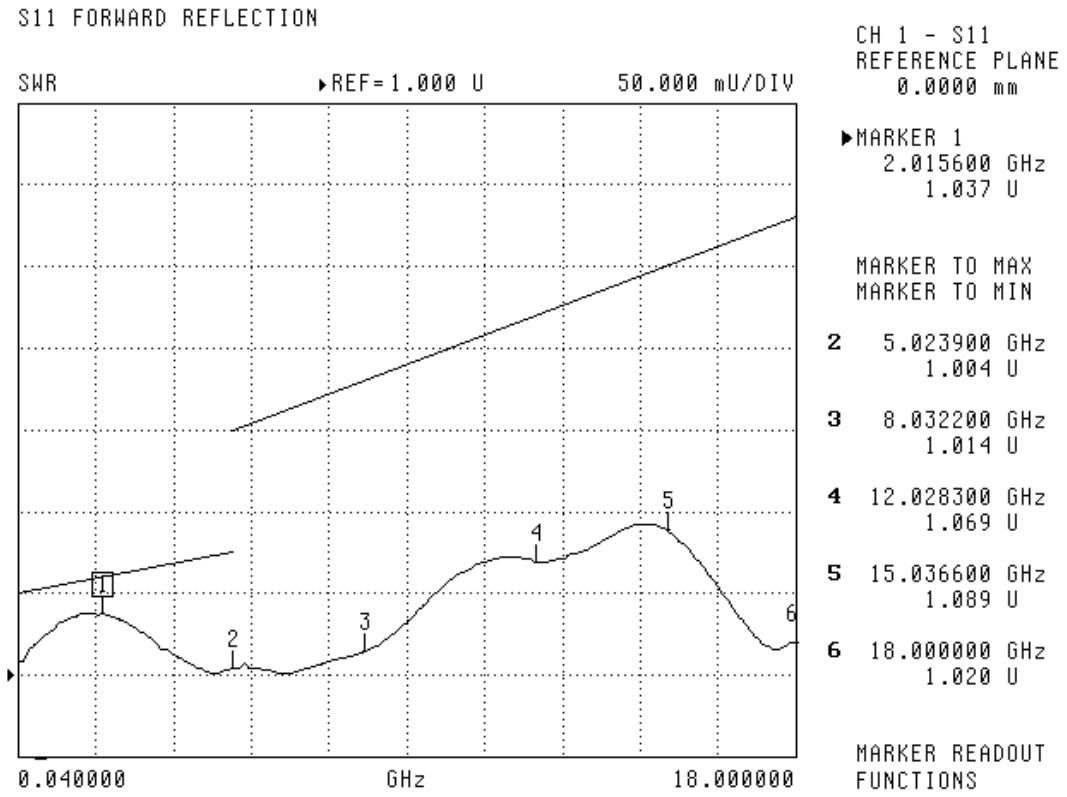


Sample 103

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

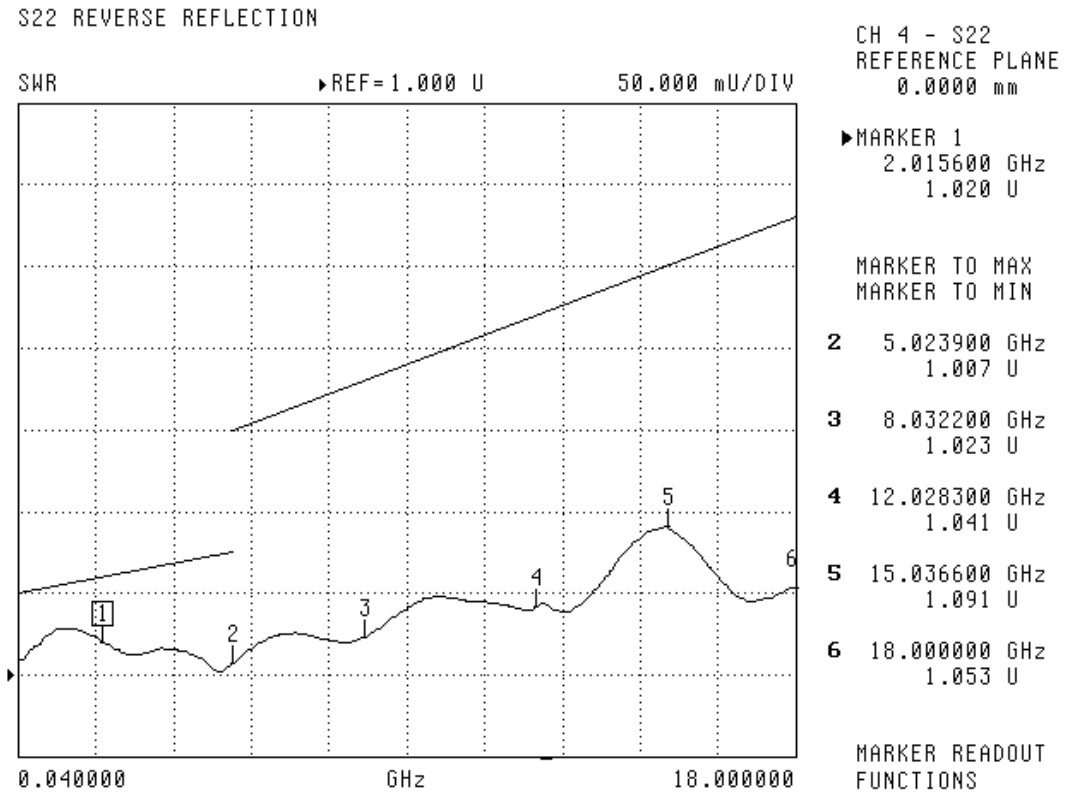


Sample 104

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

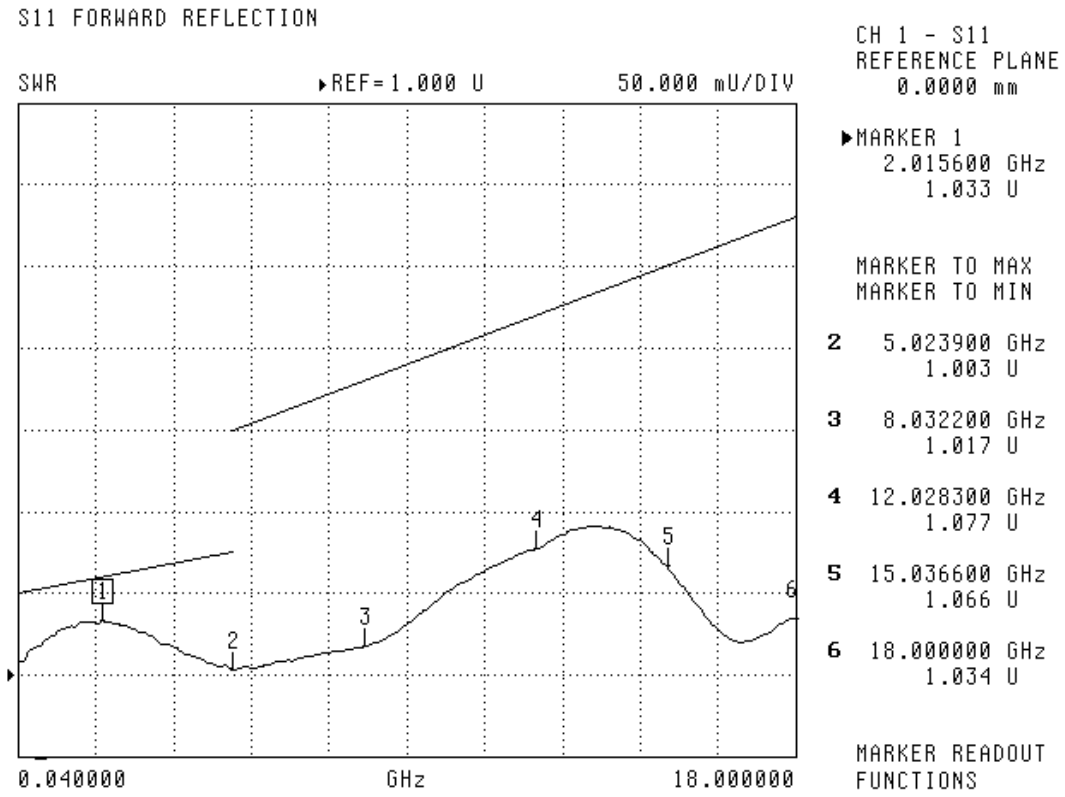


Sample 105

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

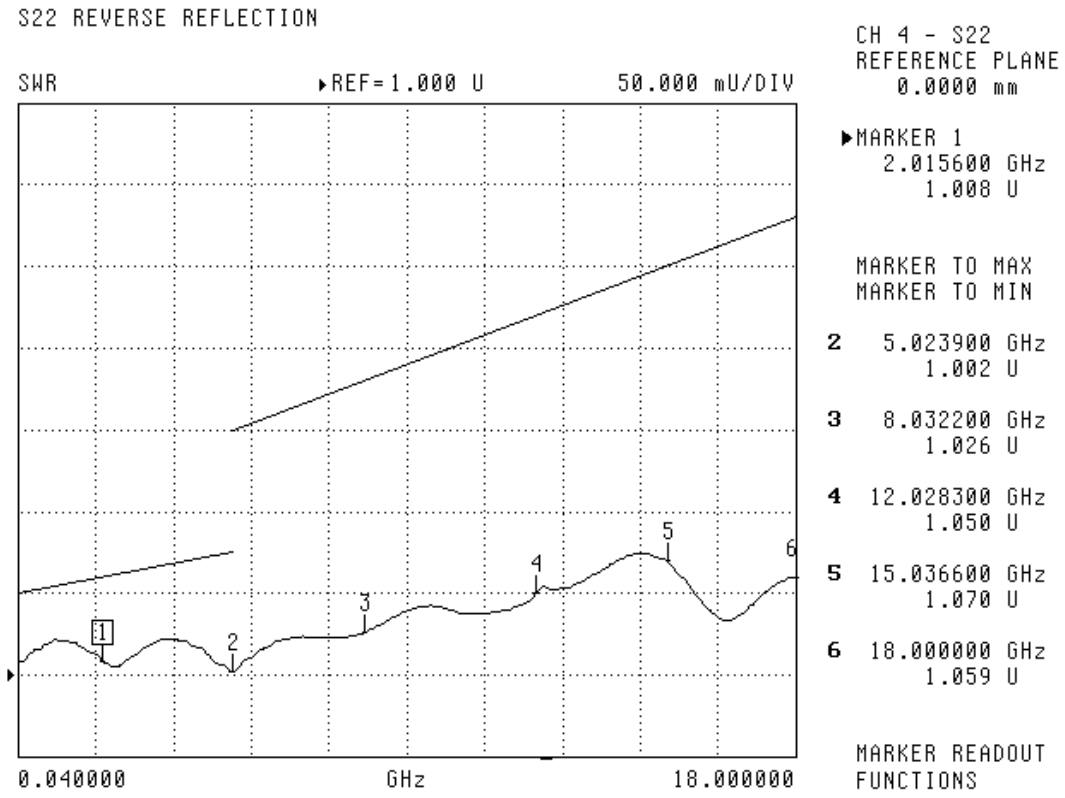


Sample 106

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

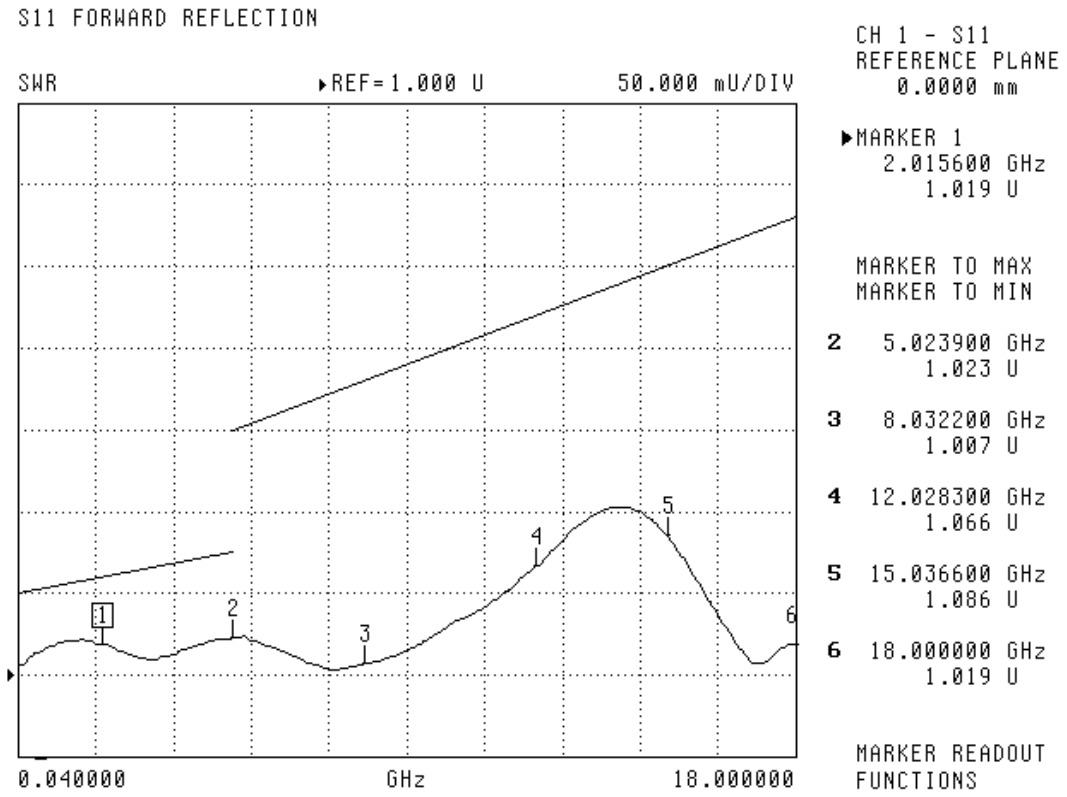


Sample 107

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

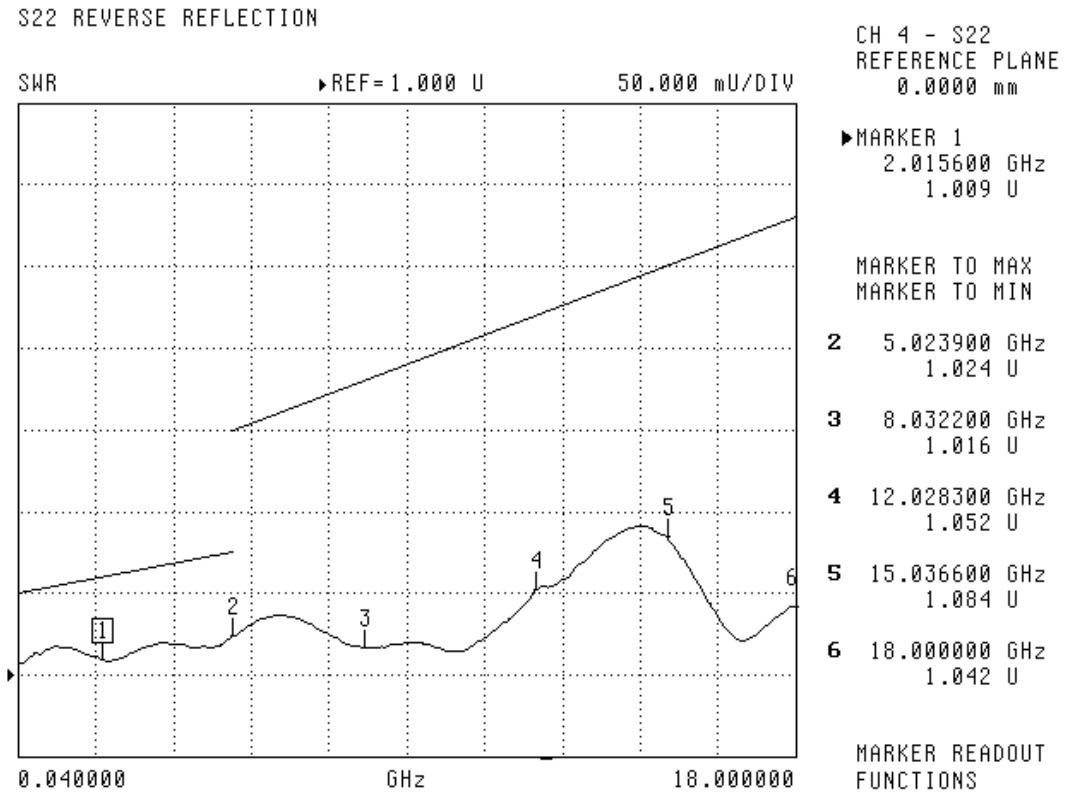


Sample 108

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

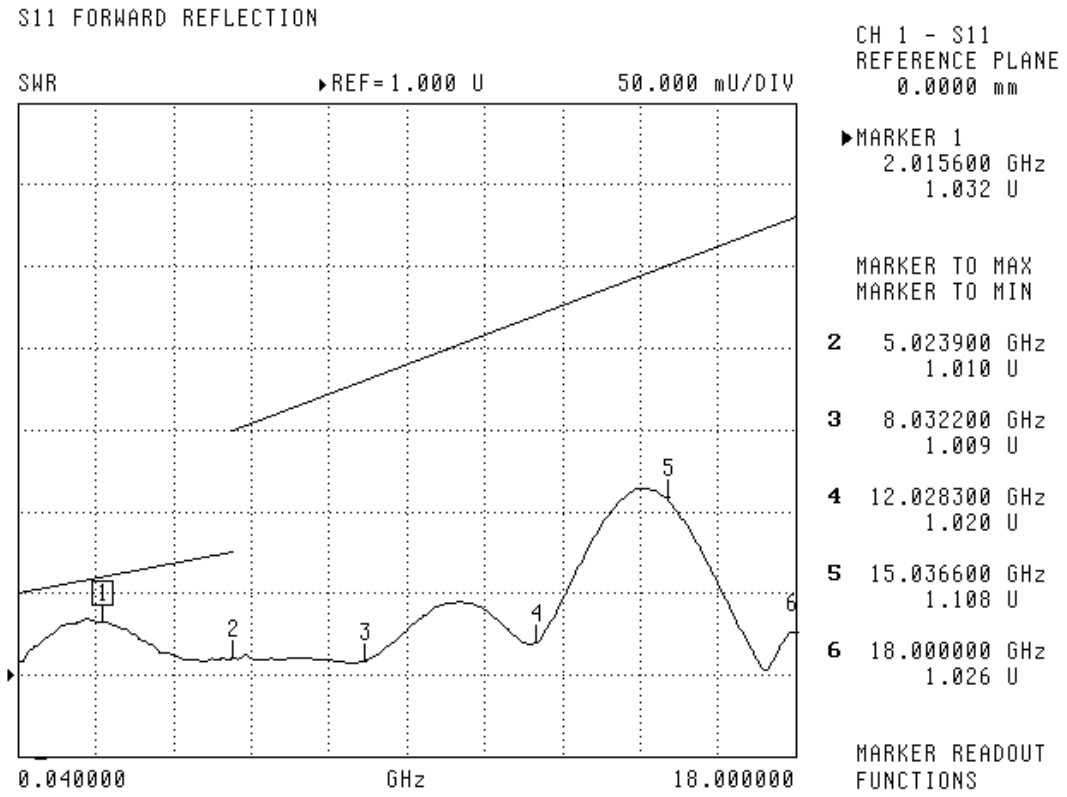


Sample 109

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

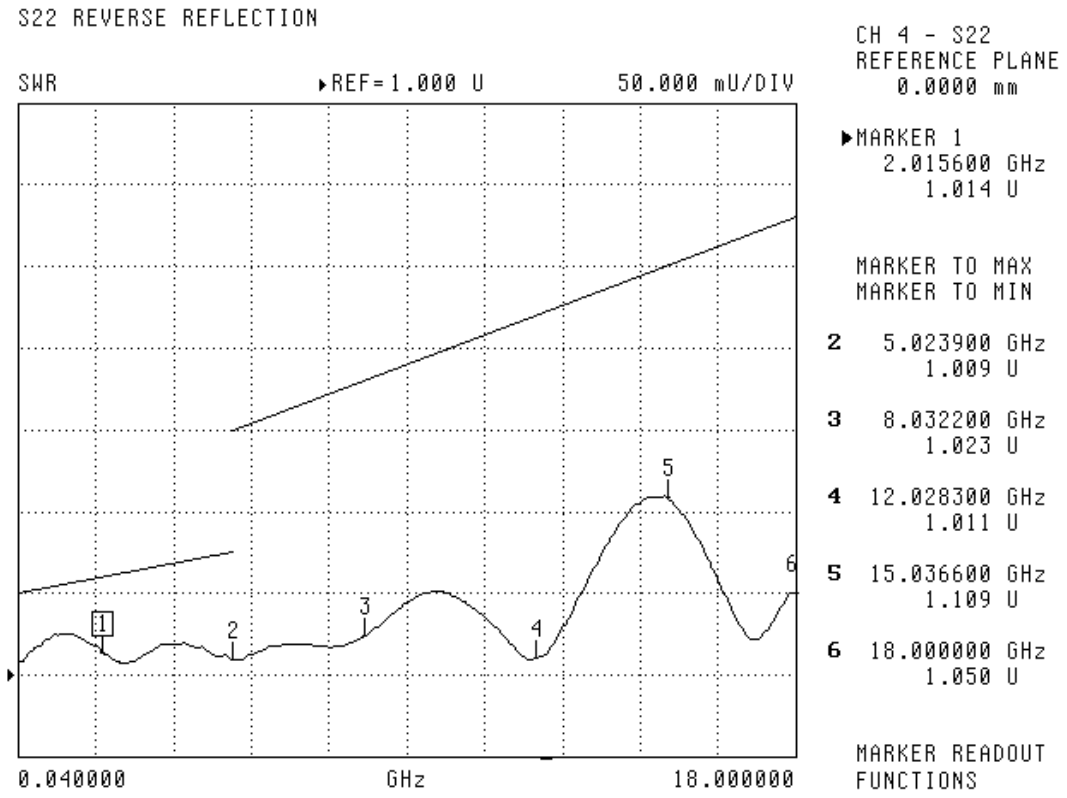


Sample 110

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

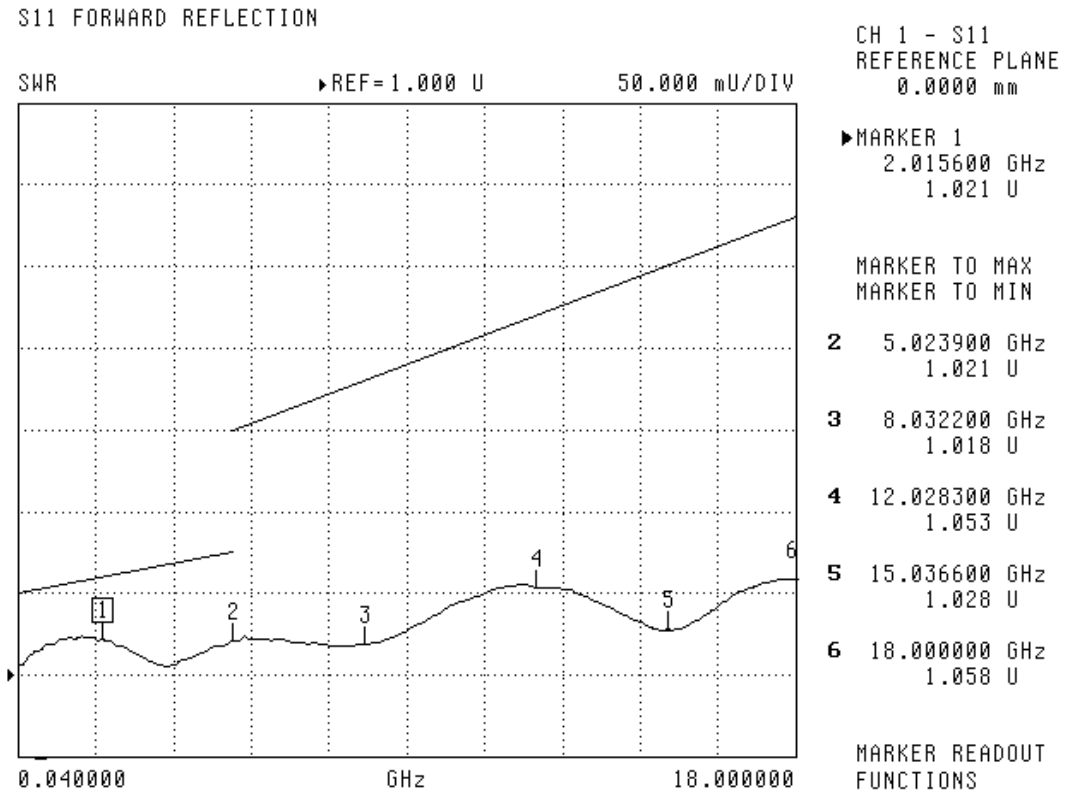


Sample 111

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

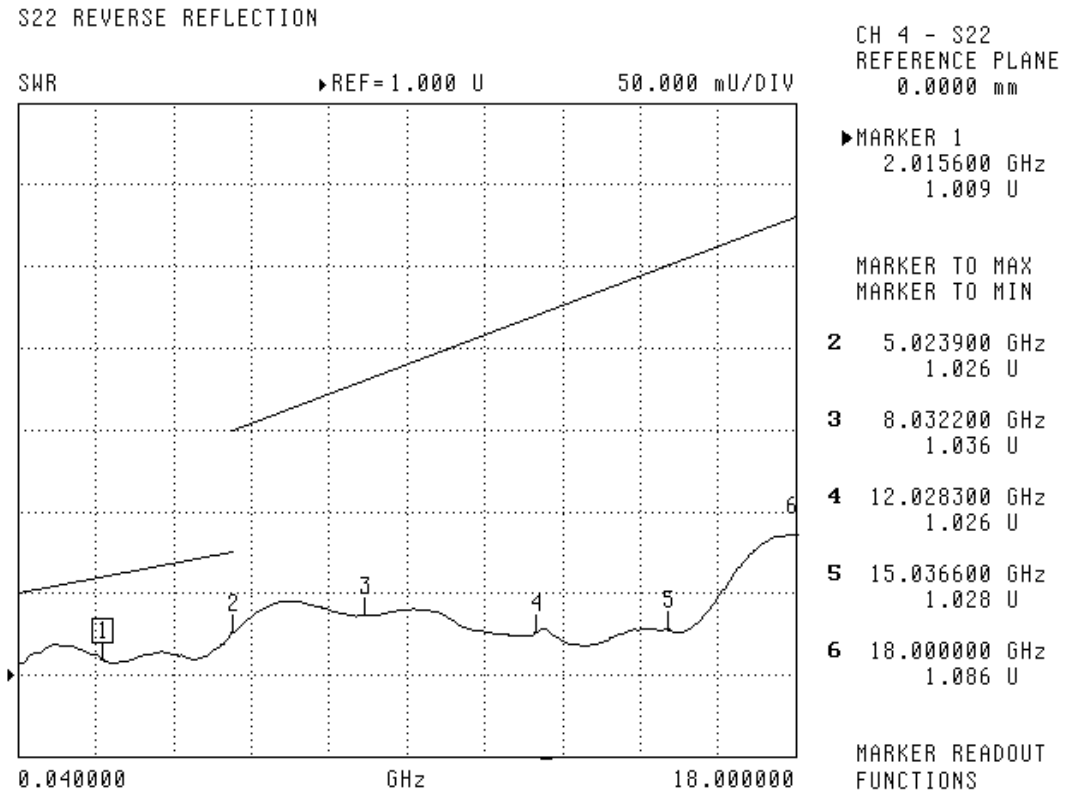


Sample 112

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

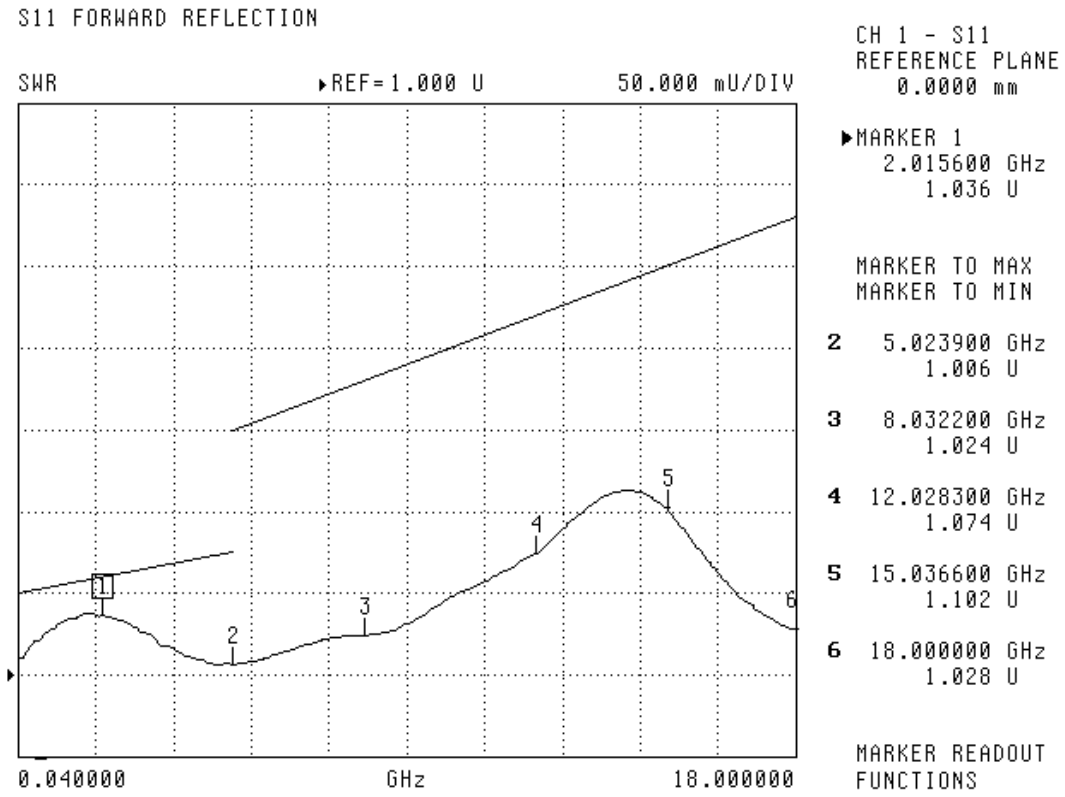


Sample 113

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

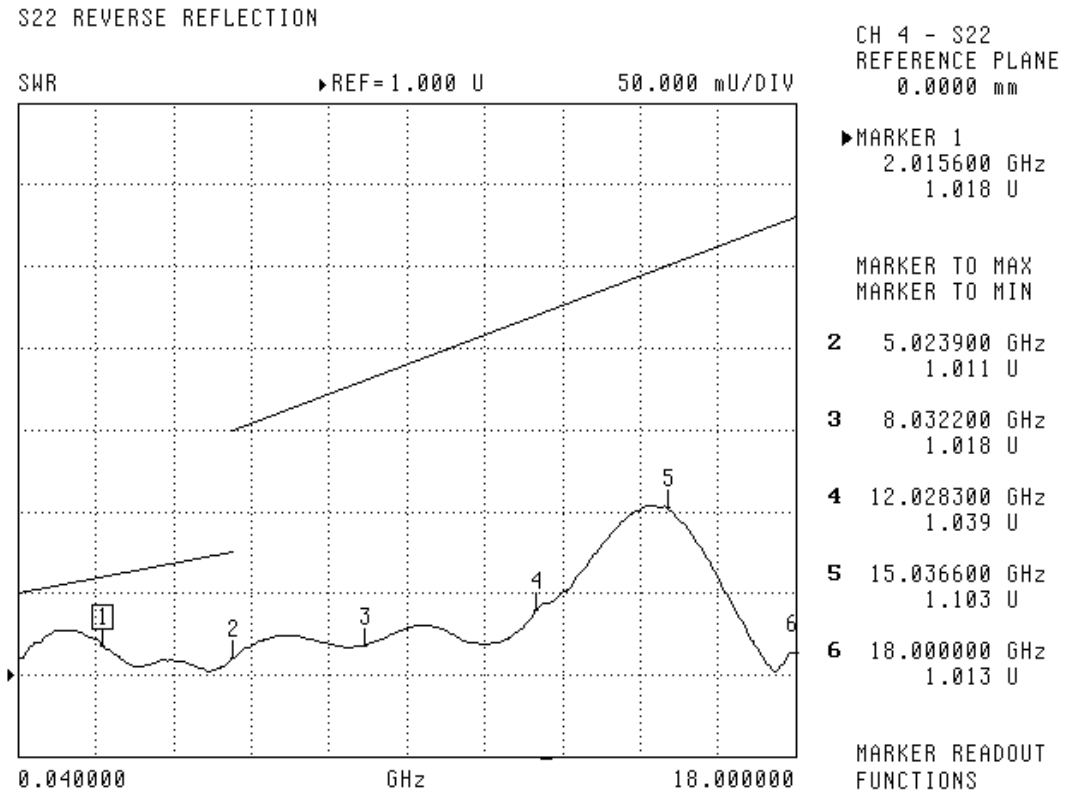


Sample 114

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

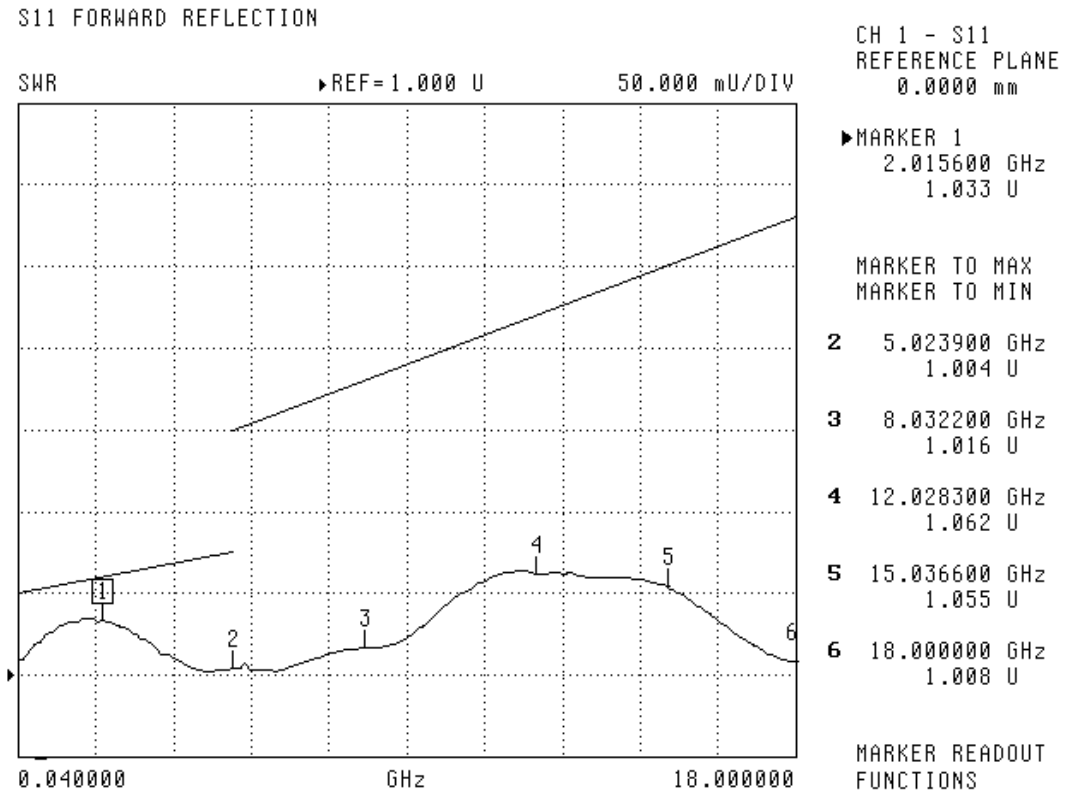


Sample 115

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

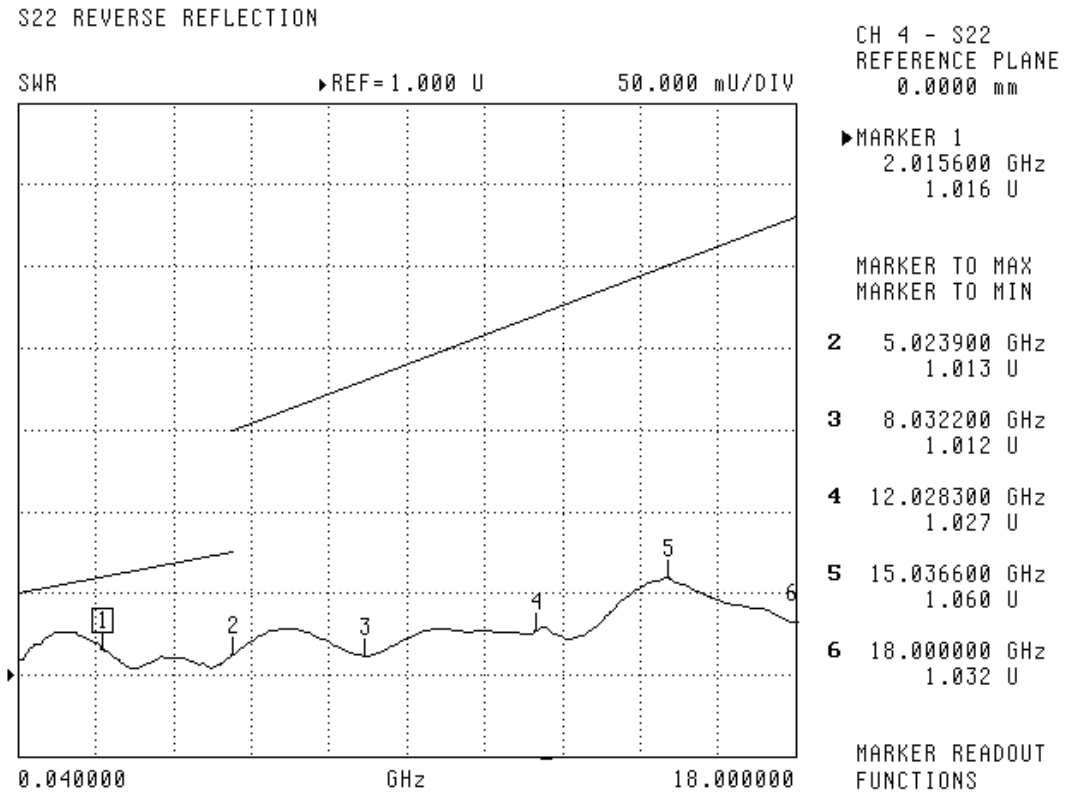


Sample 116

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006

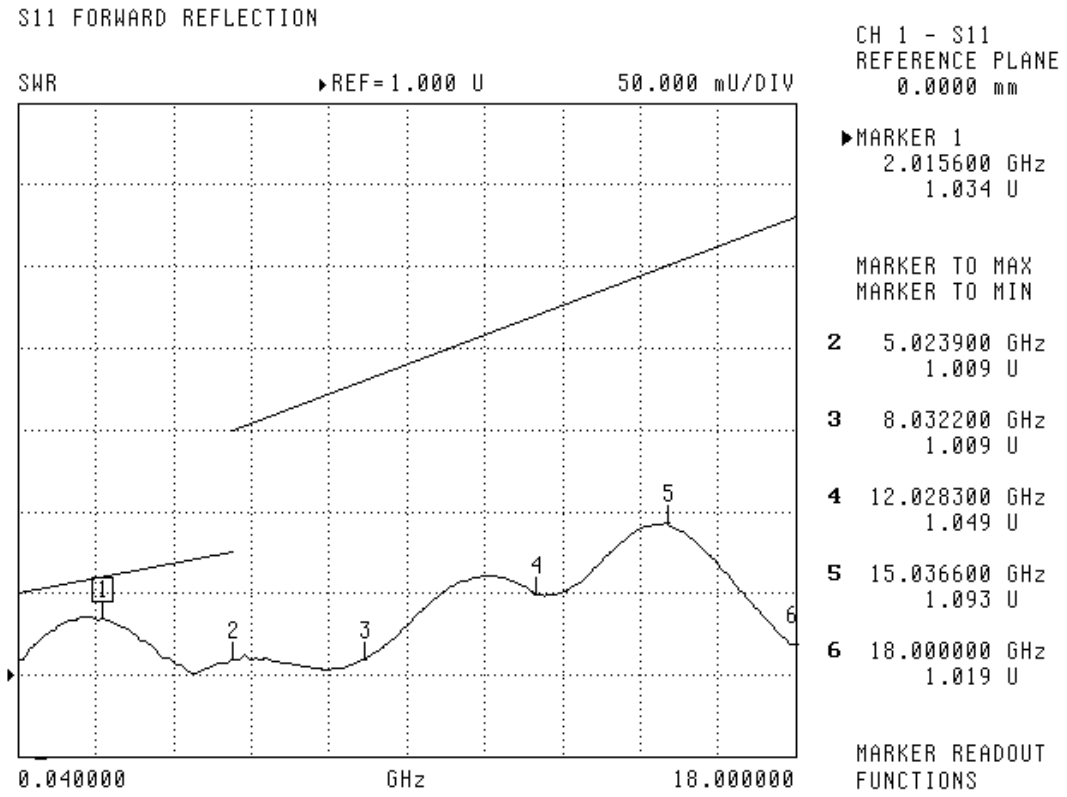


Sample 117

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006



Sample 118

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

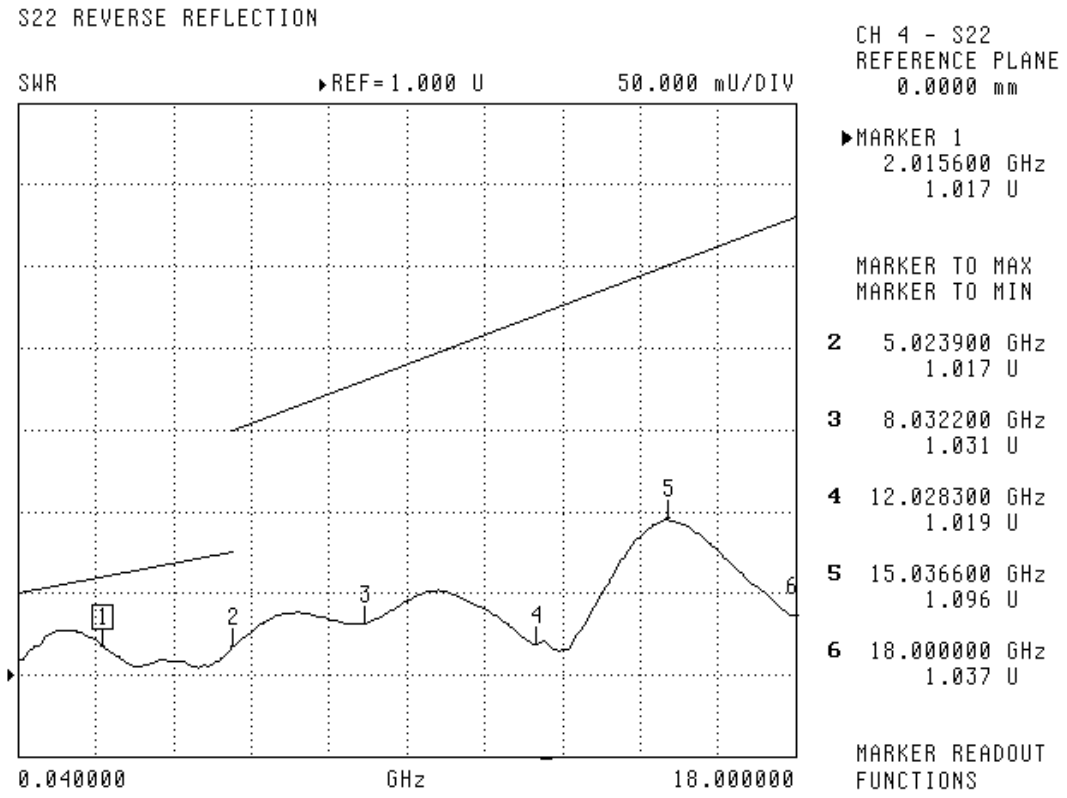
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / After thermal shock 07/02/2006



Sample 119

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

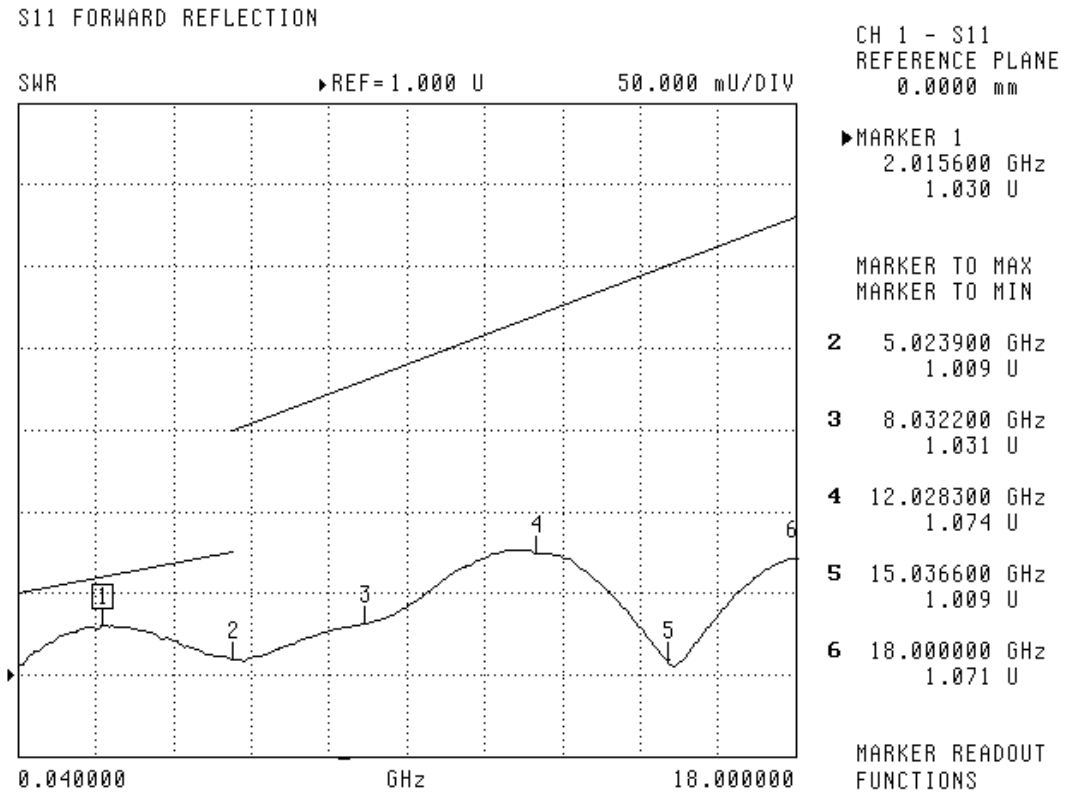
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

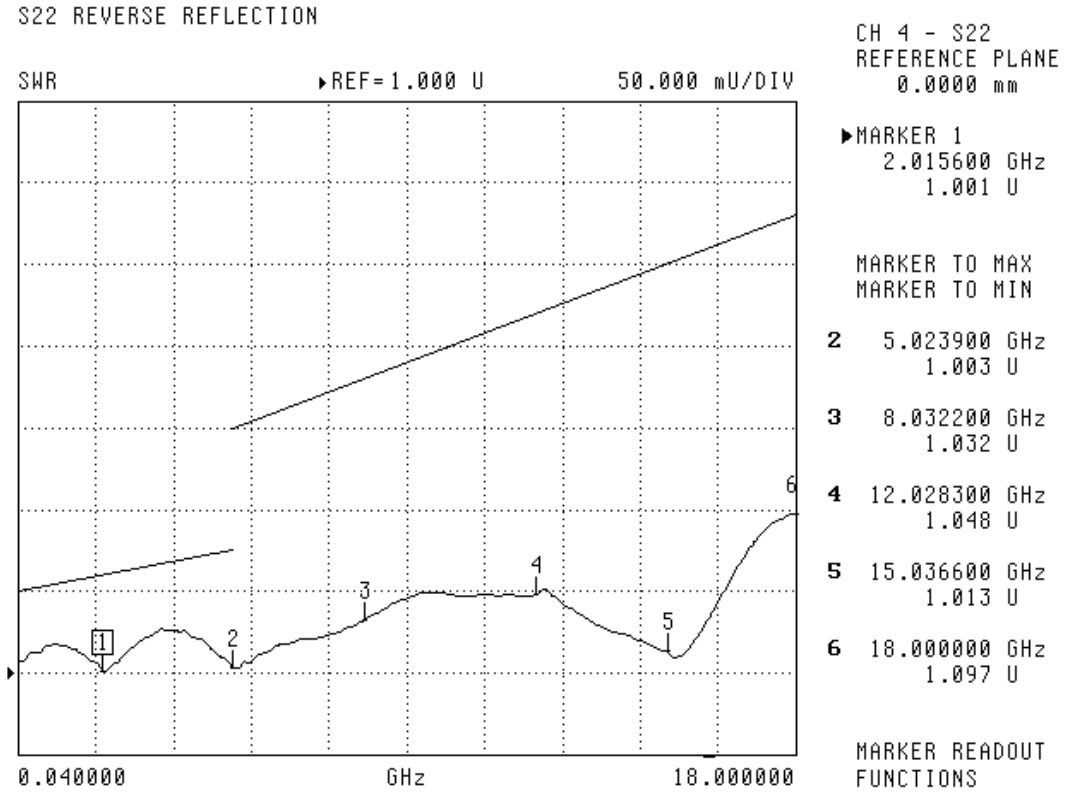


Sample 1

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

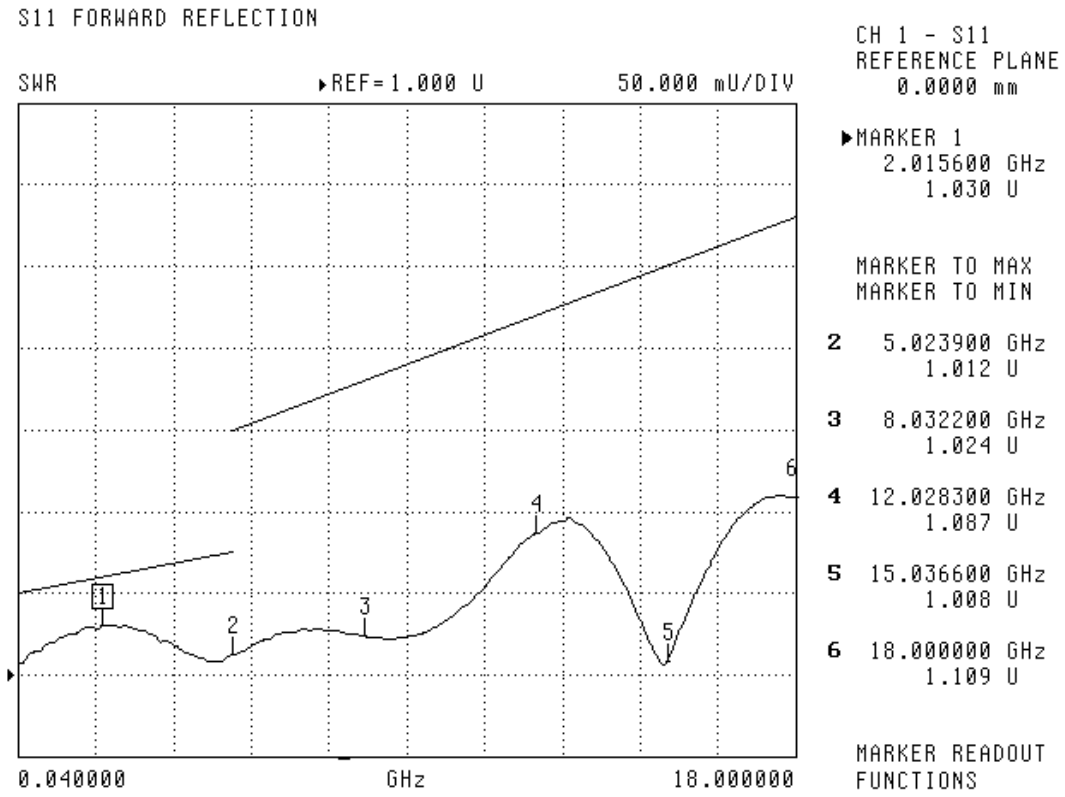


Sample 2

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

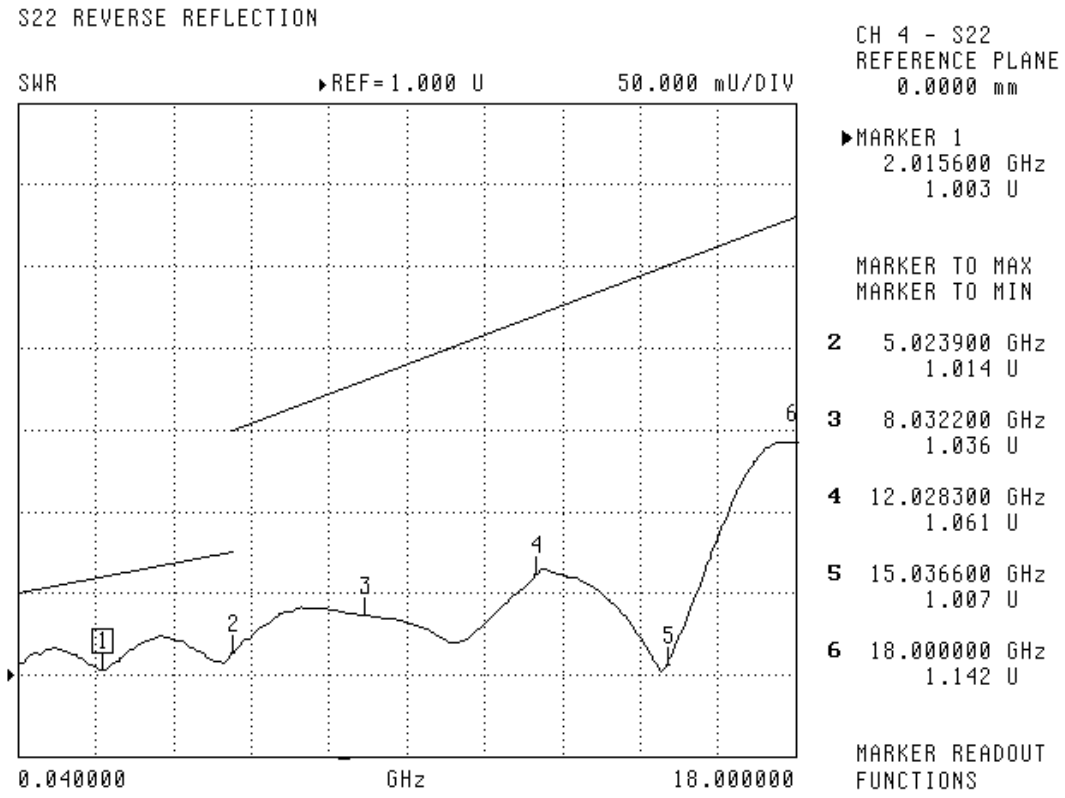


Sample 3

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

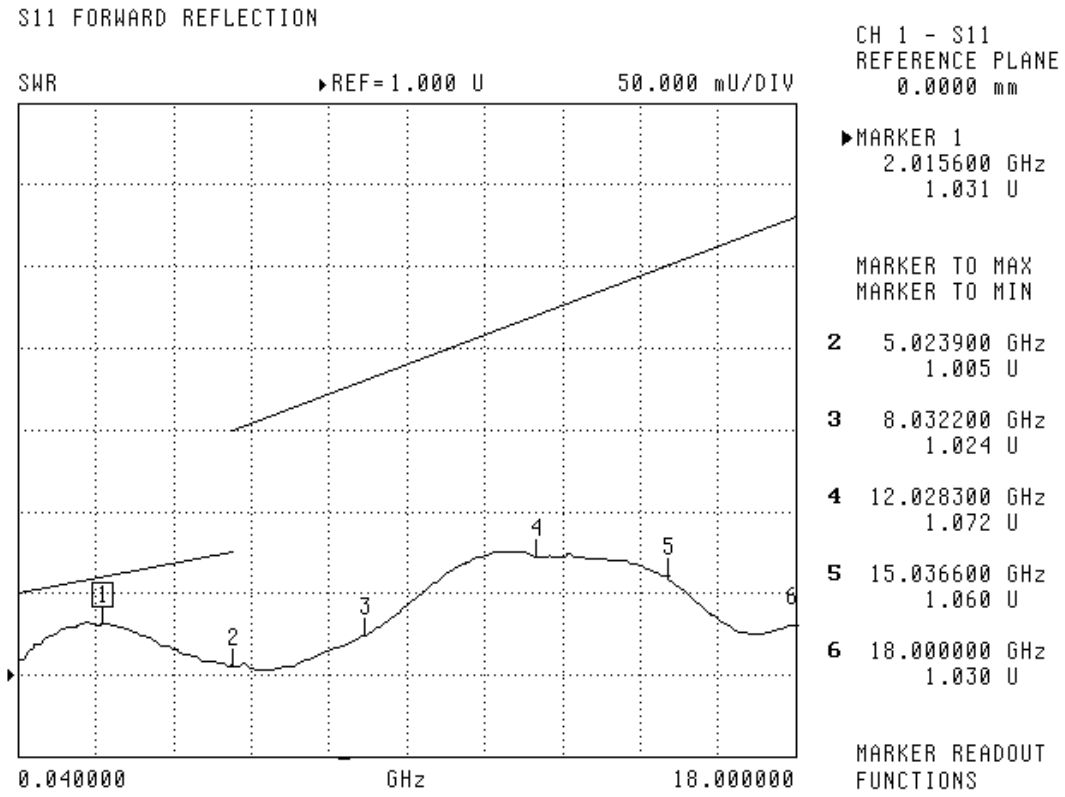


Sample 4

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

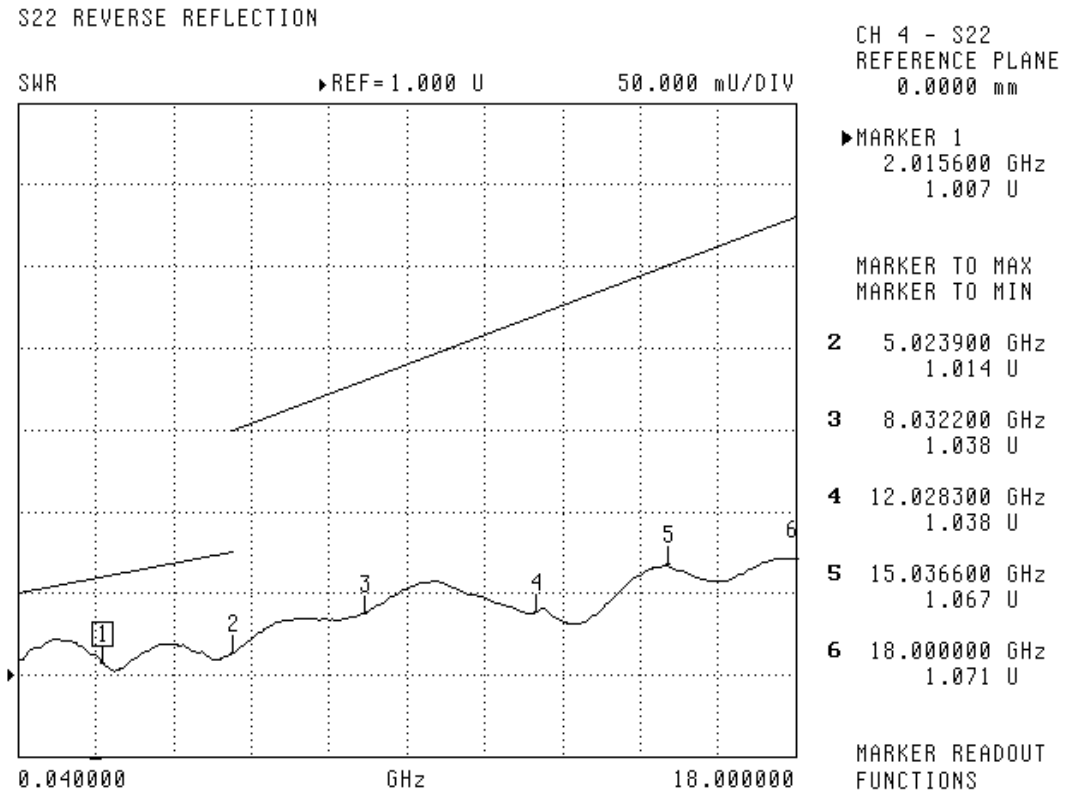


Sample 5

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

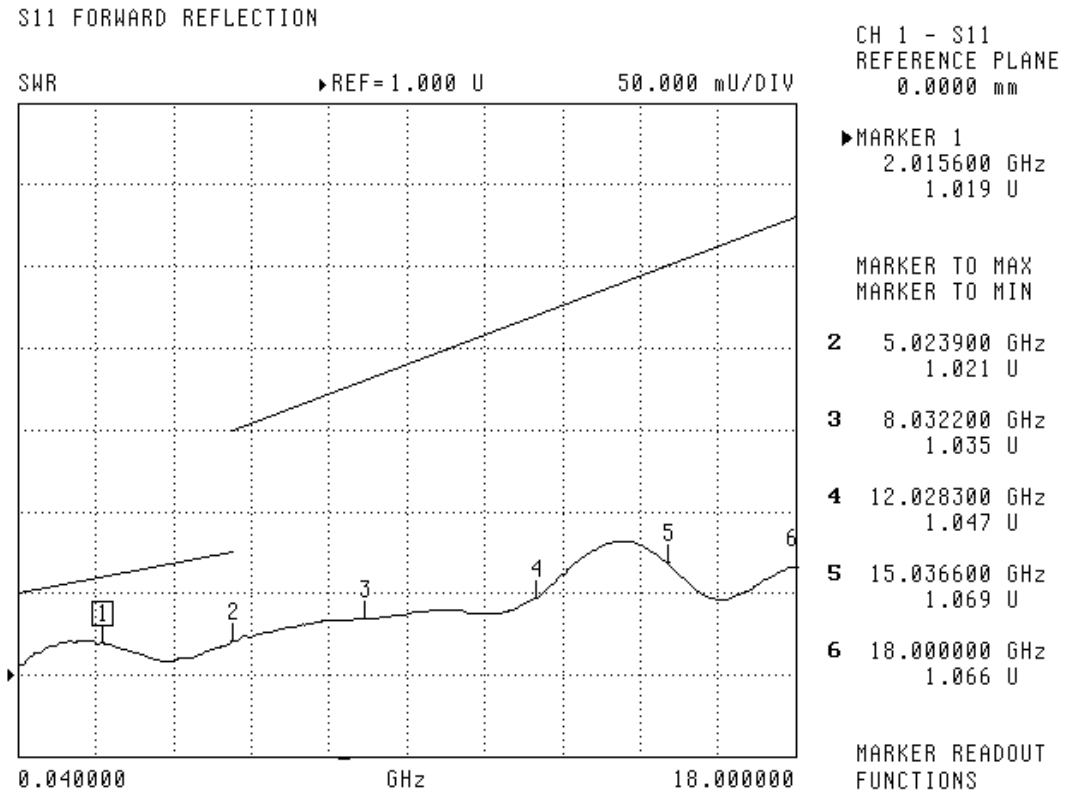


Sample 6

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

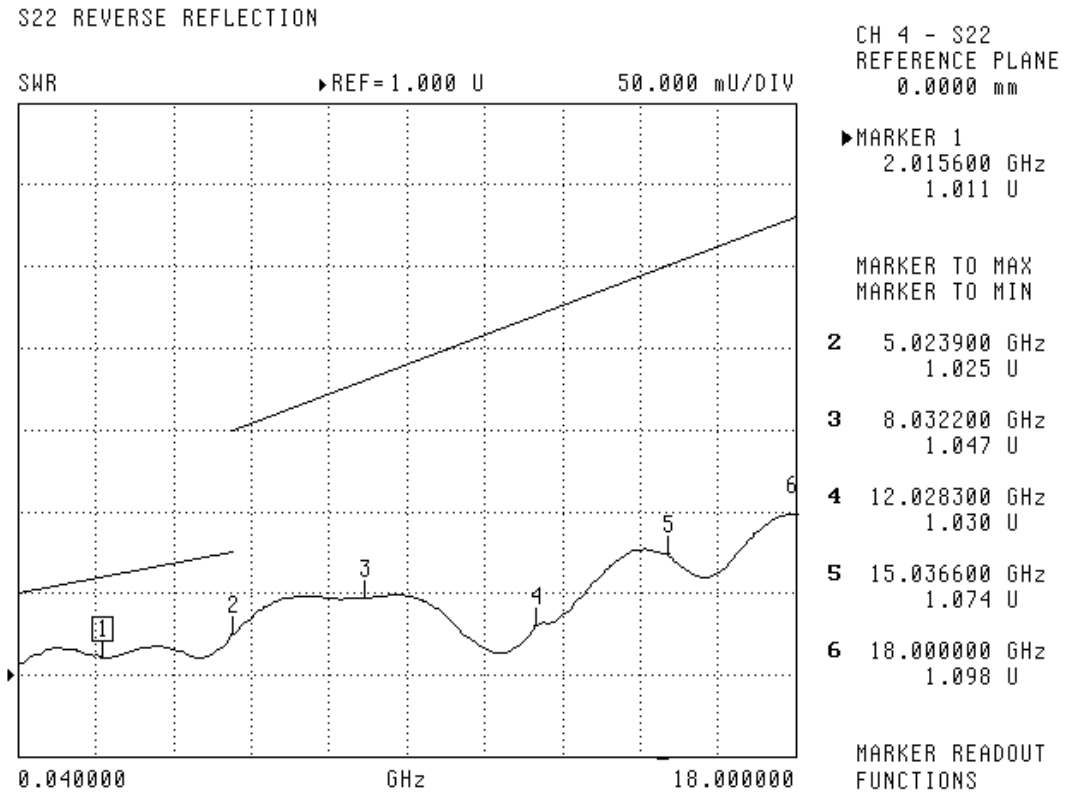


Sample 7

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

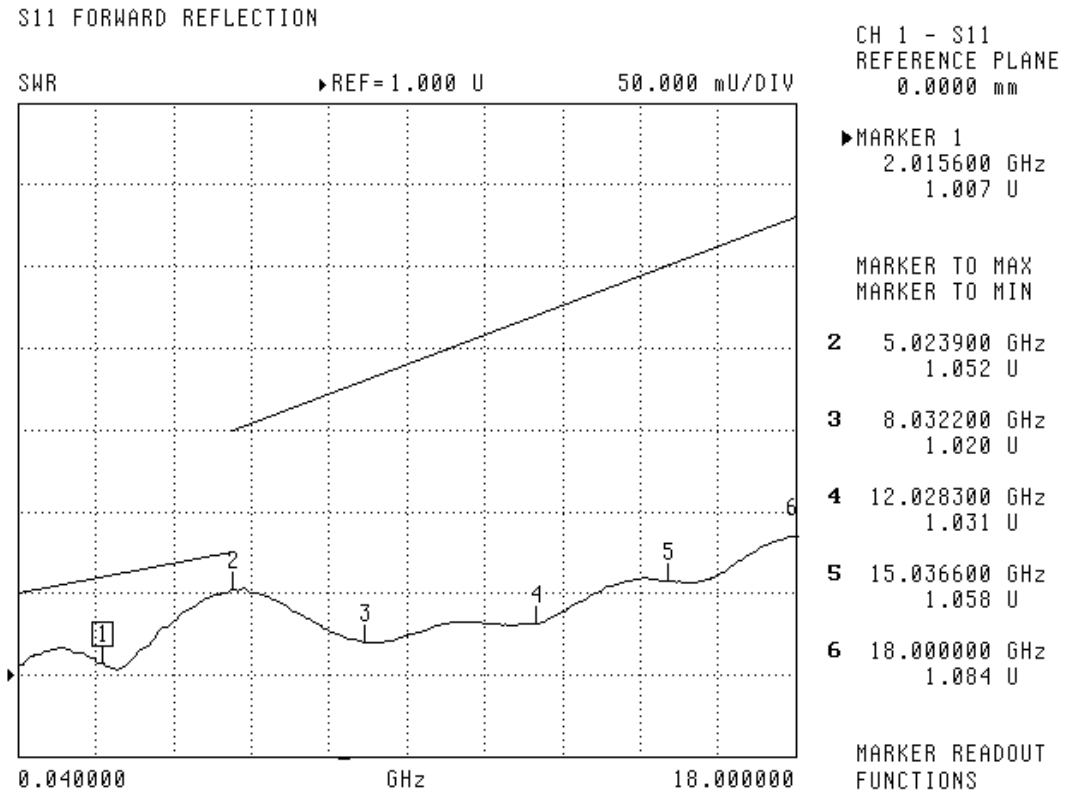


Sample 8

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

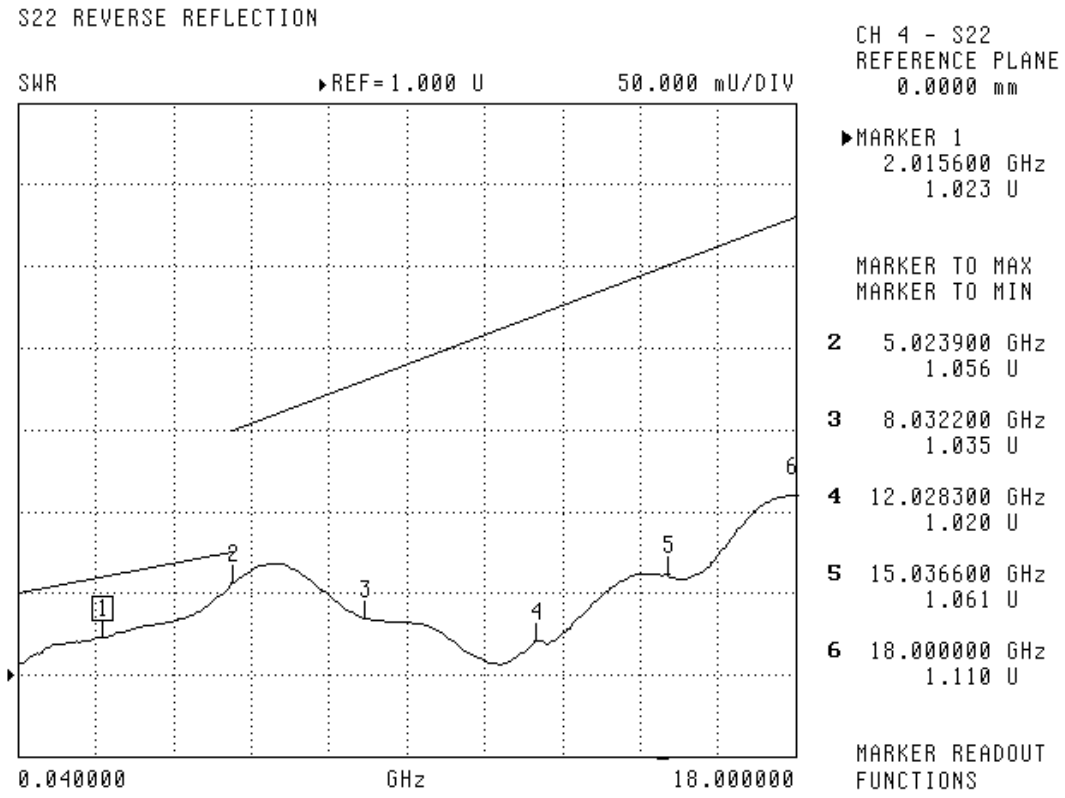


Sample 9

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

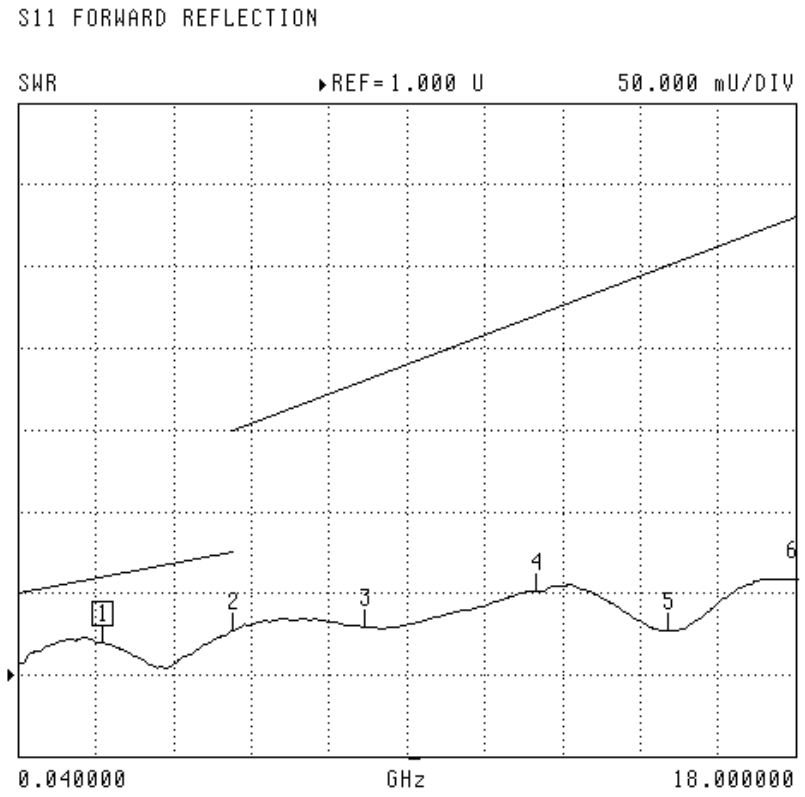


Sample 10

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

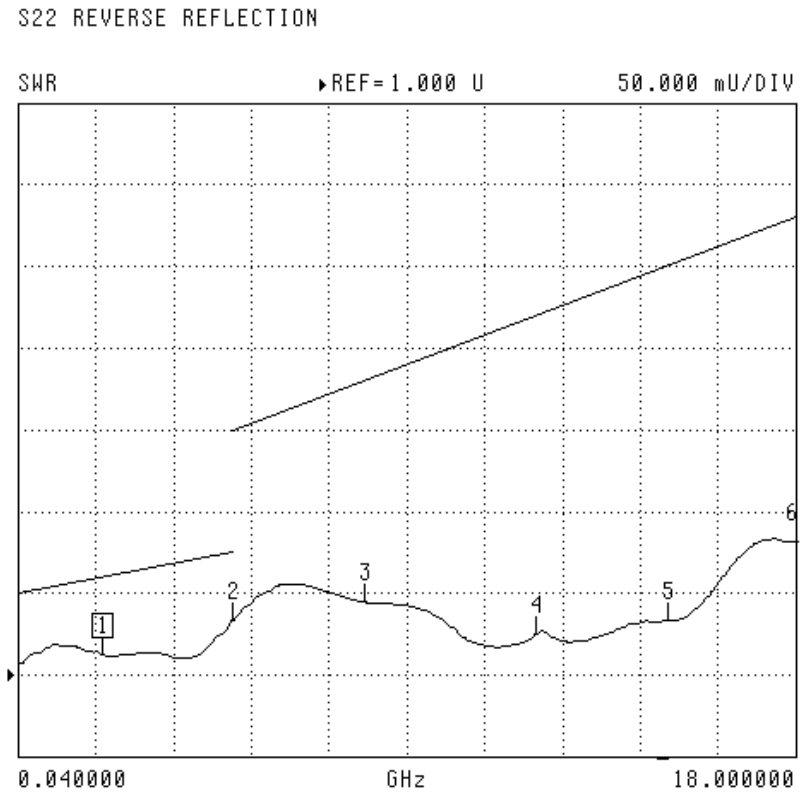


Sample 11

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

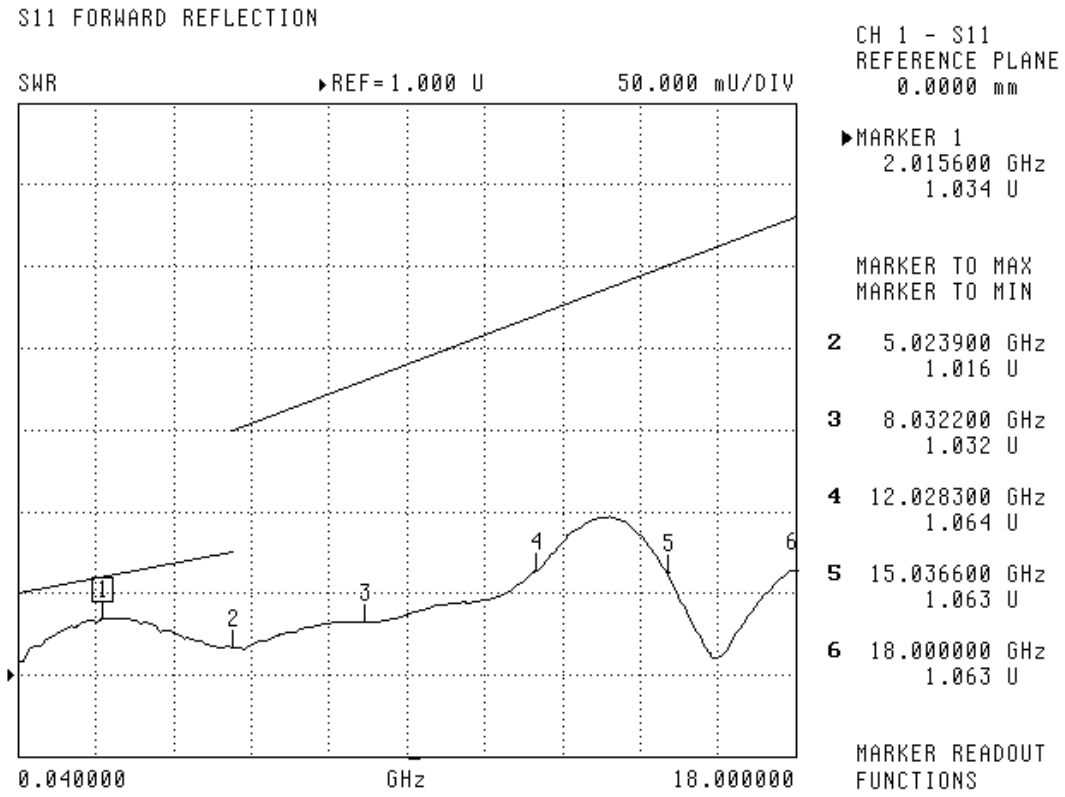


Sample 12

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006



Sample 13

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

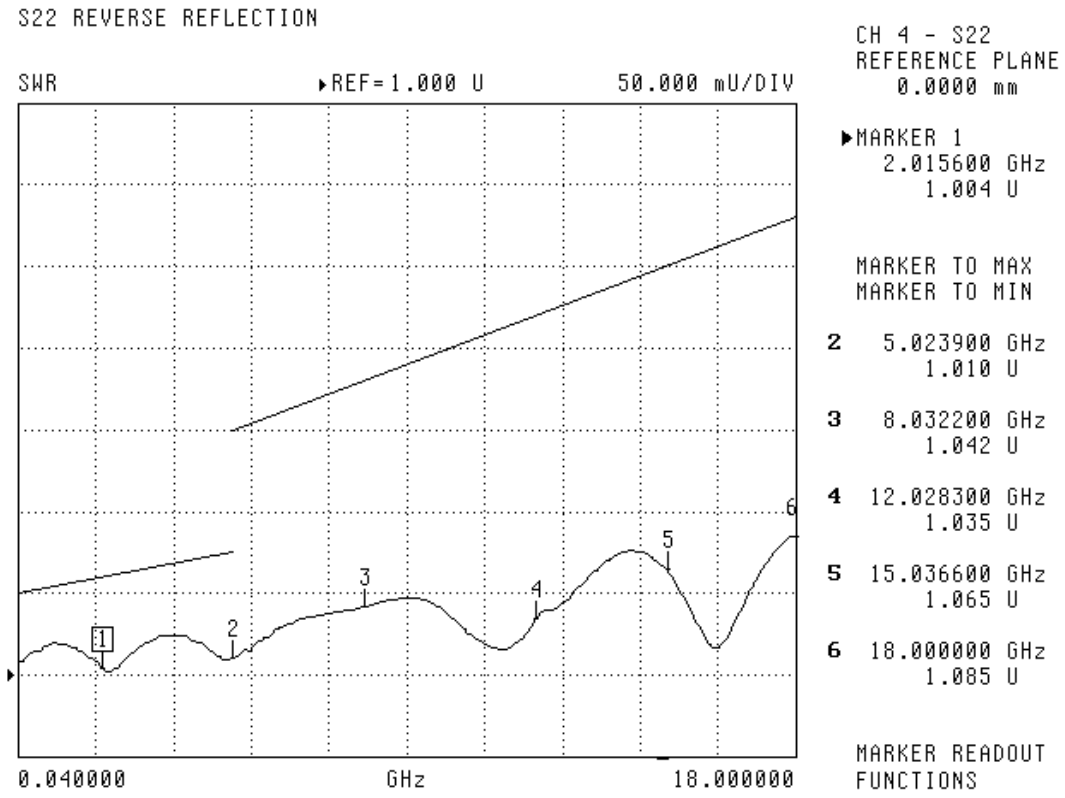
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006



Sample 14

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

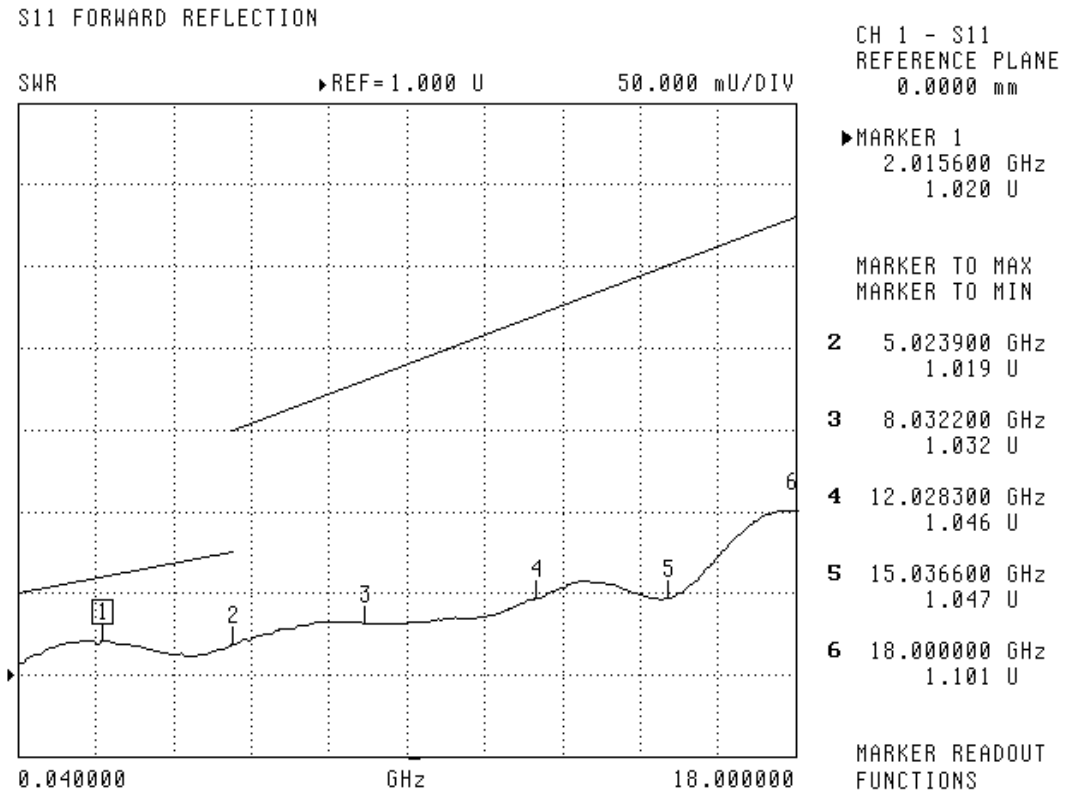
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

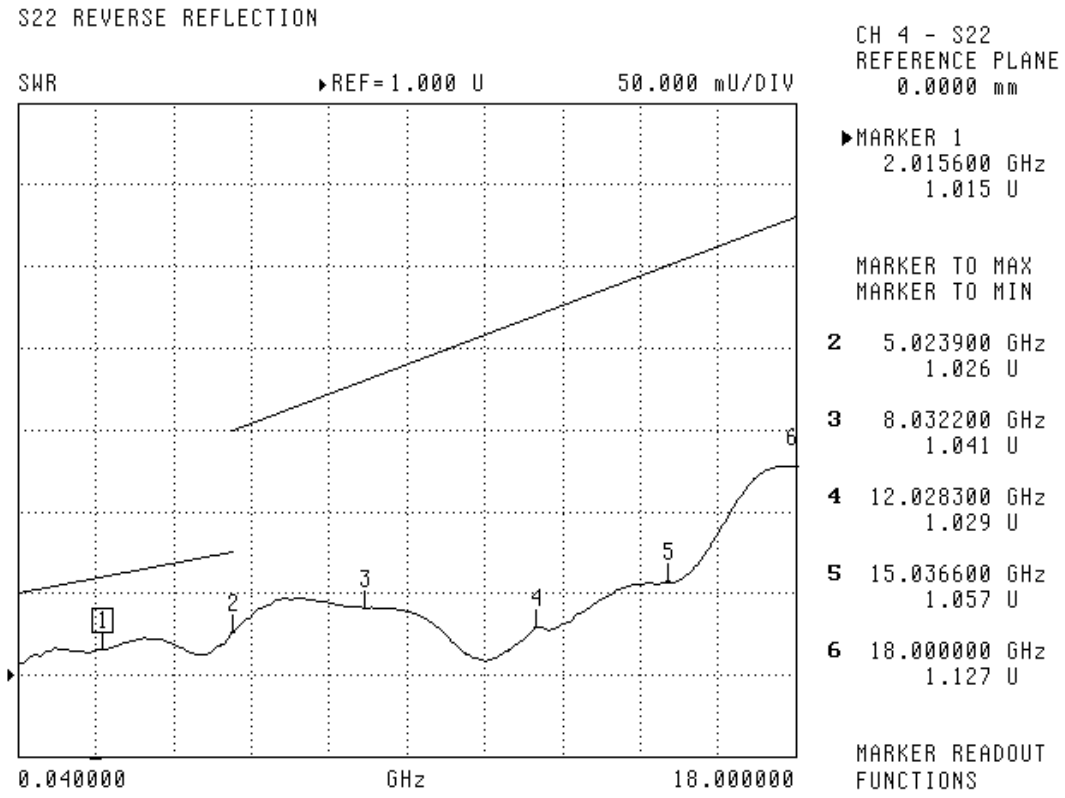


Sample 15

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

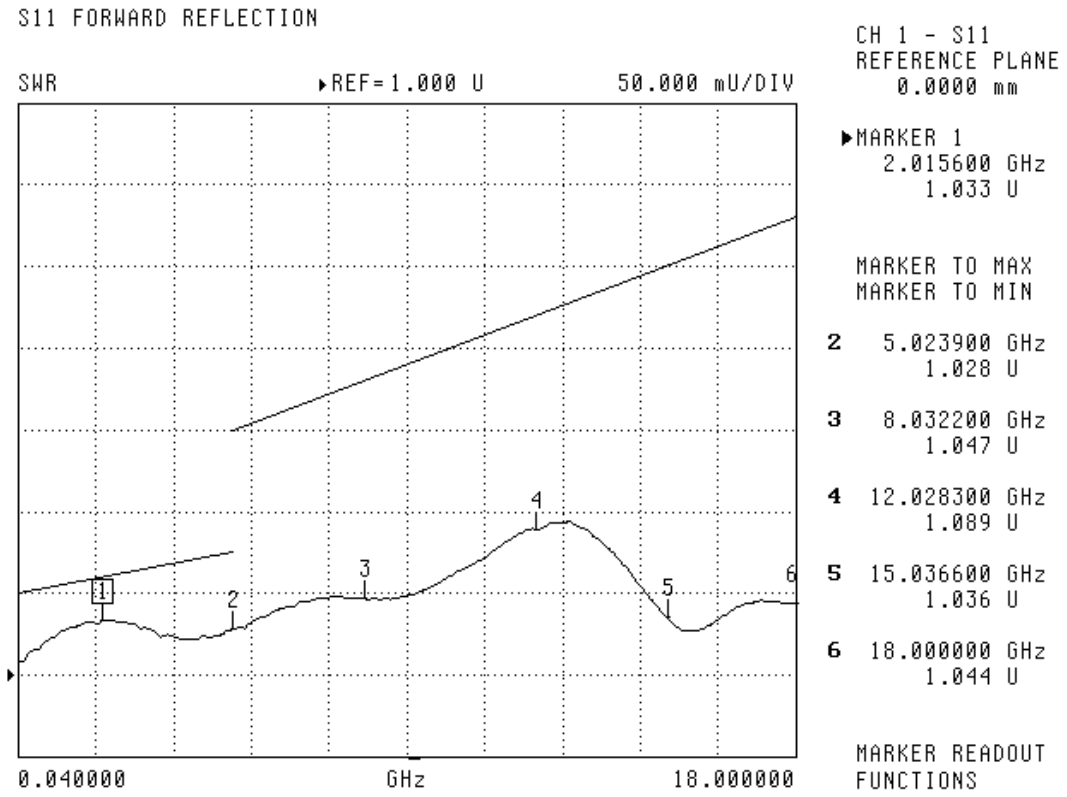


Sample 16

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

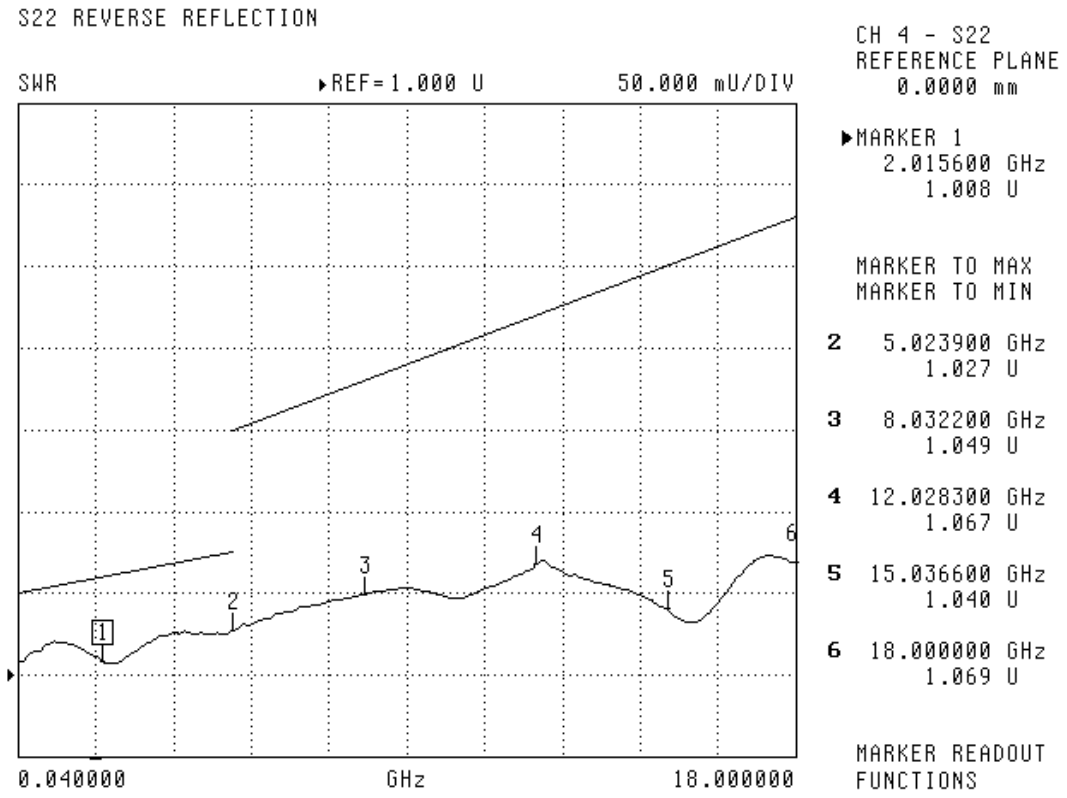


Sample 17

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

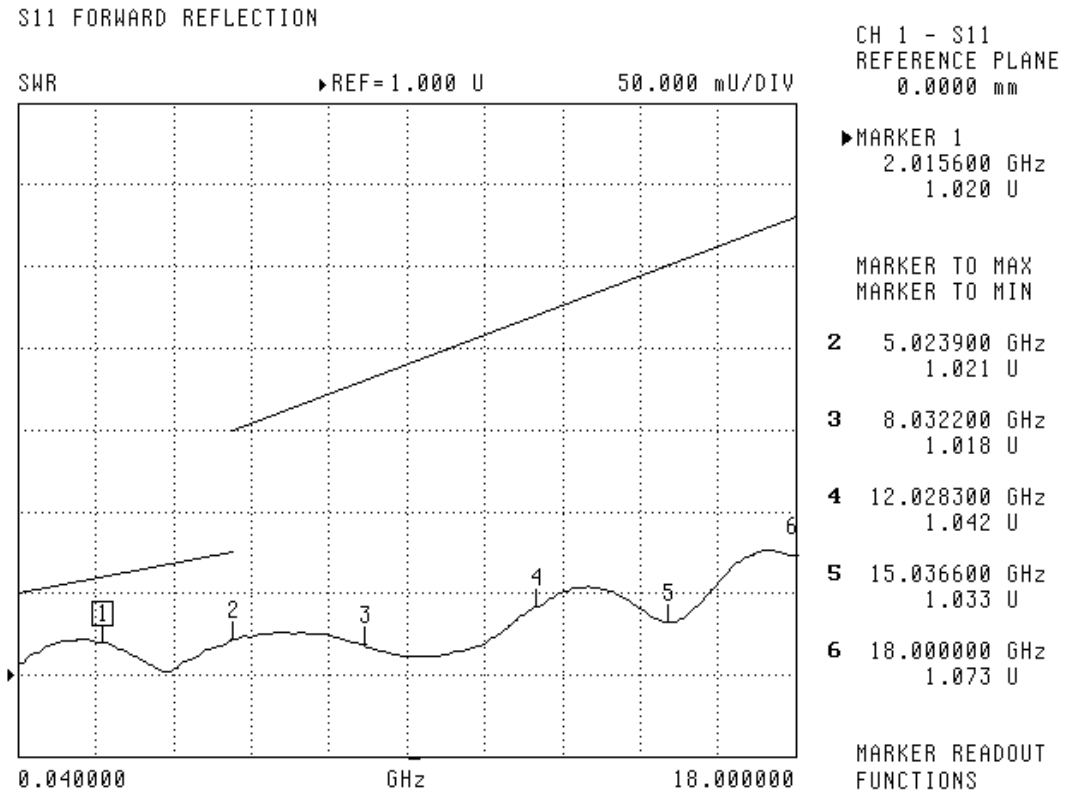


Sample 18

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

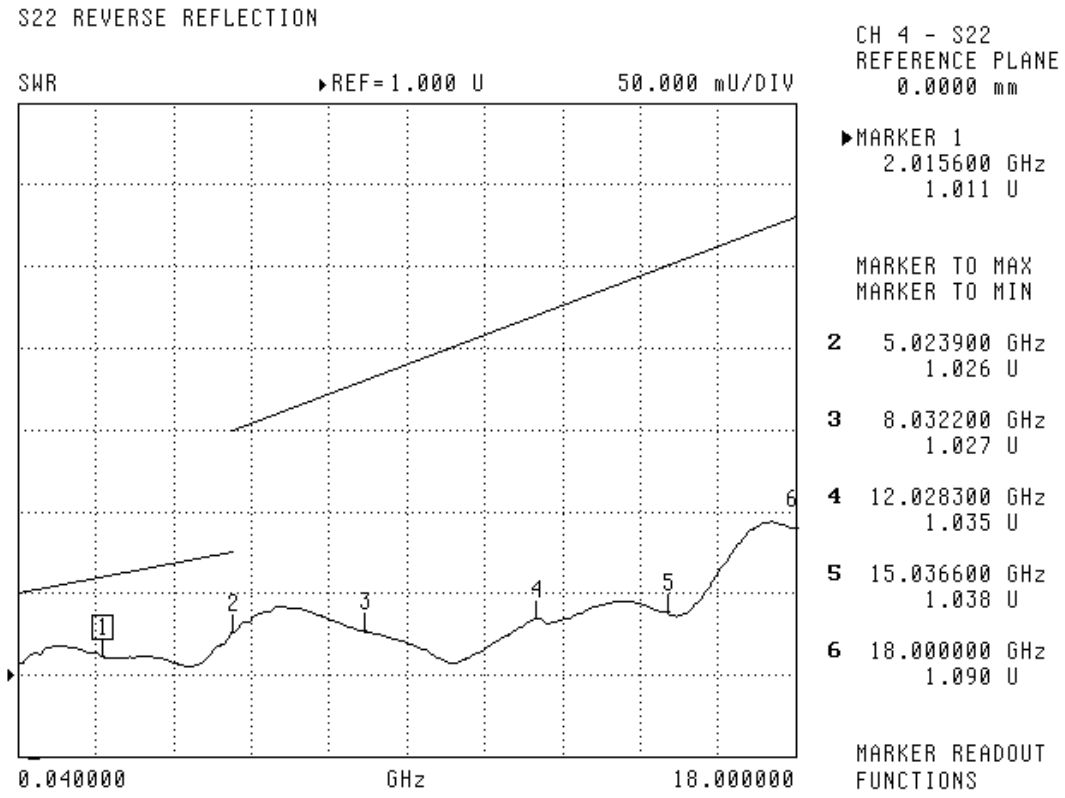


Sample 19

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

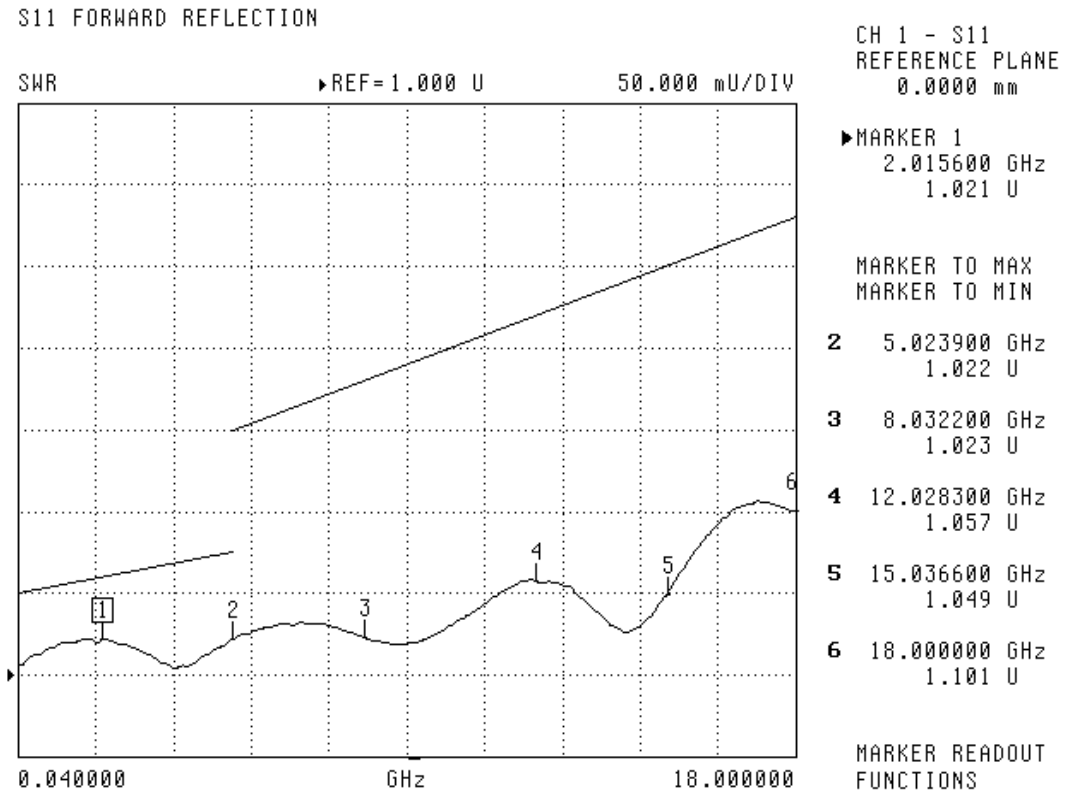


Sample 20

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

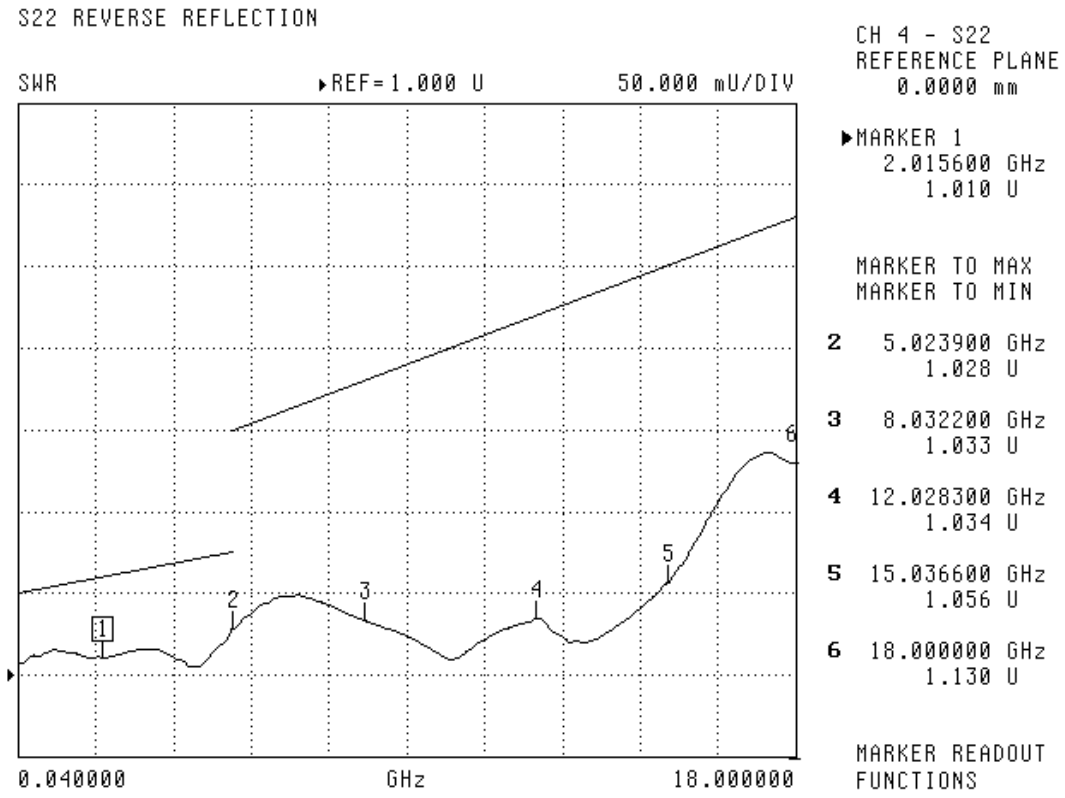


Sample 21

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

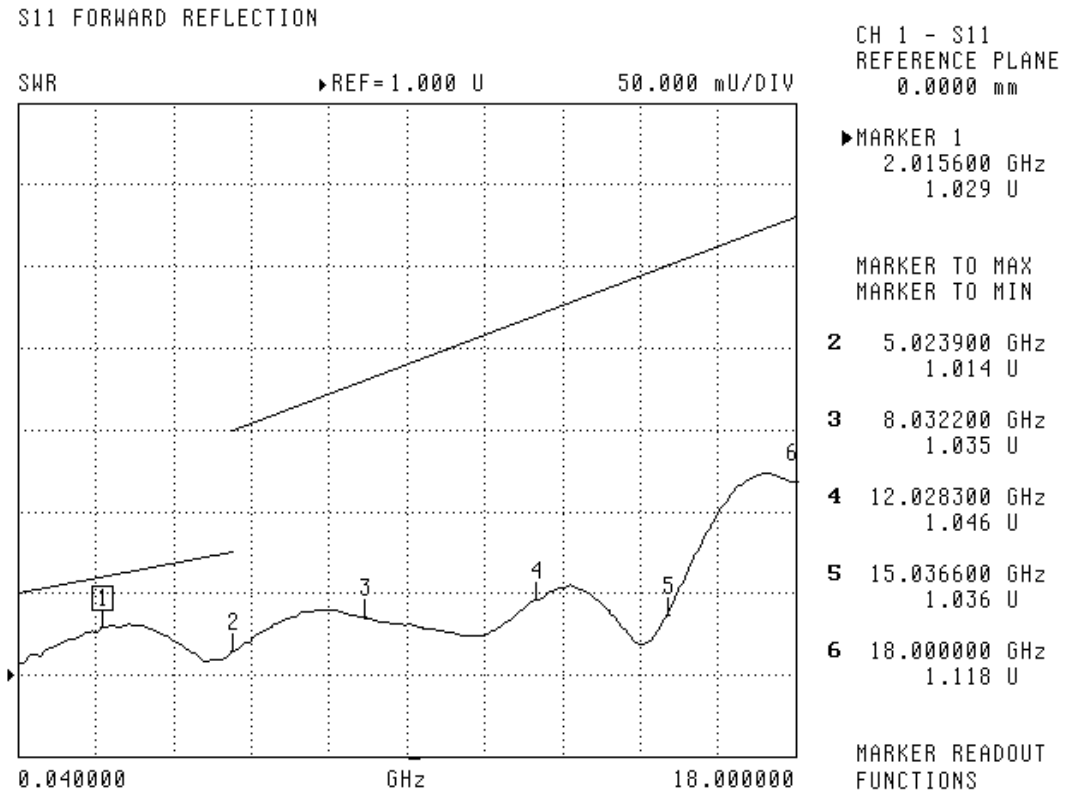


Sample 22

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

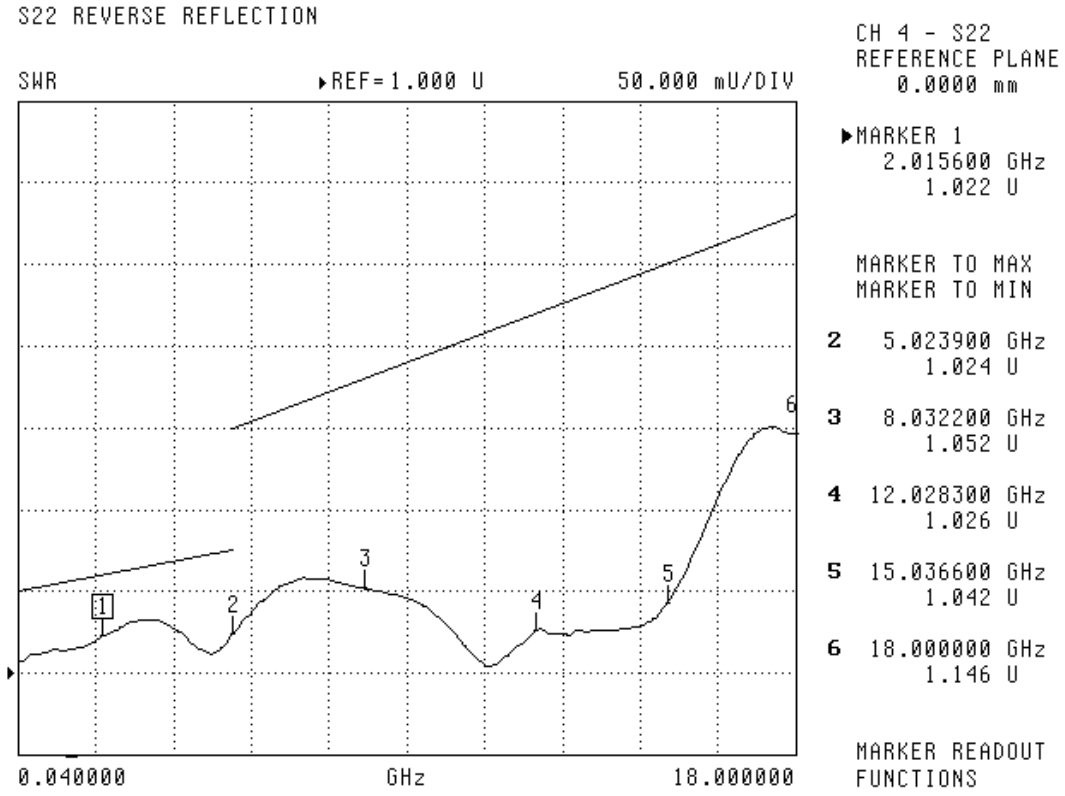


Sample 23

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

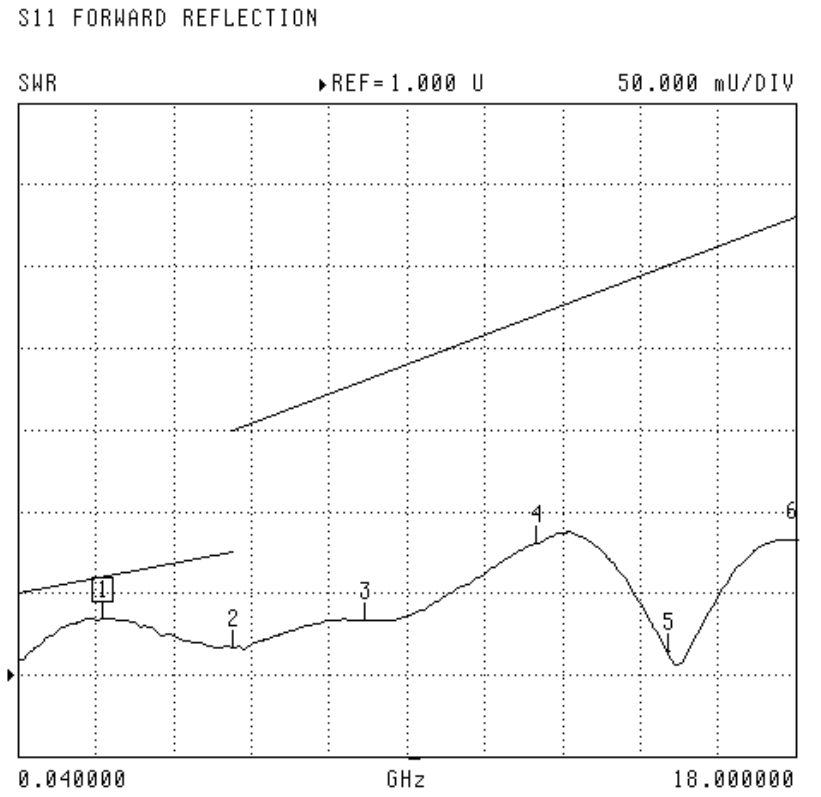


Sample 24

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006



CH 1 - S11
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
1.035 U

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
1.017 U

3 8.032200 GHz
1.033 U

4 12.028300 GHz
1.080 U

5 15.036600 GHz
1.014 U

6 18.000000 GHz
1.083 U

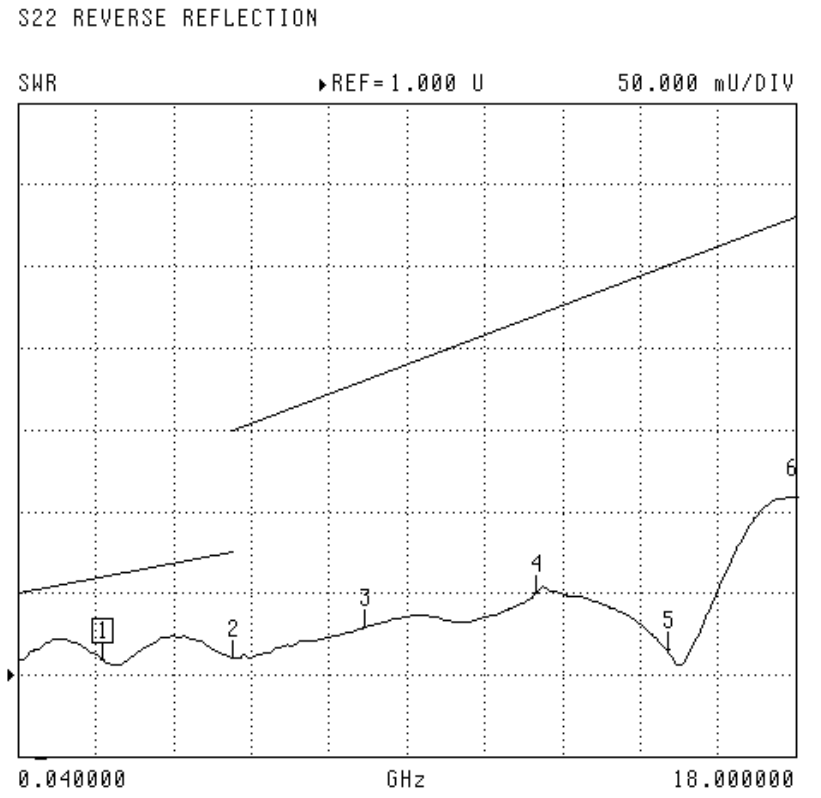
MARKER READOUT
FUNCTIONS

Sample 25

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006



CH 4 - S22
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
1.009 U

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
1.010 U

3 8.032200 GHz
1.029 U

4 12.028300 GHz
1.051 U

5 15.036600 GHz
1.015 U

6 18.000000 GHz
1.108 U

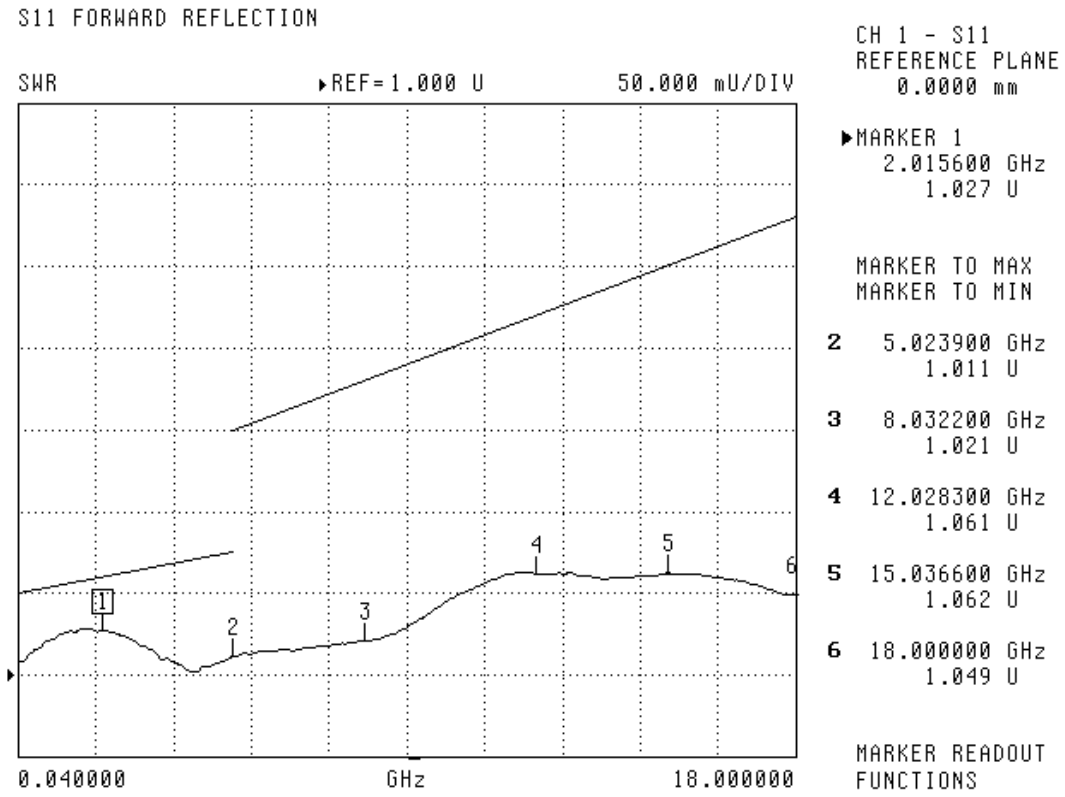
MARKER READOUT
FUNCTIONS

Sample 26

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

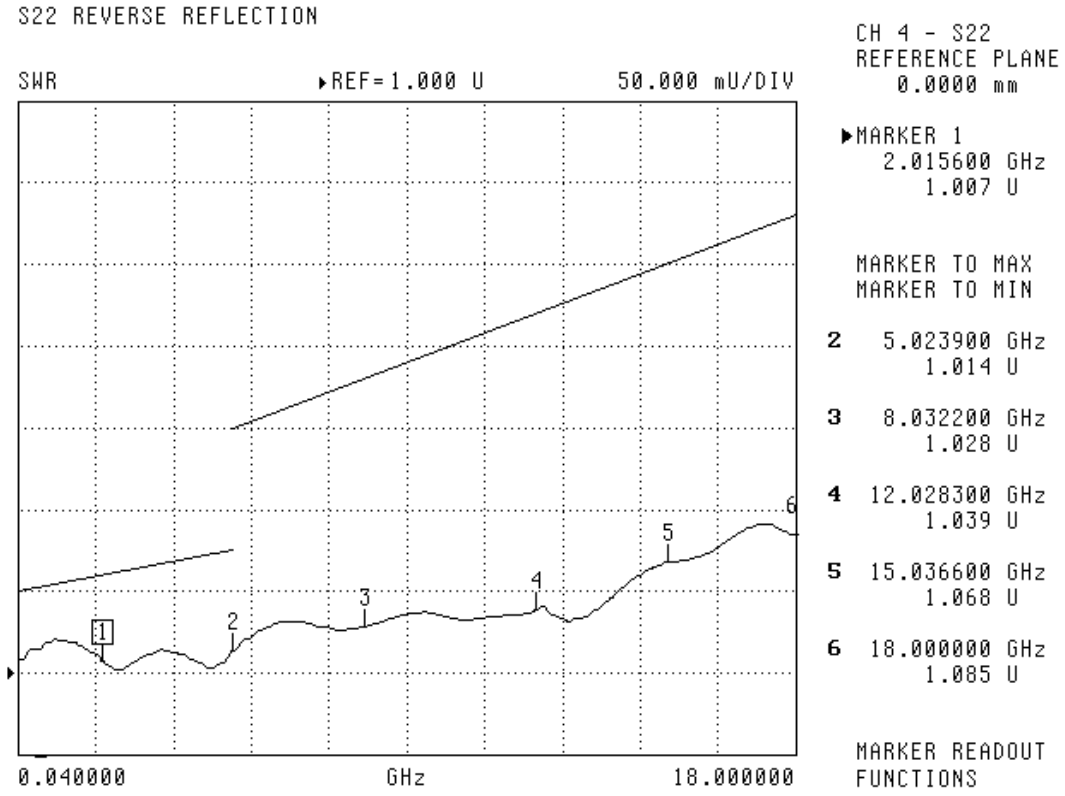


Sample 27

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

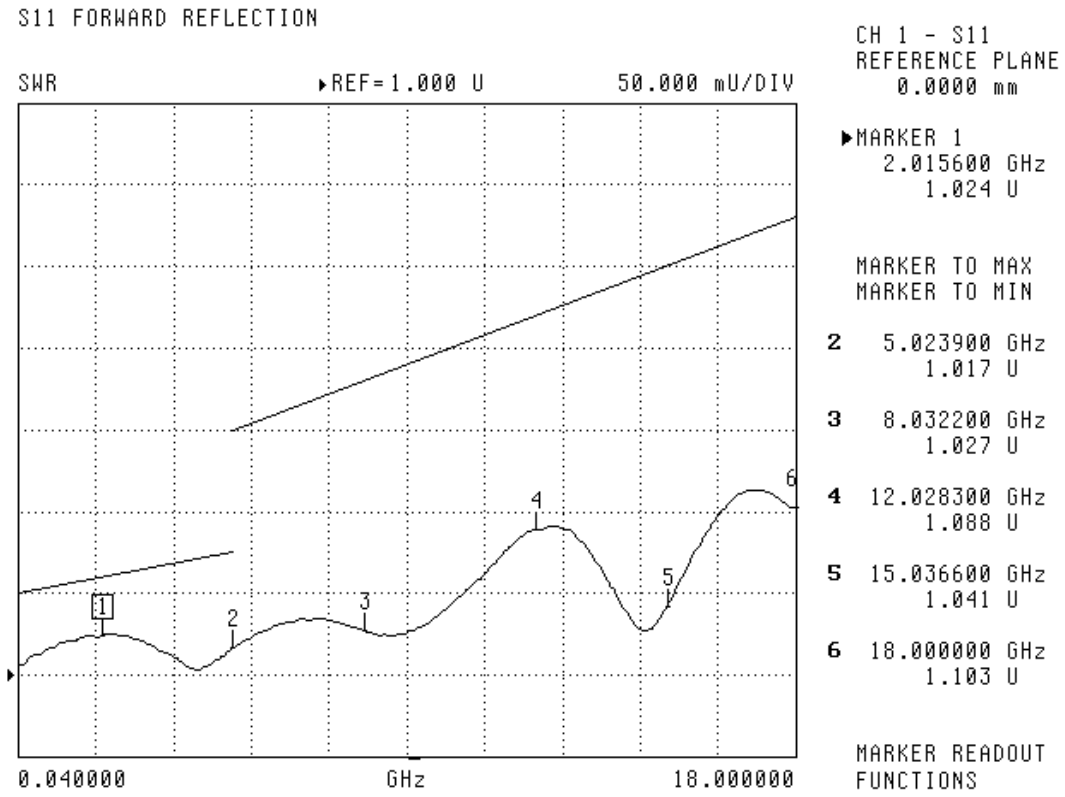


Sample 28

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

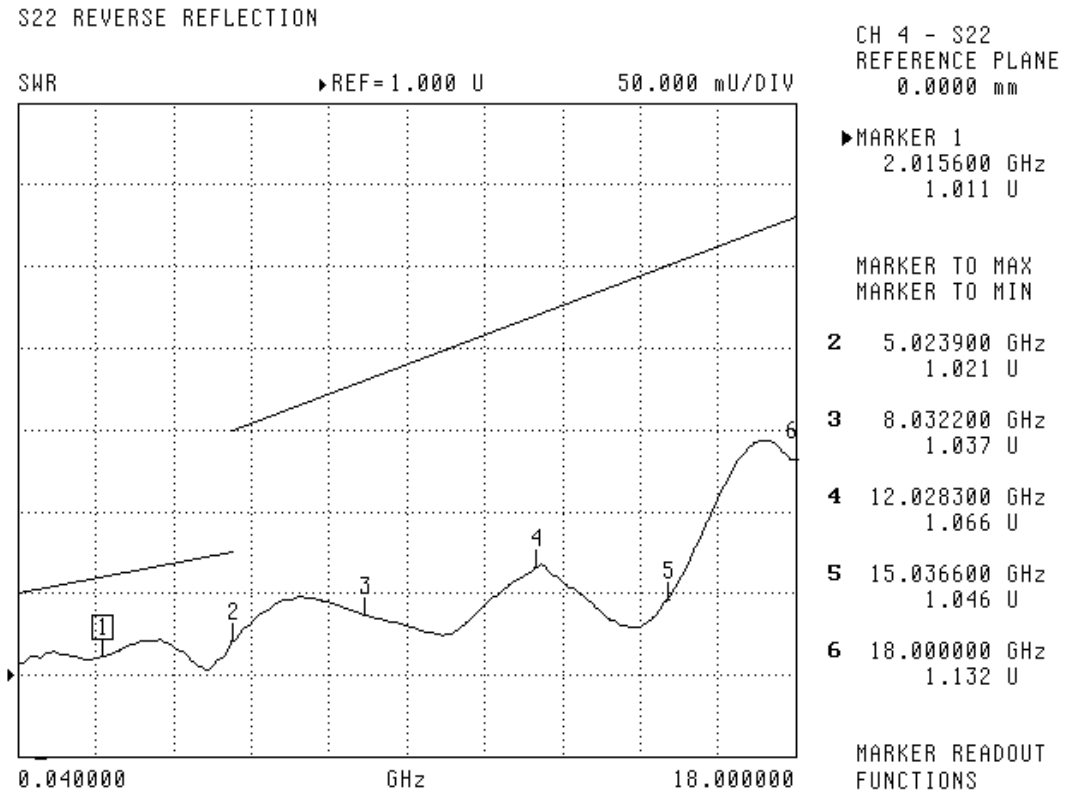


Sample 29

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

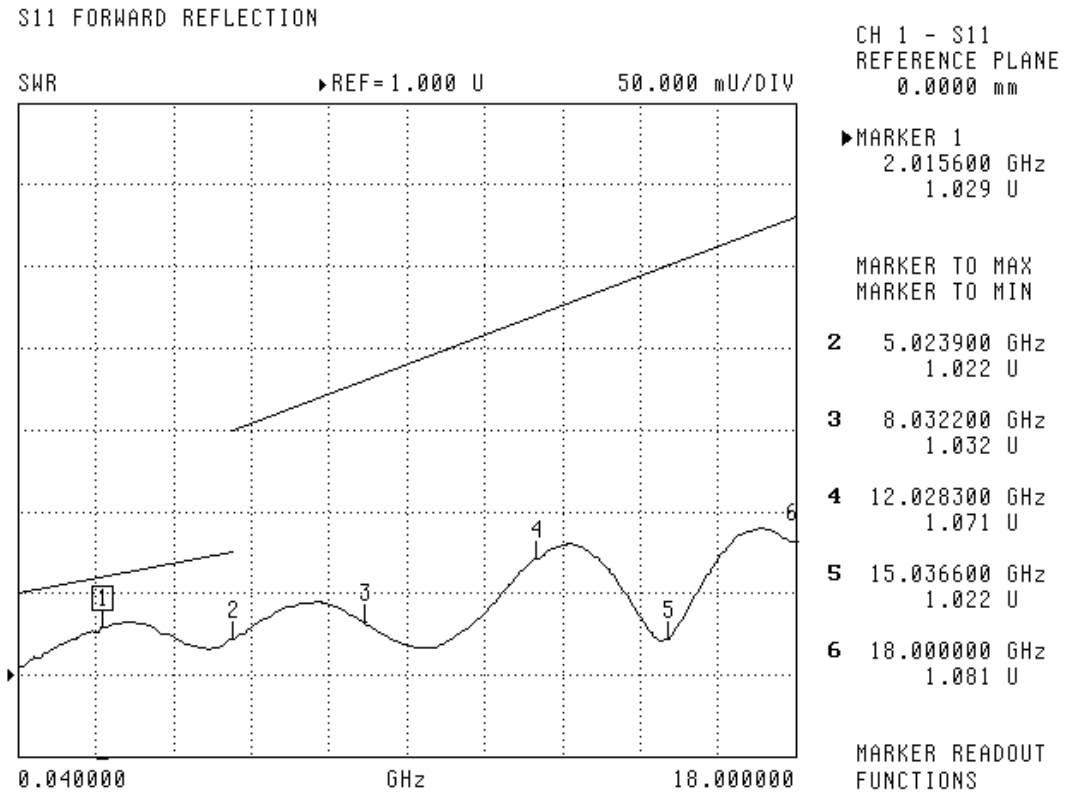


Sample 30

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

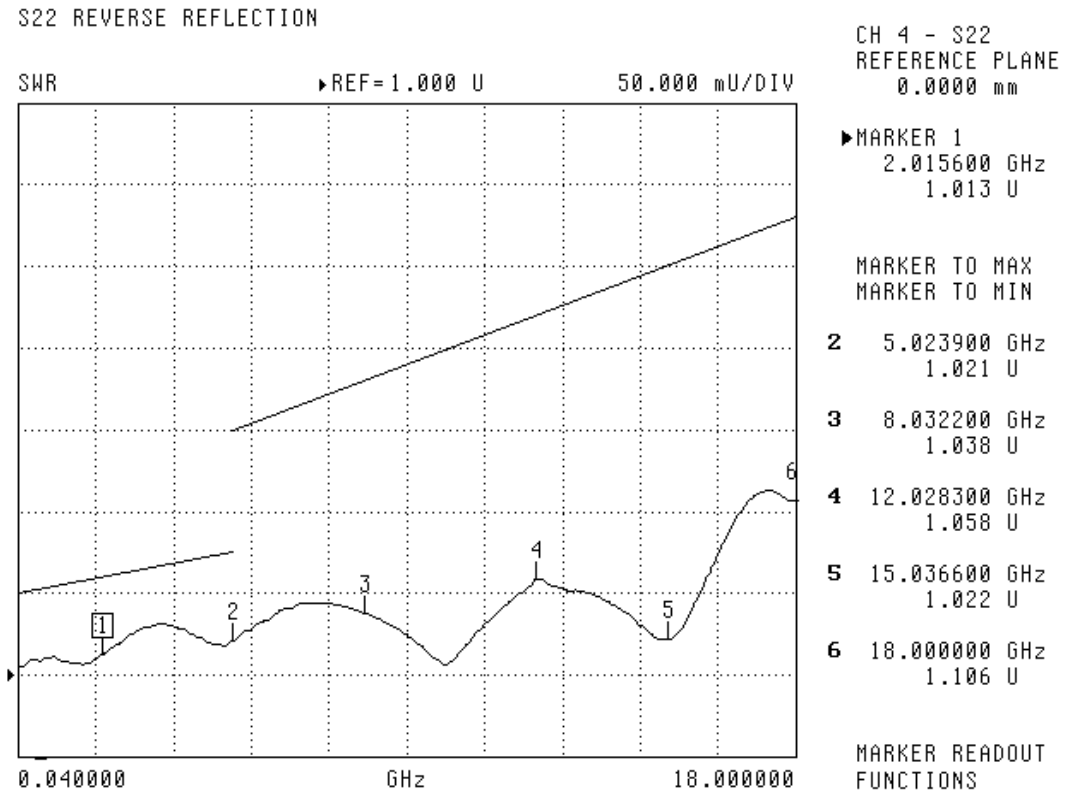


Sample 31

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

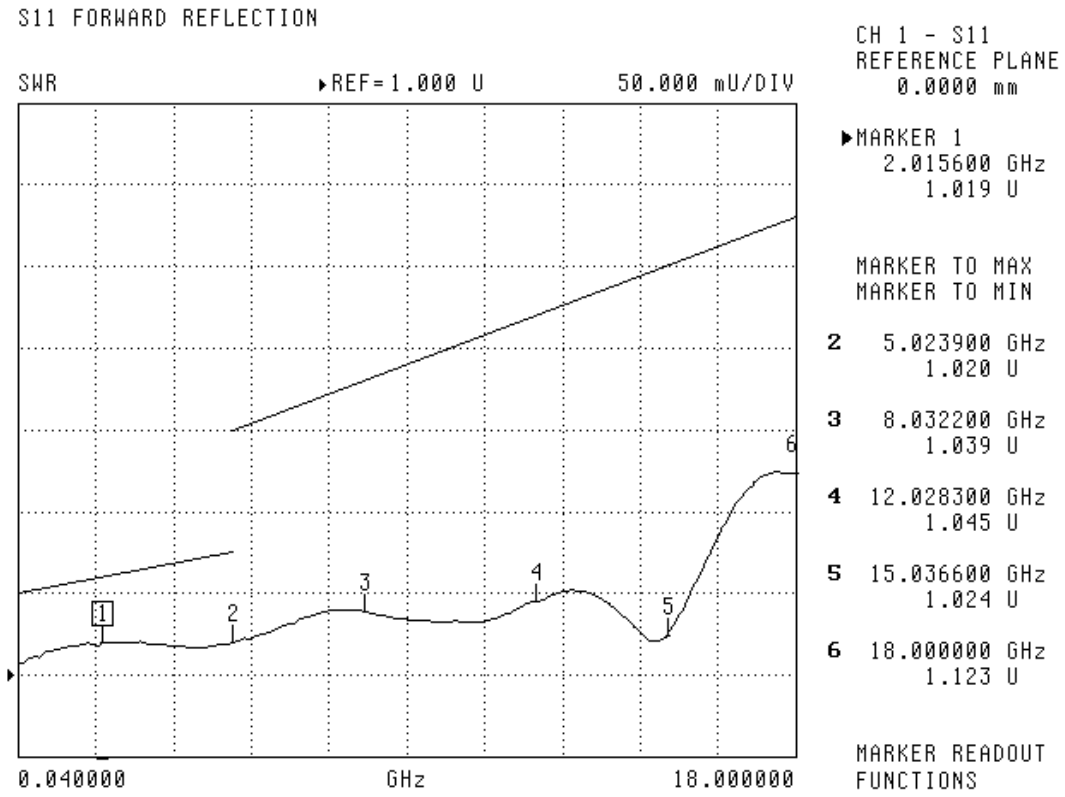


Sample 32

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

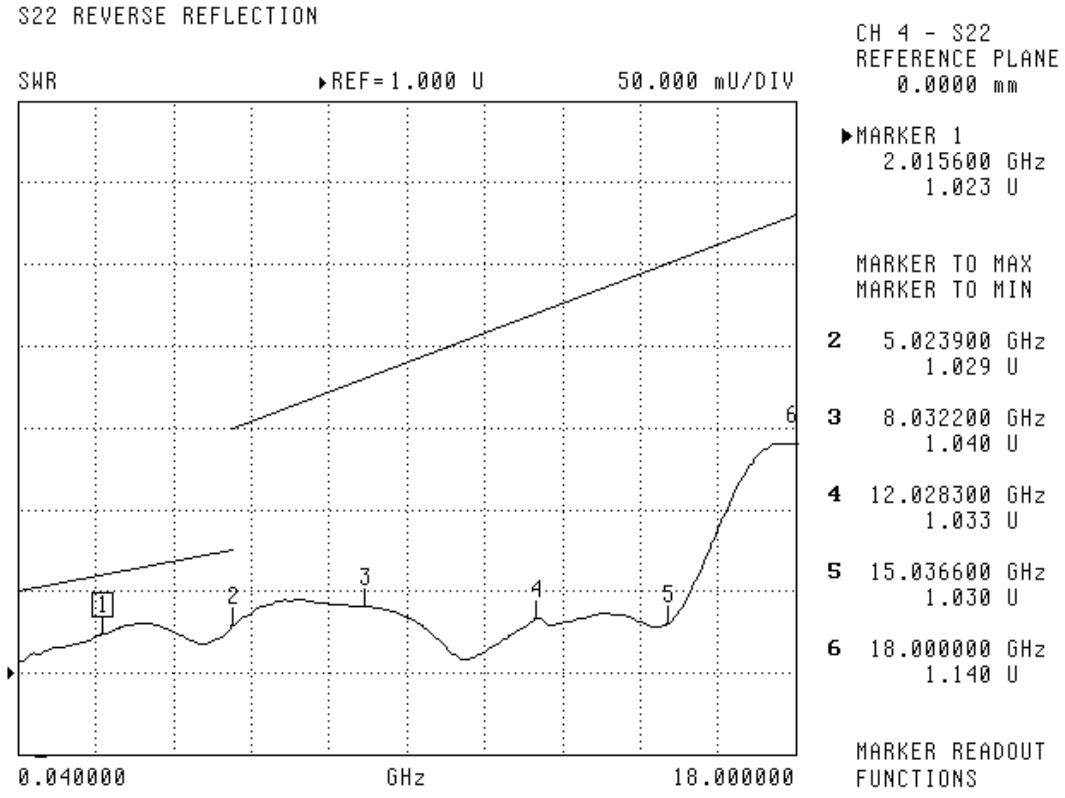


Sample 33

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

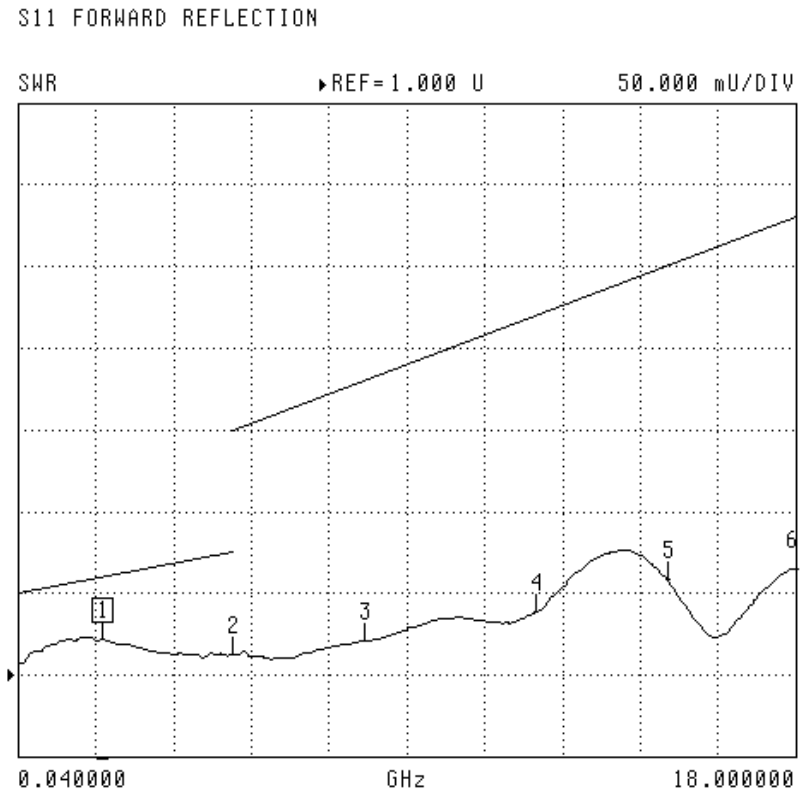


Sample 34

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006



CH 1 - S11
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
1.021 U

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
1.013 U

3 8.032200 GHz
1.020 U

4 12.028300 GHz
1.039 U

5 15.036600 GHz
1.059 U

6 18.000000 GHz
1.064 U

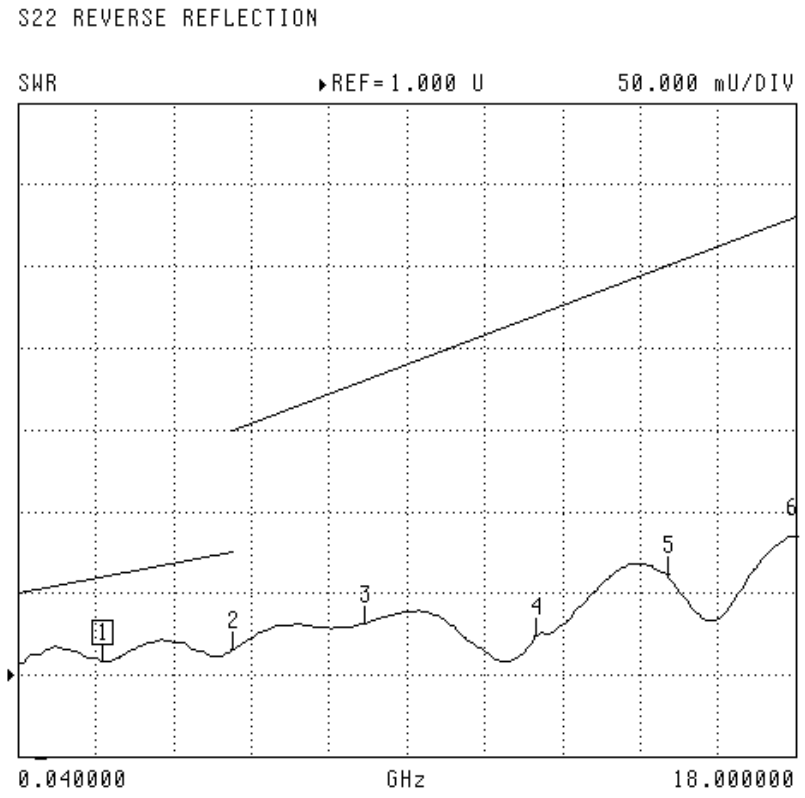
MARKER READOUT
FUNCTIONS

Sample 35

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006



CH 4 - S22
REFERENCE PLANE
0.0000 mm

▸MARKER 1
2.015600 GHz
1.008 U

MARKER TO MAX
MARKER TO MIN

2 5.023900 GHz
1.016 U

3 8.032200 GHz
1.031 U

4 12.028300 GHz
1.024 U

5 15.036600 GHz
1.061 U

6 18.000000 GHz
1.085 U

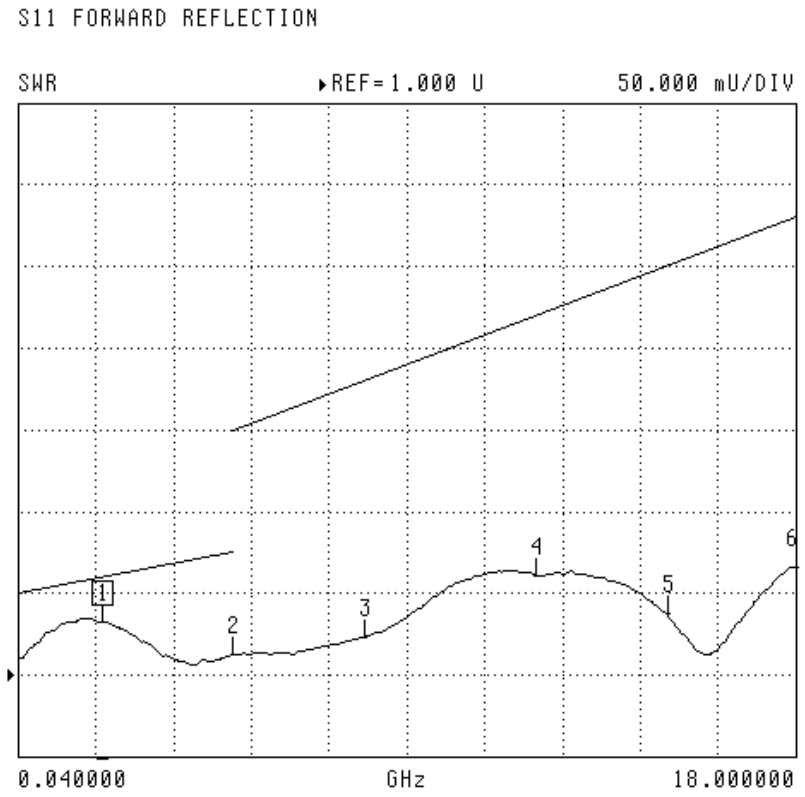
MARKER READOUT
FUNCTIONS

Sample 95

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

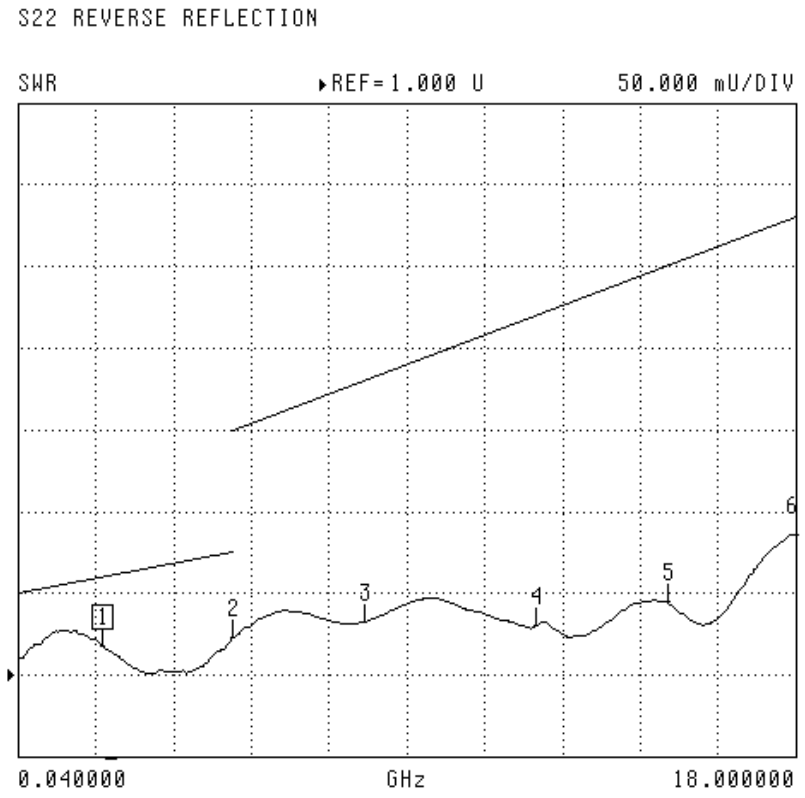


Sample 96

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

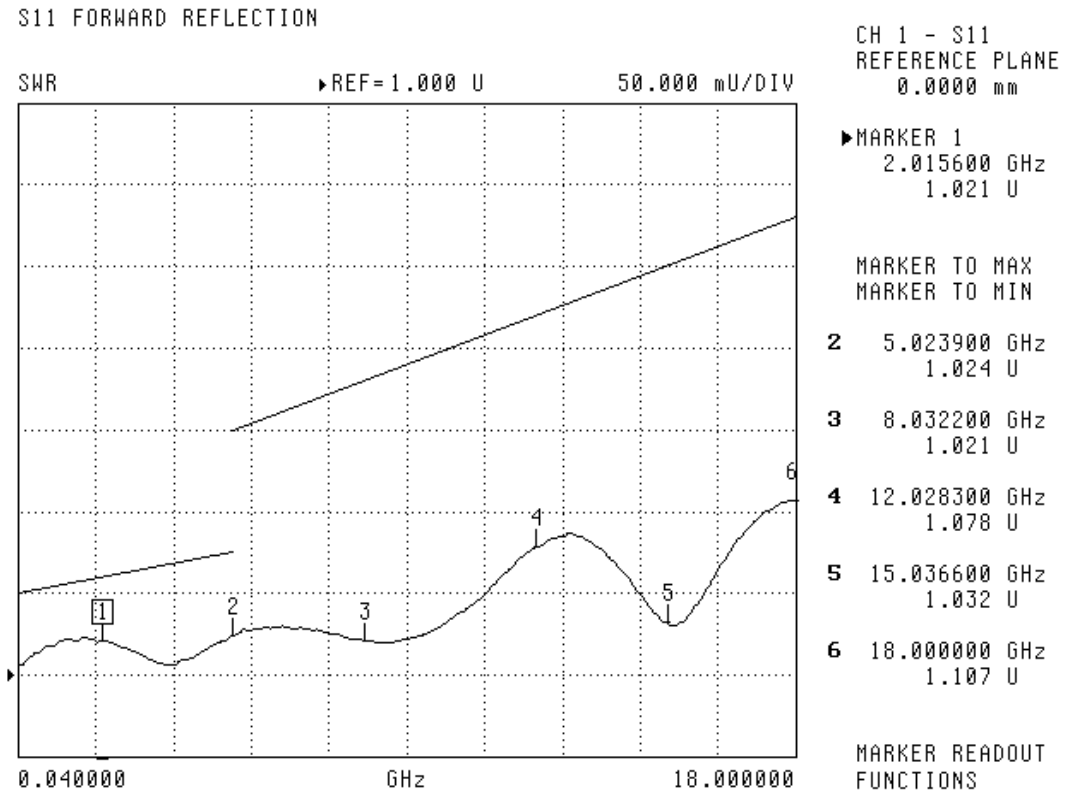


Sample 97

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

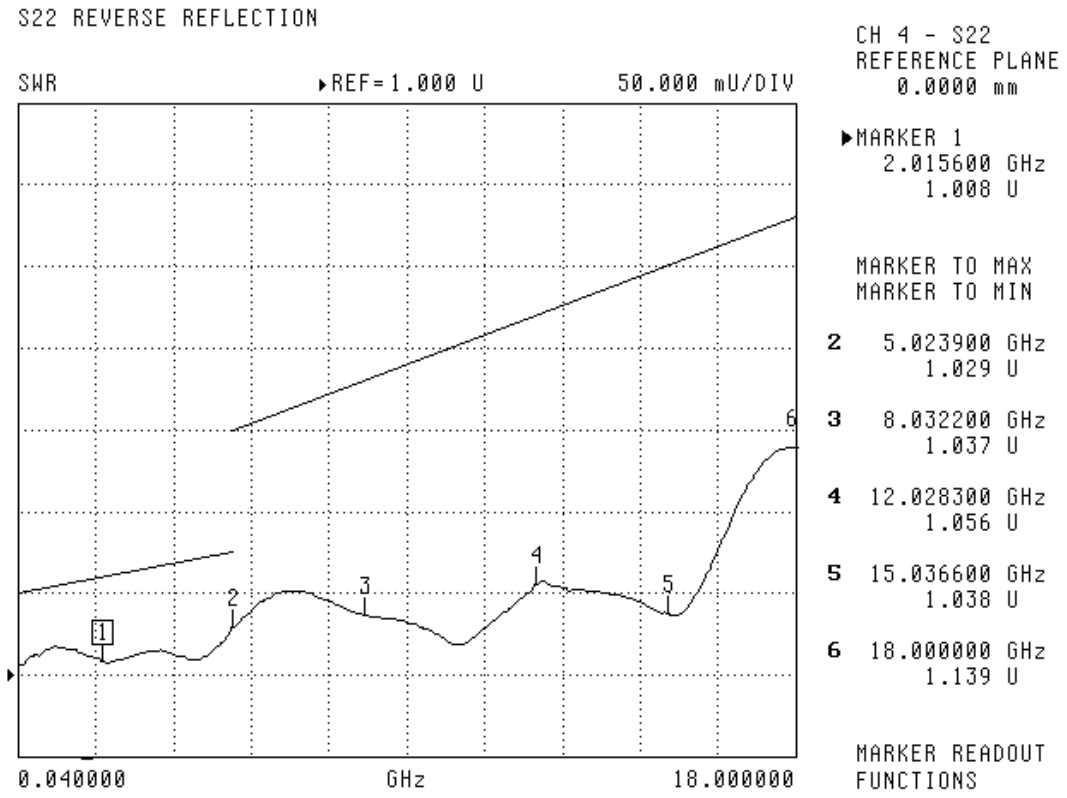


Sample 98

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

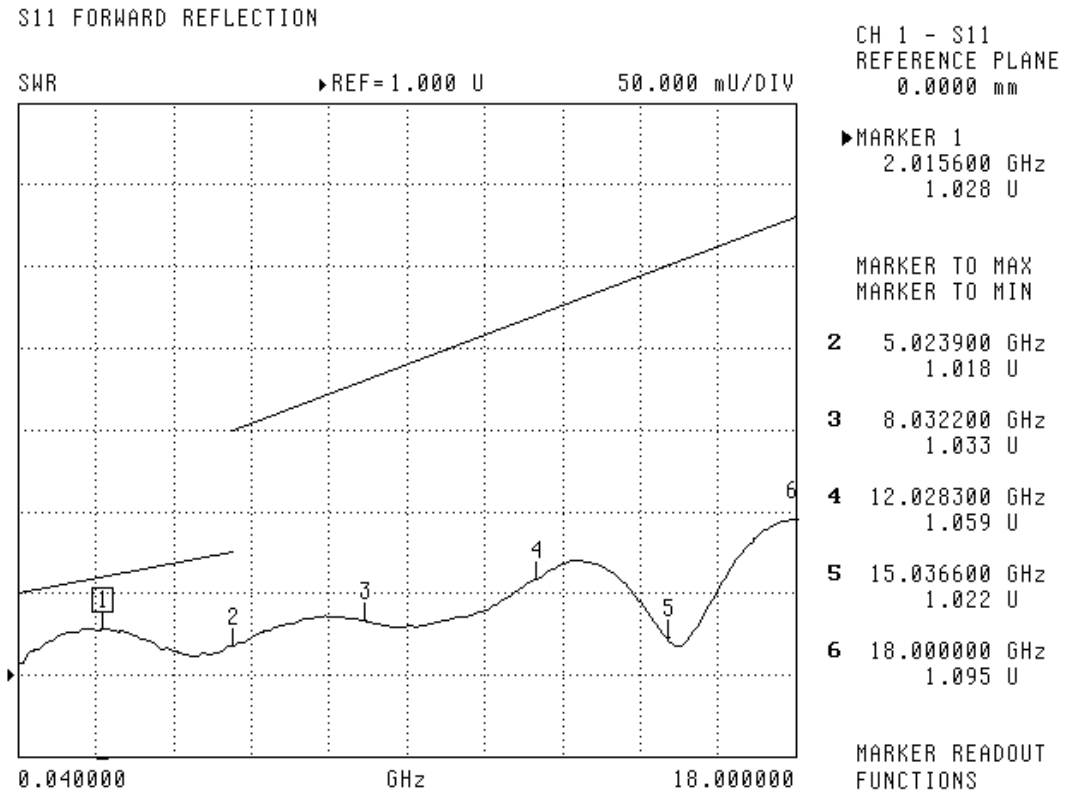


Sample 99

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

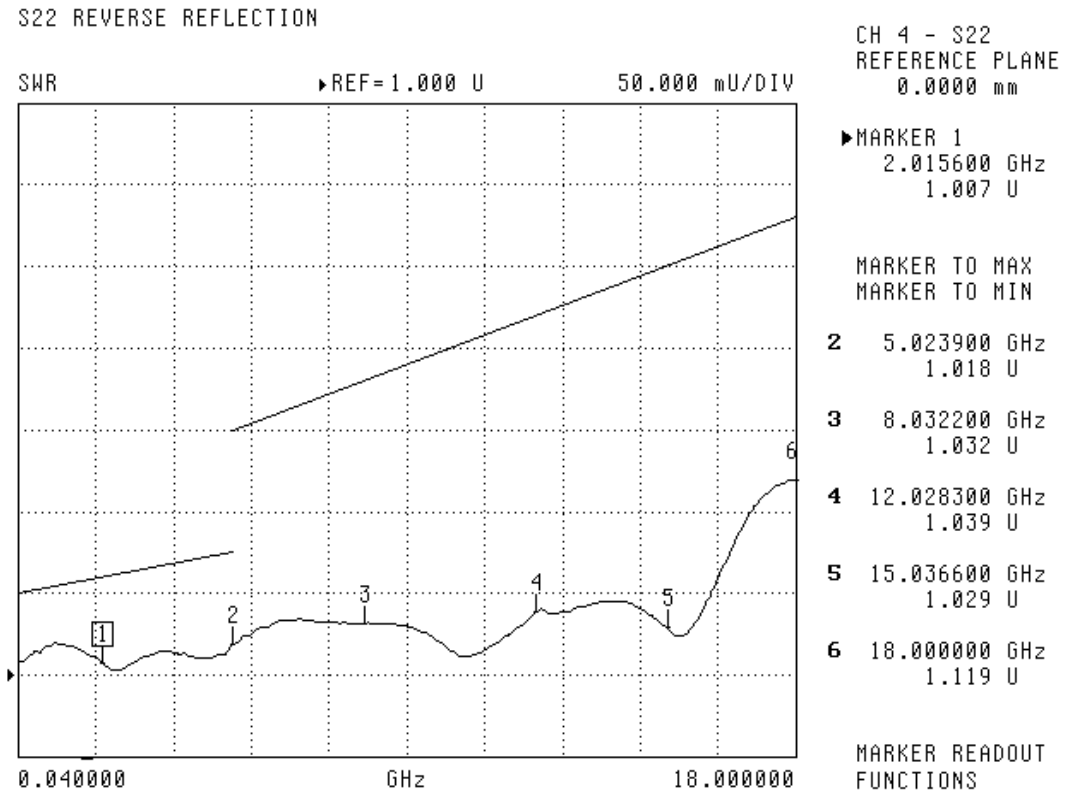


Sample 100

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

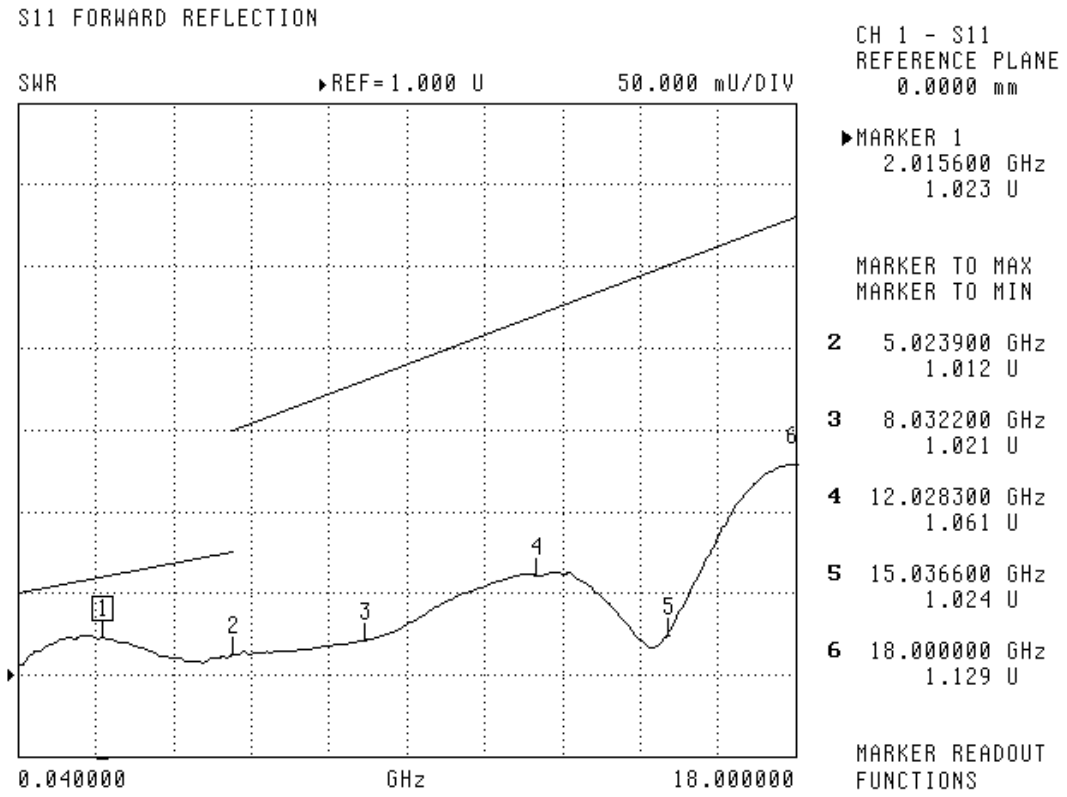


Sample 101

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

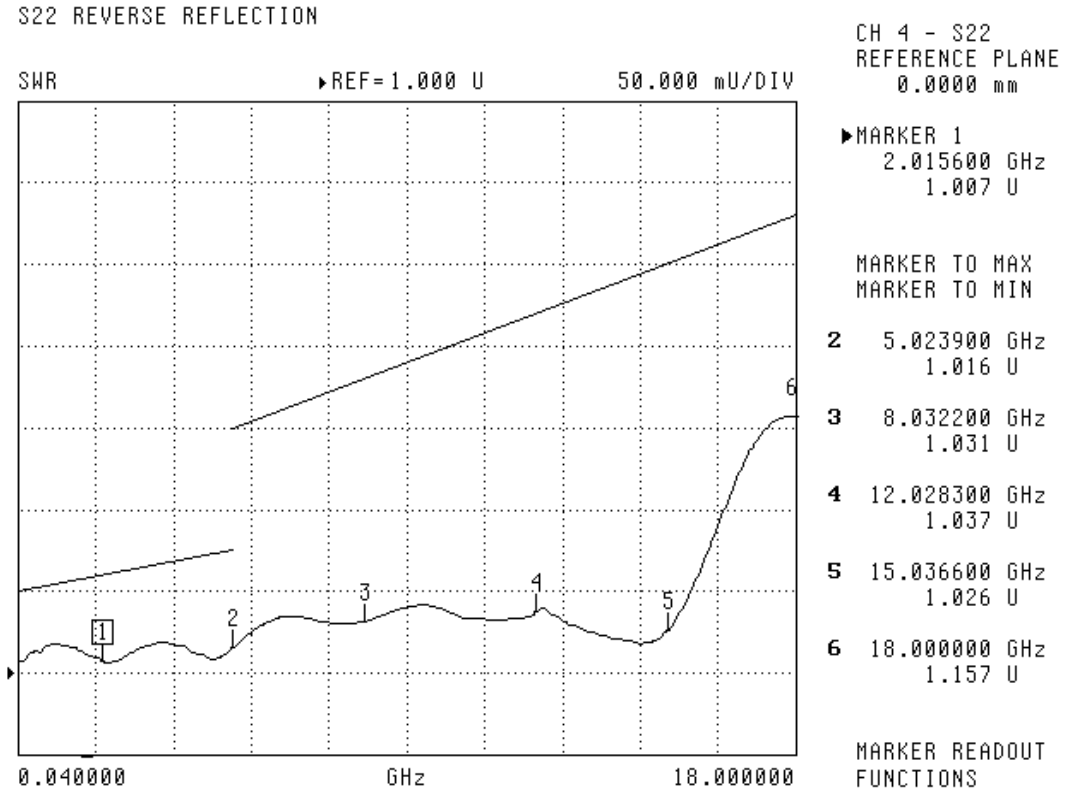


Sample 102

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

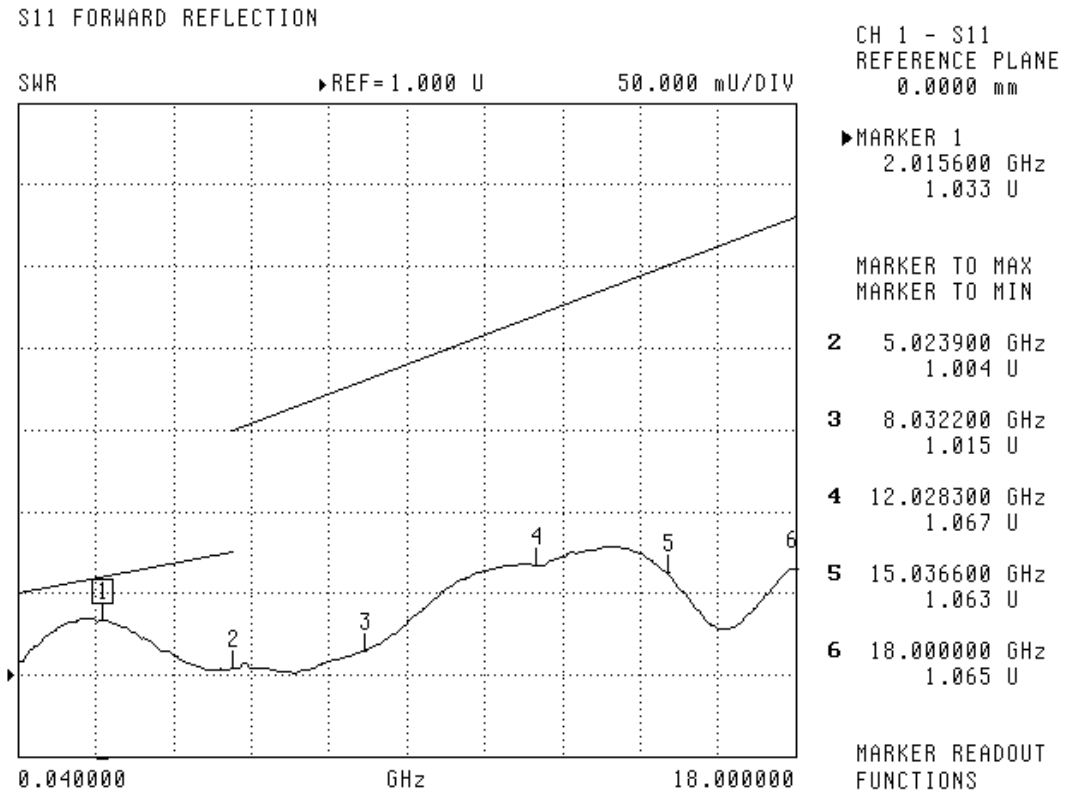


Sample 103

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

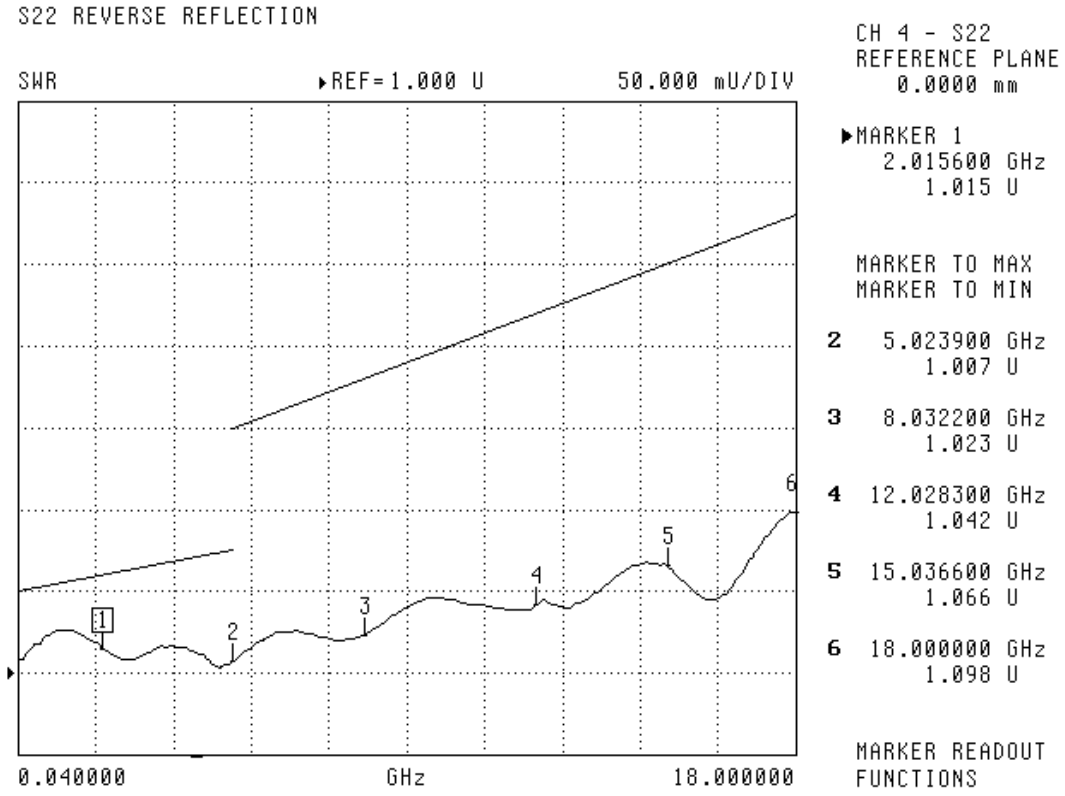


Sample 104

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

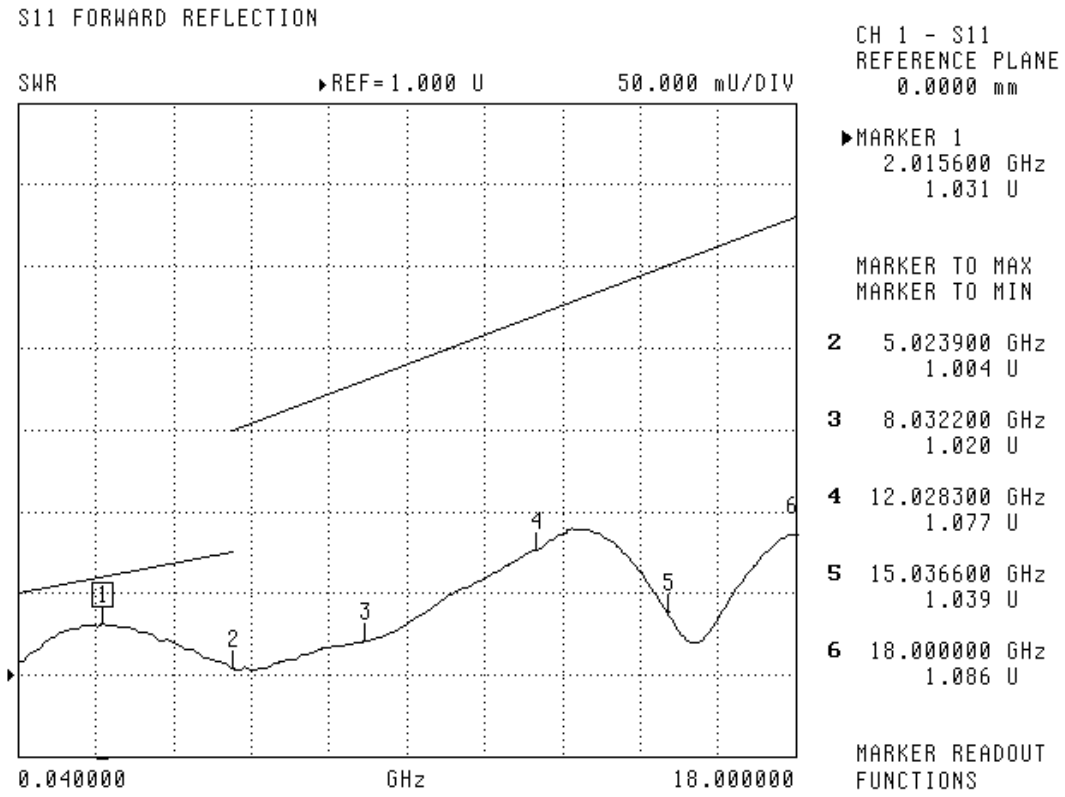


Sample 105

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

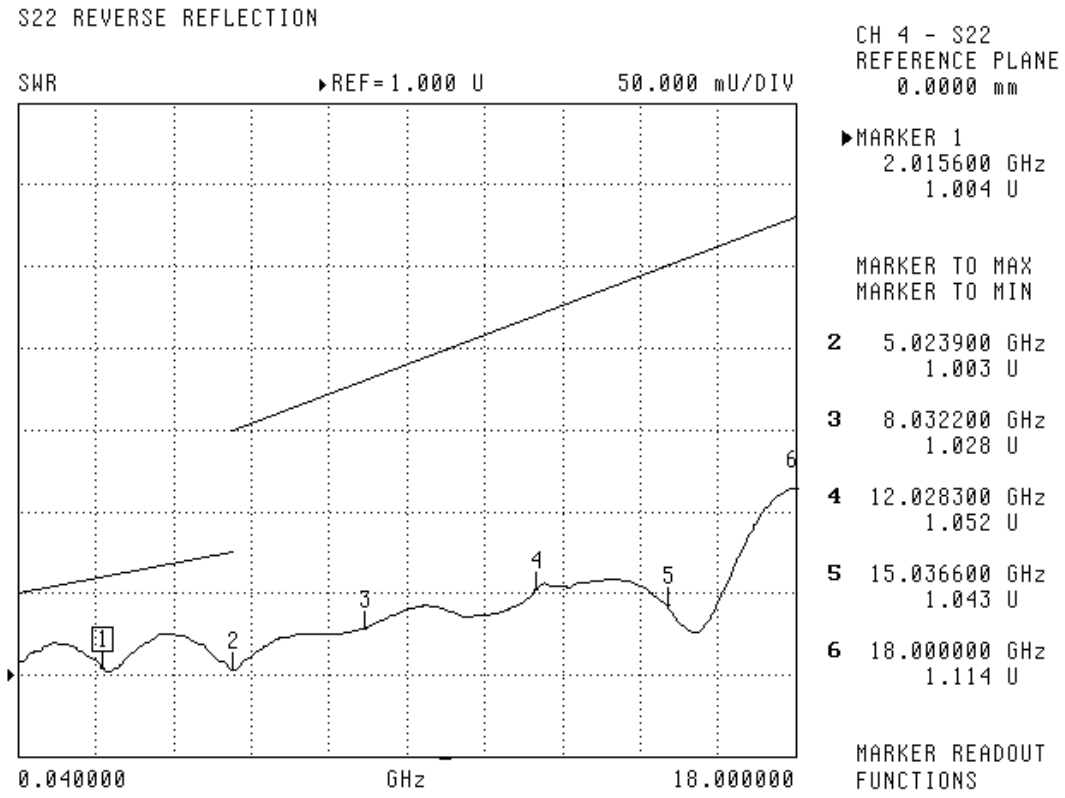


Sample 106

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

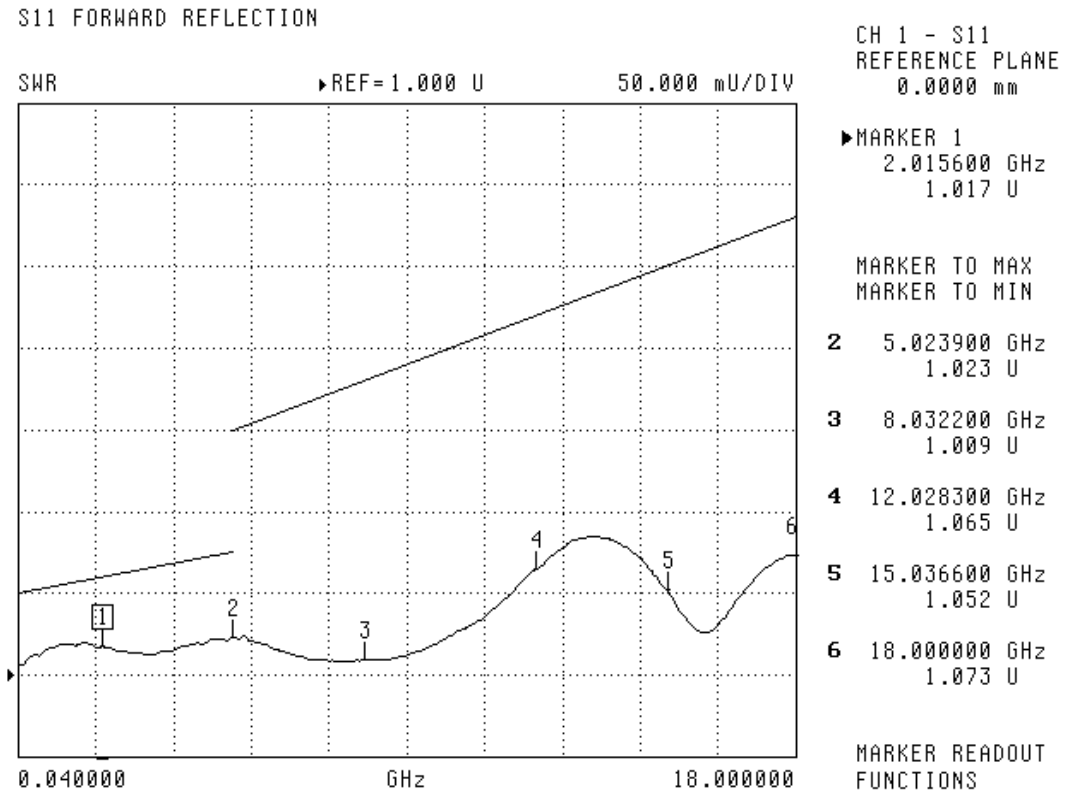


Sample 107

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

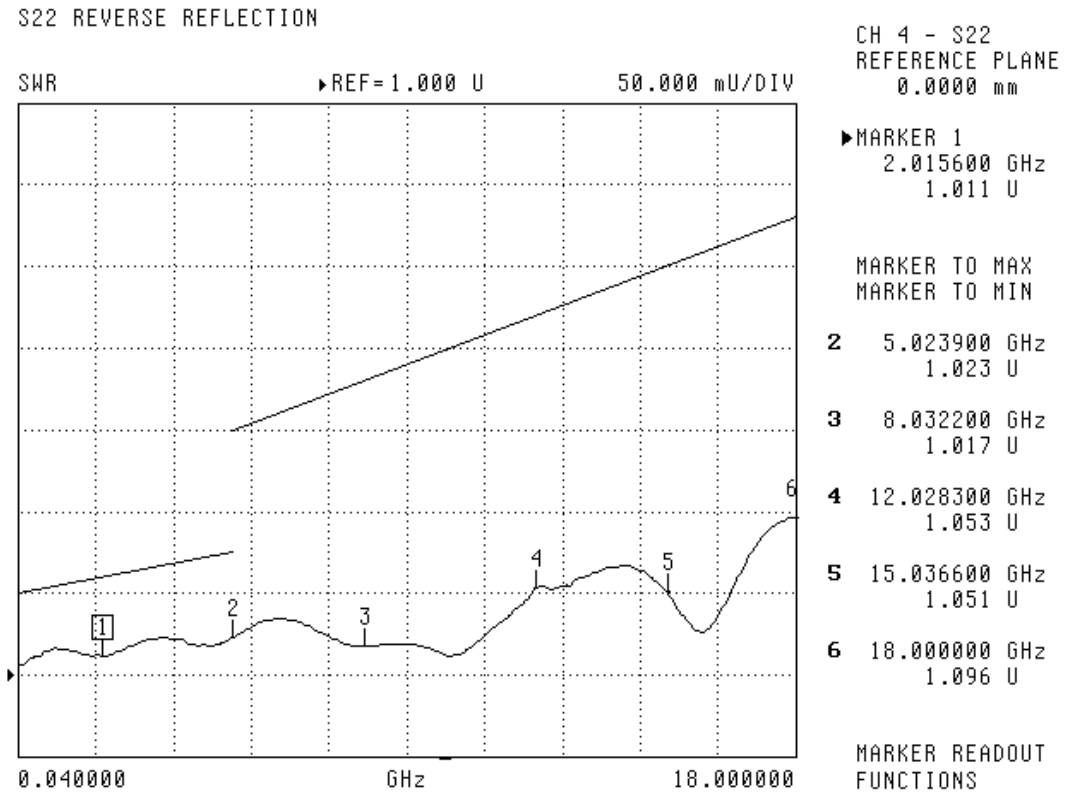


Sample 108

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

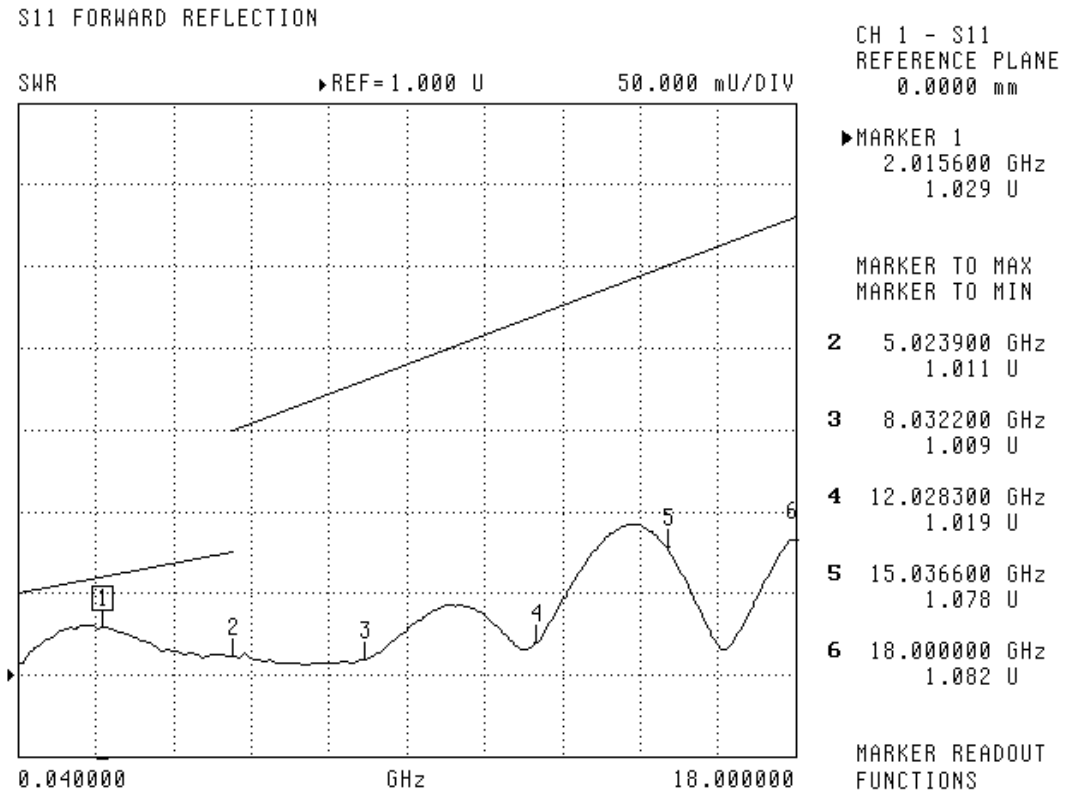


Sample 109

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006



Sample 110

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

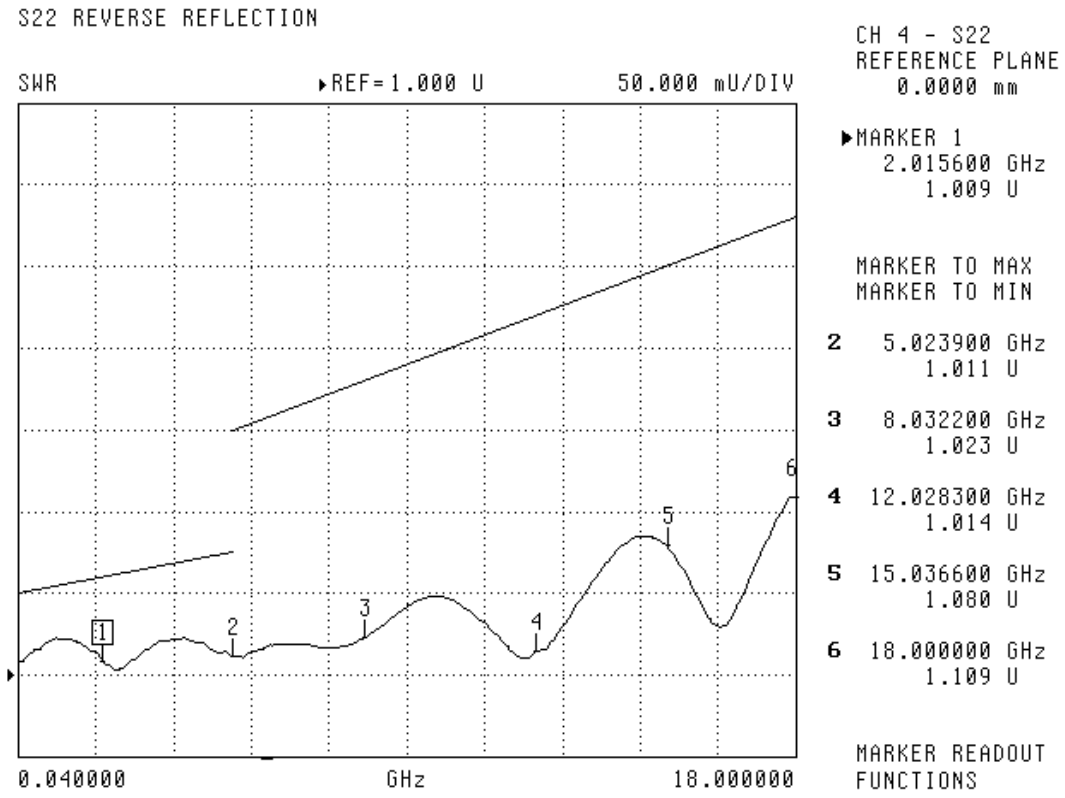
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006



Sample 111

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM

Averaging : 1 PT

Smoothing : 2.00%

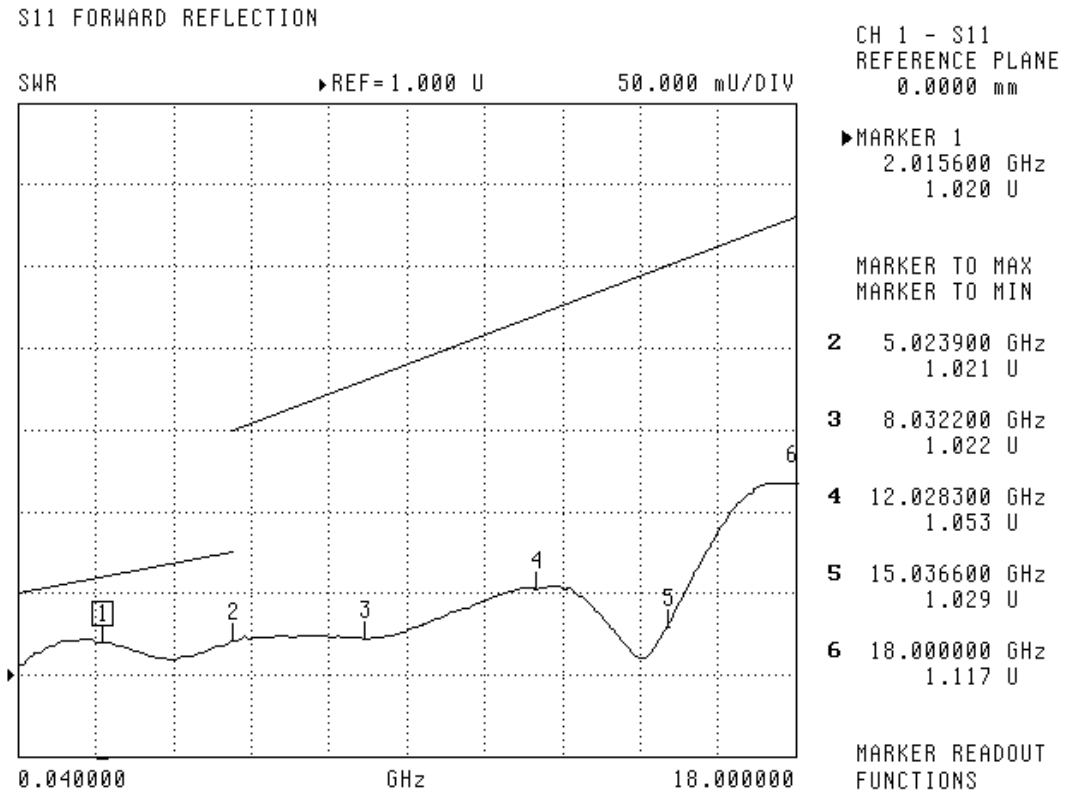
Reference plane : 0mm

IF Bandwidth : 1KHz

Normalization : OFF

Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

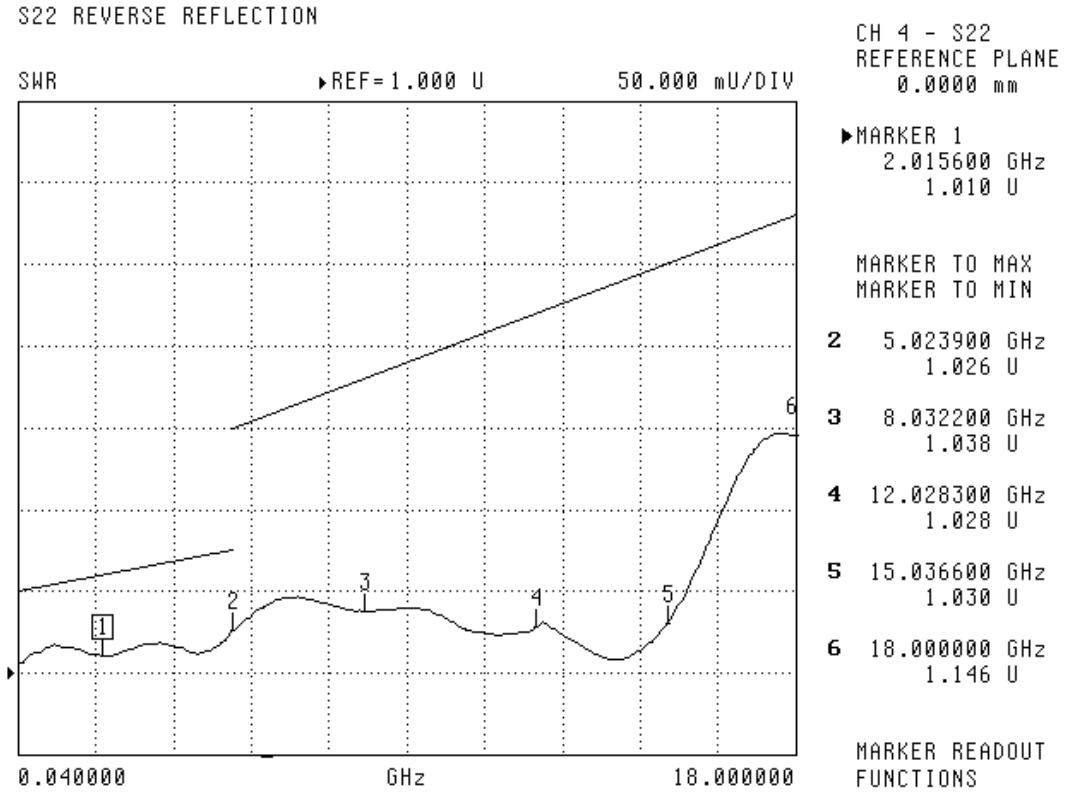


Sample 112

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

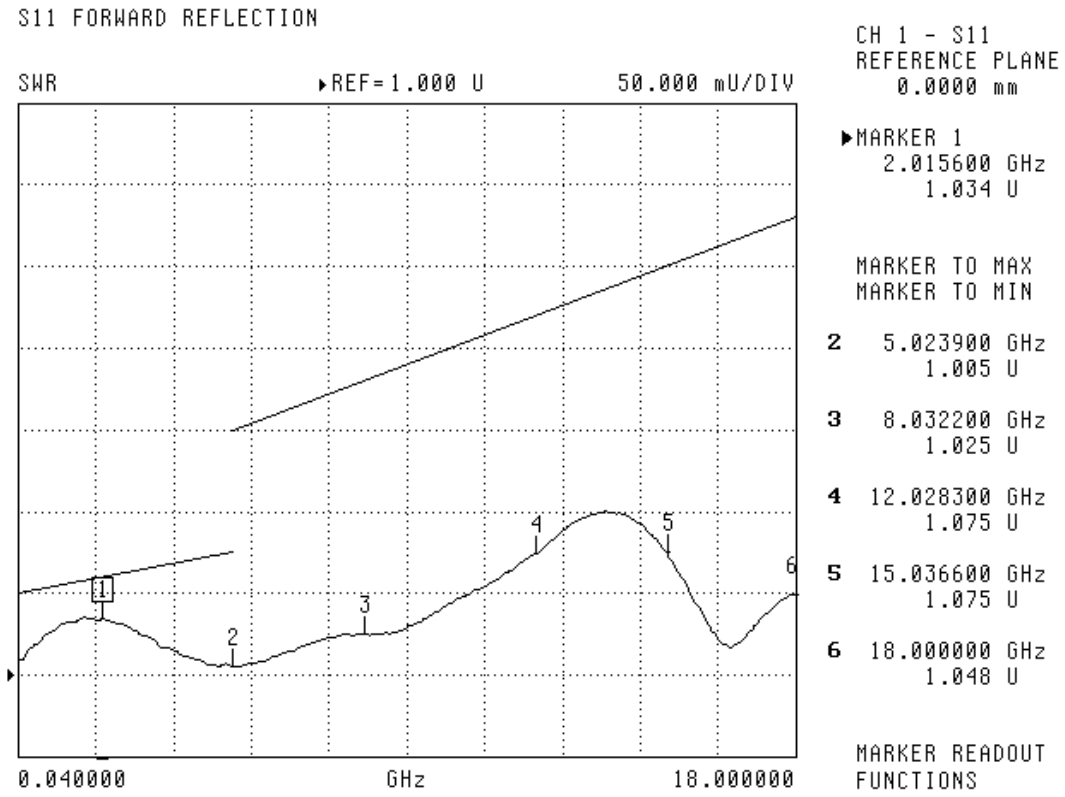


Sample 113

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

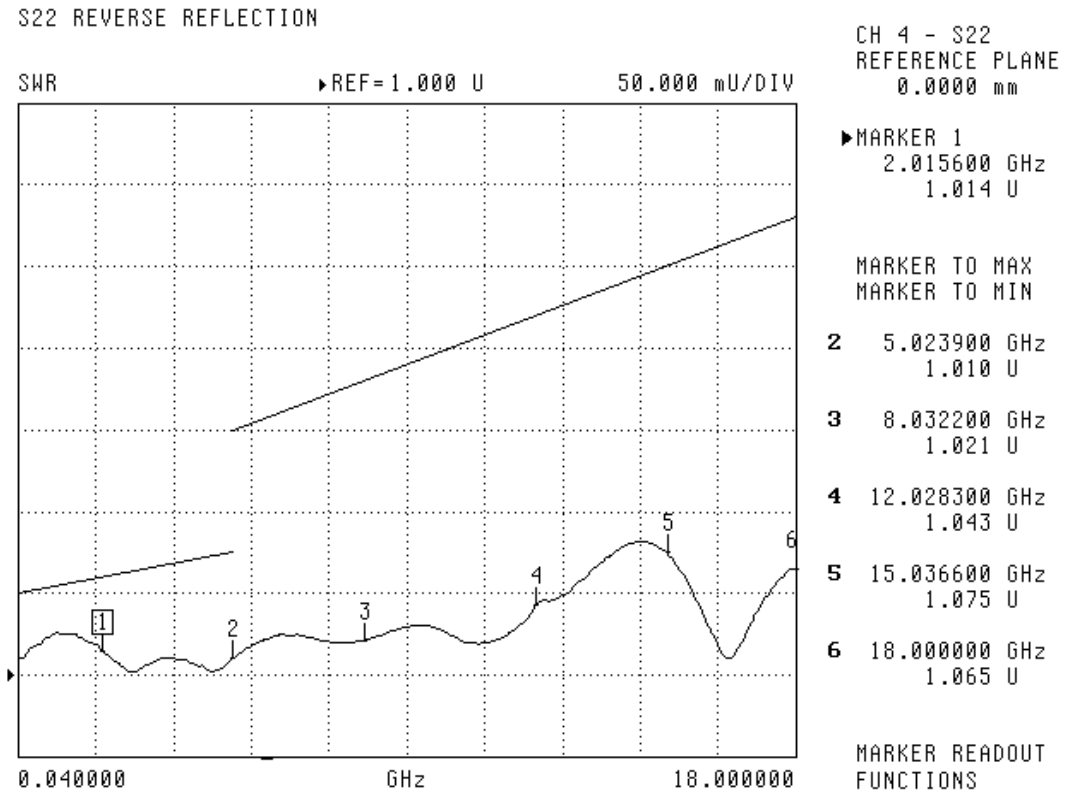


Sample 114

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

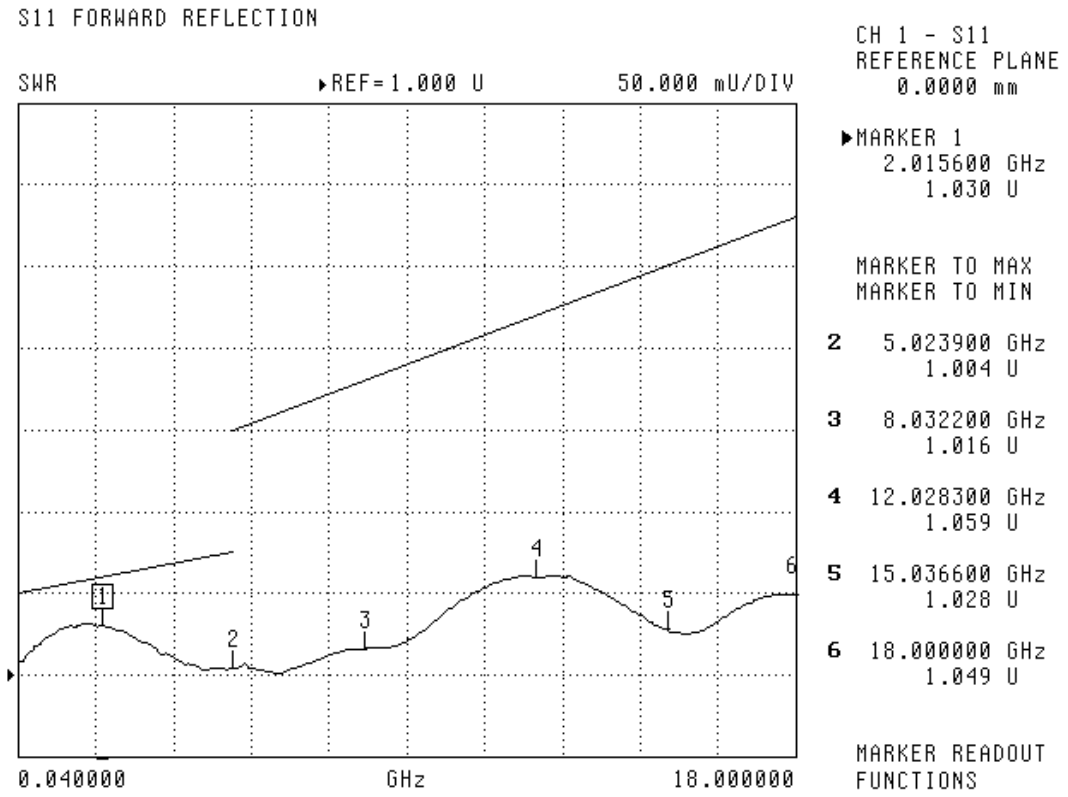


Sample 115

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

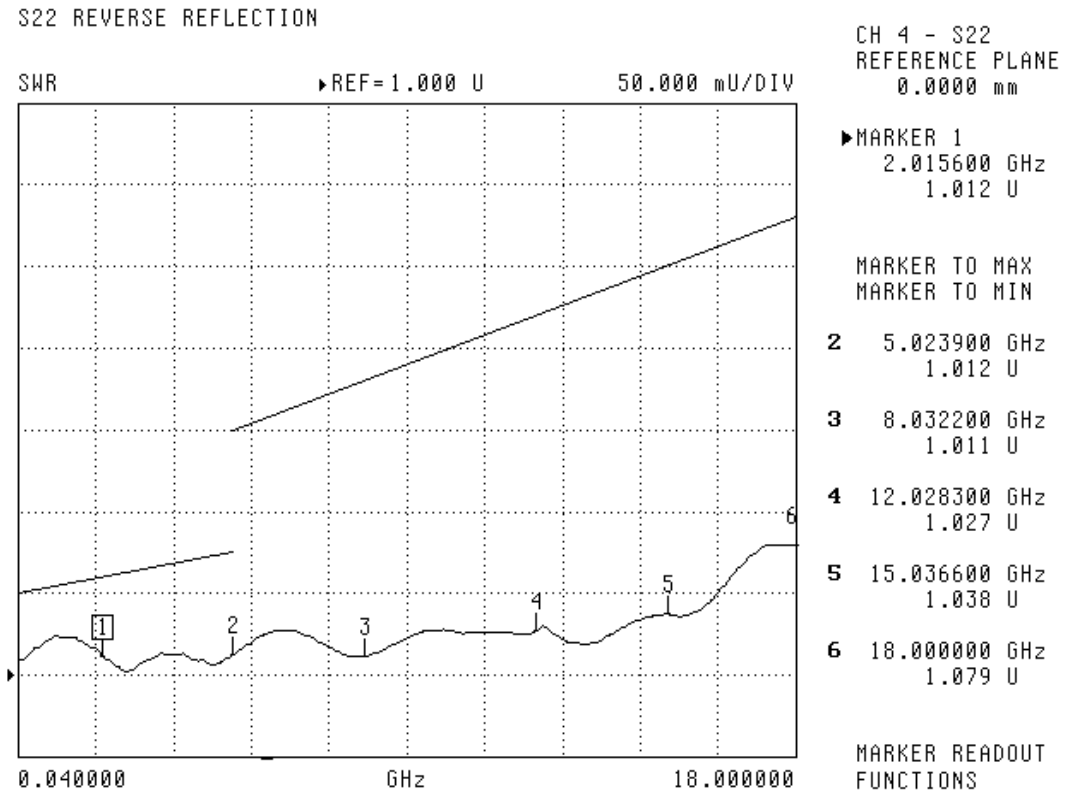


Sample 116

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

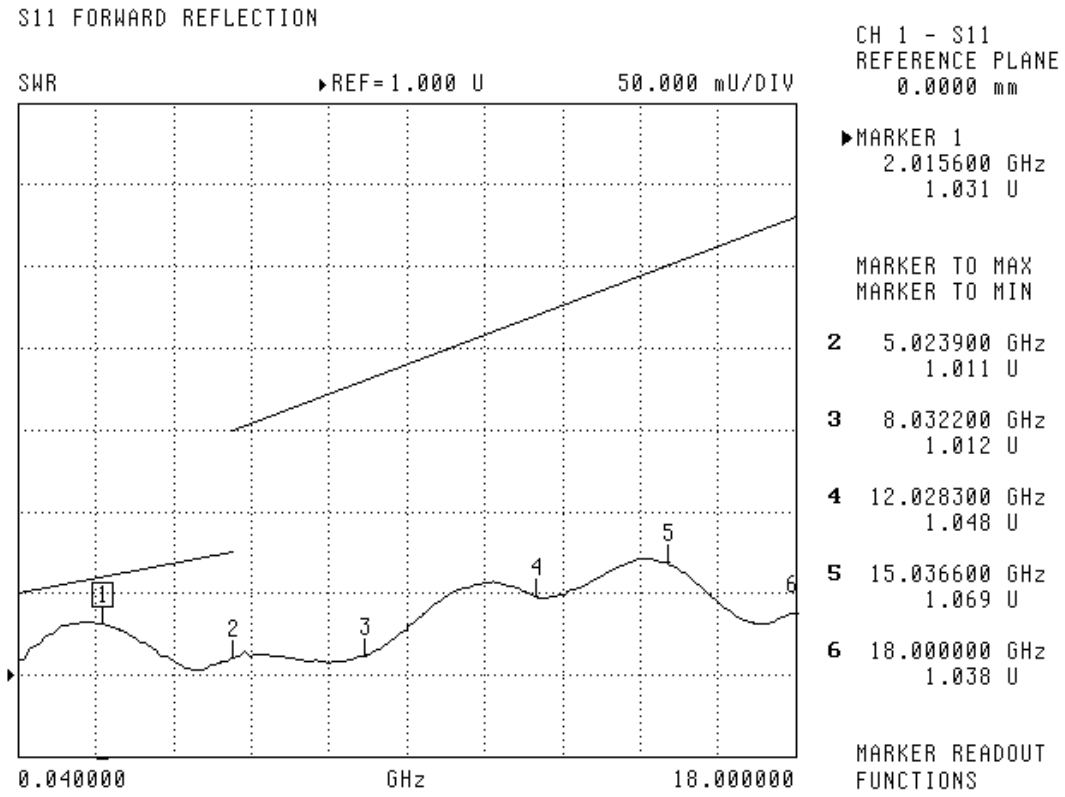


Sample 117

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

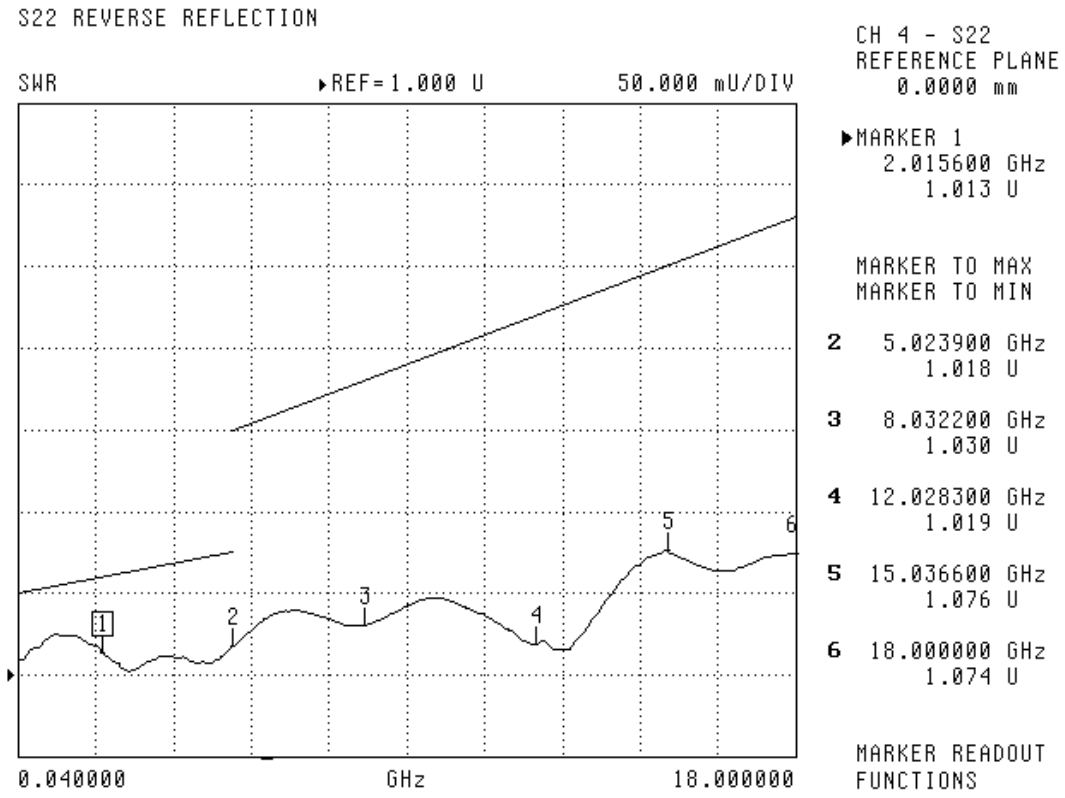


Sample 118

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At low temperature –40°C 08/02/2006

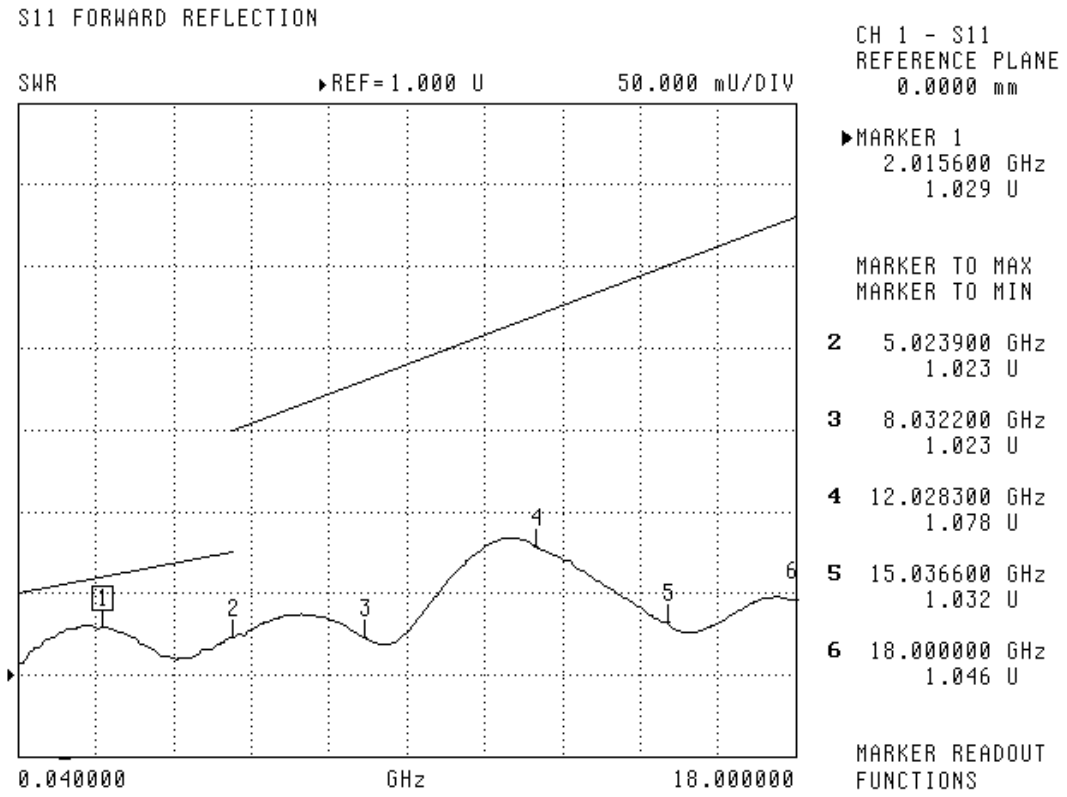


Sample 119

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

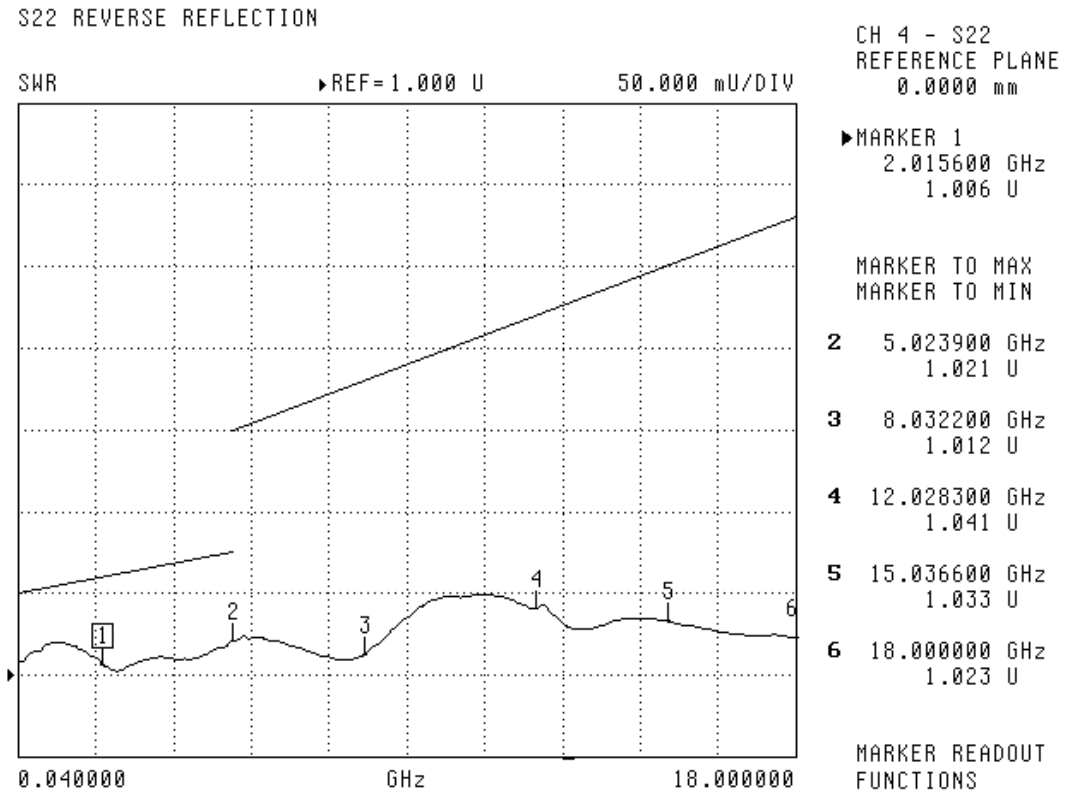


Sample 1

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

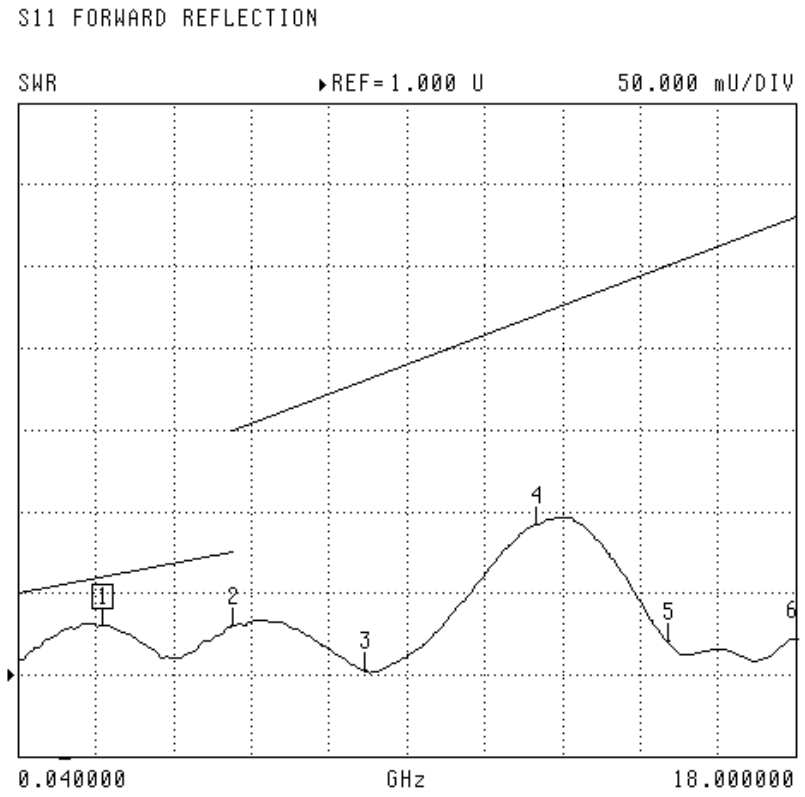


Sample 2

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

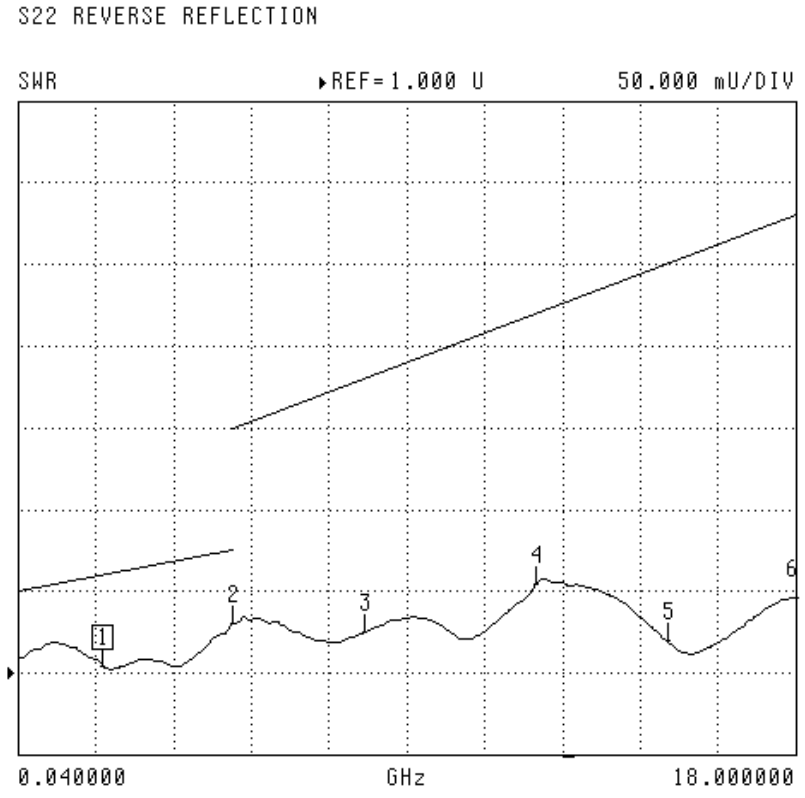


Sample 3

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

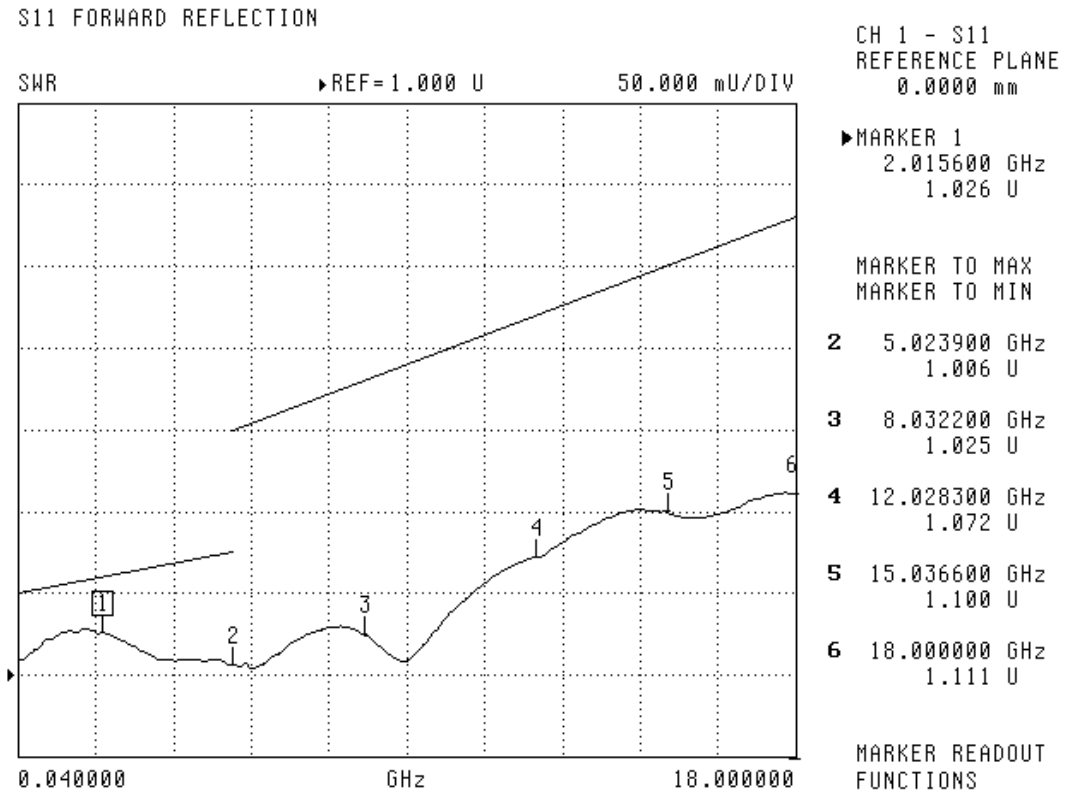


Sample 4

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

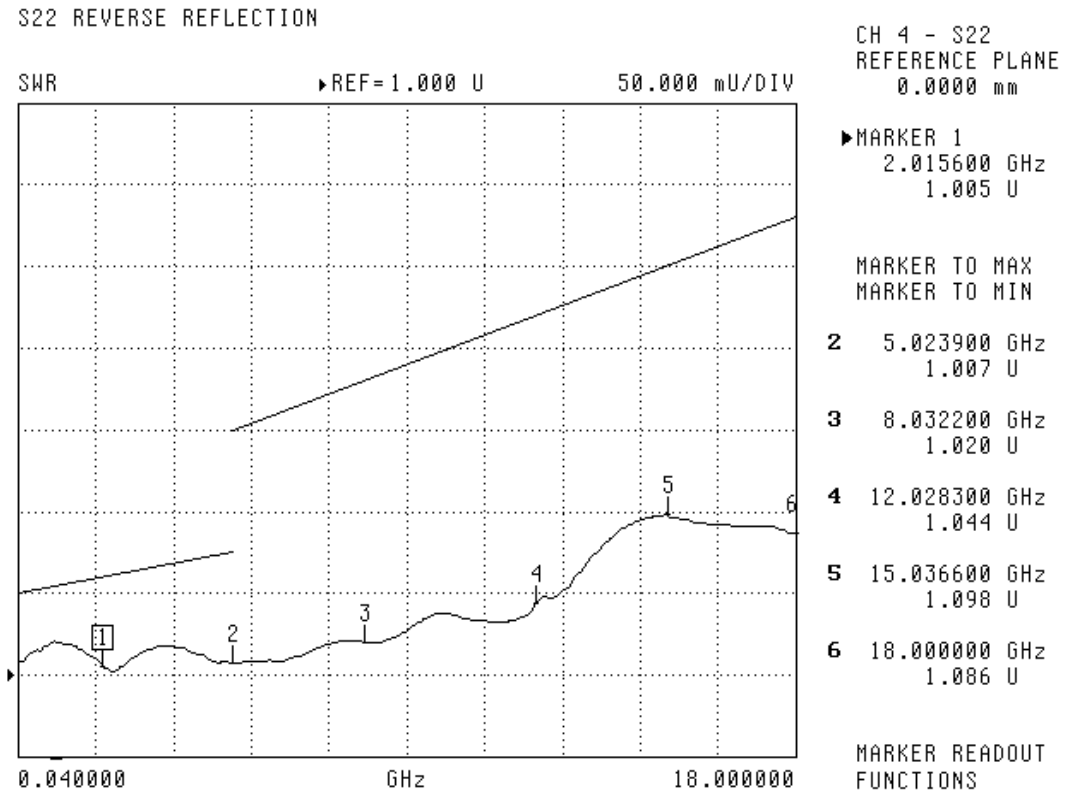


Sample 5

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

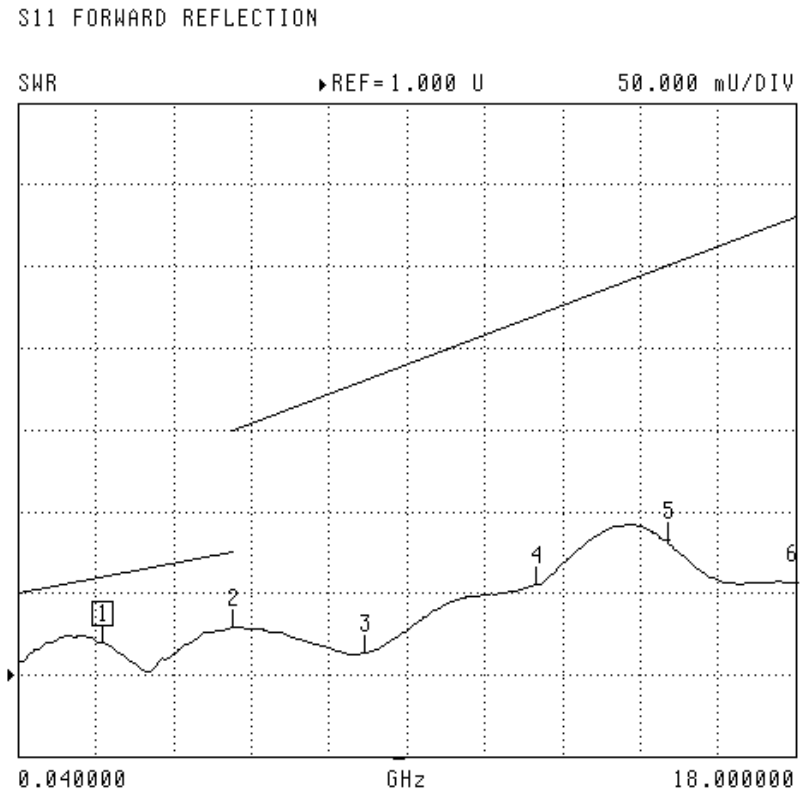


Sample 6

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

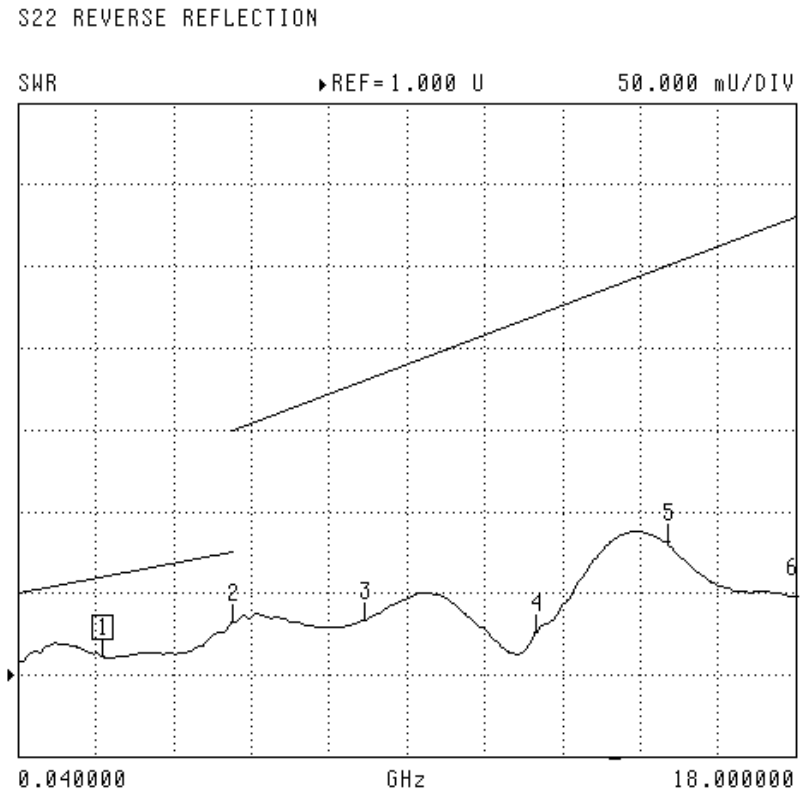


Sample 7

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

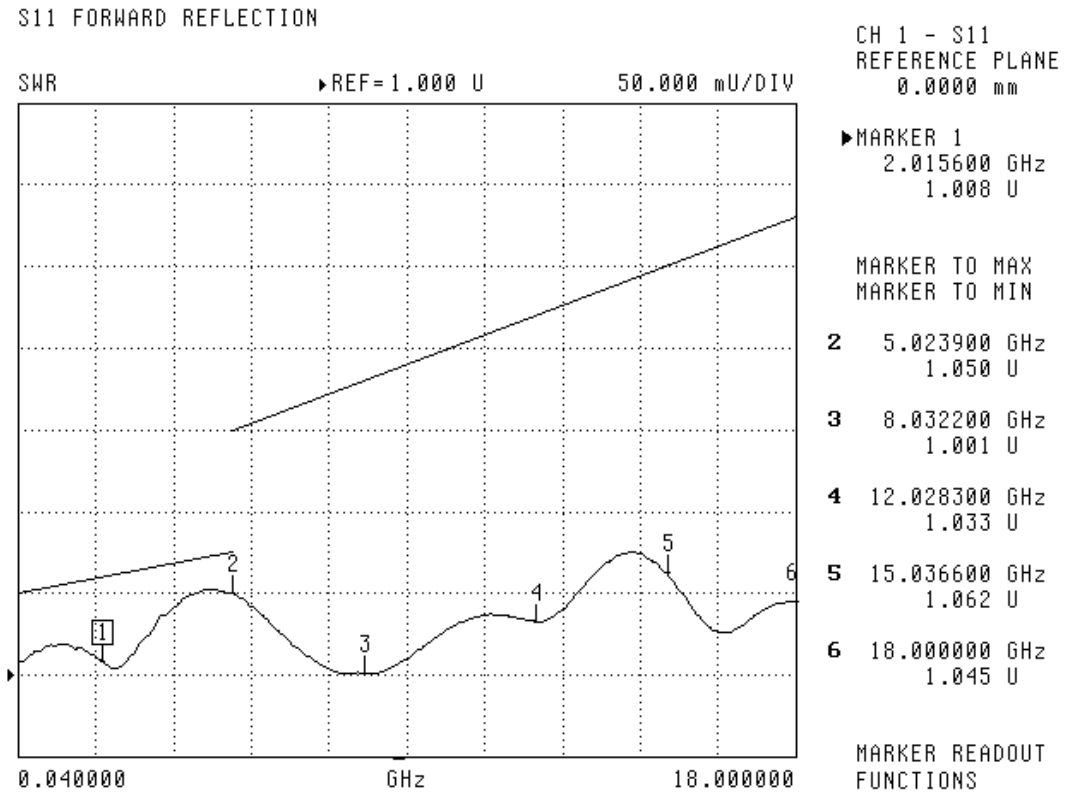


Sample 8

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

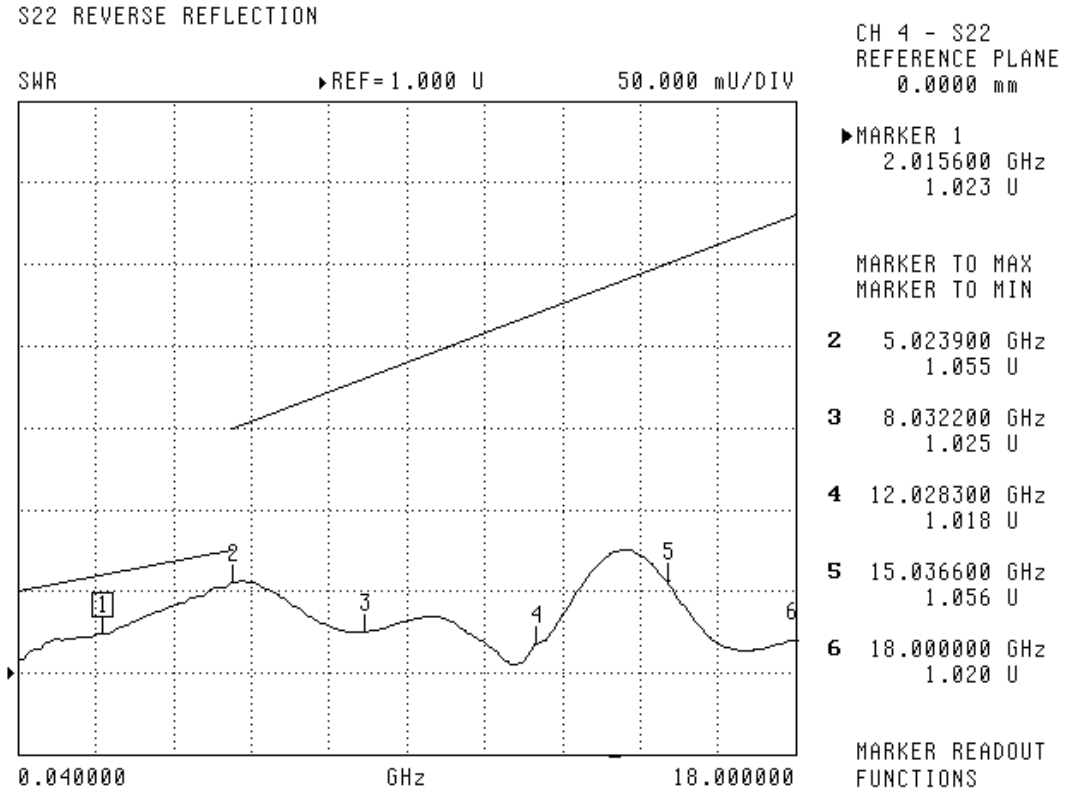


Sample 9

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

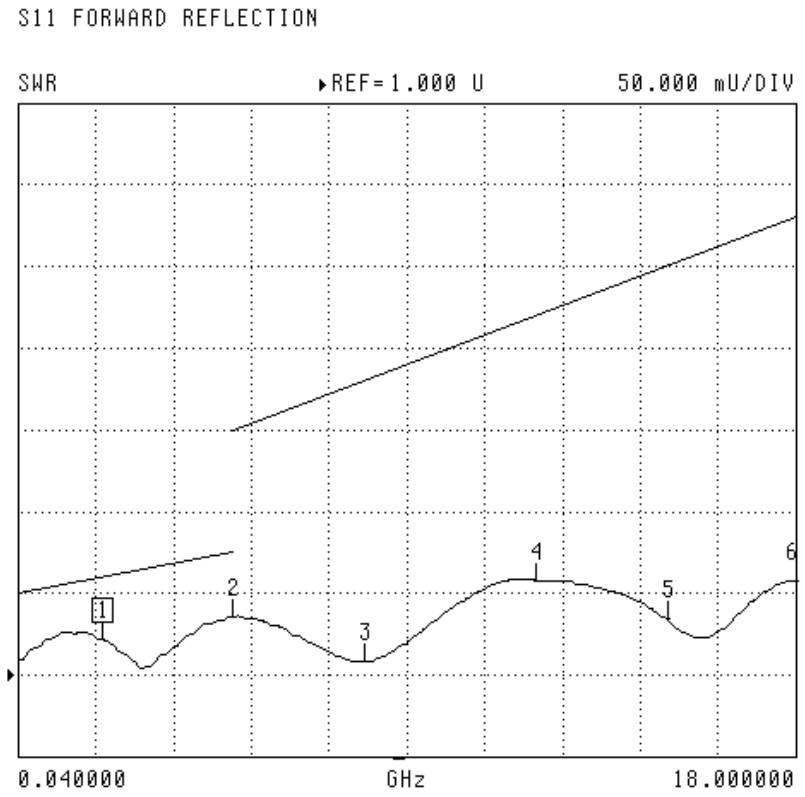


Sample 10

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

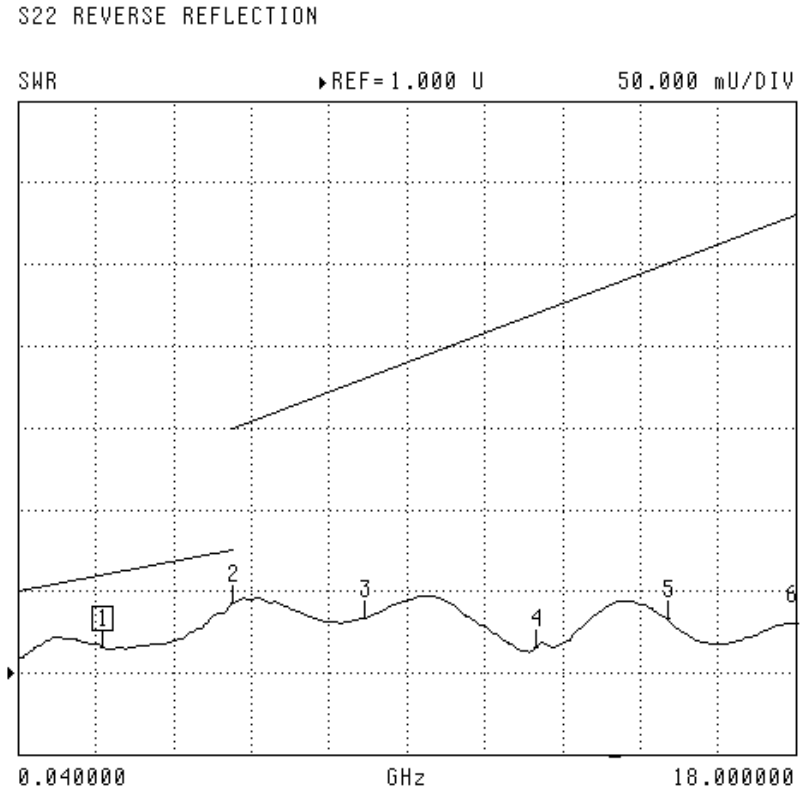


Sample 11

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

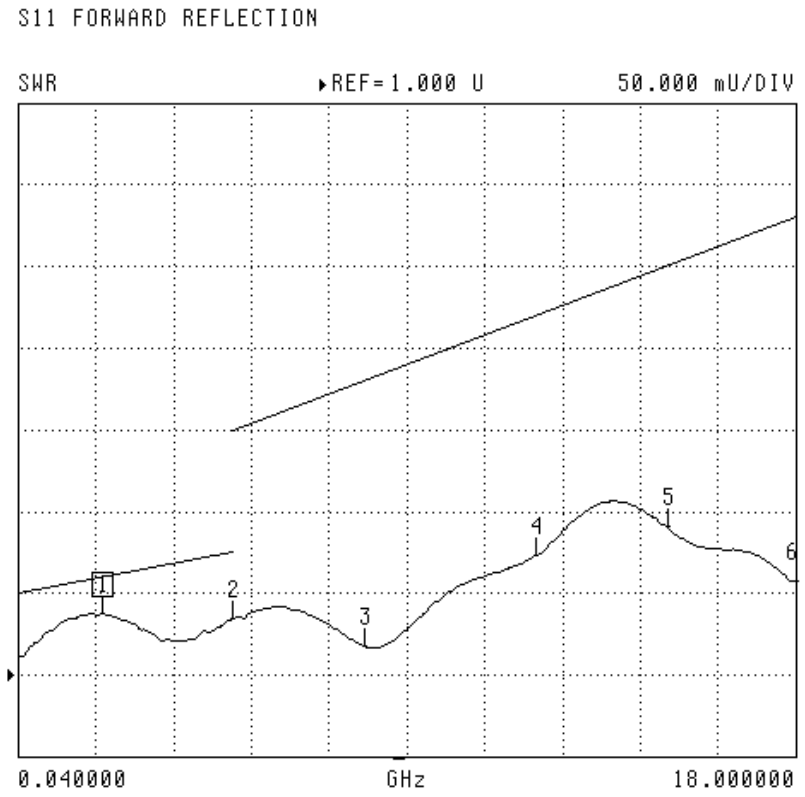


Sample 12

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

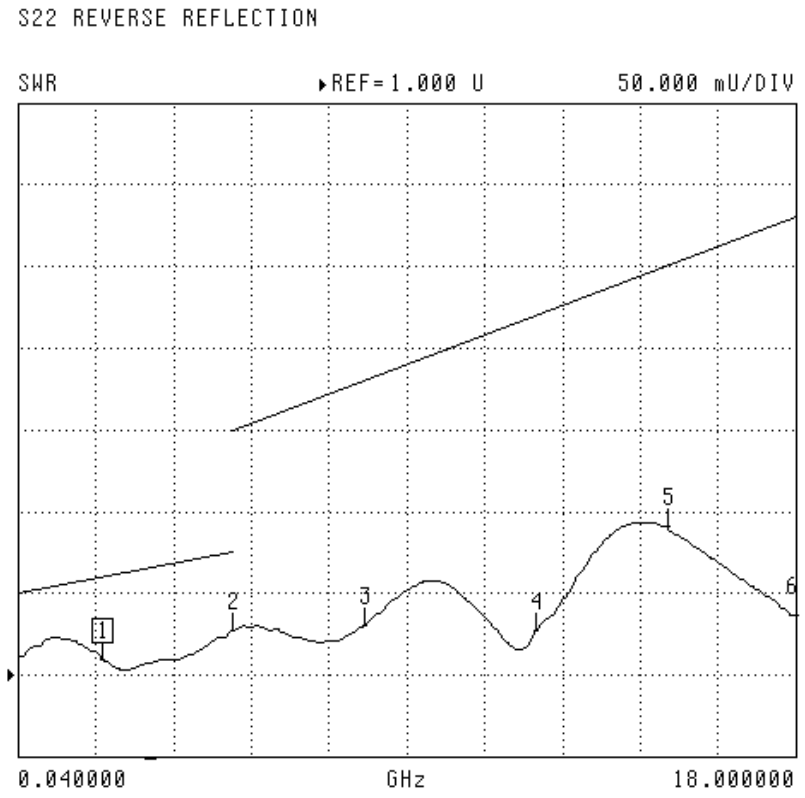


Sample 13

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

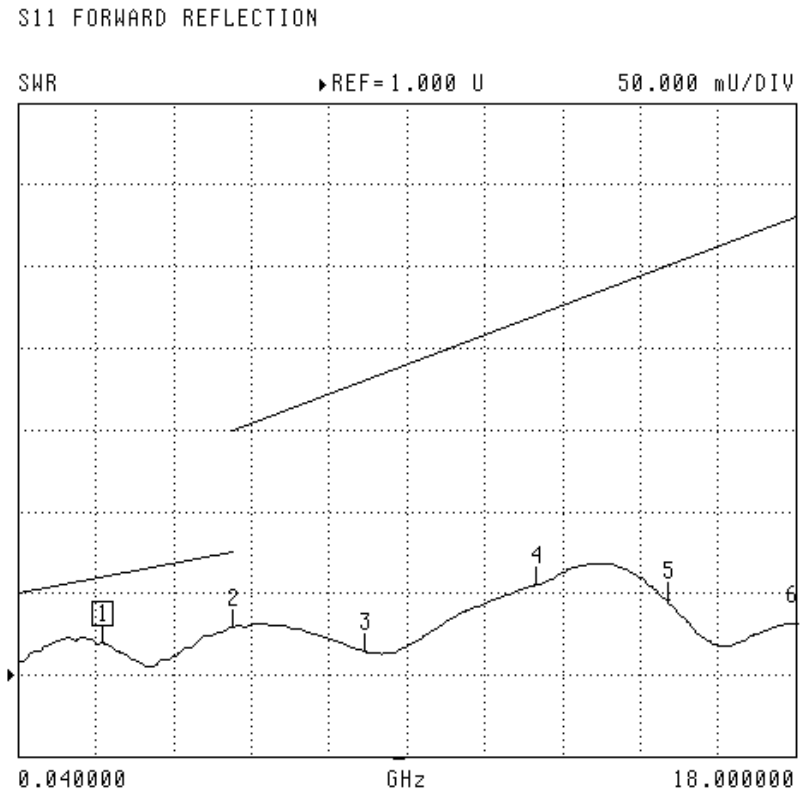


Sample 14

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

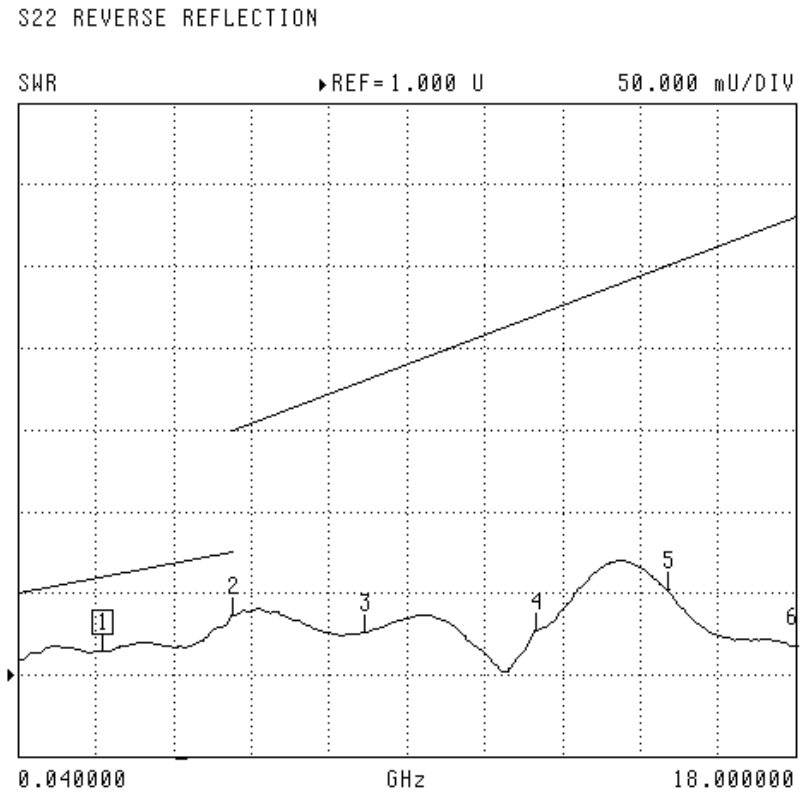


Sample 15

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

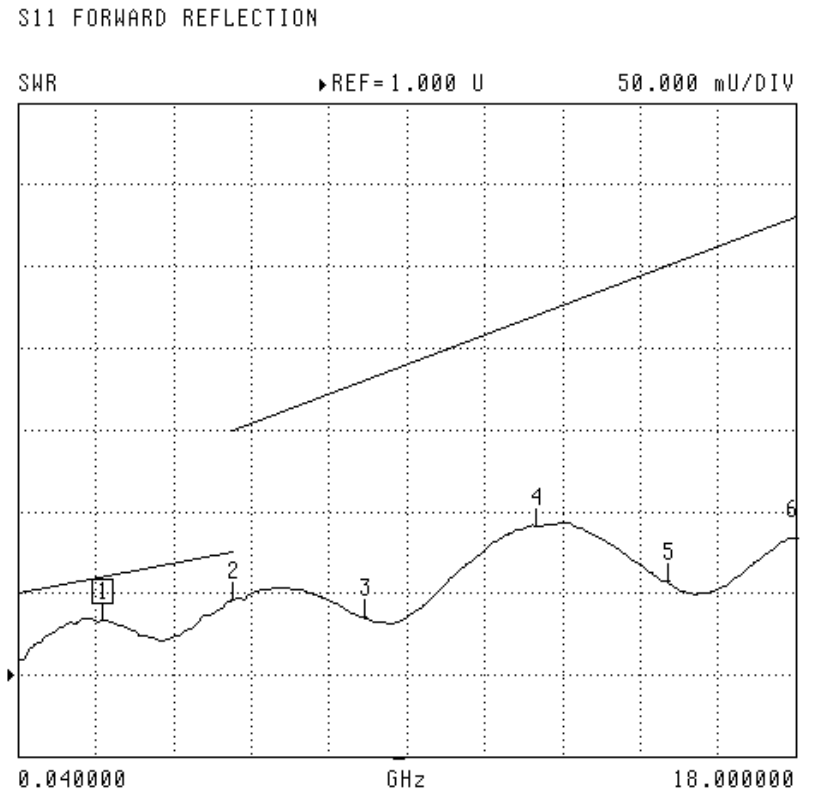


Sample 16

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

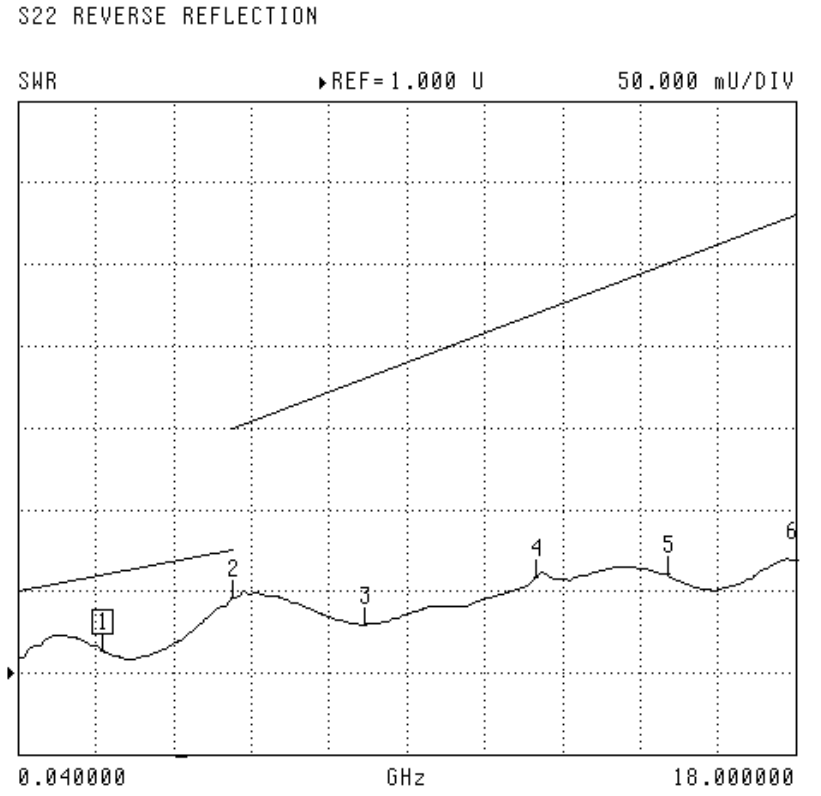


Sample 17

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

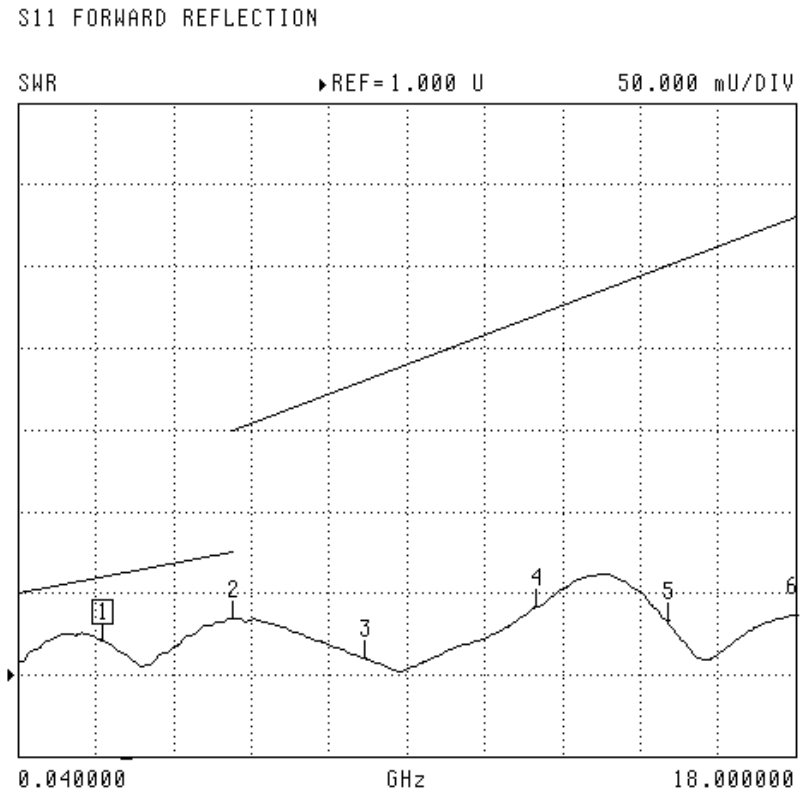


Sample 18

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

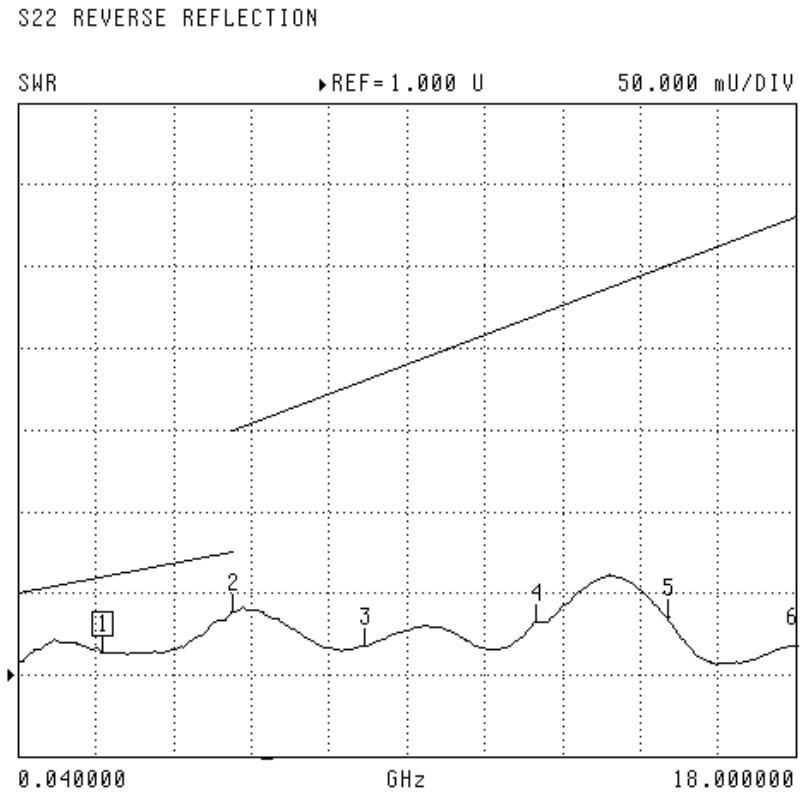


Sample 19

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

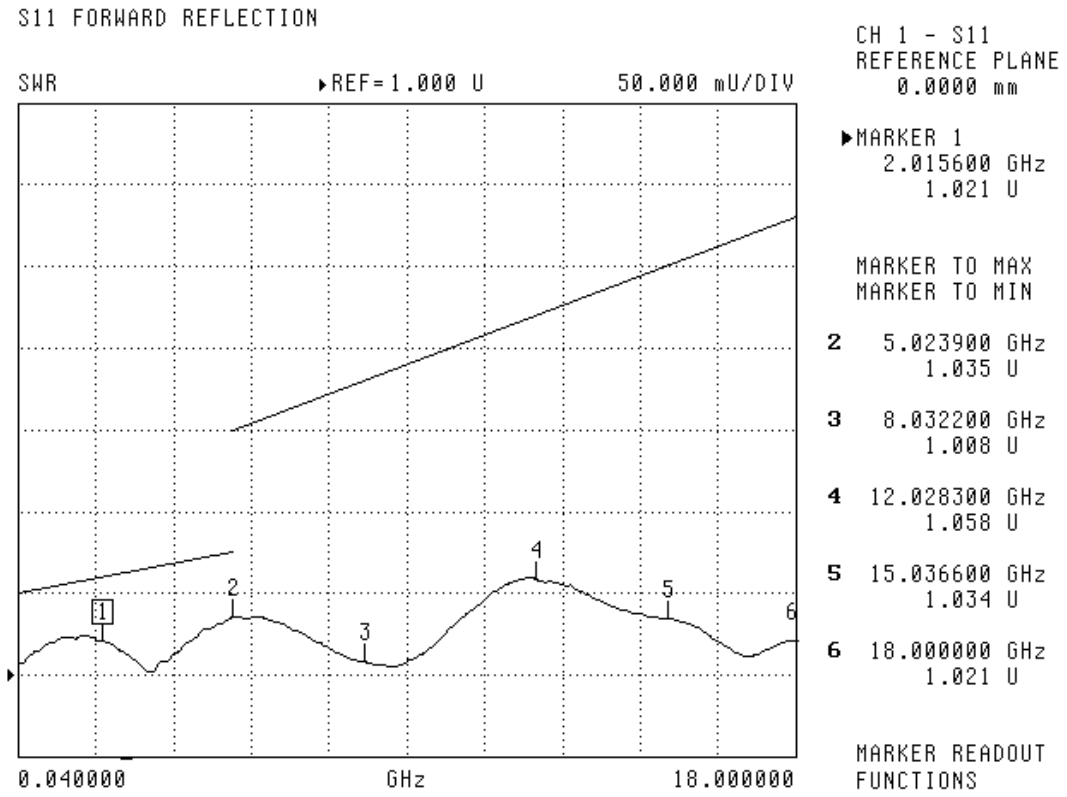


Sample 20

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

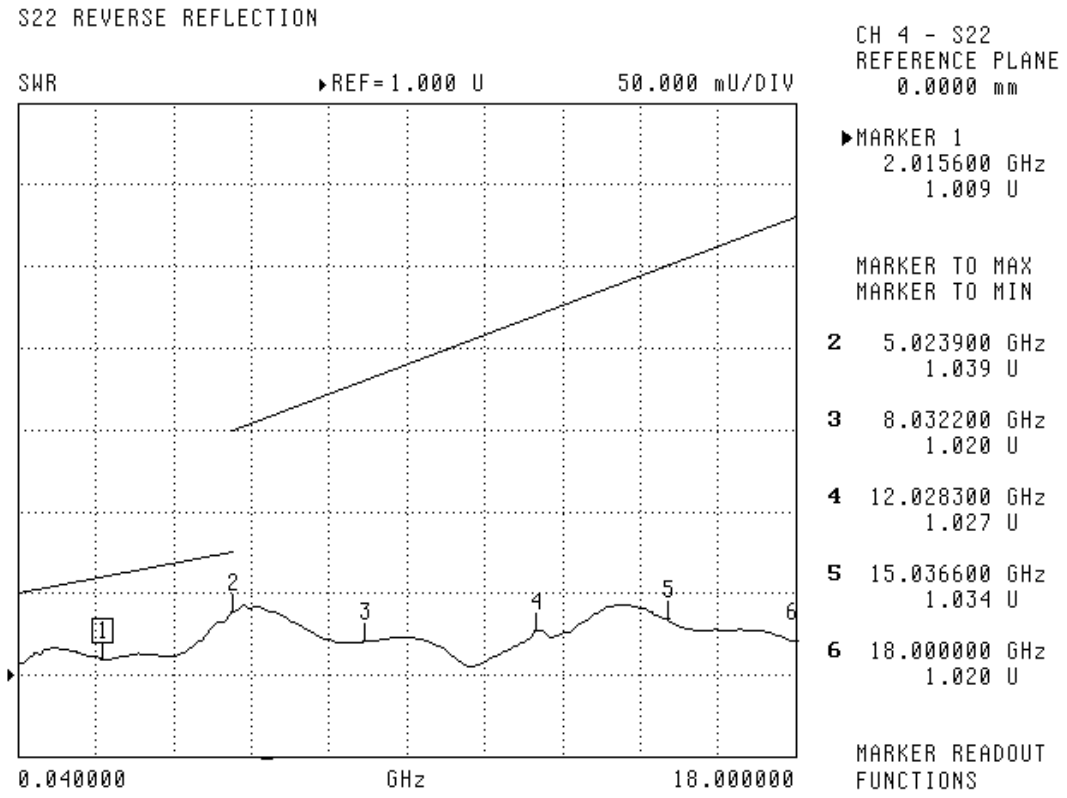


Sample 21

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

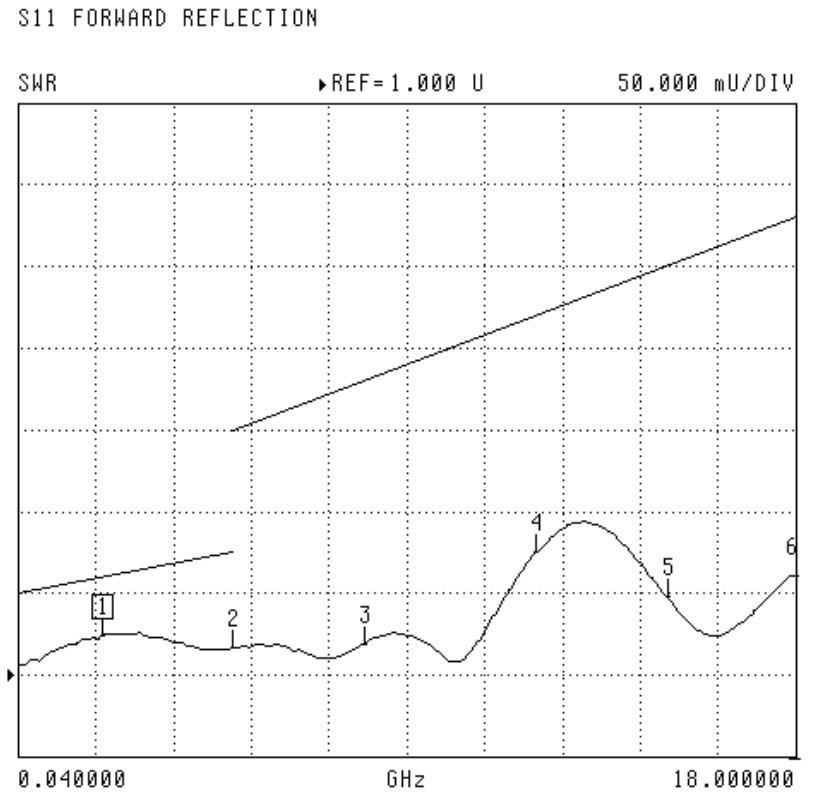


Sample 22

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

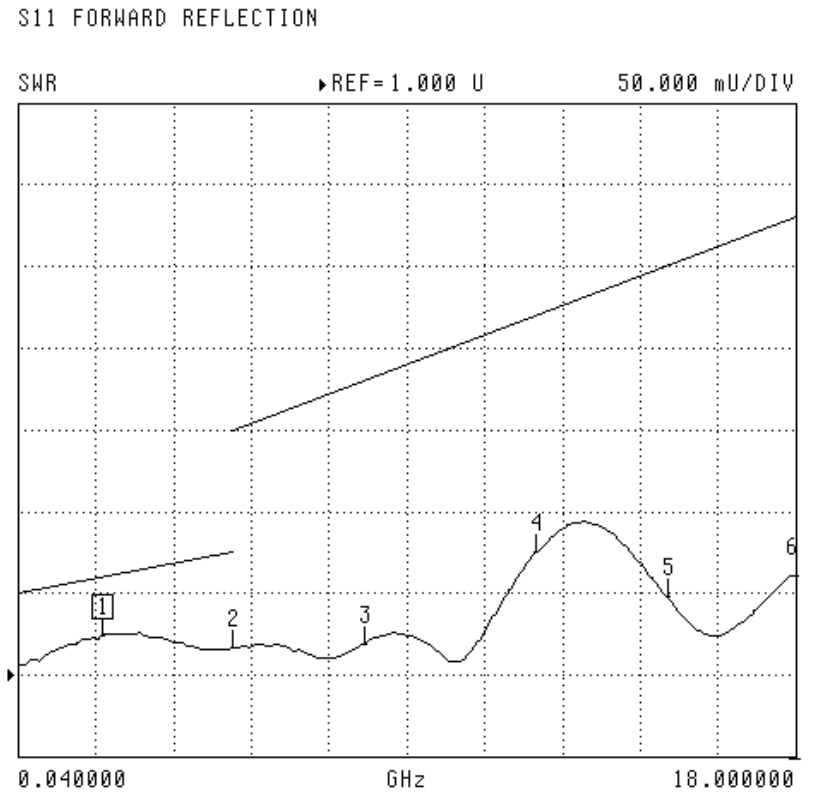


Sample 23

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

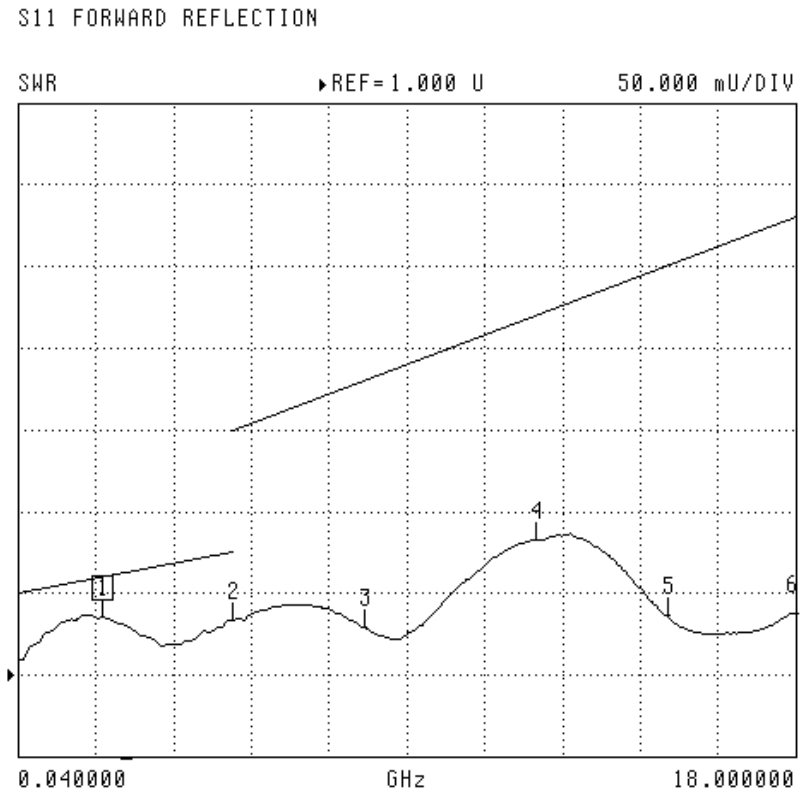


Sample 24

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

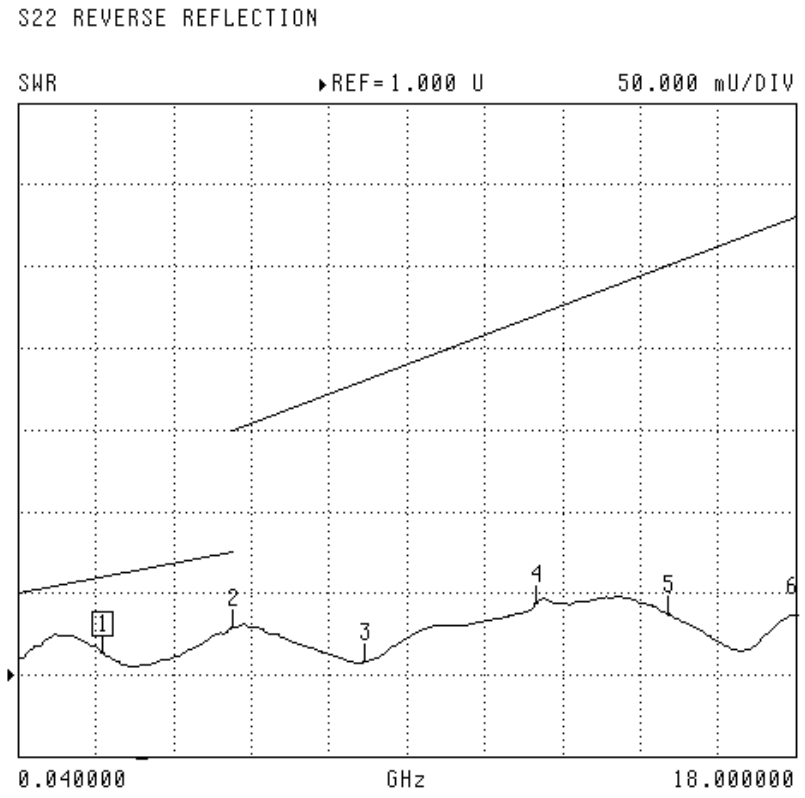


Sample 25

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

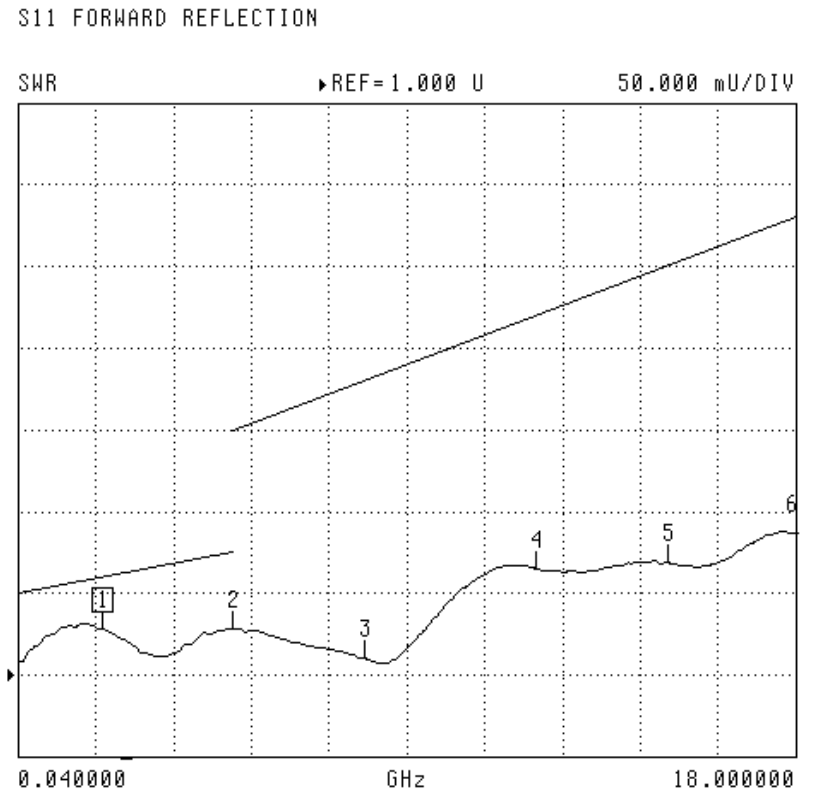


Sample 26

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

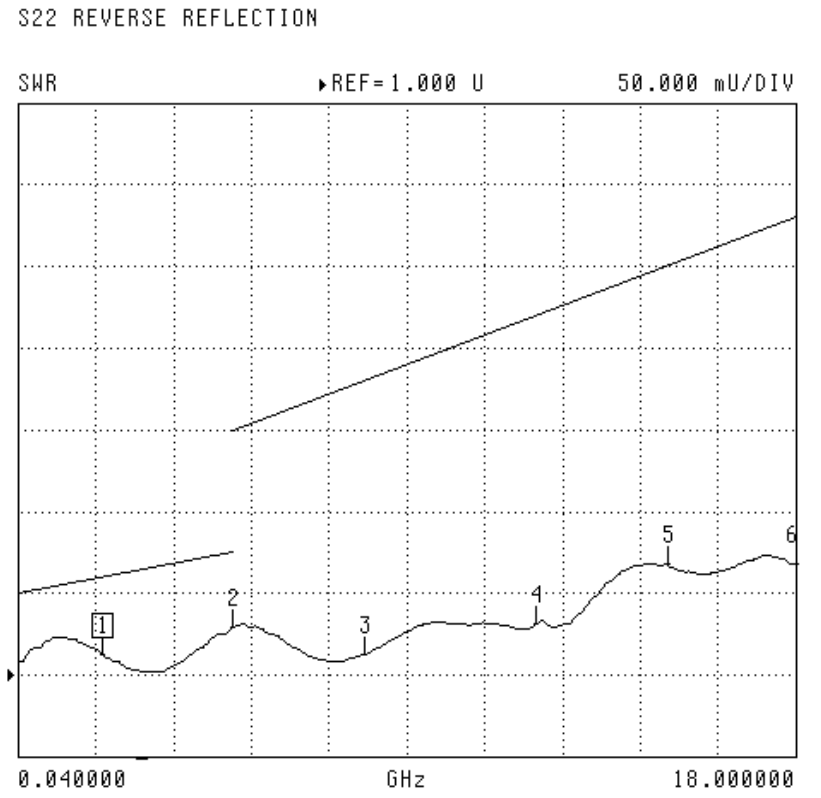


Sample 27

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

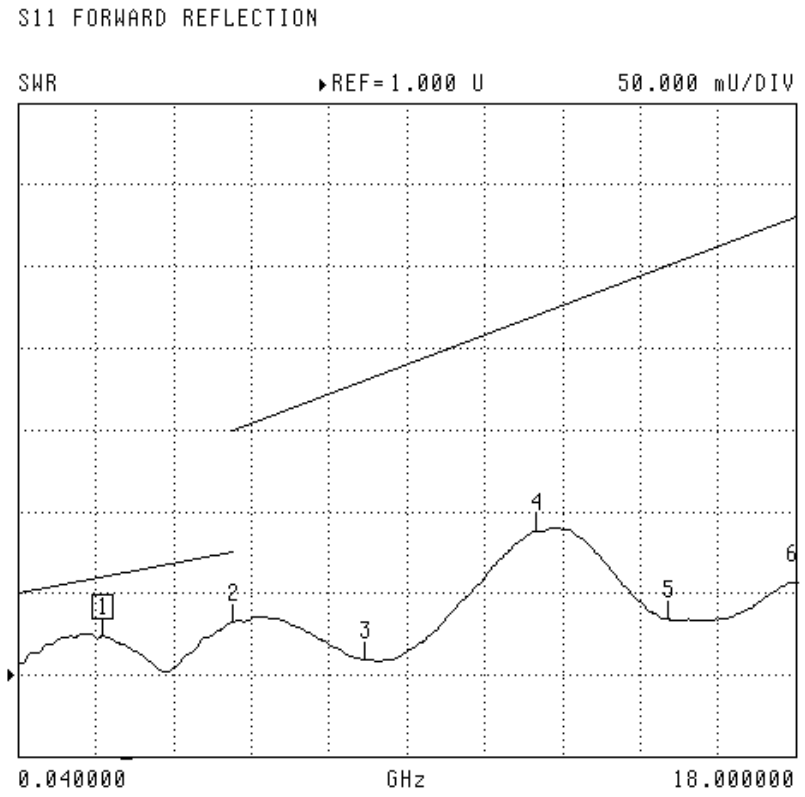


Sample 28

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

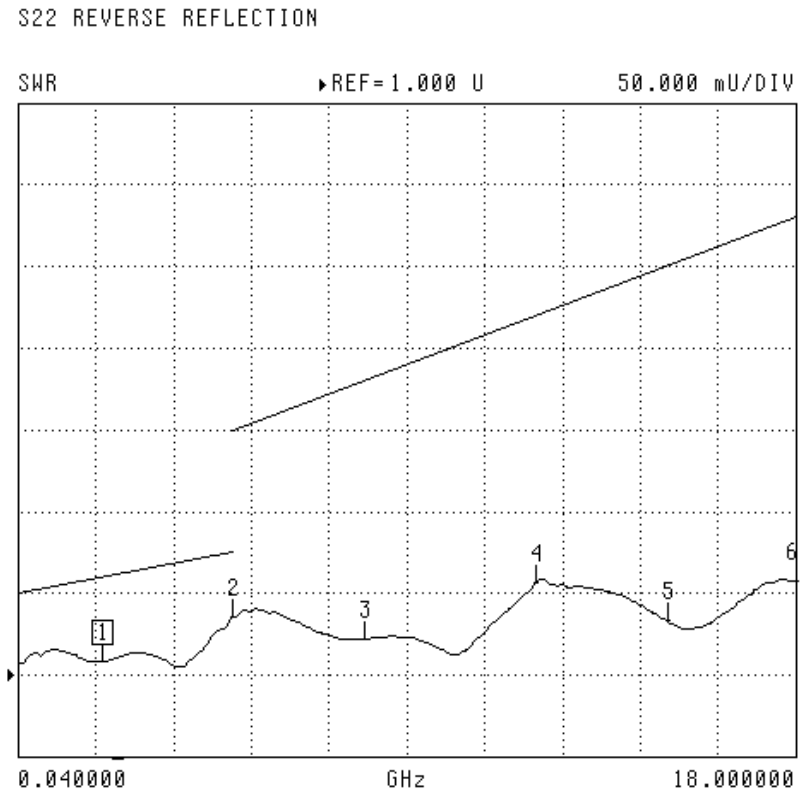


Sample 29

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

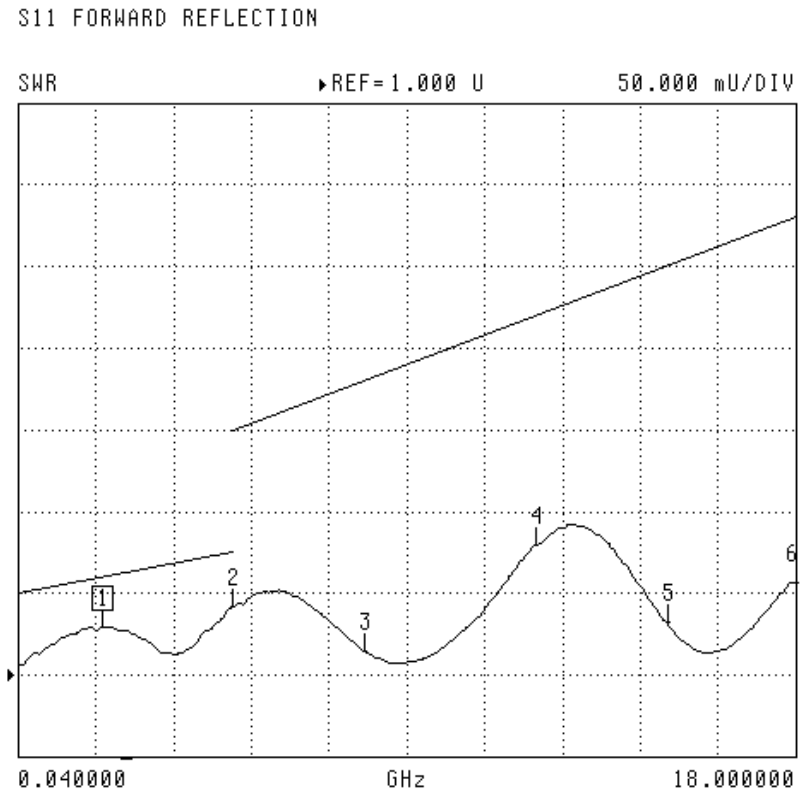


Sample 30

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

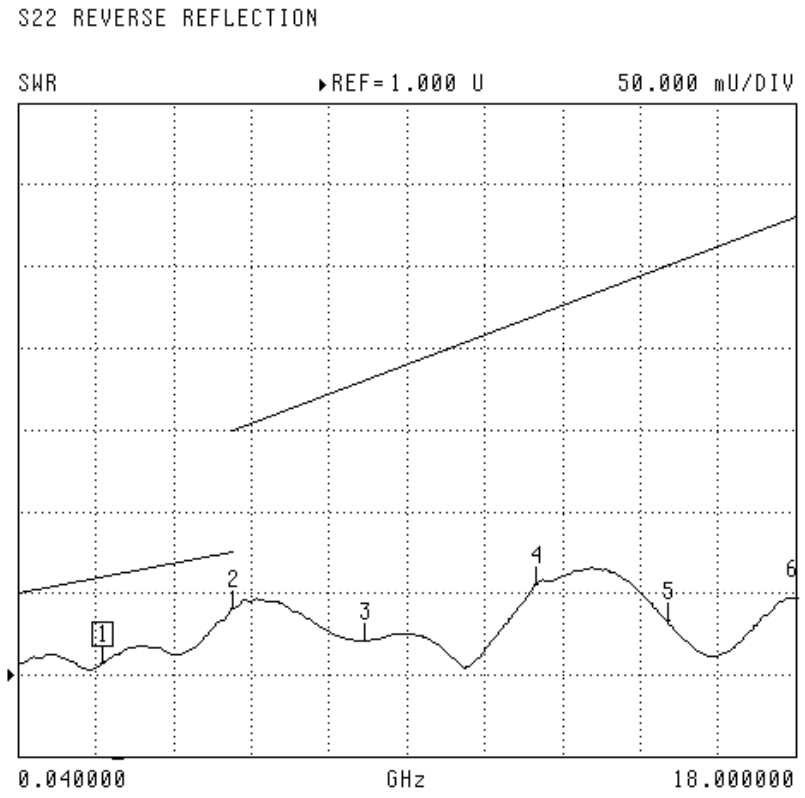


Sample 31

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

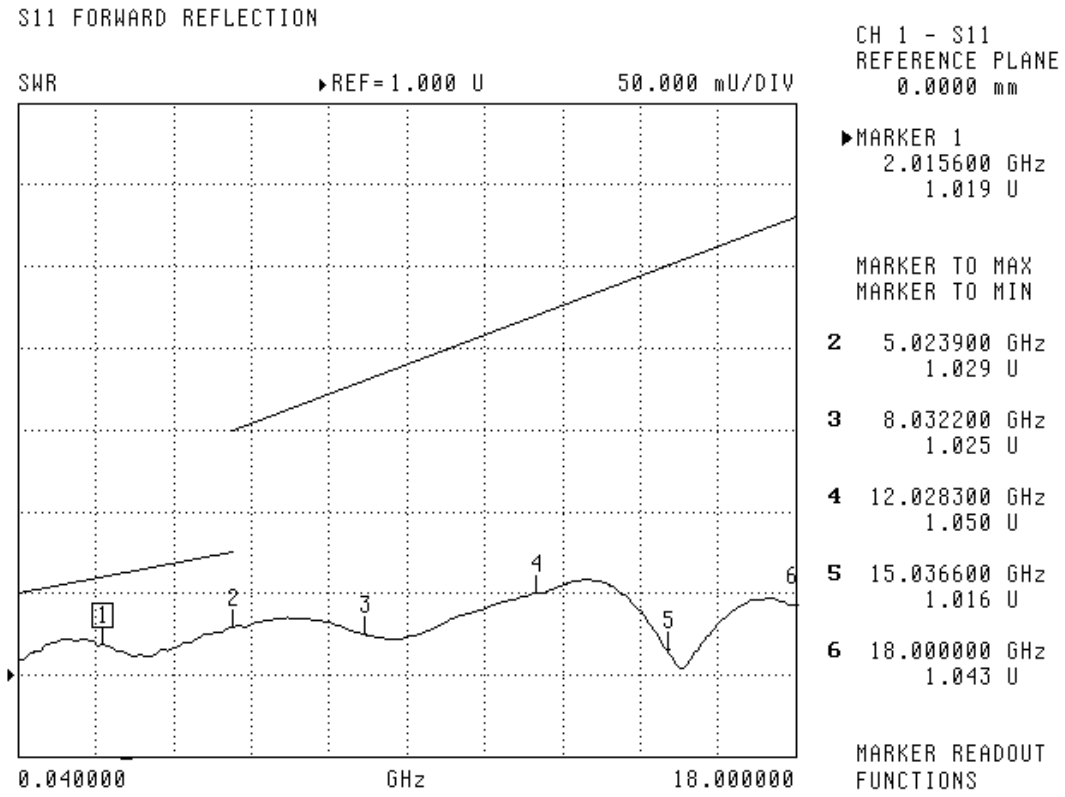


Sample 32

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

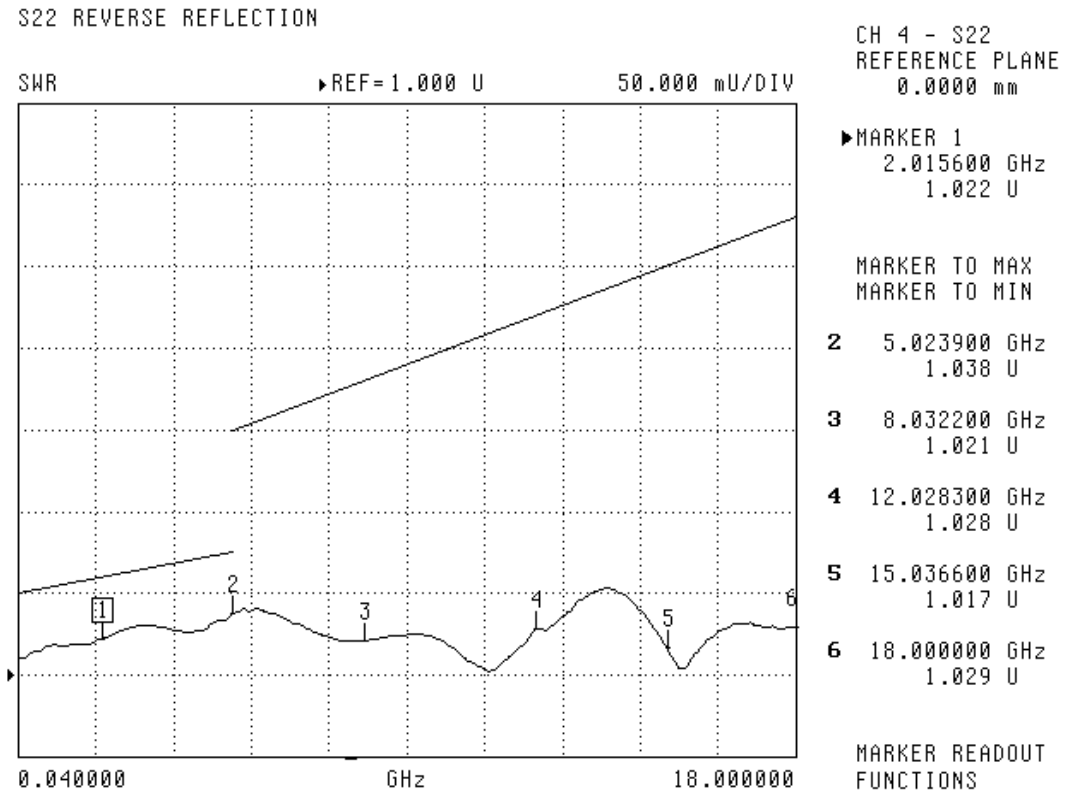


Sample 33

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

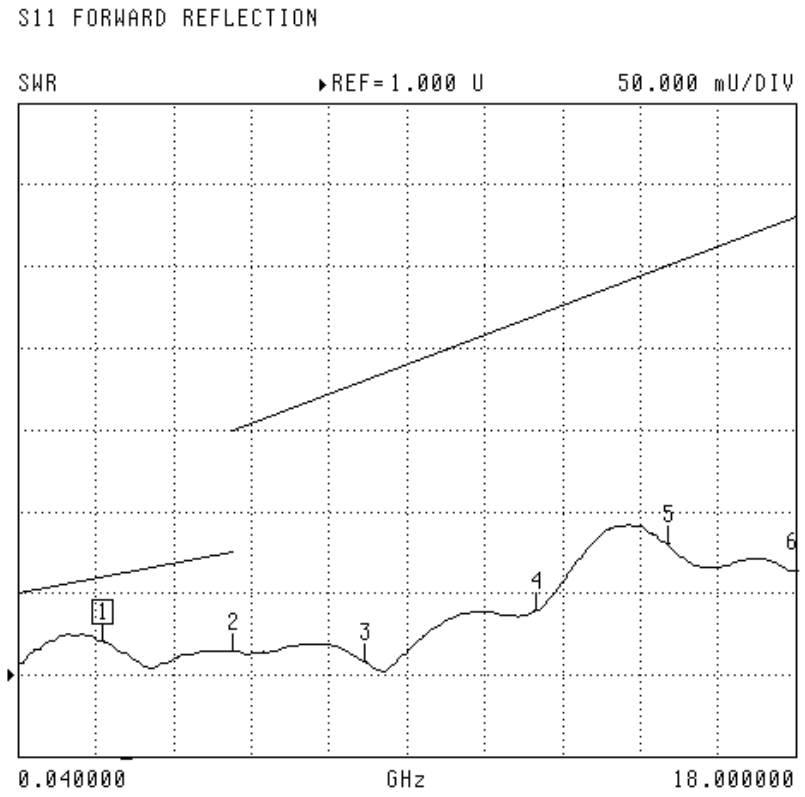


Sample 34

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

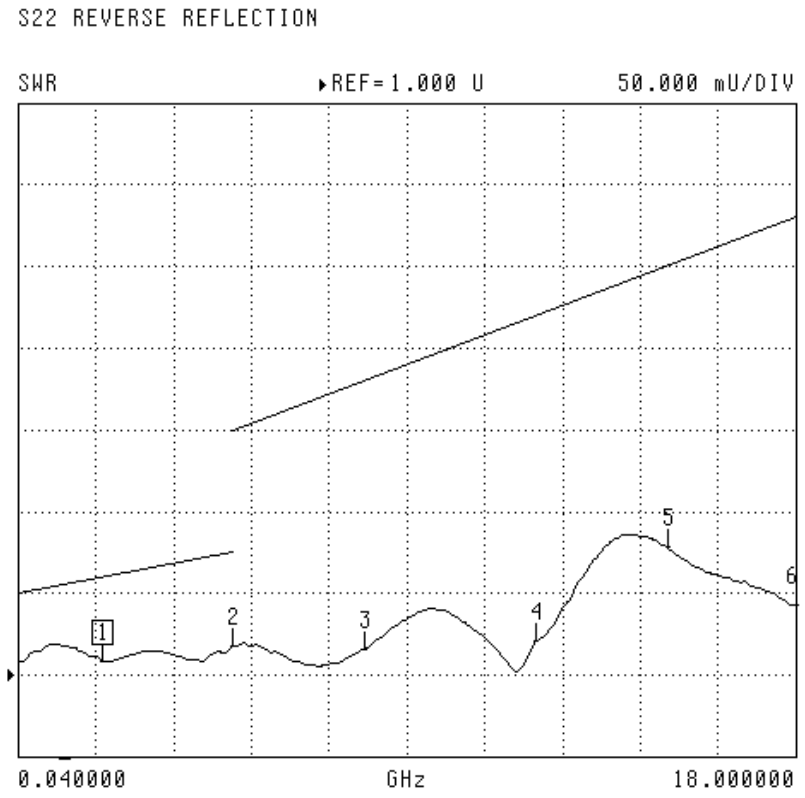


Sample 35

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

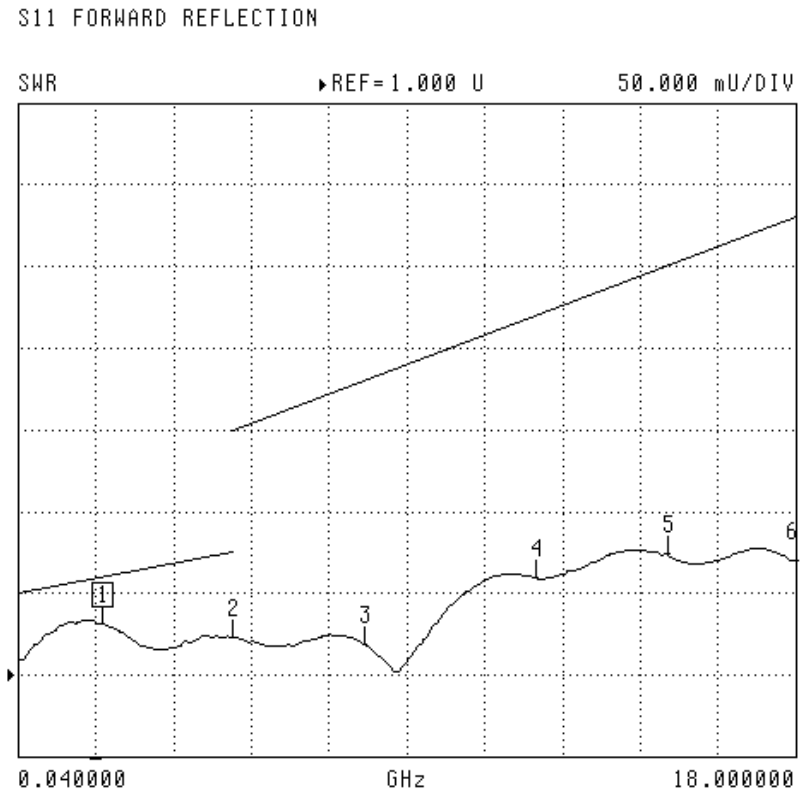


Sample 95

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

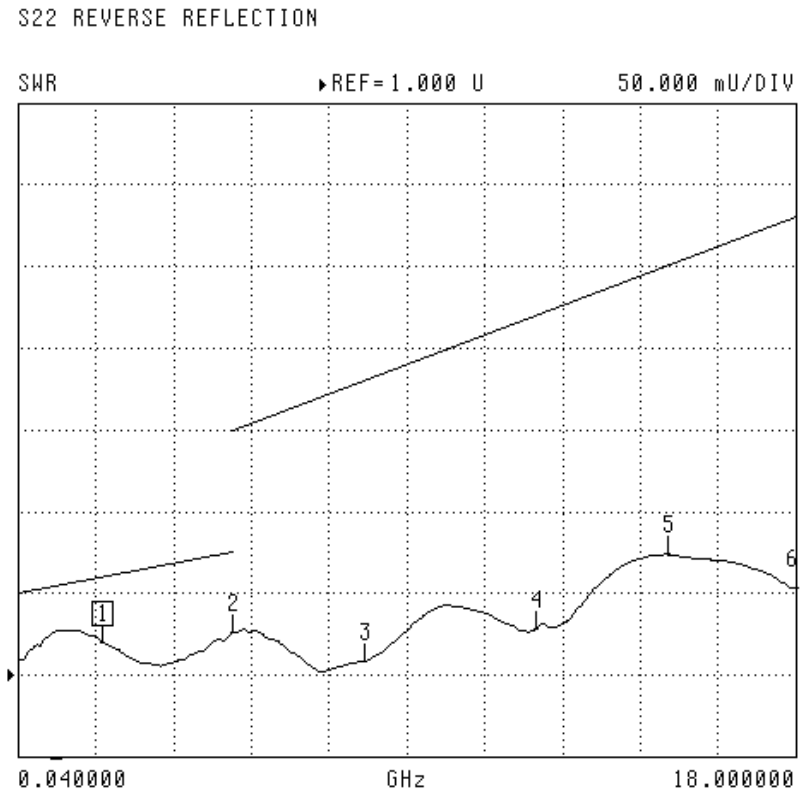


Sample 96

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

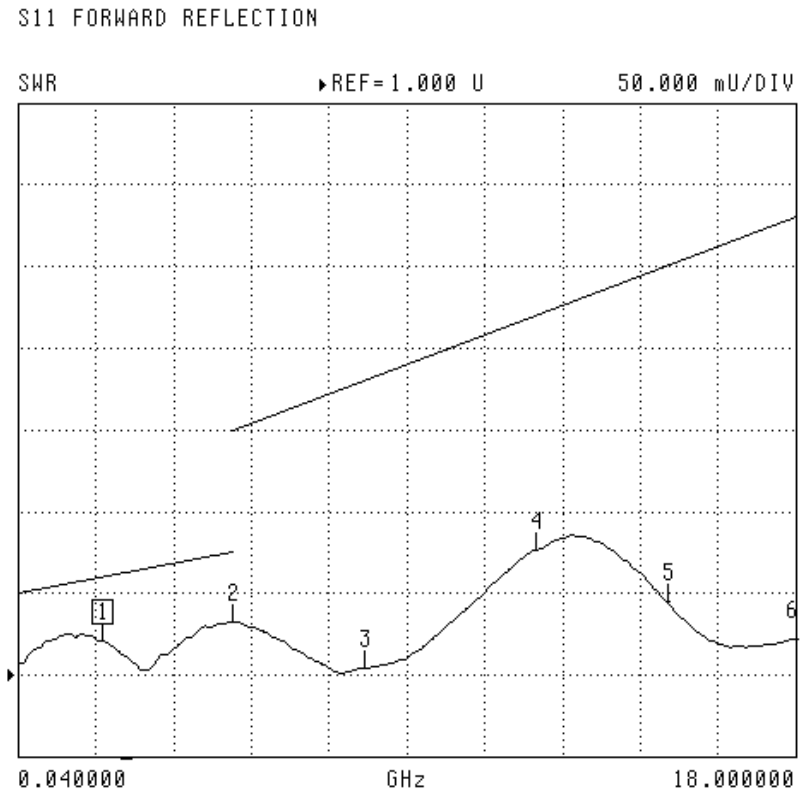


Sample 97

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

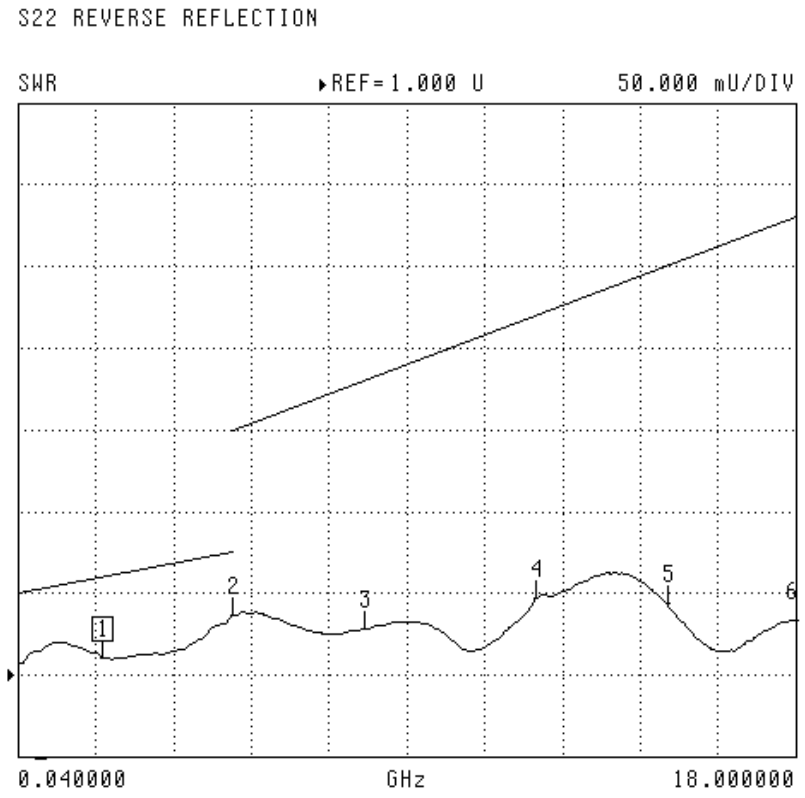


Sample 98

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

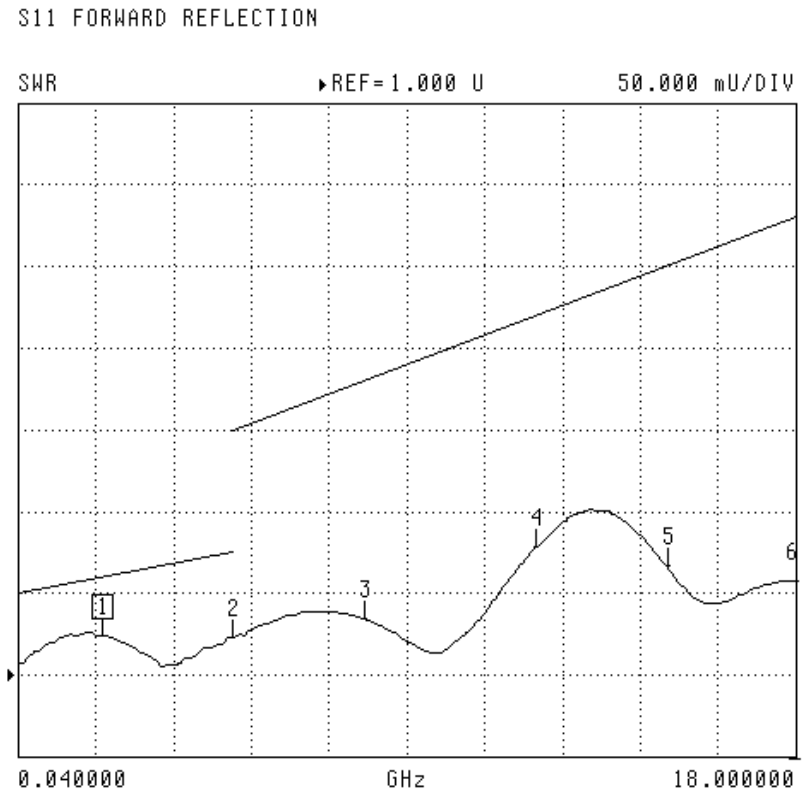


Sample 99

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

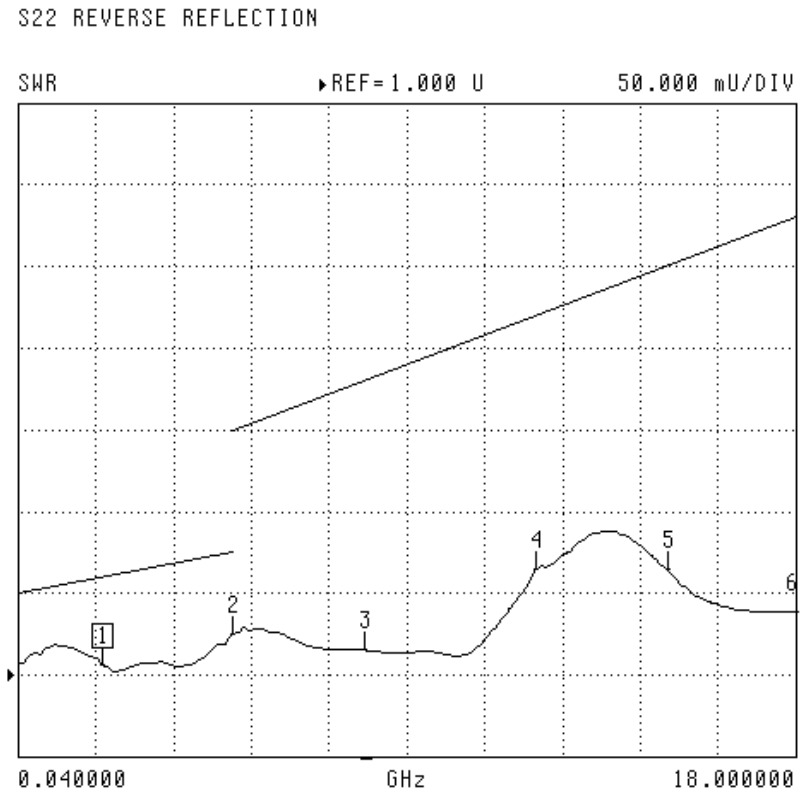


Sample 100

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

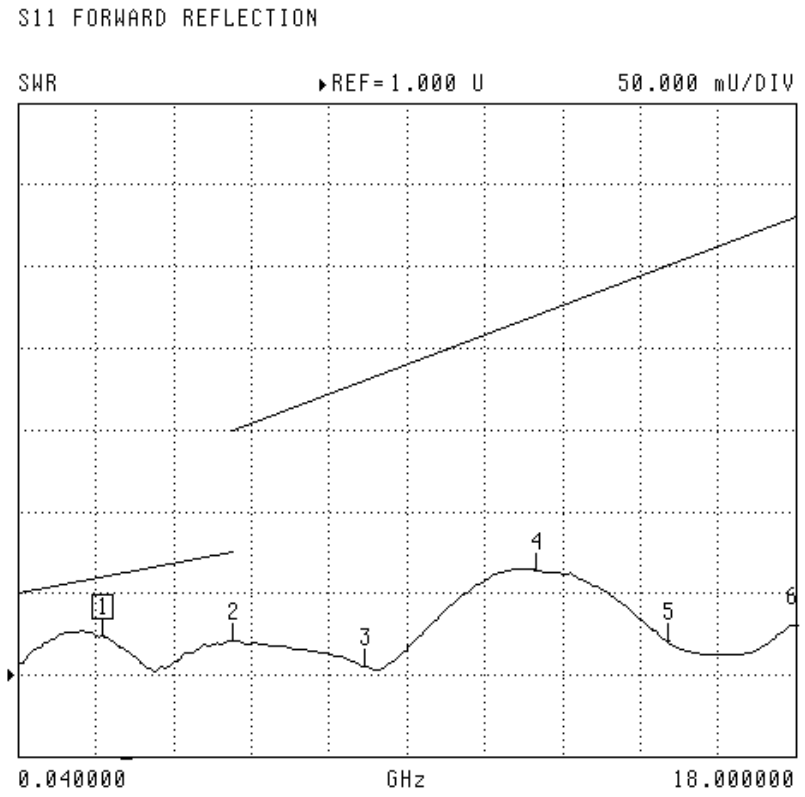


Sample 101

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

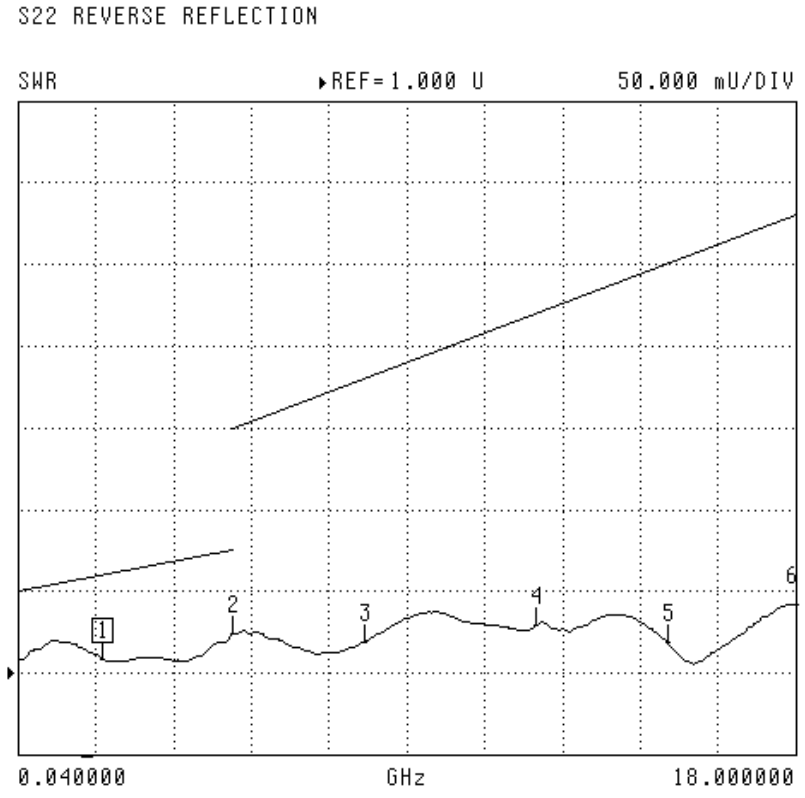


Sample 102

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

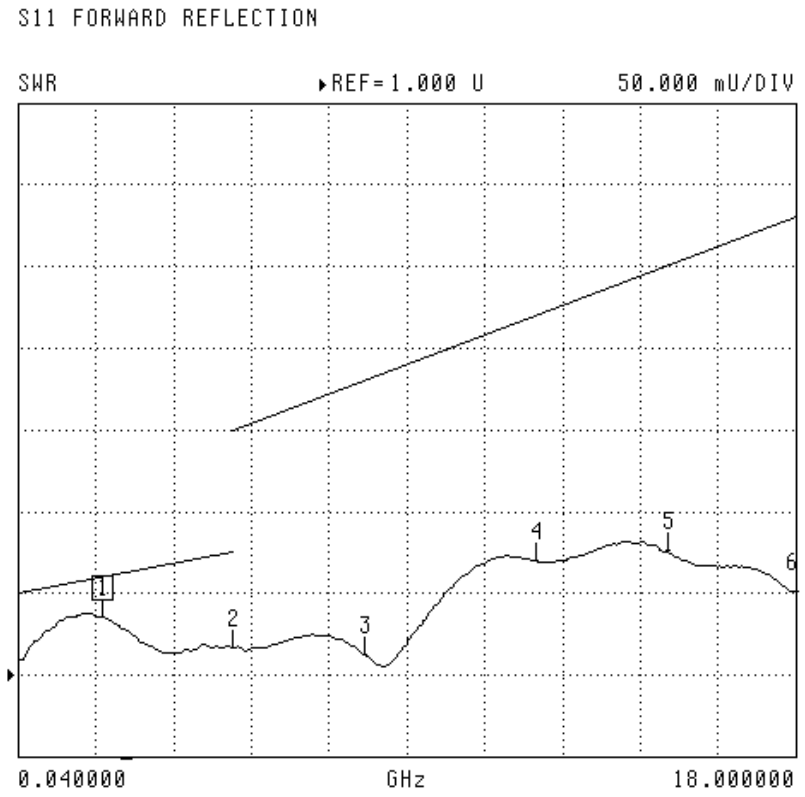


Sample 103

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

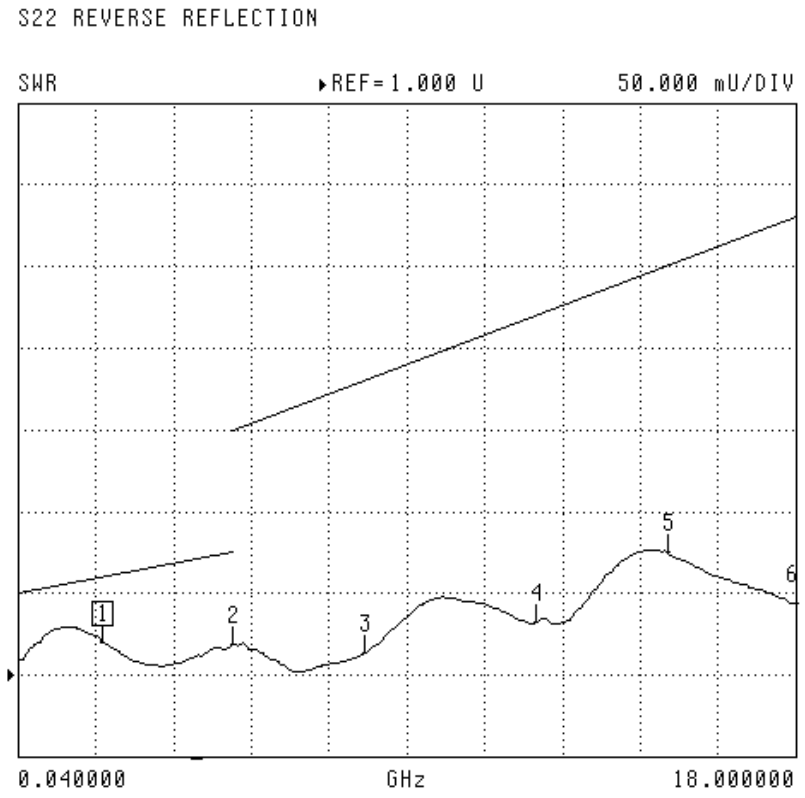


Sample 104

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

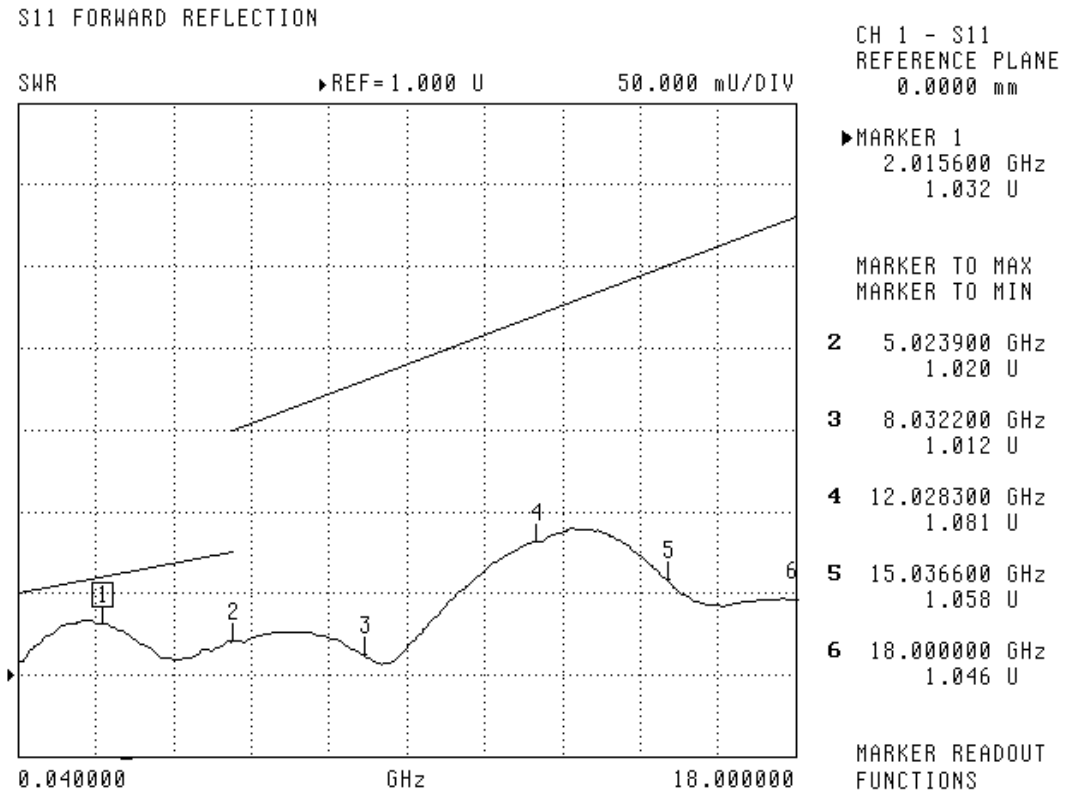


Sample 105

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

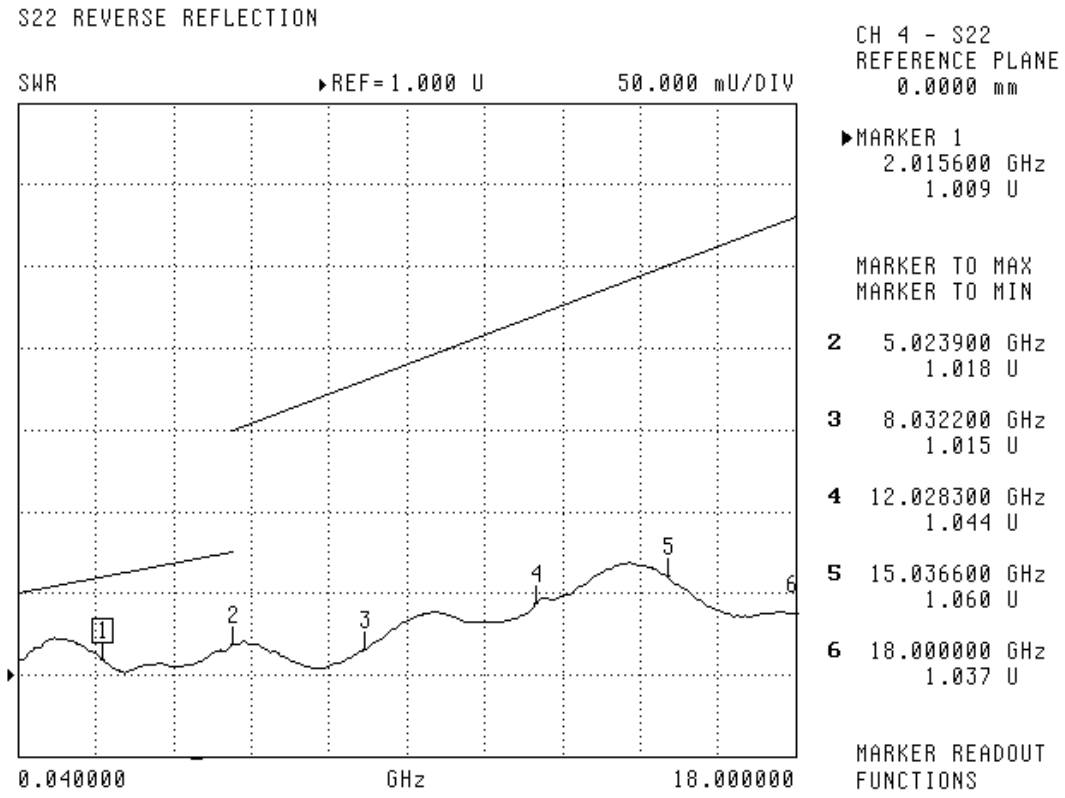


Sample 106

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

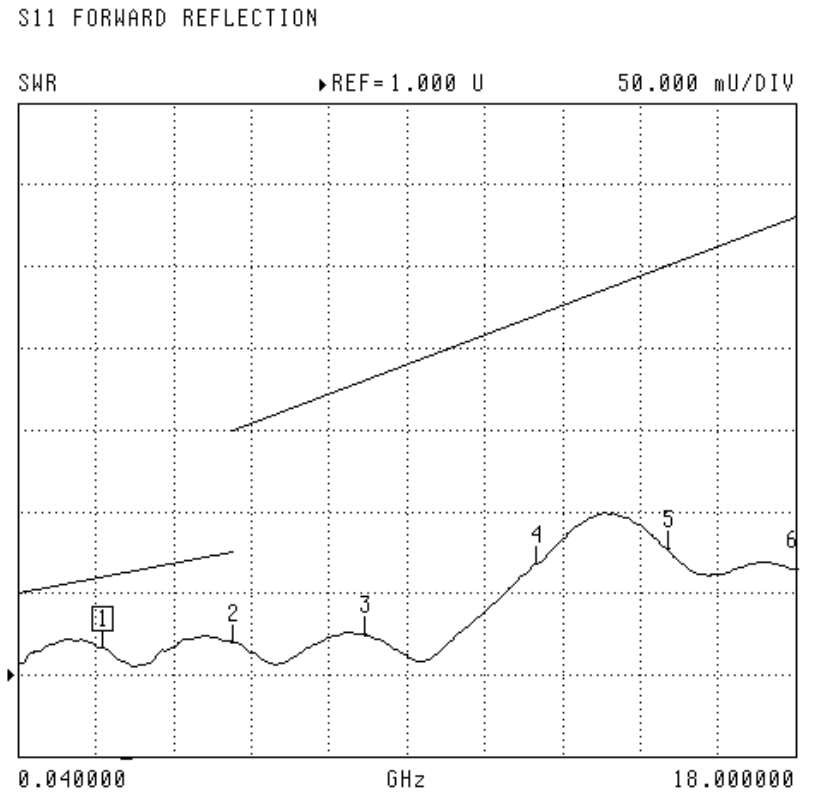


Sample 107

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

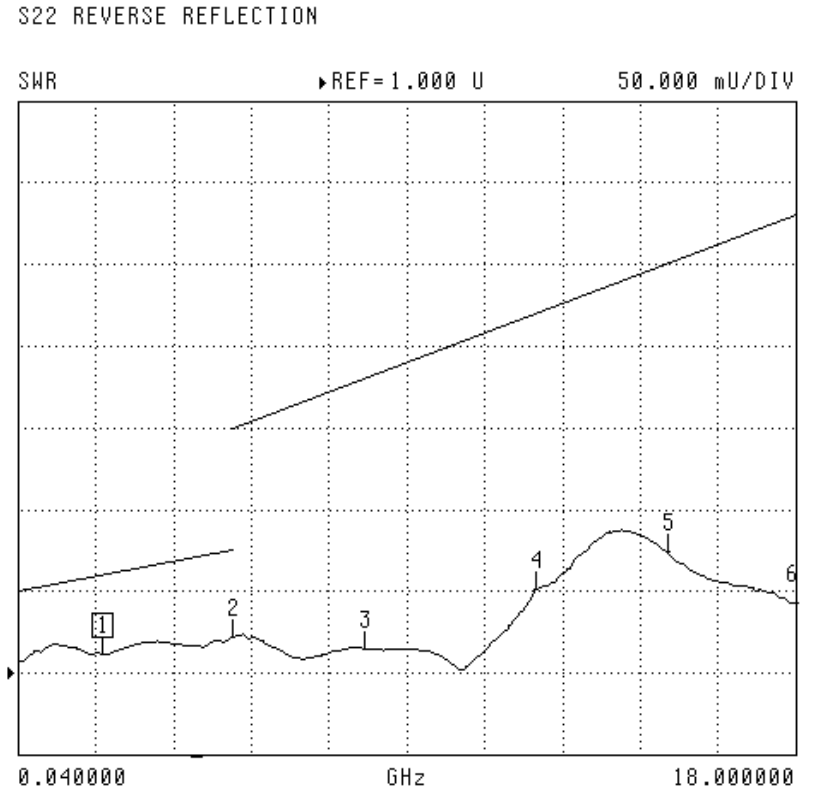


Sample 108

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

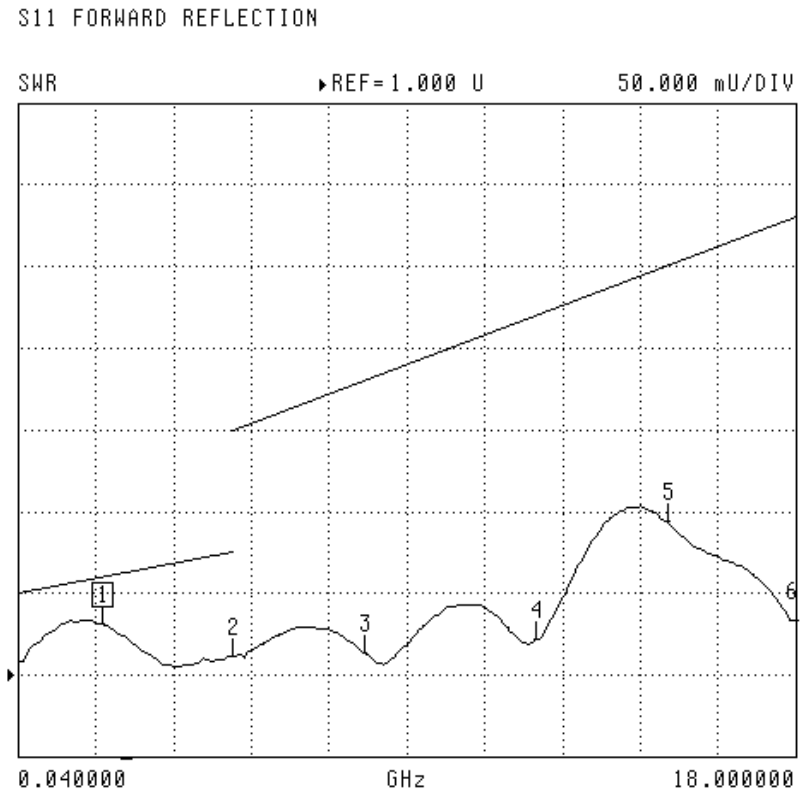


Sample 109

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

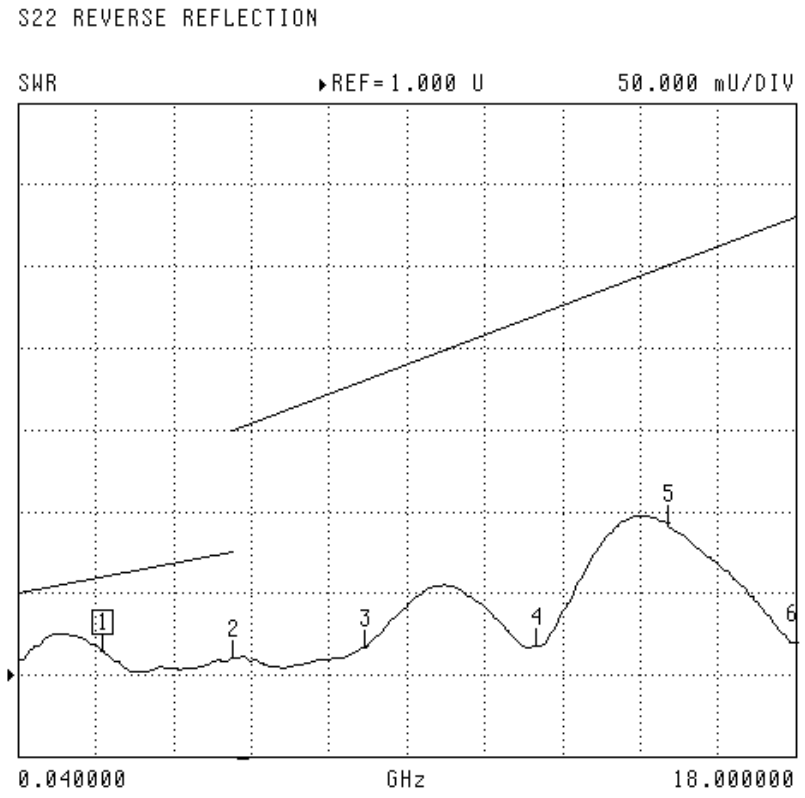


Sample 110

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

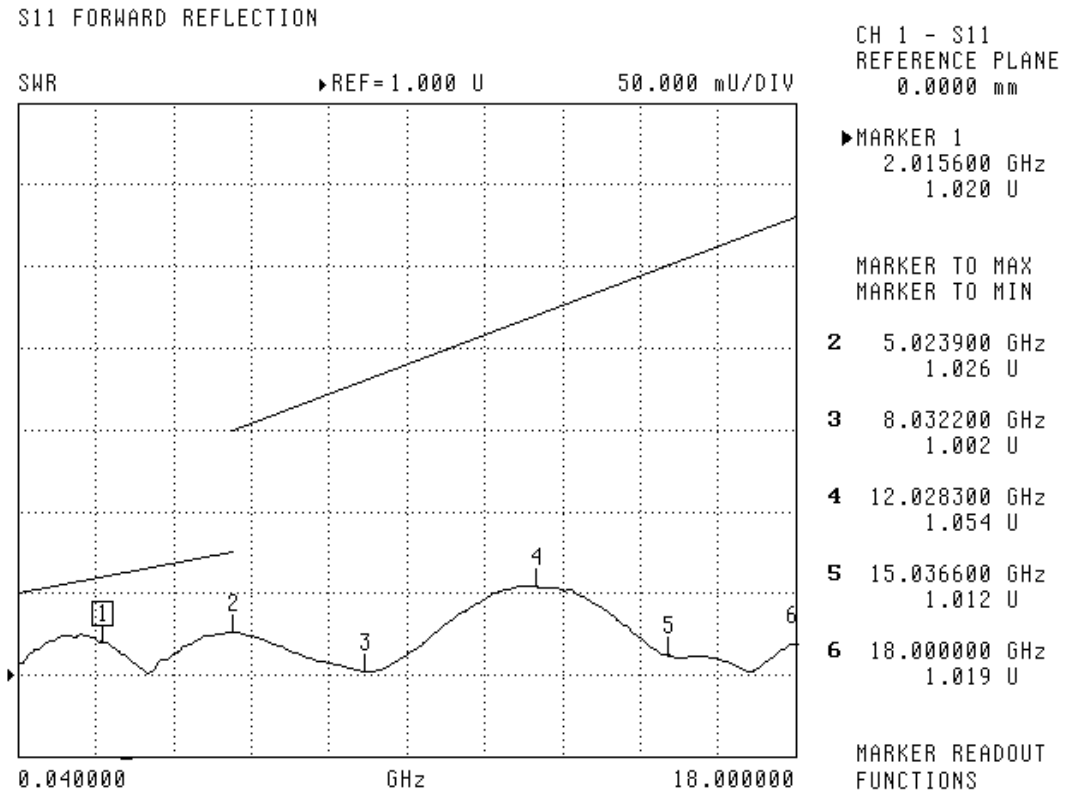


Sample 111

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

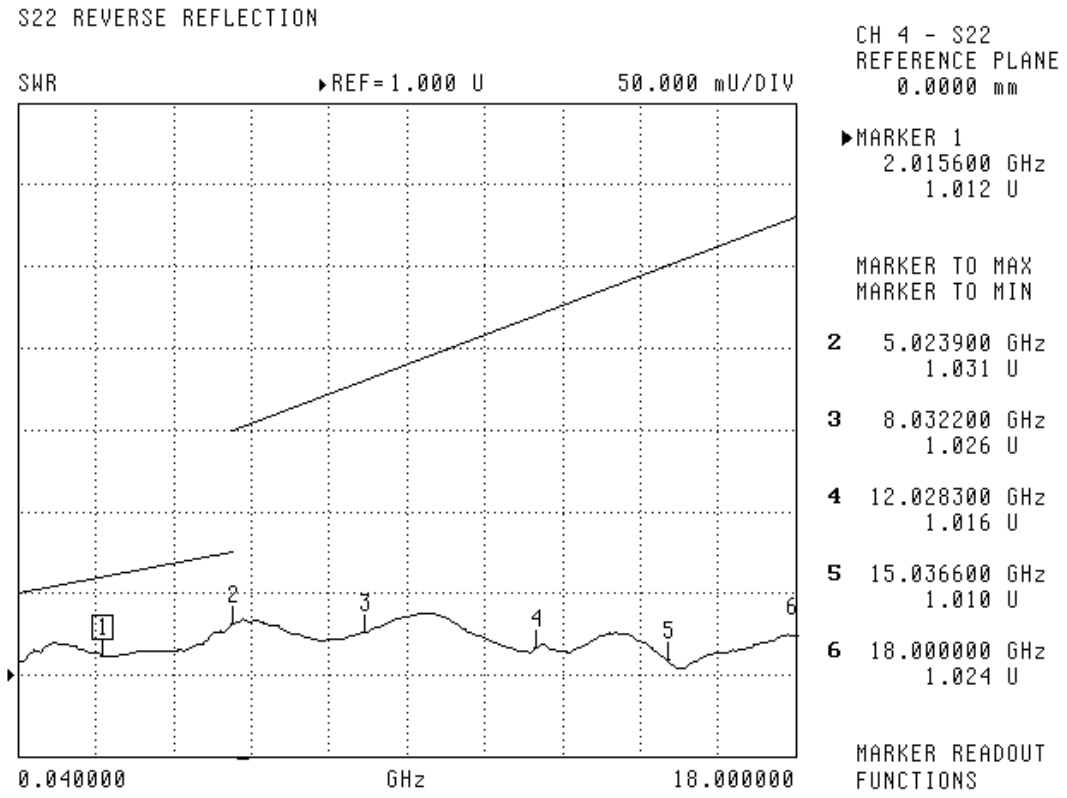


Sample 112

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

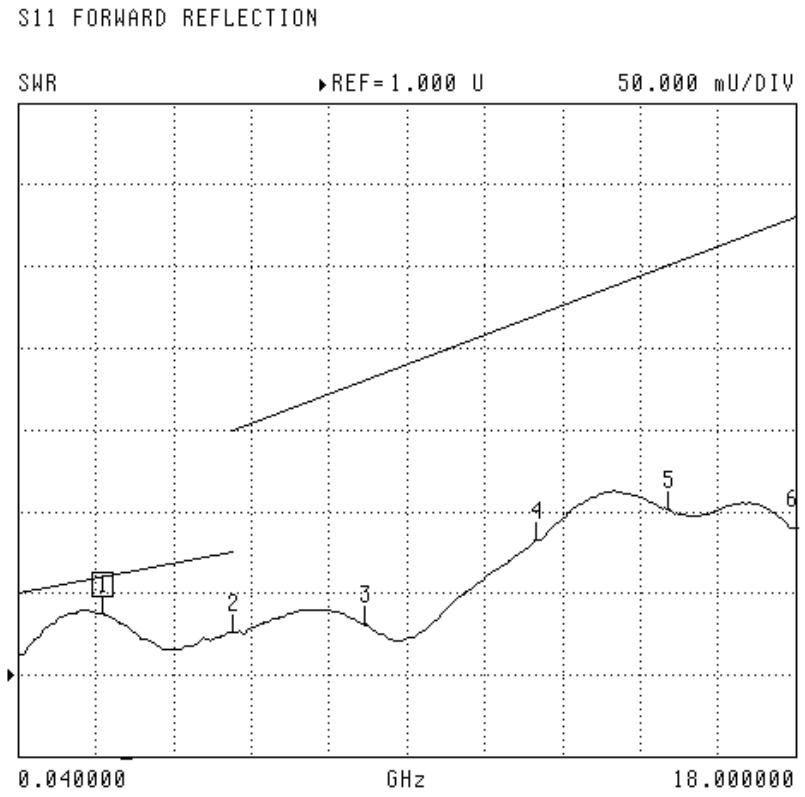


Sample 113

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

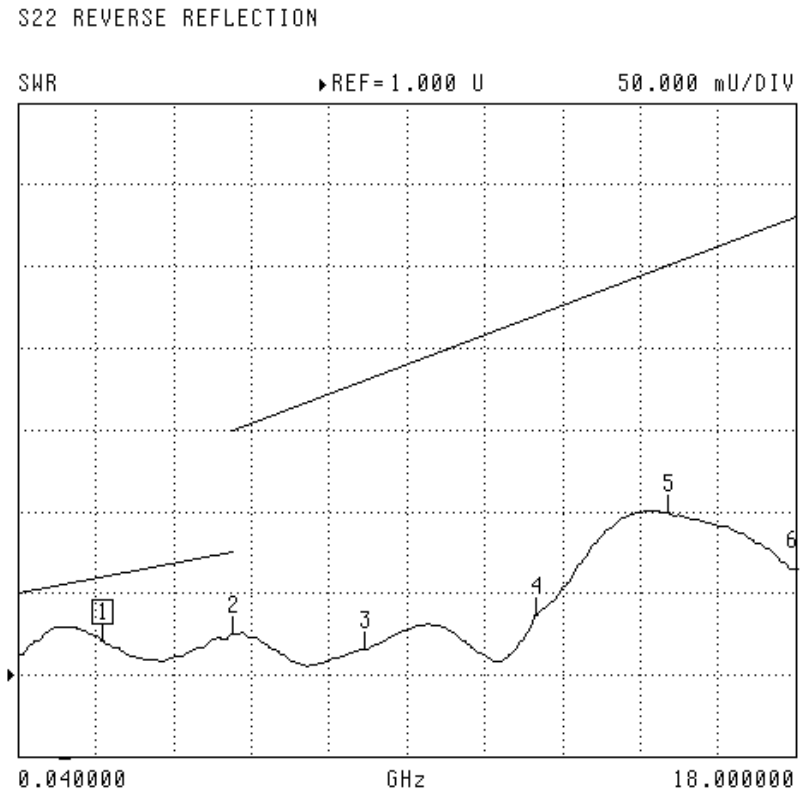


Sample 114

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

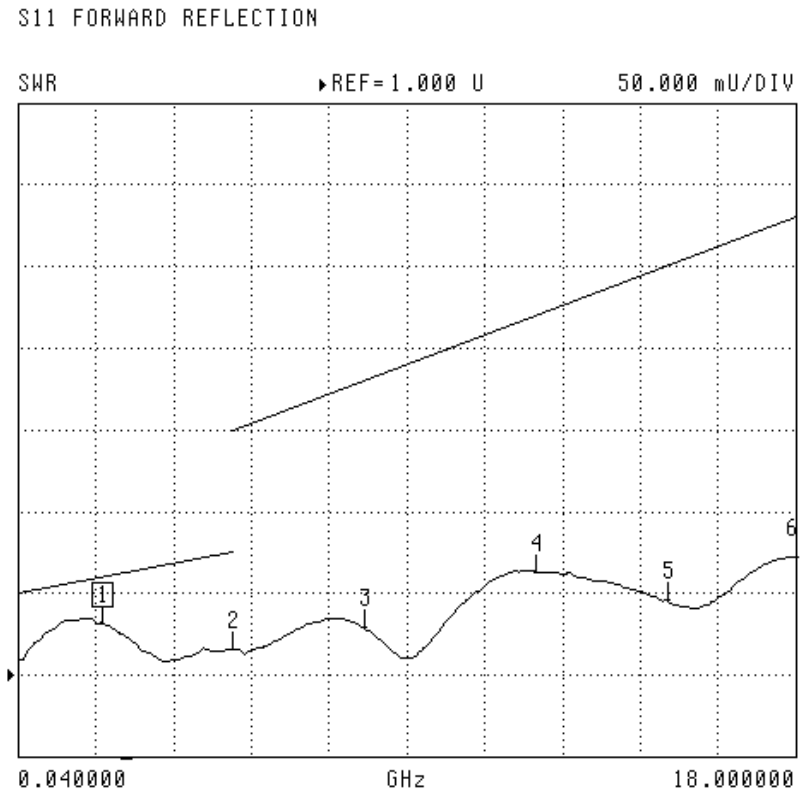


Sample 115

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

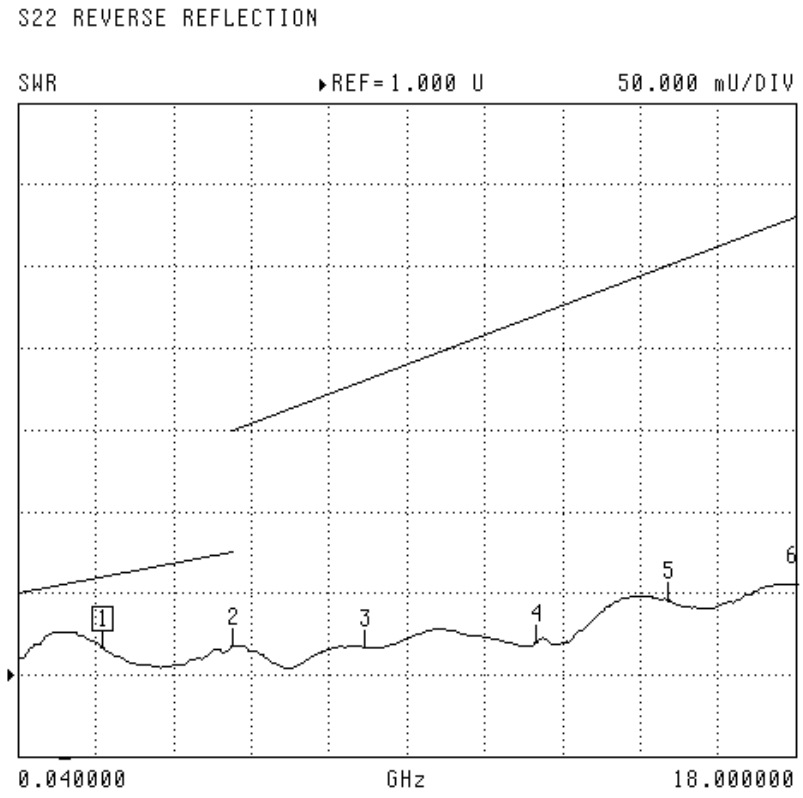


Sample 116

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

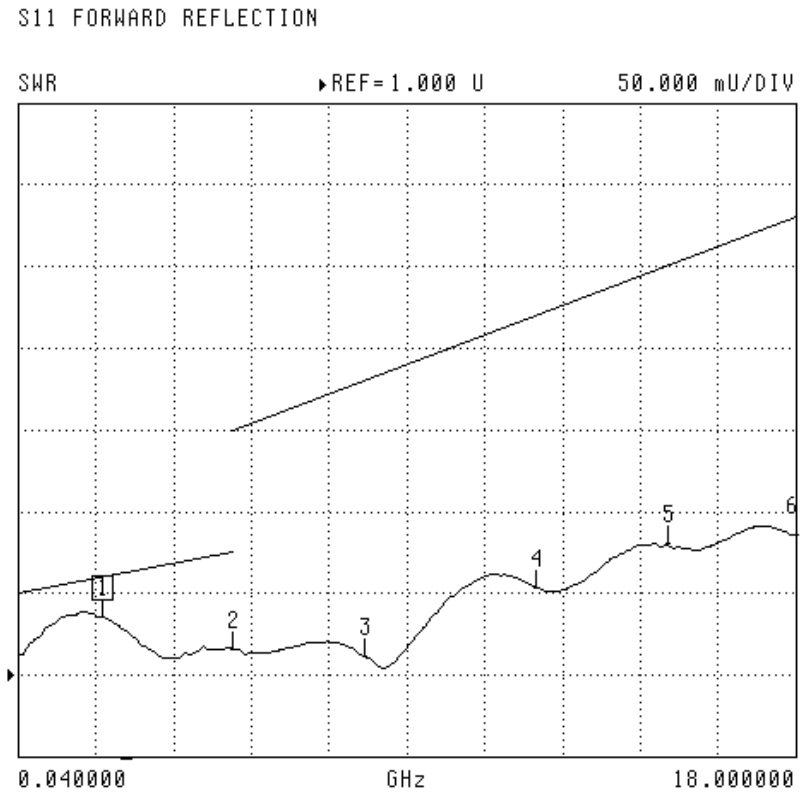


Sample 117

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006

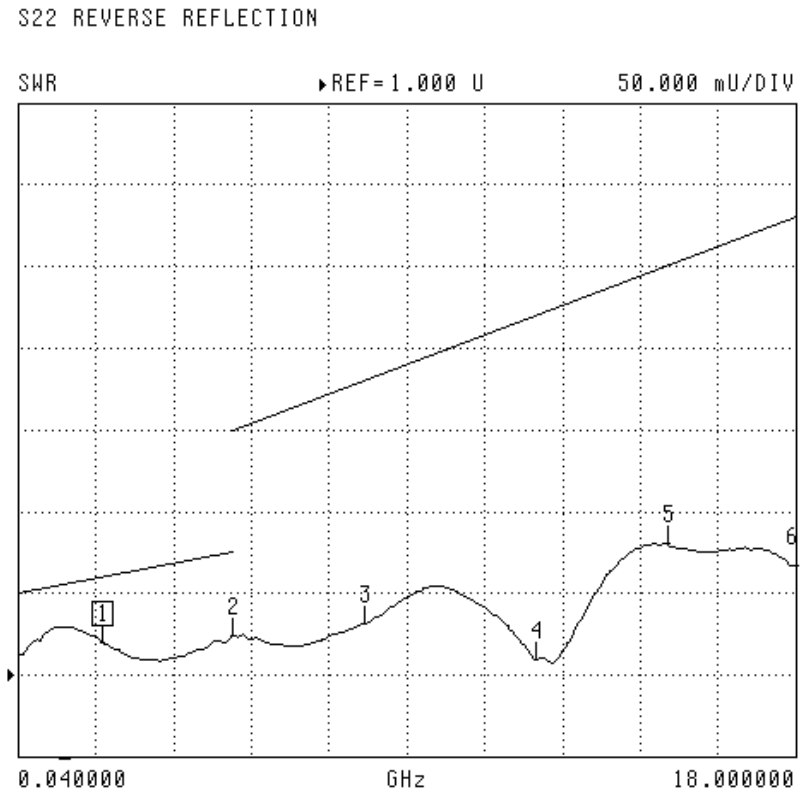


Sample 118

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

R125612140X / V.S.W.R. back to back / At high temperature +100°C 09/02/2006



Sample 119

START : 0.040000Ghz
STOP : 18.00000Ghz
STEP : 0.044900GHz

Error corr. : 12-TERM
Averaging : 1 PT
Smoothing : 2.00%
Reference plane : 0mm
IF Bandwidth : 1KHz
Normalization : OFF
Delay aperture :

LCE report N°2006.04.9089.

RADIALL S.A.
81 bd Denfert Rochereau BP 328
38509 VOIRON CEDEX

Laboratoire Central d'Essai
Approval CECC No 01/L-89

TEST REPORT

Concerning : THERMAL SHOCKS

Test specimen identification : Straight female square flange receptacles R125612140X.	**Addressee :** Denis BOUVIER PATRON RADIALL IDA
Applicant : Denis BOUVIER PATRON **Department :** Composant Hyper Spatial	**Started :** 26 January 2006 **Finished :** 27 January 2006
Written by : J. DECEMBRE	**Date :** 31 January 2006
Laboratory supervisor : S. LEFLOCH-DUBOIS 31/01/06	**Approved by :** L. BOILLOT
Test : Thermal Shocks.	**Subject :** Thermal shock test in accordance with MIL STD 202G, Method 107, Condition B.

Conclusion :

The samples have performed the thermal cycles.

Number of pages : 6	**Number of annexes : 2**
Test report No : 2006.04.9089 Rev -	**Page : 1**

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SYNOPSIS

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REVISION

Revision	Date	Page	Description of modifications	Responsibility

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SAMPLING BOARD

Manufacturer : RADIALL SA

Designation :

Batch No

sample n°	Manufacturer sample designation	batch No or serial No	normalized sample designation	Reception Date of the sample	couple No	cable assembly
1 to 94	R125612140X	05-34A		26/01/2006		
95 to 162	R125612140X	05-40A		26/01/2006		

The test sample selection is carried out by the applicant of the test.

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SAMPLING BOARD

Test or Test group	Sample No
	1 to 162
Thermal Shocks	✓

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Test :	Thermal Shocks.	
Specification :	MIL-STD 202G, method 107, condition B.	
Sampling :	All samples	
Equipment :	Thermal shock chamber VOTSCH LCE0230.	
Room temperature : 20°C	**Room humidity :** 31%RH	**Date :** 26 and 27 January 2006
Operator : J. DECEMBRE	**Site :** L.C.E. Voiron	

Test Description :

The test was performed in accordance with the method MIL-STD 202G, method 107 with the following conditions:

Thermal cycles:

50 cycles will be performed.

1 cycles =
Cold step: 15 minutes at –55°C
Hot step: 15 minutes at +105°C

Requirement : No requirement.

Result :

The samples have performed the 50 cycles.

Measurement uncertainty : ± 3°C

Conclusion :

The visual inspection, before and after test, will be made by the client.

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ANNEX 01

EQUIPMENT LIST

Annex No : 1	Number of pages : 2
Test report No : 2006.04.9089 Rev. -	page : A1.1

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LISTE DU MATERIEL LCE RADIALL VOIRON.
EQUIPMENT LIST

Equipement Equipment	Date D'entrée Income Date	Fabricant Manufactur er	Type Type	N° de série Serial Number	Précision Accuracy	Limites Limits	Périodicité d'étalonnage Frequency of calibration	N° Procédure d'étalonnage Calibration Procedure number
Choc thermique Thermal shock	1998	VOTSCH	VT 7012 S2	524/83853 LCE0230	± 2°C Tr< 20 s	-70° à 200° C	1 an 1 year	FIQL-ET-141

Notices of anomaly.

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Notice of anomaly N°1

☐ **Component anomaly**	☑ **Test procedure or test equipment anomaly**

Test applicant : Bouvier D.	**Department :** IDA laboratory	**Ref. of test report :** 2005.45.2203
Date of statement : 26/01/2006	**Detected by :** Decembre J. **approved by :** Bouvier D.	**visa :** **date :** 26/01/2006
Notification to the applicant : **made by :**	**means :** phone	**visa :** **date :** 26/01/2006

Device under test : Thermal shocks test

Identification : Square flange receptacle tab contact SMA R125612140X Batch 05-40A N°138
(reference, date code, serial number)

Test conditions :

The thermal shocks test was performed according to standard MIL-STD 202 G method 107 condition B and following conditions :
- Maximum temperature: +105°C.
- Minimum temperature: -55°C.
- Duration transfer : < 1 minute
- Stage duration: 15 minutes.
- Number of cycles: 50.

Test requirements :

Contact resistance measurements

Deviation noticed :

On sample N°138, the tab contact was broken due to a wrong handling by the operator during the installation of the test.

Particular disposition :

The LAT continue without the sample N°138

Decision of the applicant : **visa :** **date :** 26/01/2006